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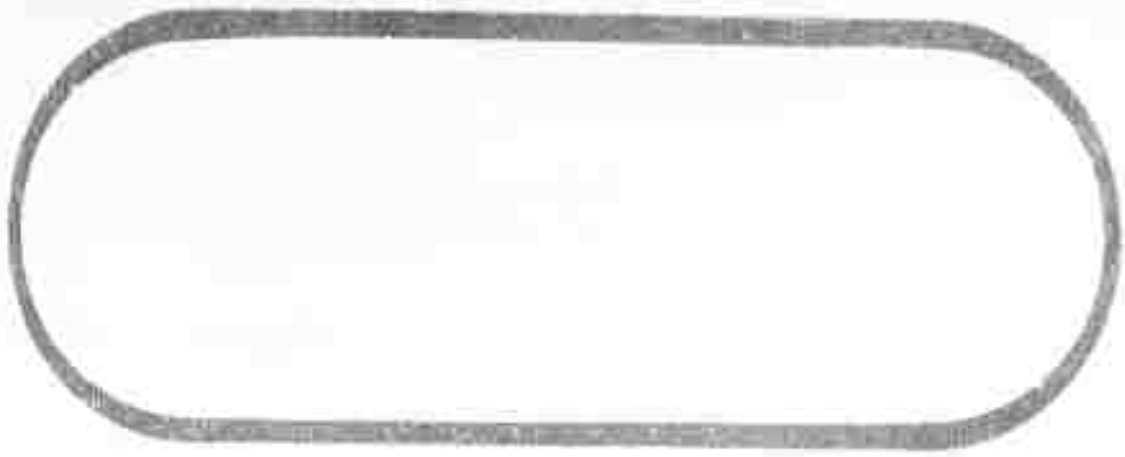


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⑤ 127 300

⑭ Document no.

~~NUMBER~~ D2-80084, Vol. 1.

~~UNCLASSIFIED~~ ⑥ EXTERNAL SURFACE PANELS

(NON-INSULATED) DEVELOPMENT - DYNA-SOAR,

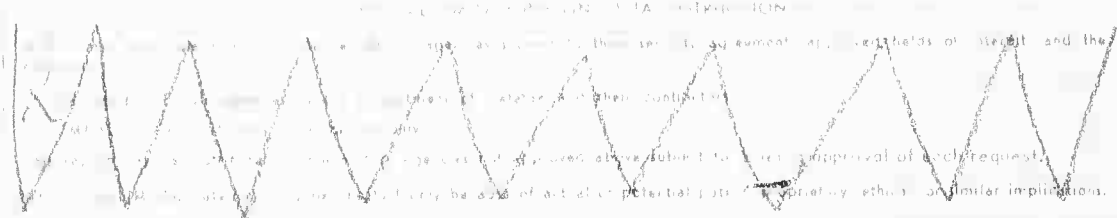
MODEL NO. X-204 ⑮ CONTRACT NO. AF33(657)-7132

ISSUE NO.

ISSUED TO

CLASSIFIED BY
DATE CLASSIFIED

CHARGE NUMBER



AT

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⑪ 23 JUL 63

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(DATE)

VOL. I
SEC.

NO D2-80084
PAGE 1 OF

CONTRACT REQUIREMENT

This document is submitted in partial fulfillment of paragraph B(1.1.1.1.9.2) of the Statement of Work, System 620A, Exhibit 620A-62-2, dated 26 January 1962, revised 1 August 1962.

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SUMMARY

This document describes all test work and test results for EWA 5-593 (Reference F).

These tests were conducted to evaluate the strength, flexibility, and sonic and thermal fatigue resistance of superalloy corrugated skin panels and the attachments of non-insulated and insulated panels to primary structures.

Panels with various methods of attachment to primary structure were evaluated. They are identified below, by their respective Boeing drawing numbers. Solution treated and aged Rene' 41 was utilized for all panel skins, corrugations, stand-offs, and attachment clip details.

- 25-20352 Two non-insulated panels 23 by 36 inches were fabricated with "omega" groove breathers every six inches running in the 23" direction in an otherwise flat skin. The skin was spot welded to corrugations. Flexible clips on long edges were utilized as the attachment technique. The panels were subjected to cyclic thermal fatigue and combined shear and pressure environments.
- 25-20344-1 Three non-insulated panels 23 by 18 inches, constructed identical to panels 25-20352 except for width, were subjected to sonic tests.
- 25-20369-1 Three insulated panels 23 by 17 inches were constructed with Rene' 41 heat shields substituted for a refractory alloy heat shield. Shield attachment to the corrugations was effected by riveting shields and corrugations to intermediate one inch long stand-off clips. A 0.25 inch layer of Fiberfrax insulation separated the shields and the corrugations. Attachment to primary structure was accomplished by flexible clips on opposite short sides of the panel. These panels were subjected to a sonic environment.
- 25-20369-2 Three panels similar to 25-20369-1 except insulation was q-felt and attachment was by direct spot welding of panel to edge beams which were supported on flexible end fittings. Sonic tests were conducted on these panels.
- 25-20370-1 Two non-insulated panels 23 by 36 inches, utilizing shallow protruding beads for expansion in the long direction and for increased skin stiffness in the short direction, were constructed with the skin spot welded to corrugations. This panel was bolted to beams which utilized flexible fittings at corners for attachment to primary structure. This panel was subjected to thermal, shear, and pressure tests.
- 25-20370-2* This panel was the same as 25-20370-1 except that six hat section stiffeners running in the long direction were riveted

* This is not Boeing part no. 25-20370-2. It is modified 25-20370-1.

to the corrugation crests to increase panel stiffness. This panel was subjected to thermal and pressure tests.

25-20374

Two 23 by 36 inch panels consisted of corrugations and were constructed to simulate the structural portion of an insulated panel and its attachments under shear and pressure and thermal conditions. Attachment techniques utilized consisted of integral beams on the long sides and flexible fittings at corners.

Thermal tests included symmetrical and unsymmetrical heating at various heating rates to temperatures of 1870° F. Sonic tests subjected panels to 152.5 db overall. Pressure tests were conducted to ultimate load. Shear tests were conducted to induce $\frac{1}{8}$ inch of shear deflection of the panel across the 23" edge.

Test data are summarized in the form of graphs and tabulated data. Photographs of specimens and test setups are included.



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REFERENCES

- A. Drawing 25-20344, Panel - Assembly of, Sonic Test (Test Only)
- B. Drawing 25-20352, Panel Assembly, Uninsulated (Test Only)
- C. Drawing 25-20369, Panel Assembly - Lower Surface (Test Only)
- D. Drawing 25-20370, Upper Wing Panel - Installation Thermal Cycle (Test Only)
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- F. D2-6783-1, Structural Integrity Development and Test Program - Detail Plan - Structures Technology
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1.0 INTRODUCTION

1.1 Background

This test program was conducted to evaluate non-insulated surface panels and the structural part of insulated panels under simulated conditions of re-entry load and environment. The concept of reliance on high temperature integrity of the panel material for sustained load-carrying capacity under aerodynamic heating distinguishes these structures from those employing cooling techniques. The panels tested were made of heat-treated Rene' 41.

1.2 Objectives

It was required to determine the effects on the panels of noise environments, cyclic heating, thermal gradients, and shear and pressure loads.

1.2.1 Sonic tests were conducted on some of the test panels in order to record the behavior of the panels to the environmental sonic conditions encountered in flight. Measurement of sound pressure level and panel motion was required for these tests.

1.2.2 A series of thermal fatigue tests, with heat applied to the outer surfaces of the panels producing a temperature gradient across the panel thickness, simulated cyclic re-entry heating. In these tests, observation of damage and measurement of deflection due to differential growth between inner and outer surfaces were required.

1.2.3 In other tests the panels were subjected to unsymmetrical heat distribution over the surface, to determine the effects of unequal edge expansion on webs and attachments.

1.2.4 The pressure tests were run to obtain ultimate pressure loads at room and elevated temperatures required to cause failure of panel corrugations and/or edge attachments.

1.2.5 In each shear test, measurement of the load necessary to produce a one-quarter inch shear deformation in the panel web was required, as well as a record of resulting damage.

2.0 TEST SPECIMEN AND INSTRUMENTATION

2.1 Test Specimen, Dwg. 25-20369-1 (Reference, Figure 229).

2.1.1 Three test insulated panels were fabricated with a flat .010" erosion shield with overall dimensions of 23.35" x 17.0". Two grooves running parallel to the 23.35" sides were formed into the shield at 1/3 span points.

2.1.2 Eleven corrugations with a pitch of 1.50" and a .75" depth were formed from a sheet of .008" material.

2.1.3 A sheet of Inconel 200 mesh wire cloth (.002" x 16.2" x 12.0") was installed between the corrugations and 1/2" Fiberfrax insulation.

2.1.4 The shield, wire cloth, Fiberfrax and corrugations were riveted together with Z clip spacer attachments.

2.1.5 Three clips were located at each end of the 17.5" edge for mounting purposes.

2.1.6 The skin, clips and corrugations were Rene' 41 (J 1610) BMS 7-95 material.

2.1.7 Photographs of a typical panel are on Figures 1 and 2, Volume I.

2.2 Test Specimen Dwg. 25-20369-2

2.2.1 Panel 25-20369-2 was similar to 25-20369-1 except for mounting support configuration, use of stabilized Q-felt insulation, and use of Inconel foil instead of mesh. Three test panels were fabricated.

2.2.1.1 One end of the panel was constructed with corner tabs for mounting.

2.2.1.2 Flexible tabs were spotwelded and bolted to the channel in a horizontal and vertical position. These tabs were designed to accept loads only in their respective planes.

2.2.1.3 A metallic foil seal extending outward 1.5" from the panel was attached across the 17.0" ends.

2.2.1.4 A sheet of .004" Inconel foil was installed between the corrugations and stabilized Q-felt insulation.

2.2.2 Photographs of a typical panel are shown on Figures 3 and 4, Volume I.

2.3 Test Specimen, Dwg. 25-20344-1 (Reference, Figure 230).

2.3.1 The panel was fabricated with a flat .008" skin which was spotwelded to a corrugated .010" stiffener web. The web had twelve parallel corrugations 0.75" high spaced 1.50" apart.

2.3.2 Overall dimensions were 23.35" x 17.50".



- 2.3.3 Three clips were located at each end of the 17.50" edge for mounting purposes.
- 2.3.4 The skin and corrugations were Rene' 41 (J 1610) BMS 7-95 material.
- 2.3.5 Photographs of the panel are shown on Figures 5 and 6, Volume I.
- 2.4 Test Specimen, Dwg. 25-20374-1 (Reference Figure 231)
- 2.4.1 Panel was fabricated from a corrugated .003 Rene' 41 skin with overall dimensions 23.40" x 35.16".
- 2.4.2 Panel contained 23 corrugations .75" high on 1.50" centers.
- 2.4.3 Formed .030" channel support beams were spotwelded to the corrugations and to .02" clips which in turn were spotwelded to the corrugated panel along the 35.16" sides. Twelve clips per side were used.
- 2.4.4 Tabs were spotwelded to the ends of one support beam, parallel to the 35.16" edge of the panel.
- 2.4.5 A .002" Inconel 702 foil seal was seamwelded around four sides, extending 2.7" beyond the 35.16" sides and 1.6" beyond the 23.40" sides.
- 2.4.5.1 The foil seal was folded and pleated to fit around the corrugations.
- 2.4.6 Seven .02" electronic deflection indicator clips were spotwelded to the panel; one at each corner, one at the center of each 35.16" side, and one at the center of the panel.
- 2.4.7 Three .020" x .50" x 1.0" channels were bolted to the support beams.
- 2.4.8 The corrugations, clips and support beams were Rene' 41 (J 1610) BMS 7-95 material.
- 2.4.9 Photographs of the panel are on Figures 7 and 8, Volume I.
- 2.5 Test Specimen, Dwg. 25-20374-2
- 2.5.1 Panel 25-20374-2 was identical to panel 25-20374-1.
- 2.6 Test Specimen, Dwg. 25-20700-1 (Reference Figure 232)
- 2.6.1 The test panel was fabricated with a flat .003" skin with overall dimensions of 23.35" x 36.00". Twenty-three beads, .06" high, and on 1.50" centers were formed into it.
- 2.6.2 Twenty-three corrugations, with a pitch of 1.50" and a .75" depth, were formed from a sheet of .003" material and spotwelded to the beaded skin.
- 2.6.3 Channels, formed of .030 material, were bolted to the 36.00" edges of the panel.

- 2.6.4 Two .060" attachment plates, one on each end of one channel and parallel to the 36.00" side, were attached to the channel.
- 2.6.5 Electronic deflection indicator clips were spotwelded to the panel at six locations.
- 2.6.6 Skin, corrugations, channels, clips and attachment plates were made from Rene' 41 (J 1610) BMS 7-95 material.
- 2.6.7 Photographs of the panel are on Figures 9, 10 and 11, Volume I.
- 2.7 Test Specimen, Dwg. 25-20370-2
 - 2.7.1 Panel 25-20370-2 was identical to panel 25-20370-1, except that the panel was modified for two tests, LT-5593-2-6B and -4-4.
 - 2.7.1.1 Six hat-section stiffeners were riveted to the corrugation crests to increase panel rigidity.
 - 2.7.1.2 A photograph of the modified panel is shown on Figure 12, Volume I.
- 2.8 Test Specimen, Dwg. 25-20352-1 (Reference, Figure 233).
 - 2.8.1 The test panel was fabricated with a .008" skin into which five creases, .20" deep, and on 6.00" centers, were formed. Overall finished dimensions were 36.00" x 23.35".
 - 2.8.2 Twenty-three corrugations, with a pitch of 1.50" and a .75" depth, were formed from a sheet of .008" material and spotwelded to the creased skin.
 - 2.8.3 Six .020" support clips were spotwelded and riveted to each 36.00" side.
 - 2.8.4 Two formed channels, .032" x 2.00" x .75", were bolted to the support angles parallel to the 36.00" sides.
 - 2.8.5 Skin, corrugations, support angles and channels were made from Rene' 41 (J 1610) BMS 7-95 material.
 - 2.8.6 Photographs of the panel are shown on Figures 13 and 14, Volume I.
- 2.9 Test Specimen, Dwg. 25-20352-2
 - 2.9.1 Panel 25-20352-2 was identical to panel 25-20352-1 except the two .032" x .75" x 2.00" channels were not included.
 - 2.9.2 Photographs of the panel are shown on Figures 15 and 16, Volume I.



2.10 INSTRUMENTATION

2.10.1 Test LT-5593-1 Sonic Test (Panels 25-20344 and 25-20369-1, -2)

2.10.1.1 Two Altec 21 BR-200 microphones were used to monitor the sound level.

2.10.1.1.1 One microphone was placed inside the progressive wave chamber to monitor the sound level at the face of the specimen.

2.10.1.1.2 The second microphone was located on the opposite side of the specimen external to the progressive wave chamber.

2.10.1.2 Three non-contact deflection pickups were used to monitor the RMS deflections of the panel.

2.10.1.2.1 One deflection pickup was mounted along the centerline of the 23.5" edge at 1/4 point.

2.10.1.2.2 A second deflection pickup was along the centerline of the 17.5" edge at 1/4 point.

2.10.1.2.3 A third deflection pickup was mounted at the center of the panel.

2.10.1.3 Photographs showing microphone and deflection pickups are shown on figures 17 and 18, Volume I.

2.10.1.4 The test panels were instrumented with 6 chromel-alumel control thermocouples for the heating cycle phase of the test. See Figure 65, Volume I.

2.10.2 Test LT-5593-2 Thermal Cycle Tests

2.10.2.1 Test LT-5593-2-1 (Panel 25-20374-1)

2.10.2.1.1 Fifty-four chromel-alumel thermocouples were spotwelded to the panel and beaded seals. See Figures 66, 67 and 68, Volume I.

2.10.2.1.2 Electronic deflection indicators were attached at seven locations to measure vertical deflections. Locations are shown on Figure 69, Volume I.

2.10.2.1.3 Electronic deflection indicators were attached at three locations to measure horizontal deflections at the ends and midpoint of one 35.6" side.

2.10.2.2 Test LT-5593-2-2 (Panel 25-20374-2)

2.10.2.2.1 Eleven chromel-alumel thermocouples were spotwelded to the panel. Thermocouple locations are shown on Figure 70, Volume I.

2.10.2.2.2 Electronic deflection indicators were attached at five locations to measure vertical deflections. Locations are shown on Figure 71, Volume I.

2.10.2.3 Test LT-5593-2-3 (Panel 25-20352-1 and 25-20374-1)

- 2.10.2.3.1 Ten chromel-alumel thermocouples were spotwelded to the 25-20352-1 panel, as shown on Figure 72, Volume I.
- 2.10.2.3.2 Eight chromel-alumel control thermocouples were spotwelded to the 25-20374-1 panel as shown on Figure 73, Volume I.
- 2.10.2.3.3 Electronic deflection indicators were attached at five locations as shown on Figure 74, Volume I. Quartz rods were used to actuate the electronic deflection indicators D02, D04 and D06.
- 2.10.2.4 Test LT-5593-2-4 (Panel 25-20352-2)
- 2.10.2.4.1 Instrumentation for this test was identical to that for LT-5593-2-3.
- 2.10.2.5 Test LT-5593-2-5 (Panel 25-20370-1)
- 2.10.2.5.1 Instrumentation for this test was identical to that for LT-5593-2-3.
- 2.10.2.6 Test LT-5593-2-6 (Panel 25-20370-2)
- 2.10.2.6.1 Instrumentation for this test was identical to that for LT-5593-2-3.
- 2.10.2.7 Test LT-5593-2-6B (Panel 25-20370-2)
- 2.10.2.7.1 Ten chromel-alumel monitor thermocouples were spotwelded to the panel in the locations shown on Figure 75, Volume I.
- 2.10.2.7.2 Seven chromel-alumel control thermocouples were spotwelded to the panel in the locations shown on Figure 75, Volume I.
- 2.10.2.7.3 Five electronic deflection indicators were attached to the panels as shown on Figure 76, Volume I.
- 2.10.3 Test LT-5593-3 Shear Tests
- 2.10.3.1 Test LT-5593-3-1 (Panel 25-20374-1)
- 2.10.3.1.1 Eleven chromel-alumel monitor thermocouples were spotwelded to the panel in the locations shown on Figure 77, Volume I.
- 2.10.3.1.2 Nine chromel-alumel control thermocouples were spotwelded to the panel in the locations shown on Figure 78, Volume I.
- 2.10.3.1.3 Five electronic deflection indicators were attached to the panel at the locations shown on Figure 78, Volume I to measure vertical deflections.
- 2.10.3.2 Test LT-5593-3-2 (Panel 25-20352-2)
- 2.10.3.2.1 Thermocouple installations and locations were identical to those of Test LT-5593-3-1.
- 2.10.3.2.2 Eight electronic deflection indicators were attached at the four panel corners as shown on Figure 79, Volume I.



- 2.10.3.3 Test LT-5593-3-3 (Panel 25-20370-1)
 - 2.10.3.3.1 Thermocouple installations and locations were identical to those of Test LT-5593-3-1.
 - 2.10.3.3.2 Eight electronic deflection indicators were attached to the panel at three corners as shown on Figure 80, Volume I.
- 2.10.4 Test LT-5593-4 Pressure Tests
 - 2.10.4.1 Test LT-5593-4-1 (Panel 25-20374-1)
 - 2.10.4.1.1 Thermocouple installations and locations were identical to those of Test LT-5593-3-1.
 - 2.10.4.1.2 Five electronic deflection indicators were attached to the panel at the locations shown on Figure 78, Volume I.
 - 2.10.4.2 Test LT-5593-4-2 (Panel 25-20374-2)
 - 2.10.4.2.1 Eleven chromel-alumel monitor thermocouples were spotwelded to the panel in the locations shown on Figure 77, Volume I.
 - 2.10.4.2.2 Nine chromel-alumel control thermocouples were spotwelded to the panel as shown on Figure 78, Volume I.
 - 2.10.4.2.3 Five electronic deflection indicators were attached to the panel at the locations shown on Figure 78, Volume I.
 - 2.10.4.3 Test LT-5593-4-3 (Panel 25-20352-1)
 - 2.10.4.3.1 Thermocouple installations and locations, and electronic deflection indicator attachment locations are identical to those of LT-5593-4-2.
 - 2.10.4.4 Test LT-5593-4-4 (Panel 25-20370-2)
 - 2.10.4.4.1 Thermocouple installations and locations, and electronic deflection indicator attachment locations are identical to those of LT-5593-4-2.
 - 2.10.4.5 Test LT-5593-4-5 (Panel 25-20352-2)
 - 2.10.4.5.1 Electronic deflection indicator number and location was identical to that of LT-5593-4-2.
 - 2.10.4.5.2 No thermocouples were used as this test was at room temperature.
 - 2.10.4.6 Test LT-5593-4-6 (Panel 25-20370-1)
 - 2.10.4.6.1 Electronic deflection indicator number and location was identical to that of LT-5593-4-2.
 - 2.10.4.6.2 No thermocouples were used as this test was at room temperature.



2.10.5 Test LT-5593-5 Sonic Test (Panel 25-20344)

2.10.5.1 Four Altec 21BR-200 microphones were used to monitor sound level.

2.10.5.1.1 The microphones were located as follows:

<u>Microphone</u>	<u>Location</u>
1	Center of 24" edge nearest horn with panel in 0° position.
2	Center of panel - outside face.
3	Center of 24" edge farthest from horn with panel in 0° position.
4	Center of panel - inside anechoic box.

2.10.5.2 Three non-contact deflection pickups were used to monitor the RMS deflections of the panel in an identical manner to that used in LT-5593-1.



- 3.0 TEST SETUP
- 3.1 Test Setup for LT-5593-1
- 3.1.1 Sonic test panels 1477, 1478, 1479 (Panels 25-20344) were mounted through the end clips to a pair of .040 gage Rene' 41 channels with 3/16" dia. bolts. The Rene' 41 channels in turn were attached at each end by 1/2" dia. bolts to the steel frame around the 24" opening in the progressive wave test chamber. The 23.5" edge of the specimens was unsupported.
- 3.1.2 Two Altec-Lansing Model 6786 electro-pneumatic transducers mounted at the throat of the progressive wave chamber served as the sound source. The electrical signal to the transducers was provided by an Allison 3MAN9 noise generator and octave band equalizer through a dual channel McIntosh amplifier. Refer to Figure 19, Volume I, for a photograph of the sonic test setup.
- 3.1.3 Sonic test panels No. 1493, 1494, and 1495 (panels 25-20369-1) were mounted through the end clips to a pair of .040 gage Rene' 41 channels with 3/16" dia. bolts. The Rene' 41 channels were attached at each end by a 1/2" dia. bolt to the steel frame of the 24" opening in the progressive wave chamber. The 23.35" edge was unsupported.
- 3.1.4 Sonic test panels No. 1497, 1498, and 1499 (panels 25-20369-2) were mounted at one end by bolting a .040 Rene' channel with six 3/16" bolts to the three tabs provided. Each end of the channel was then bolted to the frame of the test chamber with two 1/2" bolts. The opposite end of the panel (17.0" edge) was secured to the test frame by flexible plates in horizontal and vertical positions. The edge of the foil seal was clamped between the test frame and a 1/4" x 1/4" bar with five 5/32" bolts. See Figure 20, Volume I, for mounting details.
- 3.1.5 Four Altec-Lansing Model 6786 electro-pneumatic transducers mounted at the throat of the progressive wave chamber served as the sound source. The electrical signal to the transducers was provided by an Allison 3MAN9 noise generator and octave band equalizer through a dual channel McIntosh amplifier.
- 3.2 Test Setup for LT-5593-2
- 3.2.1 Test Setup for LT-5593-2-1 (Panel 25-20374-1)
- 3.2.1.1 The test panel was mounted on a vacuum box lined from top to bottom with 2.5" thick K-30 insulation brick. A sketch of the box is shown on Figure 82, Volume I. A photograph of the panel installation is on Figure 21, Volume I.
- 3.2.1.2 Two 25-20344 panels were placed 10.6" below the test panel in the vacuum box to simulate a proposed upper wing panel.
- 3.2.1.3 Thirty-seven high density radiant heat lamps were mounted above the test panel and were controlled from eight zones, shown on Figure 78, Volume I. The lamp locations are shown on Figure 81, Volume I.



- 3.2.1.4 A beaded seal was spotwelded to the box as shown on Figure 22, Volume I.
- 3.2.1.5 An overall view of the specimen test setup is shown on Figure 23, Volume I.
- 3.2.2 Test Setup for LT-5593-2-2 (Panel 25-20374-2)
 - 3.2.2.1 This test setup was identical to the one used for LT-5593-2-1, except a 2.0" thick layer of Fibre Frax batt was placed approximately two inches below the support channels of the test panel.
- 3.2.3 Test Setup for LT-5593-2-3 (Panel 25-20352-1)
 - 3.2.3.1 The test panel was mounted below a re-radiating panel as shown on Figures 82 and 24, Volume I.
 - 3.2.3.2 The heat lamp setup and arrangement was identical to that of LT-5593-2-1.
- 3.2.4 Test Setup for LT-5593-2-4 (Panel 25-20352-2)
 - 3.2.4.1 Test panel mounting and heat lamp setups were identical to those of LT-5593-2-3.
- 3.2.5 Test Setup for LT-5593-2-5 (Panel 25-20370-1)
 - 3.2.5.1 Test panel mounting and heat lamp setups were identical to those of LT-5593-2-3.
- 3.2.6 Test Setup for LT-5593-2-6 (Panel 25-20370-2)
 - 3.2.6.1 Test panel mounting and heat lamp setups were identical to those of LT-5593-2-3.
- 3.2.7 Test Setup for LT-5593-2-6B (Panel 25-20370-2)
 - 3.2.7.1 The test panel was mounted in the vacuum box as shown on Figure 83, Volume I.
 - 3.2.7.2 The heat lamp setup and arrangement was identical to that of LT-5593-2-1.
- 3.3 Test Setup for LT-5593-3
 - 3.3.1 Test Setup for LT-5593-3-1 (Panel 25-20374-1)
 - 3.3.1.1 An H52-1B hydraulic ram was attached to one corner of the test panel in order to apply a load parallel to the long dimension of the panel.
 - 3.3.1.2 The panel was mounted in the vacuum box by rigidly fastening the corner opposite the loading point to the vacuum box, using a welded up fixture of .37" Inconel X plates.



- 3.3.1.3 The loaded corner was restricted to motion in the direction of loading by attaching it to the box with a .050" Rene' 41 'Z' shaped fitting.
- 3.3.1.4 The general arrangement of the panel mounting is shown on Figure 84, Volume I.
- 3.3.1.5 The hydraulic ram setup and the vacuum box were rigidly mounted to the tie down rails in the floor of the test area.
- 3.3.1.6 The heat lamp setup and arrangement was identical to that of LT-5593-2-1.
- 3.3.1.7 A photograph of the setup is shown on Figure 25, Volume I.
- 3.3.2 Test Setup for LT-5593-3-2 (Panel 25-20352-2)
- 3.3.2.1 The entire test setup was identical to that for LT-5593-3-1.
- 3.3.3 Test Setup for LT-5593-3-3 (Panel 25-20370-1)
- 3.3.3.1 The entire test setup was identical to that for LT-5593-3-1.
- 3.4 Test Setup for LT-5593-4
- 3.4.1 Test Setup for LT-5593-4-1 (Panel 25-20374-1)
- 3.4.1.1 The test setup was identical to that of LT-5593-2-1, except that a model 600 Jaeger compressor was used as a vacuum pump to apply uniform loading to the test panel surface by creating a pressure differential across the top and bottom panel surfaces.
- 3.4.2 Test Setup for LT-5593-4-2 (Panel 25-20374-4)
- 3.4.2.1 The test panel was mounted in the vacuum box as shown on Figure 85, Volume I.
- 3.4.2.2 Inconel 702 foil seals were spotwelded to the panel and to the vacuum box to provide a seal for the pressure tests, but were omitted in the unsymmetrical heat cycles.
- 3.4.2.3 A two-inch thick Fibre Frax blanket was placed below the panel in all tests to block the flow of heat to the bottom of the vacuum box.
- 3.4.2.4 The pressure loading setup was identical to that of LT-5593-4-1.
- 3.4.2.5 The heat lamp setup and arrangement was identical to that of LT-5593-2-1.
- 3.4.3 Test Setup for LT-5593-4-3 (Panel 25-20352-1)
- 3.4.3.1 The test setup was identical to that for LT-5593-4-2.



- 3.4.4 Test Setup for LT-5593-4-4 (Panel 25-20370-2)
- 3.4.4.1 The test setup was identical to that for LT-5593-4-2.
- 3.4.5 Test Setup for LT-5593-4-5 (Panel 25-20352-2)
- 3.4.5.1 The test setup was identical to that for LT-5593-4-2 except no heat lamps or fibrefrax insulation was used since the test was to be run at room temperature.
- 3.4.6 Test Setup for LT-5593-4-6 (Panel 25-20370-1)
- 3.4.6.1 The test setup was identical to that for LT-5593-4-5.
- 3.5 Test Setup for LT-5593-5
- 3.5.1 Panel 25-20344-1, sonic test panel No. 1477, was mounted through the end clips to a pair of .040 gage Rene' 41 channels with 3/16" dia. bolts. The Rene' 41 channels in turn were attached at each end by 1/2" dia. bolts to a steel "picture frame" jig. The 23.5" edge of the specimen was unsupported. An anechoic box was attached to the underside of the "picture frame" jig to attenuate the sound level at the inside surface of the specimen. The panel mounting fixture was built so that the angle of sound with respect to the panel could be continuously varied at any angle from 0 to 90°. The exponential steel horn was rolled up to the panel mounting fixture with the axis of the horn bisecting the 23.5" panel edge.
- 3.5.2 Two Altec-Lansing Model 6786 electropneumatic transducers mounted on the exponential horn served as the noise source. The electrical signal to the transducers was provided by an Allison 3MAN9 noise generator and octave band equalizer through a dual channel McIntosh amplifier.
- 3.5.3 The microphones were monitored with a Ballantine true rms meter and a General Radio octave band analyzer. The outputs of the displacement pickups were also measured with the Ballantine meter. The output of both the microphones and the displacement pickups was tape recorded on a 4 sec. continuous loop tape for each condition.



4.0 TEST PROCEDURE

4.1 Test procedure for LT-5593-1 (Panels 25-20344-1, No's. 1477, 1478, 1479)

4.1.1 Each of three panels was sonic tested for five minutes at an overall sound level of 152 db. The output of the microphones was analyzed on a General Radio octave band analyzer and also recorded on magnetic tape. The microphone output octave band analysis was compared to the theoretical design spectrum. The output of the non-contact amplitude pickups were also recorded on magnetic tape.

4.1.2 After completing five minutes of sonic testing, the panels were inspected for failures and then sent to the Structures Laboratories Heat Lab. for a 15 minute 2000°F heat cycle test. (Ref. Figure 143).

4.1.3 The panels were returned to the Sonic Laboratory, inspected for failures and photographed. Each panel was reinstalled in the progressive wave chamber and sonic tested to the same spectrum for an additional 55 minutes. Microphone output was analyzed on the General Radio octave band analyzer and tape recordings made of the microphones and deflection pickups at the beginning and end of the 55 minute period. Each panel was removed from the progressive wave chamber and visually inspected for additional failures at 15 to 20 minute intervals and at the end of the test.

4.2 Test procedure for LT-5593-1 (Panels 25-20369-1, No's. 1493, 1494, 1495 and 25-20369-2, No's. 1497, 1498, 1499)

4.2.1 Each of six panels was sonic tested for five minutes at an overall sound level of 152.5 db. The output of the microphones was analyzed on an octave band analyser and compared to the theoretical design spectrum. The output of the microphones was also recorded on magnetic tape. Spectral density analyses were made from these tapes.

4.2.2 After completing five minutes of sonic testing, the panels were inspected for failures and sent to the Structures Laboratories Heat Lab. for the heat environment cycle defined in Paragraph 4.1.2.

4.2.3 The panels were then returned to the Sonic Laboratory, inspected for failures, and photographed. Each panel was reinstalled in the progressive wave chamber and sonic tested to the same spectrum for an additional 55 minutes. Microphone output was analyzed on the octave band analyzer and tape recordings made of the microphones and deflection pickups at the beginning and end of the 55 minute period. The test plan was changed during this phase of the program to include a 30 second test at an increased sound level of 157.5 db and another 30 second test at an increased level of 162.5 db. Data were recorded during each new level. Panels 1497, 1498, and 1499 were subjected to the revised sonic levels. Each panel was removed from the progressive wave chamber and visually inspected for failures at 15 to 20 minute intervals and at the end of the test.



- 4.3 Test procedure for LT-5593-2
- 4.3.1 Test procedure for LT-5593-2-1 (Panel 25-20374-1)
- 4.3.1.1 The simulated and test panels were subjected to a heating program consisting of ten cycles of symmetrical heat application to a maximum of 1750°F, plus an unsymmetrical heating cycle, also to 1750°F, as shown on Figure 89, Volume I. A linear temperature gradient was maintained from one long edge to the other.
- 4.3.1.2 Vertical and horizontal deflections were recorded during the heat cycling.
- 4.3.1.3 The digital data system was employed to record and reduce the data.
- 4.3.2 Test procedure for LT-5593-2-2 (Panel 25-20374-2)
- 4.3.2.1 The test panel was subjected to a heating program consisting of ten cycles of symmetrical heat application to 1370°F maximum plus an unsymmetrical heating cycle, also to 1870°F, as shown on Figure 90, Volume I. A linear temperature gradient was maintained from one long edge to the other.
- 4.3.2.2 The eleven monitor thermocouples were recorded at 24-second intervals utilizing a Leeds and Northrup strip chart recorder and a Boeing-designed stepping switch. The outputs from the five electronic deflection indicators were recorded during the first and last 25 minutes of testing on Electro Instruments' X-Y plotters.
- 4.3.3 Test procedure for LT-5593-2-3 (Panel 25-20352-1)
- 4.3.3.1 The 25-20374 panel, mounted in the outer, or upper, position on the vacuum box, was heated from above and re-radiated its heat to the test panel in the inner, or lower, position in the box.
- 4.3.3.2 The test panel heat program is shown on Figure 91, Volume I.
- 4.3.3.3 Thermocouple 4A, on the crest of an inner panel corrugation (see Figure 72, Volume I), was used to follow temperature on a manually controlled preliminary survey. Control thermocouple data from this survey was used to establish the program curves for the actual test.
- 4.3.3.4 Vertical panel deflections were recorded during the test.
- 4.3.4 Test procedure for LT-5593-2-4 (Panel 25-20352-2)
- 4.3.4.1 Test LT-5593-2-4 was run in a manner identical to that of test LT-5593-2-3.
- 4.3.5 Test procedure for LT-5593-2-5 (Panel 25-20370-1)
- 4.3.5.1 Test LT-5593-2-5 was run in a manner identical to that of test LT-5593-2-3.

- 4.3.6 Test procedure for LT-5593-2-6 (Panel 25-20370-2)
- 4.3.6.1 Test LT-5593-2-6 was run in a manner identical to that of LT-5593-2-3.
- 4.3.7 Test procedure for LT-5593-2-6B (Panel 25-20370-2)
- 4.3.7.1 Panel 25-20370-2 was subjected to an unsymmetrical heat condition consisting of a 250°F thermal gradient from one long edge of the panel to the other. Maximum temperature was 1200°F. See Figure 92, Volume I.
- 4.3.7.2 The panel was heated at a rate of 15°F/sec along one edge and at 13°F/sec along the opposite edge.
- 4.3.7.3 Vertical deflections were measured during the heat condition.
- 4.3.7.4 Two heat cycles were run.
- 4.4 Test procedure for LT-5593-3
- 4.4.1 Test procedure for LT-5593-3-1 (Panel 25-20374-1)
- 4.4.1.1 The test panel was heated symmetrically to 1870°F at a rate of 5°F/sec.
- 4.4.1.2 After the panel had reached test temperature, a shear load was applied at a rate of 100 lb/min. until failure of the panel occurred.
- 4.4.1.3 Electronic deflection indicator readings were recorded during the test.
- 4.4.2 Test procedure for LT-5593-3-2 (Panel 25-20352-2)
- 4.4.2.1 Test procedure for LT-5593-3-2 was identical to that of LT-5593-3-1 except the panel was not loaded to failure.
- 4.4.2.1.1 Loading was discontinued when deflection of the panel at the loading point had reached approximately .40".
- 4.4.3 Test procedure for LT-5593-3-3 (Panel 25-20370-1)
- 4.4.3.1 Test procedure for LT-5593-3-3 was identical to that of LT-5593-3-2.
- 4.5 Test procedure for LT-5593-4
- 4.5.1 Test procedure for LT-5593-4-1 (Panel 25-20374-1)
- 4.5.1.1 The heating rate was to have been 3 degrees/second until the test temperature of 1750°F was reached. The panel temperatures were then to have been allowed to stabilize after which a load rate of 1 PSI/minute was to have been applied to the panel until failure occurred.



(See paragraph 6.4.1 for actual test conduct.)
- 4.5.1.2 To prevent the seals from buckling and overheating as they neared the lamps, a uniform load of approximately 0.50 PSI was applied to the test panel before and during the heating period.



- 4.5.1.3 An Electro Instruments X-Y plotter was used to continuously record the pressure differential. The pressure transducer was located near the bottom center of the vacuum box (reference Figure 71, Volume I). Eleven monitor thermocouples were recorded at 24 second intervals utilizing a Leeds & Northrup strip chart recorder and a Boeing designed stepping switch. Five electrical deflection indicators were also recorded continuously on Electro Instruments X-Y plotters.
- 4.5.2 Test procedure for LT-5593-4-2 (Panel 25-20374-2)
- 4.5.2.1 The test panel was symmetrically heated to 1870°F at a rate of 5°F/sec.
- 4.5.2.2 A pressure of .50 PSI was applied before and during heating period to avoid buckling and overheating the seals during heating.
- 4.5.2.3 After heating stabilization, test pressure was applied at the rate of 1.0 PSI/min. until failure.
- 4.5.2.4 Load was measured by a pressure transducer and automatically recorded on an X-Y plotter.
- 4.5.2.5 Vertical deflections were measured during the test.
- 4.5.3 Test procedure for LT-5593-4-3 (Panel 25-20352-1)
- 4.5.3.1 The test panel was given an unsymmetrical heat cycle by heating to 2000°F along one long edge at a rate of 15°F/sec, and heating to 1750°F along the opposite edge at a rate of 13°F/sec.
- 4.5.3.2 Deflection readings were taken during the heating cycle.
- 4.5.3.3 The test panel was then cooled to room temperature.
- 4.5.3.4 The test panel was then given a symmetrical heat cycle to 1870°F at a rate of 5°F/sec.
- 4.5.3.5 After the panel had reached test temperature, test pressure was applied at a rate of 1.0 PSI/min. until panel failure.
- 4.5.3.6 Deflection readings were taken during loading.
- 4.5.3.7 Load was measured by a pressure transducer and automatically recorded on an X-Y plotter.
- 4.5.4 Test procedure for LT-5593-4-4 (Panel 25-20370-2)
- 4.5.4.1 The test procedure for LT-5593-4-4 was identical to that of LT-5593-4-3.
- 4.5.5 Test procedure for LT-5593-4-5 (Panel 25-20352-2)
- 4.5.5.1 Test pressure was applied at a rate of 1.0 PSI/min. until panel failure.
- 4.5.5.2 Load was measured by a pressure transducer and automatically recorded on an X-Y plotter.



- 4.5.5.3 Vertical deflections were measured during the test.
- 4.5.6 Test procedure for LT-5593-4-6 (Panel 25-20370-1)
- 4.5.6.1 The test procedure for LT-5593-4-6 was identical to that of LT-5593-4-5.
- 4.6 Test procedure for LT-5593-5 (Panel 25-20344-1, No. 1477)
- 4.6.1 The panel response was measured at two overall sound levels, 140 db and 147 db. The spectrum was shaped to the design octave band spectrum using the Allison equalizer with the panel at 0° sound incidence. Tape recordings of the microphone and pickup output were made at each specified angle of sound incidence. A power spectral density analysis was run on each recording and a peak count analysis was made of five selected recordings.
- 4.7 Panel Testing Summary

Panel Drawing Number	Panel Number	Testing Sequence
25-20344-1	1477	LT-5593-5, -1
	1478	LT-5593-1
	1479	LT-5593-1
25-20369-1	1493	LT-5593-1 
	1494	LT-5593-1
	1495	LT-5593-1 
25-20369-2	1497	LT-5593-1
	1498	LT-5593-1
	1499	LT-5593-1
25-20352-1	One Panel Tested	LT-5593-2-3, -4-3
25-20352-2	One Panel Tested	LT-5593-2-4, -3-2, -4-5
25-20370-1	One Panel Tested	LT-5593-2-5, -3-3, -4-6
25-20370-2	One Panel Tested	LT-5593-2-6, -2-6B, -4-4
25-20374-1	One Panel Tested	LT-5593-2-1, 4-1, 3-1
25-20374-2	One Panel Tested	LT-5593-2-2, -4-2



Panel was subsequently subjected to vibration and acceleration tests as detailed in D2-80080, "Insulated Panel Development Dyna-Soar".



- 5.0 TEST RESULTS
- 5.1 Test results, LT-5593-1
 - 5.1.1 Panels 25-20344, No's. 1477, 1478, 1479
 - 5.1.1.1 The individual panel test logs with inspection records are shown on Figures 93 through 95, Volume I.
 - 5.1.1.2 45 power spectral density analyses were made from the magnetic tape records. See Figures 96 through 140, Volume I.
 - 5.1.1.3 Time-temperature graphs of the heat cycle on each panel are plotted on Figures 141 through 143, Volume I.
 - 5.1.1.4 Microphone output compared to design spectrum is shown on Figures 144 through 146, Volume I.
 - 5.1.2 Panels 25-20369-1, No's. 1493, 1494, 1495 and 25-20369-2, No's 1497, 1498, 1499
 - 5.1.2.1 The individual panel test logs with inspection records are shown on Figures 147 through 152, Volume I.
 - 5.1.2.2 TPC power spectral density analyses of sound and panel amplitude plots and peak counts were made from the tape recordings. See Figures 153 through 222, Volume I.
 - 5.1.2.3 Microphone output compared to design spectrum is shown on Figures 223 through 228, Volume I.
- 5.2 Test results, LT-5593-2
 - 5.2.1 Test results, LT-5593-2-1 (Panel 25-20374-1)
 - 5.2.1.1 Seven vertical deflections were recorded to determine the vertical deflections of the 25-20374 panel center and the centers of the long edges with respect to the panel corners. The maximum vertical deflection occurred during the early cycles at the panel center and was approximately 0.40 inches. See Figures 1 through 46, Volume II.
 - 5.2.1.2 Horizontal deflections of the long edge (heated to 1500°F maximum) mid point and ends were measured. No significant deviation among the three measurements was observed. Maximum horizontal deflections reached 0.11 inches during the first ten cycles and 0.09 inch during the unsymmetrical heating cycle. See Figures 7 and 8, Volume II.
 - 5.2.1.3 Temperature data is included on Figures 9 through 40, Volume II.
 - 5.2.2 Test results, LT-5593-2-2 (Panel 25-20374-2)
 - 5.2.2.1 Thermocouple data is included on Figures 41 through 66, Volume II.



- 5.2.2.2 Deflection curves are included on Figures 67 through 71, Volume II.
- 5.2.3 Test results, LT-5593-2-3 (Panel 25-20352-1)
 - 5.2.3.1 Deflection of the inner, or test, panel was measured at three points.
 - 5.2.3.1.1 Deflections at two corners were measured to provide references for panel center deflections. Maximum deflection occurred at the panel center (EDI D04) and was 0.24".
 - 5.2.3.1.2 Deflection vs. time records are included on Figures 72 through 76, Volume II.
 - 5.2.3.2 Temperature vs. time records are included on Figures 77 through 104, Volume II.
- 5.2.4 Test results, LT-5593-2-4 (Panel 25-20352-2)
 - 5.2.4.1 Deflection of the inner, or test, panel was measured at three points.
 - 5.2.4.1.1 Deflections at two corners were measured to provide references for panel center deflections. Maximum deflection occurred at the panel center (EDI D04) and was 0.21".
 - 5.2.4.1.2 Deflection vs. time records are included on Figures 105 through 109, Volume II.
 - 5.2.4.2 Temperature vs. time records are included on Figures 110 through 137, Volume II.
- 5.2.5 Test results, LT-5593-2-5 (Panel 25-20370-1)
 - 5.2.5.1 Deflection of the inner, or test, panel was measured at three points.
 - 5.2.5.1.1 Deflections at two corners were measured to provide references for panel center deflections. Maximum deflection occurred at the panel center (EDI D04) and was 0.38".
 - 5.2.5.1.2 Deflection vs. time records are included on Figures 138 through 142, Volume II.
 - 5.2.5.2 Temperature vs. time records are included on Figures 143 through 168, Volume II.
- 5.2.6 Test results, LT-5593-2-6 (Panel 25-20370-2)
 - 5.2.6.1 Deflections of the inner, or test, panel were measured at three points.
 - 5.2.6.1.1 Deflections at two corners were measured to provide references for panel center deflections. Maximum deflection occurred at the panel center (EDI D04) and was 0.45".
 - 5.2.6.1.2 Deflection vs. time records are included on Figures 169 through 173, Volume II.



- 5.2.6.2 Temperature vs. time records are included on Figures 174 through 197, Volume II.
- 5.2.7 Test results, LT-5593-2-6B (Panel 25-20370-2)
 - 5.2.7.1 A record of peak test temperatures is given on Figure 75, Volume I, for both cycles.
 - 5.2.7.2 Maximum deflection of the panel occurred at the center of the panel 3.75 minutes after the start of each cycle and was .465" in cycle one, and .490" in cycle two.
 - 5.2.7.3 Deflections at all EDI locations at 3.75 minutes are given for both cycles on Figure 76, Volume I.
 - 5.2.7.4 Deflection vs. time records are included on Figures 198 through 202, Volume II.
- 5.3 Test results, LT-5593-3
 - 5.3.1 Test results, LT-5593-3-1
 - 5.3.1.1 No data was taken on this test.
 - 5.3.2 Test results, LT-5593-3-2 (Panel 25-20352-2)
 - 5.3.2.1 Deflection vs. load curves are included on Figures 203 through 210, Volume II.
 - 5.3.3 Test results, LT-5593-3-3 (Panel 25-20370-1)
 - 5.3.3.1 Deflection vs. load curves are included on Figures 211 through 218, Volume II.
- 5.4 Test results, LT-5593-4
 - 5.4.1 Test results, LT-5593-4-1 (Panel 25-20374-1)
 - 5.4.1.1 The pressure applied to the panel remained nearly constant during the tests (reference Figure 219, Volume II). Deflection curves are shown on Figures 220 through 224, Volume II. The maximum recorded deflection was 1.02 inches measured near the panel center. Monitor thermocouple temperatures during power and panel failures are represented on Figure 225, Volume II.
 - 5.4.1.2 Time vs. temperature curves are included on Figures 226 through 233, Volume II.
 - 5.4.2 Test results, LT-5593-4-2 (Panel 25-20374-2)
 - 5.4.2.1 The test panel failed at a load of 1.1 PSI.
 - 5.4.2.2 Panel center deflection immediately preceding failure was .38" measured from the panel position at temperature without load.



- 5.4.2.3 Deflection vs. pressure data are included on Figures 234 through 238, Volume II.
- 5.4.3 Test results, LT-5593-4-3 (Panel 25-20352-1)
 - 5.4.3.1 Maximum deflection during the unsymmetrical heat cycle was .33" at the center of the panel at maximum temperature.
 - 5.4.3.2 During the pressure phase, the panel failed at a load of 2.05 PSI.
 - 5.4.3.3 The deflection of the panel center, immediately prior to failure, was .78" measured from panel position at temperature without load.
 - 5.4.3.4 Deflection vs. pressure data are included on Figures 239 through 243, Volume II.
- 5.4.4 Test results, LT-5593-4-4 (Panel 25-20370-1)
 - 5.4.4.1 The maximum deflection during the unsymmetrical heating cycle at the panel center was approximately .8".
 - 5.4.4.2 The pressure test caused panel failure by buckling at 2.05 PSI.
 - 5.4.4.3 Maximum center deflection, at instant of failure, was approximately 1.0".
 - 5.4.4.4 Deflection vs. pressure data are included on Figures 244 through 248, Volume II.
- 5.4.5 Test results, LT 5593-4-5 (Panel 25-20352-2)
 - 5.4.5.1 Deflection vs. pressure curves are included on Figures 249 through 253, Volume II.
- 5.4.6 Test results, LT-5593-4-6 (Panel 25-20370-1)
 - 5.4.6.1 Deflection vs. pressure curves are included on Figures 254 through 258, Volume II.
- 5.5 Test results, LT-5593-5 (Panel 25-20344-1, No. 1477)
 - 5.5.1 The effect of sound angle of incidence on panel amplitude at 140 db and 147 db is shown on Figure 259, Volume II. In addition, 49 power spectral density analyses were made. See Figures 260 through 308, Volume II.
 - 5.5.2 Microphone output compared to design spectrum is shown on Figures 309 and 310, Volume II.

5.6

The following is a tabulation of types of tests run and panels tested.

LT-5593-1	Sonic Tests	Panel 25-20344
	Sonic Tests	Panel 25-20369-1, -2
LT-5593-2-1	Thermal Cycle Tests	Panel 25-20374-1
LT-5593-2-2	Thermal Cycle Tests	Panel 25-20374-2
LT-5593-2-3	Thermal Cycle Tests	Panel 25-20352-1
LT-5593-2-4	Thermal Cycle Tests	Panel 25-20352-2
LT-5593-2-5	Thermal Cycle Tests	Panel 25-20370-1
LT-5593-2-6	Thermal Cycle Tests	Panel 25-20370-2
LT-5593-2-6B	Thermal Cycle Tests	Panel 25-20370-2
LT-5593-3-1	Shear Tests	Panel 25-20374-1
LT-5593-3-2	Shear Tests	Panel 25-20352-2
LT-5593-3-3	Shear Tests	Panel 25-20370-1
LT-5593-4-1	Pressure Tests	Panel 25-20374-1
LT-5593-4-2	Pressure Tests	Panel 25-20374-2
LT-5593-4-3	Pressure Tests	Panel 25-20352-1
LT-5593-4-4	Pressure Tests	Panel 25-20370-2
LT-5593-4-5	Pressure Tests	Panel 25-20352-2
LT-5593-4-6	Pressure Tests	Panel 25-20370-1
LT-5593-5	Sonic Tests	Panel 25-20344



Two 25-20369-1 panels were subsequently subjected to vibration and acceleration tests as detailed in D2-80080, "Insulated Panel Development Dyna-Soar".

6.0 TEST OBSERVATIONS

6.1 Test observations, LT-5593-1

6.1.1 Panels 25-20344, No's. 1477, 1478, 1479

6.1.1.1 No failures were detected at the end of the first five minutes of sonic testing. At the end of the 15 minute heat test, the panel skins had assumed a general waffle-like appearance and numerous spotweld failures and skin cracks occurred along the supported edges of the specimen. At each inspection interval during the 55 minute sonic test, additional spotweld failures and skin cracks were detected.

6.1.1.2 Diagrams indicating spotweld failures and skin cracks due to heat and sonic testing are presented on Figures 86, 87 and 88, Volume I.

6.1.1.3 Photographs of the specimens after the 5 minute sonic test and 2000°F. heat test, but prior to the 55 minute sonic test, are shown on Figures 26, 27 and 28, Volume I, with the failures marked with an inking pen.

Photographs of the specimen after the 55 minute sonic test are on Figures 29, 30 and 31, Volume I.

6.1.1.4 The reasons that the heat cycles differed for each panel were as follows:

6.1.1.4.1 Panel 1477 - During the increase from 1300°F. to 2000°F., a bad Thyatron in Phase II of the power unit for Zone 2 caused Zone 2 to have a slower heat rate than Zone 1.

6.1.1.4.2 Panel 1478 - After the temperature had been at 2000°F. for 25 seconds, a malfunction of equipment cutoff power to the heat lamps. The temperature decreased to ambient and Dyna-Soar personnel inspected the panel. The panel was then heated to 2000°F. and held there for 15 minutes.

6.1.1.4.3 Panel 1479 - All test conditions were completed according to the predetermined time-temperature program.

6.1.2 Panels 25-20369-1, No's. 1493, 1494, 1495 and 25-20369-2, No's. 1497, 1498, 1499

6.1.2.1 No failures were detected at the end of the first 5 minutes of sonic testing. Sonic testing of the panels after the heat test produced no detectable structural failures on visual inspection in the Sonic Lab. Small fragments of the Fiberfrax insulation crumbled and vibrated from between the skin structure and wire mesh backing along the exposed edges of panels.

6.1.2.2 Photographs of the specimens after the 5 minute sonic test and the 2000°F. heat test, but prior to the 55 minute sonic test, are shown on Figures 32 through 43, Volume I.



- 6.1.2.3 Panel 1494 was burned so badly during the heat test that further sonic testing was not completed on this panel.
- 6.2 Test observations, LT-5593-2
- 6.2.1 Test observations, LT-5593-2-1, Panel 25-20374-1
- 6.2.1.1 Thermocouples on the beaded seal indicated temperatures in excess of 2000°F during the first cycle and necessitated the disconnection of seven lamps in this area for the remainder of the test. The beaded seal temperatures were then observed to have a maximum gradient of approximately 700°F and did not exceed 1700°F. One corner of the 25-20374 panel was consistently 200°F below the rest of the panel at maximum temperature.
- 6.2.1.2 Thermocouples show that a non-linear lateral temperature distribution during the unsymmetrical heating cycle subjected the 25-20374 panel to more thermal stress than if the required linear distribution could have been produced.
- 6.2.1.3 Surface panel damage if any, could not be detected. Only broken spotwelds between the panel seal and the beaded seal were evident.
- 6.2.2 Test observations, LT-5593-2-2 (Panel 25-20374-2)
- 6.2.2.1 Thermocouple data indicate that maximum panel surface temperature deviations from the required temperatures occurred during the 11th or unsymmetrical heating cycle.
- 6.2.2.1.1 Thermocouple No. 7 reached a maximum of 1630°F during this cycle versus the 1870°F stipulated. Similarly, during the 11th cycle, thermocouples no. 4 required a 1685°F maximum and no. 40 required a 1500°F maximum. They reached maximums of 1720°F and 1545°F respectively. A panel surface temperature (thermocouple no. 7) of 1660°F maximum was indicated as the largest deviation from the required temperature of 1870°F from the symmetrical heating cycles reported.
- 6.2.2.2 The surface of the Fiberfrax batt nearest the test panel reached a maximum of 1455°F forty-nine minutes after the start of the test. The gradient through the two inch thick insulation at this time was 520°F.
- 6.2.2.3 Temperature readings for the lower crest of the corrugation at the panel center (reference corrugation at the panel center, Figure 41, Volume II, thermocouple no. 3) are not reported due to a faulty thermocouple.



- 6.2.2.4 Deflection curves indicate that a maximum vertical deflection of 0.37 inches occurred during the first heating cycle near the center of the panel. See Figure 70, Volume II.
- 6.2.2.5 Buckling of the seals caused spotweld failures and some damage to the panel seal. One-half inch diameter Inconel 702 foil disks, spotwelded to the panel seal in an attempt to repair holes or damage incurred during fabrication, loosened considerably.
- 6.2.3 Test observations, LT-5593-2-3 (Panel 25-20352-1)
- 6.2.3.1 Due to limitations of the X-Y plotters it was necessary to block out the time base on the deflection record during some of the cycles on each test. The deflection curve for each of these cycles is represented by a straight vertical line from which only maximum and minimum deflections can be read.
- 6.2.3.2 Examination of the deflection curves and the tested panel revealed that no damage resulted from the tests.
- 6.2.4 Test observations, LT-5593-2-4 (Panel 25-20352-2)
- 6.2.4.1 Examination of the deflection curves and the tested panel revealed that no damage resulted from the tests.
- 6.2.5 Test observations, LT-5593-2-5 (Panel 25-20370-1)
- 6.2.5.1 Due to limitations of the X-Y plotters, it was necessary to block out the time base on the deflection record during some of the cycles on each test. The deflection curve for each of these cycles is represented by a vertical line from which only maximum and minimum deflections can be read.
- 6.2.5.2 Deflection of one panel corner was indicated by the plotter as being approximately 0.25" on cycles 5 and 6. (See curve for EDI D01). Since this corner is limited in vertical motion by brackets attached to the vacuum box, (see plan view, Figure 82, Volume I), this data is questionable. Examination of the bracket installation after test showed no failure of this attachment that could have allowed this much deflection. Also an operational check of the recording equipment indicated normal performance.
- 6.2.6 Test observations, LT-5593-2-6 (Panel 25-20370-2)
- 6.2.6.1 Examination of the deflection curves and the tested panel revealed that no damage resulted from the tests.
- 6.2.7 Test observations, LT-5593-2-6B (Panel 25-20370-2)
- 6.2.7.1 A visual examination of the panel following the test did not reveal any damage.



- 6.3 Test observations, LT-5593-3
 - 6.3.1 Test observations, LT-5593-3-1 (Panel 25-20374-1)
 - 6.3.1.1 Panel deflections went beyond calibration range of the EDI's.
 - 6.3.1.1.1 Calibrated range of the EDI's was .25". Panel deflections exceeded 1.0" under heat and load.
 - 6.3.1.2 No valid data was taken and none is presented. Failure of the panel under load prevented a rerun of the test.
 - 6.3.2 Test observations, LT-5593-3-2 (Panel 25-20352-2)
 - 6.3.2.1 A visual examination of the panel following the test did not reveal any damage.
 - 6.3.3 Test observations, LT-5593-3-3 (Panel 25-20370-1)
 - 6.3.3.1 A visual examination of the panel following the test did not reveal any damage.
 - 6.4 Test observations, LT-5593-4
 - 6.4.1 Test observations, LT-5593-4-1 (Panel 25-20374-1)
 - 6.4.1.1 The test was conducted as planned with a uniform load of 0.50 PSI and a heating rate of approximately three degrees/second being applied until a plant power failure occurred 577 seconds after the start of the test. This power failure caused heat to be lost from the eight control zones shown on Figures 225 through 233, Volume II. Following power return to the heating lamps, the panel was heated at a rate over one-hundred degrees/second as the computer attempted to return to the heating curve.
 - 6.4.1.2 Between the time of power failure and return to the heating curve the corrugations of 1/2 the panel (zone 5) buckled at the upper crests at their beam centerline. Because power to the lamps of the different zones could not be restored to the panel concurrently, temperature gradients may have induced enough thermal stress to cause the failure in zone 5. The maximum gradient, approximately 1040°F, occurred between zone 1 and zone 5 at the test time of 602 seconds. Note that the control thermocouple temperature curve on Figure 229, Volume II, represents the temperature of the zone 4 region adjacent to zone 6 only.
- Additional study of the data indicates the possibility of panel failure occurring in zone 5 prior to the failure time as indicated by a deflection indicator (reference Figure 223, Volume II) located near the center of the panel. Flagnote 1 on Figure 230, Volume II, points out that the control thermocouple for zone 5 indicates that the panel lost temperature as it was being reheated following the restoration of plant power.



6.4.1.2 (Continued)

One probable explanation is that the control thermocouple moved away from the heat lamps as the corrugations failed in the area of zone 5. The failure of the corrugations in zone 5, detected in this manner, would then have occurred approximately 29 seconds prior to the failure as indicated by the deflection near the center of the panel nine inches away.

6.4.2 Test observations, LT-5593-4-2 (Panel 25-20374-2)

6.4.2.1 The panel failure consisted of buckling of the corrugations and "caving in" of the panel.

6.4.2.2 Photographs of panel damage are on Figures 44 through 48, Volume I.

6.4.3 Test observations, LT-5593-4-3 (Panel 25-20352-1)

6.4.3.1 The unsymmetrical heat cycle produced no visible damage.

6.4.3.2 Panel damage due to pressure is shown in the photographs, Figures 49 through 52, Volume I.

6.4.4 Test observations, LT-5593-4-4 (Panel 25-20370-2)

6.4.4.1 The unsymmetrical heat cycle resulted in damage as shown on Figures 53 and 54, Volume I.

6.4.4.2 Panel damage is shown in the photographs on Figures 55, 56 and 57, Volume I.

6.4.5 Test observations, LT-5593-4-5 (Panel 25-20352-2)

6.4.5.1 The test panel failed under pressure as shown on Figures 58, 59 and 60, Volume I.

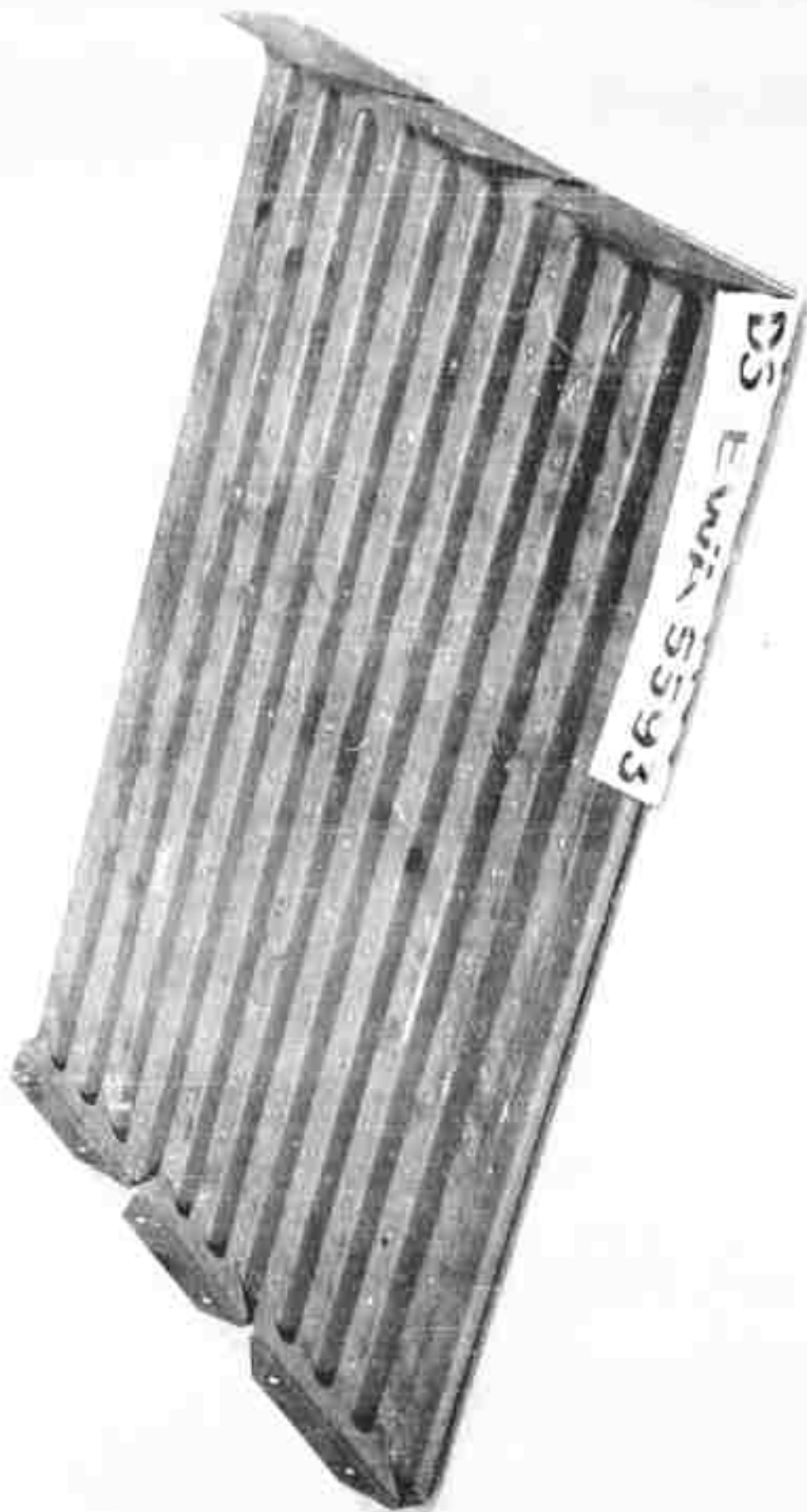
6.4.6 Test observations, LT-5593-4-6 (Panel 25-20370-1)

6.4.6.1 The test panel failed under pressure as shown on Figures 61 through 64, Volume I.

6.5 Test observations, LT-5593-5 (Panel 25-20344-1, No. 1477)

6.5.1 Figure 259, Volume II, shows the effect of sound angle of incidence on panel amplitude response. The Dyna-Soar sonic fatigue program has been setup to test specimens at 0° (grazing) incidence.





DMA 593 DS PANEL 1493

1493

2400721

U3-4071-1000 (was BAC 1546-L-R3)

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Page 2

DWA 15995 005 PANEL 1493



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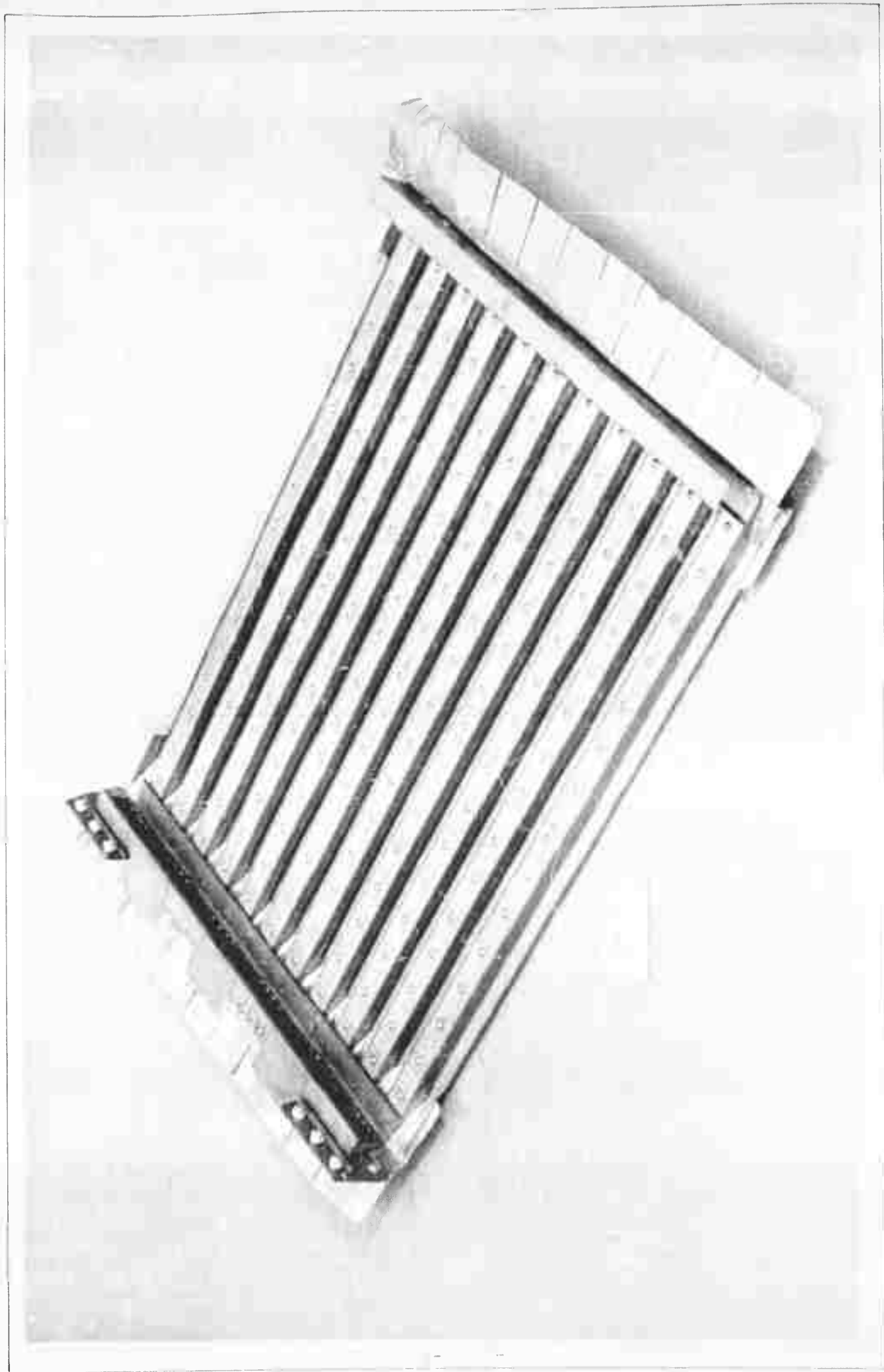
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SONIC TEST 5-1-61

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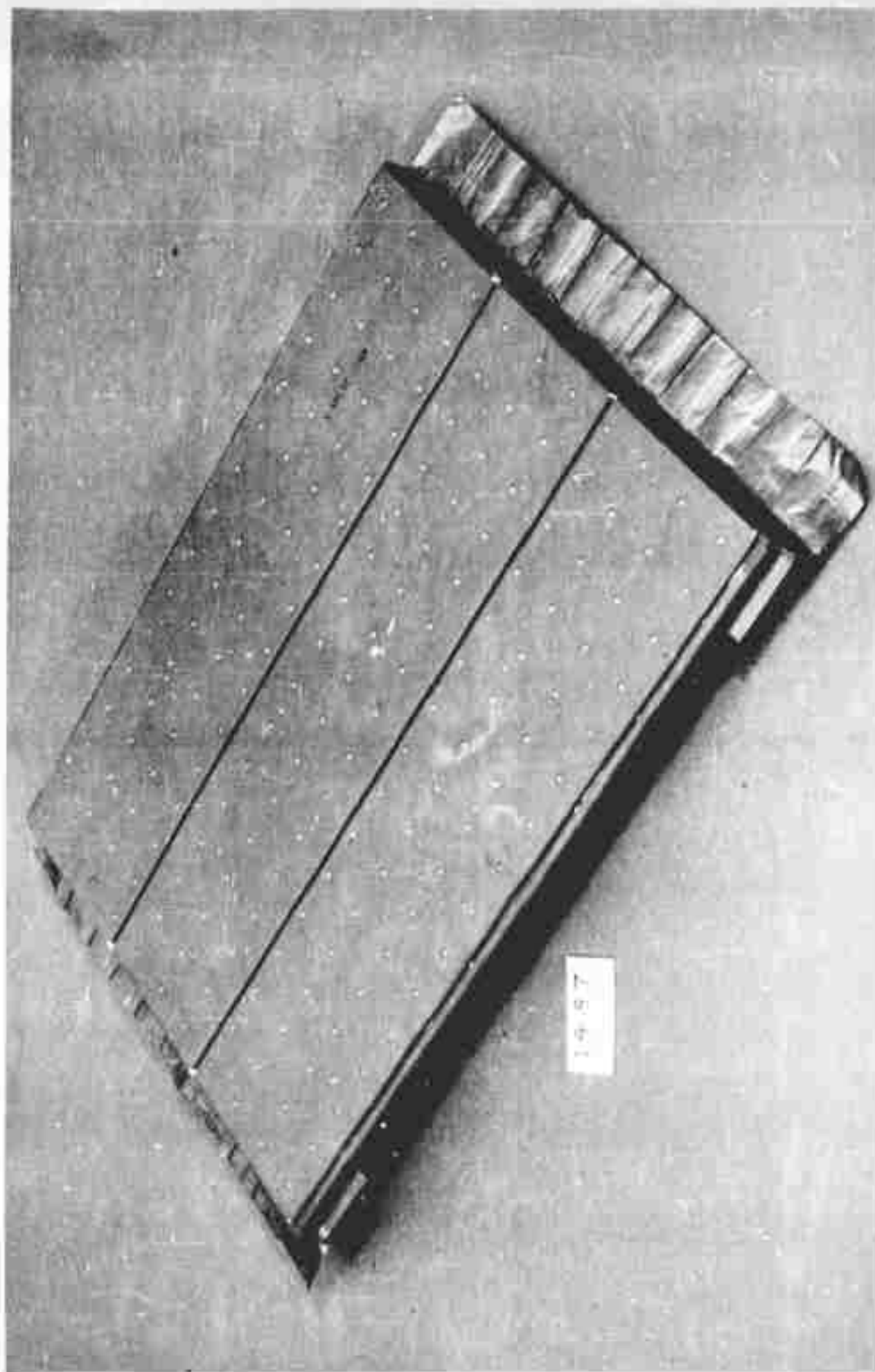
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DMA 5-593 PANEL ATTACHMENT - TYPE I PRELIM.
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5-1-61
SONIC TEST.



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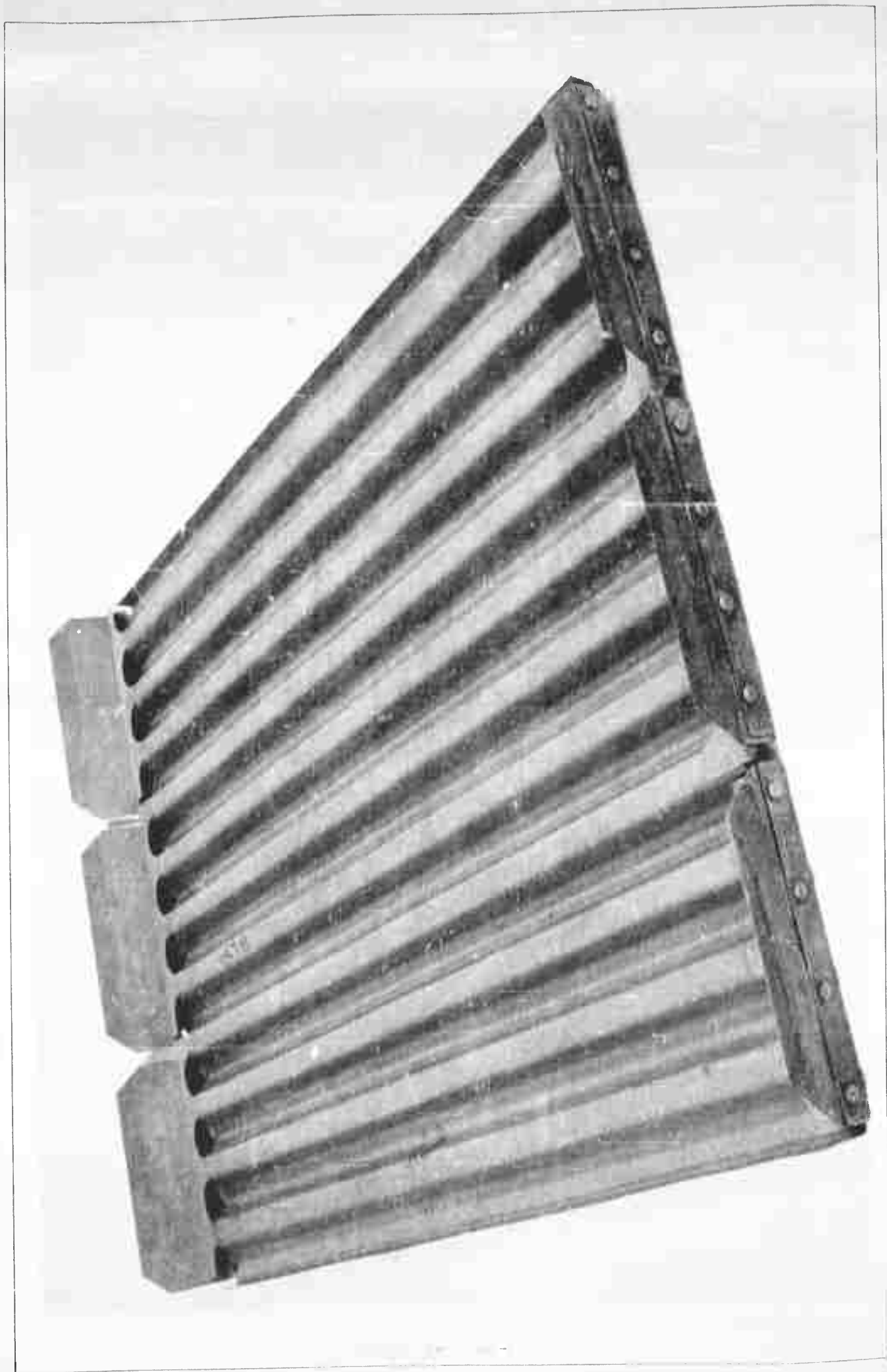
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DYNASOAR NON-INSULATED PANEL TEST SPECIMEN 2A55544
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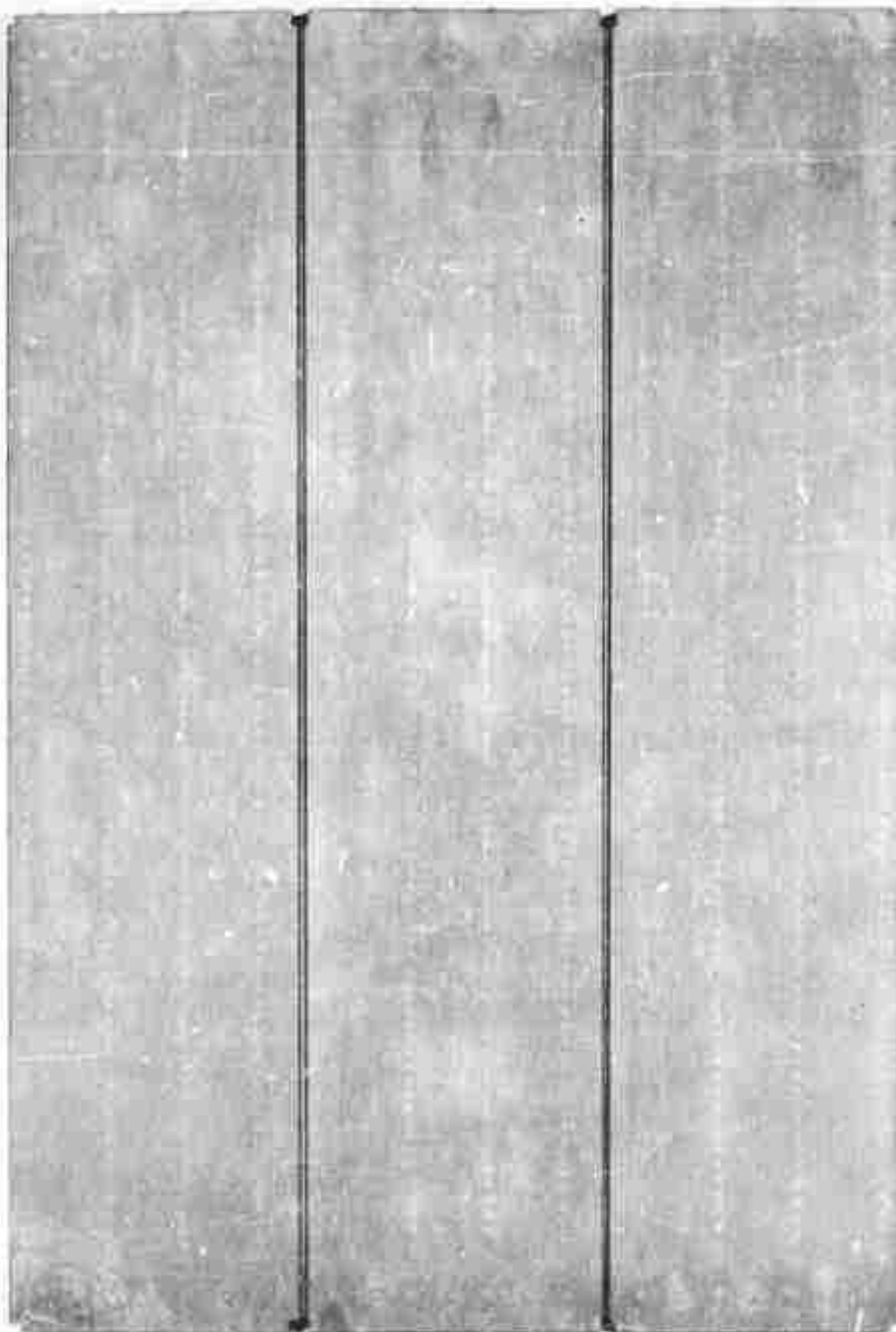
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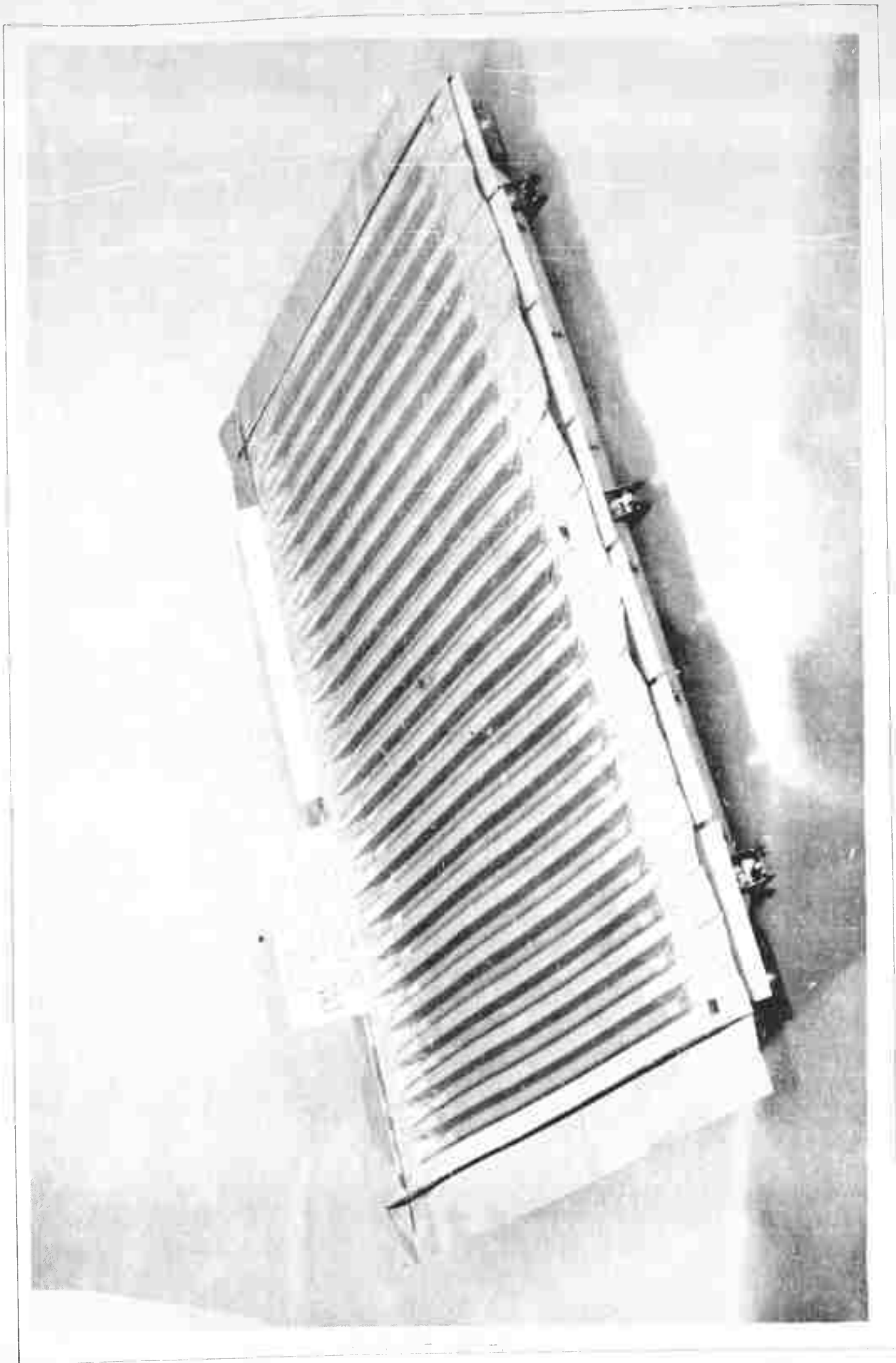
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DS-1 - RESE 41 WING PANELS PWA 1546-L-R3



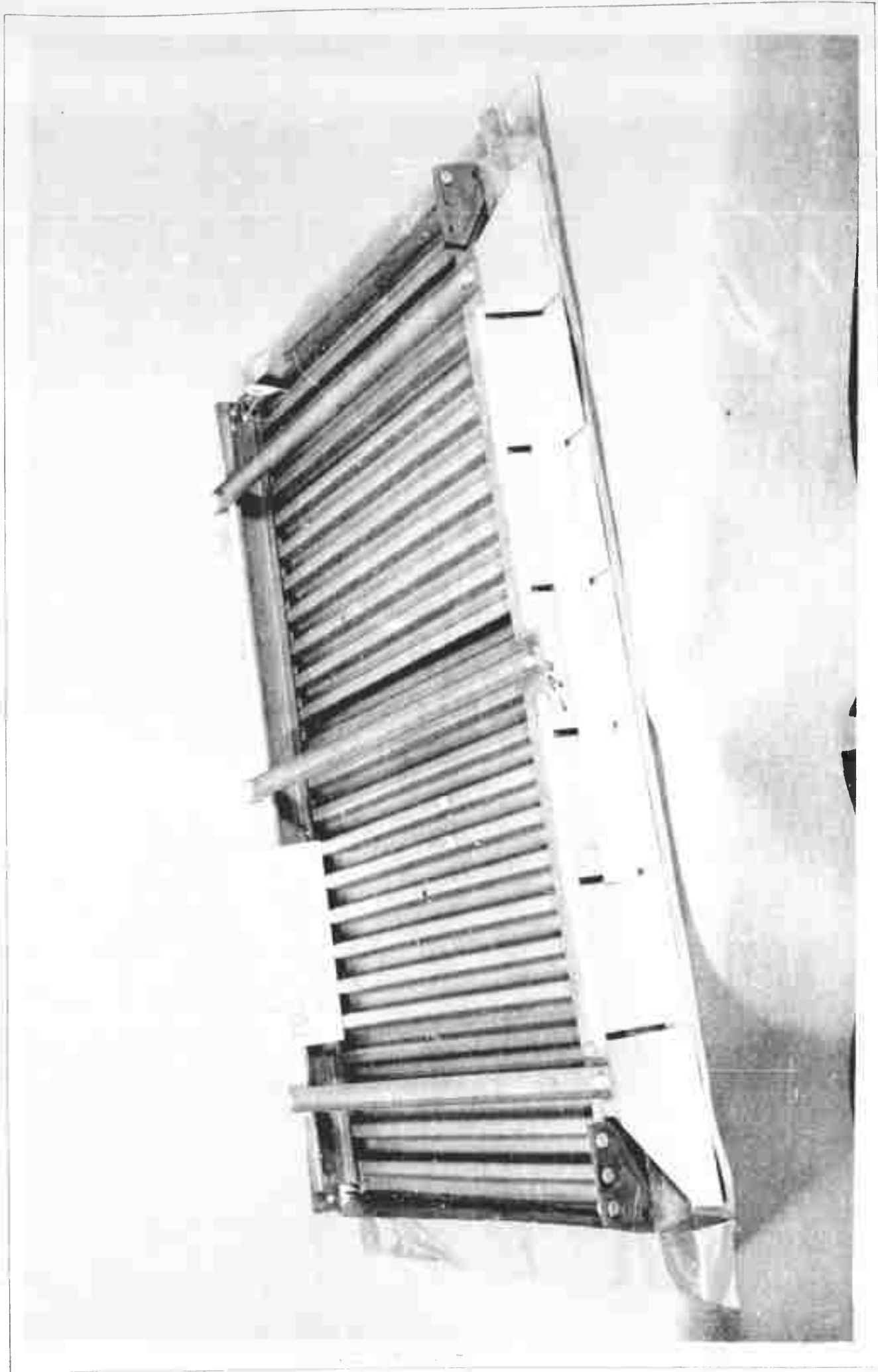
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10-1 - REE #1 #2 #3 #4 #5 #6 #7 #8 #9 #10 #11 #12 #13 #14 #15 #16 #17 #18 #19 #20 #21 #22 #23 #24 #25 #26 #27 #28 #29 #30 #31 #32 #33 #34 #35 #36 #37 #38 #39 #40 #41 #42 #43 #44 #45 #46 #47 #48 #49 #50 #51 #52 #53 #54 #55 #56 #57 #58 #59 #60 #61 #62 #63 #64 #65 #66 #67 #68 #69 #70 #71 #72 #73 #74 #75 #76 #77 #78 #79 #80 #81 #82 #83 #84 #85 #86 #87 #88 #89 #90 #91 #92 #93 #94 #95 #96 #97 #98 #99 #100



U3-4071-1000 (was BAC 1546-L-R3)

BOEING

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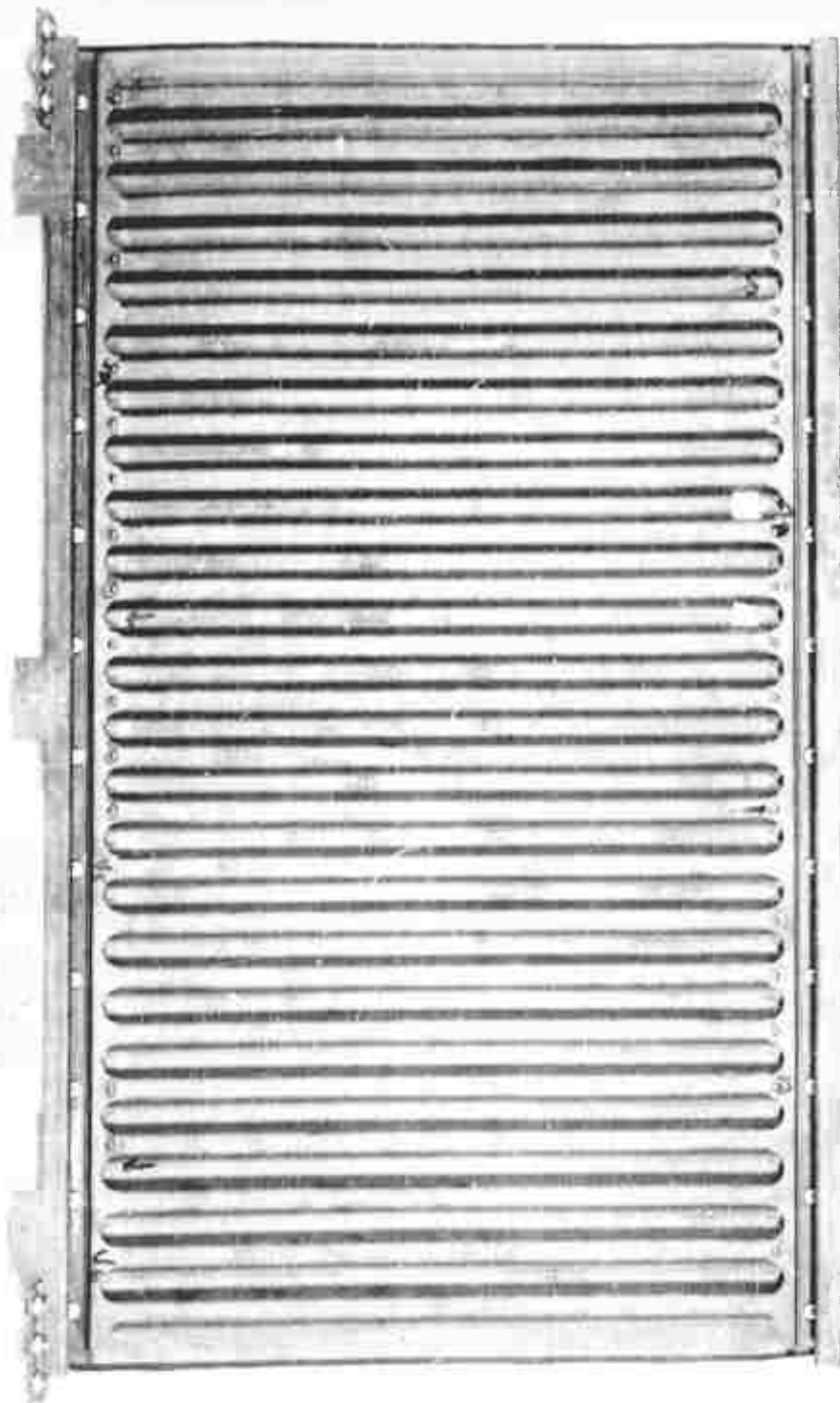
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2462517

3-7-61

DS-I PANEL #25-20570



U3-4071-1000 (was BAC 1546-L-R3)

BOEING

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2A62516

3-7-61

DS-1 PANEL #25-20370

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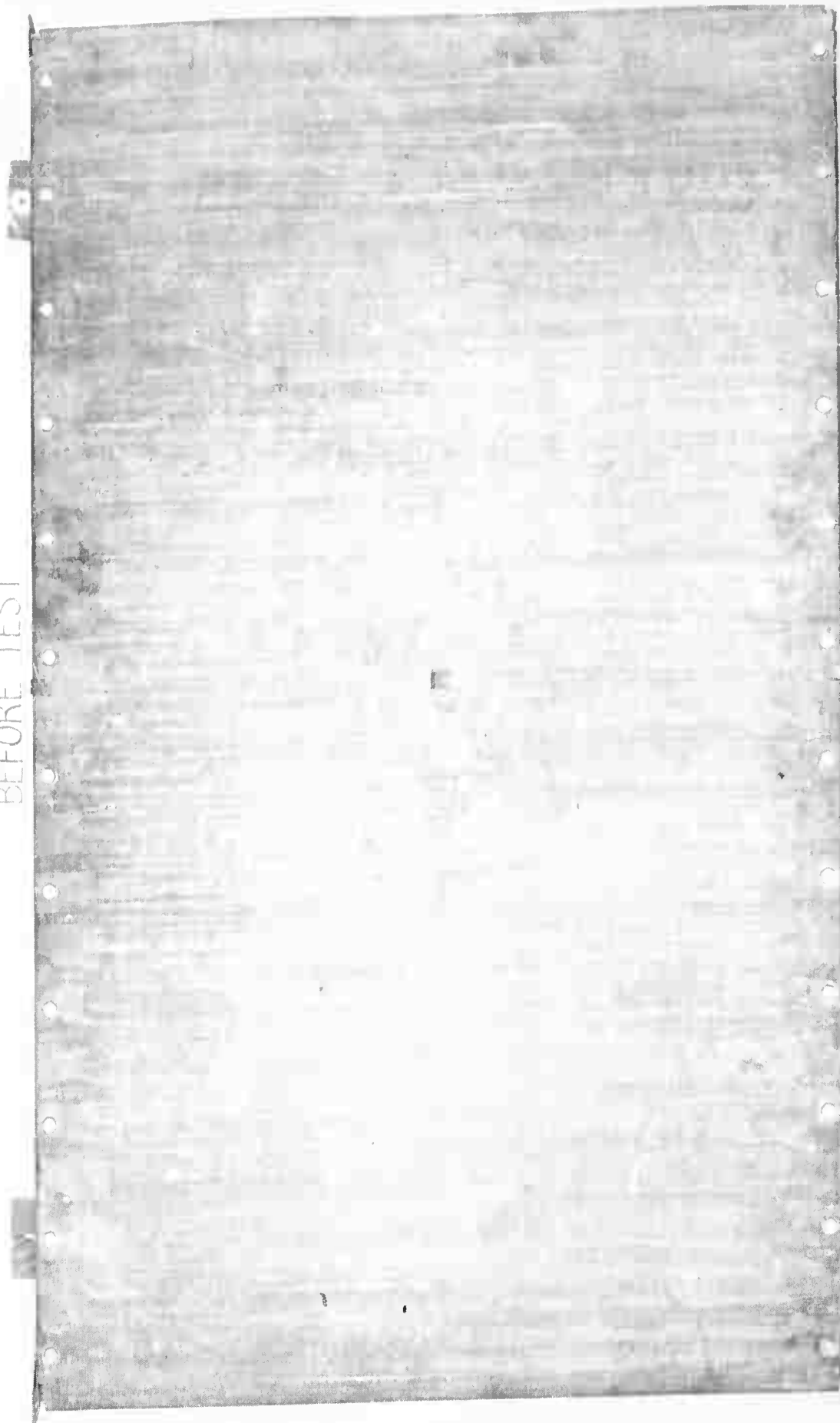


2162515

3-7-61

DS-I PANEL #25-29370

EWA 5-593
DWG. # 25-20370 #1
BEFORE TEST



U3-4071 1000 (was BAC 1546-L-R3)

BOEING

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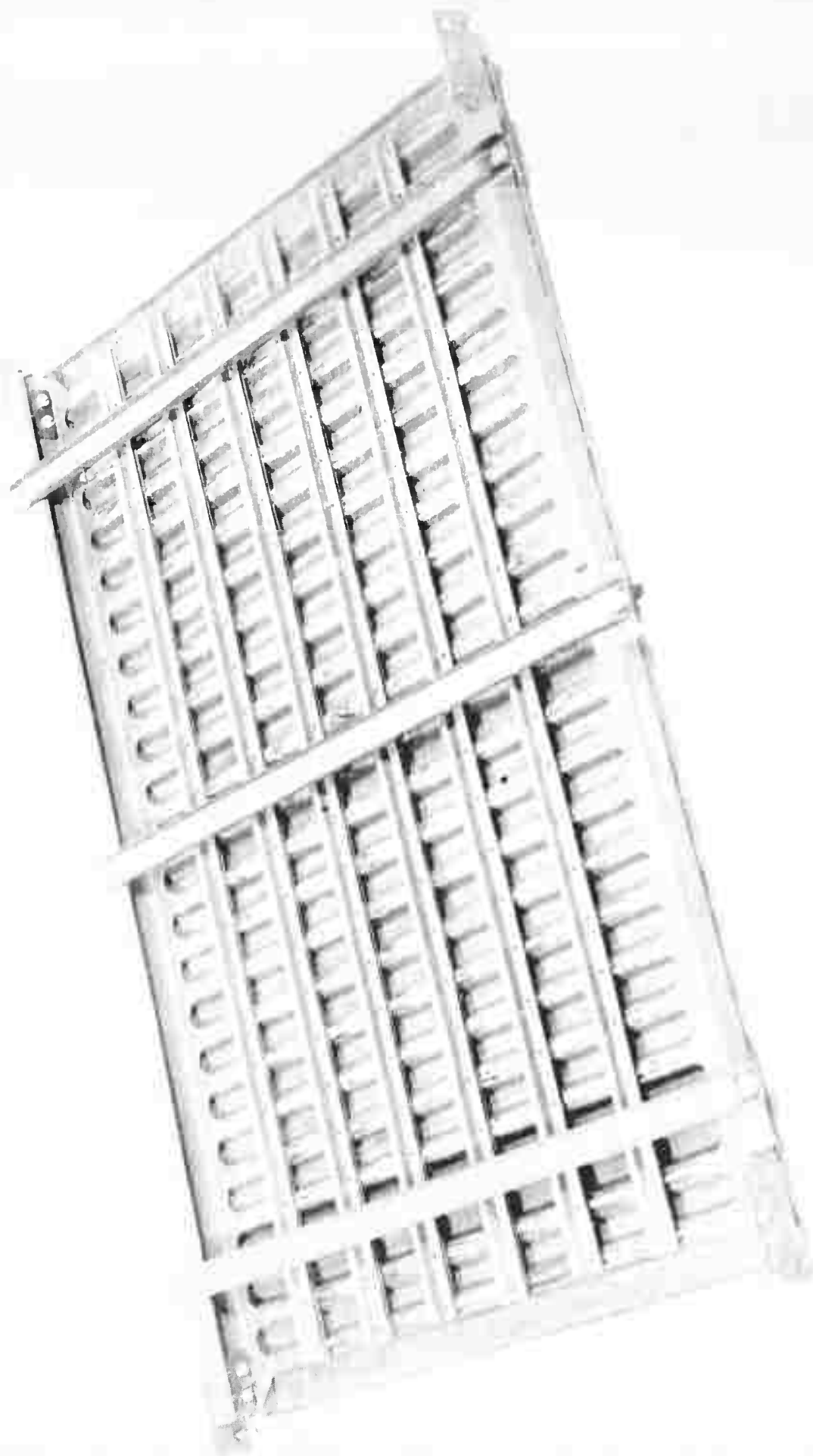
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DRAKOP PANEL TYPE I

2893065



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BOEING

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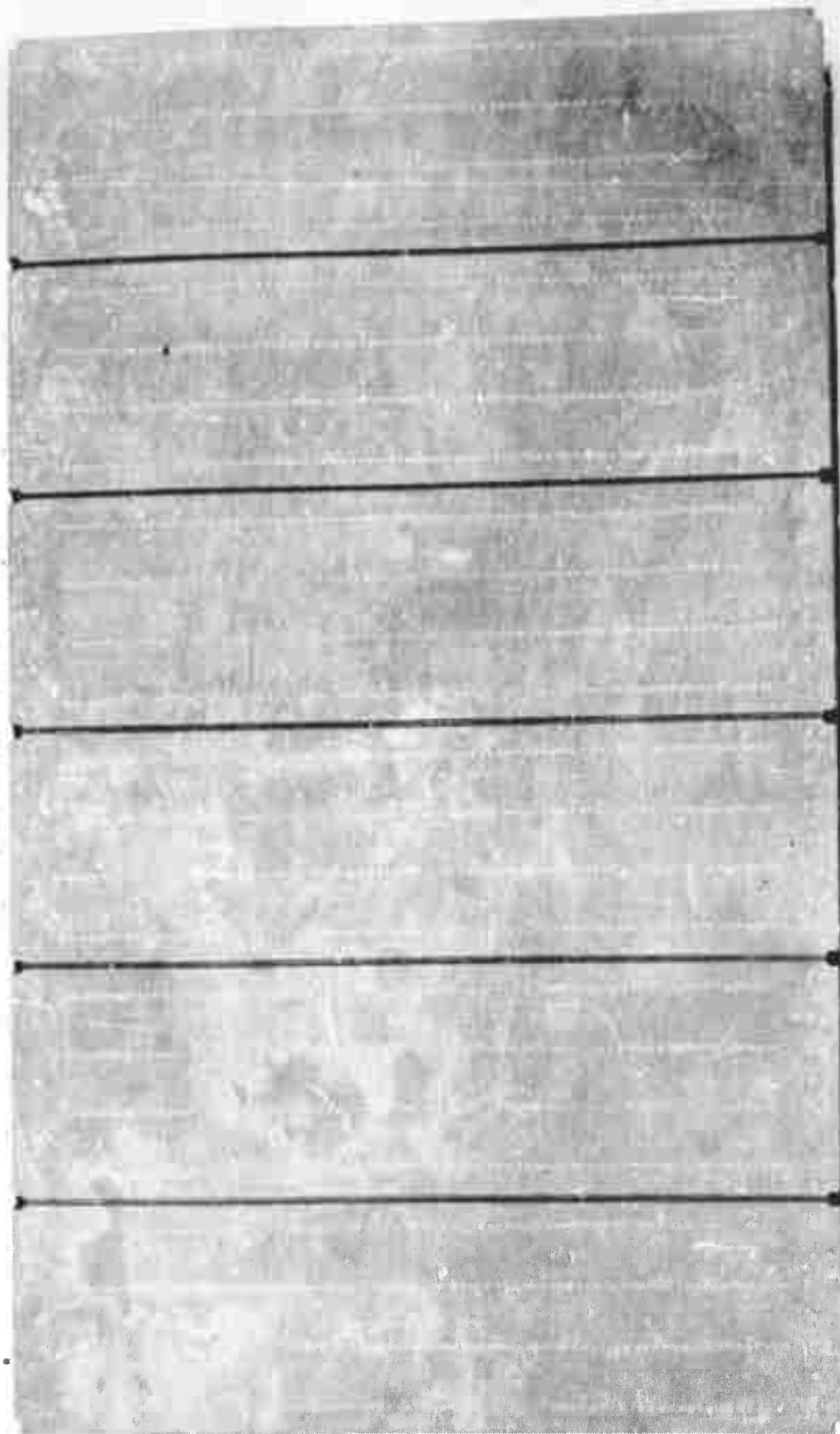


JA62513

3-7-61

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QWA 5 556
QWL #25-20552 #1
BEFORE TEST

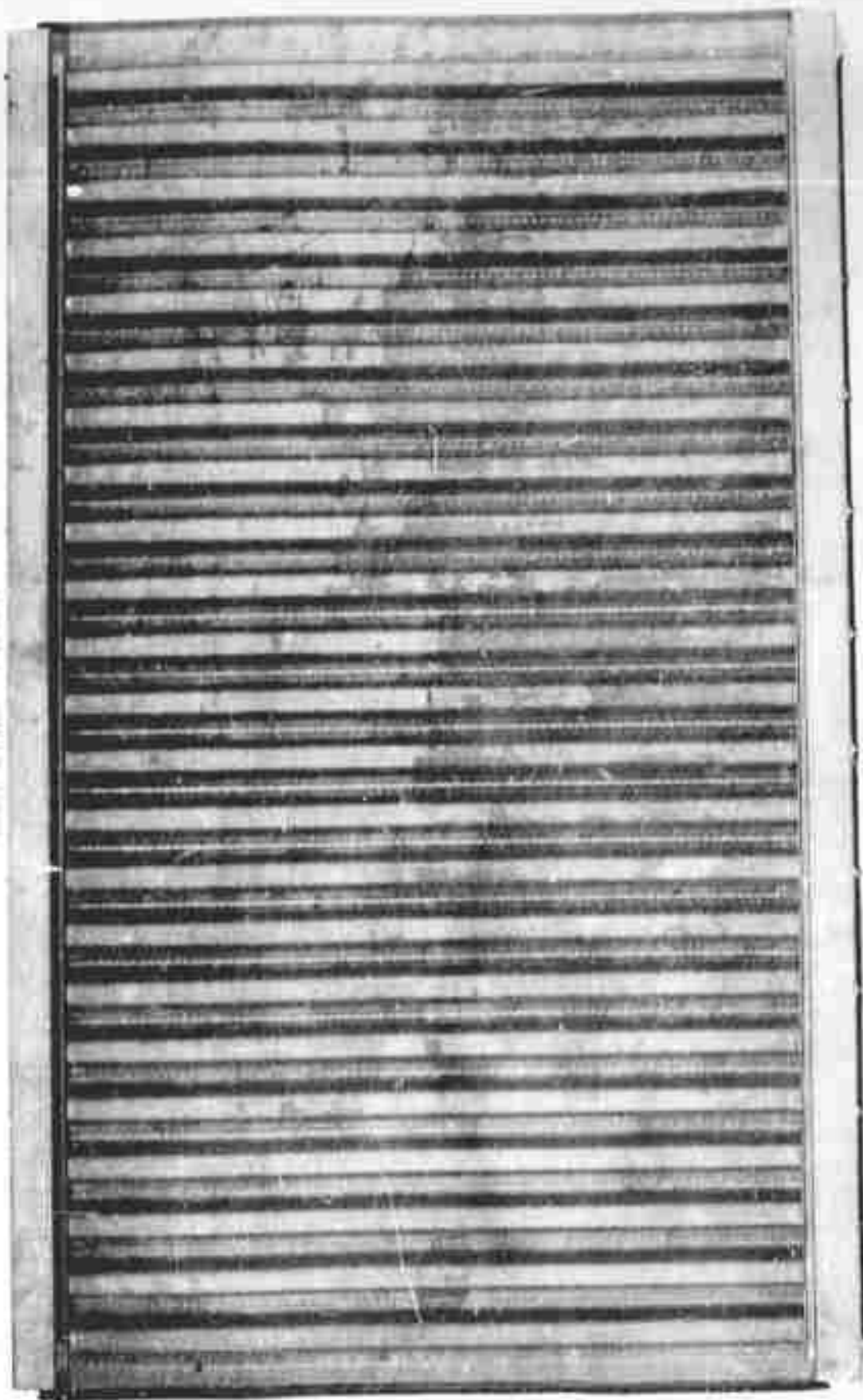


2A62509

3-7-61

DS-1 PANEL #25-20552

FINA 5-593
DWG # 25-20552
BEFORE TEST



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BOEING

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DS-I WING PANELS EWA 5-593

3-16-61

2405045

U3.4071-1000 (was BAC 1546-L-R3)

BOEING

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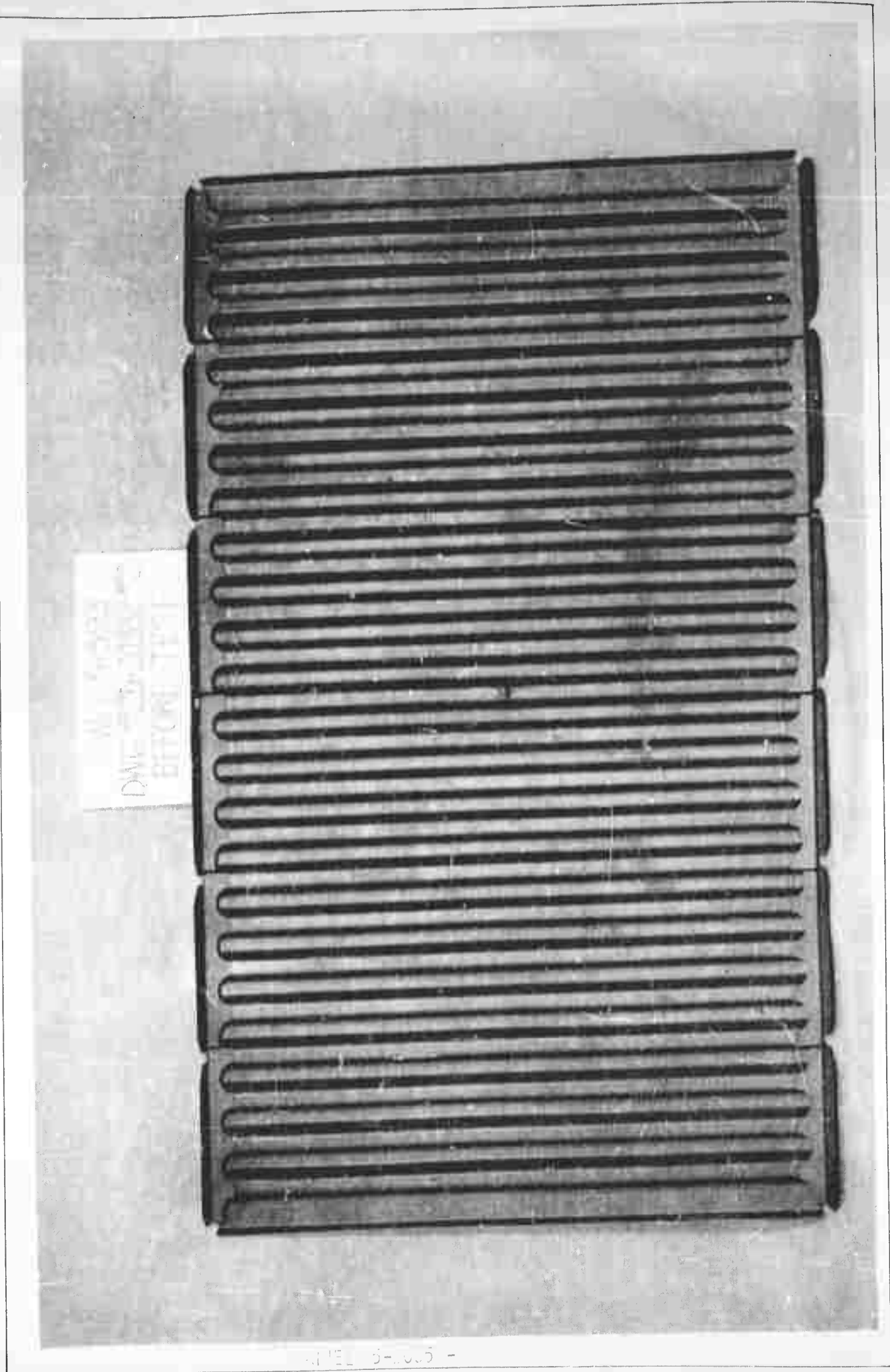
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2463050

DS-I WING PANELS BWA 5-593 3-16-61

U3-4071-1000 (was BAC 1546-L-R3)



MODEL 5-1005 -

BOEING

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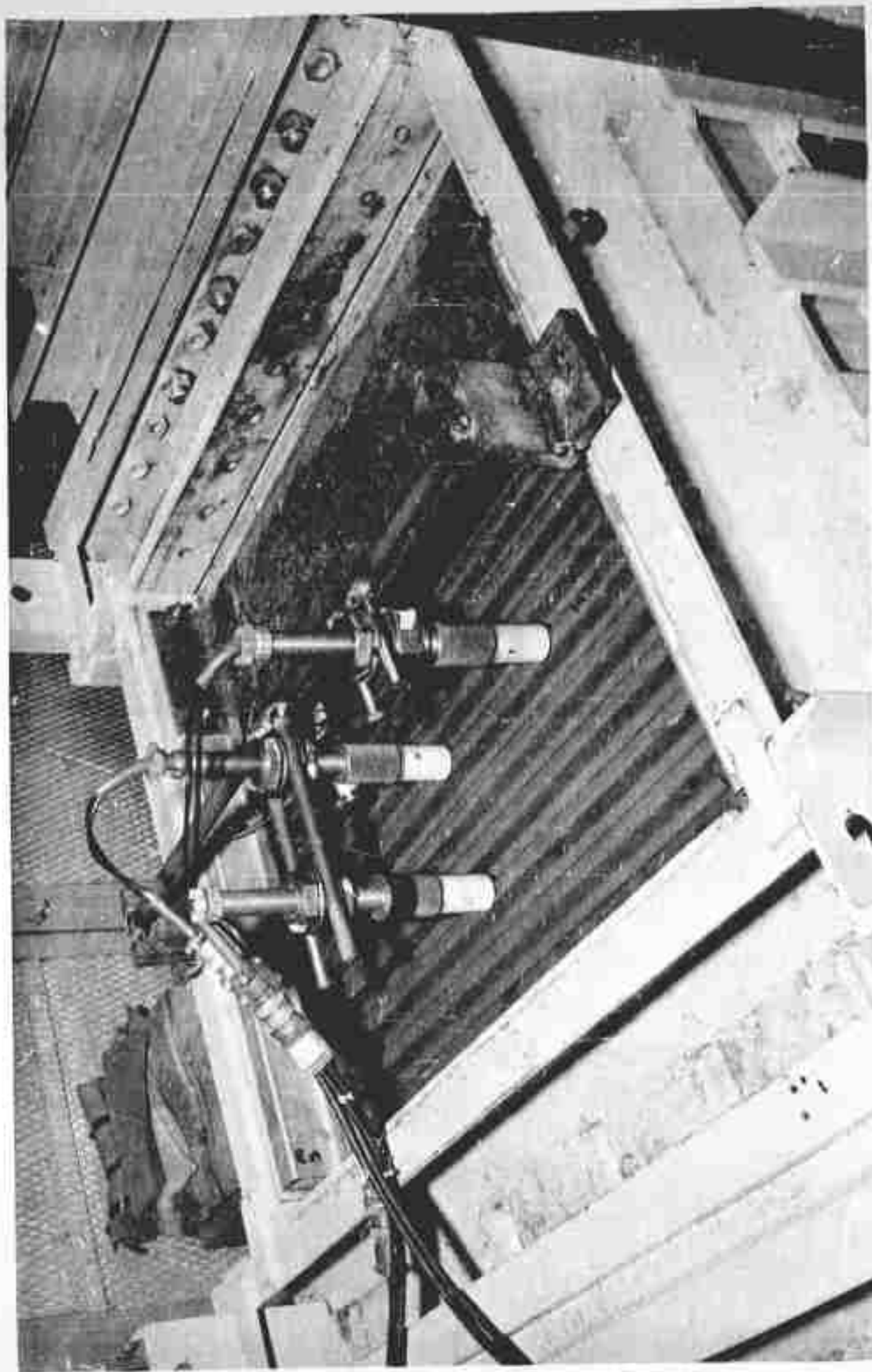
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FILE



DYNASOAR NON-INSULATED PANEL SONIC TEST
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 12-9-60
 SETUP



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BOEING

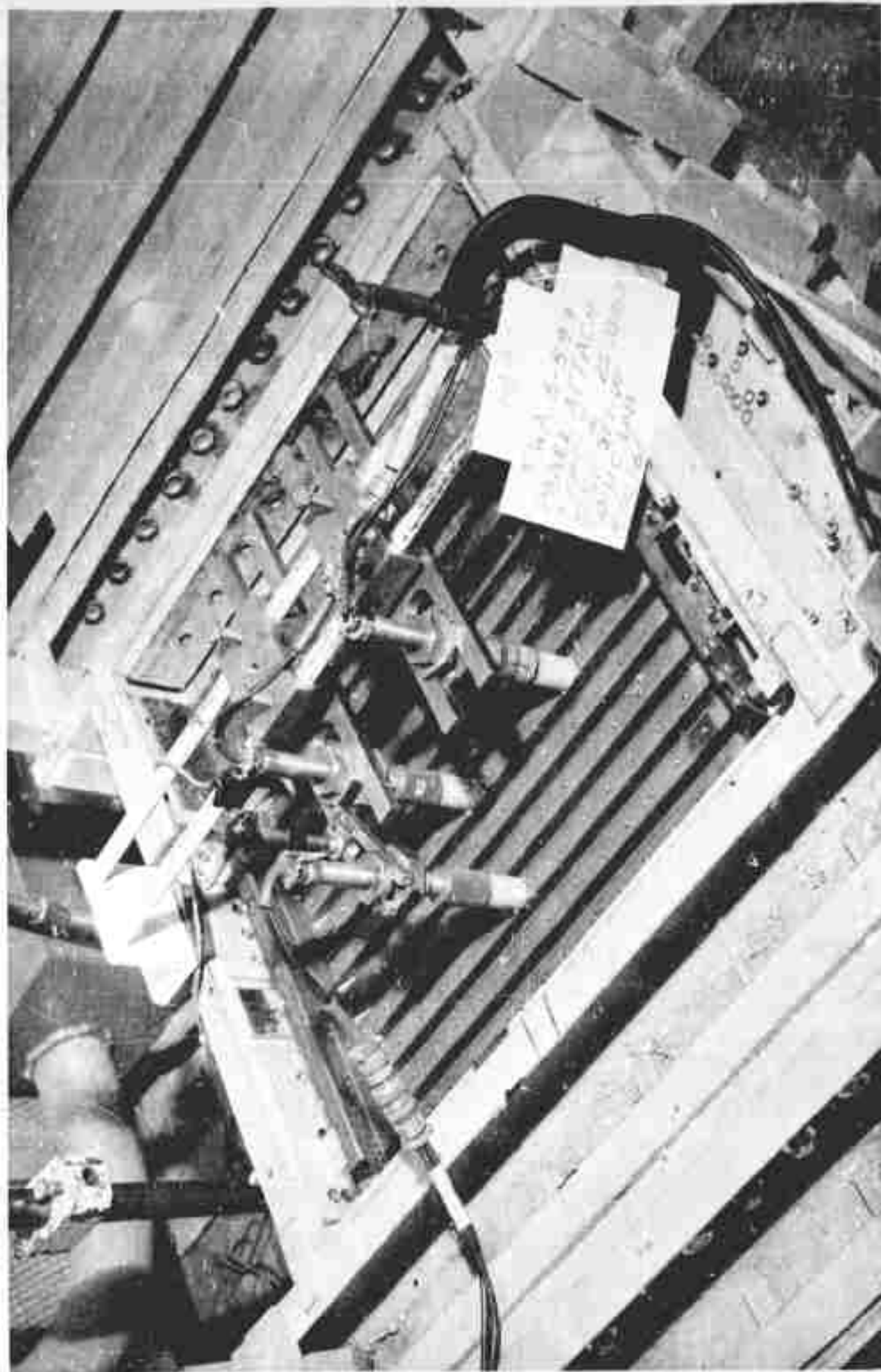
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7401



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5-10-61 2A06576



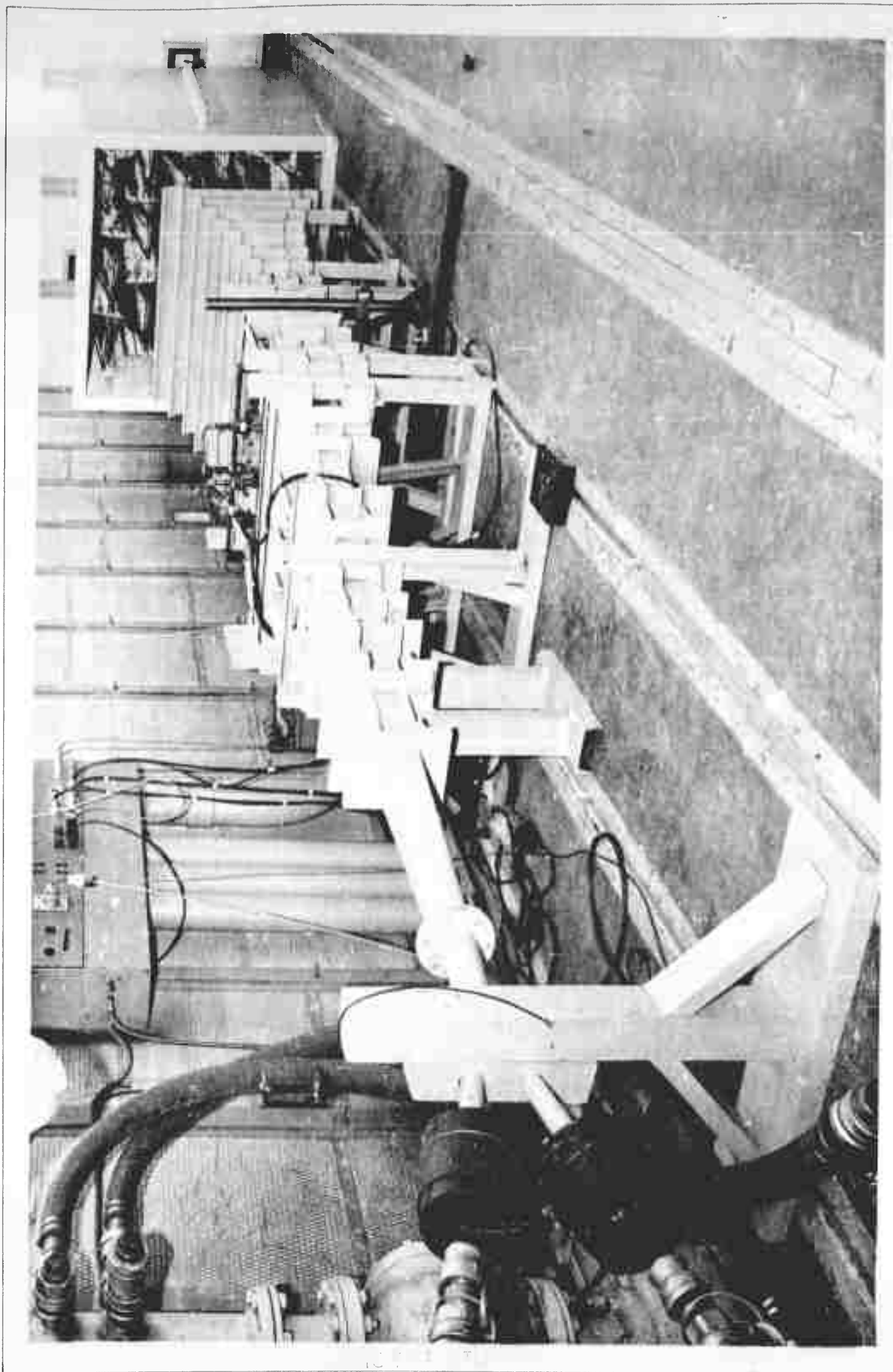
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DYNASOAR NON-INSULATED PANEL SONIC TEST
SETUP
12-9-60 2A55509



U3-4071-1000 (was BAC 1546-LR3)

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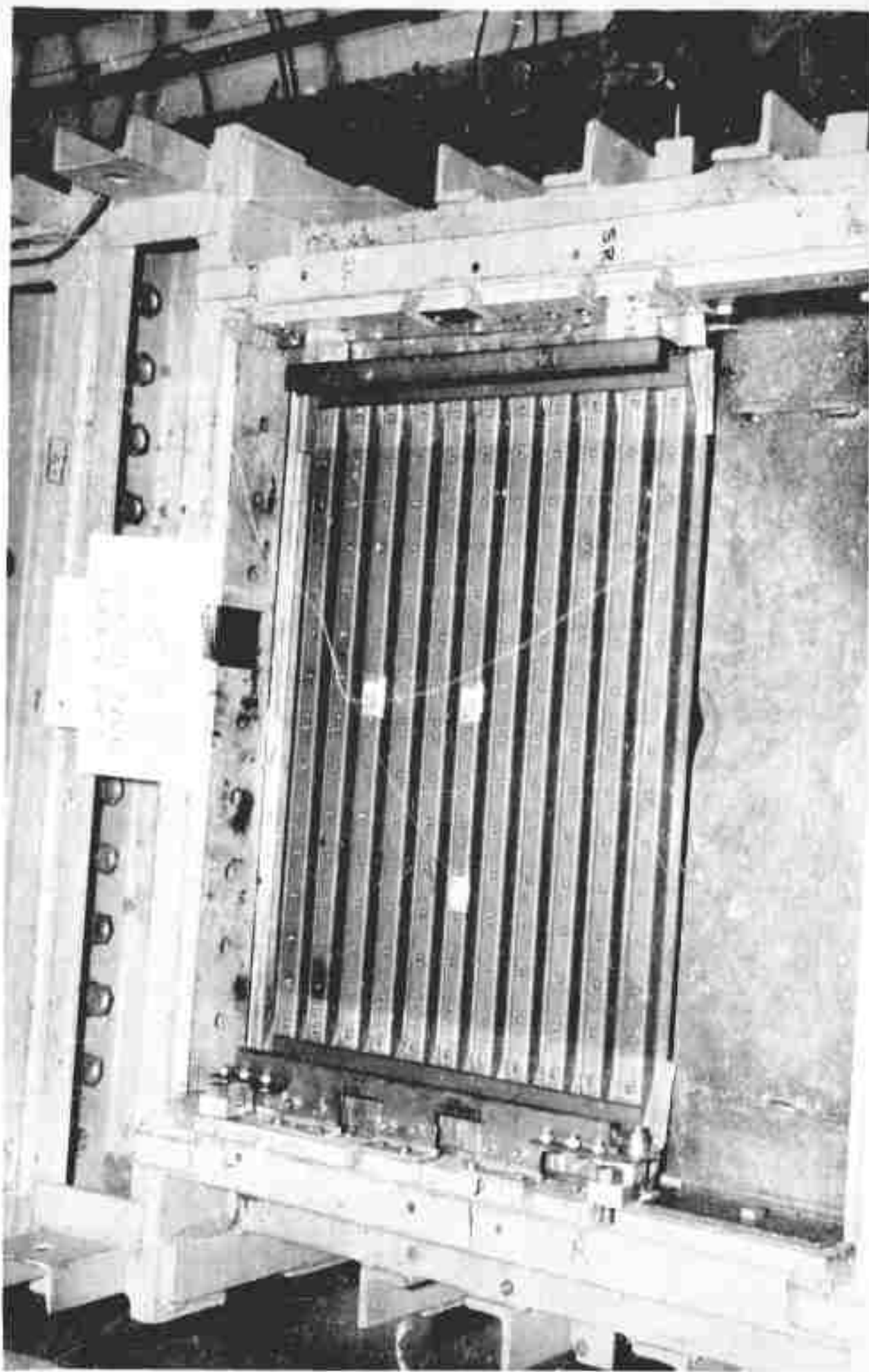
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2A66575

PS-1 EWA 5-593 PANEL 1499 TEST SETUP
5-10-61



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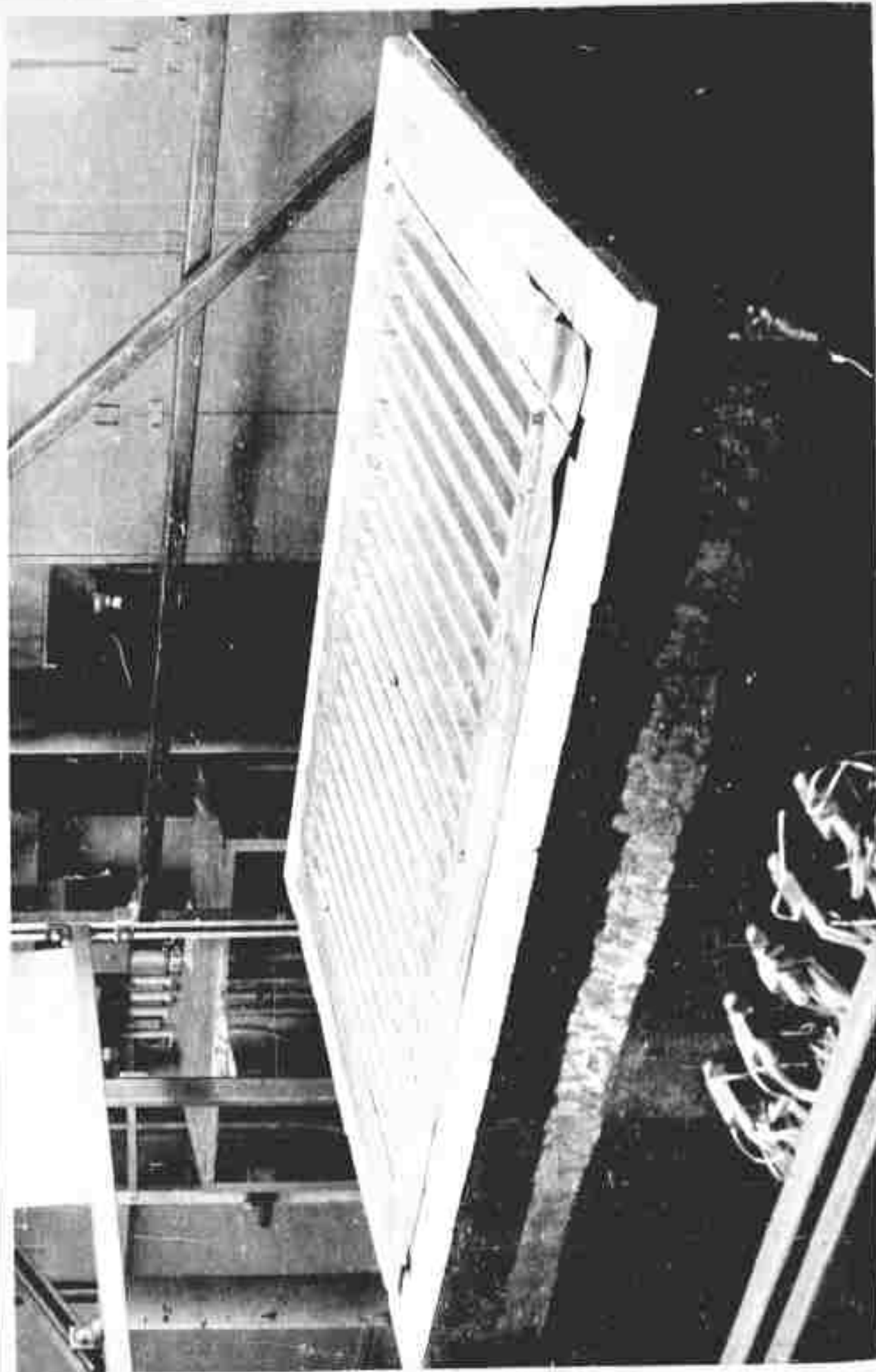
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Doc 1 - PANEL ATTACHMENT TEST: E4A 7-1-03 4-10-64 JAG/SJA



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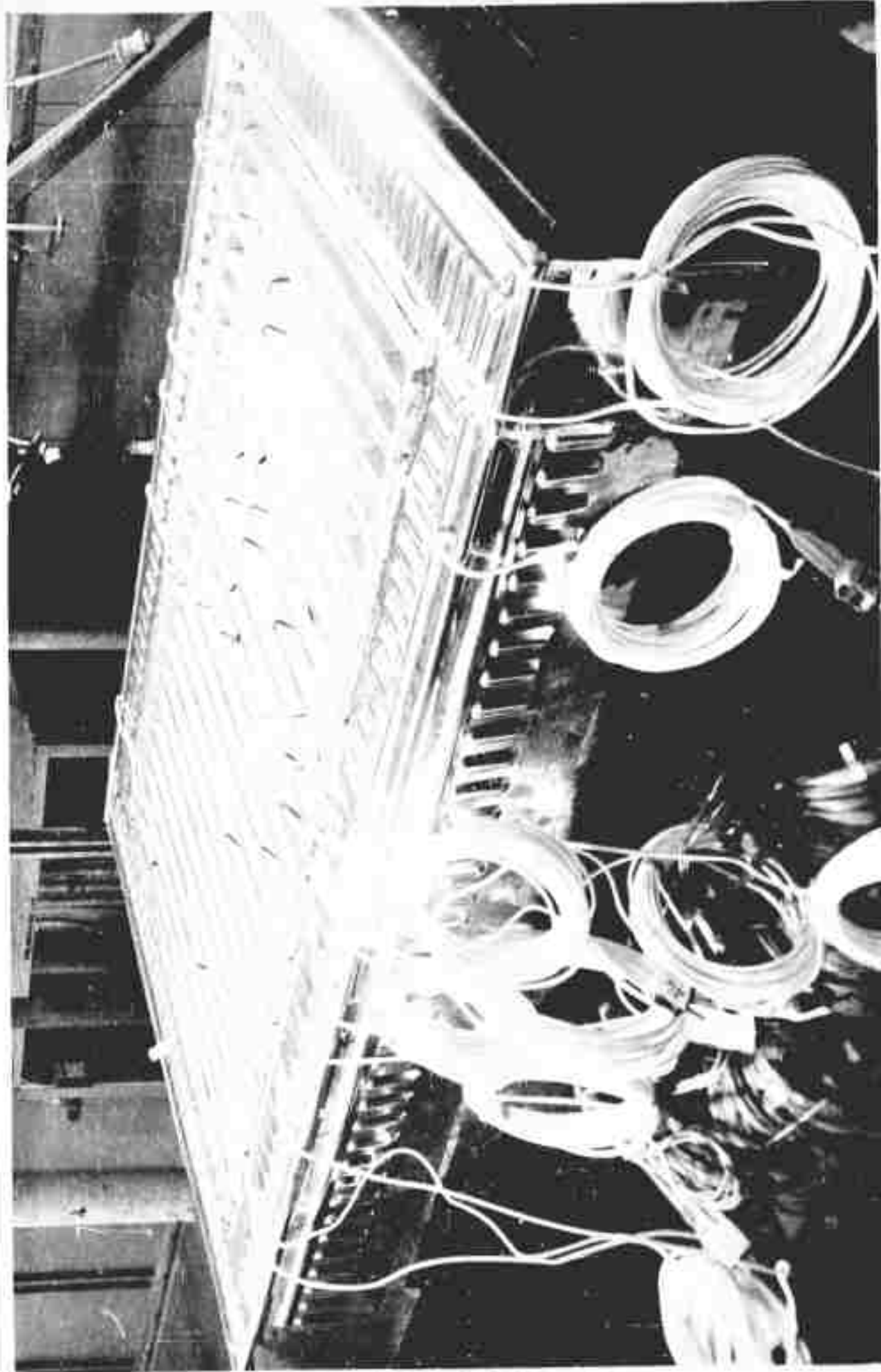
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DS-I - WING PANEL TEST SETUP EWA 5-593
4-21-01



WING PANEL HEATING SYSTEM TEST

U3-4071-1000 (was BAC 1546-L-R3)

BOEING

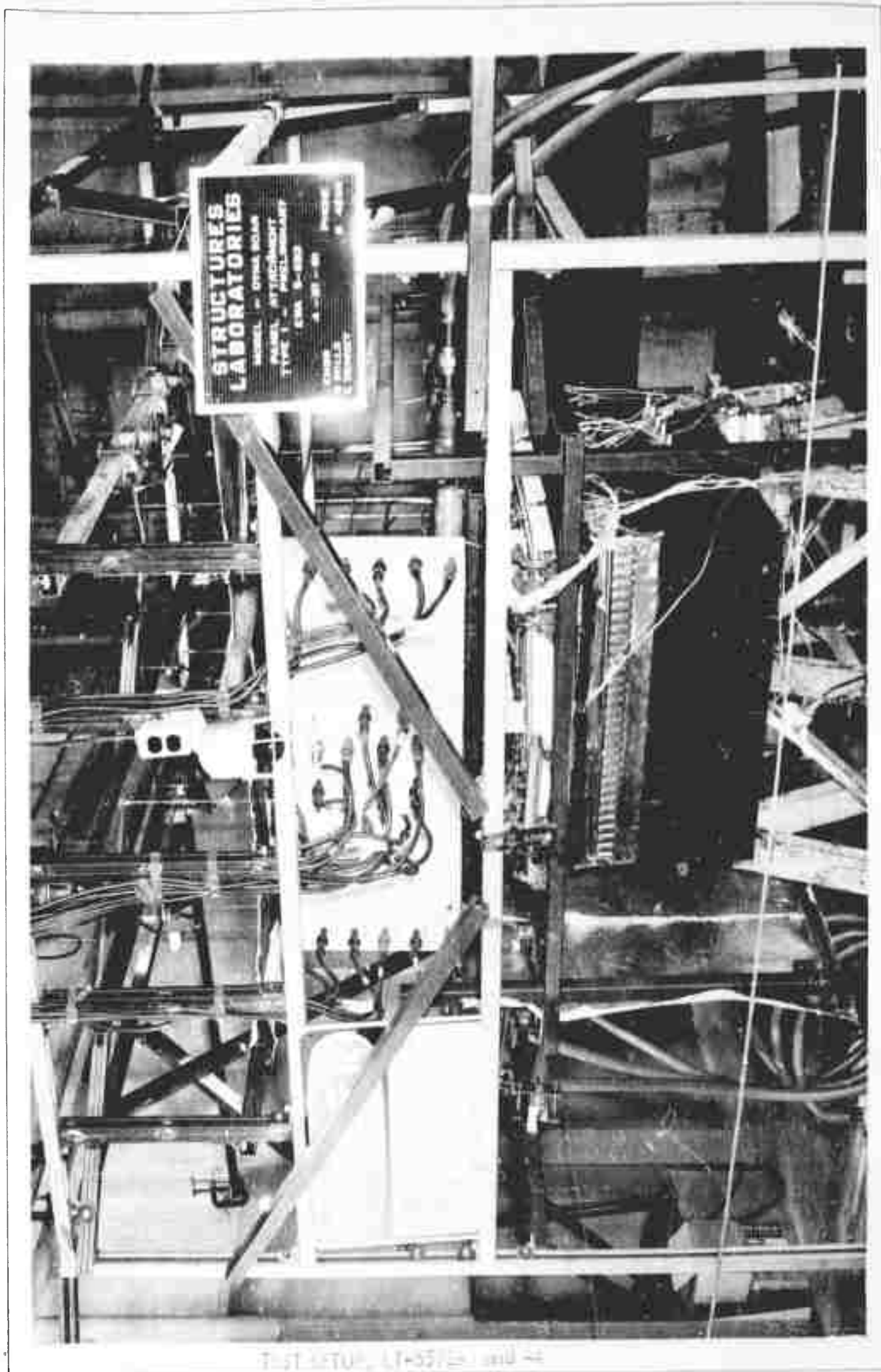
VOL I

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DS-1 WING PANEL TEST SETUP DWA 5-593
5-2-61 2A65952



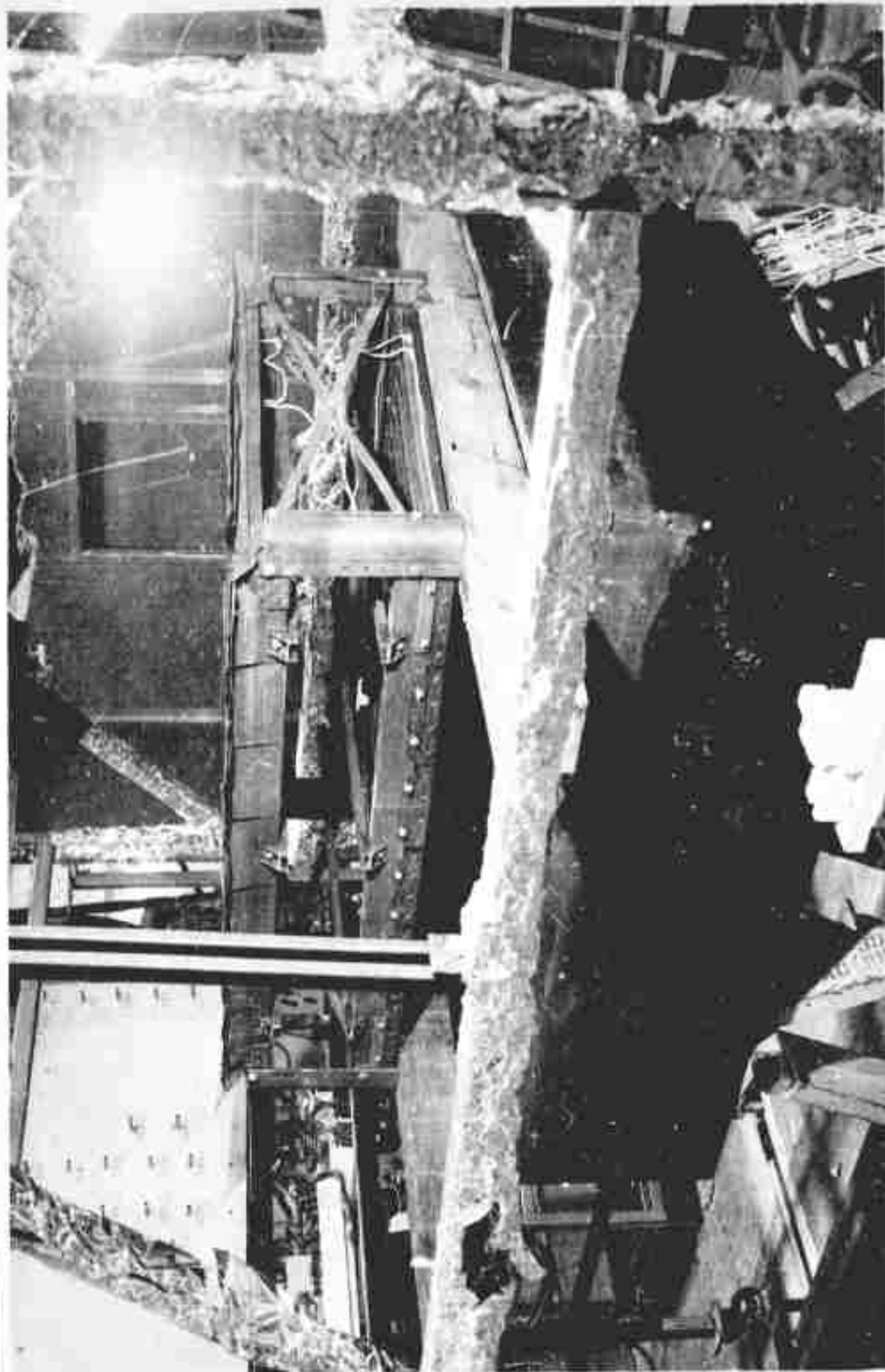
U3-4071-1000 (was RAC 1546-L-R3)

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PAGE 2167.5



2A56648
THERMO-FATIGUE TEST OF SIMULATED WING PANEL
DS-I 8-21-61



PANEL MOUNTING FOR INSTALLATION IN P. CLAM LOX

DS-401-100 1944 BAC 1944-RTT

BOEING

VOL I

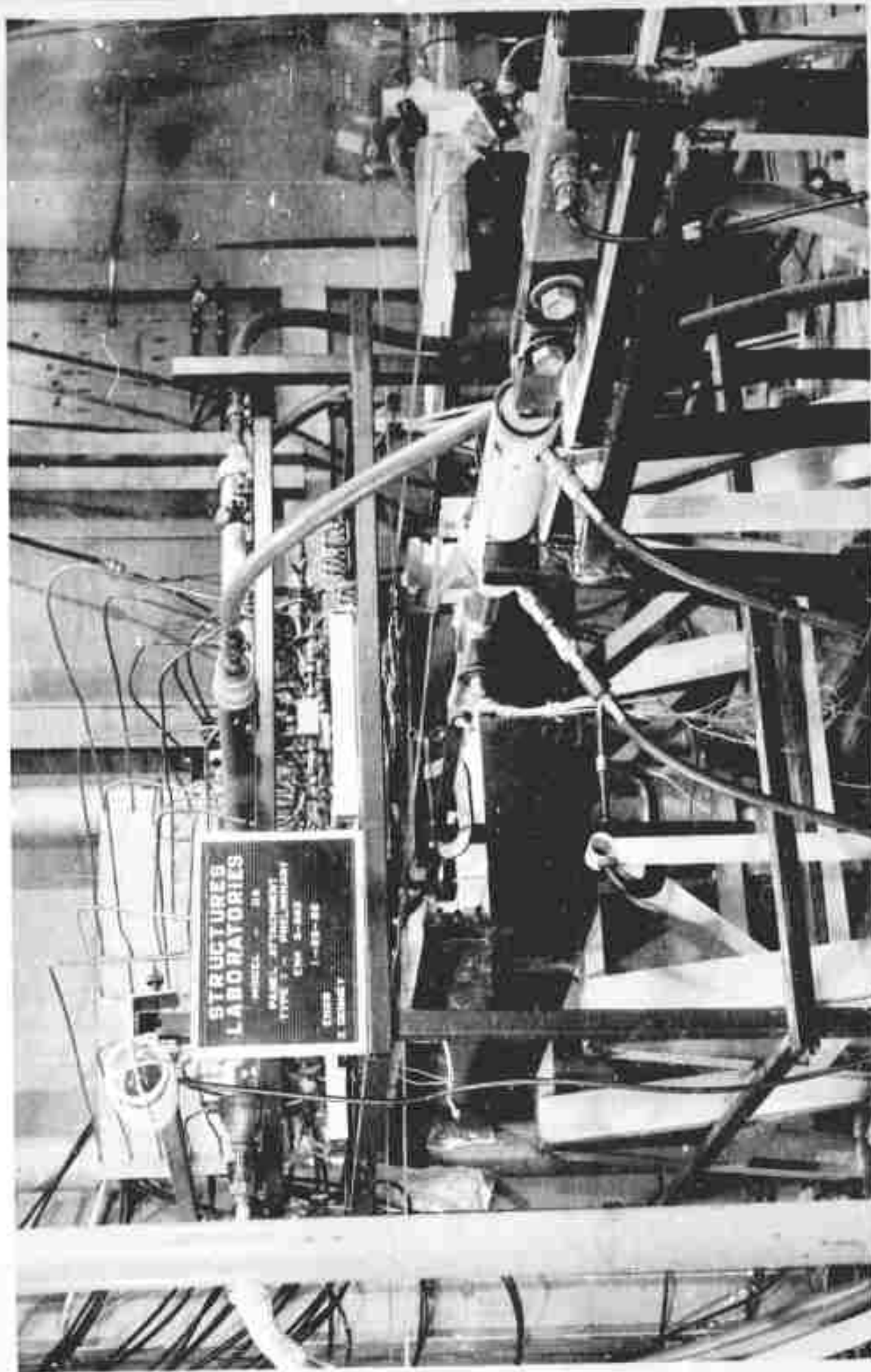
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1-26-62 2A100019

DS-1 WING PANEL SHEAR TEST



U3-4071-1000 (was BAC 1546-L-R3)

BOEING

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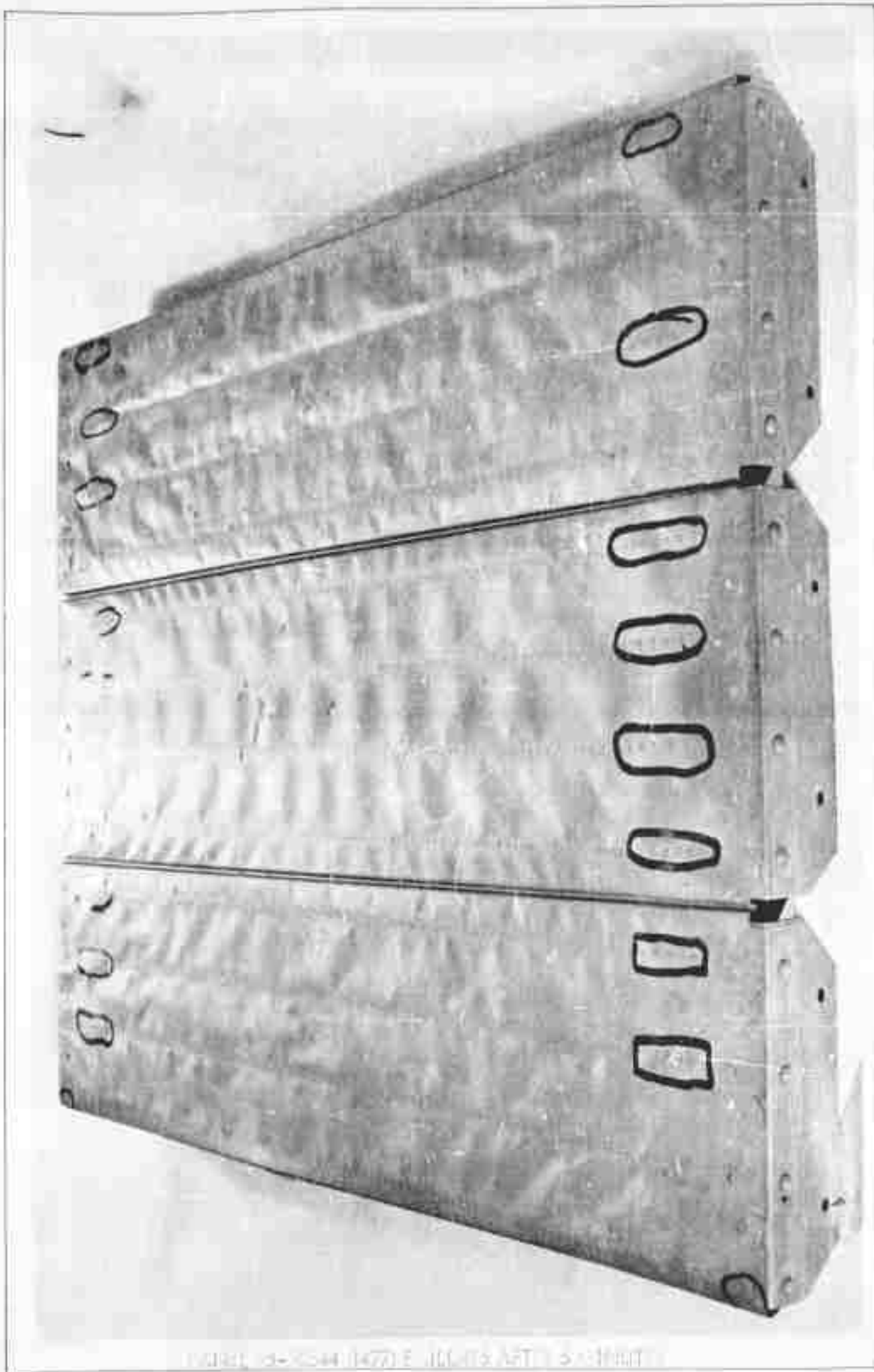
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102-1001-1

FIG 2



DYNASOAR SONIC TEST PANEL #1477 FAILURE
 DIAGRAM #2A 12-20-60 2453656



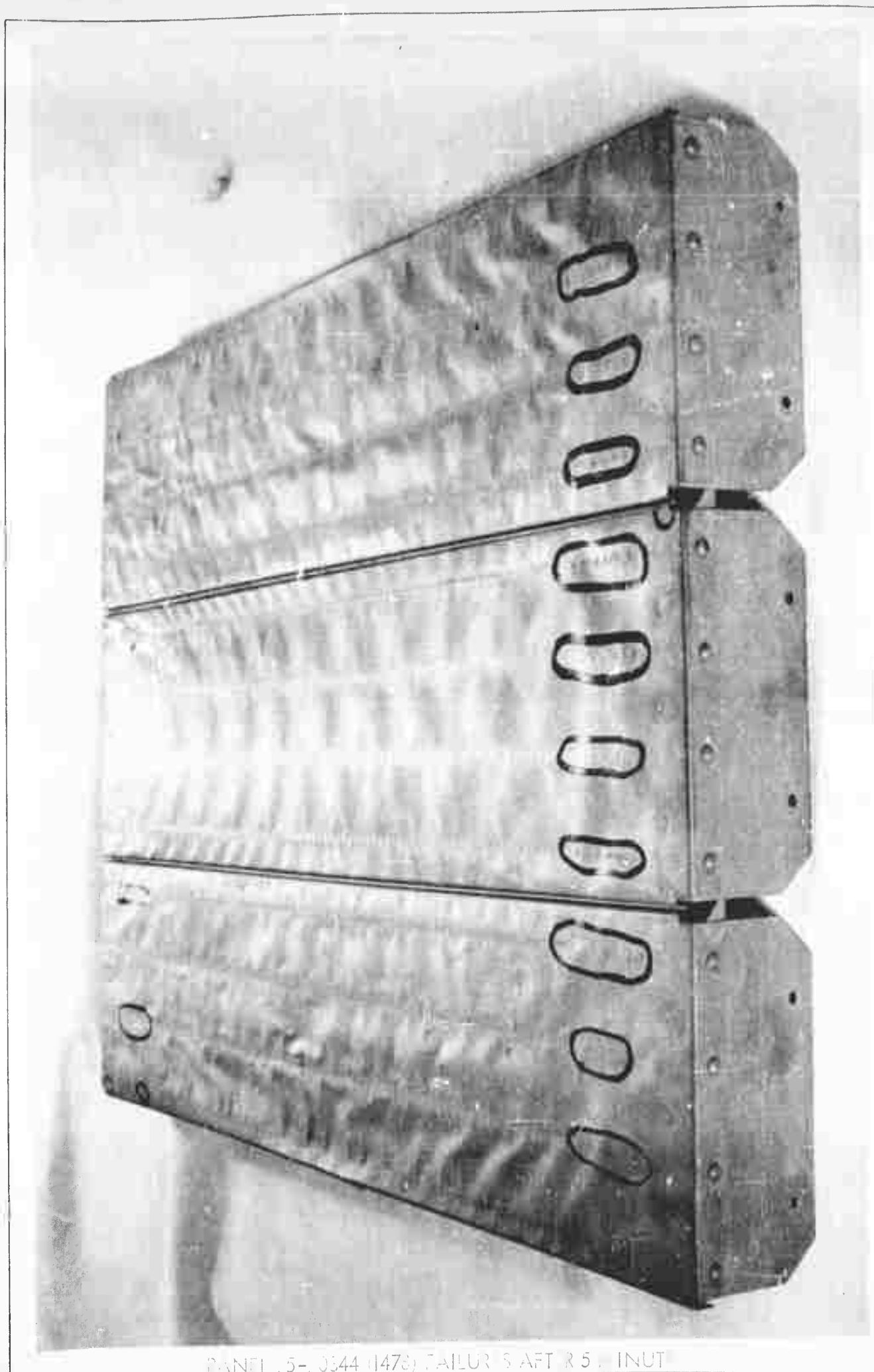
U3-4071-1000 (was BAC 1546-L-R3) SONIC TEST AND 15 MINUTE HEAT TEST

BOEING
 VOL I

NO. D2-10004
 PAGE FIG. 25



DYNASOAR SONIC TEST PANEL #1478 FAILURE
 DIAGRAM #2A
 12-20-60
 2453957



PANEL 15-0344 (1478) TAILOR'S AFT R 5. INUT
 SONIC TEST AND 15. INUT THERM T ST

U3-4071-1000 (was BAC 1546-L-R3)

BOEING

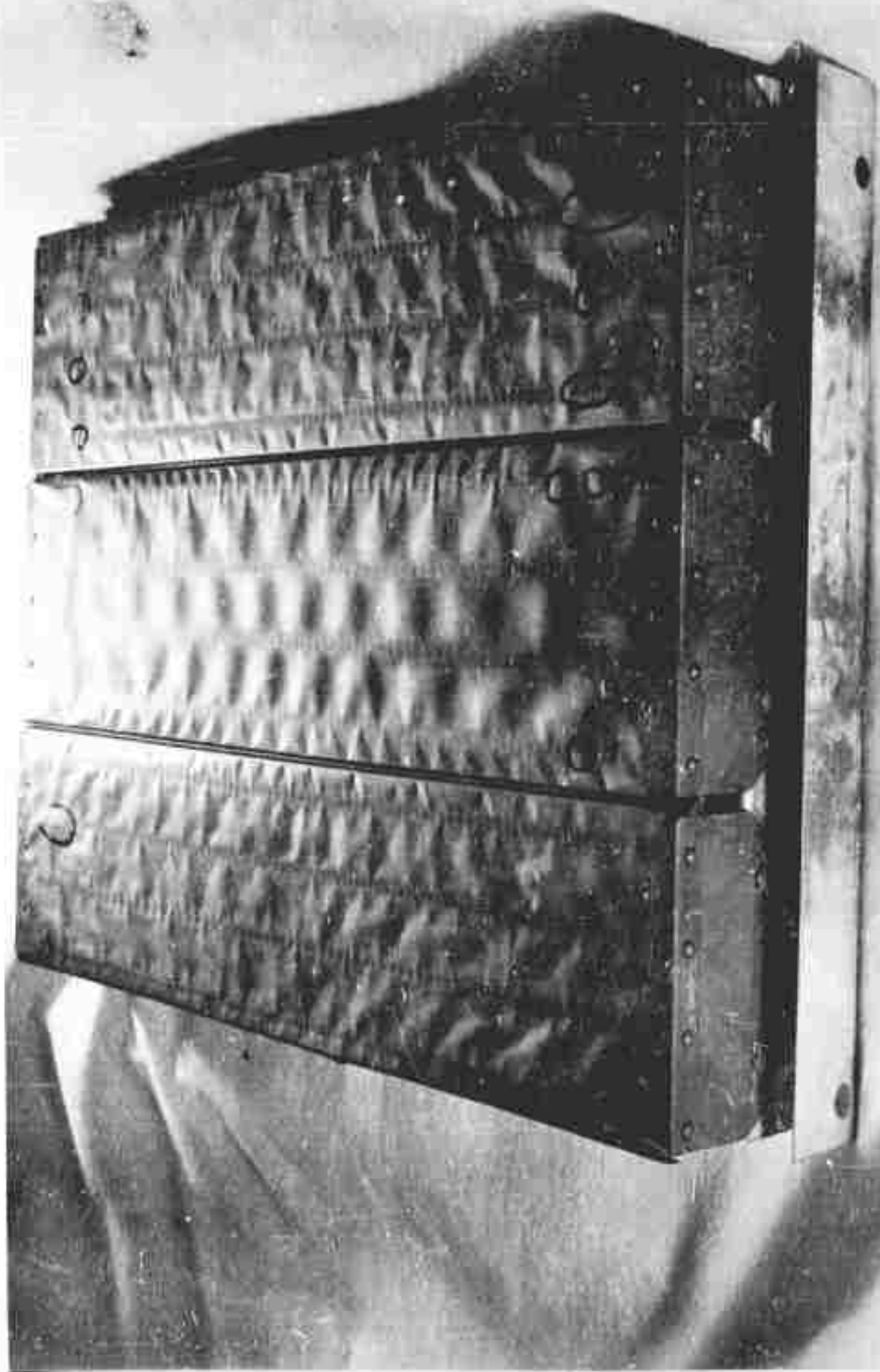
VOL I

NO. D2-0004

PAGE FIG. 27



DYNASOAR SONIC TEST PANEL FAILURE - HEAT PANEL
NO. 3 RE-TEST 12-19-60 2A53942



PANEL 15-10344 (1479) FAILURE 5 AFT. 15 MINUT
SONIC TEST AND 157 INUT HEAT TEST

U3-4071-1000 (was BAC 1546-L-R3)

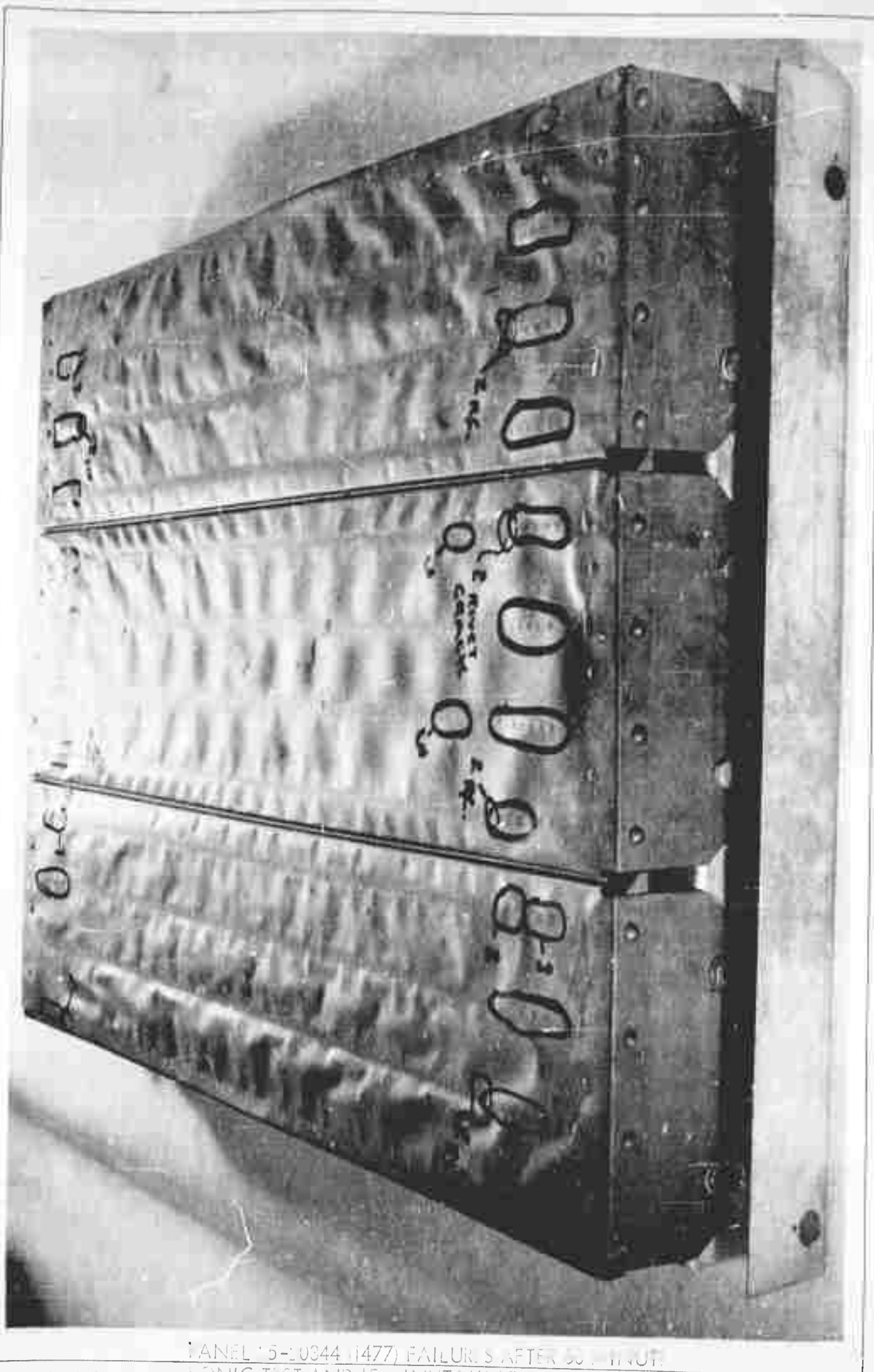
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PAGE FIG. 25





PANEL 15-20344 (1477) FAILURES AFTER 50 MINUTE
SONIC TEST AND 15 MINUTE HEAT TEST

U3-4071-1000 (was BAC 1546-L-R3)

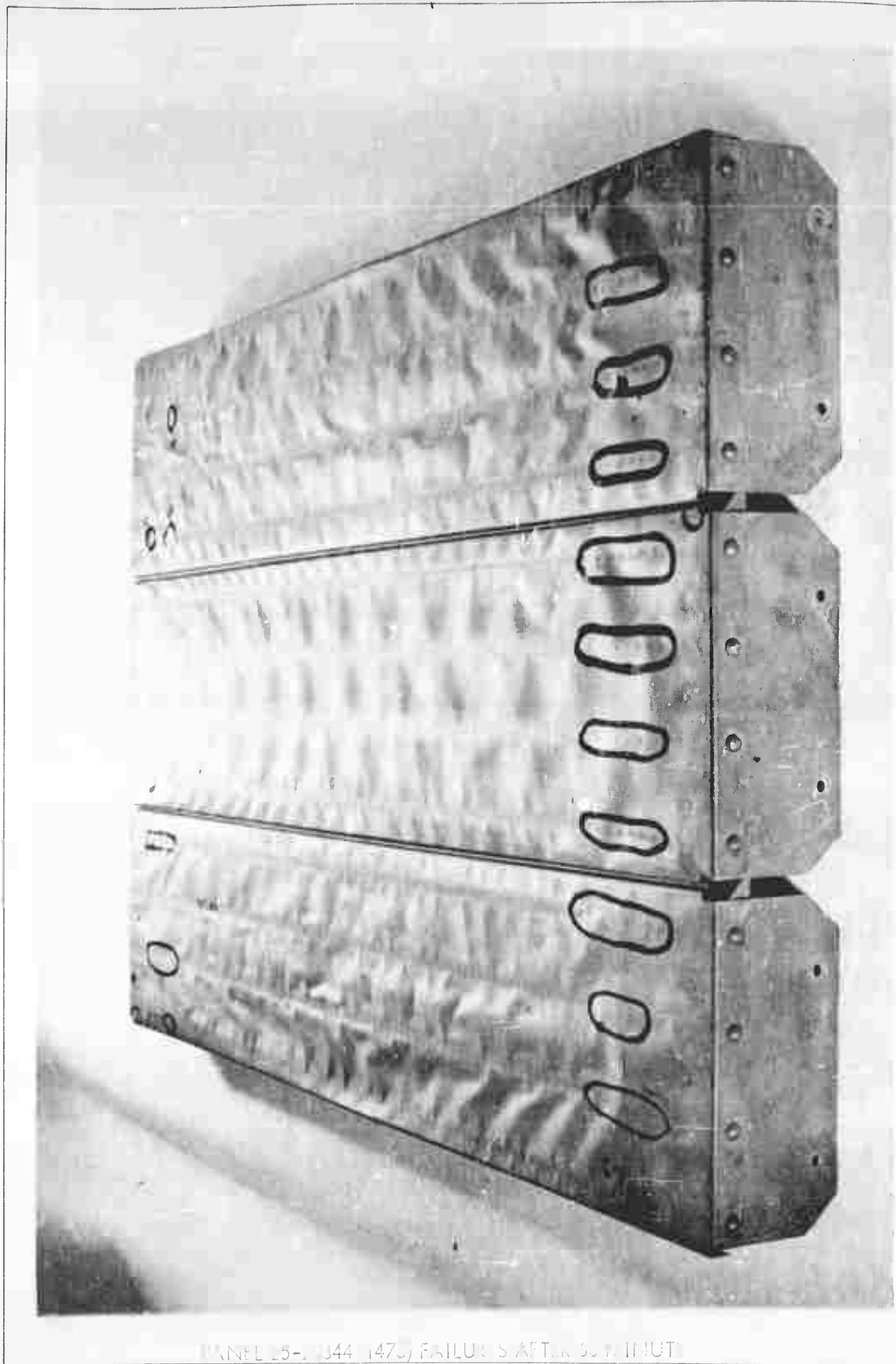
BOEING

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PAGE FIG. 29





PANEL 25-2344 (1478) FAILURES AFTER 50 MINUTE
SONIC TEST AND 15 MINUTE HEAT TREAT

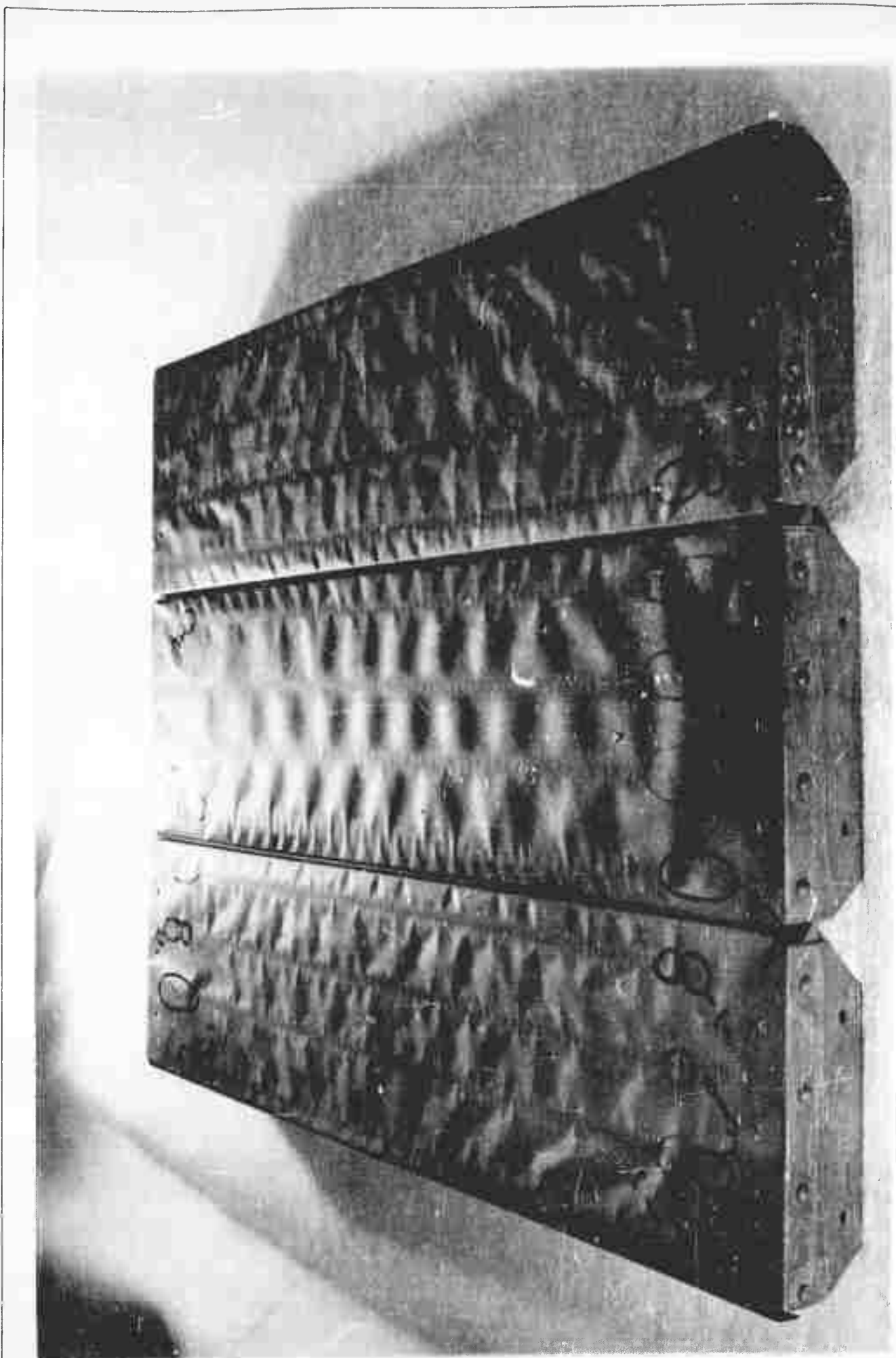
U3-4071-1000 (was BAC 1546-L-R3)

BOEING
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PAGE FIG. 30



2A54932
 IS-I PANEL #1179 SONIC TEST FAILURE DIAGRAM
 12-28-60



PAN. L 15-0344 (147% FAILURES AFTER 60 MINUT.
 SONIC TEST AND 15 MINUTE HEAT TEST

U3-4071-1000 (was BAC 1546-L-R3)

BOEING
 VOL I

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 PAGE FIG. 31



IS-1 EWA 5-593 AFTER HEAT & SONIC TESTING
5-9-61 .46658

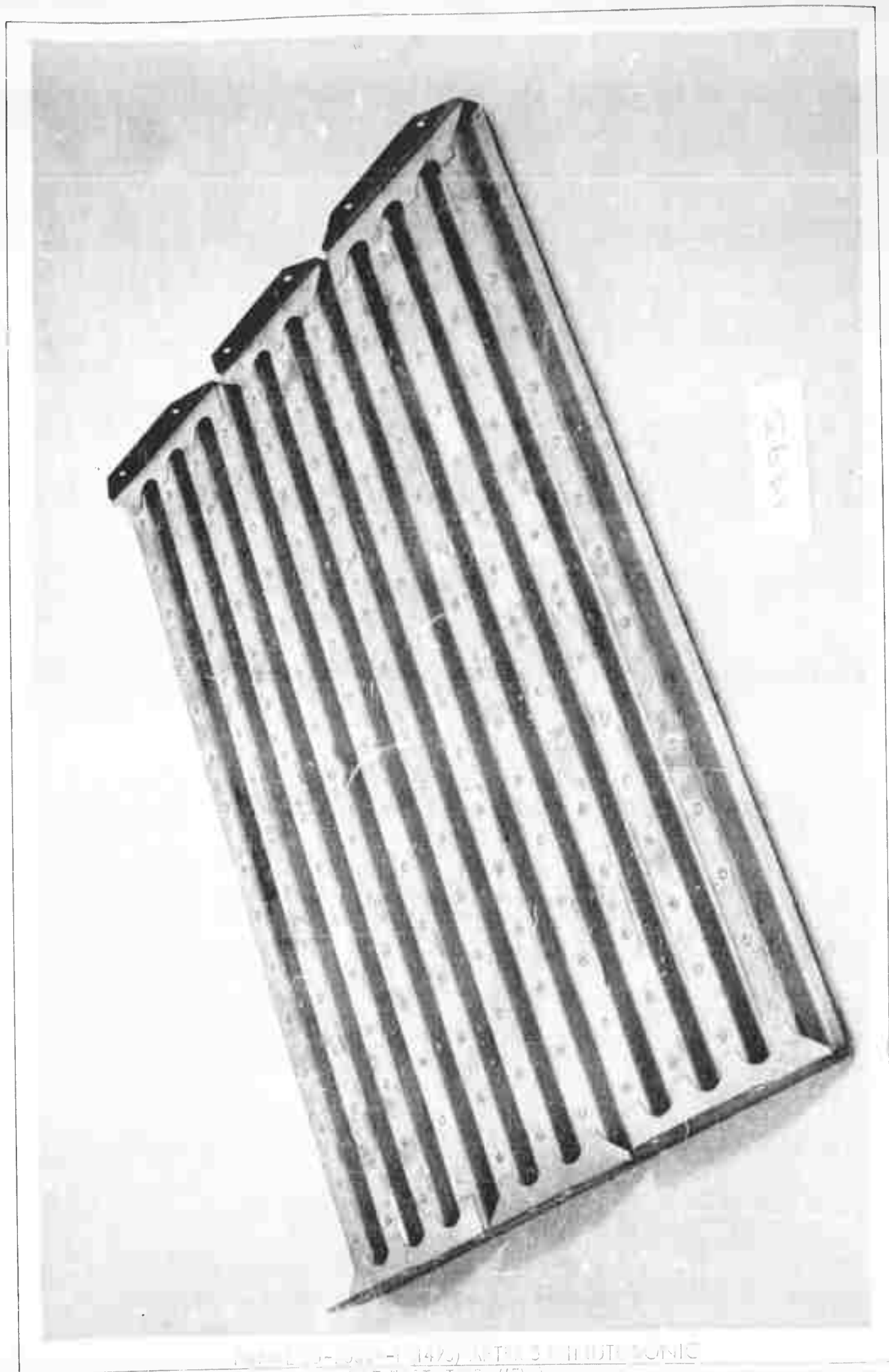


FIG. 1 (5-593 - 1493) AFTER 3 HOUR SONIC
TEST AND HEAT TEST (TOP VIEW)

U3.4071-1000 (was BAC 1546-L-R3)

BOEING

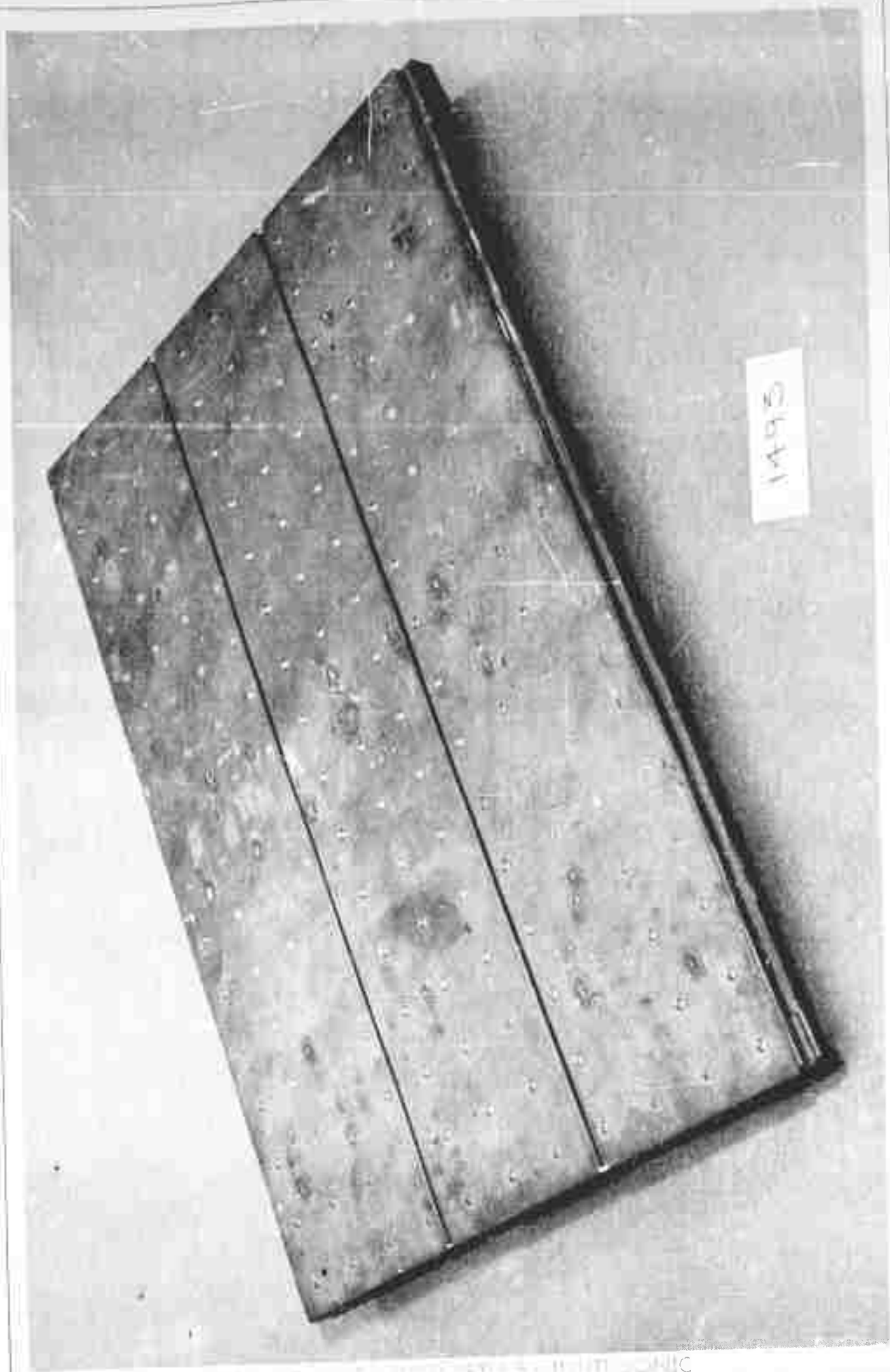
VOL I

NO. D2-1004

PAGE FIG. 32



DS-1 EWA 5-593 AFTER HEAT & SONIC TESTING 2A6455
5-9-61



PANEL 25-1000Y-1 (475) AFTER 5 H. UTI SONIC
TEST AND HEAT TEST (BOTTOM VIEW)

3-4071-1000 (was BAC 1546-L-R3)

BOEING

VOL I

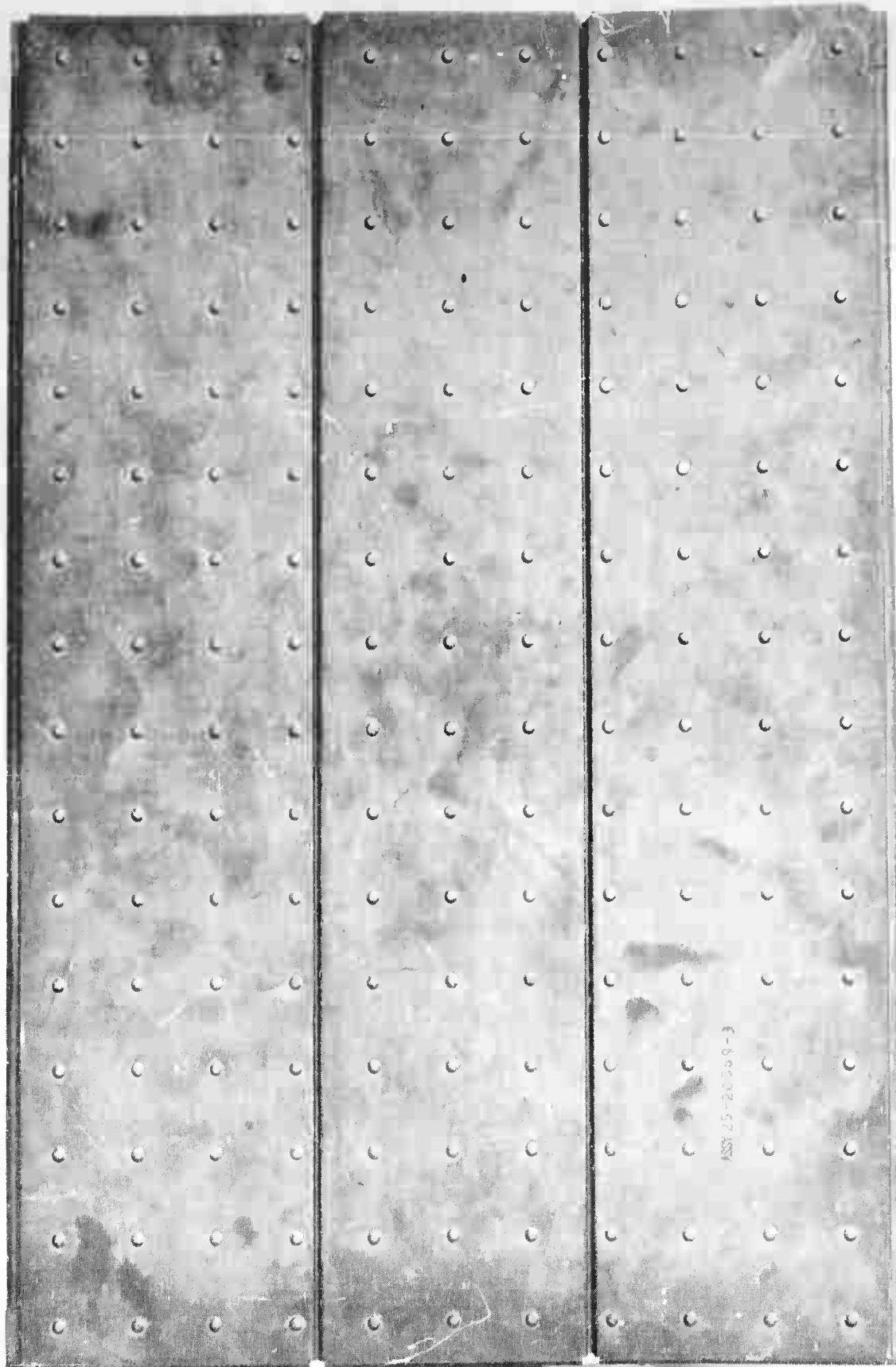
NO. D2-0004

PAGE FIG. 30



2A 37K

DS-I INSULATED PANEL # 1494 EJA 5598 -
SONIC TEST 5-28-61



PNY 25-20359-3

U3-4071-1000 (was BAC 1546-L-R3)

PANEL 25-20359-3 (1494) AFTER 57 MINUTE SONIC
TEST AND HEAT TEST (TOP VIEW)

BOEING

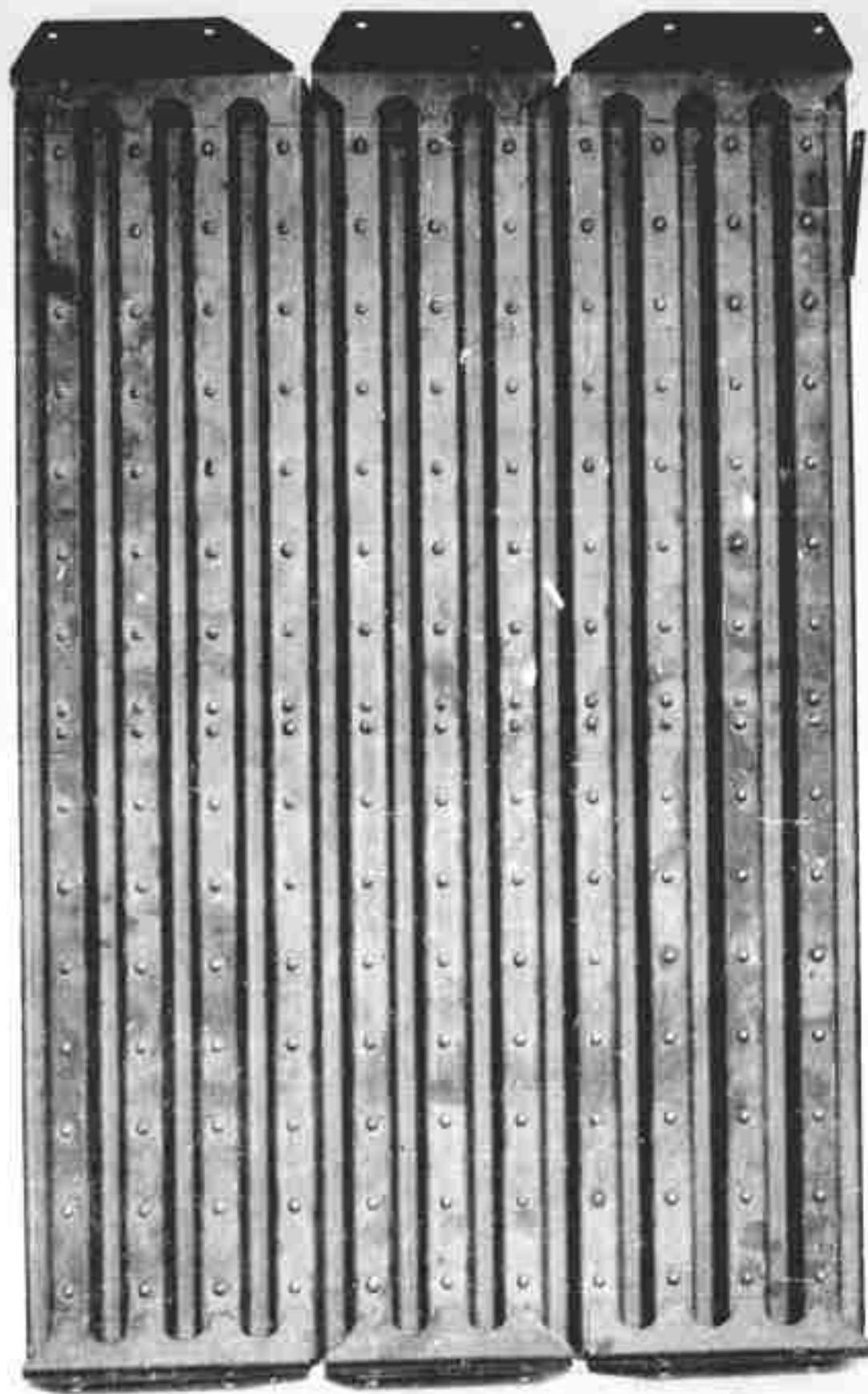
VOLT

NO. D2-500.4

PAGE FIG. 34



DS-1 INSULATED PANEL #1494 DWA 5598- SONIC
TEST 3-28-61 2465771



PANEL 25-20399-1 11.75" WIDE 14.75" HIGH 1.00" THICK
TEST AND HEAT TEST (OTTO, VIE 1)

U3-4071-1000 (was BAC 1546-L-R3)

BOEING

VOLI

NO. DE-00.4

PAGE FIG. 30



DS-1 FWA 5-993 AFTER HEAT & SONIC TESTING
5-9-61

2A66516



PANEL 25-10839-1 (495) AFT
TEST AND HEAT TEST TOP VIEW

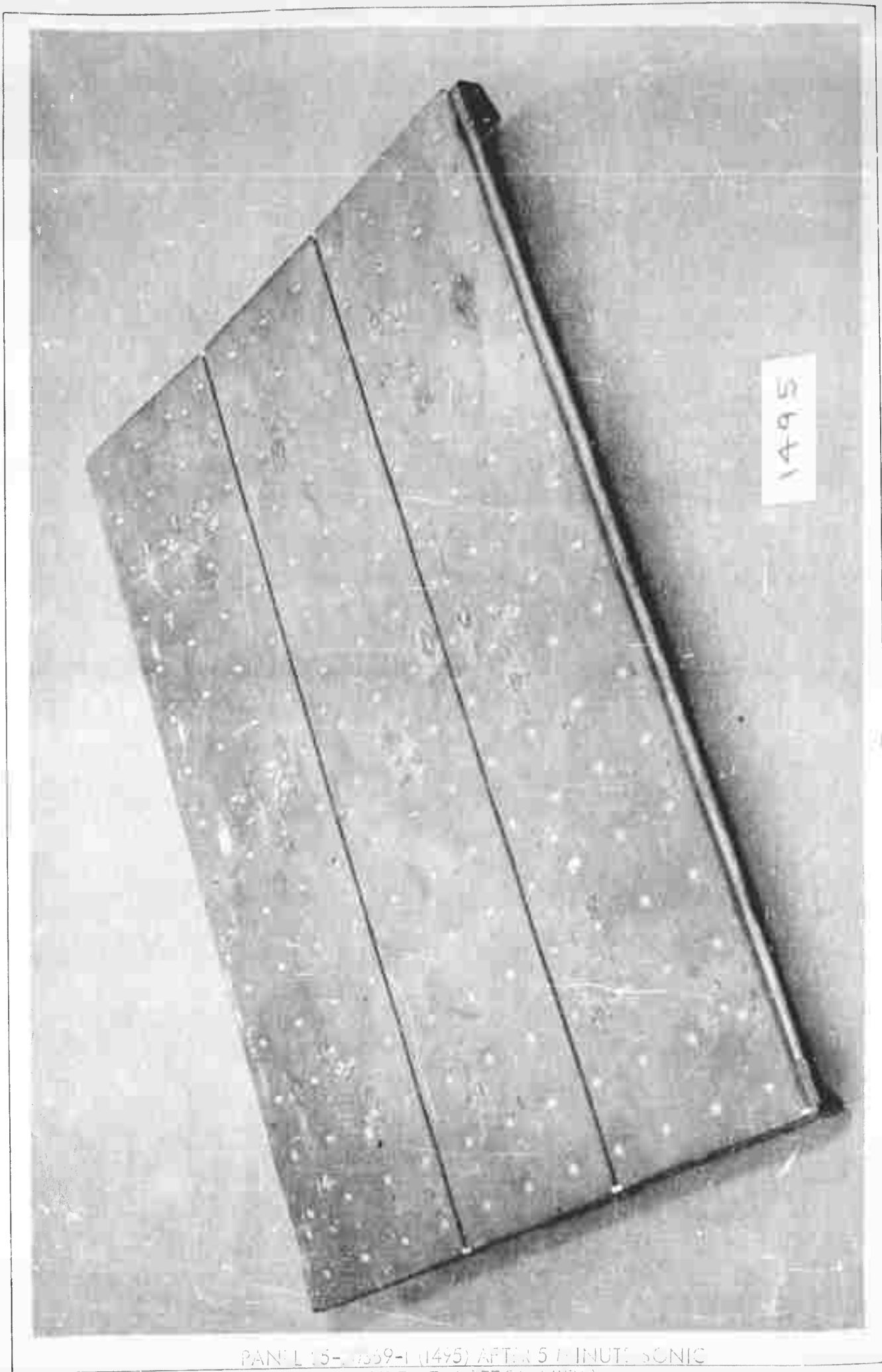
U3-4071-1000 (was BAC 1546-L-R3)

BOEING
VOLT

NO. D2-100.4
PAGE FIG. 50



DS-I EWA 5-593 AFTER HEAT & SONIC TESTING 2A66555
5-9-61



PANEL 15-1559-1 (1495) AFTER 5 MINUTE SONIC
TEST AND LEAK TEST (BOTTOM VIEW)

U3-4071-1000 (was BAC 1546-L-R3)

BOEING

VOL I

NO. D2-100-1

PAGE FIG. 3



STRUCTURES LABORATORIES

SONIC LAB.
DS INS PANEL
AFTER HEAT & SONIC
PANEL 1497
EWA 5-593
DWG 25-20389-2
8-30-1

PANEL 25-20389-2 (1497) AFTER 5 MINUTE SONIC
TEST AND PLATT TEST (TOP VIEW)

BOEING

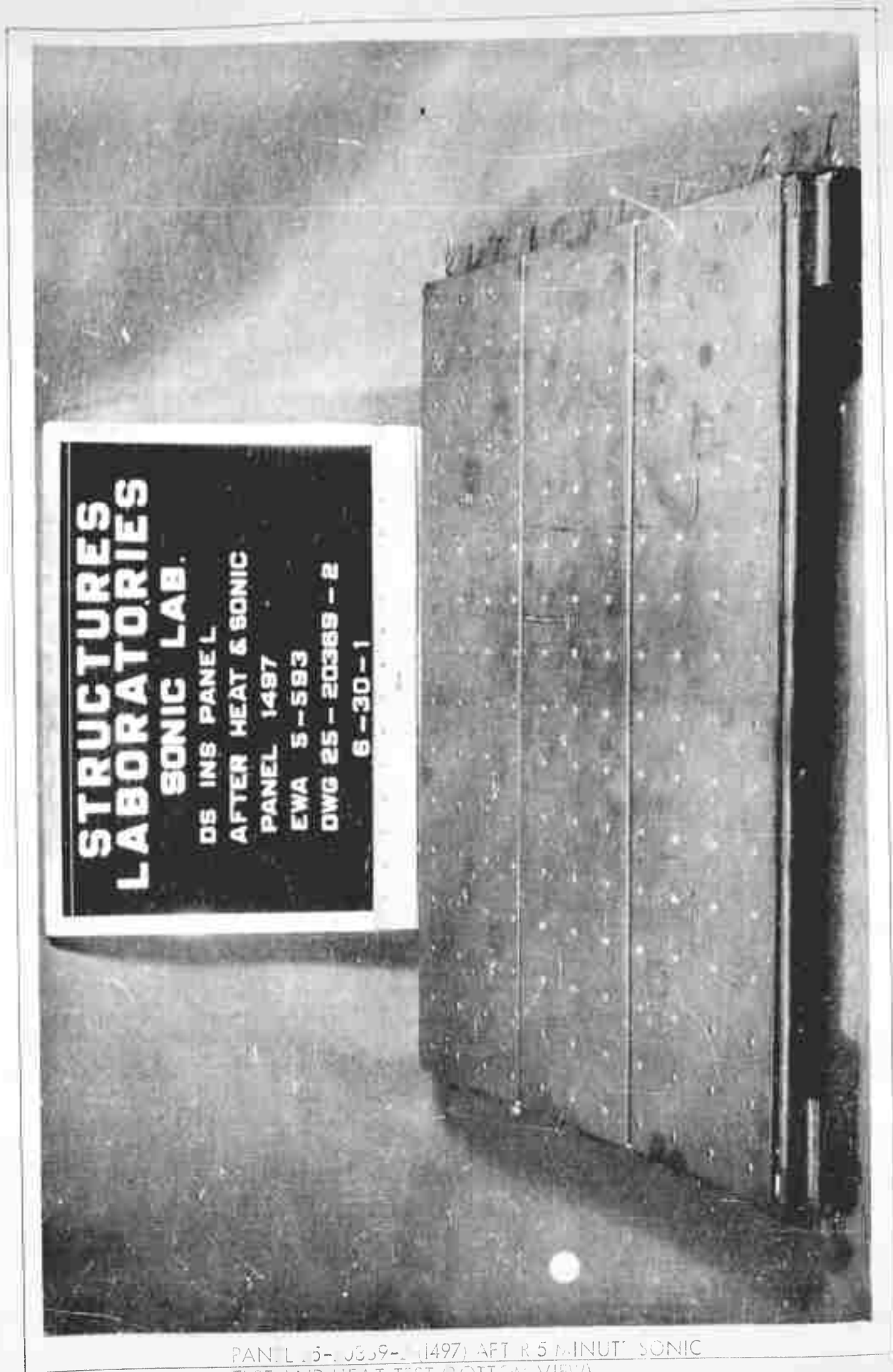
VOL I

NO. D2-0000

PAGE FIG. 1



DS-I INSULATION PANEL AFTER HEAT AND SONIC
TEST PANEL 1497 EWA 5-593 7-3-61 248-705



STRUCTURES LABORATORIES

SONIC LAB.

DS INS PANEL

AFTER HEAT & SONIC

PANEL 1497

EWA 5-593

DWG 25-20389-2

6-30-1

U3-4071-1000 (was BAC 1546-L-R3)

PANEL 15-0359-1 (1497) AFT R 5 MINUT SONIC
TEST AND HEAT TEST (BOTTOM VIEW)

BOEING

VOLI

NO. D2-10014

PAGE FIG. 39



DS-1 INSULATION PANEL AFTER HEAT AND SONIC TEST 2A82703
 PANEL 1498 EWA 5-593 7-5-61

U3-4071-1000 (was BAC 1546-L-R3)

STRUCTURES LABORATORIES

SONIC LAB.
 DS INS PANEL
 AFTER HEAT & SONIC
 PANEL 1498
 EWA 5-593
 DWG 25-20369-2
 6-30-1

PANEL 25-20369-2 (R3) AFTER 5 MINUTE SONIC
 TEST AND HEAT TEST TOP VIEW

BOEING
 VOL I

NO. 122-10004
 PAGE 216-40



DS-1 INSULATION PANEL AFTER HEAT AND SONIC TEST 2A82704
 PANEL 1498 EWA 5-595 7-3-61

U3-4071-1000 (was BAC 1546-L-R3)

STRUCTURES LABORATORIES

SONIC LAB.

DS INS PANEL
AFTER HEAT & SONIC

PANEL 1498

EWA 5-593

DWG 25-20369-2

8-30-1

PANEL 1498 (149) AFTER 5 MINUTE SONIC
 TEST AND HEAT TEST (BOTTOM VIEW)

BOEING

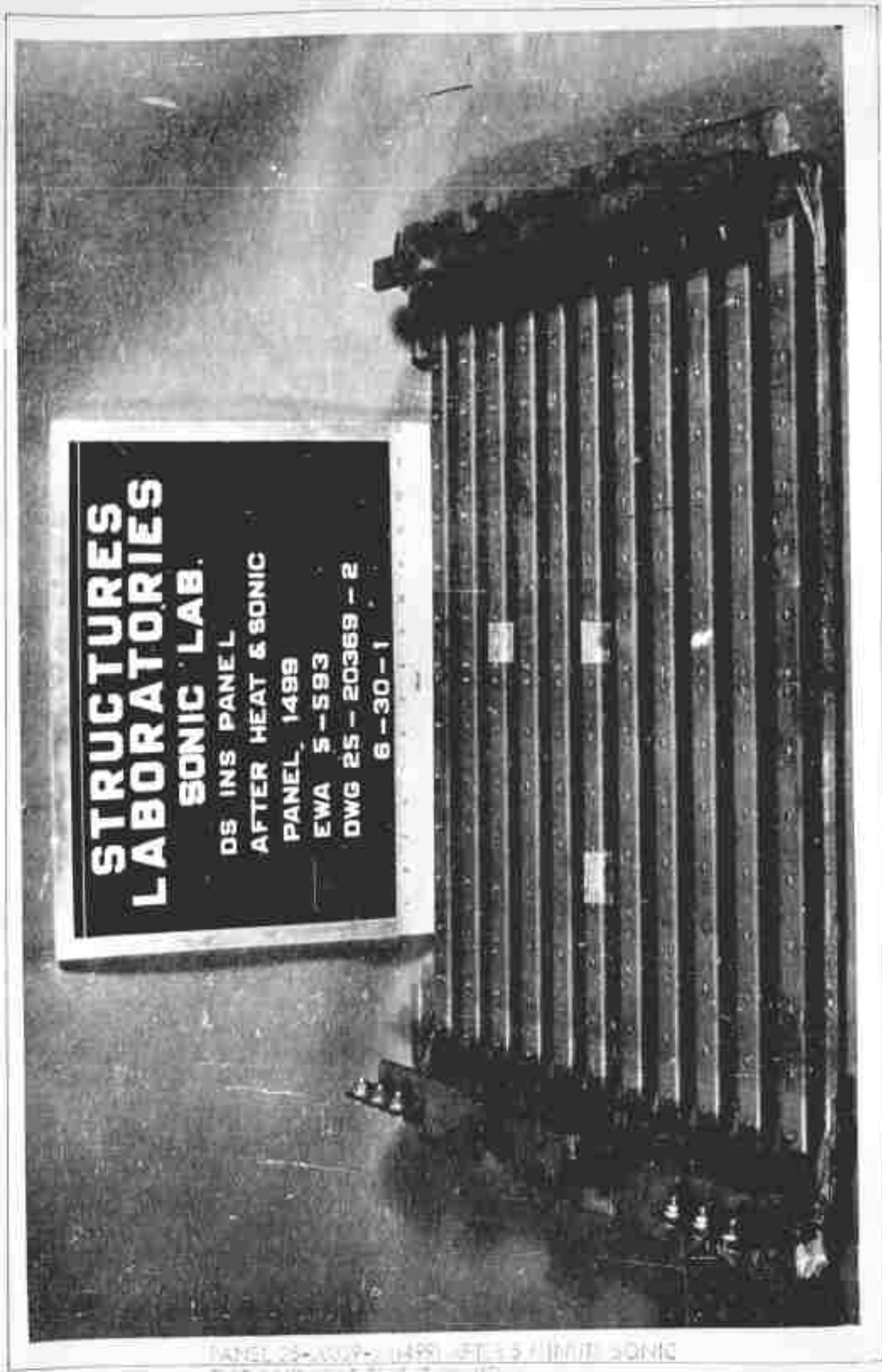
VOL I

NO. D2-0004

PAGE FIG. 41



DS-1 INSULATION PANEL AFTER HEAT AND SONIC TEST 2A82702
 PANEL 1499 EWA 5-593 7-5-61



STRUCTURES LABORATORIES

SONIC LAB.
 DS INS PANEL
 AFTER HEAT & SONIC
 PANEL, 1499
 EWA 5-593
 DWG 25-20369-2
 6-30-1

PANEL 25-20369-2 (1499) AFTER 5 HOURS SONIC
 TEST AND HEAT TEST (TOP VIEW)

U3-4071-1000 (WALBAC 1946-CH21)

BOEING

VOL I

NO 02-0004

PAGE 210, 140



DS-1 INSULATION PANEL AFTER HEAT AND SONIC TEST CAS 2701
 PANEL 1489 EWA 5-593 7-3-61

STRUCTURES LABORATORIES

SONIC LAB.

DS INS PANEL

AFTER HEAT & SONIC

PANEL 1489

EWA 5-593

DWG 25-20389-2

8-30-1

U.S. GOVERNMENT PRINTING OFFICE (1944 E)

PANEL 1489, ART 25-1, HEAT & SONIC
 TEST AND AFTER HEAT VIEW

BOEING

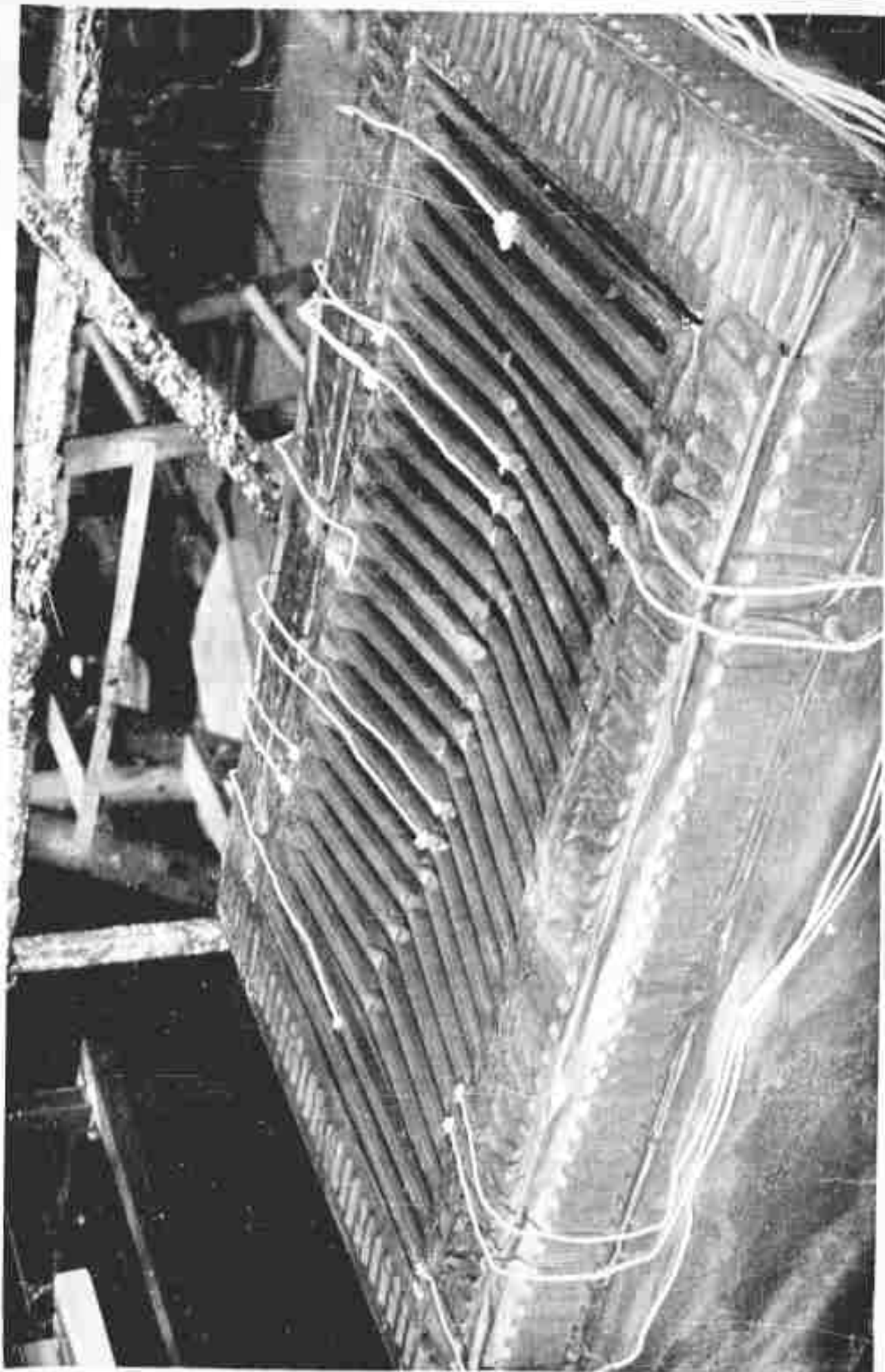
VOL I

NO 25-20389

PAGE TWO-40



COL. D-18 BLDG 9.101 D.C. - DS-1 PANEL 25-20374-2 2A94228
PRESSURE TEST FAILURE 12-8-61



PANEL 25-20374-2

U3-4071-1000 (was BAC 1546-L-R3)

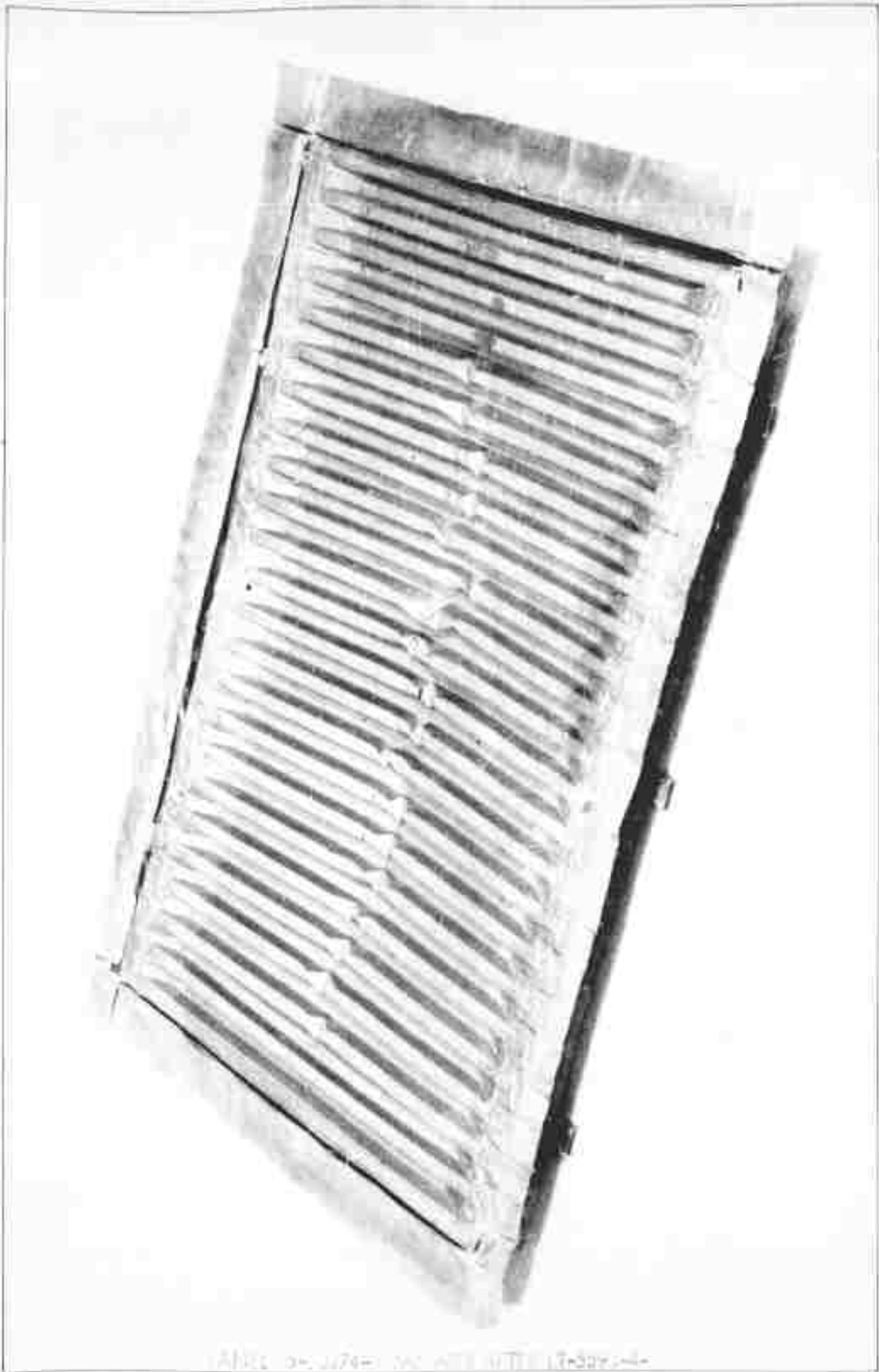
BOEING

NO 12-0024

VOLT



DYNASOAR WING PANEL FAILURE TOP VIEW
12-20-61 2494984



U3-4071-1000 (was BAC 1546-L-R3)

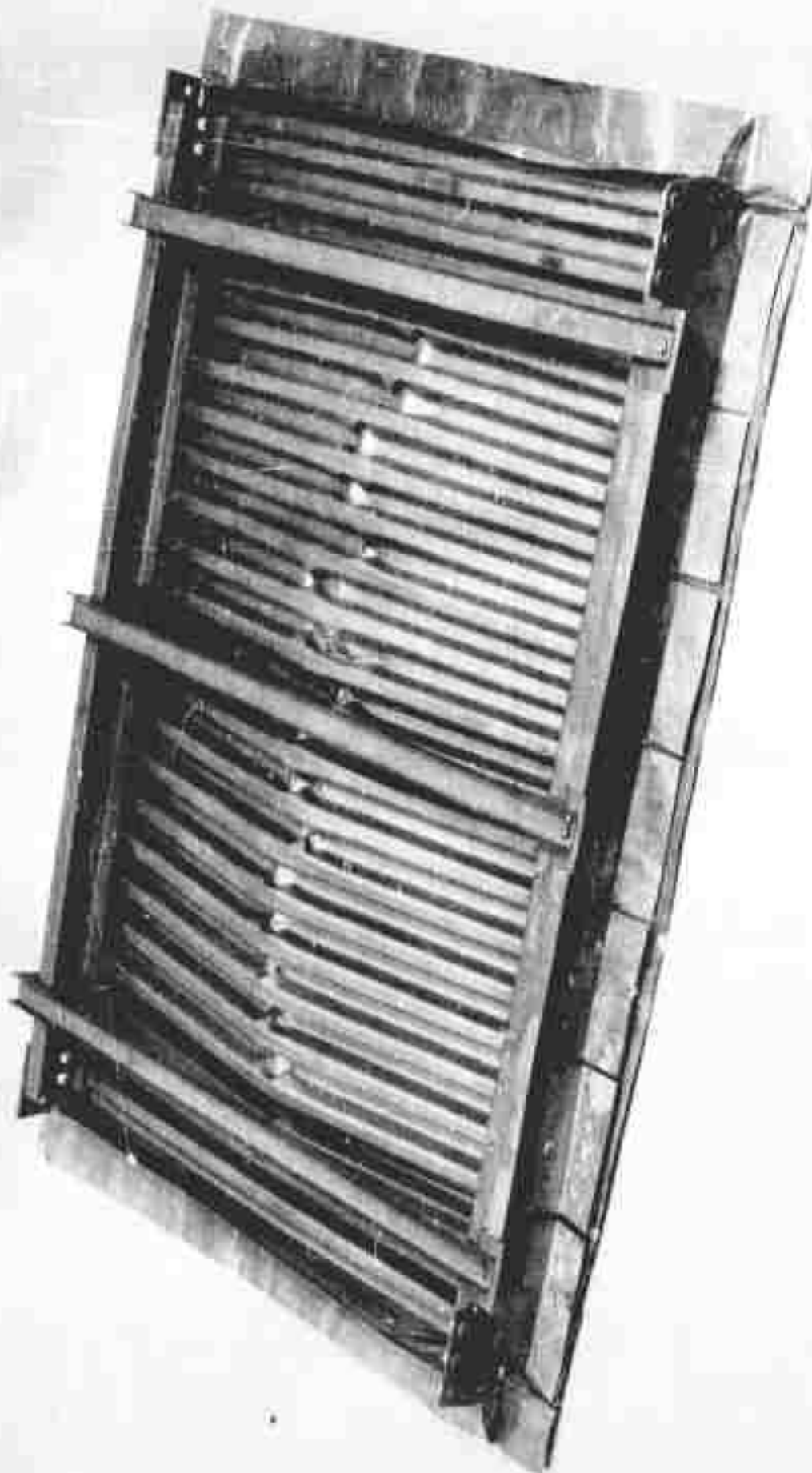
BOEING
VOL I

NO. D2- 00.4
PAGE FIG. 45



2A94985

DYNASOAR WING PANEL FAILURE 25-20374-2
BOTTOM VIEW 12-20-61



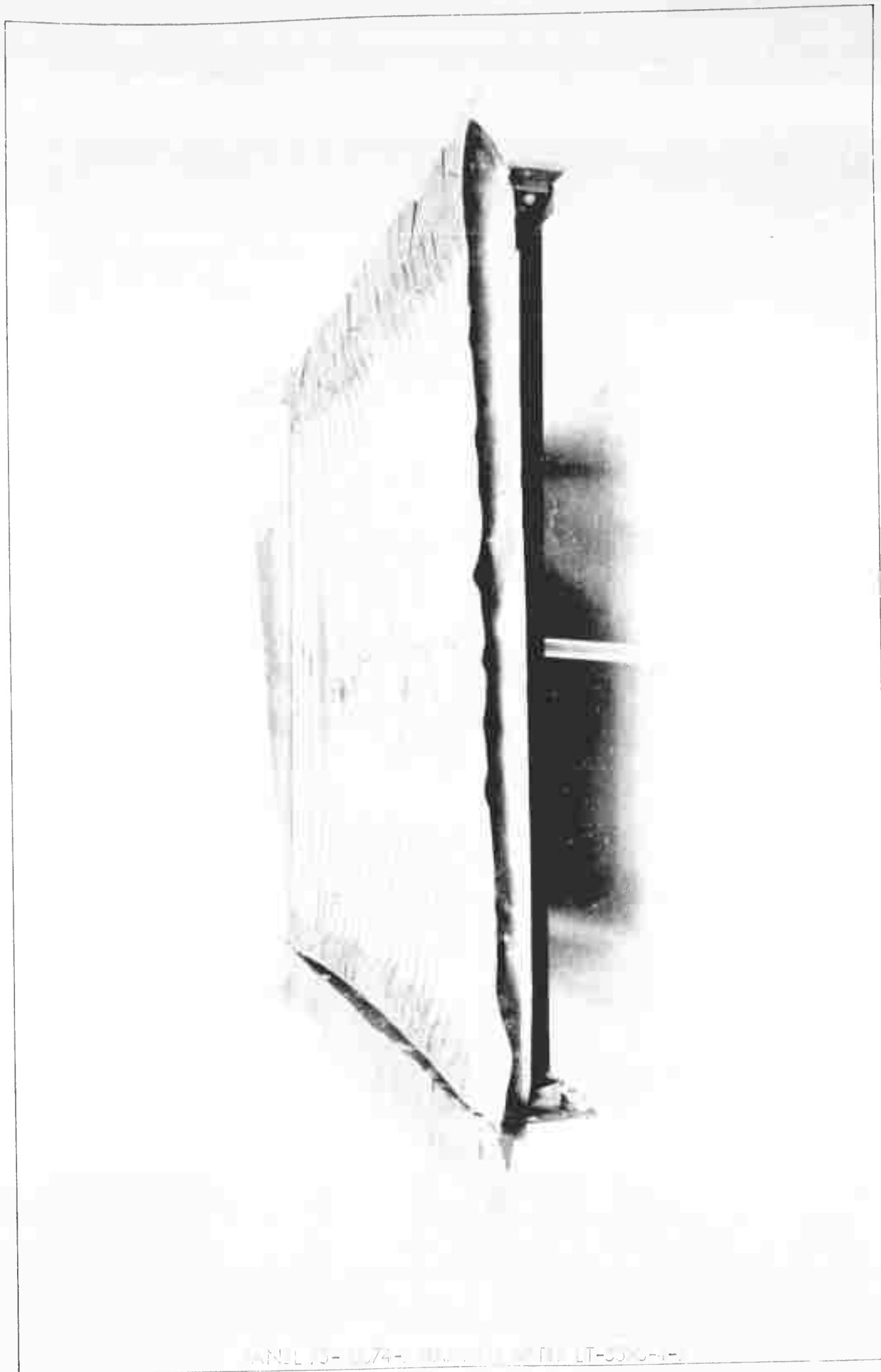
U3-4071-1000 (was BAC 1546-L-R3)

BOEING
VOL I

NO. 22-2008
PAGE 21



DYNASOAR WING PANEL FAILURE END VIEW
12-20-61 2A94987



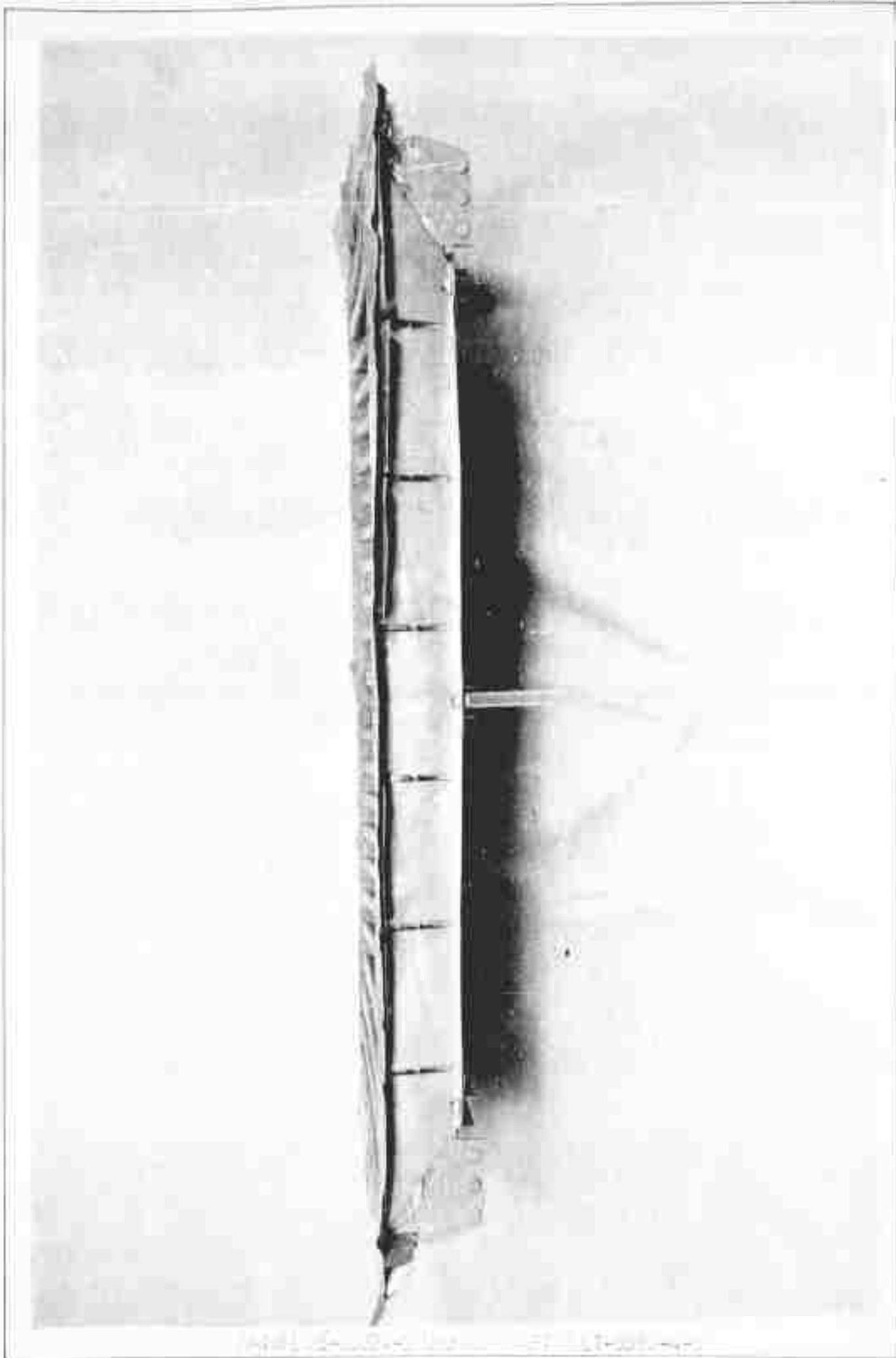
U3-4071-1000 (was BAC 1546-L-R3)

BOEING
VOLI

NO D1-100 4
PAGE FIG. 47



DYNASOAR WING PANEL FAILURE SIDE VIEW 2A9-986
12-20-61



U3-4071-1000 (was BAC 1546-L-R3)

BOEING
VOL I

NO. 22-000000
PAGE 100



2495904

DS-1 WING PANEL FAILURE - TOP VIEW
1-3-62



U3-4071-1000 (was BAC 1546-L-R3)

BOEING
VOL I

NO. D2- 00.4
PAGE FIG. 42



245595

LET - KING PANE. FAILURE - B.O. JIP
1-3-62

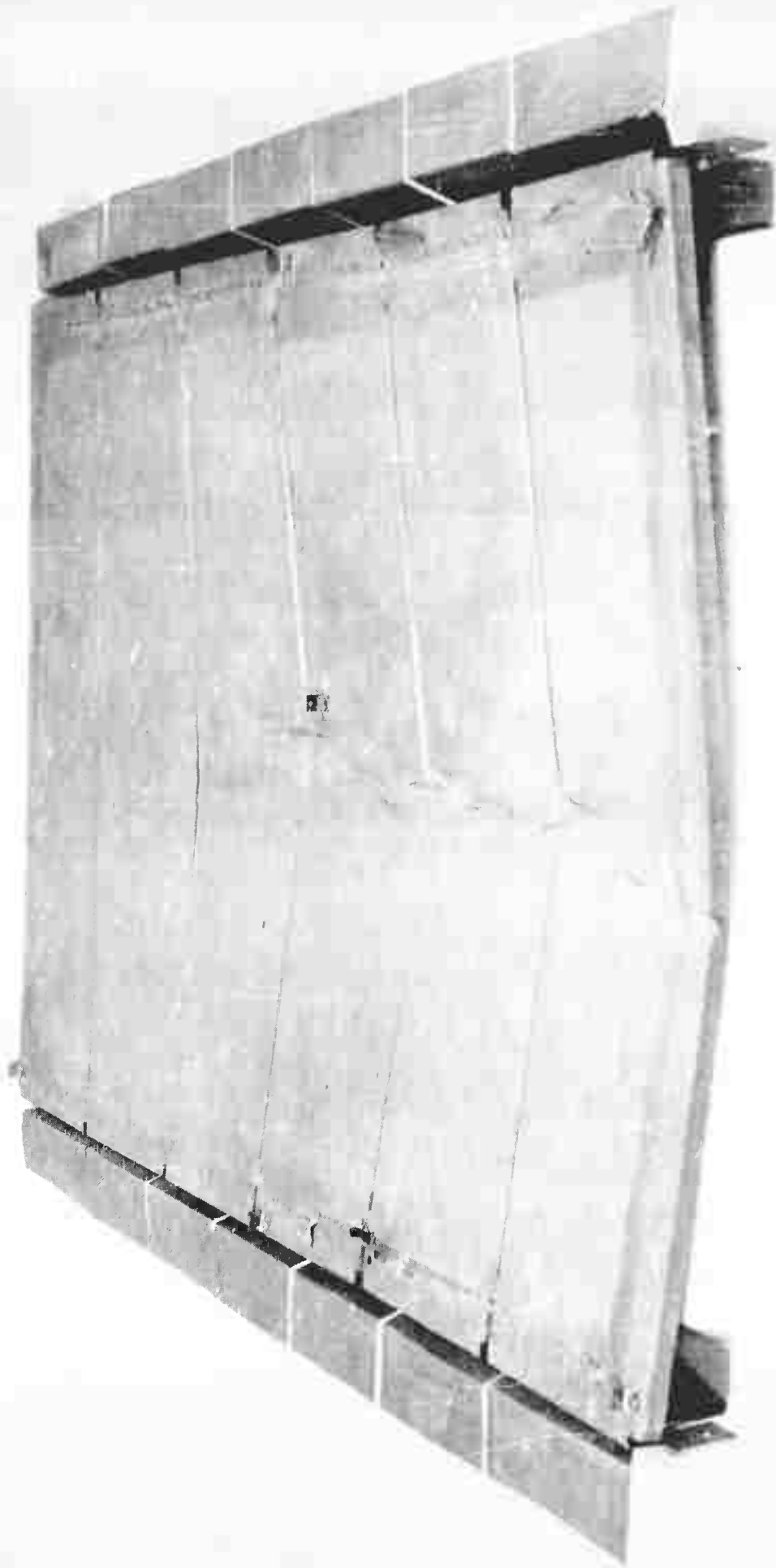


FIG. 1 - KING PANE. FAILURE - B.O. JIP
AFT LT-5595-4-1

U3-4071-1000 (was BAC 1546-L-R3)

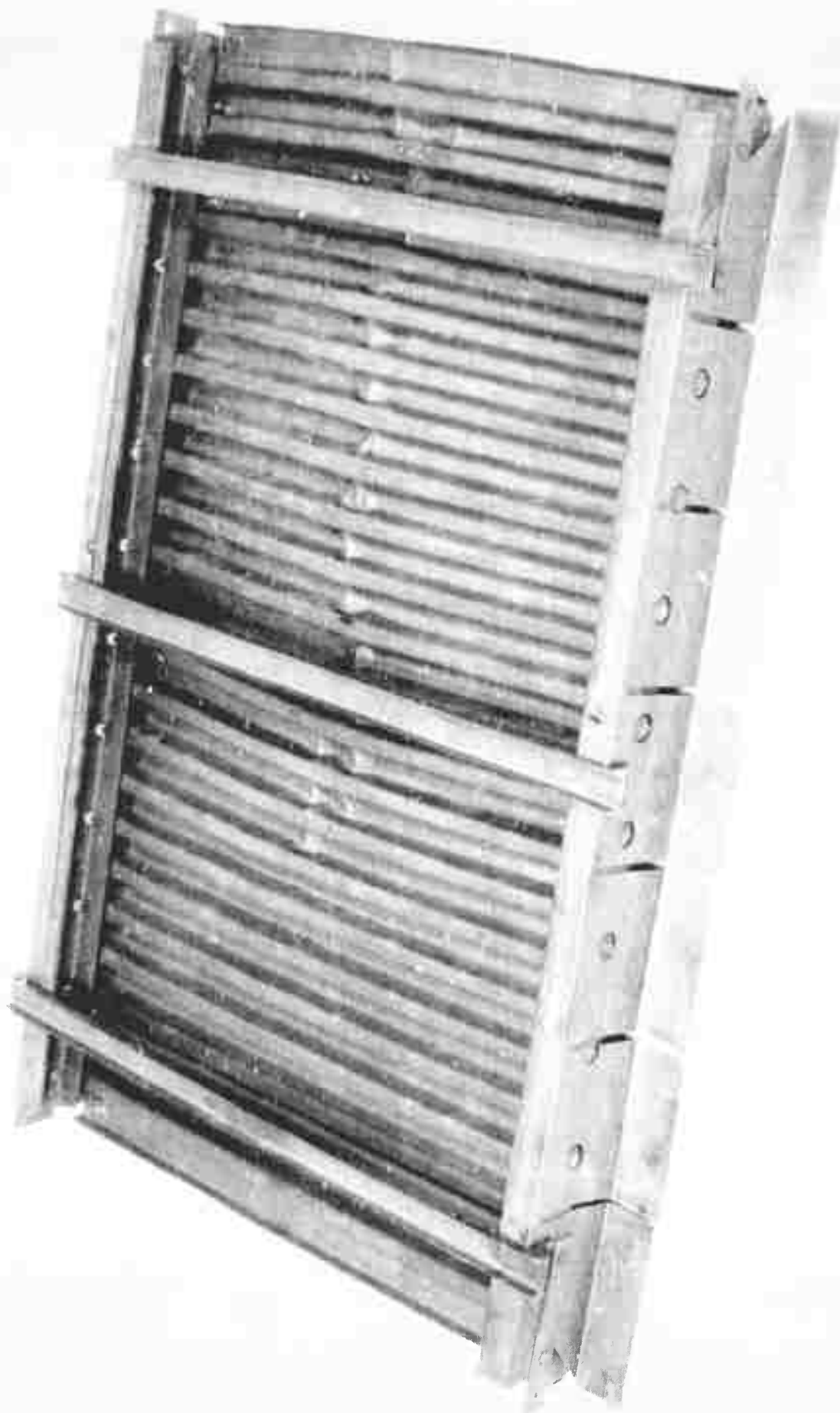
BOEING
VOL I

NO. 02-10004
PAGE FIG. 10



2495993

261 - WING PANEL FAILURE - BOTTOM VIEW
1-3-62



(13.4071 1000 (was BAC 1546 L-R3))

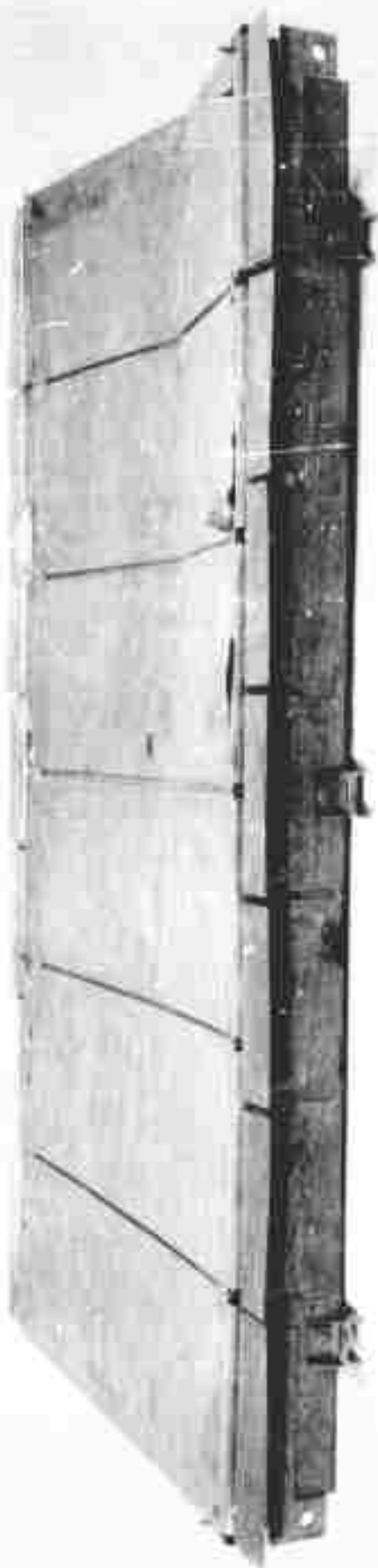
BOEING
VOLI

NO. 27-0001
PAGE 10



2A95342

DSI - WING PANEL FAILURE - SIDE VIEW
1-3-62



U3-4071-1000 (was BAC 1546-L-R3)

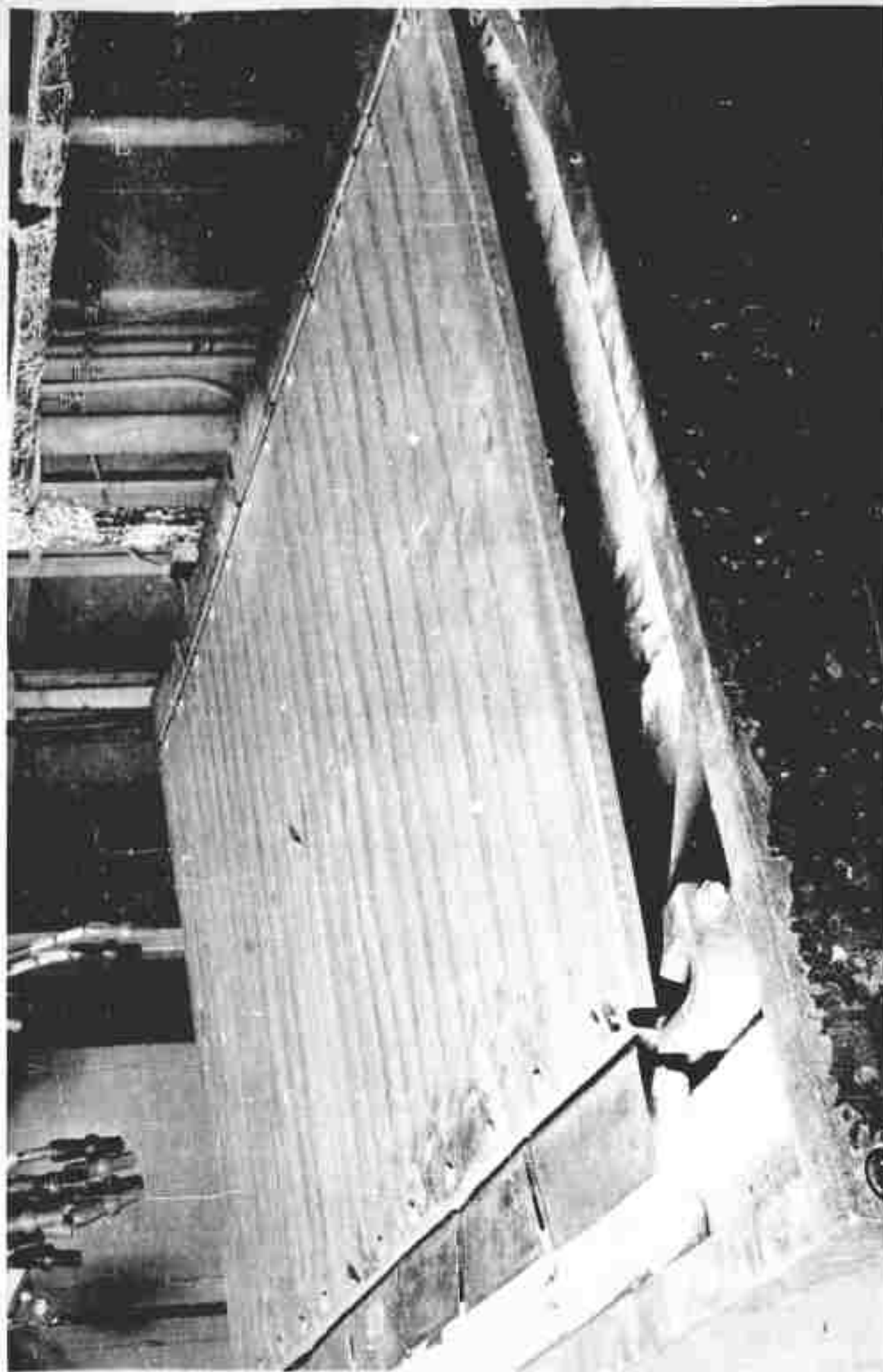
BOEING
VOL I

NO. D2-100 4
PAGE FIG. 52



3-1 WING PANEL FAILURE PANEL #25-20370-2
 CP VIEW SHOWING RINKLES
 1-5-62

2495074



GE477-1000 (Rev. 8-60) (44 L. 83)

TEST CYCLE, IT-359, 4-4

BOEING

VOL I

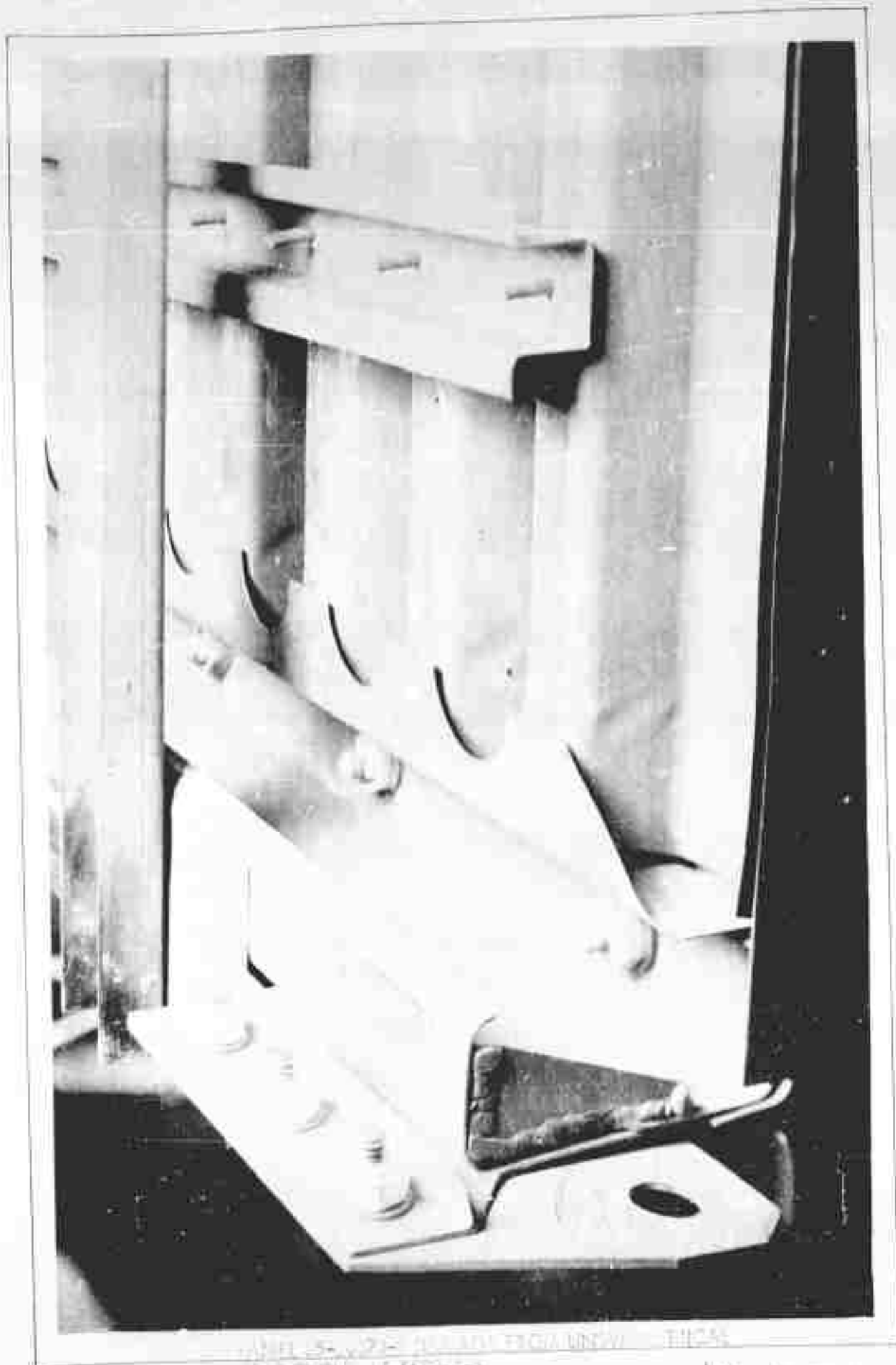
NO. 25-20370-2

PAGE TWO, 30



2495676

DS-1 WING PANEL FAILURE PANEL
SHOWING #25-20370-2 SHOWING WRINKLES
ON CORNER
1-5-62



U3-4071-1000 (was BAC 1546-L-R3)

WING PANEL FAILURE PANEL - TITAN
TEST EYE, LT-3553-4-2

BOEING
VOL I

NO. 32-375
PAGE FIG. 1



2495116

DS-1 - WING PANEL FAILURE
PANEL 25-20352 - TOP VIEW 1-15-62



PANEL 25-20352 - WING PANEL FAILURE

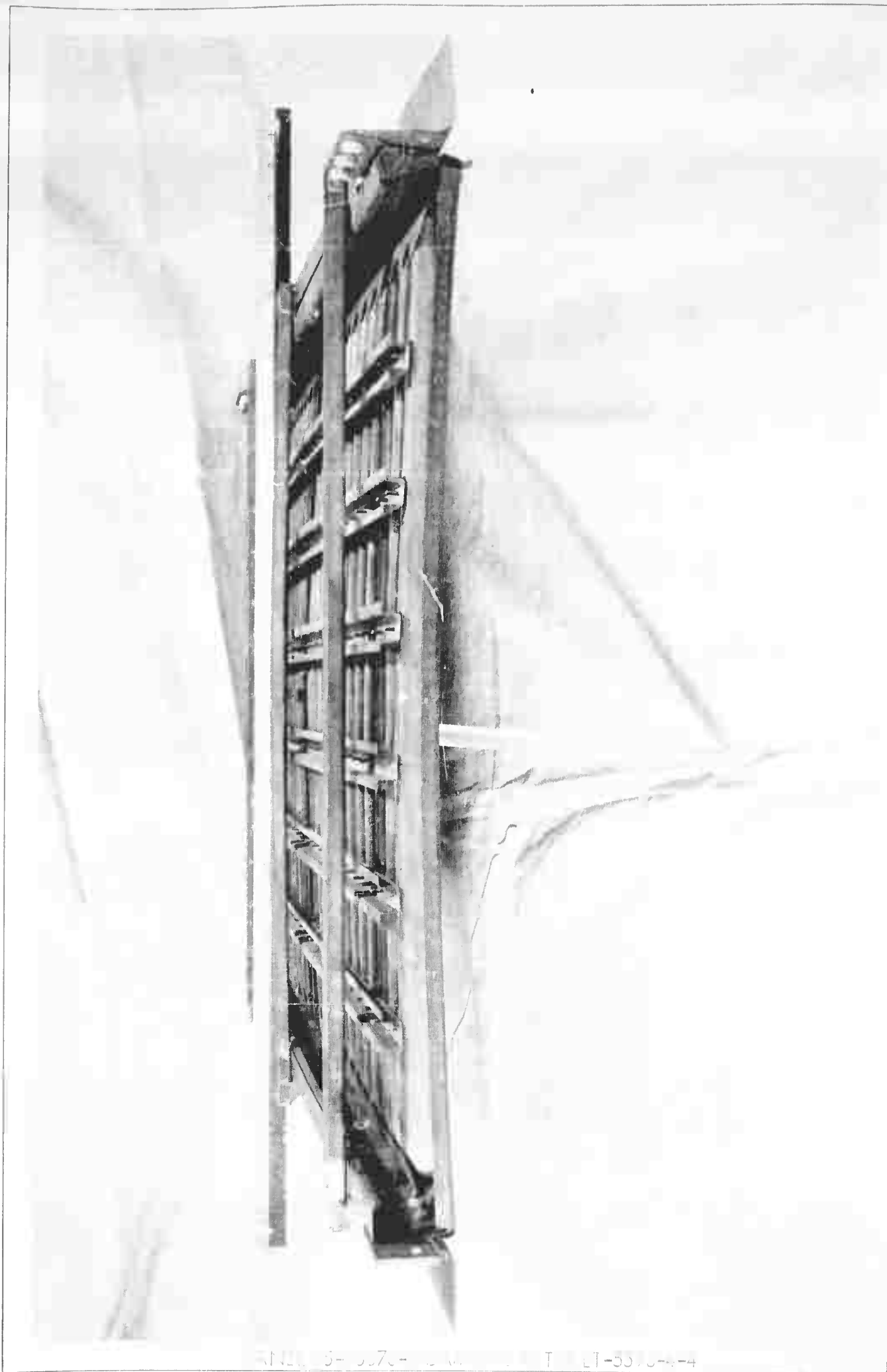
U3-4071-1000 (was BAC 1546-L-R3)

BOEING
VOL I

NO. 01-000 4
PAGE FIG. 55



DS-1 - WING PANEL FAILURE
 PANEL 25-20352- END VIEW
 1-15-62
 2496117



Panel 25-20352- End View T-107-4-4

U3-4071-1000 (was BAC 1546-L-R3)

BOEING
 VOL I

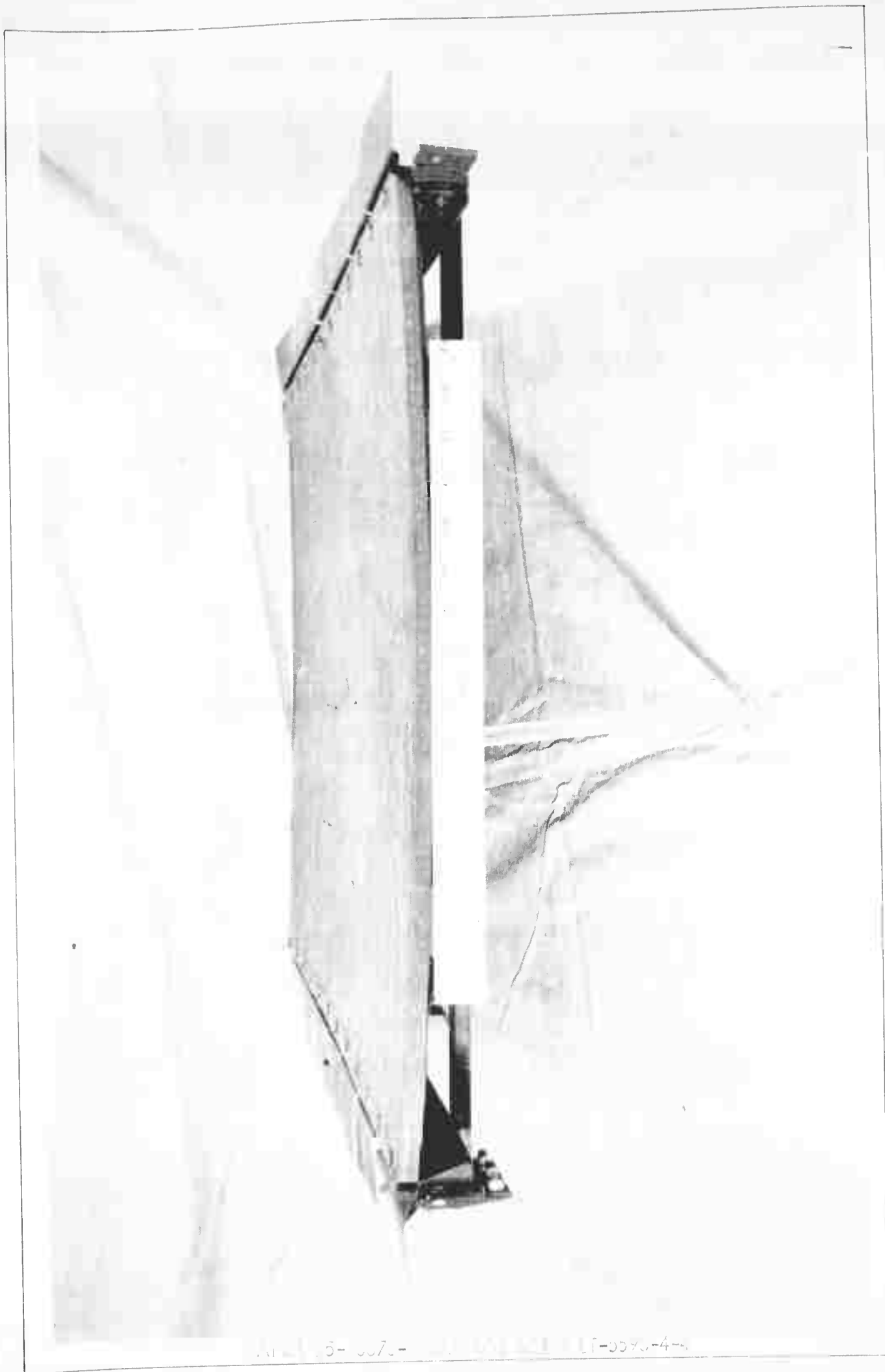
NO. D2- 00.4
 PAGE FIG



2A96118

1-15-62

DS-1 - WING PANEL FAILURE
PANEL 25-20352 - END TOP VIEW



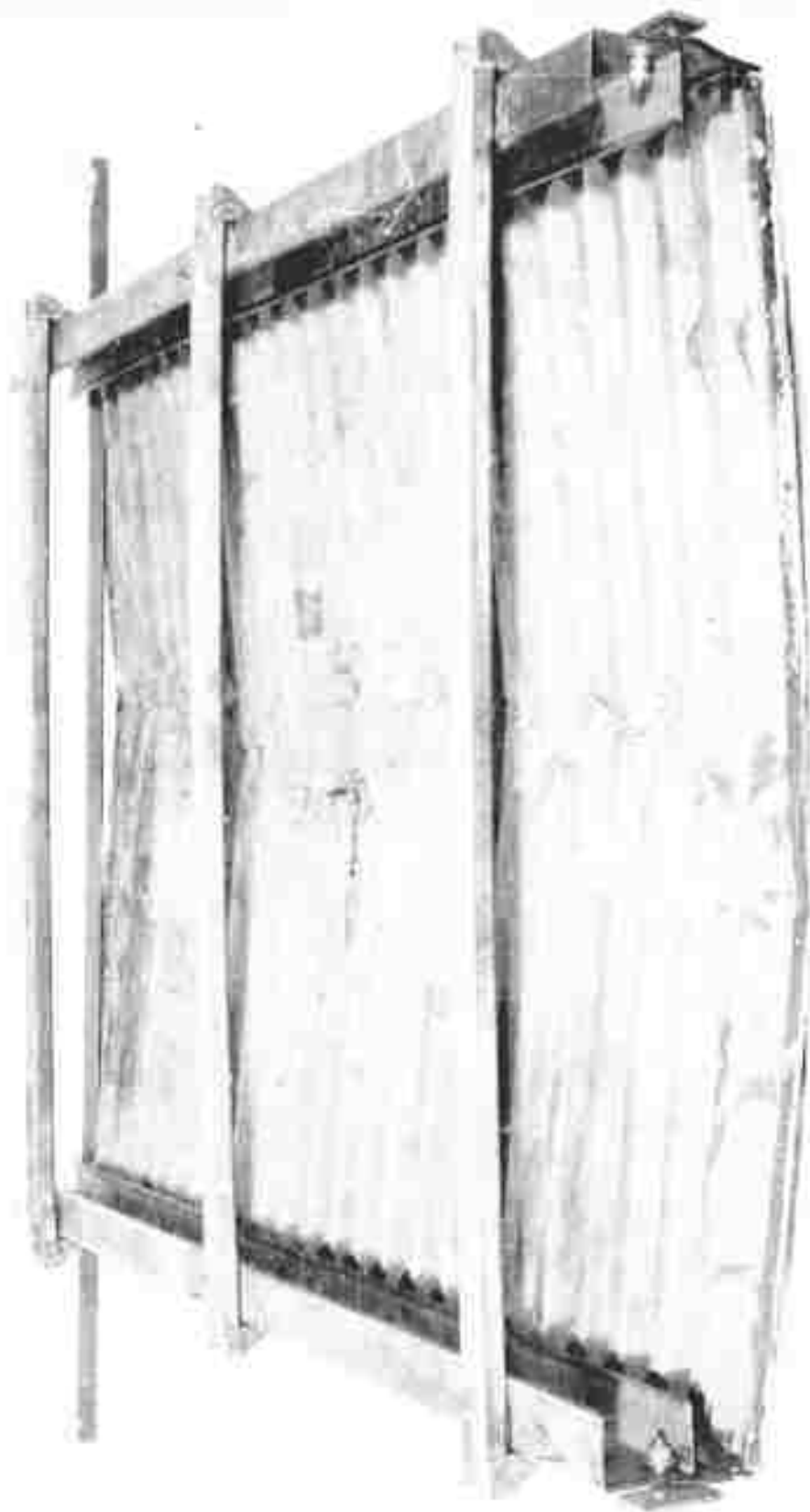
U3-4071-1000 (was BAC 1546-L-R3)

BOEING
VOLI

NO. D2-100.4
PAGE FIG. 17



DS-1 PANEL 25-20352 R.T. AFTER PRESSURE TEST 2A102(20)
 BOTTOM END VIEW - 3-6-68



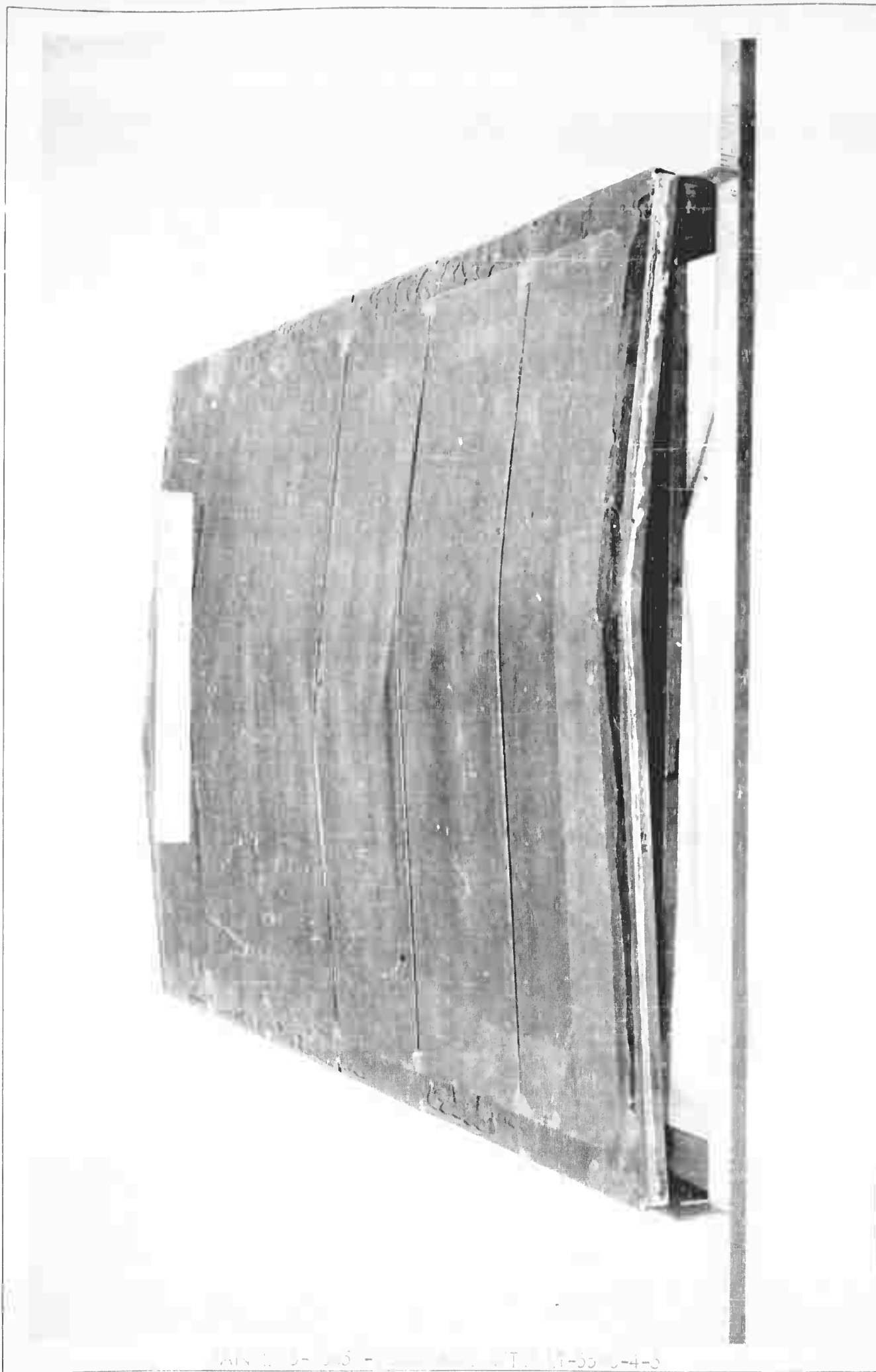
U3-4071-1000 (was BAC 1546-L-R3)

BOEING
 VOL I

NO. D2-004
 PAGE FIG.



DS-I PANEL 25-20352 R.T. AFTER PRESSURE TEST 2A102624
TOP END VIEW - 3-6-62



AIN 1 0-0-5 - 1-35 0-4-5

U3-4071-1000 (was BAC 1546-L-R3)

BOEING
VOL I

NO. 01-100 4
PAGE FIG. 59



DS-1 PANEL 25-20352 R.T. AFTER PRESSURE TEST 2A102683
TOP VIEW - 3-6-66



FIG. 10-555 - DS-1 PANEL AFTER LT-5570-4-5

U3-4071-1000 (was BAC 1546-LR3)

DS-I WING PANEL #20-2031 - PRESSURE TEST
FAILURES



PANEL DS-I 70-11100-101 WT 111-530-443

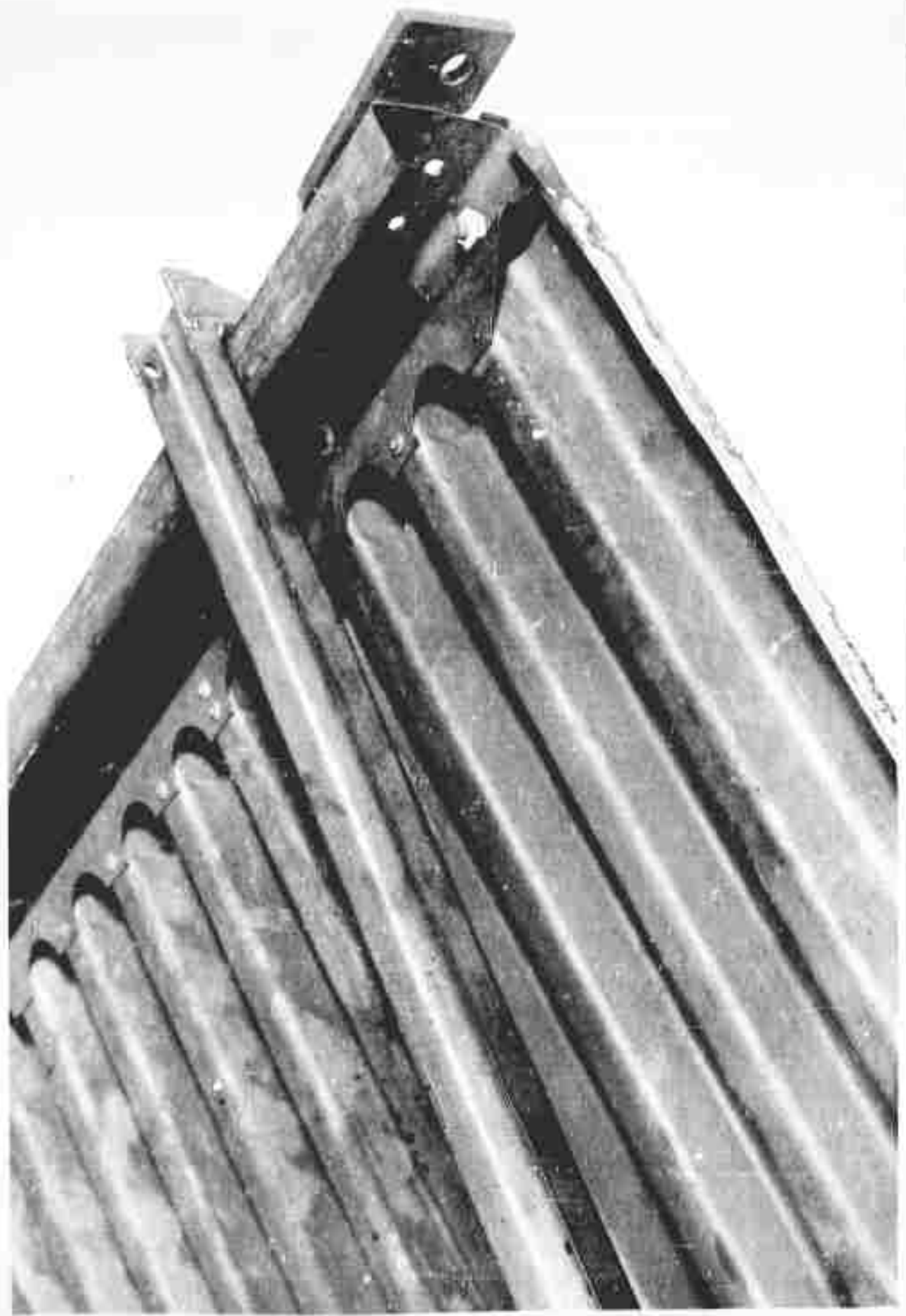
U3-4071-1000 (was BAC 1546-L-R3)

BOEING
VOL I

NO. 35-1514
PAGE 115 12



DS-I WING PANEL #25-20370 - PRESSURE TEST
3-12-62
2A104150
FAILURES



PANEL 25-20370-1 DRAWN BY WFT. LT-5593-4-5

U3-4071-1000 (was BAC 1546-L-R3)

BOEING

VOL I

NO. 02-004

PAGE FIG. 30



2A104151
 D8-I WING PANEL #25-20370 - PRESSURE TEST
 3-12-62
 FAILURES

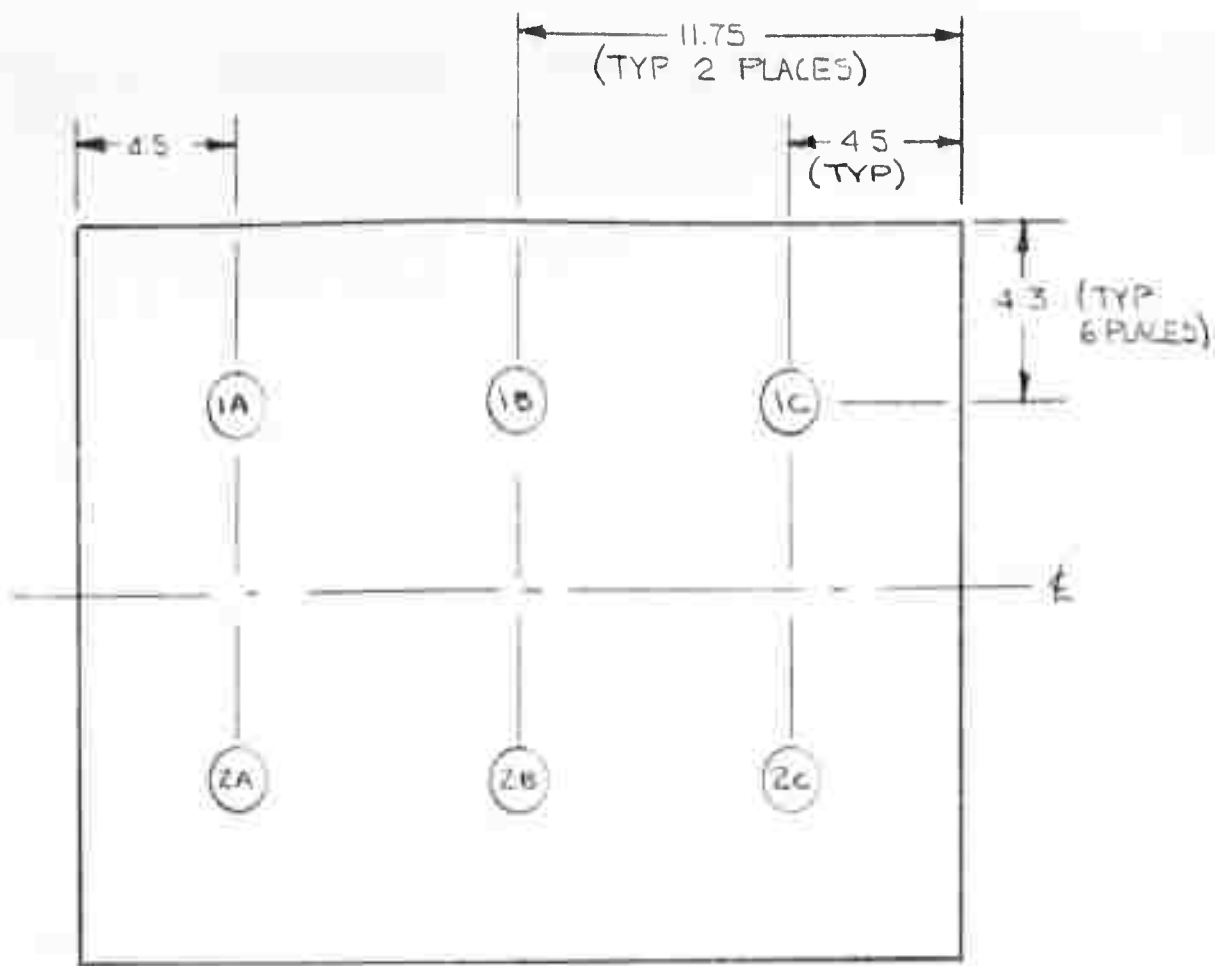


U3-4071-1000 (was BAC 1546-L-R3)

BOEING
 VOL I

NO. D2-0004
 PAGE FIG. 34

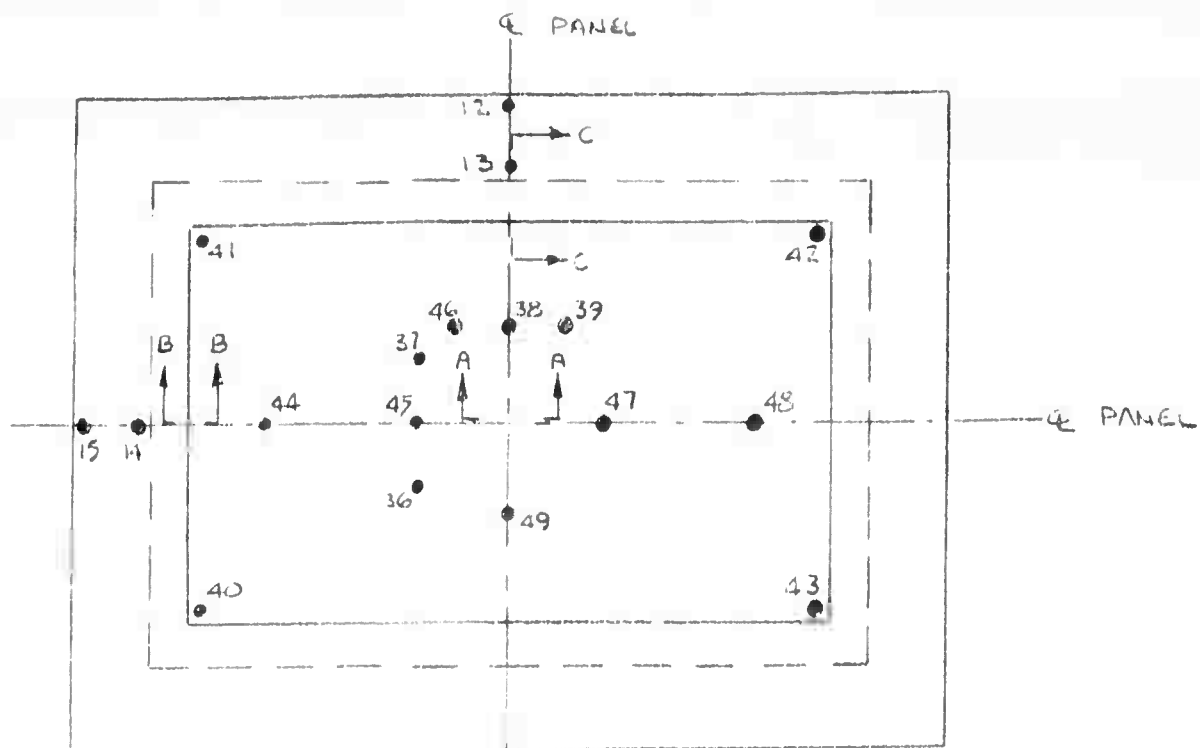




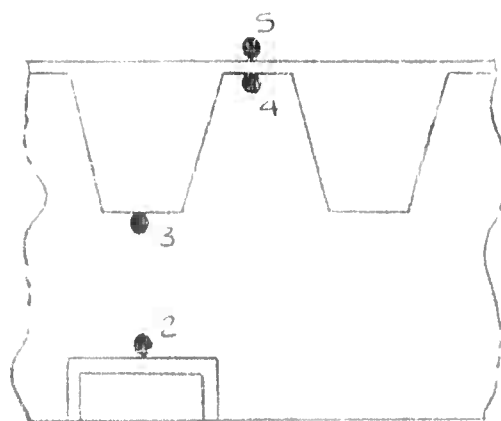
PANEL
(OUTSIDE SKIN SHOWN)

NOTE: ALL THERMOCOUPLES SHOWN ARE CONTROLS,
AND ARE ATTACHED TO OUTSIDE SKIN ONLY.

CALC	<i>Schmidt</i> 7-63	REVISED	DATE	CONTROL THERMOCOUPLE LOCATIONS	VOL I
CHECK				LT-5593-1	DZ-80084
APPD				BOEING AIRPLANE COMPANY	PAGE FIG 65



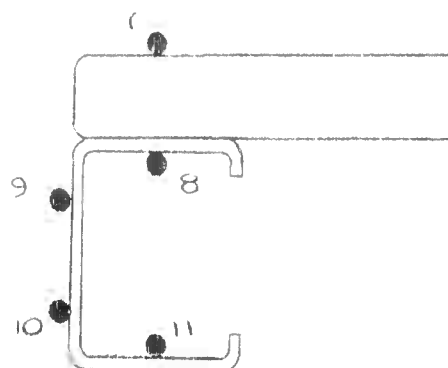
TEST PANEL 25-20374-1



VIEW A-A



VIEW B-B



VIEW C-C

ROTATED 90° COUNTERCLOCKWISE

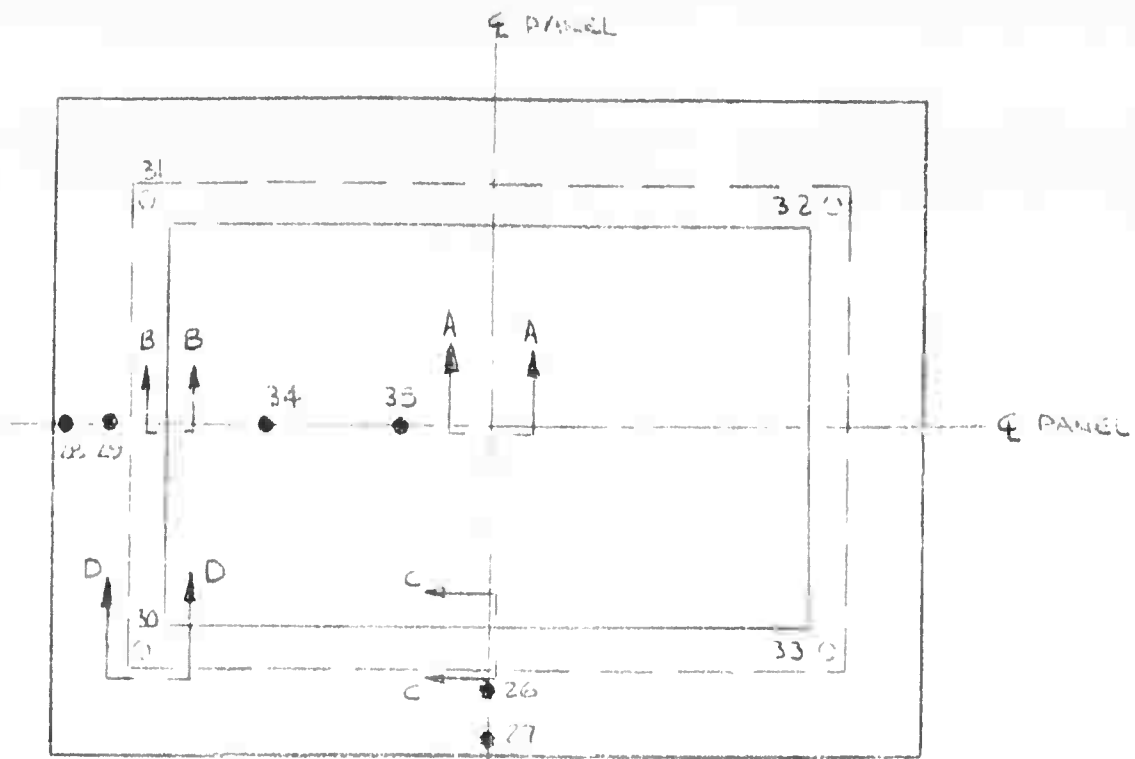
Submarine 7-63

THERMOCOUPLE LOCATIONS
TEST PANEL 25-20374-1
LT-5593-Z-1

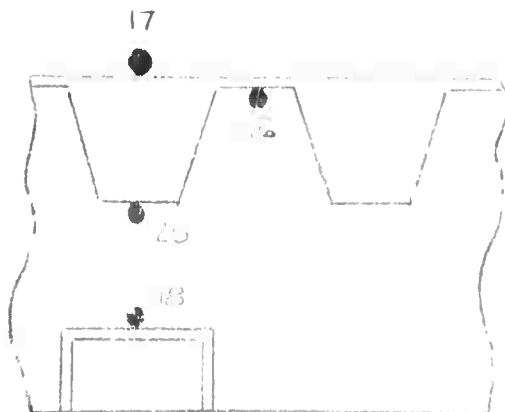
THE HUBBARD COMPANY

DZ-00084

FIG. 1



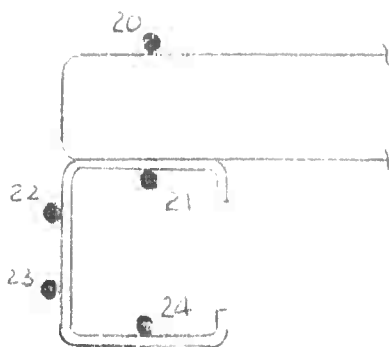
RE-RADIATING PANEL



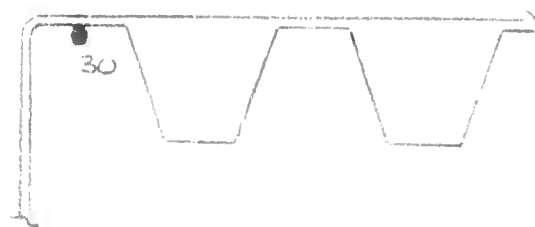
VIEW A-A



VIEW B-B



VIEW C-C
ROTATED 90° CLOCKWISE



VIEW D-D

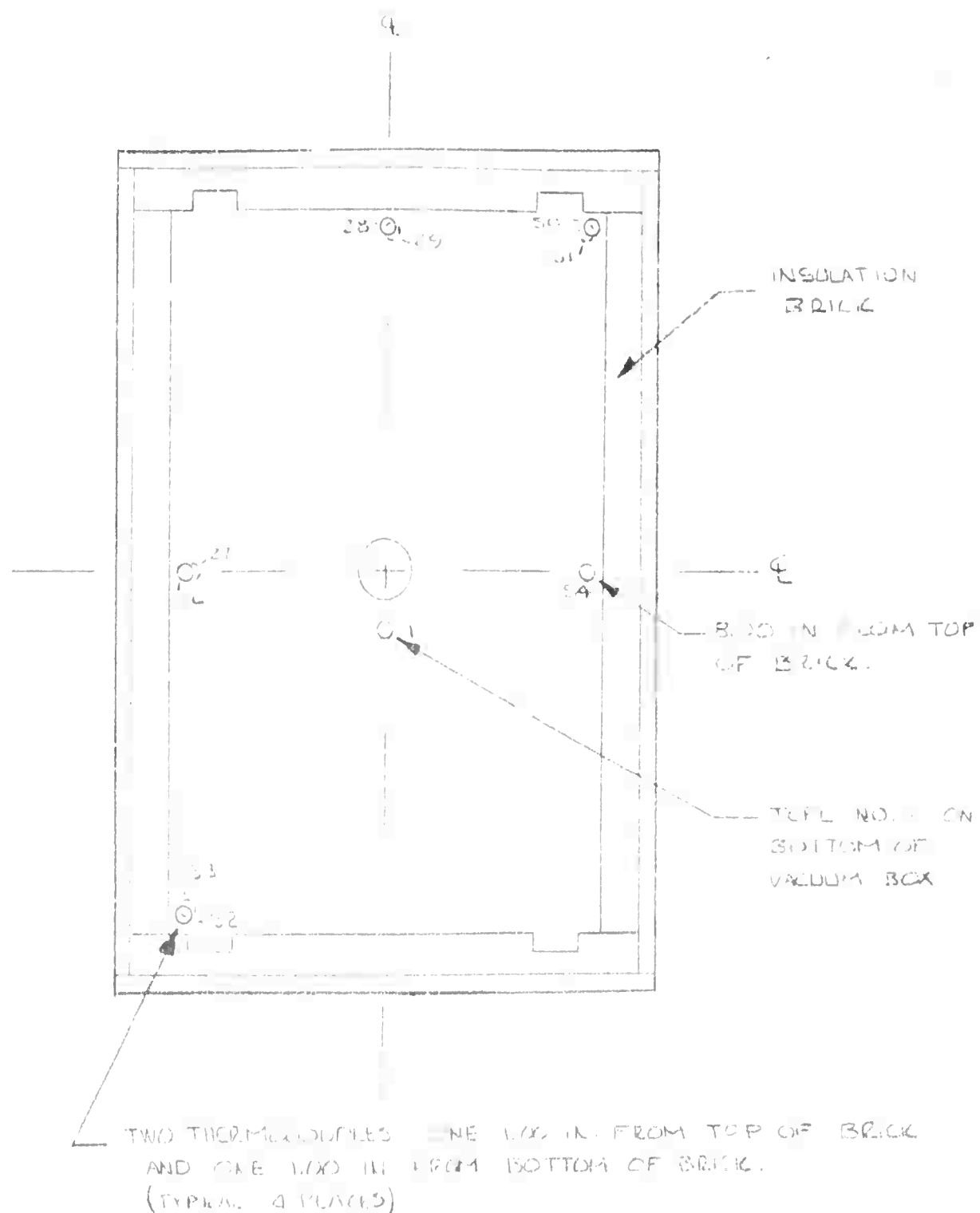
Sketch 7-63

THERMOCOUPLE LOCATIONS
RE-RADIATING PANEL
LT-5593-2-1

THE ENGINE COMPANY

DZ-80084

Fig



Sketch 7-63

THERMOCOUPLE LOCATIONS

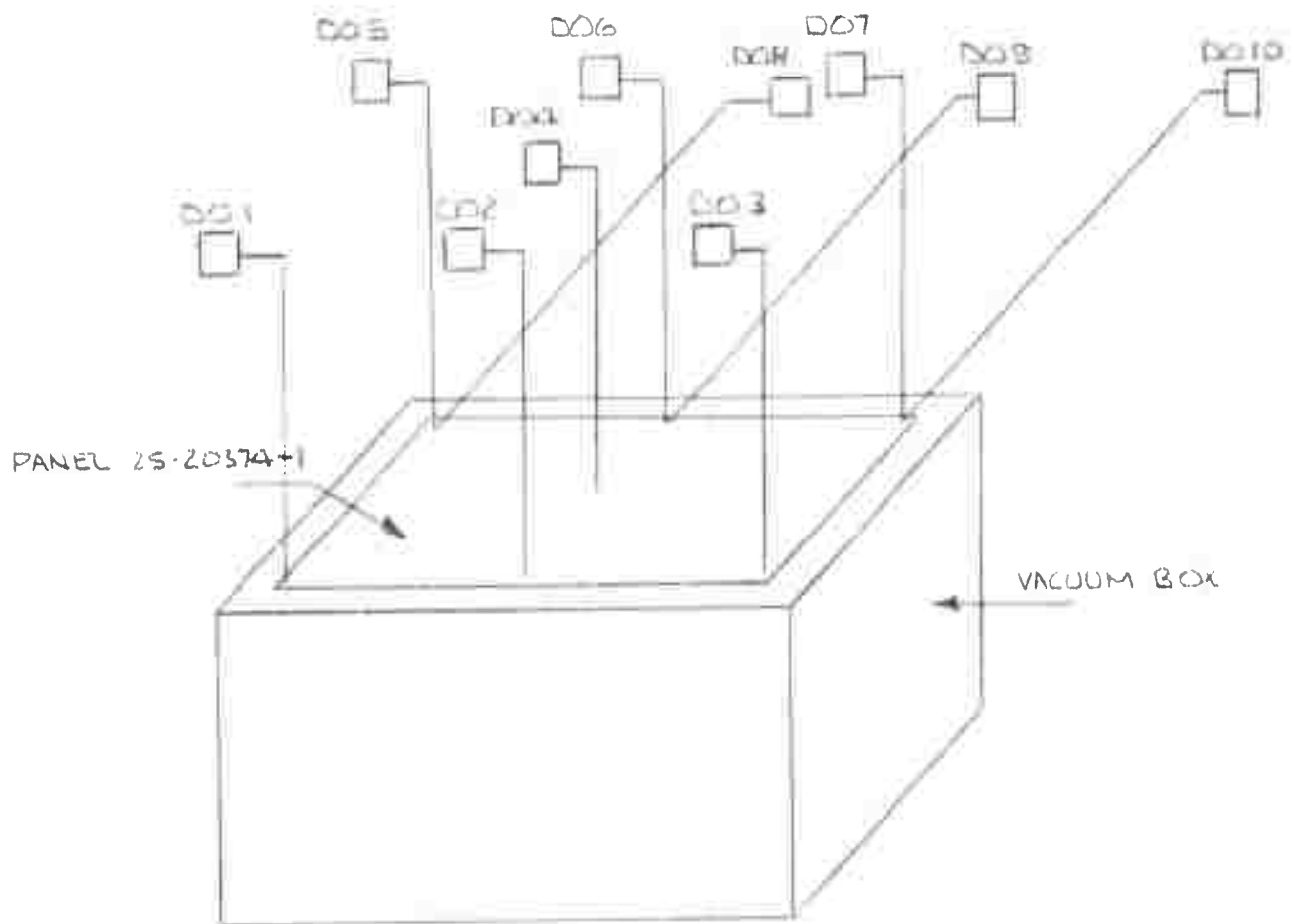
VACUUM BOX

11-5593-2-1

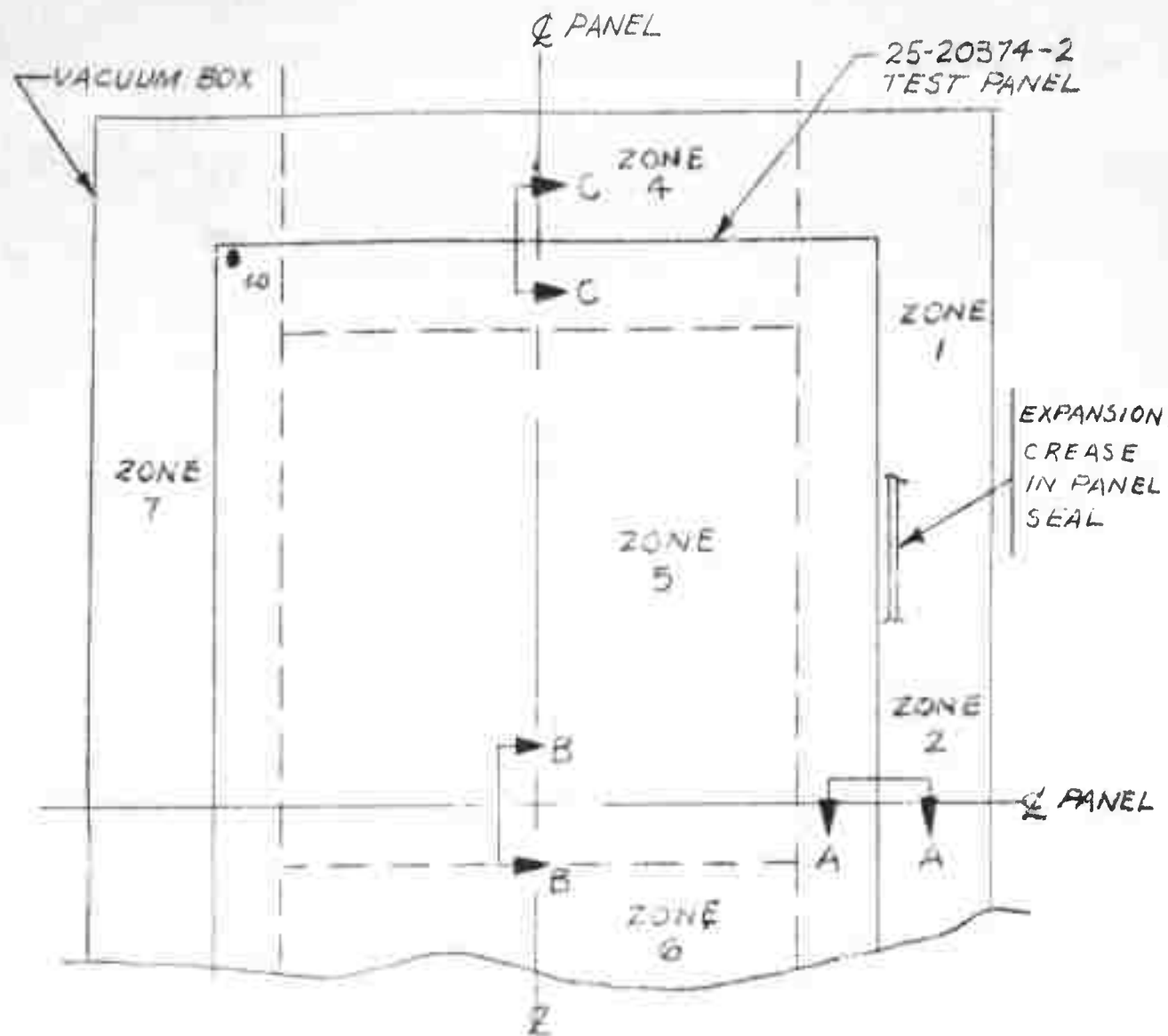
THE WINDING MOUNT

02 80084

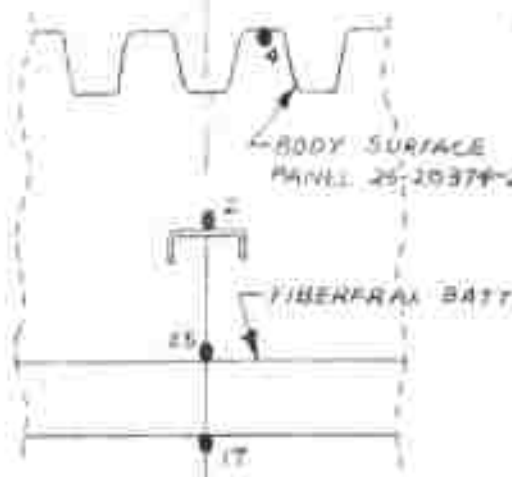
Fig



CALC <i>Silvest 7-63</i>	REVISED	DATE	DEFLECTION GAGE LOCATIONS		
CHECK			LT-5593-2-1		D2-80084
APPD			BOEING AIRPLANE COMPANY		PAGE
APPE					FIG 69



VIEW A-A

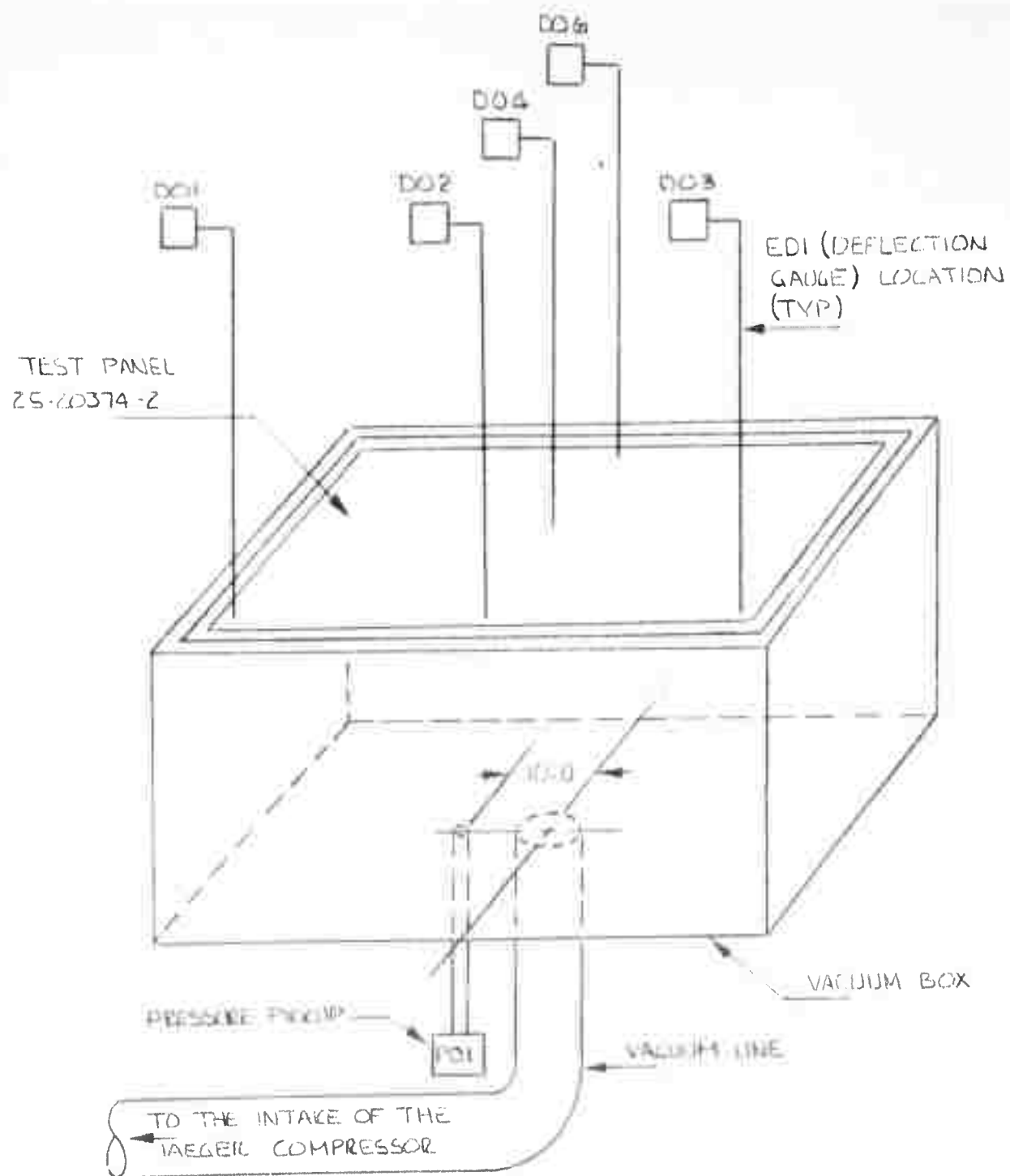


VIEW B-B

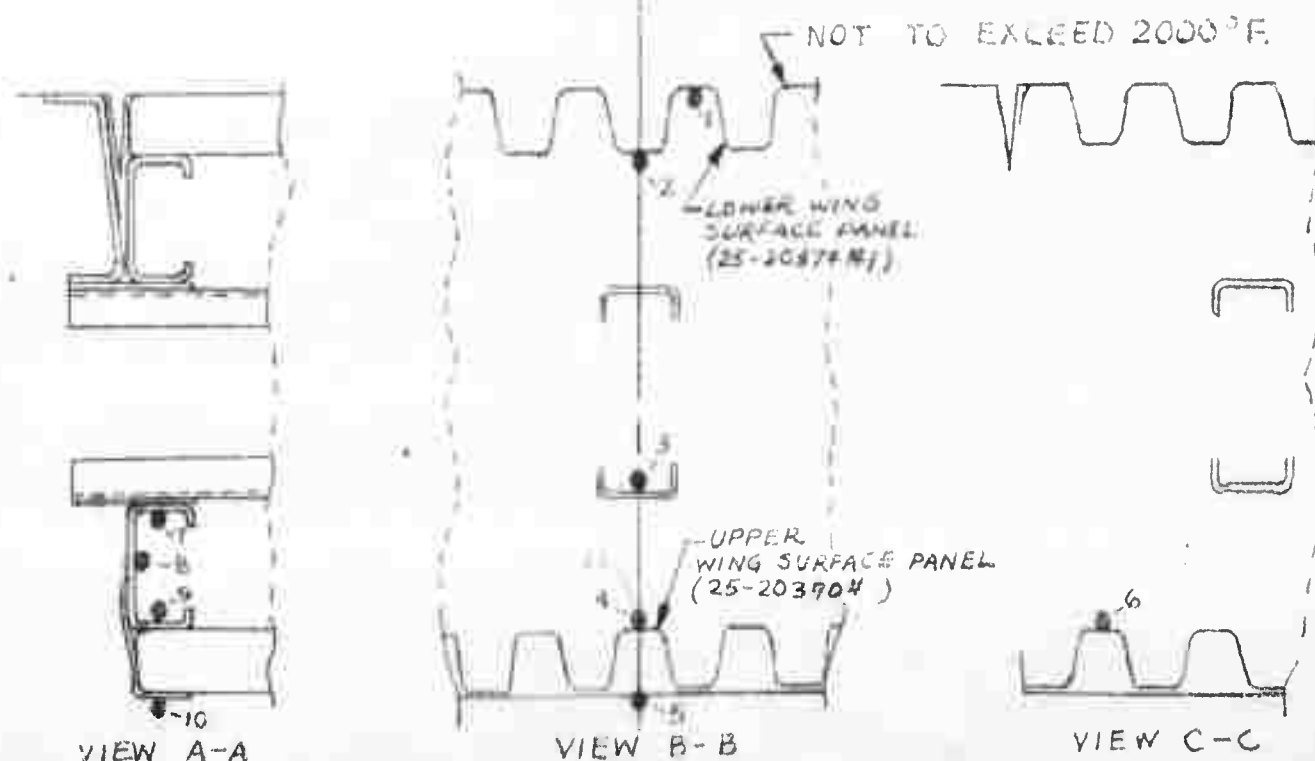
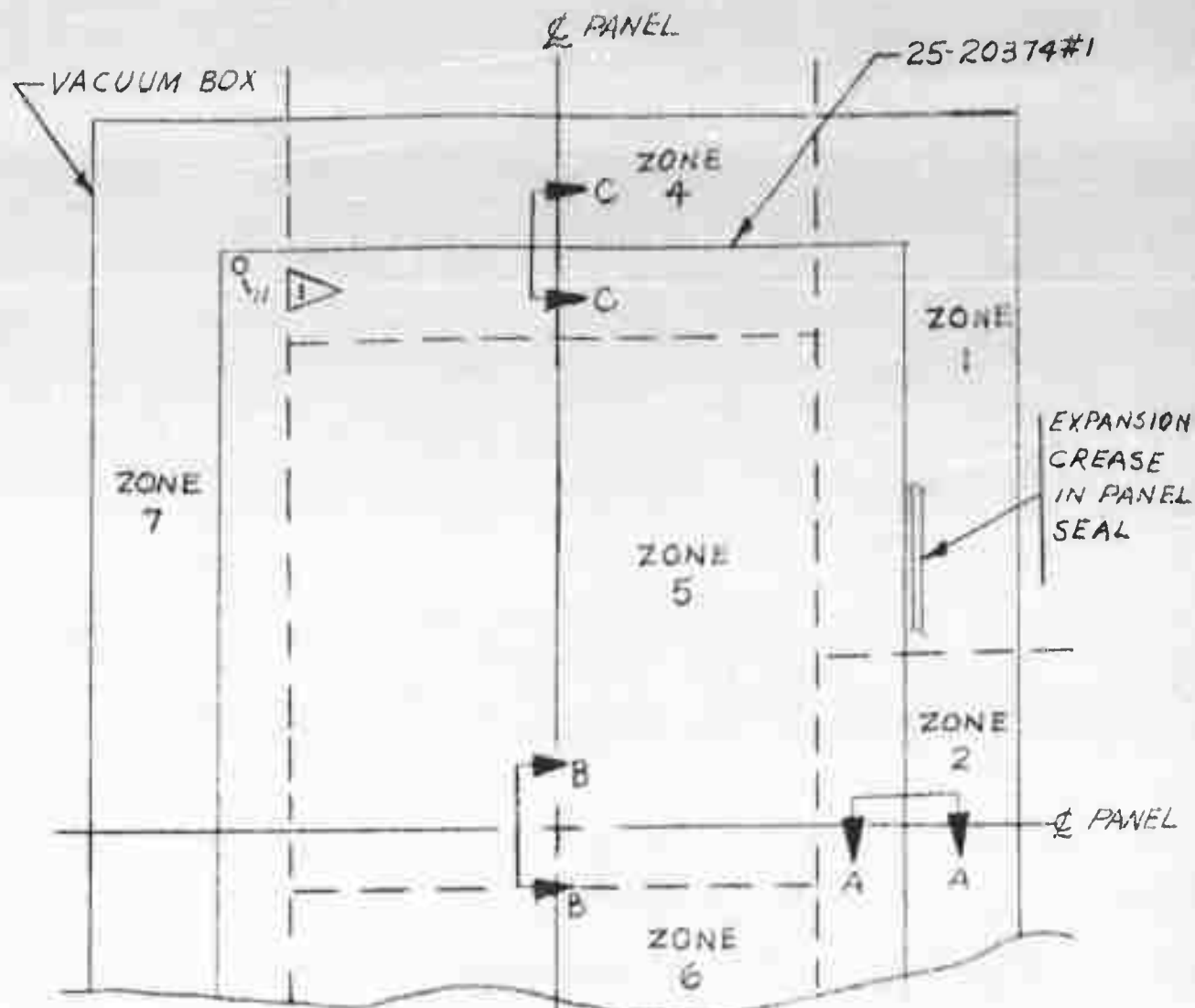


VIEW C-C

CALC	G. MILLS	7/17/61	REVISED	DATE	MONITOR THERMOCOUPLE LOCATIONS LT 2-2	VOL 1
CHECK	E. Hervey	7/17/61				02-80084
APR						
APR						
					BOEING AIRPLANE COMPANY	PAGE FIG 70

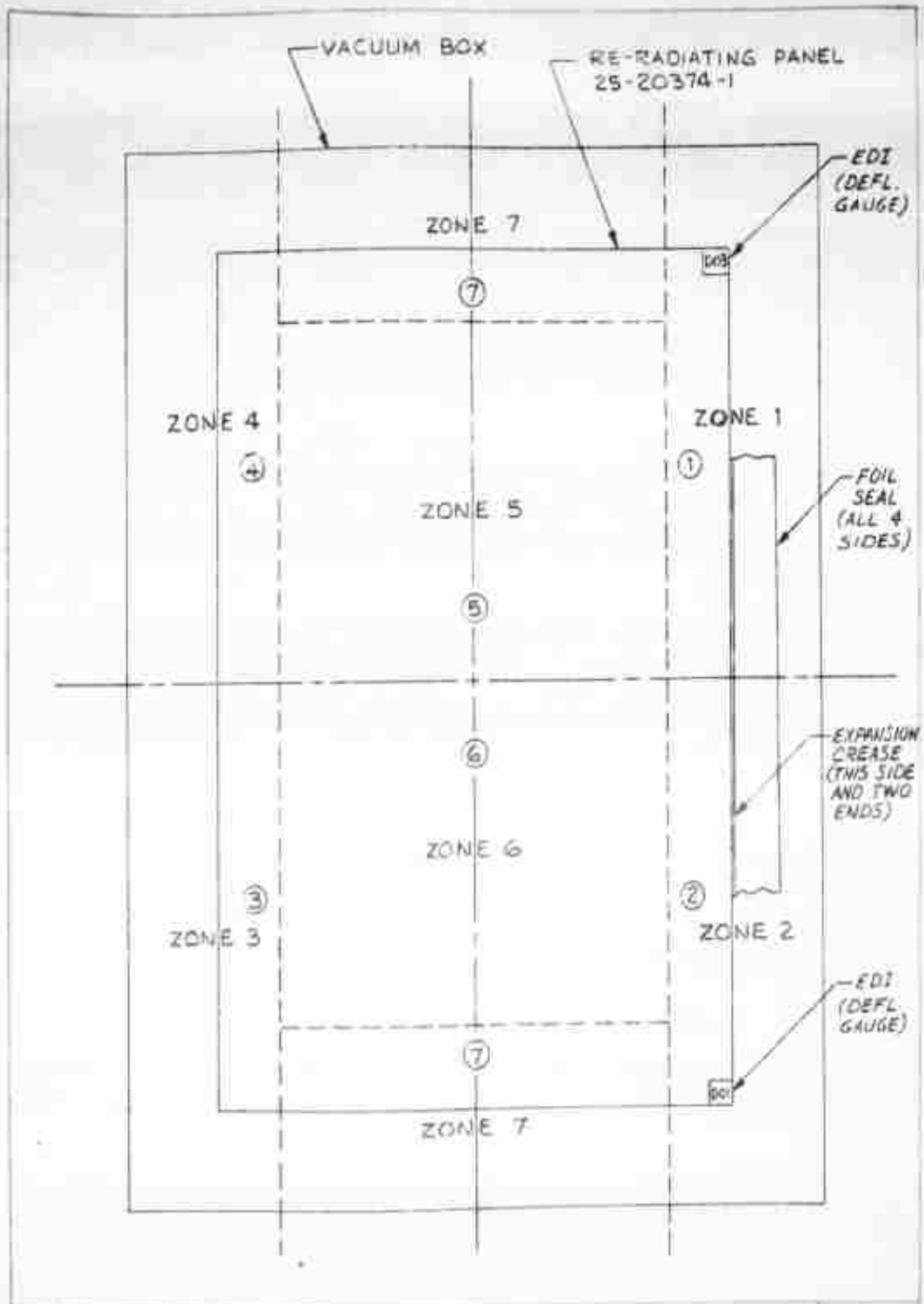


CALC	Schneider	5-31-63	REVISED	DATE	DEFLECTION AND PRESSURE MEASUREMENT LOCATIONS	VOL I
CHECK					WING PANEL TEST LT-2-2, 1	DZ-80084
APPD					THE BOEING COMPANY	PAGE
APPD						FIG 71

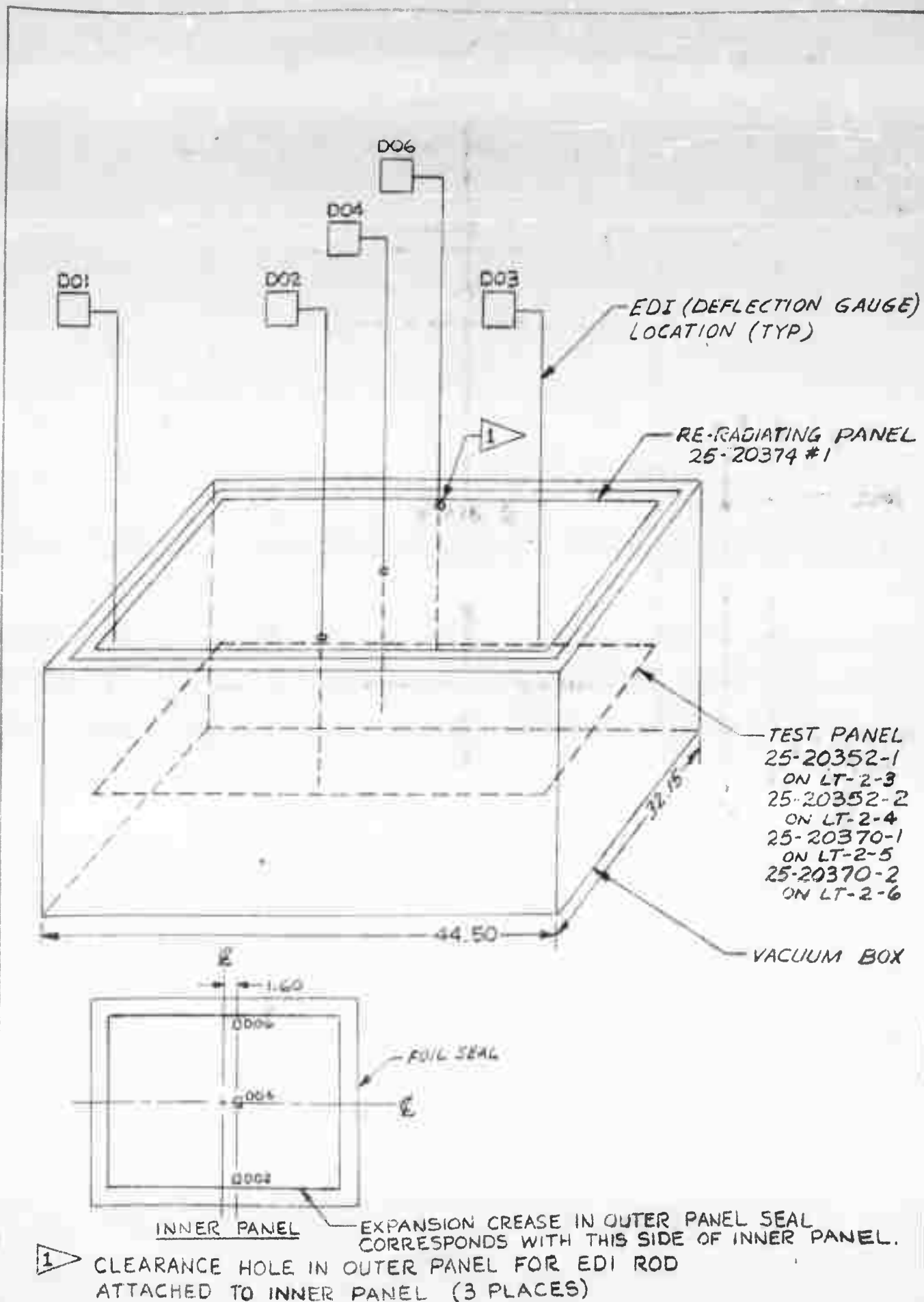


VIEW A-A VIEW B-B VIEW C-C
 THERMOCOUPLE #11 LOCATED ON 25-20374 PANEL SKIN.

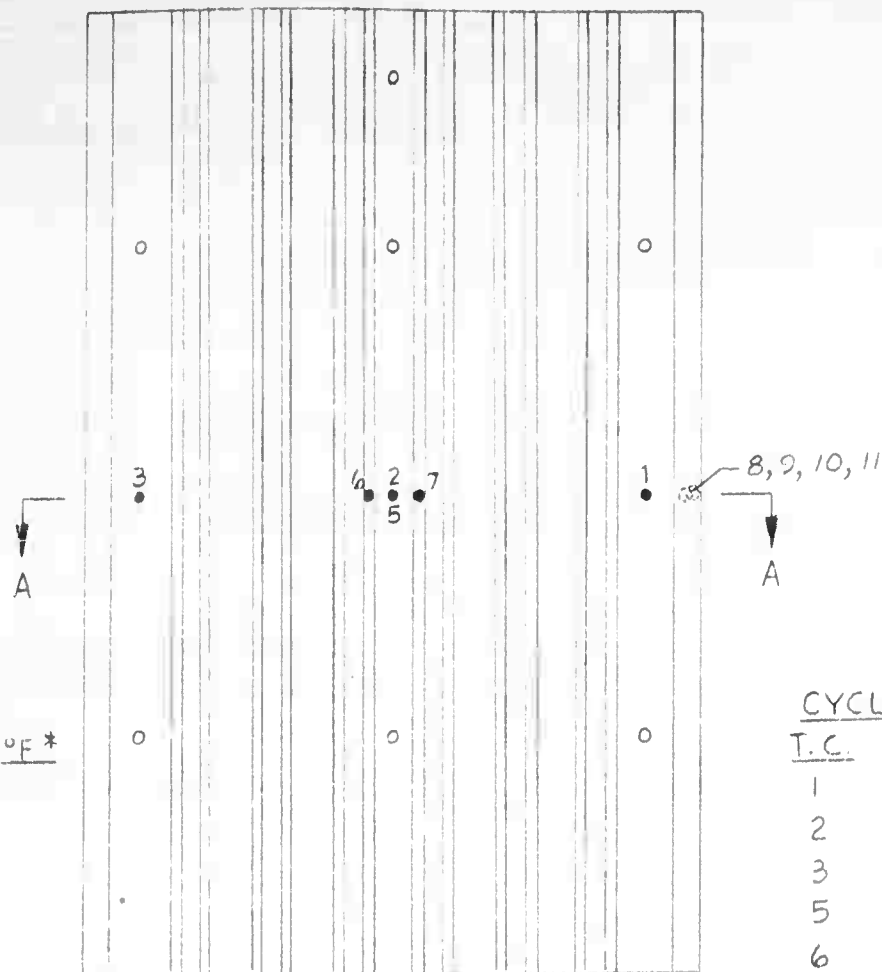
CALC	G. MILLS 8/22/61	REVISED	DATE	MONITOR THERMOCOUPLE	Vol 1
CHECK				LOCATIONS	
APR				TEST LT-2-B thru LT-2-G	DZ-80084
APR				BOEING AIRPLANE COMPANY	PAGE F15 72



DATE	9/29/64	ZONE LAYOUT - EDI & T.C.	VOL 1
CHECK		LOCATIONS, OUTER PANEL 25-20374-1	D2-80004
APPD.		LT-2-3 THRU LT-2-6	PAGE 72
		COMPANY	

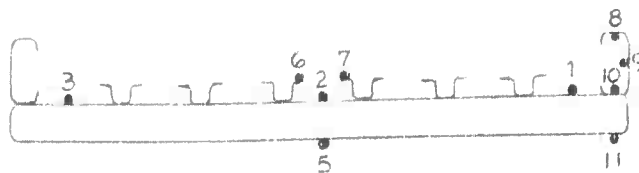


CALC	<i>Edenney 9/28/61</i>	REVISED	DATE	DEFLECTION GAUGE LOCATIONS	VOL I
CHECK				TESTS LT-2-3 THRU	02-80024
APPD				LT-2-6	PAGE
APPD				BOEING AIRPLANE COMPANY	FIG 7A



CYCLE 1	
T.C.	TEMP ~ °F *
1	1180
2	920
3	850
5	760
6	970
7	1050
8	1100
9	840
10	890
11	780

CYCLE 2	
T.C.	TEMP ~ °F *
1	1160
2	1000
3	930
5	810
6	1030
7	1060
8	1090
9	860
10	910
11	800



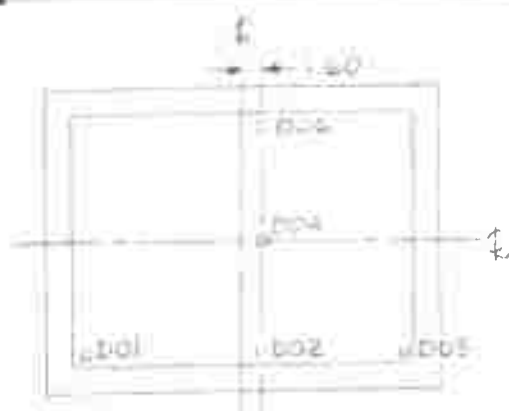
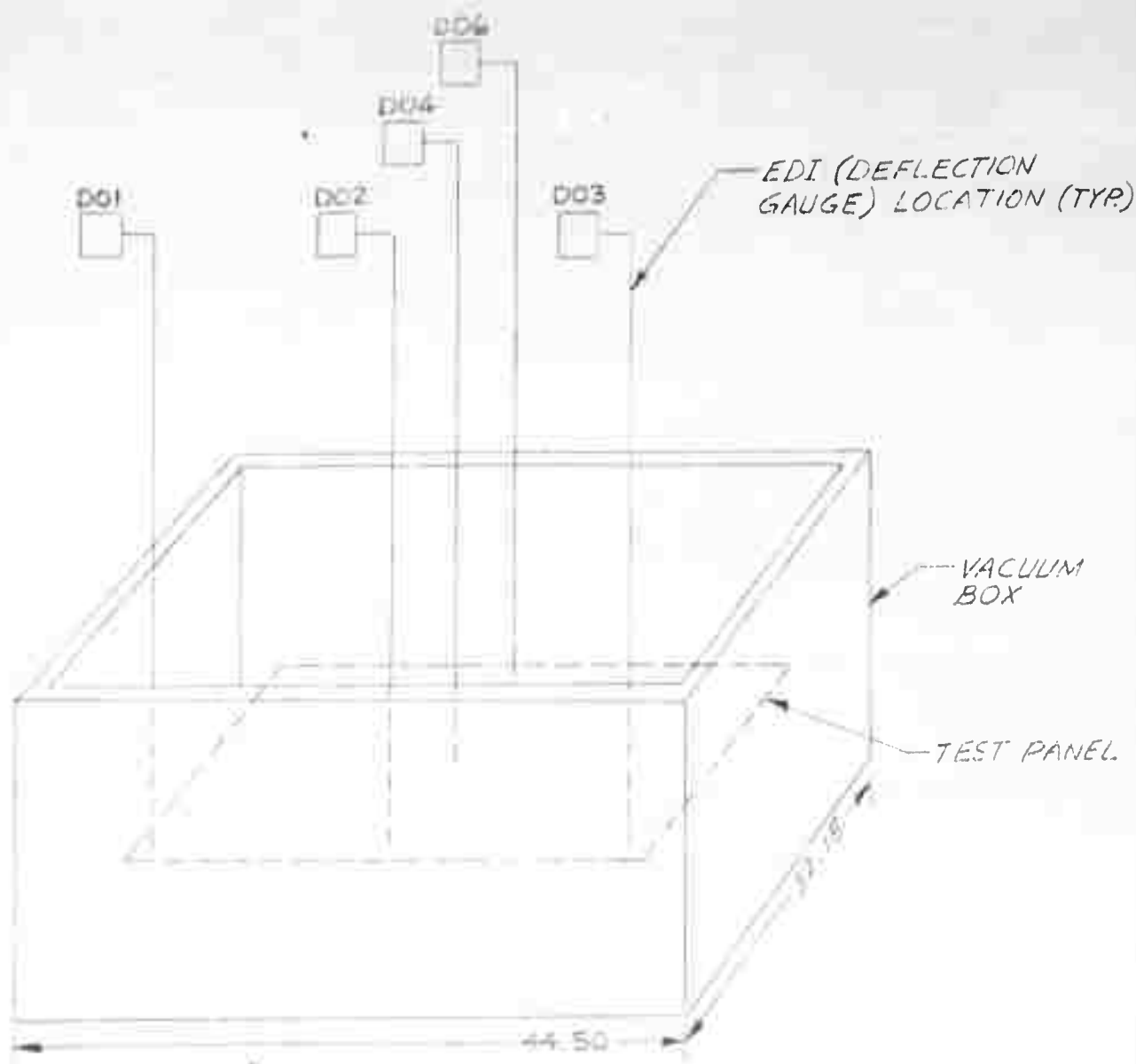
A-A

- MONITOR THERMOCOUPLES
- CONTROL THERMOCOUPLES

* AT PEAK OF CYCLE

CALC	Edlennsey 1-16-62	REVISED	DATE	THERMOCOUPLE LOCATIONS & PEAK TEST TEMPS. ~ UNSYMMETRICAL HEAT TEST LT-2-6B	Vol I
CHECK					
APPD					D2-80084
APPD					PAGE 1675

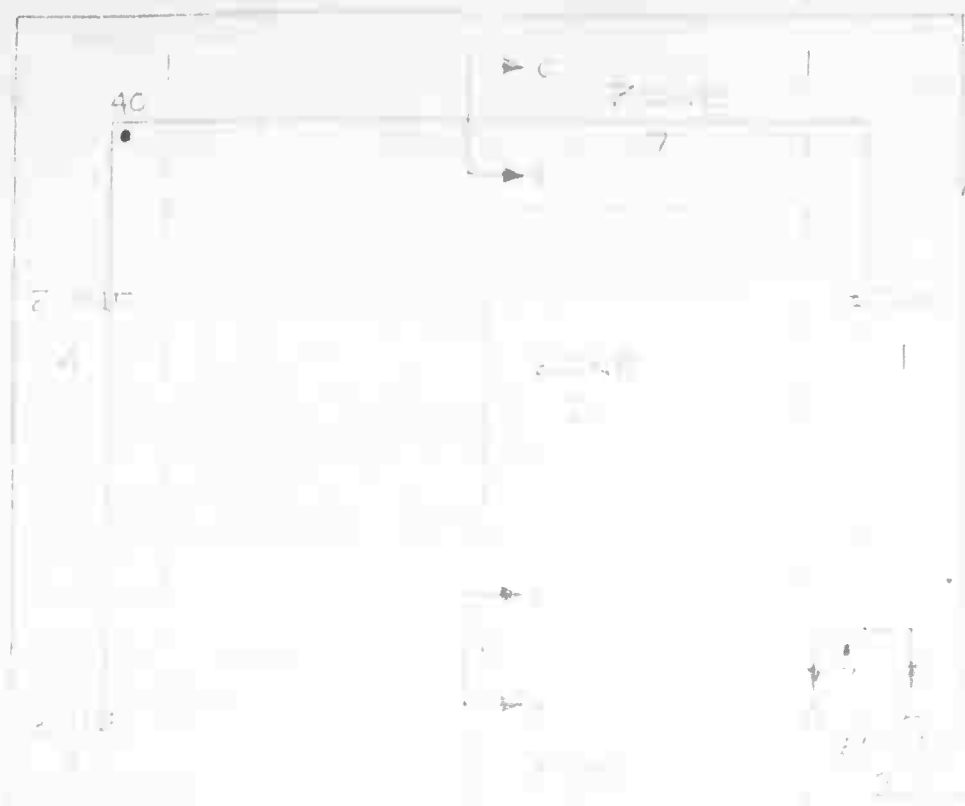
BOEING AIRPLANE COMPANY
SEATTLE 24 WASHINGTON



PEAK DEFLECTIONS

CYCLE 1		CYCLE 2	
EDI #	DEFL @ 3.75 min.	EDI #	DEFL @ 3.75 min.
D01	.010	D01	.025
D02	.295	D02	.310
D03	-.010	D03	-.023
D04	.465	D04	.490
D06	.260	D06	.300

CALC <i>Edenney</i> 1-23-2 CHECK APPD APPD	REVISED DATE	DEFLECTION GAUGE LOCATIONS UNSYMMETRICAL HEAT TEST LT-2-6B	VOL 1 D2-8008A PAGE FIG. 29
		BOEING AIRPLANE COMPANY	



HOTTER
SIDE IN
UNSYM.
HEAT TESTS



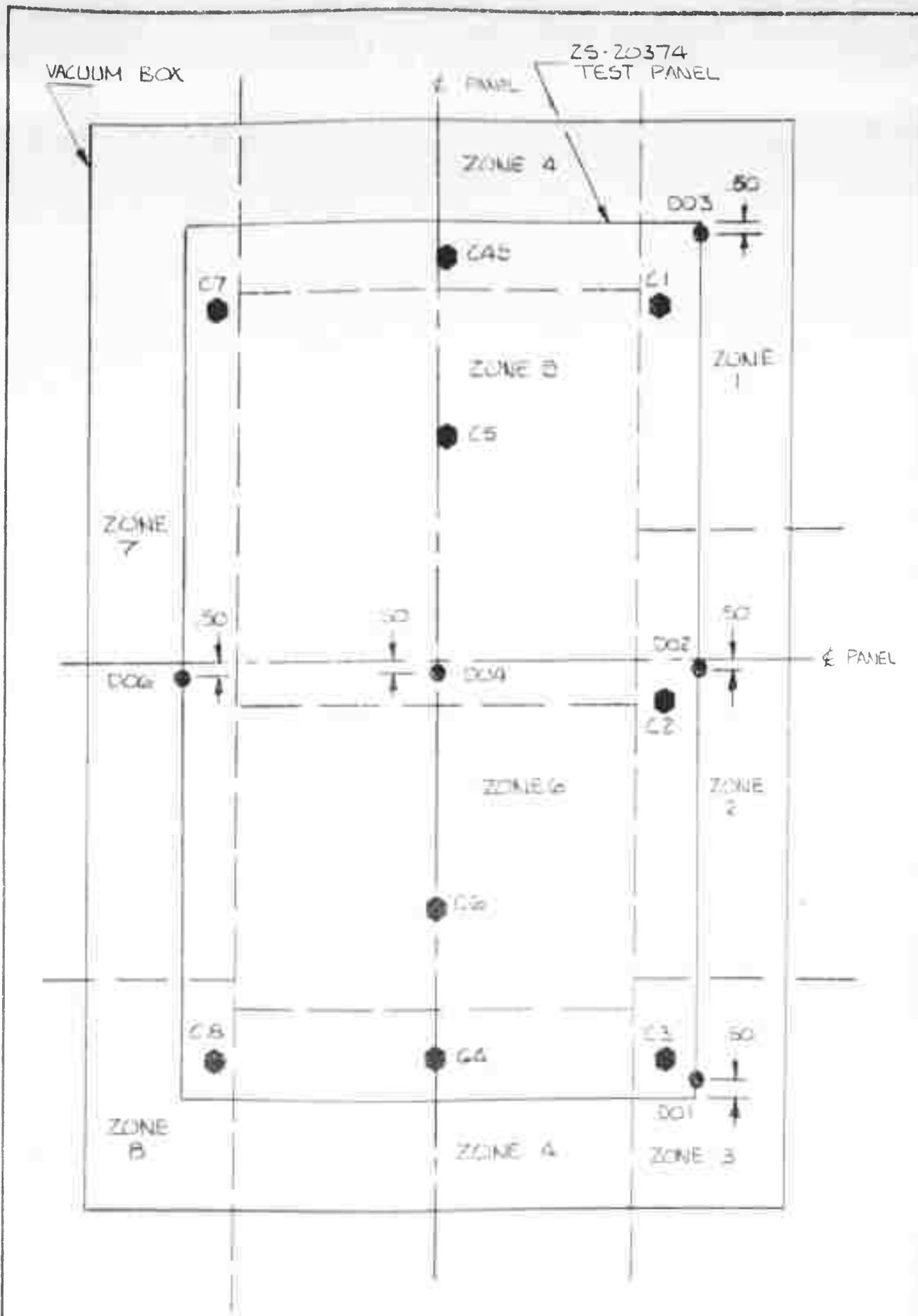
VIEW A-A

VIEW B-B

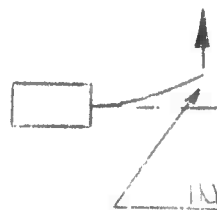
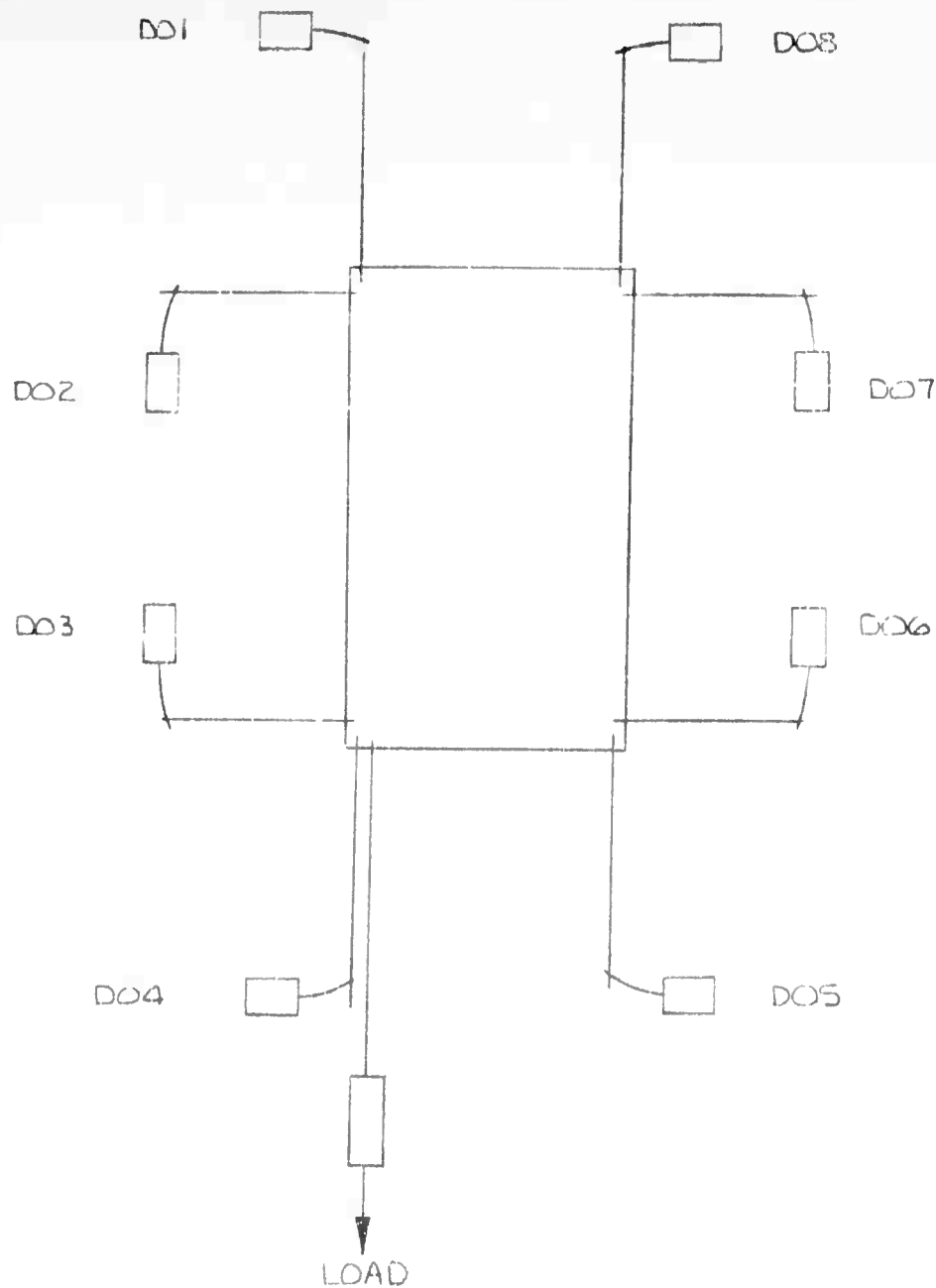
VIEW C-C



CALC	REVISED	DATE	THESE ARE THE ONLY TWO	VOL I 02-80084 PAGE FIG 11
CHECK			THESE ARE THE ONLY TWO	
APR			THESE ARE THE ONLY TWO	
APR			THESE ARE THE ONLY TWO	
BOEING AIRPLANE COMPANY				



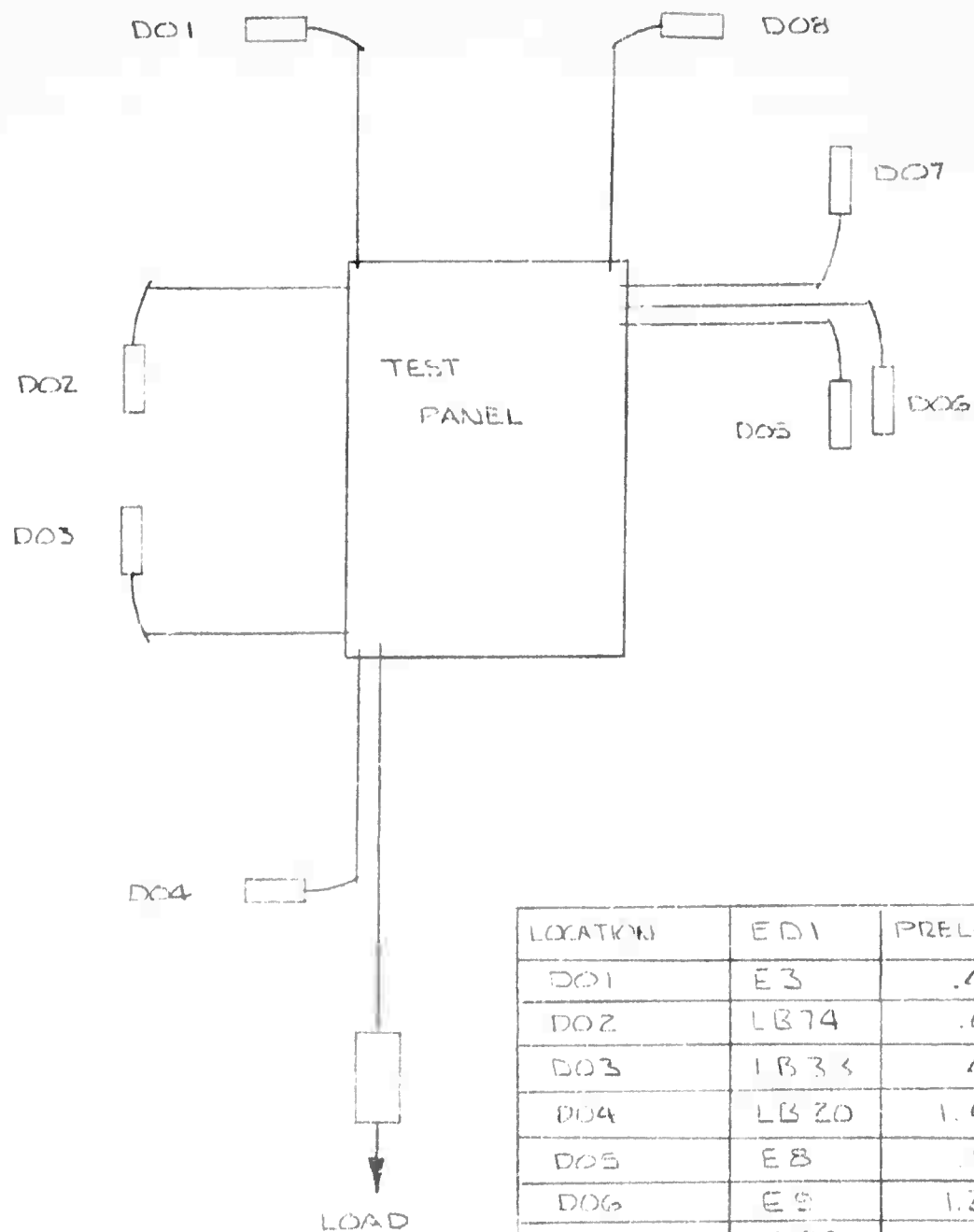
CALL	Schneider	5-31-63	TEST NO.	DATE	DEFLECTION AND CONTROL THERMOCOUPLE LOCATIONS WING PANEL TESTS LT-3-1, 4-1, 4-2	VOL 1
CHECK						D1-B0001
APPD						PAGE
APPD					THE BOEING COMPANY	PL 15



MOTION IN THIS DIRECTION WITH RESPECT TO
THE EDI-BEAM-INITIAL-DISPLACEMENT IS POSITIVE
(UPWARD ON LOAD-DEFLECTION PLOTS)

INITIAL DISPLACEMENT

CALC	Schneid 6-63	REVISED	DATE	EDI LOCATIONS TEST LTS-593-3-2	VOL 2
CHECK					01-00084
APPD					
APPD					
				THE BOEING COMPANY	



LOCATION	EDI	PRELOAD
DO1	E3	.4
DO2	LB74	.6
DO3	LB33	.4
DO4	LB20	1.4
DO5	E8	.8
DO6	E9	1.2
DO7	LB55	.6
DO8	E12	.4

CALC	Schneid 5-31-63	REVISED	DATE	EDI LOCATIONS TEST LT S-593-3-3	VOL 1
CHECK					02-80084
APPD					
APPD					
THE BOEING COMPANY					PAGE 90

[illegible]

EL N.

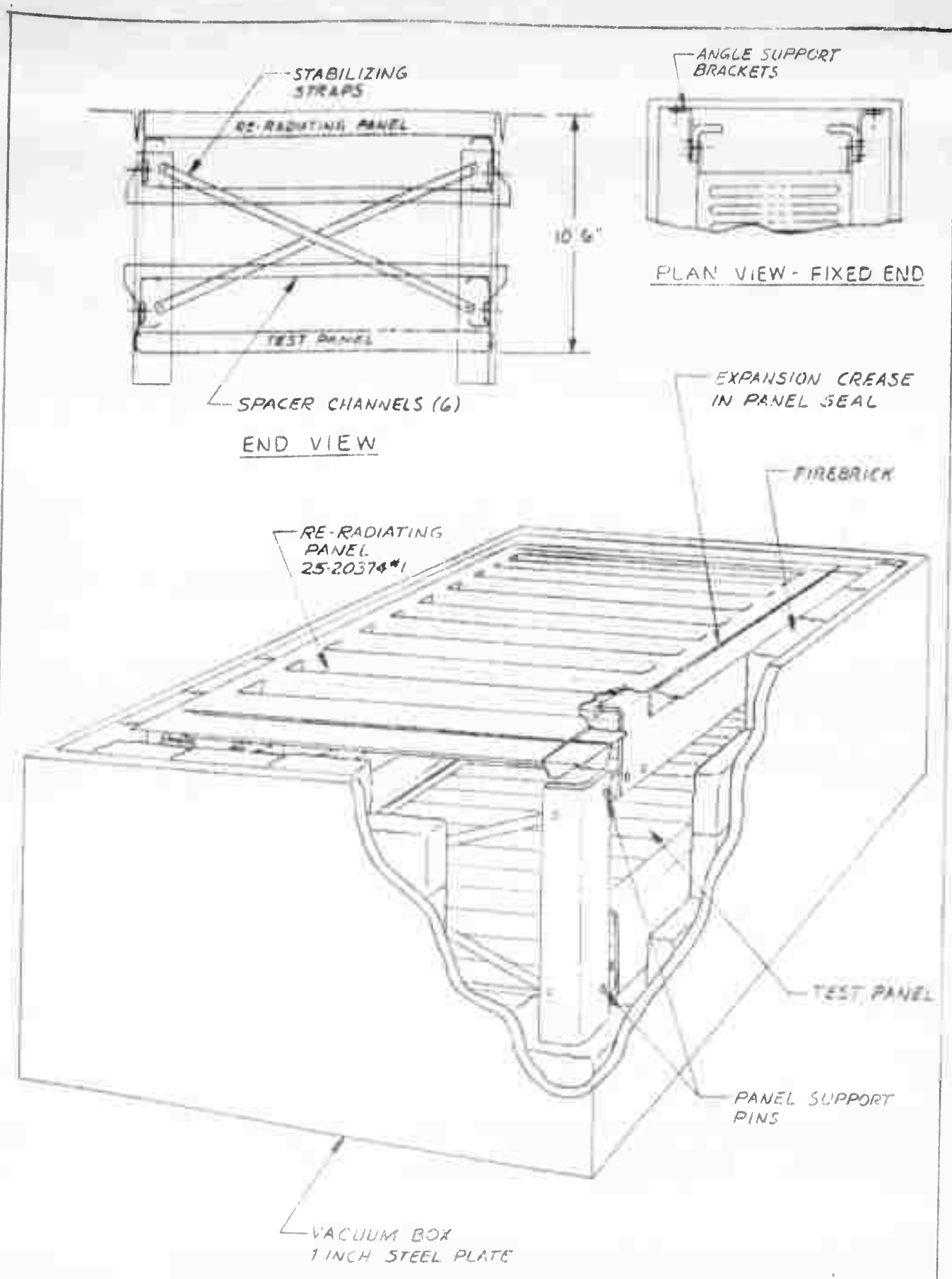
[illegible]

Vol I

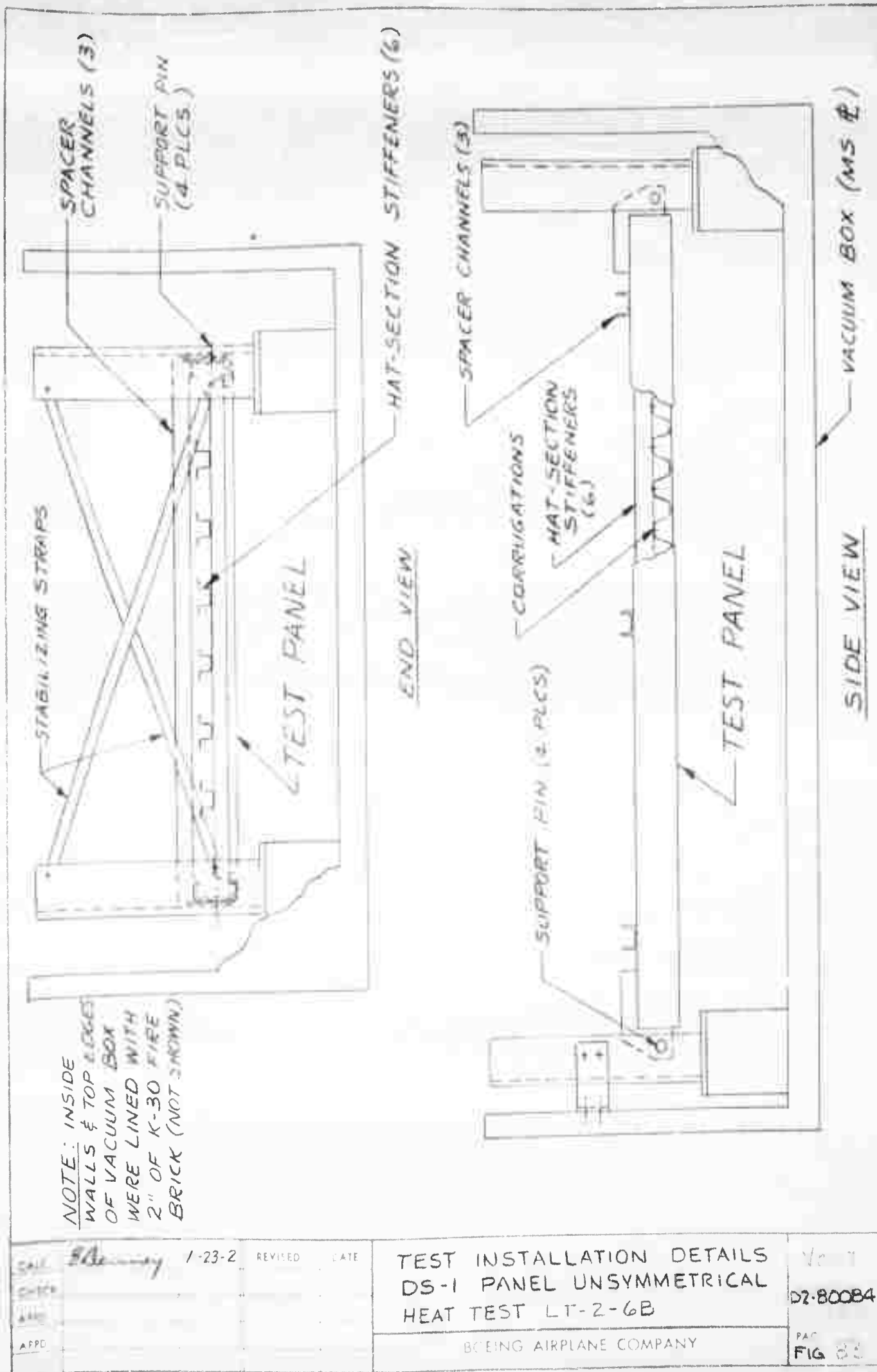
DZ-80084

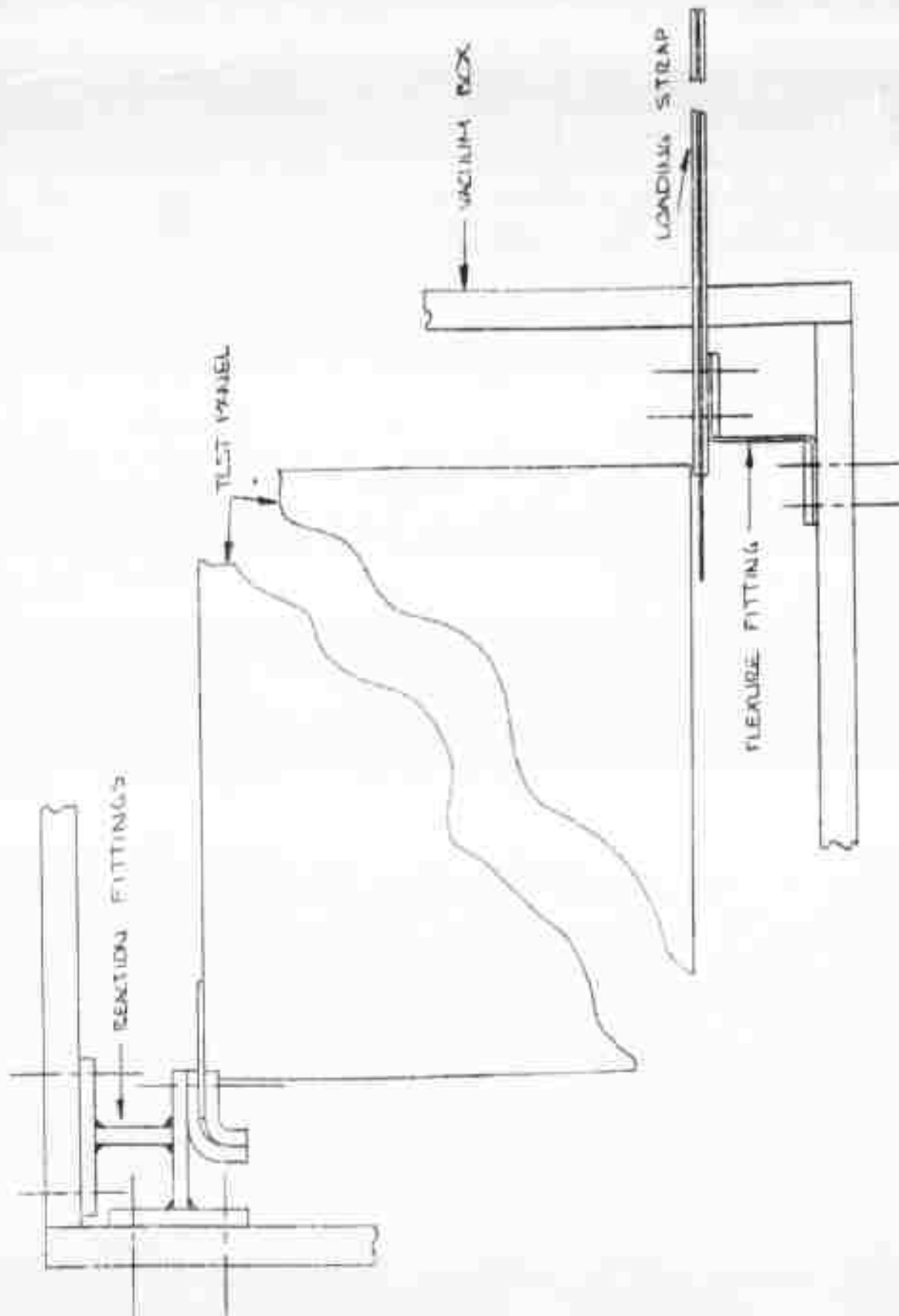
BOEING AIRPLANE COMPANY

1. 2. 3.

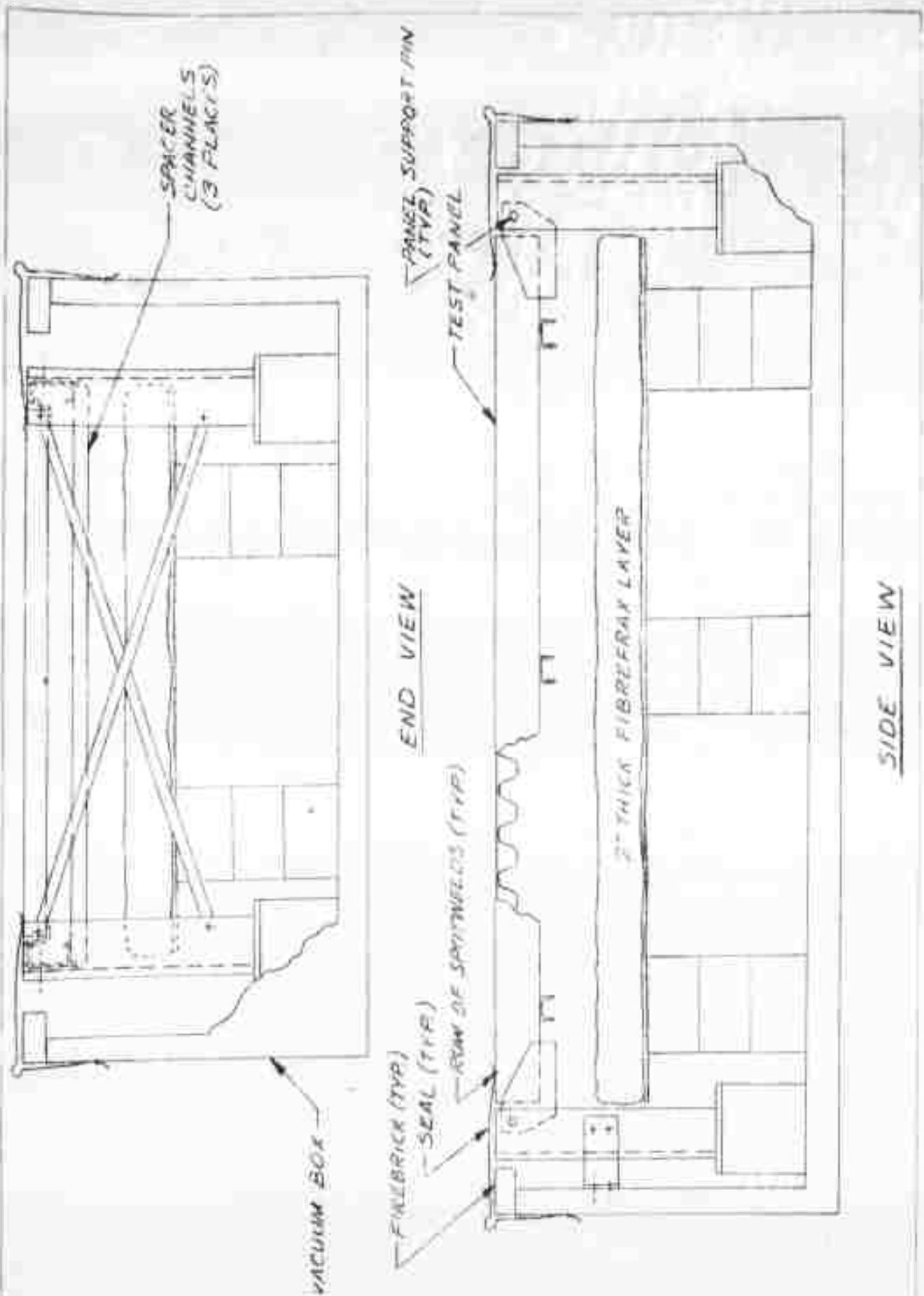


DATE	11/2/41	REVISED	DATE	TEST PANEL INSTALLATION	7/20/41
DRAWN				THERMAL FATIGUE TESTS	
APPROVED				LT-2-3 THRU LT-2-6	D2-80084
APPROVED				BOEING AIRPLANE COMPANY	PAGE 82
				SEATTLE 24 WASHINGTON	

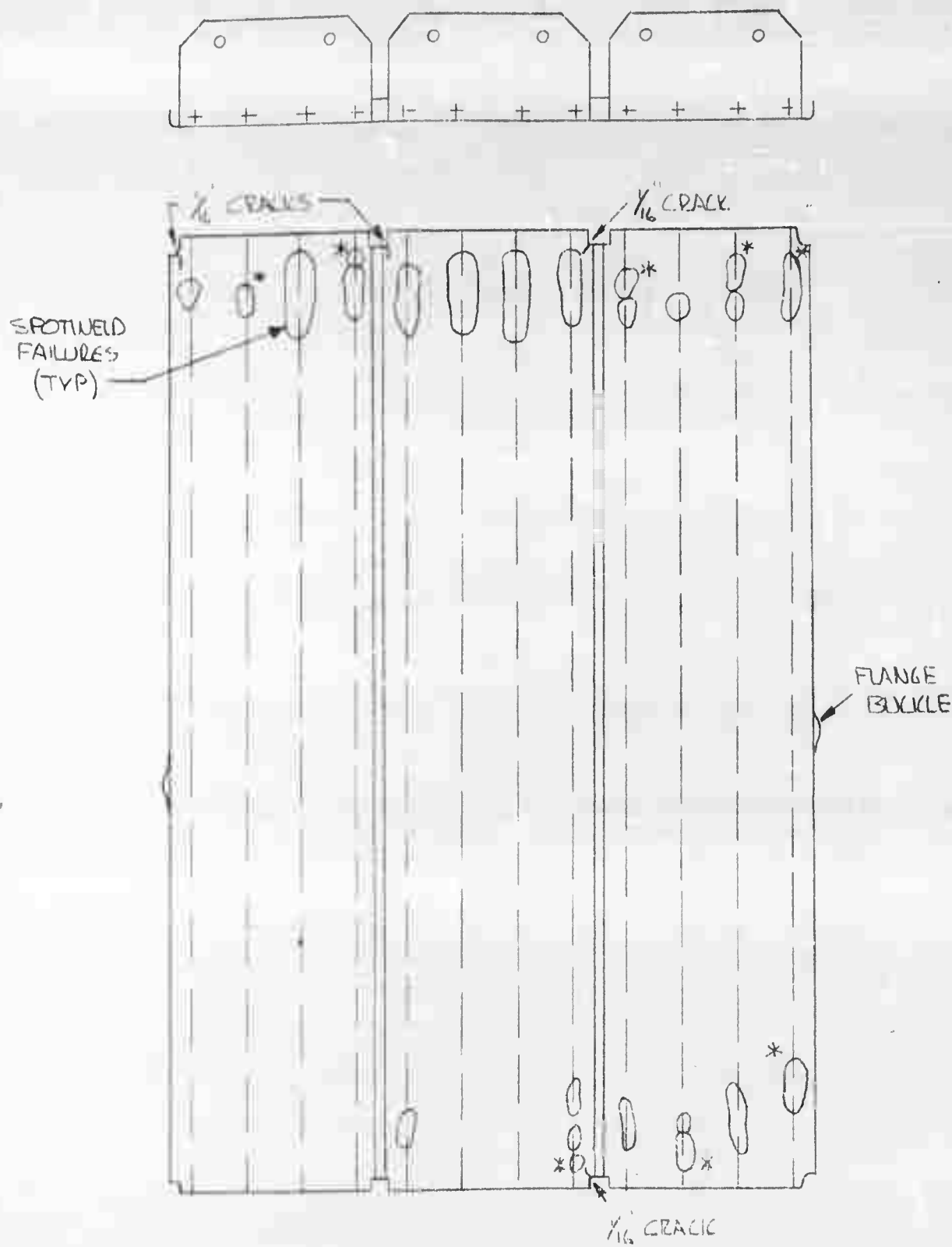




CALC	<i>Submittal</i> 6-10-63	REV	SED	DATE	TEST PANEL MOUNTING GENERAL ARRANGEMENT, LT-5593-3	7021
CHECK						D2-80084
APPD						PAGE
APPD					THE BOEING COMPANY	170 84

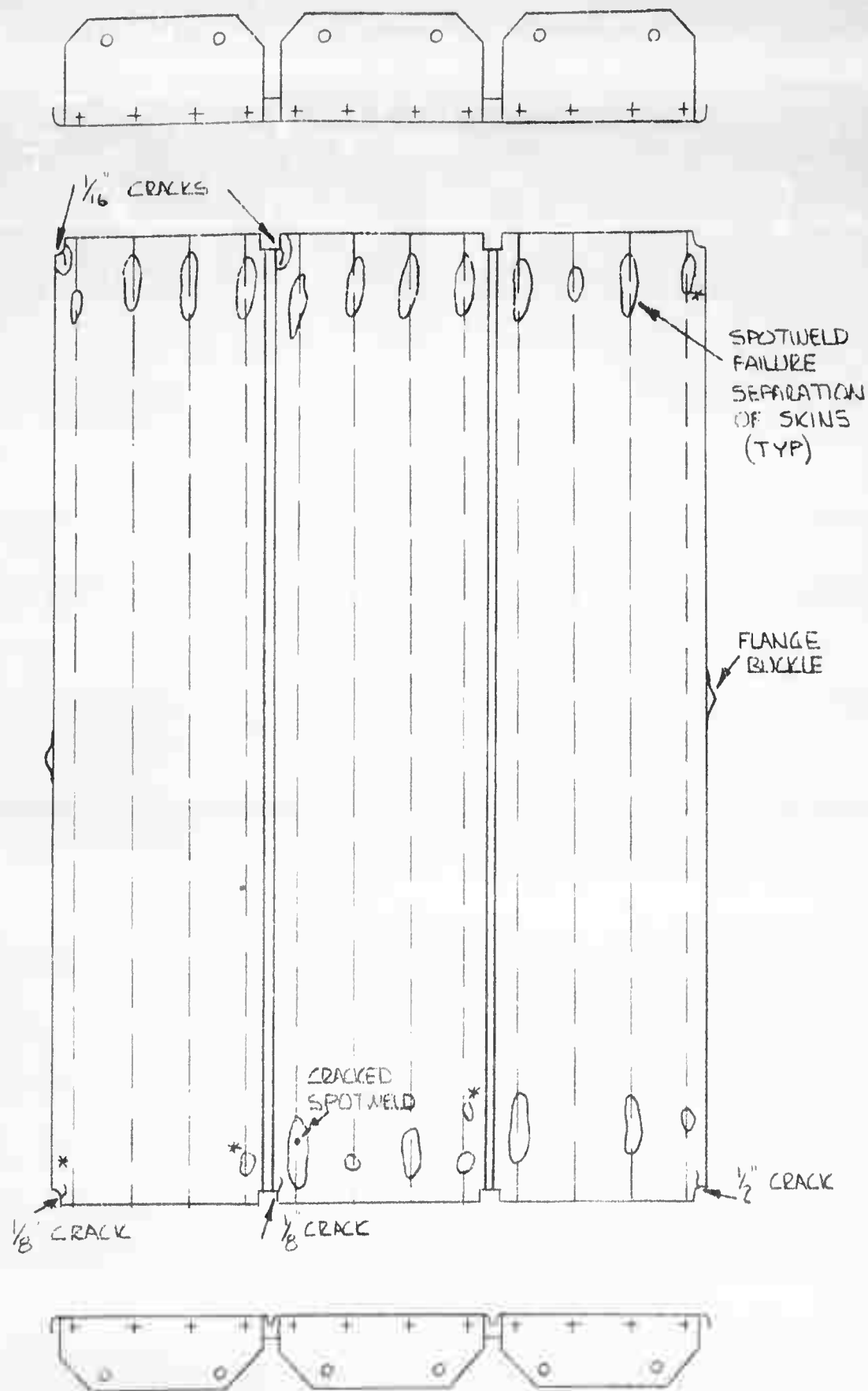


CALC. <i>Chenney</i> 1-31-2 CHECK APPD. APPD.	REPRESENTATIVE PANEL INSTALLATION TESTS LT-4-2, -4-3 & -4-4 ~DS WG. PANEL UNSYM. HEAT & PRESSURE TESTS	Vol. 1 DE-60004 PAGE 16
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* FAILURE DUE TO SONIC TESTING

CALC	Schneid 6-7-63	REVISED	DATE	PANEL 25-20344-1 AFTER HEAT AND SONIC TESTING PANEL 1479	Vol. 2 02-80086 PAGE 1
CHECK					
APPD					
APPD					
				THE BOEING COMPANY	

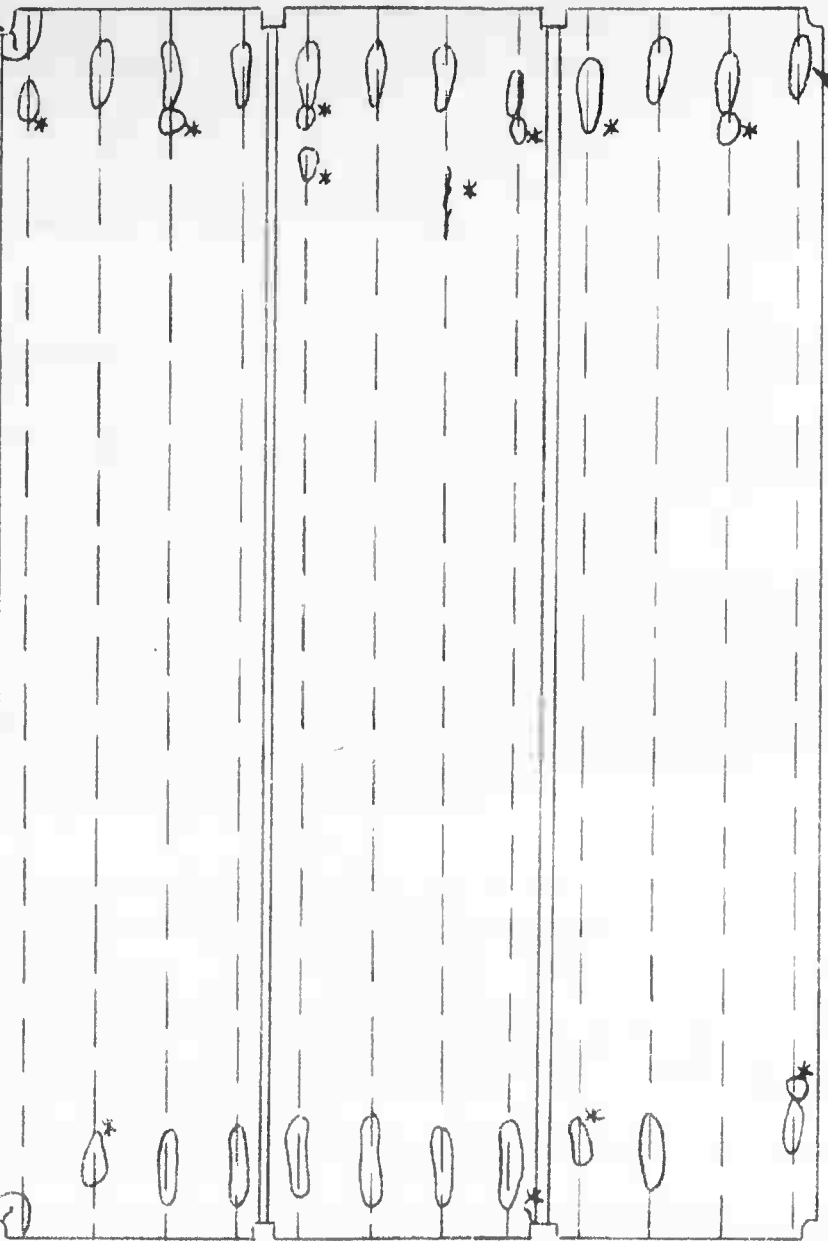


* FAILURE DUE TO SONIC TESTING


CALC	<i>Schneider</i>	6-7-63	REVISED	DATE	PANEL 25-20344-1 AFTER HEAT AND SONIC TESTING PANEL 1478 THE BOEING COMPANY	Vol. 1
CHECK						02-80084
APPD						
APPD						



$\frac{1}{8}$ " CRACK →

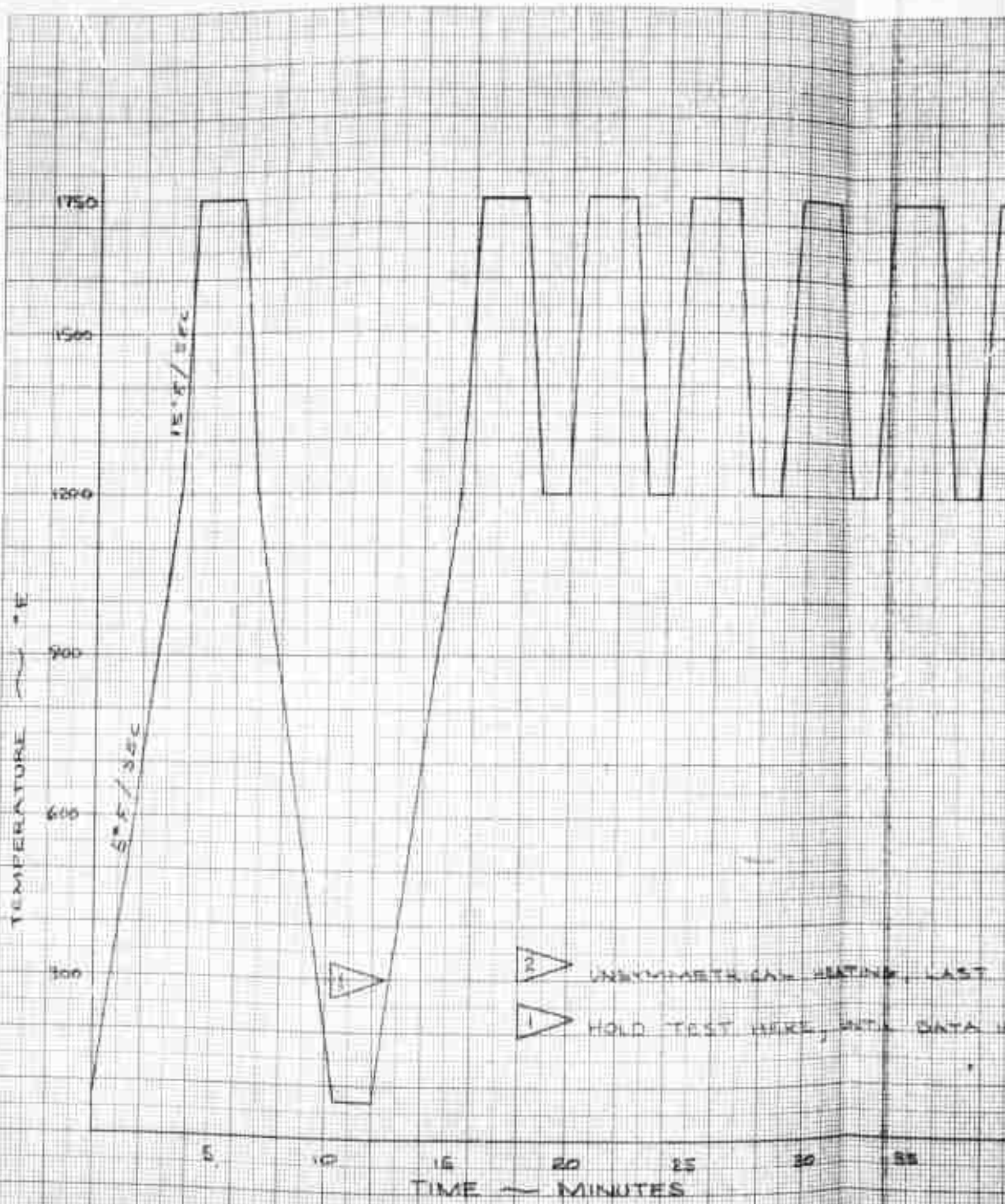


SPOTWELD
FAILURE
SEPARATION
OF SKINS
(TYP)

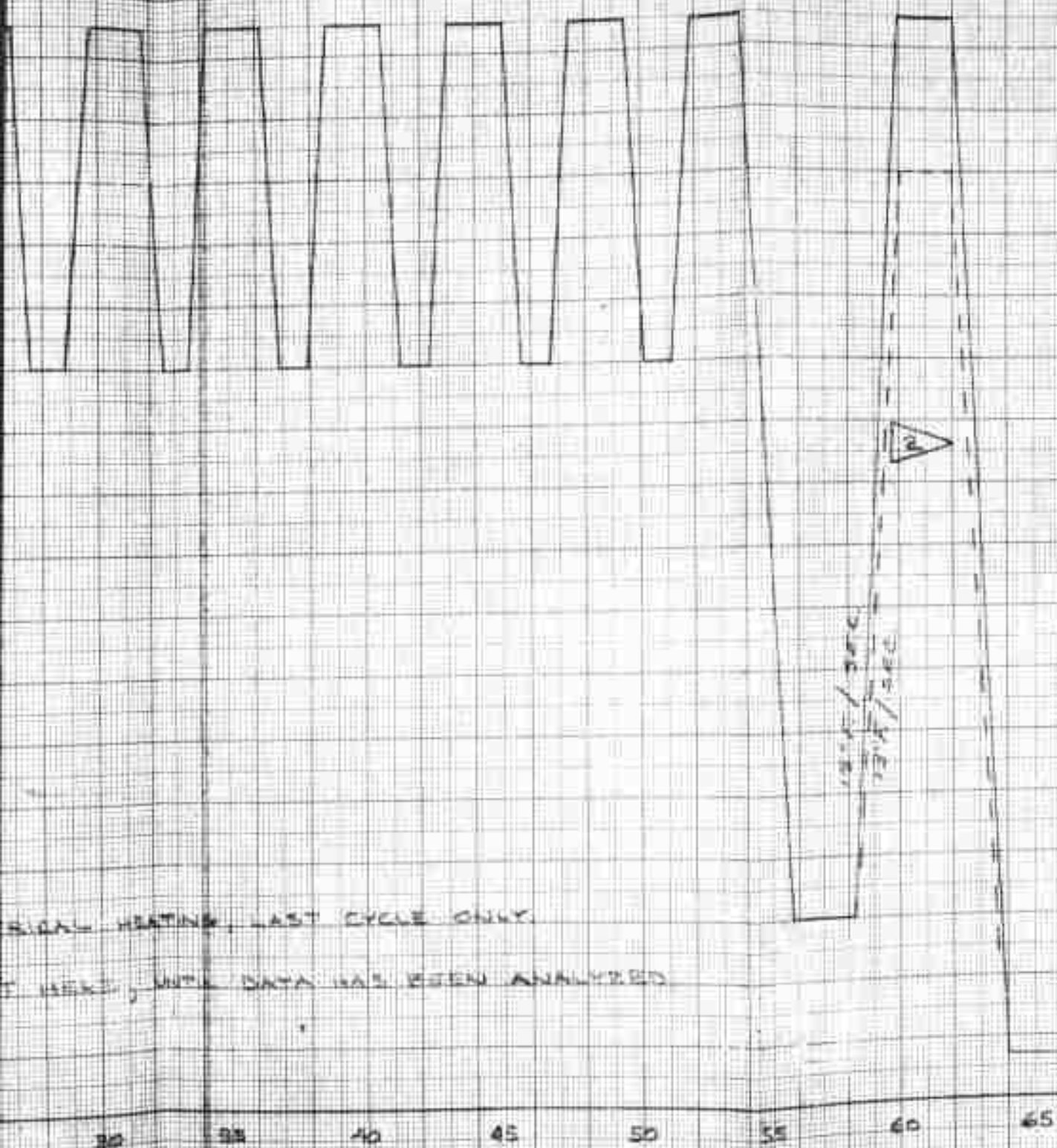


* FAILURES DUE TO SONIC TESTING

CALC	Schmeich	6-7-63	REVISED	DATE	PANEL ZS-20344-1 AFTER HEAT AND SONIC TESTING PANEL 1477	VCA I
CHECK						D2-80084
APPD						
APPD					THE BOEING COMPANY	PAGE 1

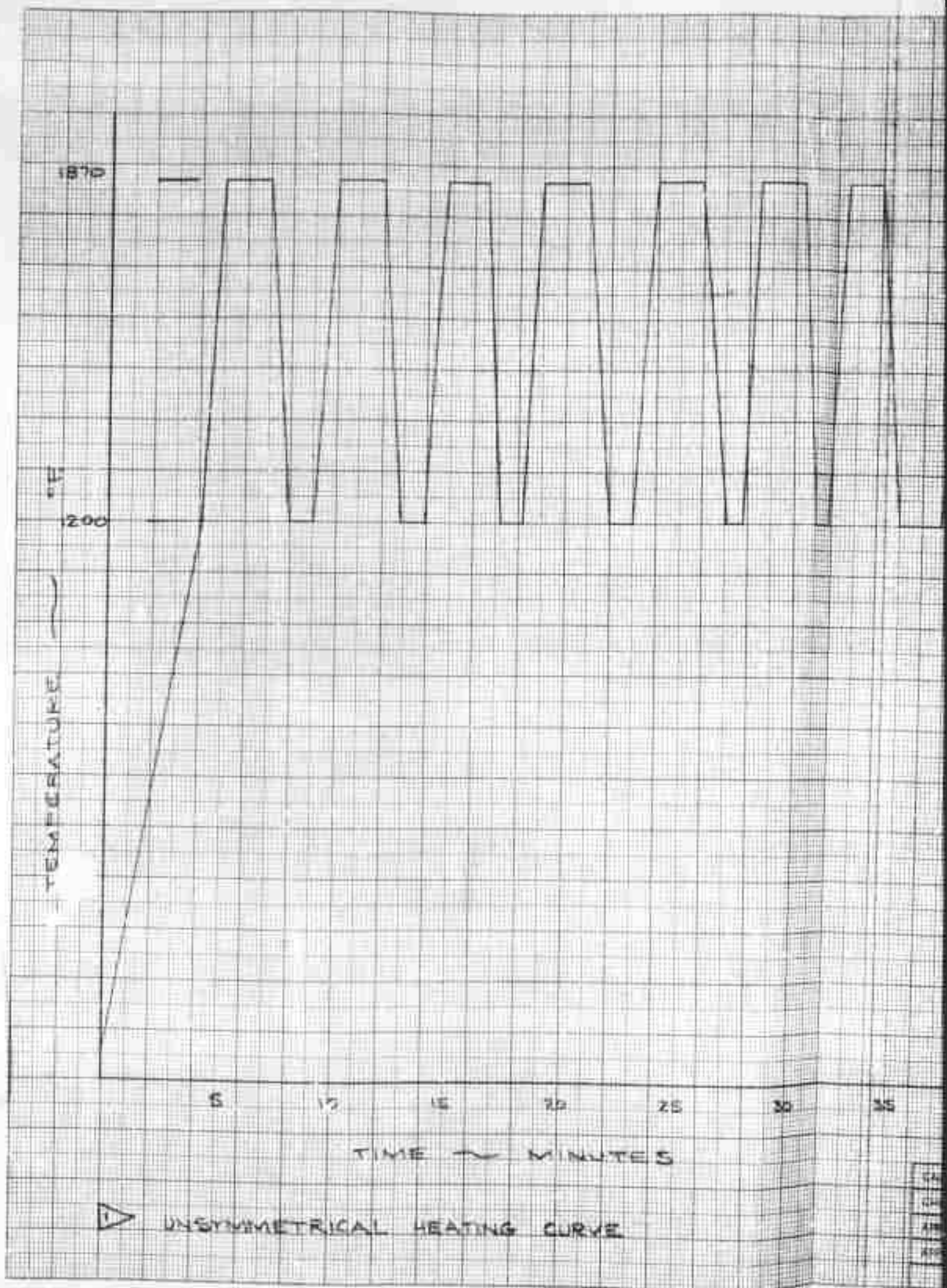


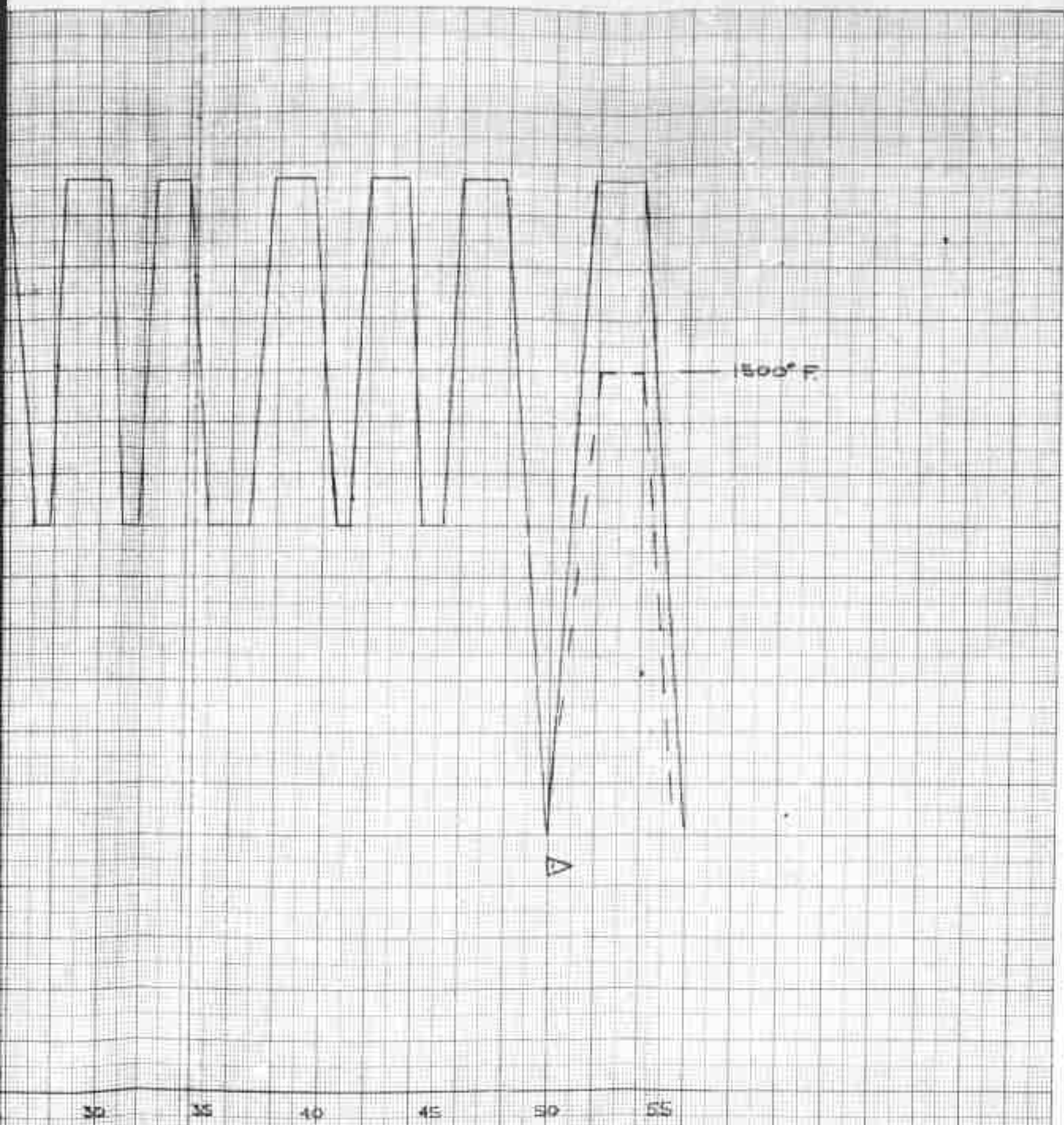
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CHARGE
APPROX
APPROX



RICAL HEATING, LAST CYCLE ONLY.
 T HERE, UNTIL DATA HAS BEEN ANALYZED

CHG	NEIGHBOR 4-7-6	ADDED	DATE	TEST PROGRAM LT 8-593-2-1 SK 11-95782 BOEING AIRPLANE COMPANY	Vol 1
CHK	JENSEN 4-11-61				01-80084
REV					PAID
APP					FIG 109

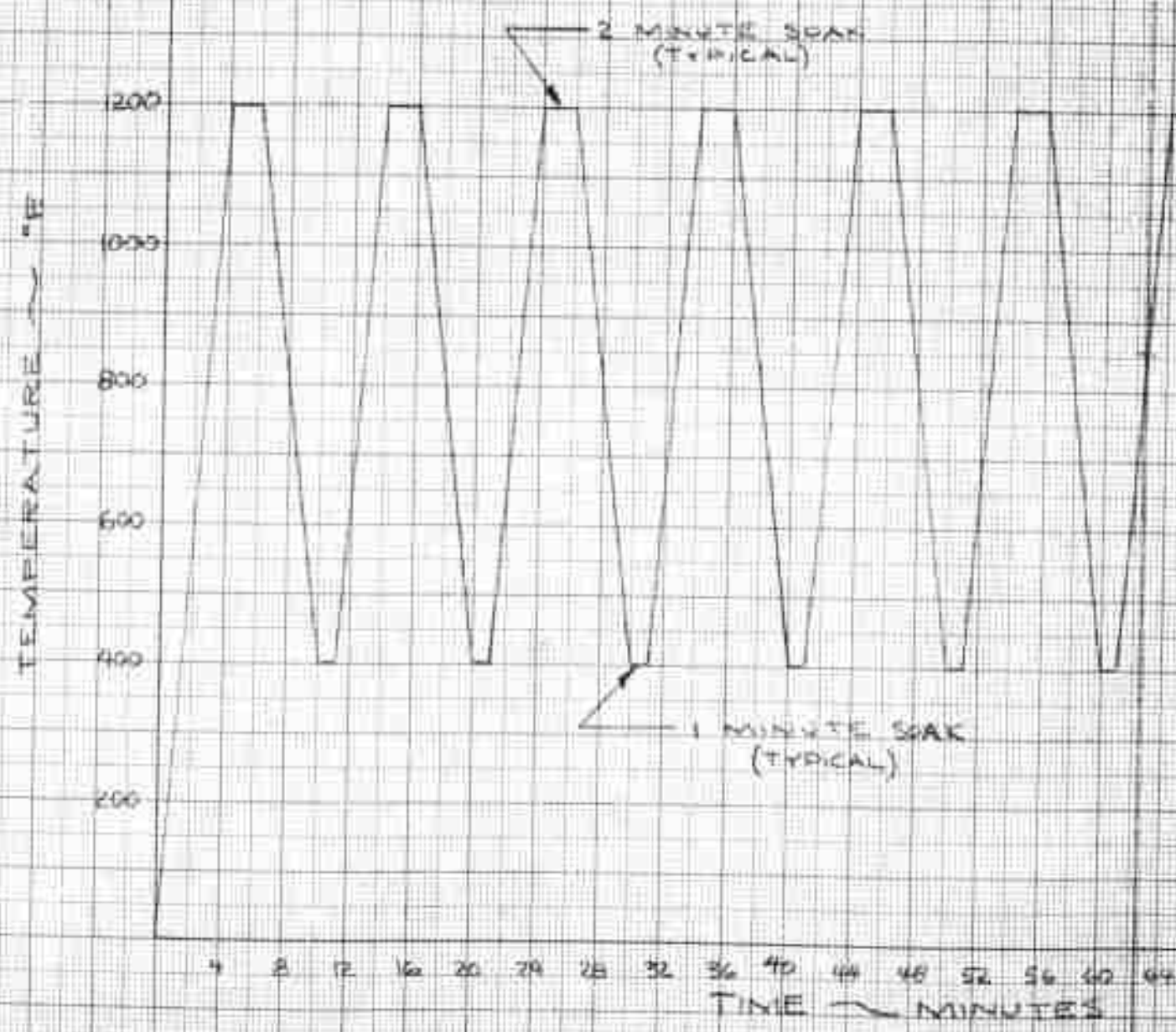




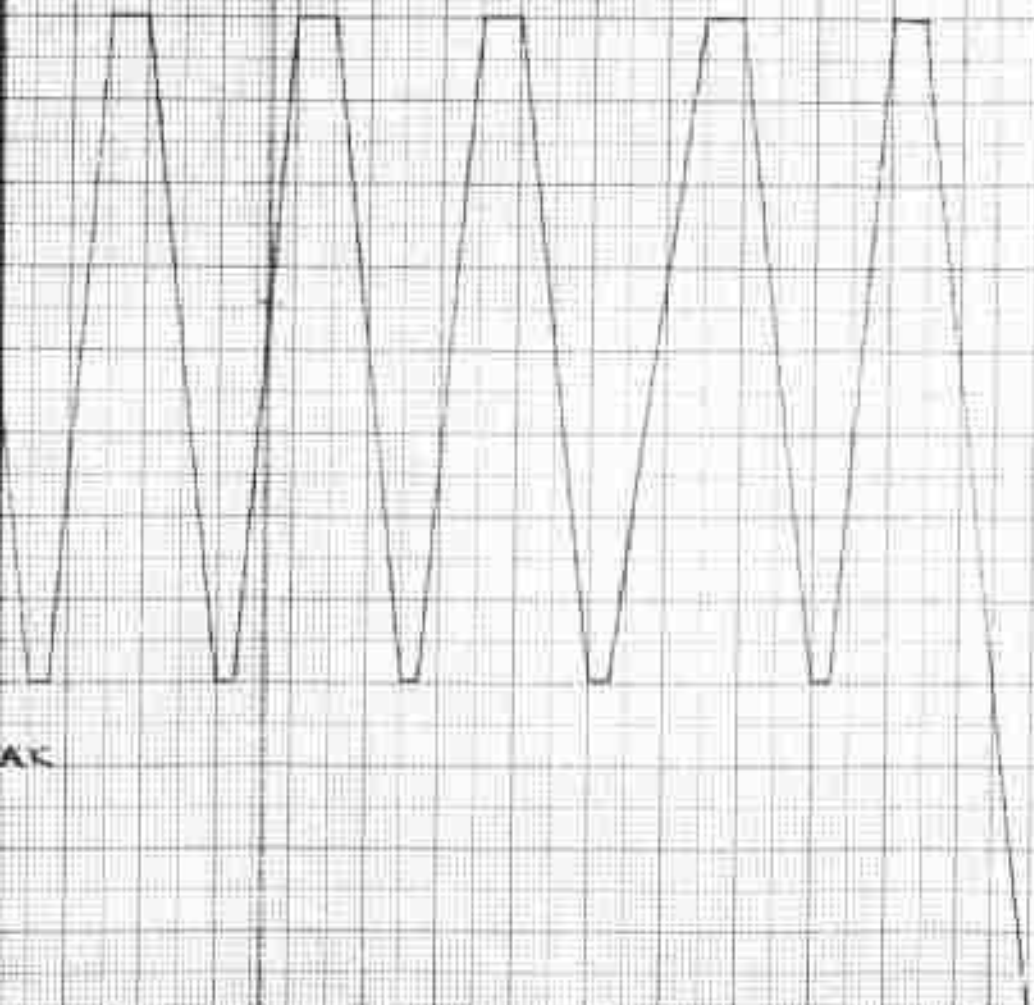
DATE	ED N	TIME	HT	PANEL ATTACHMENT TYPE 1 PRELIMINARY LT 5-593-2-2	VOL 1
CHRY					DT-30084
APPRO					PAGE
APPRO					5/11/30

2

NOTE:



NOTE: THIS HEAT PROGRAM IS FOR LOWER PANEL
 HEAT RATE IS 3°F/SECOND
 UPPER PANEL TEMPERATURE IS 1750°F (MAXIMUM)
 COOLING RATE IS NATURAL COOLING NO HEAT APPLIED

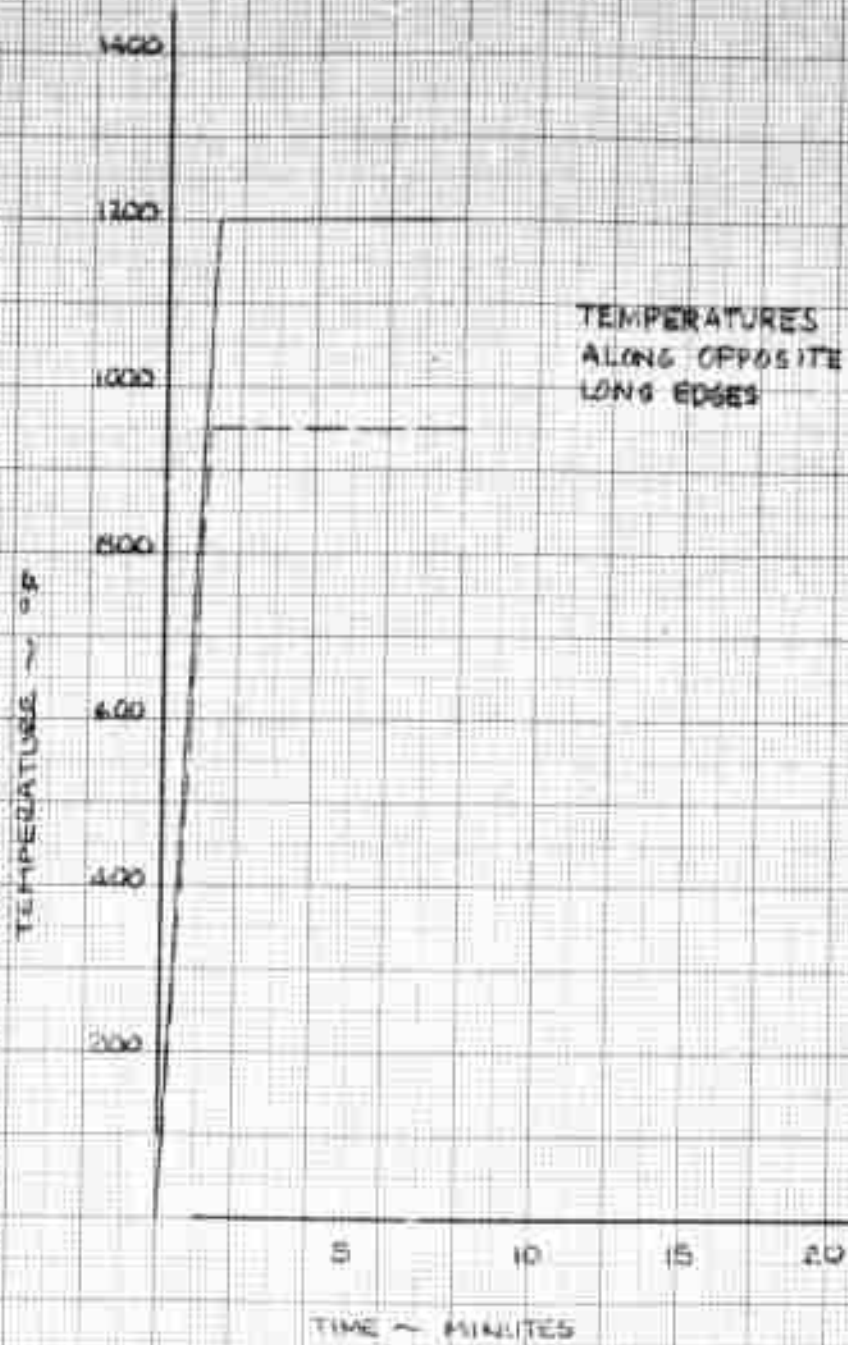


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MINUTES

DATE	ED N	3/27/64	REVISION	N/A	PANEL ATTACHMENT	Ver 1
CHECK					LT 5-593-2-3, -4, -5, -6	D2-82084
APPROVED						PAGE
						File 91

2



CALC	<i>Smith</i>	7-63	REVISION	DATE	HEATING PROGRAM LT-5593-2-60	Vol 1
CHECK						DE-80084
APP						
APP						
					THE BOEING COMPANY	PAGE FIG 92

<p>A</p> <p>CP</p> <p>1410/60</p>	<p>PANEL 1417</p> <p>TEST LOG</p> <p>EWA 5-593-1</p>	<p>P.W.</p> <p>13 db</p> <p>DZ-800</p> <p>Vol. I</p>
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DATE	TIME	TESTER	TEST NO.	TEST RESULT	REMARKS
10/10/78	14:00	J. D. Smith	100-1	Pass	
10/11/78	14:00	J. D. Smith	100-2	Fail	Excessive wear on left side
10/12/78	14:00	J. D. Smith	100-3	Pass	
10/13/78	14:00	J. D. Smith	100-4	Fail	Excessive wear on right side
10/14/78	14:00	J. D. Smith	100-5	Pass	
10/15/78	14:00	J. D. Smith	100-6	Fail	Excessive wear on left side
10/16/78	14:00	J. D. Smith	100-7	Pass	
10/17/78	14:00	J. D. Smith	100-8	Fail	Excessive wear on right side
10/18/78	14:00	J. D. Smith	100-9	Pass	
10/19/78	14:00	J. D. Smith	100-10	Fail	Excessive wear on left side
10/20/78	14:00	J. D. Smith	100-11	Pass	
10/21/78	14:00	J. D. Smith	100-12	Fail	Excessive wear on right side
10/22/78	14:00	J. D. Smith	100-13	Pass	
10/23/78	14:00	J. D. Smith	100-14	Fail	Excessive wear on left side
10/24/78	14:00	J. D. Smith	100-15	Pass	
10/25/78	14:00	J. D. Smith	100-16	Fail	Excessive wear on right side
10/26/78	14:00	J. D. Smith	100-17	Pass	
10/27/78	14:00	J. D. Smith	100-18	Fail	Excessive wear on left side
10/28/78	14:00	J. D. Smith	100-19	Pass	
10/29/78	14:00	J. D. Smith	100-20	Fail	Excessive wear on right side
10/30/78	14:00	J. D. Smith	100-21	Pass	
10/31/78	14:00	J. D. Smith	100-22	Fail	Excessive wear on left side
11/01/78	14:00	J. D. Smith	100-23	Pass	
11/02/78	14:00	J. D. Smith	100-24	Fail	Excessive wear on right side
11/03/78	14:00	J. D. Smith	100-25	Pass	
11/04/78	14:00	J. D. Smith	100-26	Fail	Excessive wear on left side
11/05/78	14:00	J. D. Smith	100-27	Pass	
11/06/78	14:00	J. D. Smith	100-28	Fail	Excessive wear on right side
11/07/78	14:00	J. D. Smith	100-29	Pass	
11/08/78	14:00	J. D. Smith	100-30	Fail	Excessive wear on left side
11/09/78	14:00	J. D. Smith	100-31	Pass	
11/10/78	14:00	J. D. Smith	100-32	Fail	Excessive wear on right side
11/11/78	14:00	J. D. Smith	100-33	Pass	
11/12/78	14:00	J. D. Smith	100-34	Fail	Excessive wear on left side
11/13/78	14:00	J. D. Smith	100-35	Pass	
11/14/78	14:00	J. D. Smith	100-36	Fail	Excessive wear on right side
11/15/78	14:00	J. D. Smith	100-37	Pass	
11/16/78	14:00	J. D. Smith	100-38	Fail	Excessive wear on left side
11/17/78	14:00	J. D. Smith	100-39	Pass	
11/18/78	14:00	J. D. Smith	100-40	Fail	Excessive wear on right side
11/19/78	14:00	J. D. Smith	100-41	Pass	
11/20/78	14:00	J. D. Smith	100-42	Fail	Excessive wear on left side
11/21/78	14:00	J. D. Smith	100-43	Pass	
11/22/78	14:00	J. D. Smith	100-44	Fail	Excessive wear on right side
11/23/78	14:00	J. D. Smith	100-45	Pass	
11/24/78	14:00	J. D. Smith	100-46	Fail	Excessive wear on left side
11/25/78	14:00	J. D. Smith	100-47	Pass	
11/26/78	14:00	J. D. Smith	100-48	Fail	Excessive wear on right side
11/27/78	14:00	J. D. Smith	100-49	Pass	
11/28/78	14:00	J. D. Smith	100-50	Fail	Excessive wear on left side
11/29/78	14:00	J. D. Smith	100-51	Pass	
11/30/78	14:00	J. D. Smith	100-52	Fail	Excessive wear on right side
12/01/78	14:00	J. D. Smith	100-53	Pass	
12/02/78	14:00	J. D. Smith	100-54	Fail	Excessive wear on left side
12/03/78	14:00	J. D. Smith	100-55	Pass	
12/04/78	14:00	J. D. Smith	100-56	Fail	Excessive wear on right side
12/05/78	14:00	J. D. Smith	100-57	Pass	
12/06/78	14:00	J. D. Smith	100-58	Fail	Excessive wear on left side
12/07/78</					

D2-80084

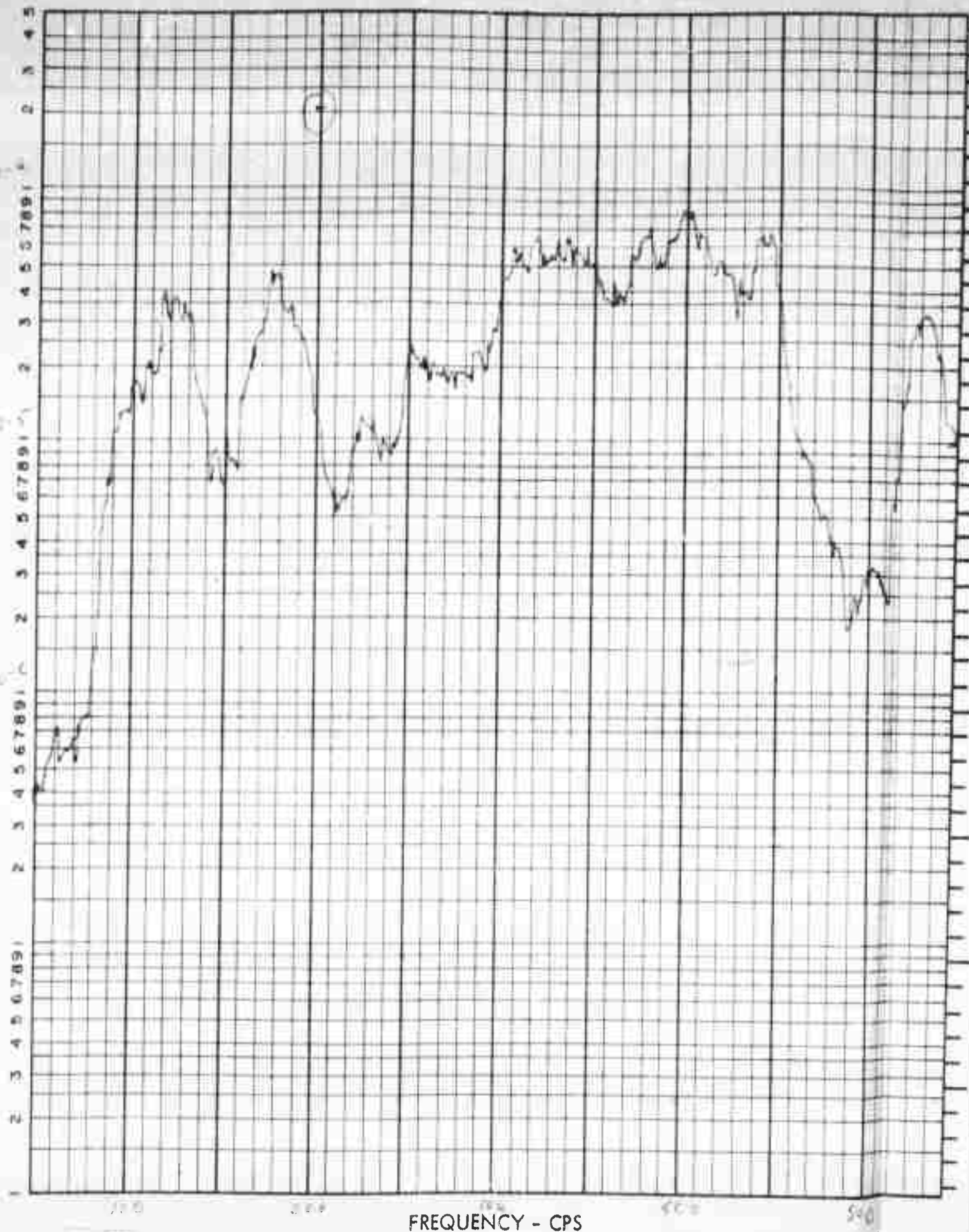
No. 1

10. $\frac{1}{2} \in \mathbb{N}$

DZ-80004
VOLI

5493

POWER SPECTRAL DENSITY - (psi)² / cps



FREQUENCY - CPS

1

ANALYSIS VARIABLES

Bandwidth

5 cycles from 50 to 500 cps
 — cycles from — to — cps
 — cycles from — to — cps

T_c 4 Sec.
 Anal. Rate 12.5 cps/Sec.
 Loop Length 4 Sec.

CALC
 CHECK
 APR.
 APR.

SPECTRUM LEVEL - DECIBELS (Re 0.0002 Microbar)

2

DATA IDENTIFICATION

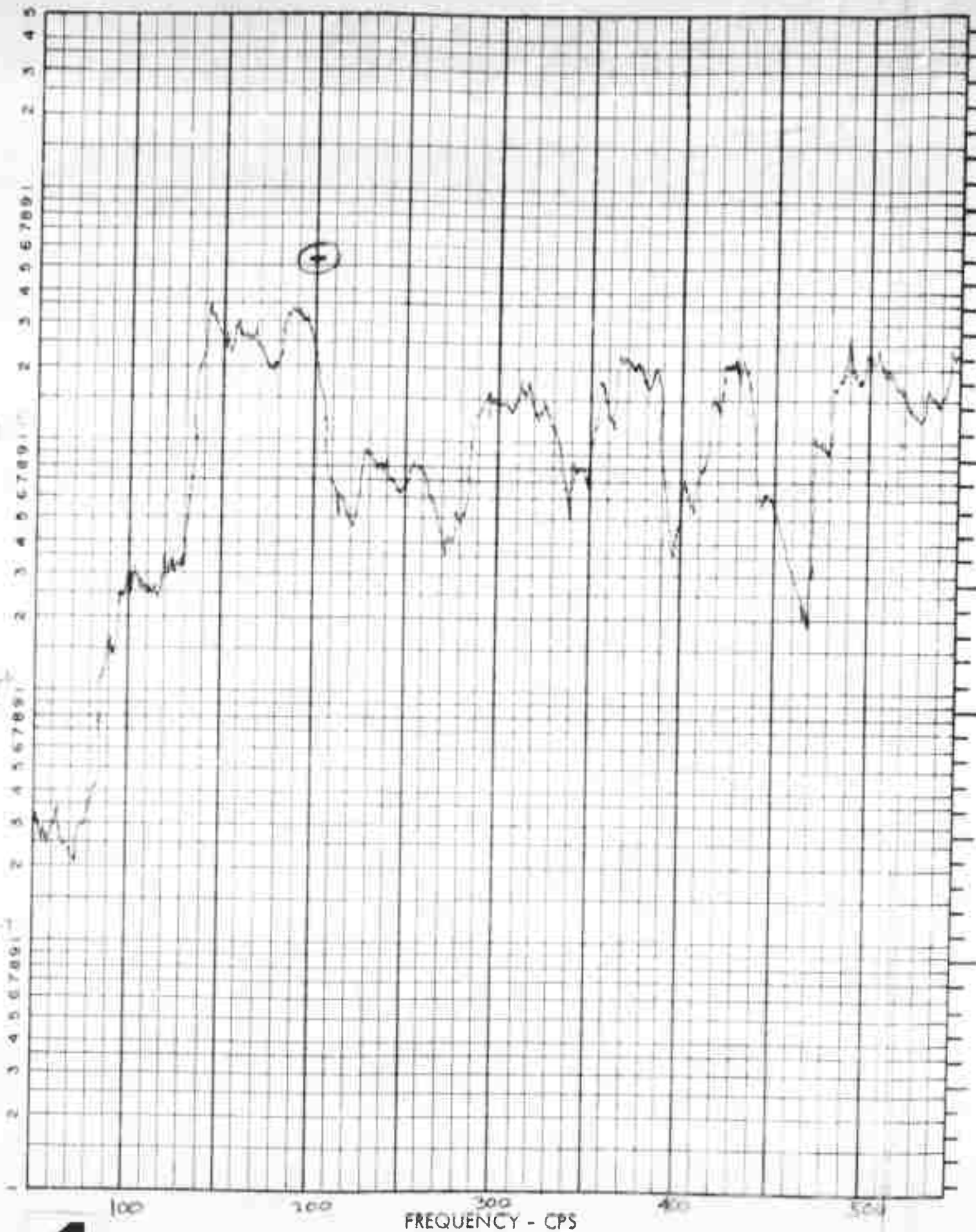
Test Title PANEL ATTACH TYPE 1 PRELIM		
EWA No. 55434	Panel or Specimen No. 407	
Tape No. 1	Tape Channel 2	Mic. No. 1
Elapsed Test Time		Mic. RMS Level at Sonic Lab. $V_L =$ Volts

CALIBRATION

Tape No.	Tape Channel	Data Tape RMS Volt $V_R = 0.005$
Calibration Voltage $V_a = V_{rms}$ into Line Amp.; $V_c =$ V_{rms} on Tape @ 2000 cps		
Line Amplifier Settings For Calibration $G_c = 1$; for Data $G_d = 1$		
Lab. Gain $LG =$	Tape Monitor Gain $TMG = \frac{G_d}{G_c} =$	
Microphone Sensitivity $S =$ psi/Volt or 1 Volt rms = 100 db SPL		
Equivalent of Calibration - psi $P_c = V_a \cdot S = 0.052 (0.21) = 0.011$		
Equivalent of Calibration for PSD Plots $\left(\frac{P_c}{(TMG)(LG)} \right)^2 = [0.011]^2 = 0.000121$ psi ² /cps		
Analyzer Attenuator Setting db	Log Converter Setting db	
Calibration Plotted at 2000 psi ² /cps		
Overall Pressure Level Data RMS pressure Level $(P_c)(V_R)$ $= \frac{(TMG)(LG)(V_c)}{}$		Equiv. to 102 db SPL
psi		

CALC	10-2-84	REVISED	DATE	POWER SPECTRAL DENSITY ANALYSIS OF MICROPHONE OUTPUT 1477 MIC NO 1 THE BOEING COMPANY	VOL I
CHECK	10-2-84				D2-80084
APR					PAGE
APR					FIG 96

POWER SPECTRAL DENSITY - (psi)² / cps



1

ANALYSIS VARIABLES

Bandwidth

5 cycles from 50 to 250 cps
 — cycles from — to — cps
 — cycles from — to — cps

1 4 Sec.
 Anal. Rate 1.25 cps/Sec.
 Loop Length 4 Sec.

CALC	
CHECK	
APR	
APR	

DATA IDENTIFICATION

Test Title FAUEL ATTACH TYPE I PRELIM		
EWA No. 5503-1		Panel or Specimen No. 1477
Tape No. 11	Tape Channel 3	Mic. No. 2
Elapsed Test Time		Mic. RMS Level at Sonic Lab. $V_L =$ Volts

CALIBRATION

Tape No. 11	Tape Channel 1	Data Tape RMS Volt $V_R = .350$
Calibration Voltage $V_a = V_{rms}$ into Line Amp.; $V_c = .5$ V_{rms} on Tape @ 200 cps		
Line Amplifier Settings For Calibration $G_c = .1$; for Data $G_d = .2$		
Lab. Gain $LG = 1$	Tape Monitor Gain $TMG = \frac{G_d}{G_c} = 2$	
Microphone Sensitivity $S = .140$ psi/Volt or 1 Volt rms = 160 db SPL		
Equivalent of Calibration - psi $P_c = V_a \cdot S = .5 \cdot .140 = .070$		
Equivalent of Calibration for PSD Plots $\left(\frac{P_c}{(TMG)(LG)} \right)^2 = \left(\frac{.070}{2 \cdot 1} \right)^2 = 5.26 \times 10^{-3}$ psi ² /cps		
Analyzer Attenuator Setting - 20 db	Log Converter Setting db	
Calibration Plotted at 5.26×10^{-3} psi ² /cps		
Overall Pressure Level Data RMS pressure Level	$(P_c)(V_R)$ $(TMG)(LG)(V_c)$	Equiv. to db SPL
=		=
		psi

SPECTRUM LEVEL - DECIBELS (Re 0.0002 Microbar)

2

CALC		REVISED	DATE	POWER SPECTRAL DENSITY ANALYSIS OF MICROPHONE OUTPUT 1477 MIC No 2 THE BOEING COMPANY	VOL I
CHECK	RD				DZ 8008A
APR					PAGE
APR					FIG 97



1

ANALYSIS VARIABLES

Bandwidth
 5 cycles from 50 to 550 cps
 — cycles from — to — cps
 — cycles from — to — cps

T_c 4 Sec.
 Anal. Rate 1.25 cps/sec.
 Loop Length 9 Sec.

CAN
 CHG
 APR
 APR

DATA IDENTIFICATION

Test Title PANEL ATTACH TYPE I PRGLIM		
EWA No. 5503-1	Panel or Specimen No. 1477	
Tape No. 11	Tape Channel 4	Displacement Pickup # 1
Elapsed Test Time		P/U RMS Level at Sonic Lab. $V_L =$ Volts

CALIBRATION

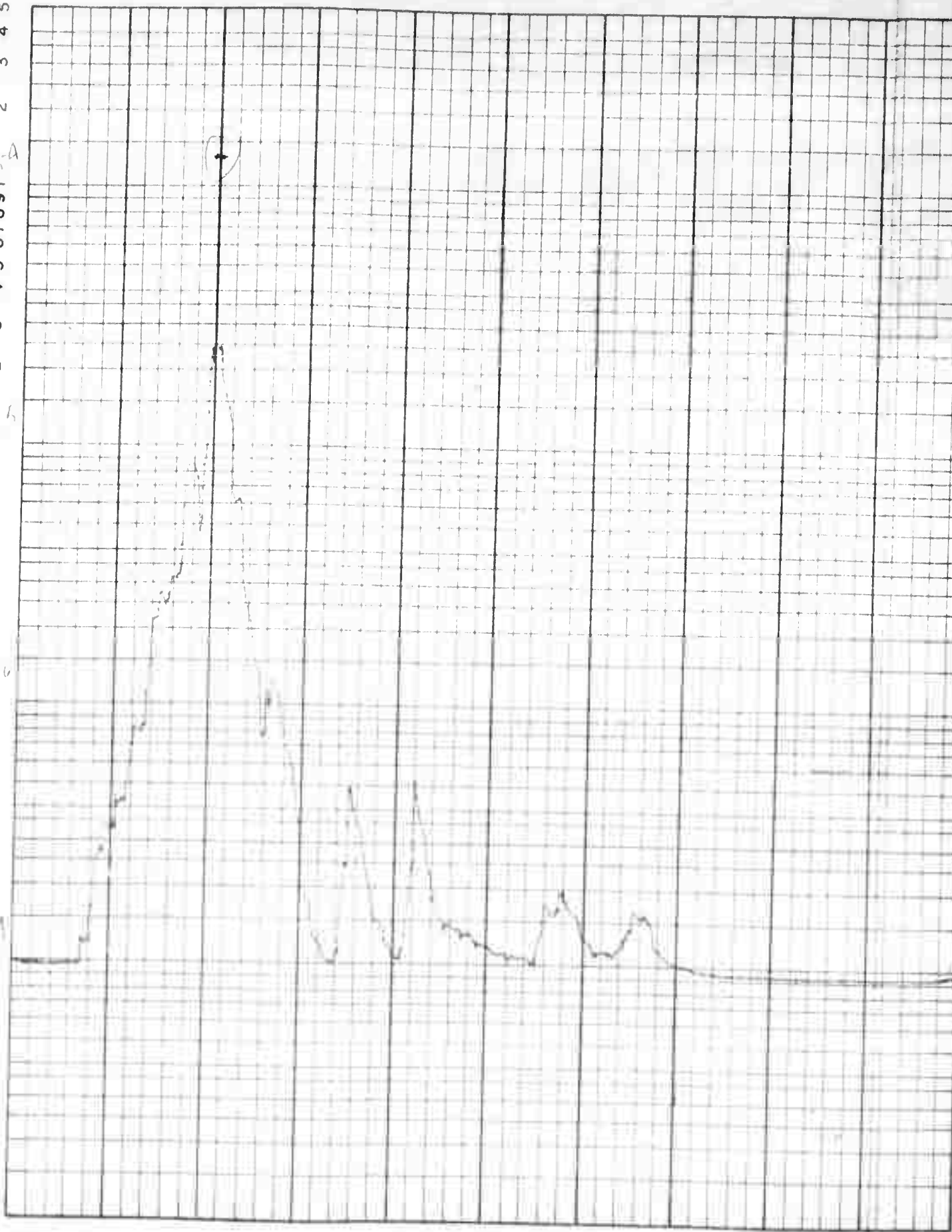
Tape No. 11	Tape Channel 1	Data Tape RMS Volt $V_R =$ 3.75
Calibration Voltage $V_a =$ V_{rms} Into Line Ampl.; $V_c = .5$ V_{rms} on Tape 200 cps		
Line Amplifier Settings For Calibration $G_c = .1$; for Data $G_d = .2$		
Lab. Gain LG = 1	Tape Monitor Gain $TMG = \frac{G_d}{G_c} = 2$	
Displacement Pickup Sensitivity $S = .0708$ in./Volt		
Equivalent of Calibration - in. $D_c = V_a \cdot S = (0.5) (.0708) = 0.0354$		
Equivalent of Calibration for PSD Plots $\left(\frac{D_c}{(TMG)(LG)} \right)^2 = \left[\frac{0.0354}{(2)(1)} \right]^2 = 3.13 \times 10^{-9}$ in. ² /cps		
Analyzer Attenuator Setting -20 db	Log Converter Setting db	
Calibration Plotted at 3.13×10^{-6} in. ² /cps		
Overall Deflection Level of Data $RMS\ Defl.\ Level = \frac{(D_c)(V_R)}{(TMG)(LG)(V_c)} =$ $=$ $=$ psf		

2

CALC		REVISED	DATE	POWER SPECTRAL DENSITY ANALYSIS OF DISPLACEMENT PICKUP 1477 P/U no 1 THE BOEING COMPANY SEATTLE 24, WASHINGTON	Vol. I
CHECK	ADS				D2-90084
APR					PAGE
APR					F1038

POWER SPECTRAL DENSITY - $(\text{In.})^2/\text{cps}$

1 2 3 4 5 6 7 8 9 10 1 2 3 4 5 6 7 8 9 10 1 2 3 4 5



FREQUENCY - CPS

ANALYSIS VARIABLES

Bandwidth
5 cycles from 50 to 550 cps
 — cycles from — to — cps
 — cycles from — to — cps

T_c 4 Sec.
 Anal. Rate 1.25 cps/sec.
 Loop Length 4 Sec.

1

DATA IDENTIFICATION

Test Title PANEL ATTACH TYPE I PRELIM		
EWA No. 5593-1	Panel or Specimen No. 1477	
Tape No. 11	Tape Channel 5	Displacement Pickup # 5
Elapsed Test Time		P/U RMS Level at Sonic Lab. $V_L =$ Volts

CALIBRATION

Tape No. 11	Tape Channel 1	Data Tape RMS Volt $V_R = 0.215$
Calibration Voltage $V_a = .5$ V_{rms} Into Line Amp.; $V_c = .5$ V_{rms} on Tape 200cps		
Line Amplifier Settings For Calibration $G_c = .1$; for Data $G_d = .1$		
Lab. Gain LG = 1	Tape Monitor Gain $TMG = \frac{G_d}{G_c} = 1$	
Displacement Pickup Sensitivity $S = .0708$ in./Volt		
Equivalent of Calibration - In. $D_c = V_a \cdot S = (.5)(.0708) = .0354$		
Equivalent of Calibration for PSD Plots $\left(\frac{D_c}{(TMG)(LG)} \right)^2 = \left[\frac{.0354}{(1)(1)} \right]^2 = 1.25 \times 10^{-3}$ in. ² /cps		
Analyzer Attenuator Setting - / 0 db	Log Converter Setting db	
Calibration Plotted at		in. ² /cps
Overall Deflection Level of Data $RMS\ Defl.\ Level = \frac{(D_c)(V_R)}{(TMG)(LG)(V_c)} =$ $=$ psi		

2

CALC	REVISED	DATE	POWER SPECTRAL DENSITY ANALYSIS OF DISPLACEMENT PICKUP 477 P/U NO. 5 THE BOEING COMPANY SEATTLE 24, WASHINGTON	Val I
CHECK				D2-80084
APR.				PAGE
APR.				FIG 99

POWER SPECTRAL DENSITY - (in.)²/cps



1

FREQUENCY - CPS

ANALYSIS VARIABLES

Bandwidth
5 cycles from 50 to 550 cps
 — cycles from — to — cps
 — cycles from — to — cps

T_c 4 Sec.
 Anal. Rate 1.25 cps/sec.
 Loop Length 4 Sec.

DATA IDENTIFICATION

Test Title PANEL ATTACH TYPE I PRELIM		
EWA No. 5593-1	Panel or Specimen No. 1477	
Tape No. 11	Tape Channel 6	Displacement Pickup 6
Elapsed Test Time		P/U RMS Level at Sonic Lab. $V_L =$ Volts

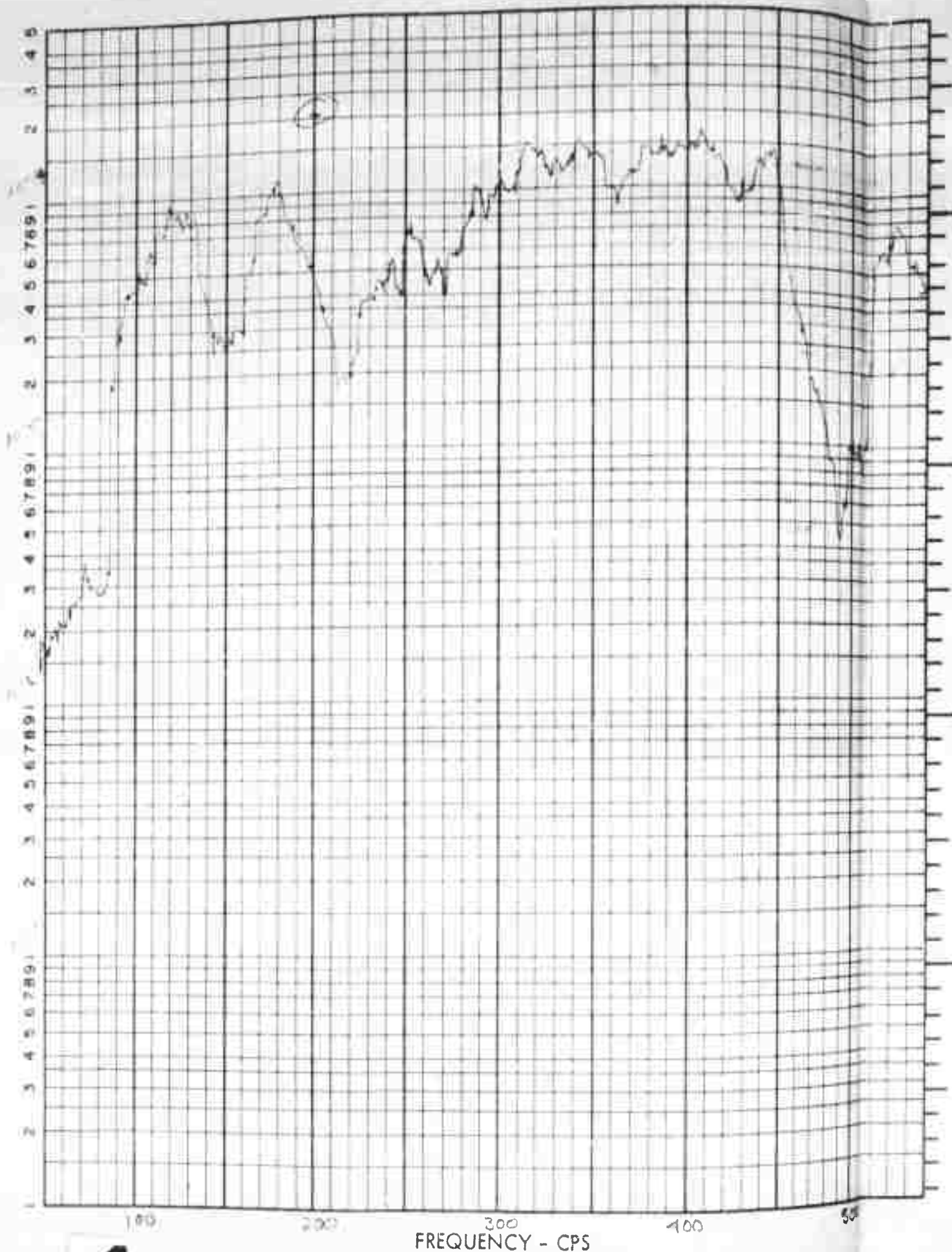
CALIBRATION

Tape No. 11	Tape Channel 1	Data Tape RMS Volt $V_R = .245$
Calibration Voltage $V_a = .5$ V_{rms} Into Line Amp.; $V_c = .5$ V_{rms} on Tape 200cps		
Line Amplifier Settings For Calibration $G_c = .1$; for Data $G_d = .1$		
Lab. Gain $LG = 1$	Tape Monitor Gain $TMG = \frac{G_d}{G_c} = 1$	
Displacement Pickup Sensitivity $S = .0708$ in./Volt		
Equivalent of Calibration - in. $D_c = V_a \cdot S = (.5)(.0708) = .0354$		
Equivalent of Calibration for PSD Plots $\left(\frac{D_c}{(TMG)(LG)} \right)^2 = \left[\frac{.0354}{(1)(1)} \right]^2 = 1.25 \times 10^{-3}$ in. ² /cps		
Analyzer Attenuator Setting -10 db	Log Converter Setting db	
Calibration Plotted at in. ² /cps		
Overall Deflection Level of Data RMS Defl. Level = $\frac{(D_c)(V_R)}{(TMG)(LG)(V_c)}$ = _____ = psi		

2

CALC		REVISED	DATE	POWER SPECTRAL DENSITY ANALYSIS OF DISPLACEMENT PICKUP	VOL I
CHECK	RDS			1477 P/U 6	02-80084
APR				THE BOEING COMPANY	PAGE
APR				SEATTLE 24, WASHINGTON	FIG 100

POWER SPECTRAL DENSITY - (psi)² / cps



1

FREQUENCY - CPS

ANALYSIS VARIABLES

Bandwidth

5 cycles from 50 to 550 cps
 — cycles from — to — cps
 — cycles from — to — cps

T_c 4 Sec.
 Anal. Rate 1.25 cps/Sec.
 Loop Length 9 Sec.

CALC	
CHECK	
APR.	
APR	

DATA IDENTIFICATION

Test Title PANEL ATTACH TYPE I PRELIM.		
EWA No. 5503-1		Panel or Specimen No. 1478
Tape No. 12	Tape Channel 2	Mic. No. 1
Elapsed Test Time		Mic. RMS Level at Sonic Lab. V _L = Volts

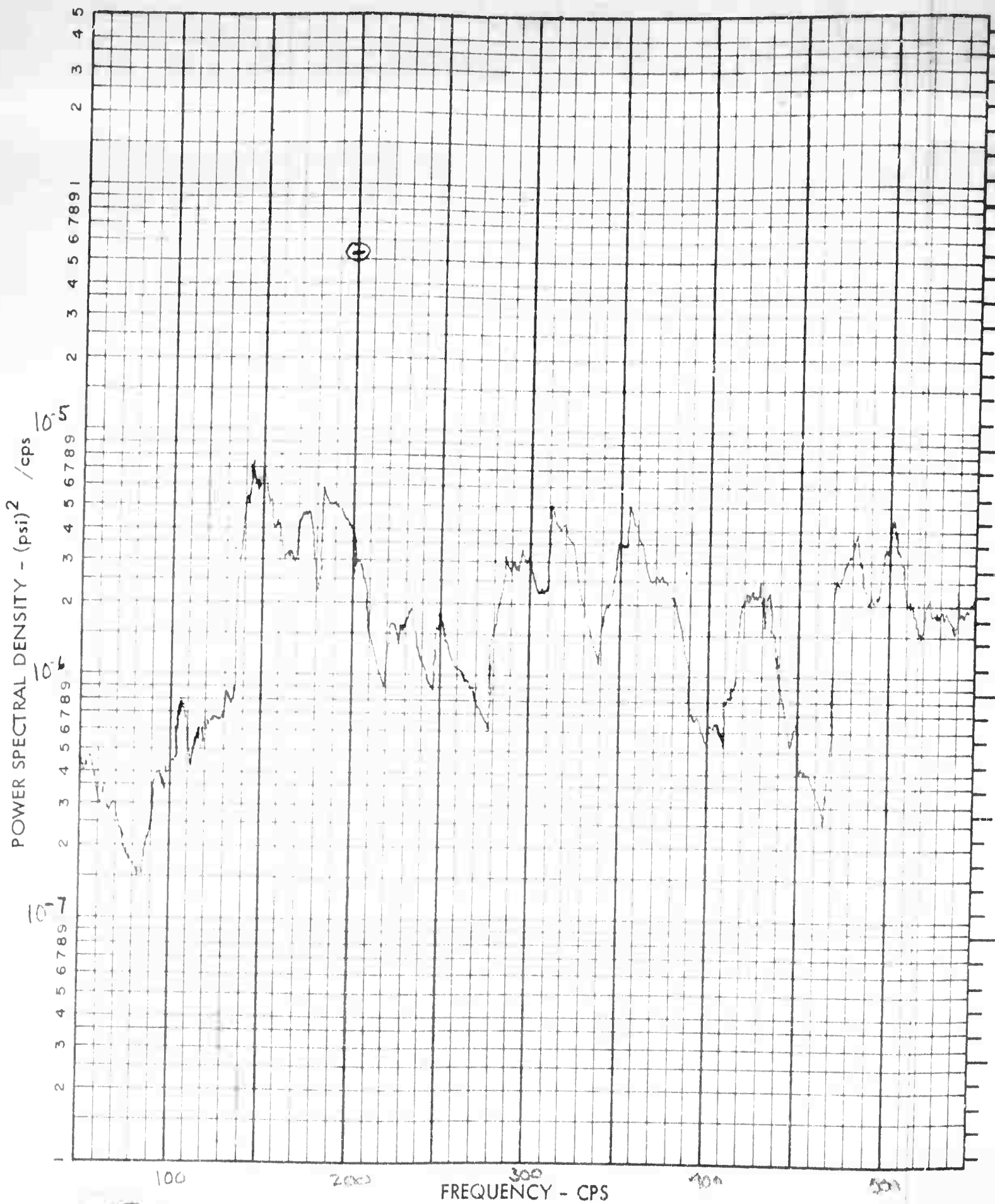
CALIBRATION

Tape No. 12	Tape Channel 2	Data Tape RMS Volt V _R = .
Calibration Voltage V _a = V _{rms} into Line Amp.; V _c = .5 V _{rms} on Tape @ 100 cps		
Line Amplifier Settings For Calibration G _c = .1 ; for Data G _d = .1		
Lab. Gain LG = 1	Tape Monitor Gain TMG = $\frac{G_d}{G_c}$ = 1	
Microphone Sensitivity S = .290 psi/Volt or 1 Volt rms = 160 db SPL		
Equivalent of Calibration - psi P _c = V _a · S = (.5) (.290) 0.145		
Equivalent of Calibration for PSD Plots $\left(\frac{P_c}{(TMG)(LG)} \right)^2 = \left[\frac{.145}{1 \times 1} \right]^2 = 2.10 \times 10^{-2}$ psi ² /cps		
Analyzer Attenuator Setting - 20 db	Log Converter Setting db	
Calibration Plotted at psi ² /cps		
Overall Pressure Level Data RMS pressure Level	(P _c) (V _R) (TMG)(LG)(V _c)	Equiv. to db SPL
= _____ =		psi

SPECTRUM LEVEL - DECIBELS (Re 0.0002 Microbar)

2

CALC		REVISED	DATE	POWER SPECTRAL DENSITY ANALYSIS OF MICROPHONE OUTPUT 1478 Mic 1 THE BOEING COMPANY	TEST
CHECK					DE 0104
APR.					PAGE
APR.					Fig 101



FREQUENCY - CPS

ANALYSIS VARIABLES

Bandwidth

5 cycles from 50 to 550 cps
 — cycles from — to — cps
 — cycles from — to — cps

T_c 4 Sec.
 Anal. Rate 1.25 cps/Sec.
 Loop Length 4 Sec.

CALC
 CHECK
 APR.
 APR.

DATA IDENTIFICATION

Test Title PAVEL ATTACH TYPE I PRELIM		
EWA No. 5503-1	Panel or Specimen No. 1478	
Tape No. 12	Tape Channel 3	Mic. No. 2
Elapsed Test Time		Mic. RMS Level at Sonic Lab. V _L = Volts

CALIBRATION

Tape No. 12	Tape Channel 1	Data Tape RMS Volt V _R =
Calibration Voltage V _a = .5 V _{rms} into Line Amp.; V _c = .5 V _{rms} on Tape @ 70 cps		
Line Amplifier Settings For Calibration G _c = .1 ; for Data G _d = .2		
Lab. Gain LG = 1	Tape Monitor Gain TMG = $\frac{G_d}{G_c}$ = 2	
Microphone Sensitivity S = 290 psi/Volt or 1 Volt rms = 160 db SPL		
Equivalent of Calibration - psi P _c = V _a · S = (.5)(290) = 145		
Equivalent of Calibration for PSD Plots $\left(\frac{P_c}{(TMG)(LG)}\right)^2 = \left[\frac{145}{(2)(1)}\right]^2 = 5.26 \times 10^{-3}$ psi ² /cps		
Analyzer Attenuator Setting -20 db	Log Converter Setting db	
Calibration Plotted at 5.26 × 10 ⁻⁵		psi ² /cps
Overall Pressure Level Data RMS pressure Level (P _c)(V _R) = $\frac{(TMG)(LG)(V_c)}{(P_c)(V_R)}$ =	Equiv. to db SPL	
psi		

SPECTRUM LEVEL - DECIBELS (Re 0.0002 Microbar)

2

CALC		REVISED	DATE	POWER SPECTRAL DENSITY ANALYSIS OF MICROPHONE OUTPUT 1478 MIC 2 THE BOEING COMPANY	VOL 1
CHECK	RLE	ULS			DE 8084
APR					PAGE
APR					FIG 102

POWER SPECTRAL DENSITY - (in.)²/cps



FREQUENCY - CPS

ANALYSIS VARIABLES

Bandwidth

5 cycles from 50 to 550 cps
 — cycles from — to — cps
 — cycles from — to — cps

T_c 4 Sec.
 Anal. Rate 1.25 cps/sec.
 Loop Length 4 Sec.

DATA IDENTIFICATION

Test Title PANEL ATTACH TYPE I PRELIM		
EWA No. 5593 -1	Panel or Specimen No. 1478	
Tape No. 12	Tape Channel 4	Displacement Pickup 1
Elapsed Test Time		P/U RMS Level at Sonic Lab. $V_L =$ Volts

CALIBRATION

Tape No. 12	Tape Channel 1	Data Tape RMS Volt $V_R = 0.175$
Calibration Voltage $V_a = .5$ V_{rms} Into Line Amp.; $V_c = .5$ V_{rms} on Tape 20 cps		
Line Amplifier Settings For Calibration $G_c = .1$; for Data $G_d = .1$		
Lab. Gain LG = 1	Tape Monitor Gain $TMG = \frac{G_d}{G_c} = 1$	
Displacement Pickup Sensitivity $S = .0708$ in./Volt		
Equivalent of Calibration - in. $D_c = V_a \cdot S = (.5)(.0708) = .0354$		
Equivalent of Calibration for PSD Plots $\left(\frac{D_c}{(TMG)(LG)} \right)^2 = \left[\frac{.0354}{(1)(1)} \right]^2 = 1.25 \times 10^{-3}$ in. ² /cps		
Analyzer Attenuator Setting - 20 db	Log Converter Setting db	
Calibration Plotted at in. ² /cps		
Overall Deflection Level of Data RMS Defl. Level = $\frac{(D_c)(V_R)}{(TMG)(LG)(V_c)} =$ = _____ = psi		

2

CALC		REVISED	DATE	POWER SPECTRAL DENSITY ANALYSIS OF DISPLACEMENT PICKUP 1478 P/U 1 THE BOEING COMPANY SEATTLE 24, WASHINGTON	Vol 1
CHECK	RDC	1023			D2-80084
APR					PAGE
APR					FIG 103

POWER SPECTRAL DENSITY - $(\ln.)^2/\text{cps}$



1

FREQUENCY - CPS

ANALYSIS VARIABLES

Bandwidth

5 cycles from 50 to 550 cps

— cycles from — to — cps

— cycles from — to — cps

T_c 1 Sec.

Anal. Rate 1.25 cps/sec.

Loop Length 4 Sec.

DATA IDENTIFICATION

Test Title PANEL ATTACH TYPE I PRELIM.		
EWA No. 5503-1	Panel or Specimen No. 1478	
Tape No. 12	Tape Channel 5	Displacement Pickup # 5
Elapsed Test Time		P/U RMS Level at Sonic Lab. V _L = Volts

CALIBRATION

Tape No. 12	Tape Channel 1	Data Tape RMS Volt V _R = . . .
Calibration Voltage V _a = .5 V _{rms} Into Line Amp.; V _c = .5 V _{rms} on Tape 200cps		
Line Amplifier Settings For Calibration G _c = .1 ; for Data G _d = .1		
Lab. Gain LG = 1	Tape Monitor Gain TMG = $\frac{G_d}{G_c}$ = 1	
Displacement Pickup Sensitivity S = .0708 in./Volt		
Equivalent of Calibration - in. D _c = V _a · S = (.5) .0708 = .0354		
Equivalent of Calibration for PSD Plots $\left(\frac{D_c}{(TMG)(LG)} \right)^2 = \left[\frac{.0354}{1 \times 1} \right]^2 = 1.25 \times 10^{-3}$ in. ² /cps		
Analyzer Attenuator Setting - / C db	Log Converter Setting db	
Calibration Plotted at		in. ² /cps
Overall Deflection Level of Data RMS Defl. Level = $\frac{(D_c)(V_R)}{(TMG)(LG)(V_c)}$ = = _____ = psi		

2

CALC		REVISED	DATE	POWER SPECTRAL DENSITY ANALYSIS OF DISPLACEMENT PICKUP 1478 P/U 5 THE BOEING COMPANY SEATTLE 24, WASHINGTON	VOL I
CHECK	RDS	10-2-3			D2-80084
APR.					PAGE
APR					Fig 104

POWER SPECTRAL DENSITY - (in.)²/cps



FREQUENCY - CPS

ANALYSIS VARIABLES

Bandwidth

5 cycles from 50 to 550 cps
 — cycles from — to — cps
 — cycles from — to — cps

4 Sec.

Anal. Rate 1.25 cps/sec.

Loop Length 4 Sec.

DATA IDENTIFICATION

Test Title PANEL ATTACH TYPE I PRELIM		
EWA No. 55	Panel or Specimen No. 1478	
Tape No. 12	Tape Channel 6	Displacement Pickup 6
Elapsed Test Time		P/U RMS Level at Sonic Lab. $V_L =$ Volts

CALIBRATION

Tape No. 12	Tape Channel 1	Data Tape RMS Volt $V_R = 0.230$
Calibration Voltage $V_a = .5$ V_{rms} Into Line Amp.; $V_c =$ V_{rms} on Tape 200cps		
Line Amplifier Settings For Calibration $G_c = .1$; for Data $G_d = .1$		
Lab. Gain $LG = 1$	Tape Monitor Gain $TMG = \frac{G_d}{G_c} = 1$	
Displacement Pickup Sensitivity $S = .0708$ in./Volt		
Equivalent of Calibration - in. $D_c = V_a \cdot S = (.5)(.0708) = .0354$		
Equivalent of Calibration for PSD Plots $\left(\frac{D_c}{(TMG)(LG)} \right)^2 = \left[\frac{.0354}{1 \times 1} \right]^2 = 1.25 \times 10^{-3}$ in. ² /cps		
Analyzer Attenuator Setting -10 db	Log Converter Setting db	
Calibration Plotted at in. ² /cps		
Overall Deflection Level of Data RMS Defl. Level = $\frac{(D_c)(V_R)}{(TMG)(LG)(V_c)} =$ = _____ = psi		

2

CALC		REVISED	DATE	POWER SPECTRAL DENSITY ANALYSIS OF DISPLACEMENT PICKUP 1478 P/U 6 THE BOEING COMPANY SEATTLE 24, WASHINGTON	Vol I
CHECK	PDS	10-2-5			02-80084
APR.					PAGE
APR.					FIG 105

POWER SPECTRAL DENSITY - (psi)² / cps



FREQUENCY - CPS

1

ANALYSIS VARIABLES

Bandwidth

5 cycles from 50 to 550 cps
 — cycles from — to — cps
 — cycles from — to — cps

T_c 4 Sec.

Anal. Rate 1.25 cps/Sec.
 Loop Length 4 Sec.

CALC	
CHECK	
APR.	
APR.	

DATA IDENTIFICATION

Test Title PANEL ATTACH. TYPE I PRELIM		
EWA No. 5593-1		Panel or Specimen No. 1479
Tape No. 13	Tape Channel 2	Mic. No. 1
Elapsed Test Time		Mic. RMS Level at Sonic Lab. V _L = Volts

CALIBRATION

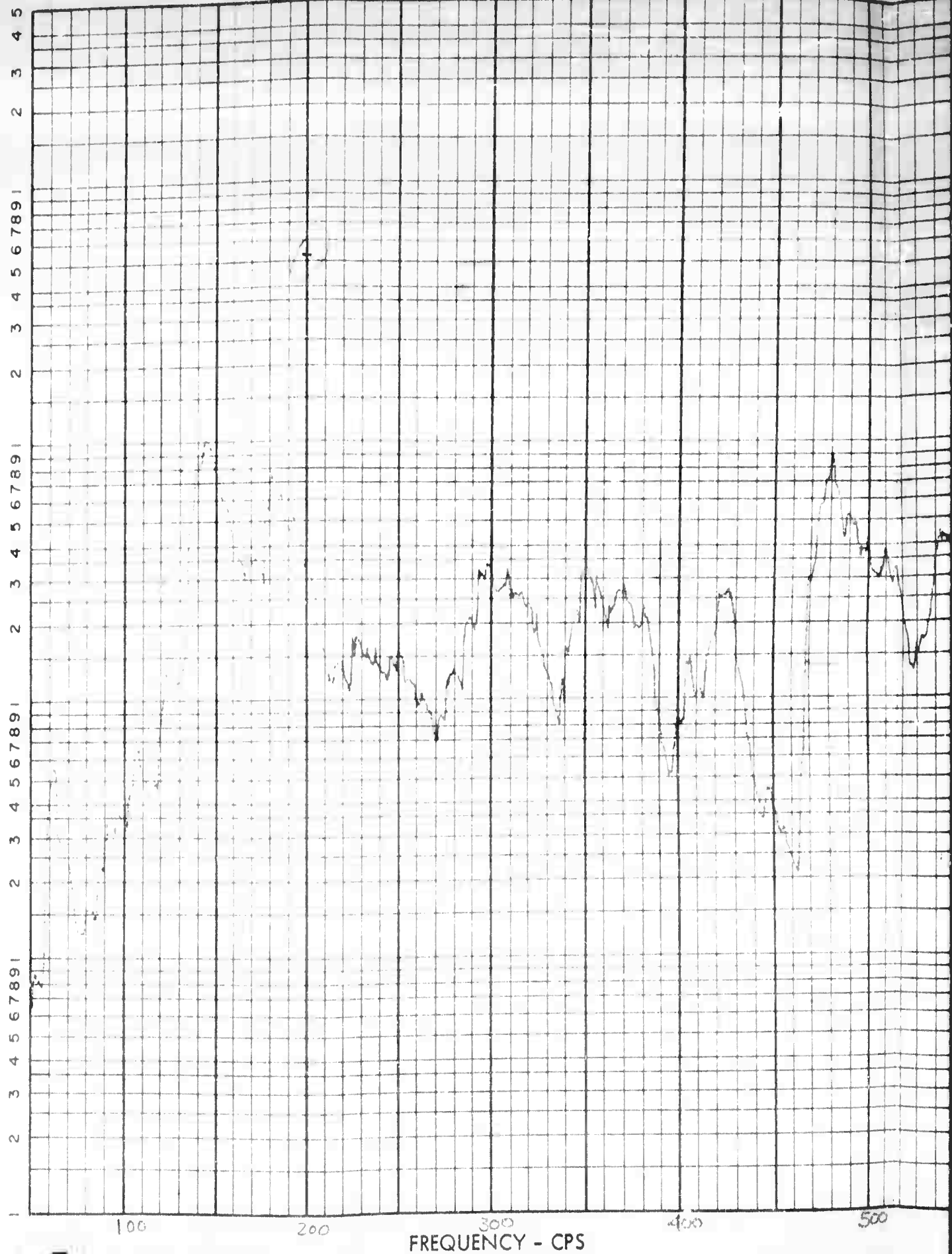
Tape No. 13	Tape Channel 1	Data Tape RMS Volt V _R = . . .
Calibration Voltage V _a = .5 V _{rms} into Line Amp.; V _c = .5 V _{rms} on Tape @ 200 cps		
Line Amplifier Settings For Calibration G _c = .1 ; for Data G _d = .1		
Lab. Gain LG = 1	Tape Monitor Gain TMG = $\frac{G_d}{G_c}$ = 1	
Microphone Sensitivity S = .290 psi/Volt or 1 Volt rms = 160 db SPL		
Equivalent of Calibration - psi P _c = V _a · S = (.5)(.290) .145		
Equivalent of Calibration for PSD Plots $\left(\frac{P_c}{(TMG)(LG)}\right)^2 = \left[\frac{.145}{1 \times 1}\right]^2 2.10 \times 10^{-2}$ psi ² /cps		
Analyzer Attenuator Setting -20 db	Log Converter Setting db	
Calibration Plotted at psi ² /cps		
Overall Pressure Level Data RMS pressure Level (P _c) (V _R) = $\frac{(TMG)(LG)(V_c)}{(P_c)(V_R)}$ =		Equiv. to db SPL
psi		

SPECTRUM LEVEL - DECIBELS (Re 0.0002 Microbar)

2

CALC	RFS	9/26/63	REVISED	DATE	POWER SPECTRAL DENSITY ANALYSIS OF MICROPHONE OUTPUT	Vol I
CHECK	KDS	10/23				
APR.					1479 Mic 1	DZ-80084
APR.					THE BOEING COMPANY	PAGE Fig 106

POWER SPECTRAL DENSITY - (psi)² / cps



FREQUENCY - CPS

ANALYSIS VARIABLES

Bandwidth

5 cycles from 50 to 500 cps
cycles from to cps
cycles from to cps

T_c 4 Sec.
Anal. Rate 1.25 cps/Sec.
Loop Length 4 Sec.



DATA IDENTIFICATION

Test Title PANEL ATTACH TYPE I PRELIM		
EWA No. 5593-1	Panel or Specimen No. 1479	
Tape No. 13	Tape Channel 3	Mic. No. 2
Elapsed Test Time		Mic. RMS Level at Sonic Lab. V _L = Volts

CALIBRATION

Tape No. 13	Tape Channel 1	Data Tape RMS Volt V _R =
Calibration Voltage V _a = .5 V _{rms} into Line Amp.; V _c = 5 V _{rms} on Tape @ 200 cps		
Line Amplifier Settings For Calibration G _c = .1 ; for Data G _d = .2		
Lab. Gain LG = 1	Tape Monitor Gain TMG = $\frac{G_d}{G_c} = 2$	
Microphone Sensitivity S = .290 psi/Volt or 1 Volt rms = 160 db SPL		
Equivalent of Calibration - psi P _c = V _a · S = (.5)(.290) = .145		
Equivalent of Calibration for PSD Plots $\left(\frac{P_c}{(TMG)(LG)} \right)^2 = \left[\frac{.145}{2 \times 1} \right]^2 = 5.26 \times 10^{-3}$ psi ² /cps		
Analyzer Attenuator Setting -20 db	Log Converter Setting db	
Calibration Plotted at psi ² /cps		
Overall Pressure Level Data RMS pressure Level (P _c) (V _R) $\frac{(P_c)(V_R)}{(TMG)(LG)(V_c)}$		Equiv. to db SPL
=		= psi

2

CALC	RFS	9/20/54	REVISED	DATE	POWER SPECTRAL DENSITY ANALYSIS OF MICROPHONE OUTPUT 1479 Mic 2 THE BOEING COMPANY	VOL I
CHECK	RFS	10/1/54				D2-80094
APR.						PAGE
APR.						FIG 107

POWER SPECTRAL DENSITY - $(\text{in.})^2 / \text{cps}$



1

FREQUENCY - CPS

ANALYSIS VARIABLES

Bandwidth
5 cycles from 50 to 550 cps
 — cycles from — to — cps
 — cycles from — to — cps

T_c 4 Sec.
 Anal. Rate 1.25 cps/sec.
 Loop Length 4 Sec.

DATA IDENTIFICATION

Test Title PAUEL ATTACH TYPE I PRELIM		
EWA No. 5508-1	Panel or Specimen No. 1479	
Tape No. 13	Tape Channel 4	Displacement Pickup 1
Elapsed Test Time		P/U RMS Level at Sonic Lab. $V_L =$ Volts

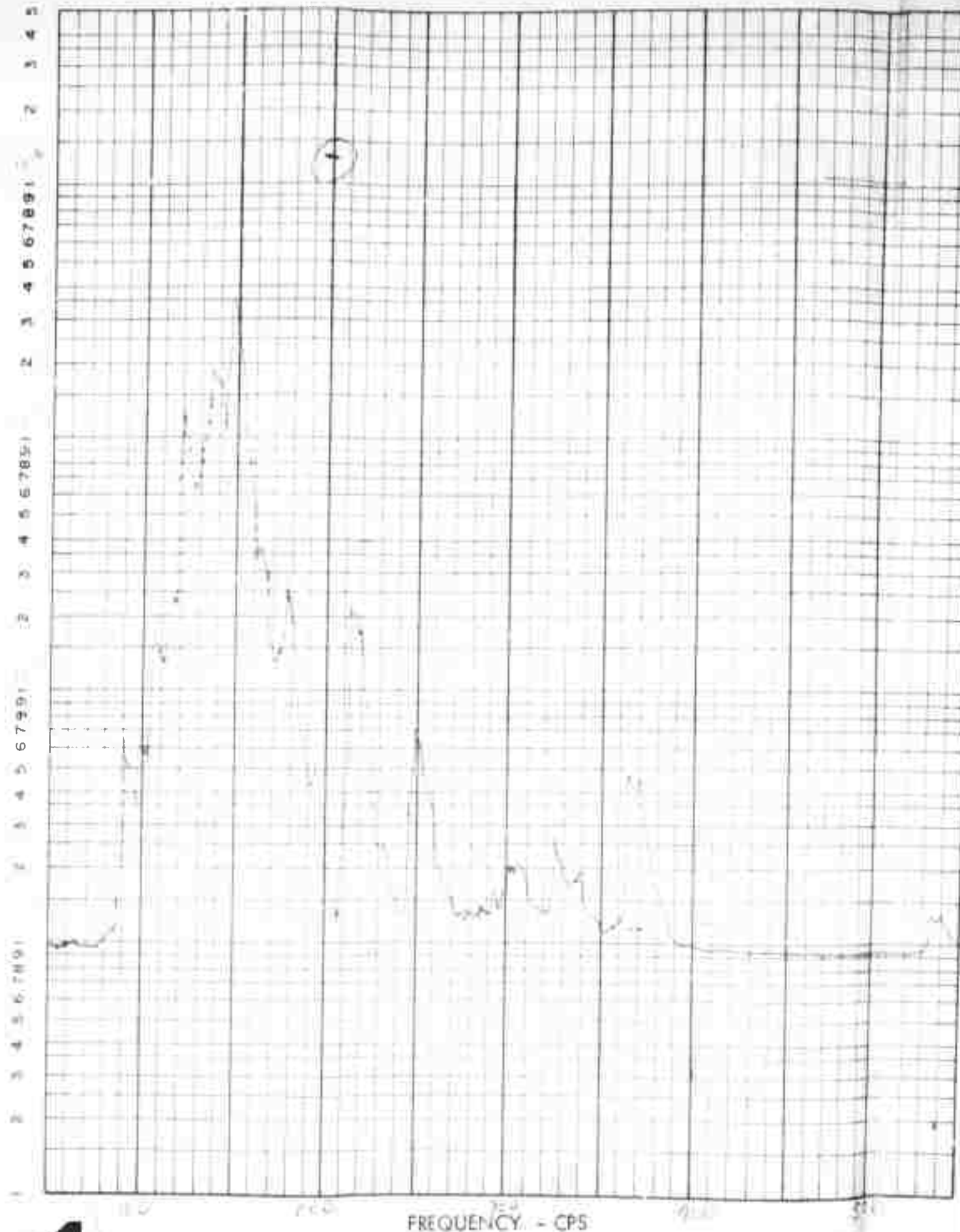
CALIBRATION

Tape No. 13	Tape Channel 1	Data Tape RMS Volt $V_R = 6.230$
Calibration Voltage $V_a = .5$ V_{rms} into Line Amp.; $V_c = .5$ V_{rms} on Tape 20 cps		
Line Amplifier Settings For Calibration $G_c = .1$; for Data $G_d = .1$		
Lab. Gain $LG = 1$	Tape Monitor Gain $TMG = \frac{G_d}{G_c} = 1$	
Displacement Pickup Sensitivity $S = .0706$ in./Volt		
Equivalent of Calibration - in. $D_c = V_a \cdot S = (.5)(.0706) = .0353$		
Equivalent of Calibration for PSD Plots $\left(\frac{D_c}{(TMG)(LG)} \right)^2 = \left[\frac{.0353}{(1)(1)} \right]^2 = 1.25 \times 10^{-4}$ in. ² /cps		
Analyzer Attenuator Setting - / 0 db	Log Converter Setting db	
Calibration Plotted at 1.25×10^{-4} in. ² /cps		
Overall Deflection Level of Data RMS Defl. Level = $\frac{(D_c)(V_R)}{(TMG)(LG)(V_c)} =$ = _____ = psi		

2

CALC		REVISED	DATE	POWER SPECTRAL DENSITY ANALYSIS OF DISPLACEMENT PICKUP	VOL I
CHECK	EDS			1479 P/U 1	D2-8004
APR.				THE BOEING COMPANY	PAGE
APR				SEATTLE 24, WASHINGTON	FIG 108

POWER SPECTRAL DENSITY - $(\ln.)^2 / \text{cps}$



1

FREQUENCY - CPS

ANALYSIS VARIABLES

Bandwidth
 cycles from 50 to 55 cps
 cycles from 10 to 10 cps
 cycles from 10 to 10 cps

T_p 4 Sec.
 Anal. Rate 25 cps/sec.
 Loop Length 4 Sec.

DATA IDENTIFICATION

Test Title PANEL ATTACH TYPE 1 PRELIM		
EWA No. 5593-1	Panel or Specimen No. 1479	
Tape No. 13	Tape Channel 2	Displacement Pickup 5
Elapsed Test Time		P/U RMS Level at Sonic Lab. $V_L =$ Volts

CALIBRATION

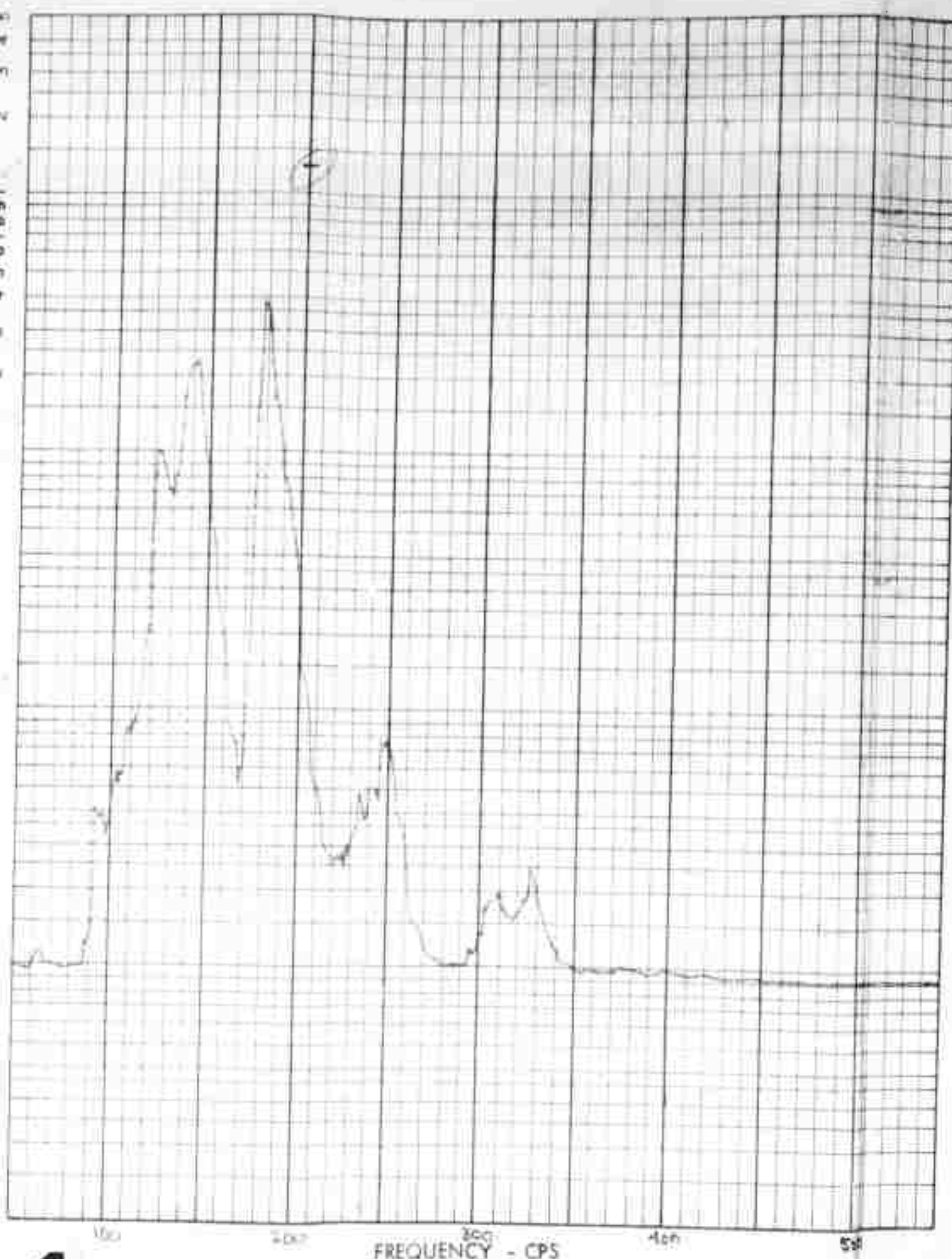
Tape No. 13	Tape Channel 1	Data Tape RMS Volt $V_R = 1.223$
Calibration Voltage $V_a = V_{rms}$ Into Line Amp.; $V_c = 0.5 V_{rms}$ on Tape 20 cps		
Line Amplifier Settings For Calibration $G_c = 0.1$; for Data $G_d = 0.1$		
Lab. Gain $LG = 1$	Tape Monitor Gain $TMG = \frac{G_d}{G_c} = 1$	
Displacement Pickup Sensitivity $S = 0.008$ in./Volt		
Equivalent of Calibration - In. $D_c = V_a \cdot S = (0.5)(0.008) = 0.004$		
Equivalent of Calibration for PSD Plots $\left(\frac{D_c}{(TMG)(LG)} \right)^2 = \left(\frac{0.004}{(1)(1)} \right)^2 = 1.6 \times 10^{-6}$ in. ² /cps		
Analyzer Attenuator Setting -12 db	Log Converter Setting db	
Calibration Plotted at 1.6 in. ² /cps		
Overall Deflection Level of Data RMS Defl. Level = $\frac{(D_c)(V_R)}{(TMG)(LG)(V_c)} =$ = psi		

2

CALC	1	2	REVISED	DATE	POWER SPECTRAL DENSITY ANALYSIS OF DISPLACEMENT PICKUP	VOL I
CHECK	8/15	10/12			1479 FUS	D2 5004
APR						
APR					THE BOEING COMPANY SEATTLE 24, WASHINGTON	PAGE FIG 109

POWER SPECTRAL DENSITY - (In.)²/cps

2 3 4 5 6 7 8 9 1 2 3 4 5 6 7 8 9 1 2 3 4 5



1

FREQUENCY - CPS

ANALYSIS VARIABLES

Bandwidth
 Σ cycles from 50 to 550 cps
 — cycles from — to — cps
 — cycles from — to — cps

T_c = 4 Sec.
 Anal. Rate 1.25 cps/sec.
 Loop Length 4 Sec.

DATA IDENTIFICATION

Test Title PANEL ATTACH. TYPE I PRELIM.		
EWA No. 5502-1	Panel or Specimen No. 1479	
Tape No. 13	Tape Channel 6	Displacement Pickup 6
Elapsed Test Time		P/U RMS Level at Sonic Lab. $V_L =$ Volts

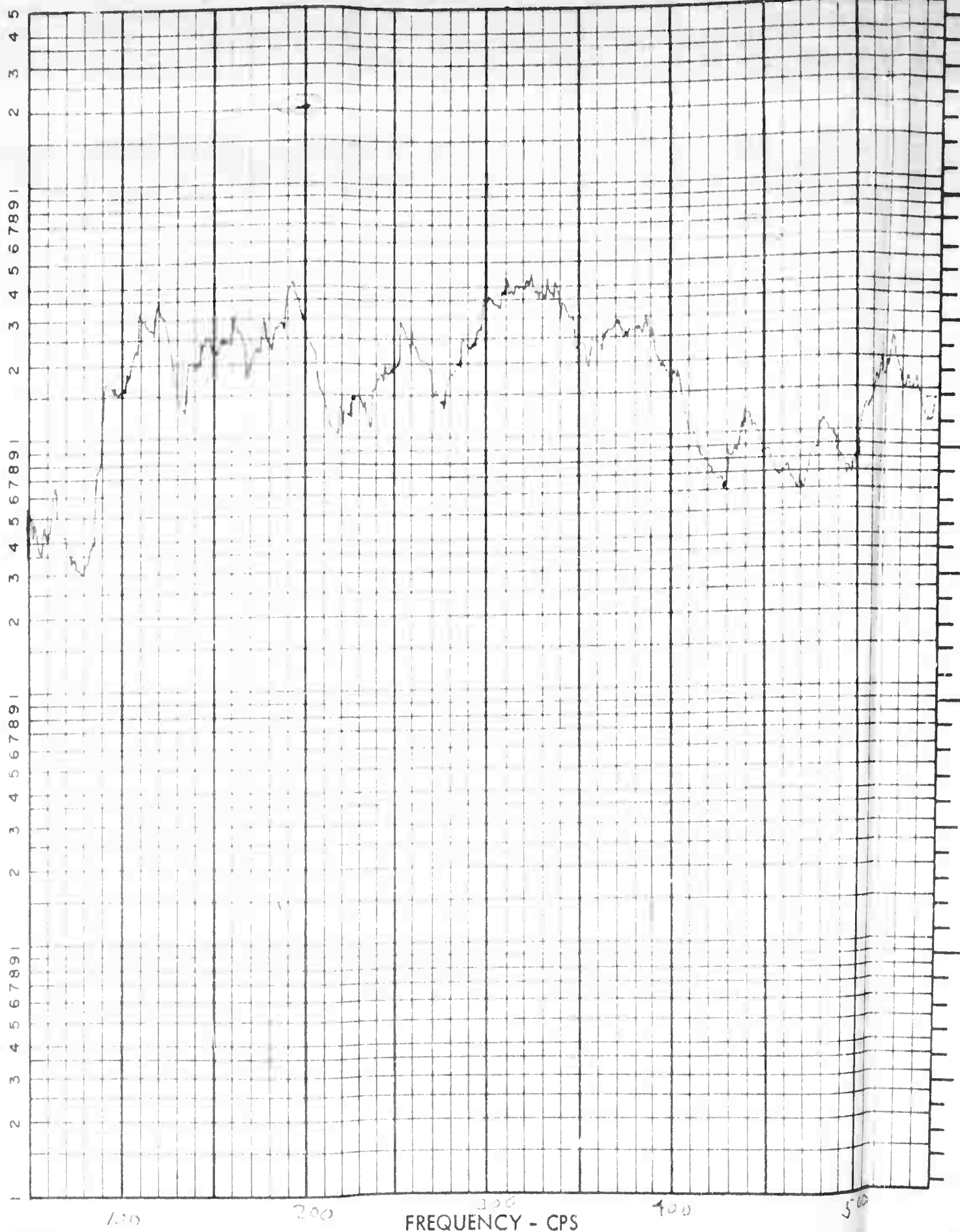
CALIBRATION

Tape No. 13	Tape Channel 1	Data Tape RMS Volt $V_R = 0.300$
Calibration Voltage $V_a = .5$ V_{rms} Into Line Amp.; $V_c = .5$ V_{rms} on Tape 200cps		
Line Amplifier Settings For Calibration $G_c = .1$; for Data $G_d = .1$		
Lab. Gain $LG = 1$	Tape Monitor Gain $TMG = \frac{G_d}{G_c} = 1$	
Displacement Pickup Sensitivity $S = .0708$ in./Volt		
Equivalent of Calibration - In. $D_c = V_a \cdot S = (.5)(.0708) = .0354$		
Equivalent of Calibration for PSD Plots $\left(\frac{D_c}{(TMG)(LG)} \right)^2 = \left[\frac{.0354}{1 \times 1} \right]^2 = 1.25 \times 10^{-3}$ in. ² /cps		
Analyzer Attenuator Setting 11 db	Log Converter Setting db	
Calibration Plotted at 200 cps		in. ² /cps
Overall Deflection Level of Data $RMS\ Defl.\ Level = \frac{(D_c)(V_R)}{(TMG)(LG)(V_c)} =$ $=$ psf		

2

CALC	RFS	REVISED	DATE	POWER SPECTRAL DENSITY ANALYSIS OF DISPLACEMENT PICKUP	VOL I
CHECK	RDS				
APR				1412 P/U 6	02-30084
APR				THE BOEING COMPANY SEATTLE 24, WASHINGTON	PAGE FIG 110

POWER SPECTRAL DENSITY - (psi)² / cps



FREQUENCY - CPS

ANALYSIS VARIABLES

Bandwidth

5 cycles from 50 to 550 cps
 cycles from to cps
 cycles from to cps

T_c 4 Sec.

Anal. Rate 1.25 cps/Sec.

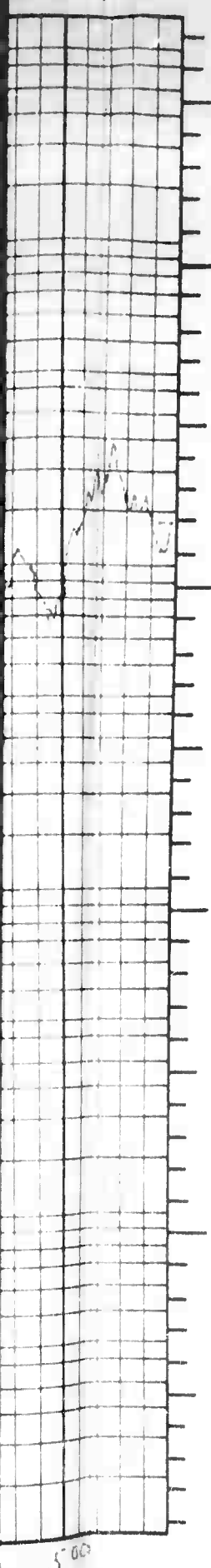
Loop Length 4 Sec.

CALC

CHECK

APR.

APR



SPECTRUM LEVEL - DECIBELS (Re 0.0002 Microbar)

2

DATA IDENTIFICATION

Test Title PANEL AITCH TYPE I PRELIM.		
EWA No. 5593-1		Panel or Specimen No. 1479
Tape No. 14	Tape Channel 2	Mic. No. 1
Elapsed Test Time		Mic. RMS Level at Sonic Lab. $V_L =$ Volts

CALIBRATION

Tape No. 14	Tape Channel 1	Data Tape RMS Volt $V_R = 380$
Calibration Voltage $V_a = V_{rms}$ into Line Amp.; $V_c = .5$ V_{rms} on Tape @ 200 cps		
Line Amplifier Settings For Calibration $G_c = .1$; for Data $G_d = .1$		
Lab. Gain $LG = .1$	Tape Monitor Gain $TMG = \frac{G_d}{G_c} = 1$	
Microphone Sensitivity $S = .197$ psi/Volt or 1 Volt rms = 100 db SPL		
Equivalent of Calibration - psi $P_c = V_a \cdot S = (.5)(.240) = .145$		
Equivalent of Calibration for PSD Plots $\left(\frac{P_c}{(TMG)(LG)} \right)^2 = \left[\frac{.145}{1 \cdot .1} \right]^2 = 2.10 \times 10^{-2}$ psi ² /cps		
Analyzer Attenuator Setting -20 db	Log Converter Setting 0 db	
Calibration Plotted at 2.10×10^{-4} psi ² /cps		
Overall Pressure Level Data RMS pressure Level $(P_c)(V_R)$ $(TMG)(LG)(V_c)$		Equiv. to db SPL
= _____ =		psi

CALC			REVISED	DATE	POWER SPECTRAL DENSITY ANALYSIS OF MICROPHONE OUTPUT 1479 MIC 1 THE BOEING COMPANY	VOL I
CHECK	RLS					DZ 80082
APR.						PAGE FIG III
APR.						

POWER SPECTRAL DENSITY - (psi)² / cps



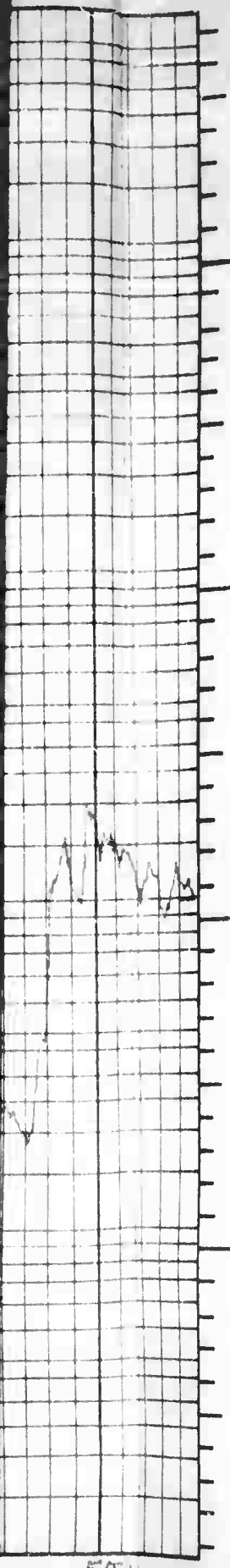
FREQUENCY - CPS

ANALYSIS VARIABLES

Bandwidth

5 cycles from 50 to 550 cps
 — cycles from — to — cps
 — cycles from — to — cps

T_c 4 Sec.
 Anal. Rate 1.25 cps/Sec.
 Loop Length 4 Sec.



SPECTRUM LEVEL - DECIBELS (Re 0.0002 Microbar)

2

DATA IDENTIFICATION

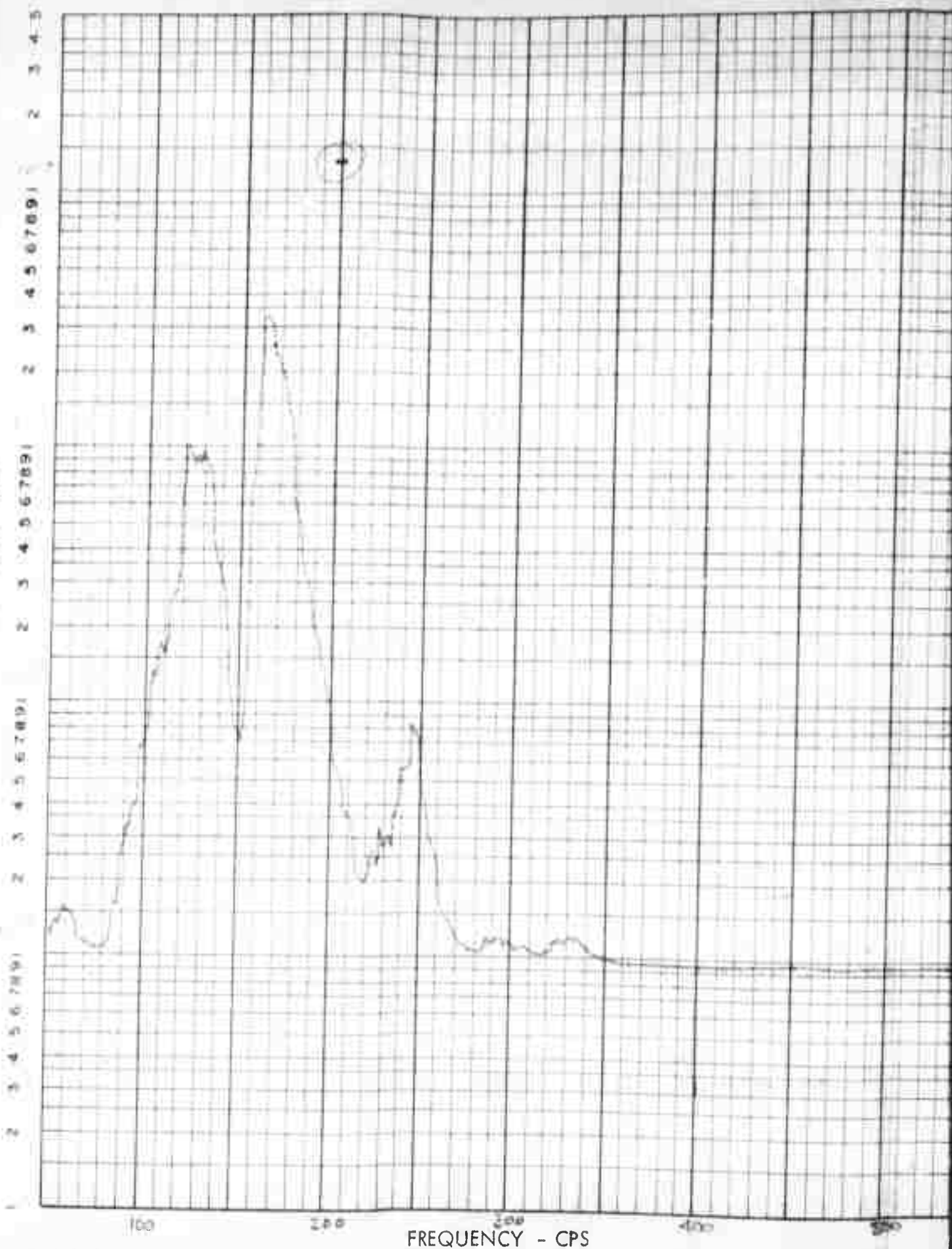
Test Title PAUEL ATTACH TYPE I PRELIM.		
EWA No. 5593-1		Panel or Specimen No. 1479
Tape No. 14	Tape Channel 3	Mic. No. 2
Elapsed Test Time		Mic. RMS Level at Sonic Lab. V _L = Volts

CALIBRATION

Tape No. 14	Tape Channel 1	Data Tape RMS Volt V _R = .220
Calibration Voltage V _a = .5 V _{rms} into Line Amp.; V _c = .5 V _{rms} on Tape @ 200 cps		
Line Amplifier Settings For Calibration G _c = .1 ; for Data G _d = .2		
Lab. Gain LG = 1	Tape Monitor Gain TMG = $\frac{G_d}{G_c}$ = 2	
Microphone Sensitivity S = .290 psi/Volt or 1 Volt rms = 160 db SPL		
Equivalent of Calibration - psi P _c = V _a · S = (.5) · 160 = .145		
Equivalent of Calibration for PSD Plots $\left(\frac{P_c}{(TMG)(LG)} \right)^2 = \left[\frac{.145}{2 \times 1} \right]^2 = 5.26 \times 10^{-3}$ psi ² /cps		
Analyzer Attenuator Setting 20 db	Log Converter Setting 0 db	
Calibration Plotted at 5.26 × 10 ⁻⁵		psi ² /cps
Overall Pressure Level Data RMS pressure Level	(P _c) (V _R) (TMG)(LG)(V _c)	Equiv. to db SPL
= _____ =		psi

CALC		REVISED	DATE	POWER SPECTRAL DENSITY ANALYSIS OF MICROPHONE OUTPUT 1479 MIC 2 THE BOEING COMPANY	VOL I
CHECK	RLS				DE 80054
APR					PAGE
APR					FIG 112

POWER SPECTRAL DENSITY - $(\text{in.})^2/\text{cps}$



FREQUENCY - CPS

ANALYSIS VARIABLES

Bandwidth

5 cycles from 50 to 550 cps
 — cycles from — to — cps
 — cycles from — to — cps

T_c 4 Sec.

Anal. Rate 1.25 cps/sec.

Loop Length 4 Sec.

1

DATA IDENTIFICATION

Test Title PANEL ATTACH TYPE I PRELIM		
EWA No. 5503-1	Panel or Specimen No. 1479	
Tape No. 14	Tape Channel 4	Displacement Pickup 1
Elapsed Test Time		P/U RMS Level at Sonic Lab. $V_L =$ Volts

CALIBRATION

Tape No. 14	Tape Channel 1	Data Tape RMS Volt $V_R =$
Calibration Voltage $V_a = .5$ V_{rms} Into Line Amp.; $V_c = .5$ V_{rms} on Tape cps		
Line Amplifier Settings For Calibration $G_c = .1$; for Data $G_d = .1$		
Lab. Gain $LG = 1$	Tape Monitor Gain $TMG = \frac{G_d}{G_c} = 1$	
Displacement Pickup Sensitivity $S = .0708$ in./Volt		
Equivalent of Calibration - In. $D_c = V_a \cdot S = (.5)(.0708) = .0354$		
Equivalent of Calibration for PSD Plots $\left(\frac{D_c}{(TMG)(LG)} \right)^2 = \left[\frac{.0354}{1 \times 1} \right]^2 = 1.25 \times 10^{-3}$ in. ² /cps		
Analyzer Attenuator Setting -10 db	Log Converter Setting db	
Calibration Plotted at 1.25 x 10⁻³ in. ² /cps		
Overall Deflection Level of Data $RMS \text{ Defl. Level} = \frac{(D_c)(V_R)}{(TMG)(LG)(V_c)} =$ $=$ psi		

2

CALC	RFS	9-6-63	REVISED	DATE	POWER SPECTRAL DENSITY ANALYSIS OF DISPLACEMENT PICKUP 1479 P/U 1 THE BOEING COMPANY SEATTLE 24, WASHINGTON	Vol I
CHECK	RDS	10-13				D2-8000
APR						PAGE
APR						FIG 113

POWER SPECTRAL DENSITY - $(\text{In.})^2 / \text{cps}$

2 3 4 5 6 7 8 9 1 2 3 4 5 6 7 8 9 1 2 3 4 5



100

200

300
FREQUENCY - CPS

400

500

1

ANALYSIS VARIABLES

Bandwidth
5 cycles from 50 to 550 cps
 — cycles from — to — cps
 — cycles from — to — cps

T_c 4 Sec.
 Anal. Rate 1.25 cps/sec.
 Loop Length 4 Sec.

DATA IDENTIFICATION

Test Title PANEL ATTACH TYPE I PRELIM		
EWA No. 5592-1	Panel or Specimen No. 1479	
Tape No. 14	Tape Channel 5	Displacement Pickup # 5
Elapsed Test Time		P/U RMS Level at Sonic Lab. V _L = Volts

CALIBRATION

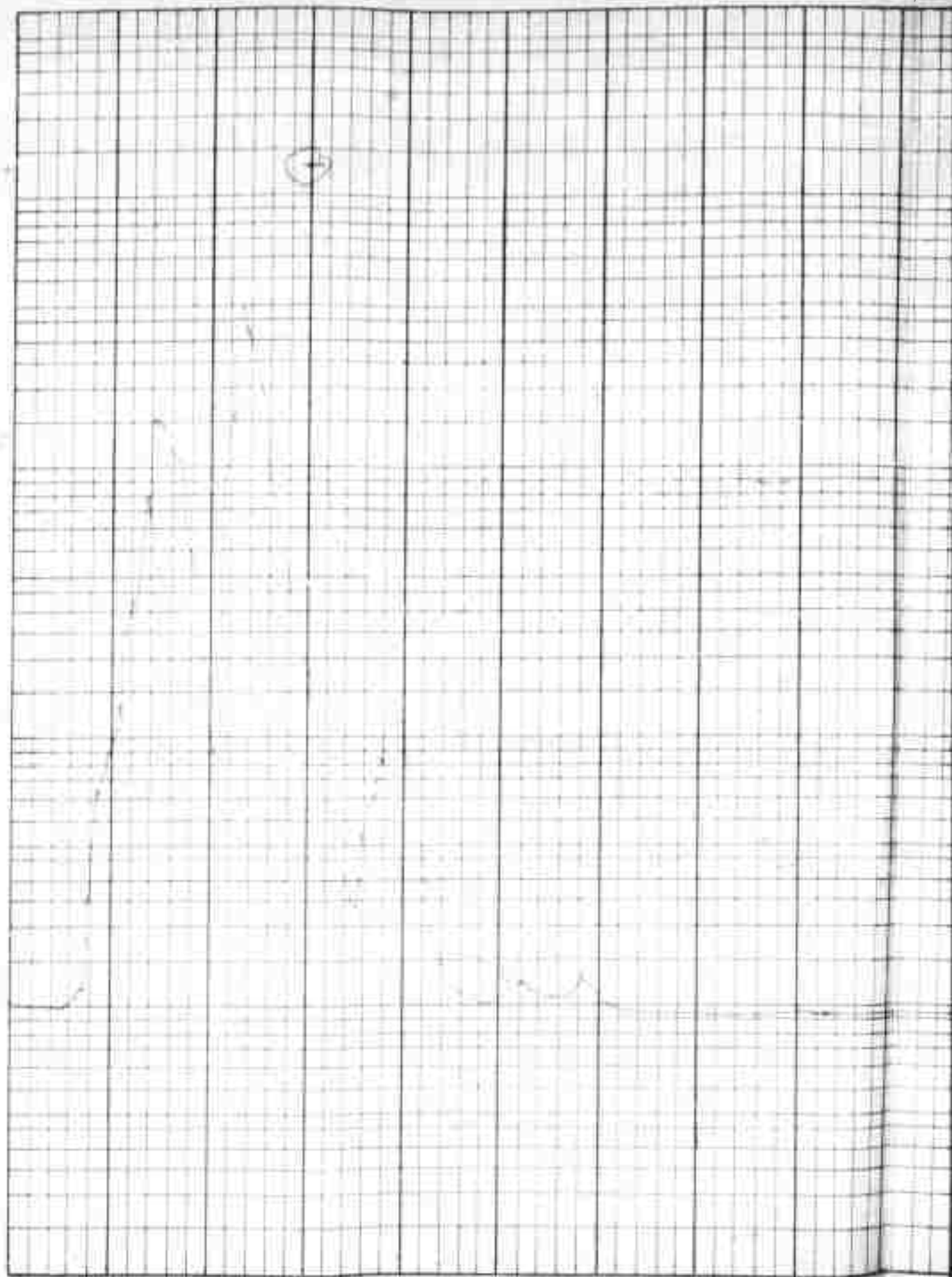
Tape No. 14	Tape Channel 1	Data Tape RMS Volt V _R =
Calibration Voltage V _a = .5 V _{rms} Into Line Amp.; V _c = .5 V _{rms} on Tape 200cps		
Line Amplifier Settings For Calibration G _c = .1 ; for Data G _d = .1		
Lab. Gain LG = 1	Tape Monitor Gain TMG = $\frac{G_d}{G_c}$ = 1	
Displacement Pickup Sensitivity S = .0708 in./Volt		
Equivalent of Calibration - in. D _c = V _a · S = (.5) (.0708) = .0354		
Equivalent of Calibration for PSD Plots $\left(\frac{D_c}{(TMG)(LG)} \right)^2 = \left[\frac{.0354}{1 \times 1} \right]^2 = 1.25 \times 10^{-3}$ in. ² /cps		
Analyzer Attenuator Setting -1 db	Log Converter Setting db	
Calibration Plotted at in. ² /cps		
Overall Deflection Level of Data RMS Defl. Level = $\frac{(D_c)(V_R)}{(TMG)(LG)(V_c)}$ = = = psi		

2

CALC	1-2-5	REVISED	DATE	POWER SPECTRAL DENSITY ANALYSIS OF DISPLACEMENT PICKUP 1479 P/U 5 THE BOEING COMPANY SEATTLE 24, WASHINGTON	VOL I
CHECK	RLS	10-2-5			DZ-8008A
APR					PAGE
APR					FIG 114

POWER SPECTRAL DENSITY - $(\text{in.})^2/\text{cps}$

1 2 3 4 5 6 7 8 9 10 20 30 40 50 60 70 80 90 100



1

FREQUENCY - CPS

ANALYSIS VARIABLES

Bandwidth

___ cycles from ___ to ___ cps
 ___ cycles from ___ to ___ cps
 ___ cycles from ___ to ___ cps

T_c ___ Sec.

Anal. Rate ___ cps/sec.

Loop Length ___ Sec.

DATA IDENTIFICATION

Test Title PANEL ATTACH TYPE I PRELIM		
EWA No. 5593-1	Panel or Specimen No. 1479	
Tape No. 14	Tape Channel 6	Displacement Pickup # 6
Elapsed Test Time		P/U RMS Level at Sonic Lab. $V_L =$ Volts

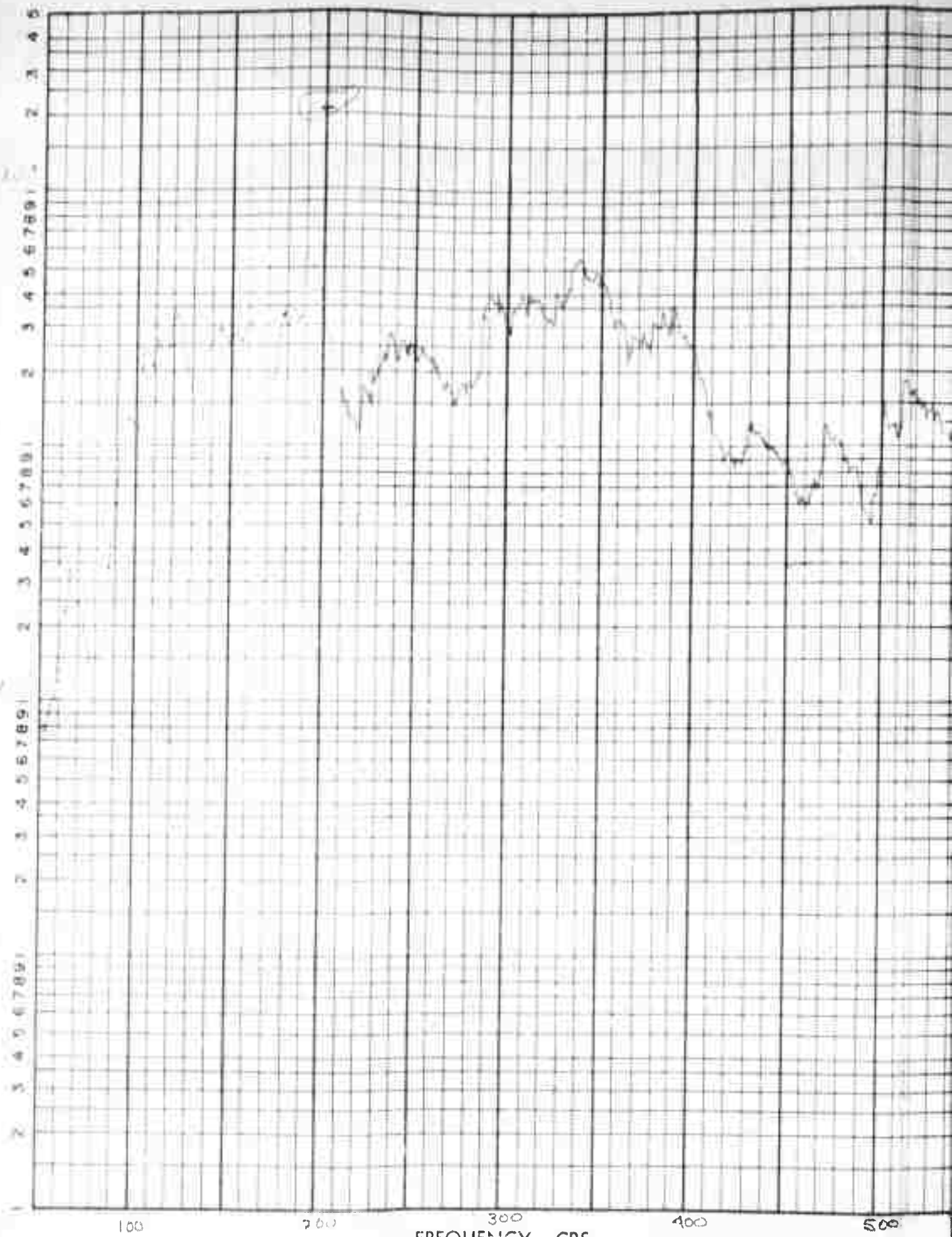
CALIBRATION

Tape No. 14	Tape Channel 1	Data Tape RMS Volt $V_R = 0.260$
Calibration Voltage $V_a = V_{rms}$ into Line Amp.; $V_c = 0.5 V_{rms}$ on Tape cps		
Line Amplifier Settings For Calibration $G_c = 0.1$; for Data $G_d = 0.1$		
Lab. Gain LG = 1	Tape Monitor Gain $TMG = \frac{G_d}{G_c} = 1$	
Displacement Pickup Sensitivity $S = 0.0708$ in./Volt		
Equivalent of Calibration - in. $D_c = V_a \cdot S = (0.5)(0.0708) = 0.0354$		
Equivalent of Calibration for PSD Plots $\left(\frac{D_c}{(TMG)(LG)} \right)^2 = \left[\frac{0.0354}{(1)(1)} \right]^2 = 0.00125$ in. ² /cps		
Analyzer Attenuator Setting -15 db	Log Converter Setting db	
Calibration Plotted at 10-23-4 in. ² /cps		
Overall Deflection Level of Data $RMS \text{ Defl. Level} = \frac{(D_c)(V_R)}{(TMG)(LG)(V_c)} =$ $=$ psi		

2

CALC	RFS	7/20/65	REVISED	DATE	POWER SPECTRAL DENSITY ANALYSIS OF DISPLACEMENT PICKUP	Vol I.
CHECK	RDS	10-23				
APR.					1479 P/U 6	DZ-80284
APR					THE BOEING COMPANY SEATTLE 24, WASHINGTON	PAGE F74 115

POWER SPECTRAL DENSITY - (psi)² / cps



1

FREQUENCY - CPS

ANALYSIS VARIABLES

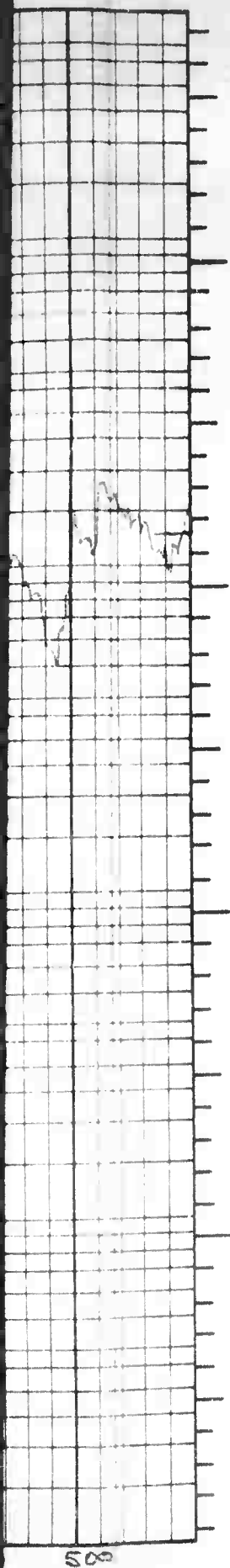
Bandwidth

5 cycles from 50 to 550 cps
 — cycles from — to — cps
 — cycles from — to — cps

T_c 4 Sec.

Anal. Rate 1.25 cps/Sec.

Loop Length 4 Sec.



SPECTRUM LEVEL - DECIBELS (Re 0.0002 Microbar)

2

DATA IDENTIFICATION

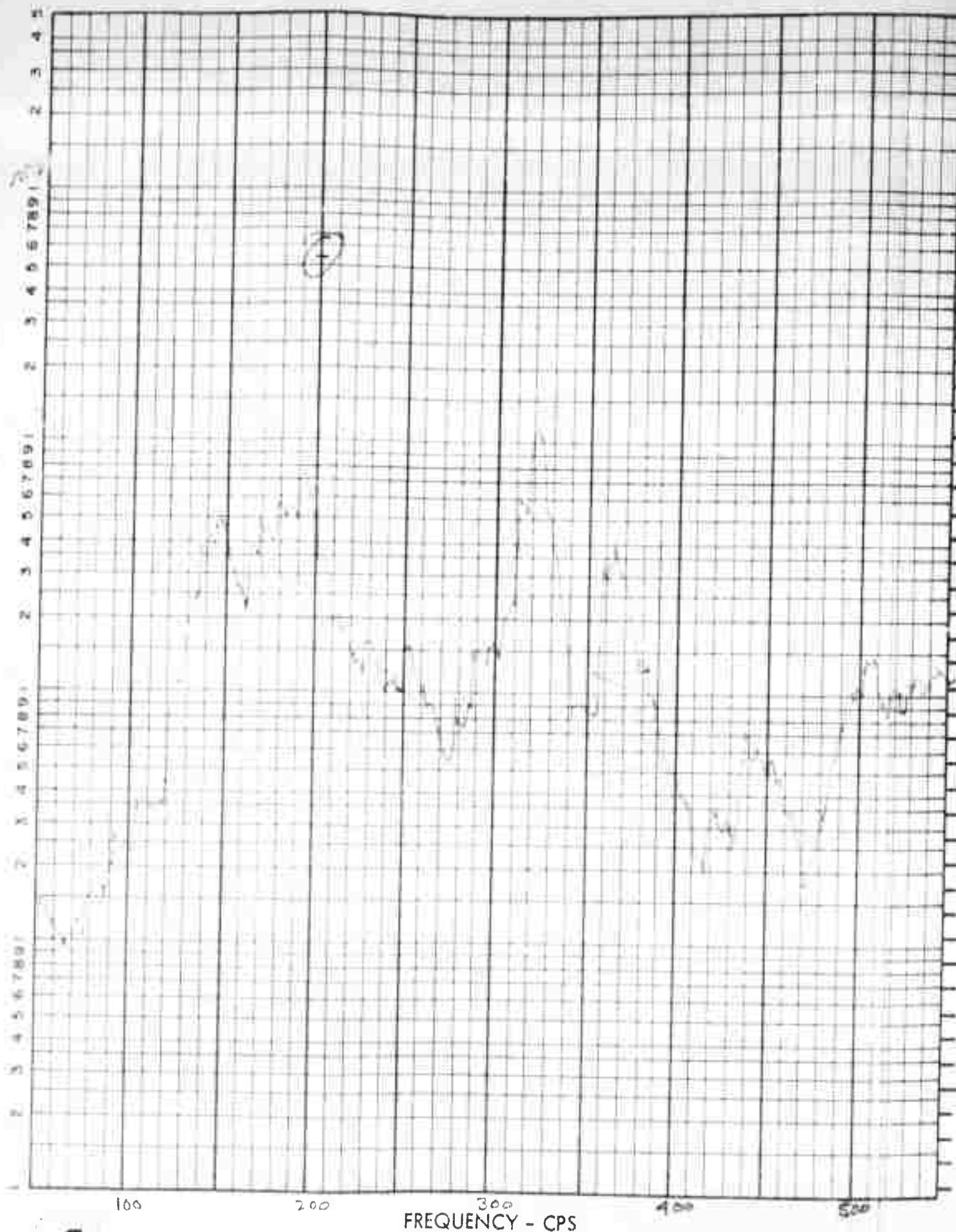
Test Title PANEL ATTACH. TYPE I PRELIM		
EWA No. 5503-1		Panel or Specimen No. 1479
Tape No. 15	Tape Channel 2	Mic. No. 1
Elapsed Test Time		Mic. RMS Level at Sonic Lab. V _L = Volts

CALIBRATION

Tape No. 15	Tape Channel 1	Data Tape RMS Volt V _R =
Calibration Voltage V _a = .5 V _{rms} into Line Amp.; V _c = .5 V _{rms} on Tape @ .2 cps		
Line Amplifier Settings For Calibration G _c = .1 ; for Data G _d = .1		
Lab. Gain LG = 1	Tape Monitor Gain TMG = $\frac{G_d}{G_c}$ = 1	
Microphone Sensitivity S = .290 psi/Volt or 1 Volt rms = 160 db SPL		
Equivalent of Calibration - psi P _c = V _a · S = (.5) (.290) = .145		
Equivalent of Calibration for PSD Plots $\left(\frac{P_c}{(TMG)(LG)} \right)^2 = \left[\frac{.145}{1 \times 1} \right]^2 = 2.1 \times 10^{-2}$ psi ² /cps		
Analyzer Attenuator Setting db	Log Converter Setting db	
Calibration Plotted at		psi ² /cps
Overall Pressure Level Data RMS pressure Level	(P _c) (V _R) $\frac{(TMG)(LG)(V_c)}{V_R}$	Equiv. to db SPL
=		psi

CALC	51	REVISED	DATE	POWER SPECTRAL DENSITY ANALYSIS OF MICROPHONE OUTPUT 1479 Mic 1 THE BOEING COMPANY	VOL 1
CHECK	1.1				1.1-116
APR.					PAGE
APR.					Fig 116

POWER SPECTRAL DENSITY - (psi)² / cps



1

ANALYSIS VARIABLES

Bandwidth

5 cycles from 50 to 550 cps
 — cycles from — to — cps
 — cycles from — to — cps

T_c 4 Sec.

Anal. Rate 1.25 cps/Sec.

Loop Length 4 Sec.

CALC
 CHECK
 APR.
 APR.

DATA IDENTIFICATION

Test Title PANEL ATTACH TYPE I PRELIM		
EWA No. 5593-1		Panel or Specimen No. 1479
Tape No. 15	Tape Channel 3	Mic. No. 2
Elapsed Test Time		Mic. RMS Level at Sonic Lab. V _L = Volts

CALIBRATION

Tape No. 15	Tape Channel 3	Data Tape RMS Volt V _R = .155
Calibration Voltage V _a = .5 V _{rms} into Line Amp.; V _c = .5 V _{rms} on Tape @ 200 cps		
Line Amplifier Settings For Calibration G _c = .1 ; for Data G _d = .2		
Lab. Gain LG = 1	Tape Monitor Gain TMG = $\frac{G_d}{G_c} = 2$	
Microphone Sensitivity S = .290 psi/Volt or 1 Volt rms = 160 db SPL		
Equivalent of Calibration - psi P _c = V _a · S = (.5) (.290) = .145		
Equivalent of Calibration for PSD Plots $\left(\frac{P_c}{(TMG)(LG)} \right)^2 = \left[\frac{.145}{2 \times 1} \right]^2 = 5.26 \times 10^{-3}$ psi ² /cps		
Analyzer Attenuator Setting - 2 db	Log Converter Setting db	
Calibration Plotted at 5.26×10^{-3} psi ² /cps		
Overall Pressure Level Data RMS pressure Level $\frac{(P_c)(V_R)}{(TMG)(LG)(V_c)}$		Equiv. to db SPL
= _____		= _____ psi

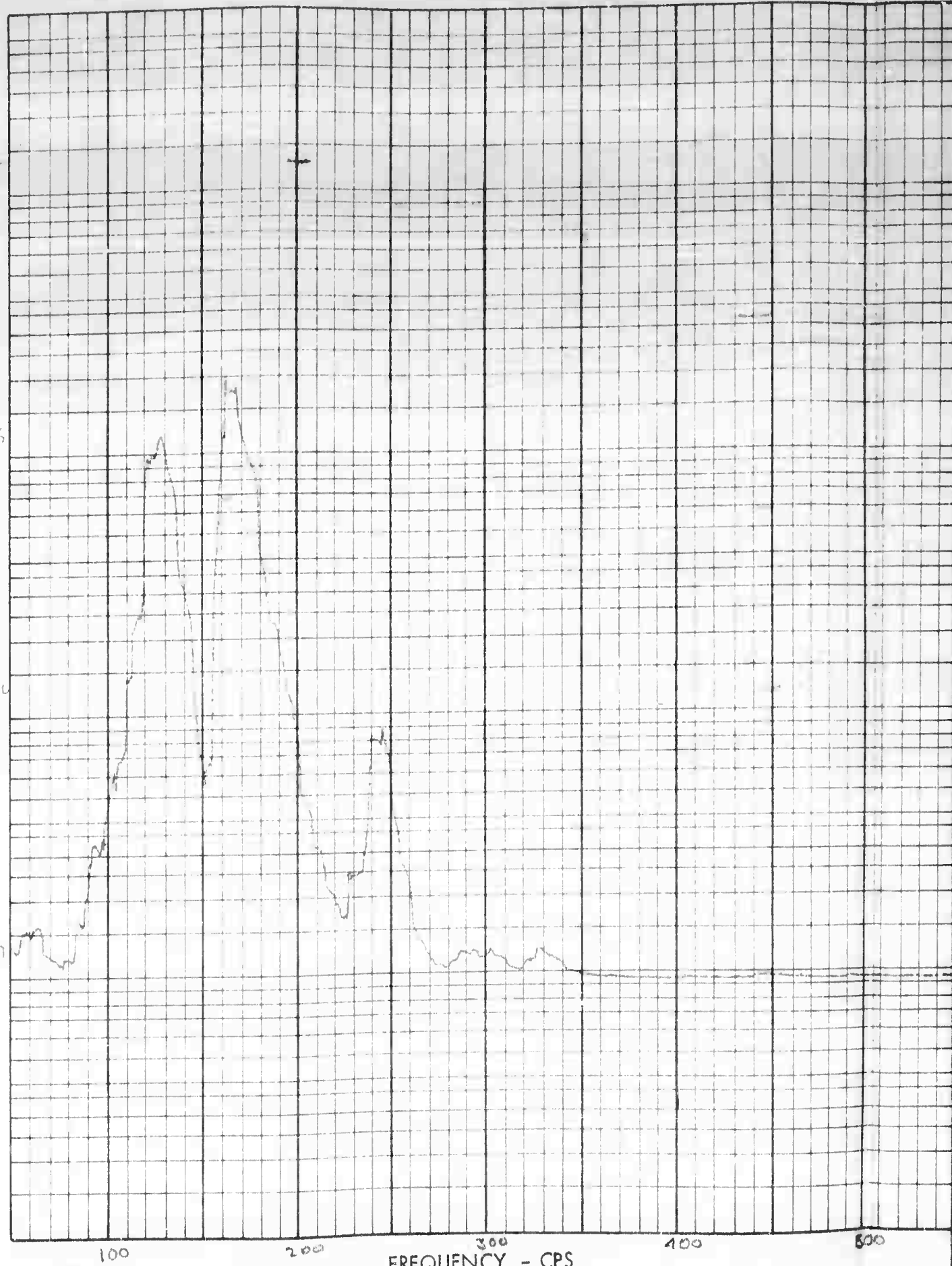
SPECTRUM LEVEL - DECIBELS (Re 0.0002 Microbar)

2

CALC	15	76.1	REVISED	DATE	POWER SPECTRAL DENSITY ANALYSIS OF MICROPHONE OUTPUT 1479 MIC 2 THE BOEING COMPANY	VOL I
CHECK	15	0.3				D280004
APR						PAGE
APR						FIG 117

POWER SPECTRAL DENSITY - $(\text{in.})^2/\text{cps}$

1 2 3 4 5 6 7 8 9 10 2 3 4 5 6 7 8 9 10 2 3 4 5 6 7 8 9 10 2 3 4 5



FREQUENCY - CPS

ANALYSIS VARIABLES

Bandwidth
5 cycles from 50 to 550 cps
— cycles from — to — cps
— cycles from — to — cps

T_c 4 Sec.
Anal. Rate 1.25 cps/sec.
Loop Length 4 Sec.

1

DATA IDENTIFICATION

Test Title PANEL ATTACH TYPE I PRELIM		
EWA No. 5502-1	Panel or Specimen No. 1479	
Tape No. 15	Tape Channel 4	Displacement Pickup # 1
Elapsed Test Time		P/U RMS Level at Sonic Lab. $V_L =$ Volts

CALIBRATION

Tape No. 15	Tape Channel 1	Data Tape RMS Volt $V_R =$ 250
Calibration Voltage $V_a = .5$ V _{rms} Into Line Amp.; $V_c = .5$ V _{rms} on Tape 200cps		
Line Amplifier Settings For Calibration $G_c = , 1$; for Data $G_d = , 1$		
Lab. Gain $LG = 1$	Tape Monitor Gain $TMG = \frac{G_d}{G_c} = 1$	
Displacement Pickup Sensitivity $S = .0708$ in./Volt		
Equivalent of Calibration - In. $D_c = V_a \cdot S = (.5)(.0708) = .0354$		
Equivalent of Calibration for PSD Plots $\left(\frac{D_c}{(TMG)(LG)} \right)^2 = \left[\frac{.0354}{1 \times 1} \right]^2 = 1.25 \times 10^{-3}$ in. ² /cps		
Analyzer Attenuator Setting -10 db	Log Converter Setting db	
Calibration Plotted at 1.25×10^{-3} in. ² /cps		
Overall Deflection Level of Data $RMS\ Defl.\ Level = \frac{(D_c)(V_R)}{(TMG)(LG)(V_c)} =$ $=$ _____ = _____ psi		

2

CALC	RCS	7/1/63	REVISED	DATE	POWER SPECTRAL DENSITY ANALYSIS OF DISPLACEMENT PICKUP 1479 P/U 1	VOL I
CHECK	RLS	10-2-63				D2-80084
APR.						THE BOEING COMPANY SEATTLE 24, WASHINGTON
APR.						

POWER SPECTRAL DENSITY - $(\text{in.})^2/\text{cps}$

1 2 3 4 5 6 7 8 9 1 2 3 4 5 6 7 8 9 1 2 3 4 5



100

200

FREQUENCY - CPS

400

500

ANALYSIS VARIABLES

Bandwidth

5 cycles from 50 to 550 cps
 — cycles from — to — cps
 — cycles from — to — cps

T_p 4 Sec.

Anal. Rate 1.25 cps/sec.

Loop Length 9 Sec.

1

DATA IDENTIFICATION

Test Title PANEL ATTACH TYPE I PRELIM		
EWA No. 5593-1	Panel or Specimen No. 1479	
Tape No. 15	Tape Channel 5	Displacement Pickup 5
Elapsed Test Time		P/U RMS Level at Sonic Lab. V _L = Volts

CALIBRATION

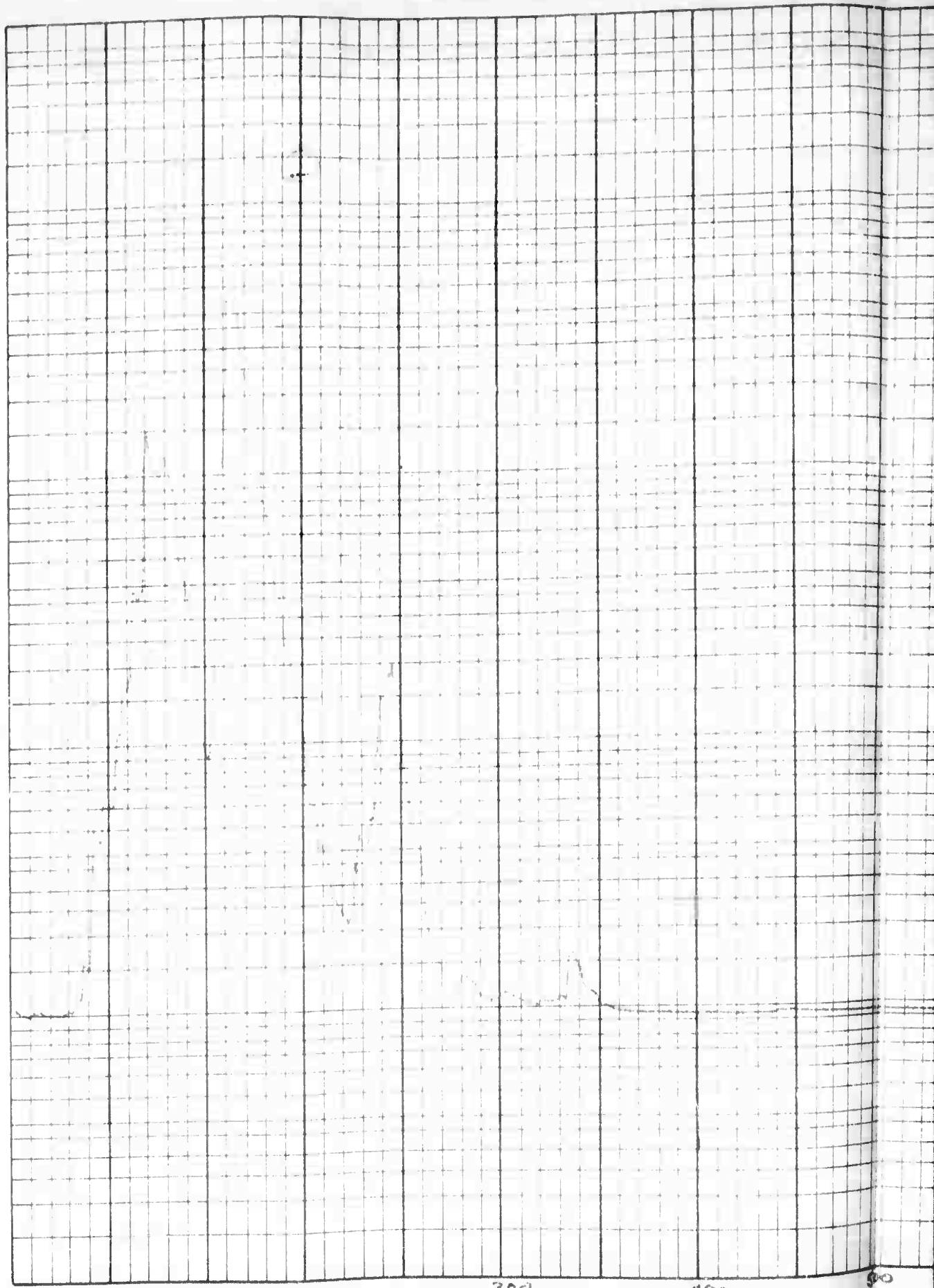
Tape No. 15	Tape Channel 1	Data Tape RMS Volt V _R = .5
Calibration Voltage V _a = .5 V _{rms} Into Line Amp.; V _c = .5 V _{rms} on Tape 200 cps		
Line Amplifier Settings For Calibration G _c = .1 ; for Data G _d = .1		
Lab. Gain LG = 1	Tape Monitor Gain TMG = $\frac{G_d}{G_c}$ = 1	
Displacement Pickup Sensitivity S = .0708 in./Volt		
Equivalent of Calibration - In. D _c = V _a · S = (.5)(.0708) = .0354		
Equivalent of Calibration for PSD Plots $\left(\frac{D_c}{(TMG)(LG)} \right)^2 = \left[\frac{.0354}{1 \times 1} \right]^2 = 1.25 \times 10^{-3}$ in. ² /cps		
Analyzer Attenuator Setting -10 db	Log Converter Setting db	
Calibration Plotted at 1.25 × 10 ⁻⁴ in. ² /cps		
Overall Deflection Level of Data RMS Defl. Level = $\frac{(D_c)(V_R)}{(TMG)(LG)(V_c)}$ = = = psi		

2

CALC	11/5	10/5/5	REVISED	DATE	POWER SPECTRAL DENSITY ANALYSIS OF DISPLACEMENT PICKUP	VOL I
CHECK	11/5	10/2/5			1479 P/U .5	DZ-80084
APR.					THE BOEING COMPANY	PAGE
APR					SEATTLE 24, WASHINGTON	FIG 119

POWER SPECTRAL DENSITY - $(\text{In.})^2 / \text{cps}$

1 2 3 4 5 6 7 8 9 1 2 3 4 5 6 7 8 9 1 2 3 4 5 6 7 8 9 1 2 3 4 5



100

200

300
FREQUENCY - CPS

400

500

1

ANALYSIS VARIABLES

Bandwidth

5 cycles from 50 to 550 cps

— cycles from — to — cps

— cycles from — to — cps

T_e 4 Sec.

Anal. Rate 1.25 cps/sec.

Loop Length 4 Sec.

DATA IDENTIFICATION

Test Title PANEL ATTACH TYPE I PRELIM		
EWA No. 5593-1	Panel or Specimen No. 1479	
Tape No. 15	Tape Channel 6	Displacement Pickup 6
Elapsed Test Time		P/U RMS Level at Sonic Lab. $V_L =$ Volts

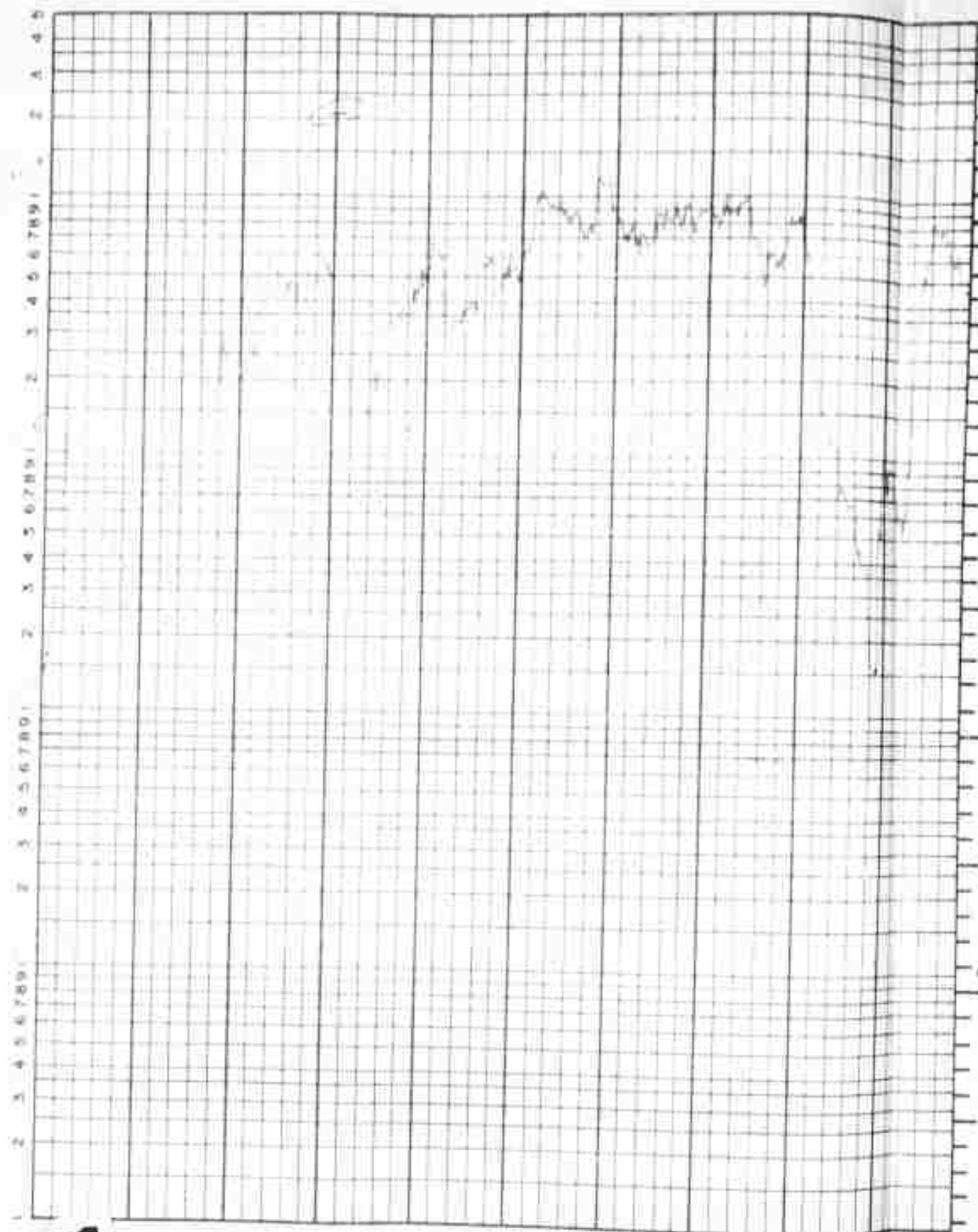
CALIBRATION

Tape No. 15	Tape Channel 1	Data Tape RMS Volt $V_R =$.5
Calibration Voltage $V_a = .5$ V_{rms} Into Line Amp.; $V_c = .5$ V_{rms} on Tape 200cps		
Line Amplifier Settings For Calibration $G_c = .1$; for Data $G_d = .1$		
Lab. Gain $LG = 1$	Tape Monitor Gain $TMG = \frac{G_d}{G_c} = 1$	
Displacement Pickup Sensitivity $S = .0708$ in./Volt		
Equivalent of Calibration - In. $D_c = V_a \cdot S = (.5)(.0708) = .0354$		
Equivalent of Calibration for PSD Plots $\left(\frac{D_c}{(TMG)(LG)} \right)^2 = \left[\frac{.0354}{1 \times 1} \right]^2 = 1.25 \times 10^{-3}$ in. ² /cps		
Analyzer Attenuator Setting 15 db	Log Converter Setting db	
Calibration Plotted at In. ² /cps		
Overall Deflection Level of Data RMS Defl. Level = $\frac{(D_c)(V_R)}{(TMG)(LG)(V_c)}$ = _____ = psi		

2

CALC		REVISED	DATE	POWER SPECTRAL DENSITY ANALYSIS OF DISPLACEMENT PICKUP	VOL I
CHECK	10-3			1479 P/U 6	D7 50084
APR.				THE BOEING COMPANY	PAGE
APR				SEATTLE 24, WASHINGTON	FIG. 120

POWER SPECTRAL DENSITY - $(\text{psi})^2 / \text{cps}$



1

FREQUENCY - CPS

ANALYSIS VARIABLES

Bandwidth

cycles from 20 to 100 cps
cycles from 20 to 100 cps
cycles from 20 to 100 cps

T₀ 4 Sec.
Anal. Rate 4 cps/Sec.
Loop Length 4 Sec.

CALC
CHECK
APR
APR



SPECTRUM LEVEL - DECIBELS (Re 0.0002 Microbar)

2

DATA IDENTIFICATION

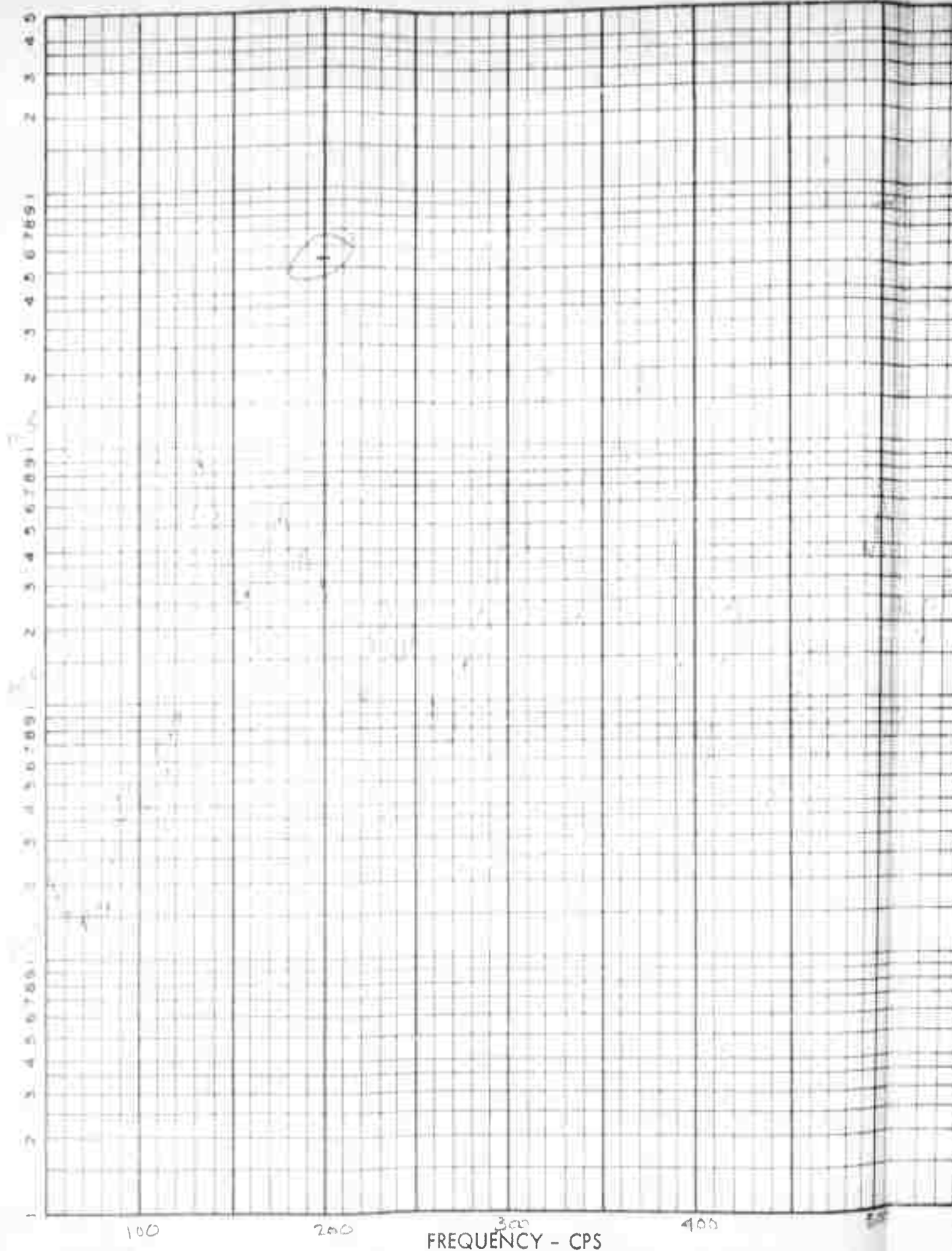
Test Title PANEL ATTACH, TYPE 1 PRELIM		
EWA No. 5573-1	Panel or Specimen No. 1477	
Tape No. 15	Tape Channel 2	Mic. No. 1
Elapsed Test Time		Mic. RMS Level at Sonic Lab. $V_L =$ Volts

CALIBRATION

Tape No. 16	Tape Channel 1	Data Tape RMS Volt $V_R = 0.95$
Calibration Voltage $V_a = 0.5$ V _{rms} into Line Amp.; $V_c = 2.5$ V _{rms} on Tape @ 200 cps		
Line Amplifier Settings For Calibration $G_c = 0.1$; for Data $G_d = 0.1$		
Lab. Gain $LG = 1$	Tape Monitor Gain $TMG = \frac{G_d}{G_c} = 1$	
Microphone Sensitivity $S = 0.5$ psi/Volt or 1 Volt rms = 165 db SPL		
Equivalent of Calibration - psi $P_c = V_a \cdot S = (0.5)(0.290) = 0.145$		
Equivalent of Calibration for PSD Plots $\left(\frac{P_c}{(TMG)(LG)} \right)^2 = \left[\frac{0.145}{(1)(1)} \right]^2 = 2.10 \times 10^{-2}$ psi ² /cps		
Analyzer Attenuator Setting -20 db	Log Converter Setting db	
Calibration Plotted at 2.10×10^{-2}		psi ² /cps
Overall Pressure Level Data RMS pressure Level	$(P_c)(V_R)$ $(TMG)(LG)(V_c)$	Equiv. to db SPL
= _____ =		psi

CALC	RFS	REVISED	DATE	POWER SPECTRAL DENSITY ANALYSIS OF MICROPHONE OUTPUT THE BOEING COMPANY	Vol. I
CHECK	WDS				DE 80084
APR.					PAGE
APR.					FIG 121

POWER SPECTRAL DENSITY - (psi)² / cps



1

FREQUENCY - CPS

ANALYSIS VARIABLES

Bandwidth

5 cycles from 50 to 550 cps
cycles from to cps
cycles from to cps

T_c 4 Sec.

Anal. Rate 1.25 cps/Sec.

Loop Length 4 Sec.

DATA IDENTIFICATION

Test Title PANEL ATTACH. TYPE I PRELIM		
EWA No. 5593-1	Panel or Specimen No. 1478	
Tape No. 16	Tape Channel 3	Mic. No. 2
Elapsed Test Time		Mic. RMS Level at Sonic Lab. V _L = Volts

CALIBRATION

Tape No. 16	Tape Channel 1	Data Tape RMS Volt V _R = 0.355
Calibration Voltage V _a = .5 V _{rms} into Line Amp.; V _c = .5 V _{rms} on Tape @ 200 cps		
Line Amplifier Settings For Calibration G _c = .1 ; for Data G _d = .2		
Lab. Gain LG = 1	Tape Monitor Gain TMG = $\frac{G_d}{G_c} = 2$	
Microphone Sensitivity S = .210 psi/Volt or 1 Volt rms = 160 db SPL		
Equivalent of Calibration - psi P _c = V _a · S = (.5) (.210) = .105		
Equivalent of Calibration for PSD Plots $\left(\frac{P_c}{(TMG)(LG)} \right)^2 = \left[\frac{.105}{(2)(1)} \right]^2 = 5.5 \times 10^{-3}$ psi ² /cps		
Analyzer Attenuator Setting -20 db	Log Converter Setting db	
Calibration Plotted at 57,000		psi ² /cps
Overall Pressure Level Data RMS pressure Level	(P _c) (V _R) (TMG)(LG)(V _c)	Equiv. to db SPL
= _____		psi

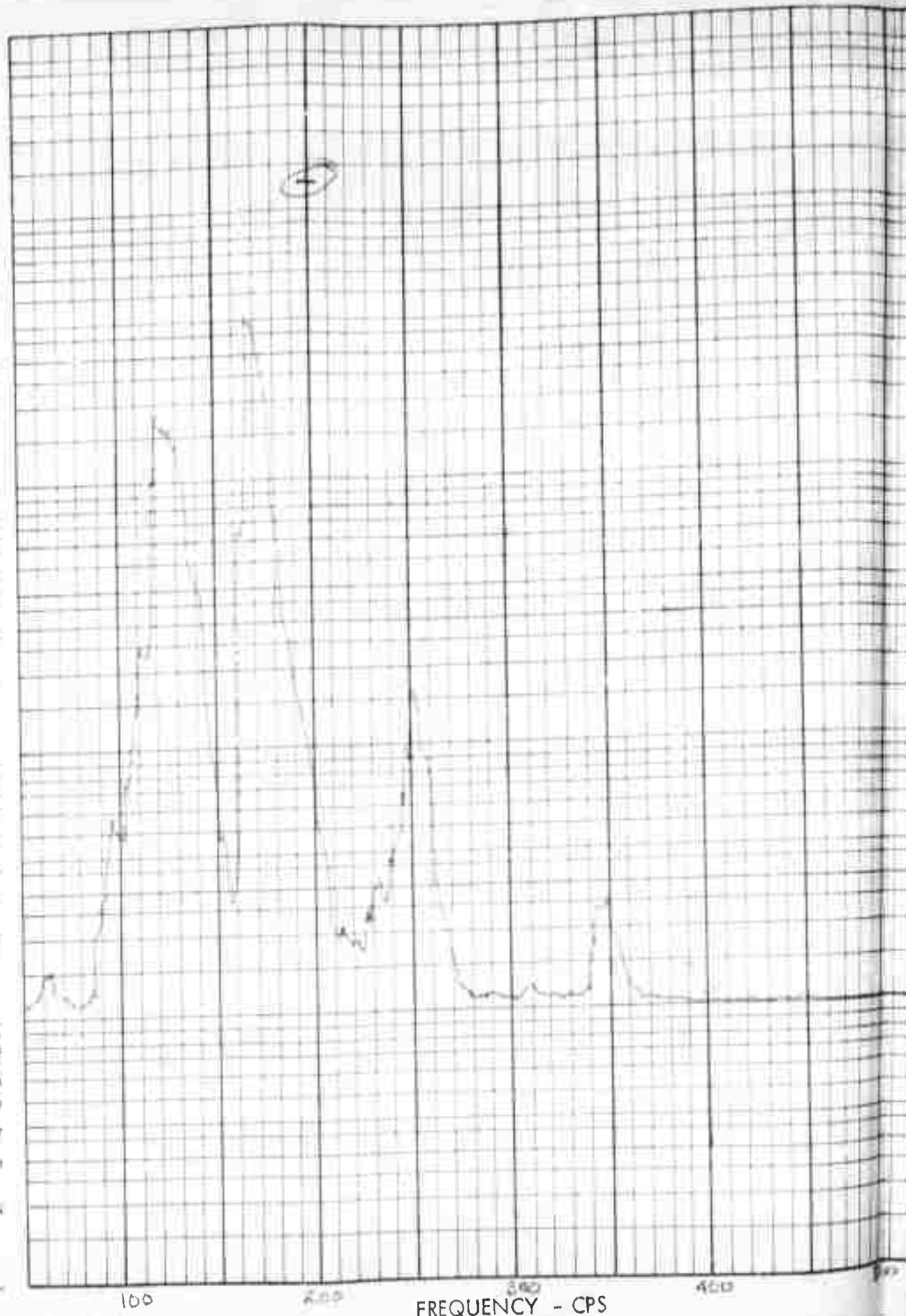
SPECTRUM LEVEL - DECIBELS (Re 0.0002 Microbar)

2

CALC	FS	9/3/68	REVISED	DATE	POWER SPECTRAL DENSITY ANALYSIS OF MICROPHONE OUTPUT 1478 Mic 2 THE BOEING COMPANY	Vol. I
CHECK	MS	10/1/68				DZ 8000A
APR						PAGE
APR						FIG 176

POWER SPECTRAL DENSITY - $(\text{in.})^2 / \text{cps}$

1 2 3 4 5 6 7 8 9 1 2 3 4 5 6 7 8 9 1 2 3 4 5



FREQUENCY - CPS

1

ANALYSIS VARIABLES

Bandwidth

5 cycles from 50 to 550 cps
 — cycles from — to — cps
 — cycles from — to — cps

4 Sec.

Anal. Rate 1.25 cps/sec.

Loop Length 4 Sec.

DATA IDENTIFICATION

Test Title PANEL ATTACH, TYPE I PRELIM.		
EWA No. 5593-1	Panel or Specimen No. 1478	
Tape No. 16	Tape Channel 4	Displacement Pickup 1
Elapsed Test Time		P/U RMS Level at Sonic Lab. $V_L =$ Volts

CALIBRATION

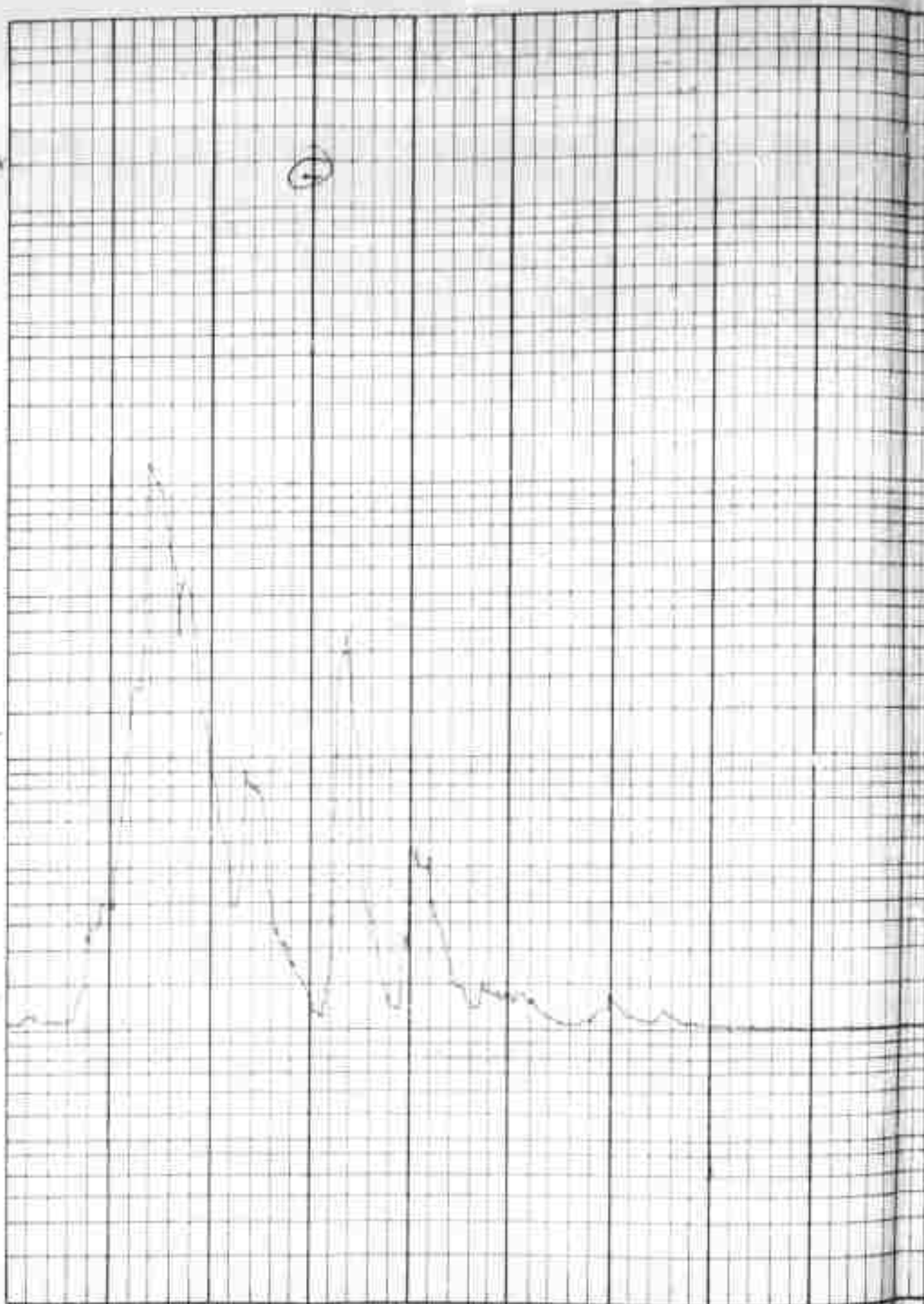
Tape No. 16	Tape Channel 1	Data Tape RMS Volt $V_R =$ 8
Calibration Voltage $V_a = .5$ V_{rms} Into Line Amp.; $V_c = .5$ V_{rms} on Tape 260 cps		
Line Amplifier Settings For Calibration $G_c = .1$; for Data $G_d = .1$		
Lab. Gain $LG =$ 1	Tape Monitor Gain $TMG = \frac{G_d}{G_c} =$ 1	
Displacement Pickup Sensitivity $S = .0708$ in./Volt		
Equivalent of Calibration - In. $D_c = V_a \cdot S = (.5)(.0708) = .0354$		
Equivalent of Calibration for PSD Plots $\left(\frac{D_c}{(TMG)(LG)} \right)^2 = \left[\frac{.0354}{1 \times 1} \right]^2 = 1.25 \times 10^{-2}$ in. ² /cps		
Analyzer Attenuator Setting -10 db	Log Converter Setting db	
Calibration Plotted at 1.25×10^{-2} in. ² /cps		
Overall Deflection Level of Data RMS Defl. Level = $\frac{(D_c)(V_R)}{(TMG)(LG)(V_c)} =$ = _____ = psi		

2

CALC	RFS	7/1/63	REVISED	DATE	POWER SPECTRAL DENSITY ANALYSIS OF DISPLACEMENT PICKUP 1478 P/U 1 THE BOEING COMPANY SEATTLE 28, WASHINGTON	VOL I
CHECK	LDS	10-3				DZ 80084
APR.						PAGE
APR						FIG 123

POWER SPECTRAL DENSITY - $(\text{in.})^2/\text{cps}$

2 3 4 5 6 7 8 9 10 2 3 4 5 6 7 8 9 10 2 3 4 5 6 7 8 9 10 2 3 4 5



100

200

300

FREQUENCY - CPS

400

500

1

ANALYSIS VARIABLES

Bandwidth

5 cycles from 50 to 550 cps

— cycles from — to — cps

— cycles from — to — cps

T_c 4 Sec.

Anal. Rate 1.25 cps/sec.

Loop Length 4 Sec.

DATA IDENTIFICATION

Test Title PANEL ATTACH TYPE I PRELIM.		
EWA No. 5522-1	Panel or Specimen No. 1478	
Tape No. 16	Tape Channel 5	Displacement Pickup 5
Elapsed Test Time		P/U RMS Level at Sonic Lab. $V_L =$ Volts

CALIBRATION

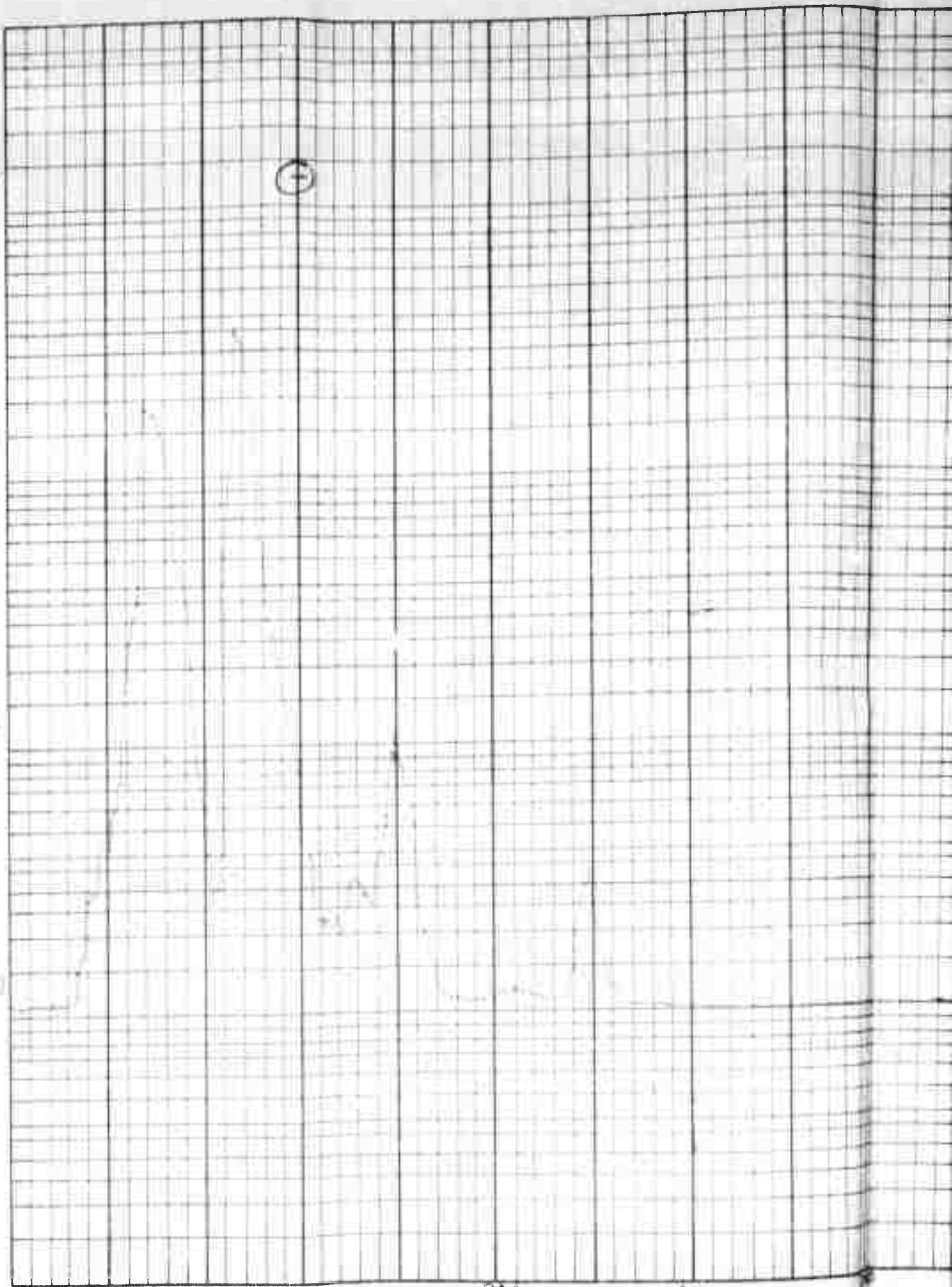
Tape No. 16	Tape Channel 1	Data Tape RMS Volt $V_R = 0.175$
Calibration Voltage $V_a = .5$ V_{rms} Into Line Amp.; $V_c = .5$ V_{rms} on Tape 200 cps		
Line Amplifier Settings For Calibration $G_c = .1$; for Data $G_d = .1$		
Lab. Gain LG = 1	Tape Monitor Gain $TMG = \frac{G_d}{G_c} = 1$	
Displacement Pickup Sensitivity $S = .0708$ in./Volt		
Equivalent of Calibration - in. $D_c = V_a \cdot S = (.5)(.0708) = .0354$		
Equivalent of Calibration for PSD Plots $\left(\frac{D_c}{(TMG)(LG)} \right)^2 = \left[\frac{.0354}{1 \times 1} \right]^2 = 1.25 \times 10^{-3}$ in. ² /cps		
Analyzer Attenuator Setting -10 db	Log Converter Setting db	
Calibration Plotted at 1.25×10^{-3} in. ² /cps		
Overall Deflection Level of Data $RMS\ Defl.\ Level = \frac{(D_c)(V_R)}{(TMG)(LG)(V_c)} =$ $=$ psi		

2

CALC	RIS	9/26/53	REVISED	DATE	POWER SPECTRAL DENSITY ANALYSIS OF DISPLACEMENT PICKUP	VOL I
CHECK	RDS	10-2-53				DZ-80054
APR.					1478 P/U 5	
APR					THE BOEING COMPANY SEATTLE 24, WASHINGTON	PAGE FIG 12A

POWER SPECTRAL DENSITY - $(\ln.)^2 / \text{cps}$

1 2 3 4 5 6 7 8 9 10 2 3 4 5 6 7 8 9 10 2 3 4 5 6 7 8 9 10 2 3 4 5 6 7 8 9 10



100

200

300

400

FREQUENCY - CPS

1

ANALYSIS VARIABLES

Bandwidth

5 cycles from 50 to 550 cps

— cycles from — to — cps

— cycles from — to — cps

T_a 4 Sec.

Anal. Rate 1.25 cps/sec.

Loop Length 4 Sec.

DATA IDENTIFICATION

Test Title PANEL ATTACH. TYPE I PRELIM.		
EWA No. 5533-1	Panel or Specimen No. 1478	
Tape No. 16	Tape Channel 6	Displacement Pickup 6
Elapsed Test Time		P/U RMS Level at Sonic Lab. $V_L =$ Volts

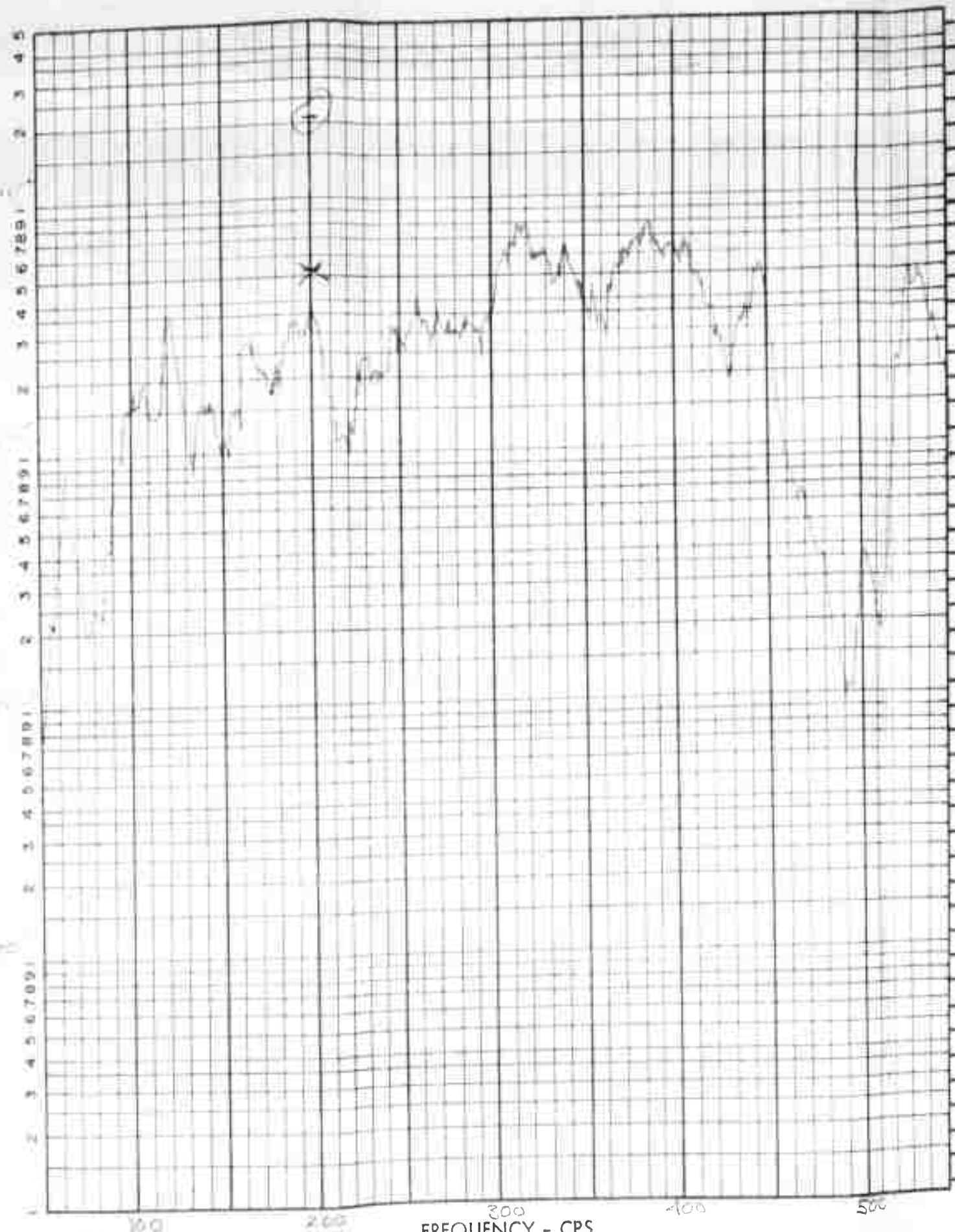
CALIBRATION

Tape No. 16	Tape Channel 1	Data Tape RMS Volt $V_R = 0.260$
Calibration Voltage $V_a = .5 V_{rms}$ Into Line Amp.; $V_c = .5 V_{rms}$ on Tape 20 cps		
Line Amplifier Settings For Calibration $G_c = .1$; for Data $G_d = .1$		
Lab. Gain LG = 1	Tape Monitor Gain $TMG = \frac{G_d}{G_c} = 1$	
Displacement Pickup Sensitivity $S = .0708 \text{ in./Volt}$		
Equivalent of Calibration - in. $D_c = V_a \cdot S = (.5)(.0708) = .0354$		
Equivalent of Calibration for PSD Plots $\left(\frac{D_c}{(TMG)(LG)} \right)^2 = \left[\frac{.0354}{1 \times 1} \right] \cdot 1.25 \times 10^{-3} \text{ in.}^2/\text{cps}$		
Analyzer Attenuator Setting - 10 db	Log Converter Setting db	
Calibration Plotted at $1.0 \times 10^{-3} \text{ in.}^2/\text{cps}$		
Overall Deflection Level of Data $\text{RMS Defl. Level} = \frac{(D_c)(V_R)}{(TMG)(LG)(V_c)} =$ $=$ psi		

2

CALC	RFS	9/26/64	REVISED	DATE	POWER SPECTRAL DENSITY ANALYSIS OF DISPLACEMENT PICKUP 1478 P/U 6 THE BOEING COMPANY SEATTLE 28, WASHINGTON	VOL I
CHECK	RFS	10/23				D2-80084
APR.						PAGE
APR.						FIG 125

POWER SPECTRAL DENSITY - (psi)² / cps



FREQUENCY - CPS

ANALYSIS VARIABLES

Bandwidth

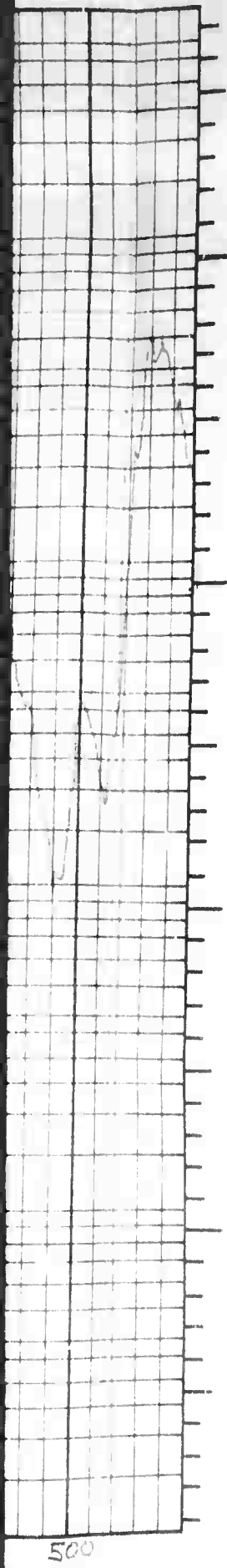
5 cycles from 50 to 550 cps
 — cycles from — to — cps
 — cycles from — to — cps

T_c 4 Sec.

Anal. Rate 1.25 cps/Sec.

Loop Length 4 Sec.

1



SPECTRUM LEVEL - DECIBELS (Re 0.0002 Microbar)

2

DATA IDENTIFICATION

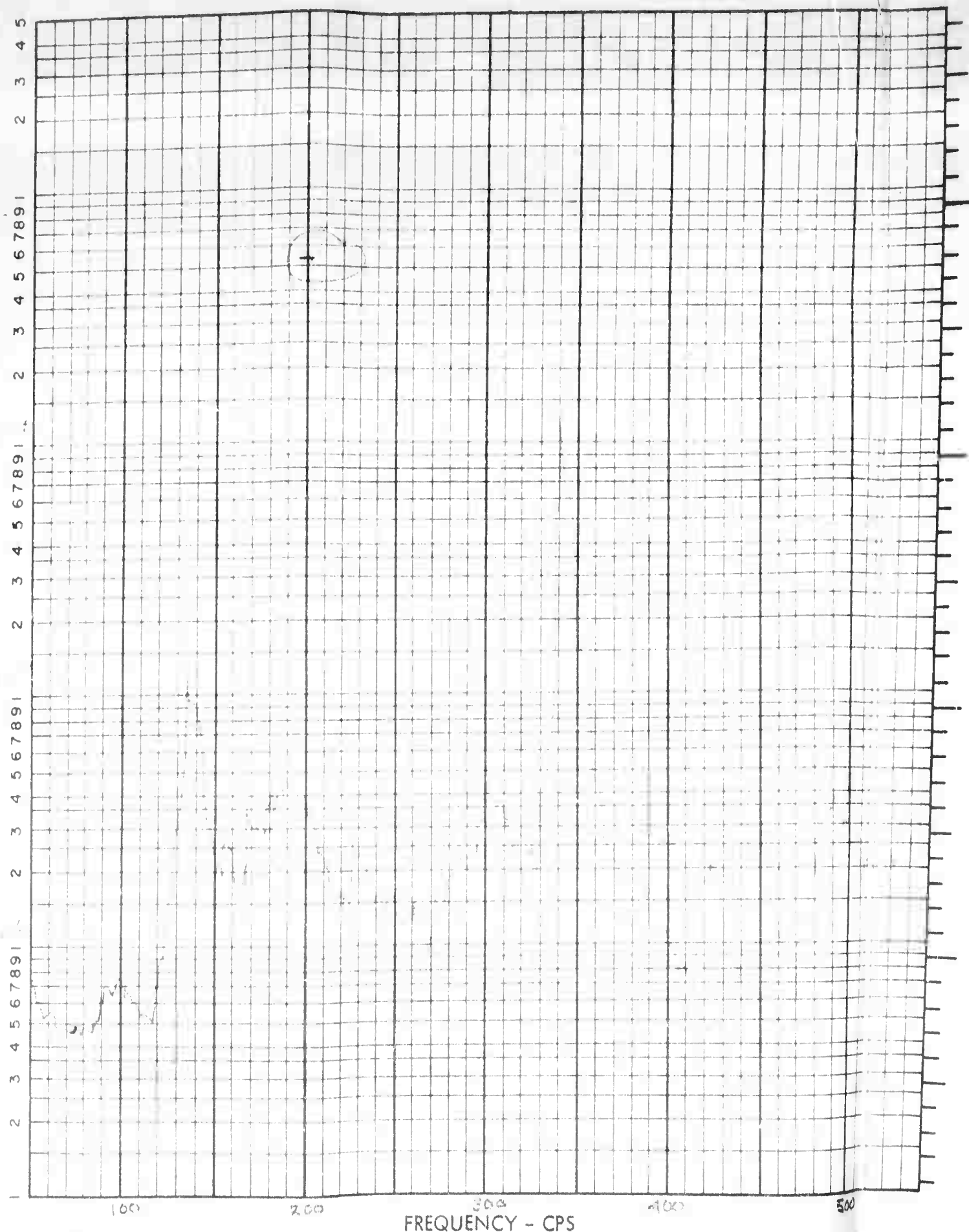
Test Title PANEL ATTACH. TYPE I PRELIM		
EWA No. 5533-1		Panel or Specimen No. 1478
Tape No. 17	Tape Channel 2	Mic. No. 1
Elapsed Test Time		Mic. RMS Level at Sonic Lab. V _L = Volts

CALIBRATION

Tape No. 17	Tape Channel 1	Data Tape RMS Volt V _R = 0.440
Calibration Voltage V _a = .5 V _{rms} into Line Amp.; V _c = .5 V _{rms} on Tape @ 100 cps		
Line Amplifier Settings For Calibration G _c = .1 ; for Data G _d = .1		
Lab. Gain LG = 1	Tape Monitor Gain TMG = $\frac{G_d}{G_c}$ = 1	
Microphone Sensitivity S = .200 psi/Volt or 1 Volt rms = 160 db SPL		
Equivalent of Calibration - psi P _c = V _a · S = .5(1.200) = .145		
Equivalent of Calibration for PSD Plots $\left(\frac{P_c}{(TMG)(LG)} \right)^2 = \left[\frac{.145}{1 \times 1} \right]^2 = 2.10 \times 10^{-2}$ psi ² /cps		
Analyzer Attenuator Setting -20 db	Log Converter Setting db	
Calibration Plotted at 2.10 × 10 ⁻² psi ² /cps		
Overall Pressure Level Data RMS pressure Level (P _c)(V _R) $\frac{(TMG)(LG)(V_c)}{}$		Equiv. to db SPL
= _____ =		psi

CALC	1	2	REVISED	DATE	POWER SPECTRAL DENSITY ANALYSIS OF MICROPHONE OUTPUT 1478 M 4 1 THE BOEING COMPANY	V _c = 1
CHECK	0.1	0.1				02 80004
APR.						PAGE
APR.						Fig 126

POWER SPECTRAL DENSITY - (psi)² / cps



FREQUENCY - CPS

1

ANALYSIS VARIABLES

Bandwidth

5 cycles from 50 to 550 cps
 cycles from ___ to ___ cps
 cycles from ___ to ___ cps

T_c 4 Sec.
 Anal. Rate 1.25 cps/Sec.
 Loop Length 4 Sec.

CALC	
CHECK	
APR	
APR	

DATA IDENTIFICATION

Test Title PANEL ATTACH TYPE I PRELIM		
EWA No. 5502-1	Panel or Specimen No. 1478	
Tape No. 17	Tape Channel 3	Mic. No. 2
Elapsed Test Time		Mic. RMS Level at Sonic Lab. V _L = Volts

CALIBRATION

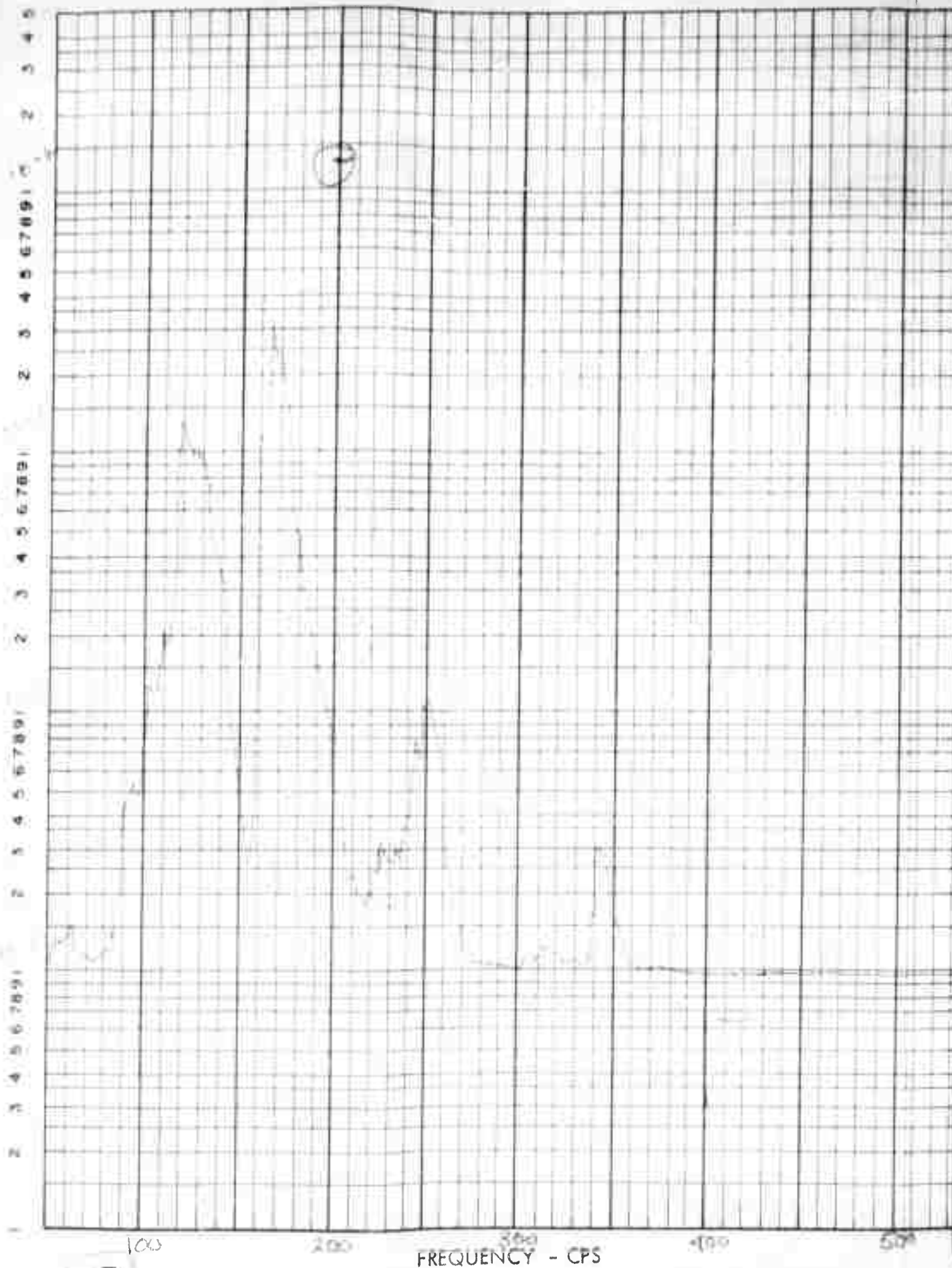
Tape No. 17	Tape Channel 1	Data Tape RMS Volt V _R = 0.390
Calibration Voltage V _a = .5 V _{rms} into Line Amp.; V _c = .5 V _{rms} on Tape @ 200 cps		
Line Amplifier Settings For Calibration G _c = ; for Data G _d =		
Lab. Gain LG = 1	Tape Monitor Gain TMG = $\frac{G_d}{G_c} = 2$	
Microphone Sensitivity S = 290 psi/Volt or 1 Volt rms = 160 db SPL		
Equivalent of Calibration - psi P _c = V _a · S = .5 · 160 = .145		
Equivalent of Calibration for PSD Plots $\left(\frac{P_c}{(TMG)(LG)} \right)^2 = \left[\frac{.145}{2 \times 1} \right]^2 = 5.26 \times 10^{-3}$ psi ² /cps		
Analyzer Attenuator Setting -10 db	Log Converter Setting db	
Calibration Plotted at 5.26 × 10 ⁻³		psi ² /cps
Overall Pressure Level Data RMS pressure Level (P _c) (V _R) $\frac{(P_c)(V_R)}{(TMG)(LG)(V_c)}$	Equiv. to db SPL	
= = psi		

SPECTRUM LEVEL - DECIBELS (Re 0.0002 Microbar)

2

CALC	REVISED	DATE	POWER SPECTRAL DENSITY ANALYSIS OF MICROPHONE OUTPUT THE BOEING COMPANY	PAGE Fg 121
CHECK				
APP				
APP				

POWER SPECTRAL DENSITY - $(\text{in.})^2/\text{cps}$



1

FREQUENCY - CPS

ANALYSIS VARIABLES

Bandwidth
5 cycles from 50 to 550 cps
 — cycles from — to — cps
 — cycles from — to — cps

T_c 4 Sec.
 Anal. Rate 1.25 cps/sec.
 Loop Length 4 Sec.

DATA IDENTIFICATION

Test Title PANEL ATTACH TYPE I PRELIM		
EWA No. 5503	Panel or Specimen No. 1478	
Tape No. 17	Tape Channel 4	Displacement Pickup 1
Elapsed Test Time		P/U RMS Level at Sonic Lab. $V_L =$ Volts

CALIBRATION

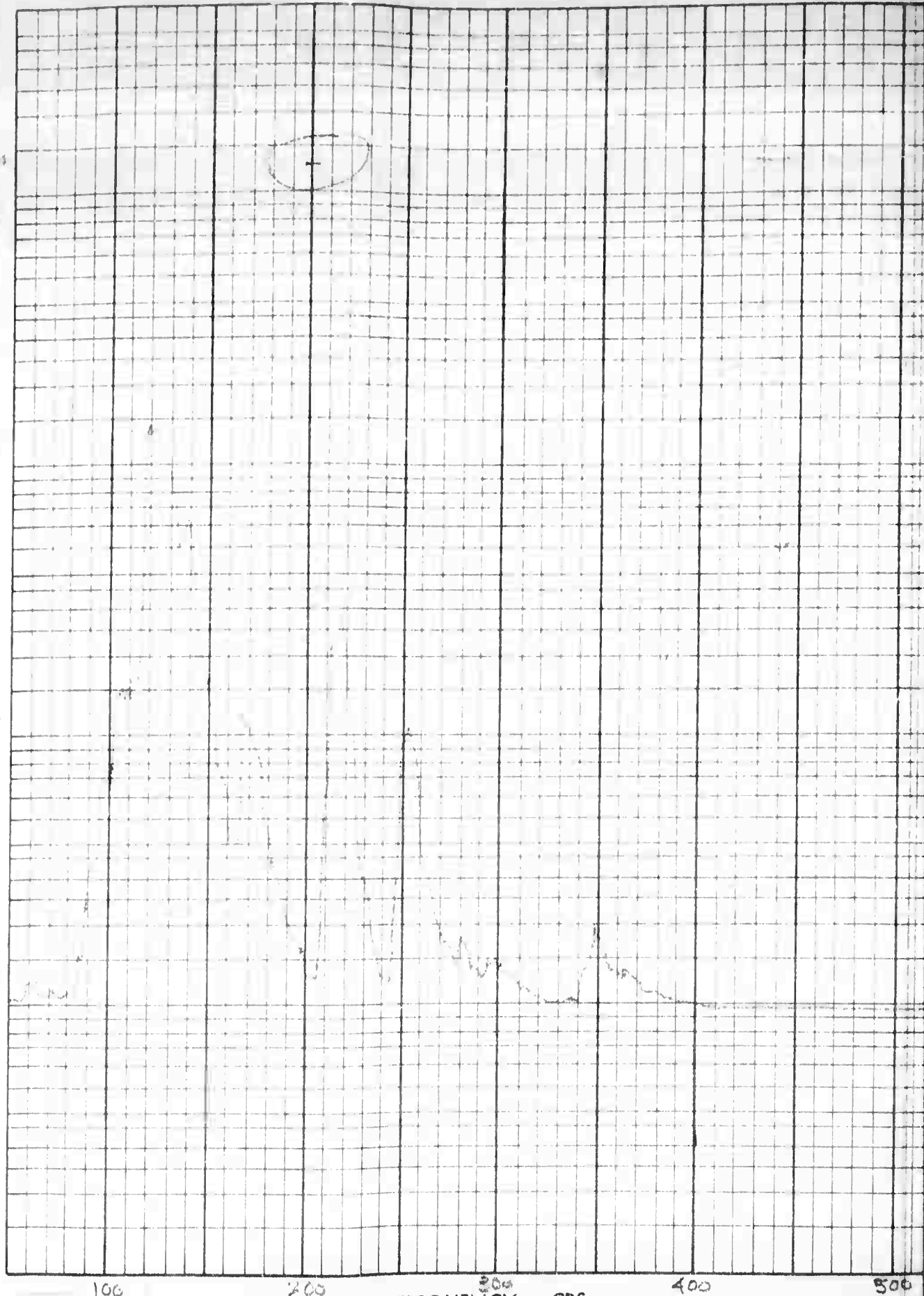
Tape No.	Tape Channel	Data Tape RMS Volt $V_R = .26$
Calibration Voltage $V_a = 5$ V _{rms} Into Line Amp.; $V_c = .5$ V _{rms} on Tape 200ps		
Line Amplifier Settings For Calibration $G_c = .1$; for Data $G_d = .1$		
Lab. Gain LG = 1	Tape Monitor Gain $TMG = \frac{G_d}{G_c} = 1$	
Displacement Pickup Sensitivity $S = .0708$ in./Volt		
Equivalent of Calibration - in. $D_c = V_a \cdot S = (.5)(.0708) = .0354$		
Equivalent of Calibration for PSD Plots $\left(\frac{D_c}{(TMG)(LG)} \right)^2 = \left[\frac{.0354}{(.1)(1)} \right]^2 = 1.25 \times 10^{-3}$ in. ² /cps		
Analyzer Attenuator Setting -10 db	Log Converter Setting db	
Calibration Plotted at 1.25×10^{-3} in. ² /cps		
Overall Deflection Level of Data RMS Defl. Level = $\frac{(D_c)(V_R)}{(TMG)(LG)(V_c)} =$ = _____ = psi		

2

CALC	RFS	7/26/60	REVISED	DATE	POWER SPECTRAL DENSITY ANALYSIS OF DISPLACEMENT PICKUP 1478 P/U 1 THE BOEING COMPANY SEATTLE 24, WASHINGTON	Vol I
CHECK	RFS	10-23				D2-80084
APR.						PAGE
APR.						FIG 128

POWER SPECTRAL DENSITY - $(\text{in.})^2 / \text{cps}$

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100



100

200

300

400

500

FREQUENCY - CPS

ANALYSIS VARIABLES

Bandwidth

5 cycles from 50 to 550 cps
— cycles from — to — cps
— cycles from — to — cps

4 Sec.

Anal. Rate 1.25 cps/sec.

Loop Length 4 Sec.

DATA IDENTIFICATION

Test Title PANEL ATTACH TYPE I PRELIM		
EWA No. 5593-1	Panel or Specimen No. 1478	
Tape No. 17	Tape Channel 5	Displacement Pickup 5
Elapsed Test Time		P/U RMS Level at Sonic Lab. $V_L =$ Volts

CALIBRATION

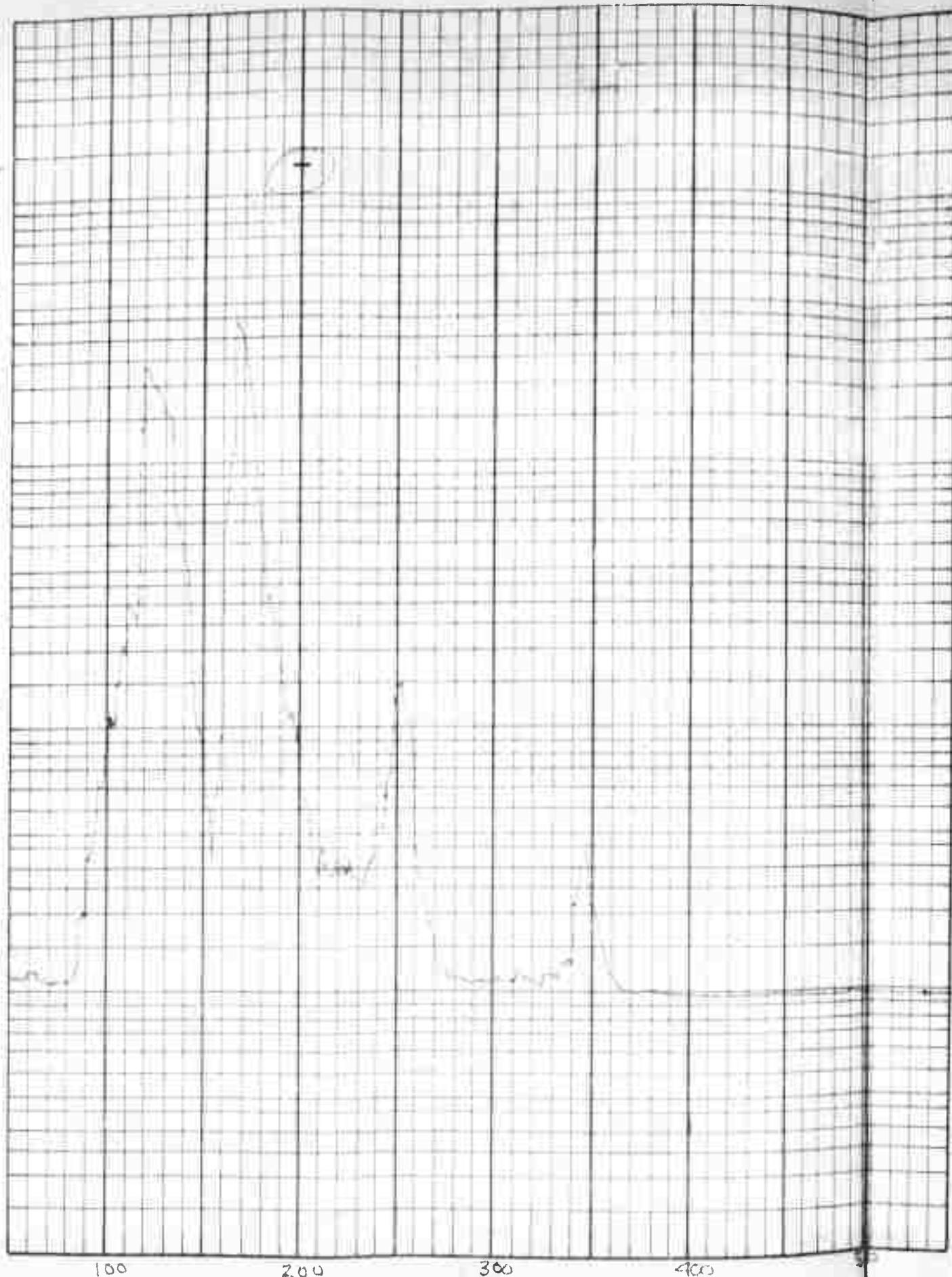
Tape No. 17	Tape Channel 1	Data Tape RMS Volt $V_R = 0.197$
Calibration Voltage $V_a = .5$ V_{rms} Into Line Amp.; $V_c = .5$ V_{rms} on Tape 200cps		
Line Amplifier Settings For Calibration $G_c = .1$; for Data $G_d = .1$		
Lab. Gain LG = 1	Tape Monitor Gain $TMG = \frac{G_d}{G_c} = 1$	
Displacement Pickup Sensitivity $S = .0708$ in./Volt		
Equivalent of Calibration - in. $D_c = V_a \cdot S = (.5)(.0708) = 0.0354$		
Equivalent of Calibration for PSD Plots $\left(\frac{D_c}{(TMG)(LG)} \right)^2 = \left[\frac{.0354}{1 \times 1} \right]^2 = 1.25 \times 10^{-3}$ in. ² /cps		
Analyzer Attenuator Setting -10 db	Log Converter Setting db	
Calibration Plotted at 1.25×10^{-3} in. ² /cps		
Overall Deflection Level of Data $RMS\ Defl.\ Level = \frac{(D_c)(V_R)}{(TMG)(LG)(V_c)} =$ $=$ psl		

2

CALC	RFS	7/6/62	REVISED	DATE	POWER SPECTRAL DENSITY ANALYSIS OF DISPLACEMENT PICKUP 1478 P/U 5 THE BOEING COMPANY SEATTLE 24, WASHINGTON	Vol I
CHECK	RFS	10-23				D2-80084
APR.						PAGE
APR						FIG 129

POWER SPECTRAL DENSITY - (in.)²/cps

1 2 3 4 5 6 7 8 9 10 11 12 13 14 15 16 17 18 19 20 21 22 23 24 25 26 27 28 29 30 31 32 33 34 35 36 37 38 39 40 41 42 43 44 45 46 47 48 49 50 51 52 53 54 55 56 57 58 59 60 61 62 63 64 65 66 67 68 69 70 71 72 73 74 75 76 77 78 79 80 81 82 83 84 85 86 87 88 89 90 91 92 93 94 95 96 97 98 99 100



1

FREQUENCY - CPS

ANALYSIS VARIABLES

Bandwidth

5 cycles from 50 to 550 cps
 — cycles from — to — cps
 — cycles from — to — cps

4 Sec.

Anal. Rate 1.25 cps/sec.

Loop Length 4 Sec.

DATA IDENTIFICATION

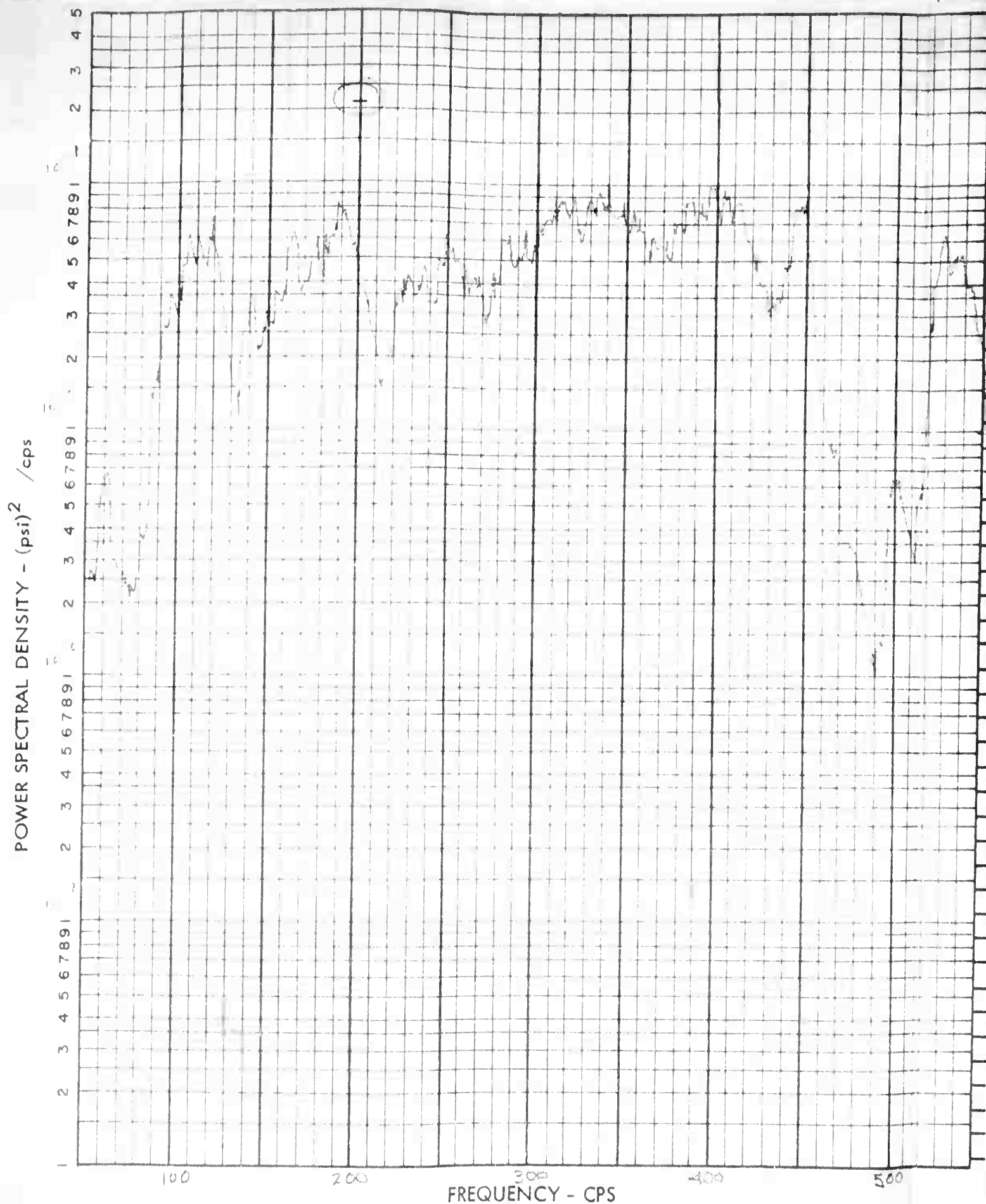
Test Title PANEL ATTACH TYPE I PRELIM		
EWA No. 5593-1	Panel or Specimen No. 1478	
Tape No. 17	Tape Channel 6	Displacement Pickup # 6
Elapsed Test Time		P/U RMS Level at Sonic Lab. $V_L =$ Volts

CALIBRATION

Tape No. 17	Tape Channel 1	Data Tape RMS Volt $V_R = .285$
Calibration Voltage $V_a = .5$ V_{rms} Into Line Amp.; $V_c = .5$ V_{rms} on Tape 200cps		
Line Amplifier Settings For Calibration $G_c = .1$; for Data $G_d = .1$		
Lab. Gain LG = 1	Tape Monitor Gain $TMG = \frac{G_d}{G_c} = 1$	
Displacement Pickup Sensitivity $S = .0708$ in./Volt		
Equivalent of Calibration - In. $D_c = V_a \cdot S = (.5)(.0708) = .0354$		
Equivalent of Calibration for PSD Plots $\left(\frac{D_c}{(TMG)(LG)} \right)^2 = \left[\frac{.0354}{1 \times 1} \right]^2 = 1.25 \times 10^{-3}$ in. ² /cps		
Analyzer Attenuator Setting -10 db	Log Converter Setting db	
Calibration Plotted at		in. ² /cps
Overall Deflection Level of Data RMS Defl. Level = $\frac{(D_c)(V_R)}{(TMG)(LG)(V_c)} =$ = = psi		

2

CALC	RFS	9/1/63	REVISED	DATE	POWER SPECTRAL DENSITY ANALYSIS OF DISPLACEMENT PICKUP 1478 P/U 6 THE BOEING COMPANY SEATTLE 24, WASHINGTON	Vol I
CHECK	LDS	10/6/63				12-80084
APR.						PAGE
APR						FIG 130



ANALYSIS VARIABLES

Bandwidth

5 cycles from 50 to 550 cps
cycles from to cps
cycles from to cps

T_c 4 Sec.
Anal. Rate 125 cps/Sec.
Loop Length 4 Sec.

CAL
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APR
APR

DATA IDENTIFICATION

Test Title PANEL ATTACH TYPE I PRELIM		
EWA No. 5503-1		Panel or Specimen No. 1477
Tape No. 18	Tape Channel 2	Mic. No. 1
Elapsed Test Time		Mic. RMS Level at Sonic Lab. V _L = Volts

CALIBRATION

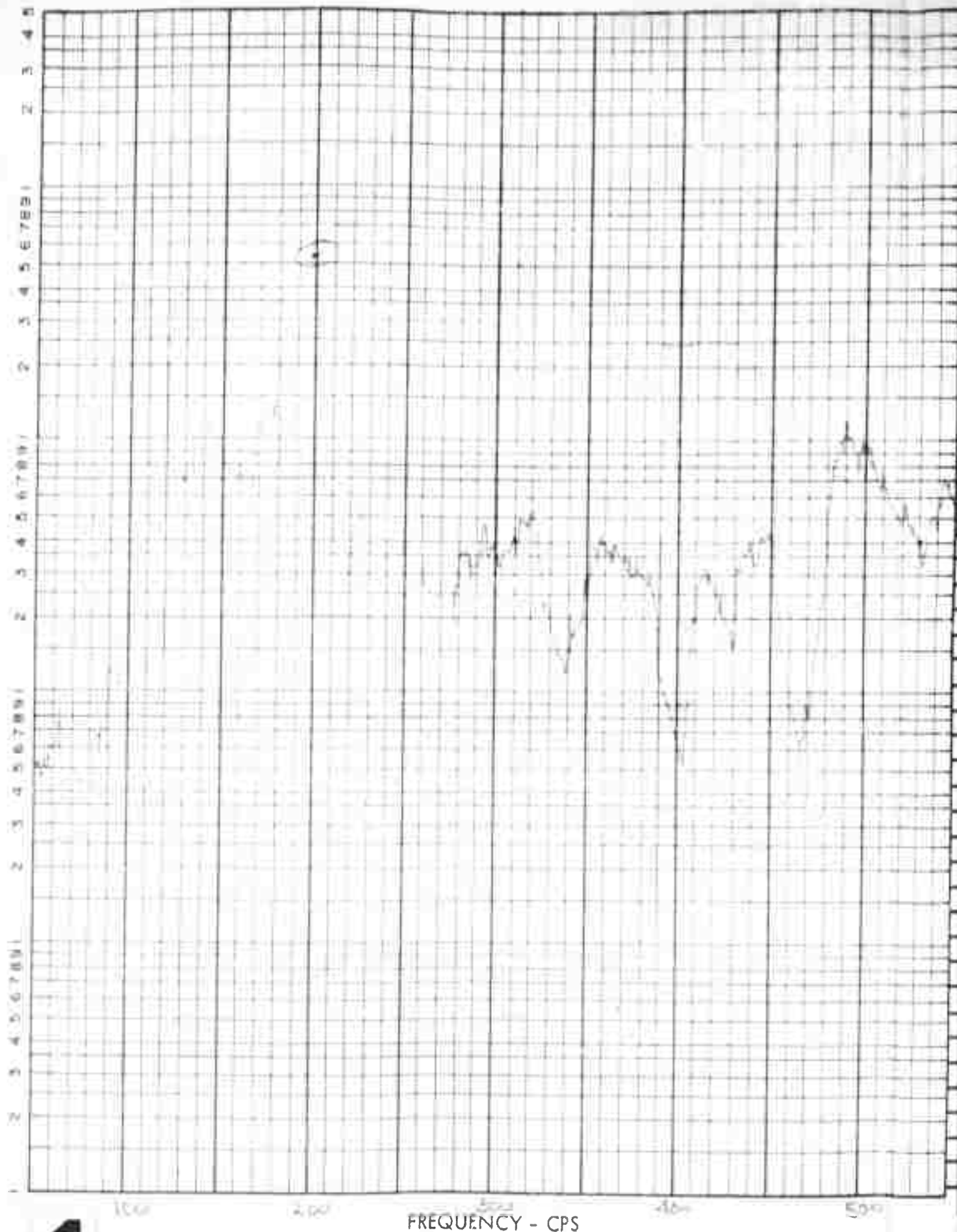
Tape No. 18	Tape Channel 1	Data Tape RMS Volt V _R = . . .
Calibration Voltage V _a = .5 V _{rms} into Line Amp.; V _c = .5 V _{rms} on Tape @ 200 cps		
Line Amplifier Settings For Calibration G _c = .1 ; for Data G _d = .1		
Lab. Gain LG = 1	Tape Monitor Gain TMG = $\frac{G_d}{G_c} = 1$	
Microphone Sensitivity S = 290 psi/Volt or 1 Volt rms = 160 db SPL		
Equivalent of Calibration - psi P _c = V _a · S = (.5)(290) = .145		
Equivalent of Calibration for PSD Plots $\left(\frac{P_c}{(TMG)(LG)} \right)^2 = \left[\frac{.145}{1 \times 1} \right]^2 = 2.10 \times 10^{-2}$ psi ² /cps		
Analyzer Attenuator Setting -20 db	Log Converter Setting db	
Calibration Plotted at 2.10 x 10 ⁻⁴		psi ² /cps
Overall Pressure Level Data RMS pressure Level	(P _c)(V _R) $\frac{(TMG)(LG)(V_c)}{}$	Equiv. to db SPL
		psi

SPECTRUM LEVEL - DECIBELS (Re 0.0002 Microbar)

2

CALC	RCS	9/2/63	REVISED	DATE	POWER SPECTRAL DENSITY ANALYSIS OF MICROPHONE OUTPUT 1477 Mic 1 THE BOEING COMPANY	Vol I
CHECK	WPS	10-23				D2-80084
APR.						PAGE
APR						FIG 131

POWER SPECTRAL DENSITY - (psi)² / cps



1

FREQUENCY - CPS

ANALYSIS VARIABLES

Bandwidth

5 cycles from 50 to 550 cps
 — cycles from — to — cps
 — cycles from — to — cps

T_c 4 Sec.

Anal. Rate 1.25 cps/Sec.

Loop Length 4 Sec.

DATA IDENTIFICATION

Test Title FAEL ATTN 4 TYPE I FREQU		
EWA No. 5595-1		Panel or Specimen No. 1477
Tape No. 18	Tape Channel 3	Mic. No. 2
Elapsed Test Time		Mic. RMS Level at Sonic Lab. V _L = Volts

CALIBRATION

Tape No. 5	Tape Channel 1	Data Tape RMS Volt V _R = 0.445
Calibration Voltage V _a = 5 V _{rms} into Line Amp.; V _c = .5 V _{rms} on Tape @ 220 cps		
Line Amplifier Settings For Calibration G _c = 1 ; for Data G _d = 1		
Lab. Gain LG = 1	Tape Monitor Gain TMG = $\frac{G_d}{G_c}$ = 1	
Microphone Sensitivity S = 270 psi/Volt or 1 Volt rms = 160 db SPL		
Equivalent of Calibration - psi P _c = V _a · S = 5 · 270 = 1350		
Equivalent of Calibration for PSD Plots $\left(\frac{P_c}{(TMG)(LG)} \right)^2 = \left[\frac{1350}{(1)(1)} \right]^2 = 1822500$ psi ² /cps		
Analyzer Attenuator Setting -20 db	Log Converter Setting db	
Calibration Plotted at		psi ² /cps
Overall Pressure Level Data RMS pressure Level (P _c) (V _R) $\frac{(P_c)(V_R)}{(TMG)(LG)(V_c)}$		Equiv. to db SPL
		psi

SPECTRUM LEVEL - DECIBELS (Re 0.0002 Microbar)

2

CALC			REVISED	DATE	POWER SPECTRAL DENSITY ANALYSIS OF MICROPHONE OUTPUT 1477 MIC 2 THE BOEING COMPANY	V. I.
CHECK	11/25	10-2-5				DE 80054
APR.						PAGE
APR						FIG 13

POWER SPECTRAL DENSITY - $(\text{in.})^2/\text{cps}$

5 4 3 2 1 0 0 1 2 3 4 5 6 7 8 9 10



100

FREQUENCY - CPS

400

500

ANALYSIS VARIABLES

Bandwidth

5 cycles from 50 to 550 cps

— cycles from — to — cps

— cycles from — to — cps

T_c 4 Sec.

Anal. Rate 1.25 cps/sec.

Loop Length 9 Sec.

1

DATA IDENTIFICATION

Test Title PANEL ATTACH. TYPE I PRELIM		
EWA No. 5598-1	Panel or Specimen No. 1477	
Tape No. 18	Tape Channel 4	Displacement Pickup 1
Elapsed Test Time		P/U RMS Level at Sonic Lab. $V_L =$ Volts

CALIBRATION

Tape No. 18	Tape Channel 1	Data Tape RMS Volt $V_R = 0.500$
Calibration Voltage $V_a = .5 V_{rms}$ Into Line Amp.; $V_c = .5 V_{rms}$ on Tape 20 cps		
Line Amplifier Settings For Calibration $G_c = .1$; for Data $G_d = .2$		
Lab. Gain LG = 1	Tape Monitor Gain $TMG = \frac{G_d}{G_c} = 2$	
Displacement Pickup Sensitivity $S = 0.708 \text{ in./Volt}$		
Equivalent of Calibration - in. $D_c = V_a \cdot S = (.5)(.0708) = .0354$		
Equivalent of Calibration for PSD Plots $\left(\frac{D_c}{(TMG)(LG)} \right)^2 = \left[\frac{.0354}{2 \times 1} \right]^2 = 3.14 \times 10^{-4} \text{ in.}^2/\text{cps}$		
Analyzer Attenuator Setting 0 db	Log Converter Setting db	
Calibration Plotted at $1.4 \times 10^{-4} \text{ in.}^2/\text{cps}$		
Overall Deflection Level of Data $\text{RMS Defl. Level} = \frac{(D_c)(V_R)}{(TMG)(LG)(V_c)} =$ $=$ psi		

2

CALC	RES	9/16/53	REVISED	DATE	POWER SPECTRAL DENSITY ANALYSIS OF DISPLACEMENT PICKUP . 1477 P/U 1 THE BOEING COMPANY SEATTLE 24, WASHINGTON	VOL I
CHECK	RDS	10-2-53				D2-80084
APR.						PAGE
APR						FIG 133

POWER SPECTRAL DENSITY - (in.)²/cps



FREQUENCY - CPS

ANALYSIS VARIABLES

Bandwidth

5 cycles from 50 to 550 cps
— cycles from — to — cps
— cycles from — to — cps

T_c 4 Sec.

Anal. Rate 1.25 cps/sec.

Loop Length 9 Sec.

DATA IDENTIFICATION

Test Title TAPE ATTACH TYPE I PRELIM		
EWA No. 5592-1	Panel or Specimen No. 1417	
Tape No. 18	Tape Channel 5	Displacement Pickup # 5
Elapsed Test Time		P/U RMS Level at Sonic Lab. $V_L =$ Volts

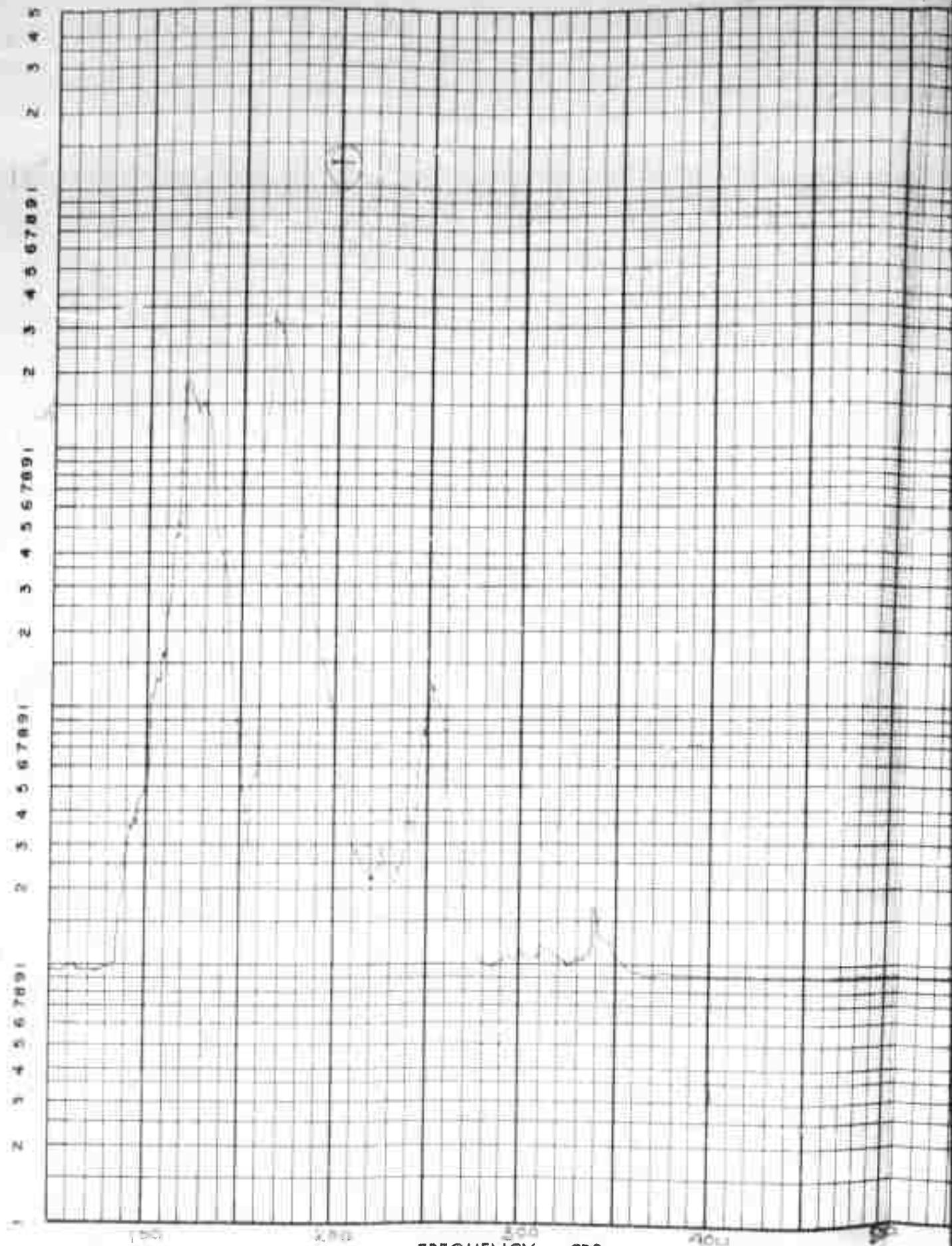
CALIBRATION

Tape No.	Tape Channel	Data Tape RMS Volt $V_R =$
Calibration Voltage $V_a = .5$ V_{rms} Into Line Amp.; $V_c = .5$ V_{rms} on Tape, 200cps		
Line Amplifier Settings For Calibration $G_c = .1$; for Data $G_d = .1$		
Lab. Gain $LG = 1$	Tape Monitor Gain $TMG = \frac{G_d}{G_c} = 1$	
Displacement Pickup Sensitivity $S = .0708$ in./Volt		
Equivalent of Calibration - in. $D_c = V_a \cdot S = .0354$		
Equivalent of Calibration for PSD Plots $\left(\frac{D_c}{(TMG)(LG)} \right)^2 = \left[\frac{.0354}{(1)(1)} \right]^2 = 1.25 \times 10^{-3}$ in. ² /cps		
Analyzer Attenuator Setting -10 db	Log Converter Setting db	
Calibration Plotted at 10.2.3 4 in. ² /cps		
Overall Deflection Level of Data $RMS\ Defl.\ Level = \frac{(D_c)(V_R)}{(TMG)(LG)(V_c)} =$ $=$ psi		

2

CALC	2.5.2	9/10/63	REVISED	DATE	POWER SPECTRAL DENSITY ANALYSIS OF DISPLACEMENT PICKUP	Vol I
CHECK	PDS	10-2-3			1417 P105	D2-81084
APR.					THE BOEING COMPANY	PAGE
APR.					SEATTLE 24, WASHINGTON	FIG 134

POWER SPECTRAL DENSITY - $(\text{in.})^2 / \text{cps}$



FREQUENCY - CPS

ANALYSIS VARIABLES

Bandwidth

5 cycles from 50 to 550 cps
 — cycles from — to — cps
 — cycles from — to — cps

T_c 4 Sec.
 Anal. Rate 1.25 cps/sec.
 Loop Length 4 Sec.

DATA IDENTIFICATION

Test Title PANEL ATTACH TYPE I PRELIM		
EWA No. 5593-1	Panel or Specimen No. 1477	
Tape No. 18	Tape Channel 6	Displacement Pickup # 6
Elapsed Test Time		P/U RMS Level at Sonic Lab. $V_L =$ Volts

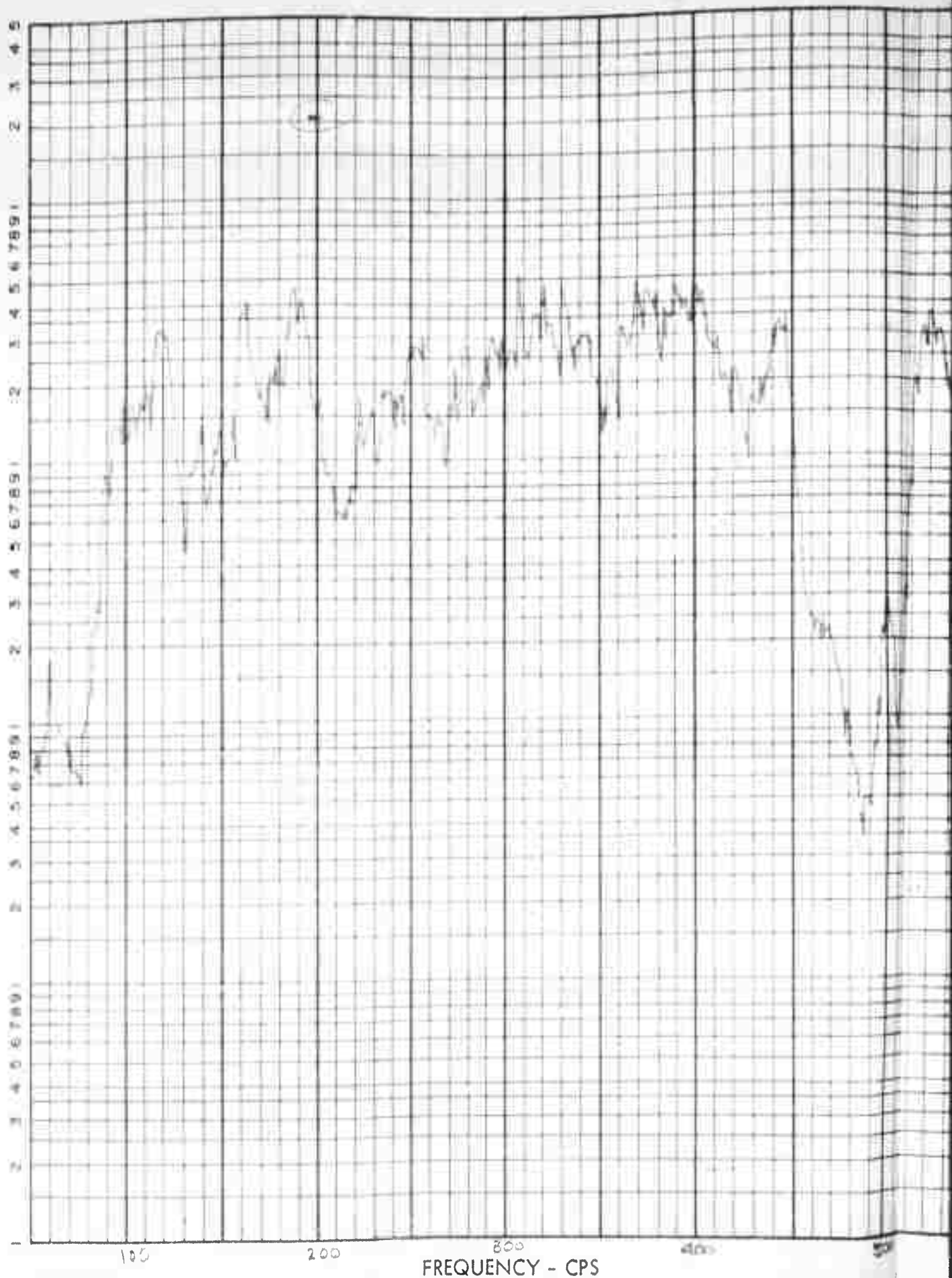
CALIBRATION

Tape No. 18	Tape Channel	Data Tape RMS Volt $V_R =$
Calibration Voltage $V_a = .5$ V_{rms} Into Line Amp.; $V_c = .5$ V_{rms} on Tape 200 cps		
Line Amplifier Settings For Calibration $G_c = .1$; for Data $G_d = .1$		
Lab. Gain $LG = 1$	Tape Monitor Gain $TMG = \frac{G_d}{G_c} = 1$	
Displacement Pickup Sensitivity $S = .0708$ in./Volt		
Equivalent of Calibration - in. $D_c = V_a \cdot S = (.5)(.0708) = .0354$		
Equivalent of Calibration for PSD Plots $\left(\frac{D_c}{(TMG)(LG)} \right)^2 = \left[\frac{.0354}{1 \times 1} \right]^2 = 1.25 \times 10^{-3}$ in. ² /cps		
Analyzer Attenuator Setting db	Log Converter Setting db	
Calibration Plotted at in. ² /cps		
Overall Deflection Level of Data RMS Defl. Level = $\frac{(D_c)(V_R)}{(TMG)(LG)(V_c)}$ = _____ = psi		

2

CALC	RT	REVISED	DATE	POWER SPECTRAL DENSITY ANALYSIS OF DISPLACEMENT PICKUP 1477 P/U 6	VOL I
CHECK	RDS	10-2-3			D2-80084
APR.					
APR.					
				THE BOEING COMPANY SEATTLE 24, WASHINGTON	PAGE FIG 135

POWER SPECTRAL DENSITY - $(\text{psi})^2 / \text{cps}$



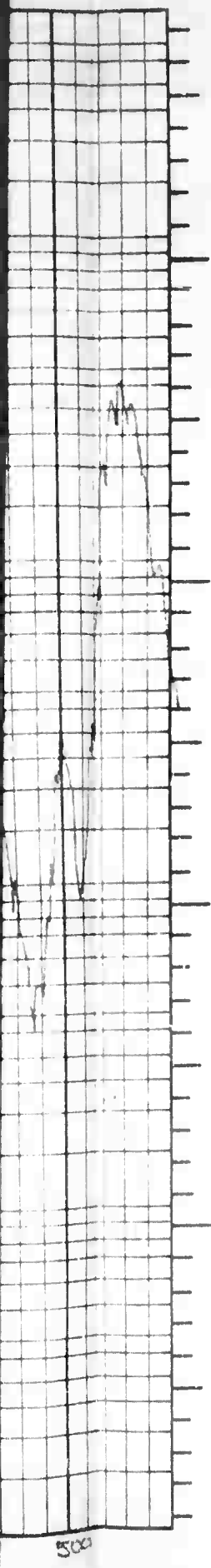
1

ANALYSIS VARIABLES

Bandwidth

5 cycles from 50 to 550 cps
 — cycles from — to — cps
 — cycles from — to — cps

T_c 4 Sec.
 Anal. Rate 1.25 cps/Sec.
 Loop Length 4 Sec.



SPECTRUM LEVEL - DECIBELS (Re 0.0002 Microbar)

2

DATA IDENTIFICATION

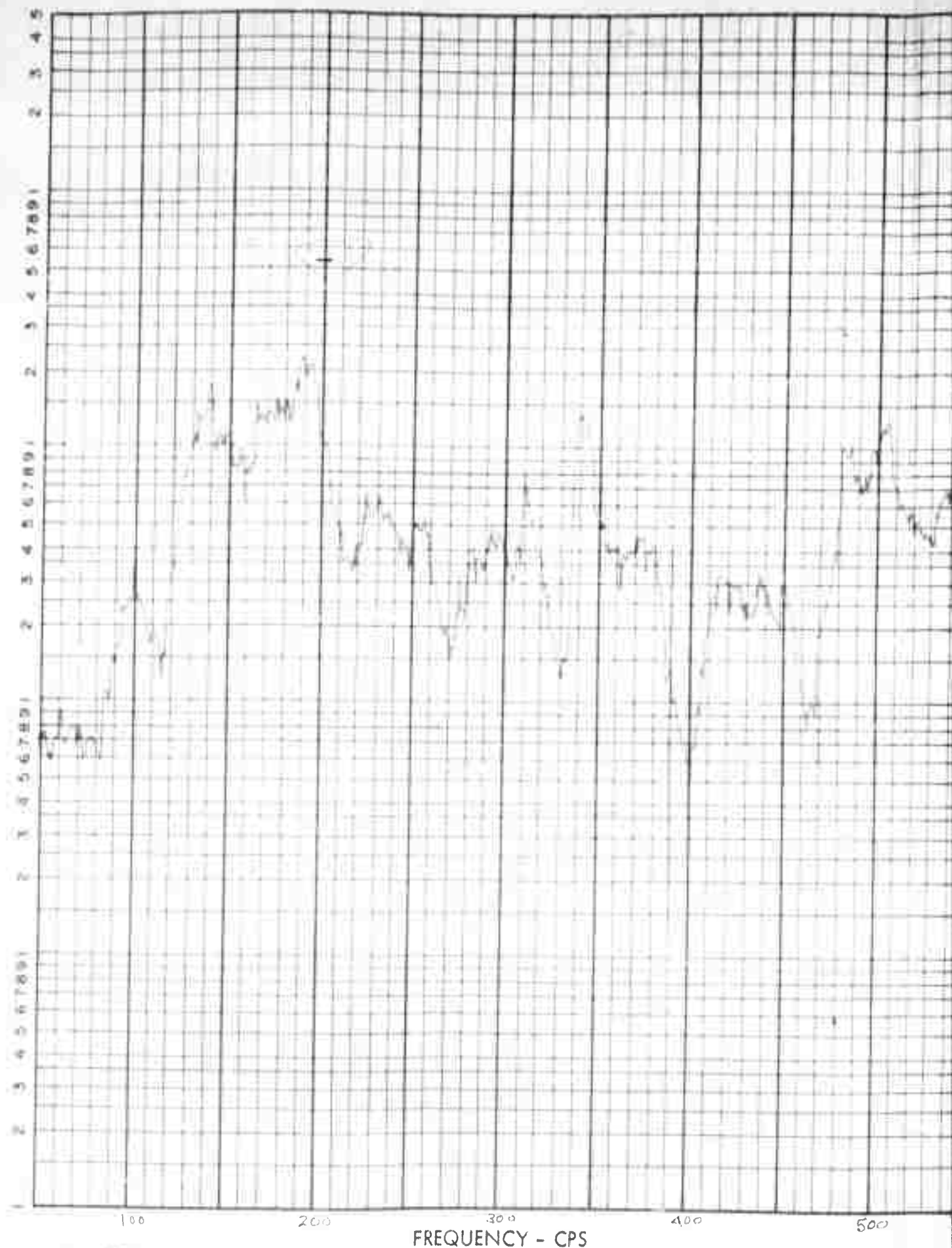
Test Title PANEL ATTACH TYPE I PRELIM		
EWA No. 5552-1		Panel or Specimen No. 1477
Tape No. 19	Tape Channel 2	Mic. No. 1
Elapsed Test Time		Mic. RMS Level at Sonic Lab. $V_L =$ Volts

CALIBRATION

Tape No. 19	Tape Channel 1	Data Tape RMS Volt $V_R =$
Calibration Voltage $V_a = 5V_{rms}$ into Line Amp.; $V_c = 5$ V_{rms} on Tape @ 1000 cps		
Line Amplifier Settings For Calibration $G_c = .1$; for Data $G_d = .1$		
Lab. Gain $LG = 1$	Tape Monitor Gain $TMG = \frac{G_d}{G_c} = 1$	
Microphone Sensitivity $S = 2.90$ psi/Volt or 1 Volt rms = 160 db SPL		
Equivalent of Calibration - psi $P_c = V_a \cdot S = .51$.145		
Equivalent of Calibration for PSD Plots $\left(\frac{P_c}{(TMG)(LG)} \right)^2 = \frac{.145^2}{1 \cdot 1} = 2.10 \times 10^{-4}$ psi²/cps		
Analyzer Attenuator Setting db	Log Converter Setting db	
Calibration Plotted at psi²/cps		
Overall Pressure Level Data RMS pressure Level $(P_c)(V_R)$ $= \frac{(TMG)(LG)(V_c)}{V_R} =$		Equiv. to db SPL psi

CALC			REVISED	DATE	POWER SPECTRAL DENSITY ANALYSIS OF MICROPHONE OUTPUT 1477 Mic 1 THE BOEING COMPANY	Vol I
CHECK	KUS	10/23				DZ-8008A
APR.						PAGE FIG 136
APR.						

POWER SPECTRAL DENSITY - (psi)² / cps



FREQUENCY - CPS

ANALYSIS VARIABLES

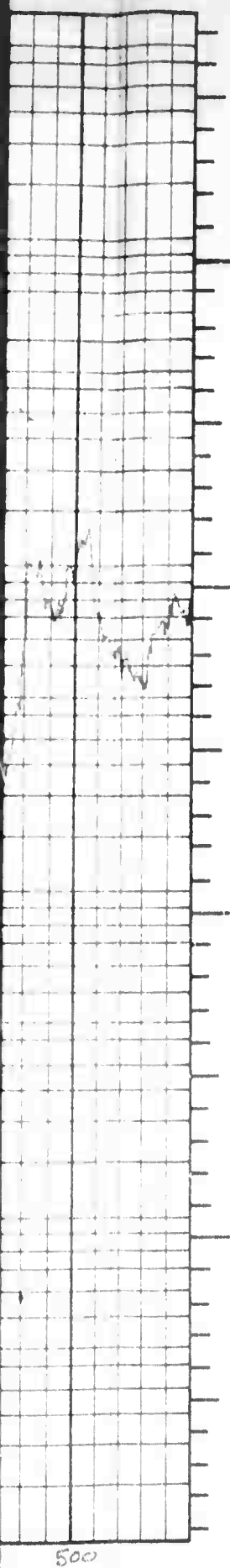
Bandwidth

5 cycles from 50 to 550 cps
cycles from to cps
cycles from to cps

T_c 4 Sec.

Anal. Rate 1.25 cps/Sec.

Loop Length 4 Sec.



DATA IDENTIFICATION

Test Title PANEL ATTACH TYPE I PRELIM		
EWA No. 5593-1		Panel or Specimen No. 1477
Tape No. 19	Tape Channel 3	Mic. No. 2
Elapsed Test Time		Mic. RMS Level at Sonic Lab. V _L = Volts

CALIBRATION

Tape No. 19	Tape Channel 1	Data Tape RMS Volt V _R = .240
Calibration Voltage V _a = 5 V _{rms} into Line Amp.; V _c = 5 V _{rms} on Tape @ cps		
Line Amplifier Settings For Calibration G _c = .1 ; for Data G _d = .2		
Lab. Gain LG = 1	Tape Monitor Gain TMG = $\frac{G_d}{G_c}$ =	
Microphone Sensitivity S = .290 psi/Volt or 1 Volt rms = 160 db SPL		
Equivalent of Calibration - psi P _c = V _a · S = .5 · .290 = .145		
Equivalent of Calibration for PSD Plots $\left(\frac{P_c}{(TMG)(LG)} \right)^2 = \left[\frac{.145}{2 \times 1} \right]^2 = 5.25 \times 10^{-3}$ psi ² /cps		
Analyzer Attenuator Setting db	Log Converter Setting db	
Calibration Plotted at psi ² /cps		
Overall Pressure Level Data RMS pressure Level	(P _c) (V _R) (TMG)(LG)(V _c)	Equiv. to db SPL
=		= psi

2

CALC	171	7	REVISED	DATE	POWER SPECTRAL DENSITY ANALYSIS OF MICROPHONE OUTPUT 1477 Mic 2 THE BOEING COMPANY	V ₀₀ I
CHECK	RUS	10-23				DC-60044
APR.						PAGE
APR.						FIG. 137

POWER SPECTRAL DENSITY - $(\text{in.})^2/\text{cps}$

1 2 3 4 5 6 7 8 9 1 2 3 4 5 6 7 8 9 1 2 3 4 5



FREQUENCY - CPS

ANALYSIS VARIABLES

Bandwidth

5 cycles from 50 to 550 cps
 — cycles from — to — cps
 — cycles from — to — cps

T_c 4 Sec.

Anal. Rate 1.25 cps/sec.

Loop Length 9 Sec.

DATA IDENTIFICATION

Test Title PANEL ATTACH TYPE I PRELIM.		
EWA No. 5592-1	Panel or Specimen No. 1477	
Tape No. 19	Tape Channel 4	Displacement Pickup 1
Elapsed Test Time		P/U RMS Level at Sonic Lab. $V_L =$ Volts

CALIBRATION

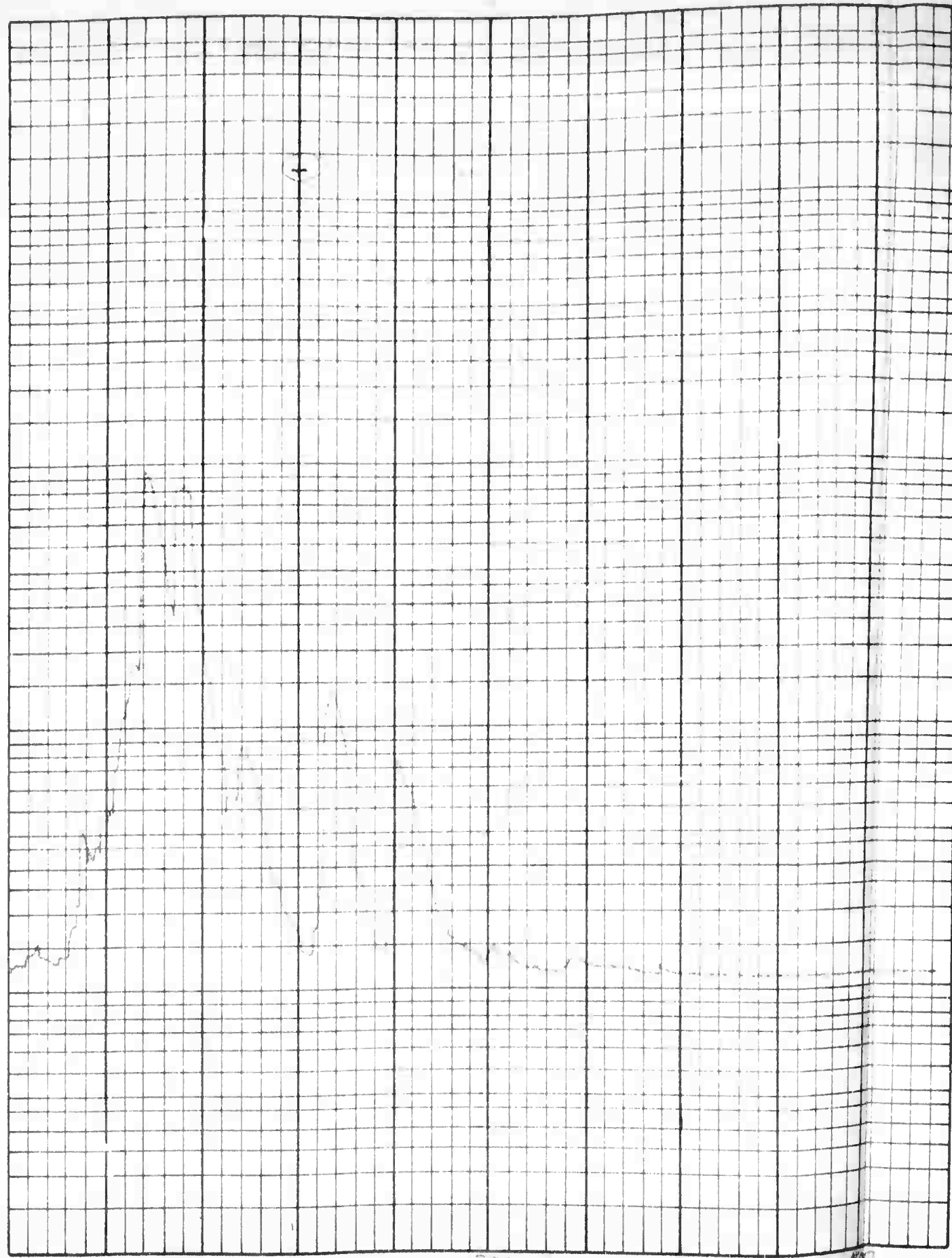
Tape No.	Tape Channel	Data Tape RMS Volt $V_R = .150$
Calibration Voltage $V_a = .5$ V_{rms} Into Line Amp.; $V_c = .5$ V_{rms} on Tape 200cps		
Line Amplifier Settings For Calibration $G_c = .1$; for Data $G_d = .2$		
Lab. Gain LG = 1	Tape Monitor Gain $TMG = \frac{G_d}{G_c} = 2$	
Displacement Pickup Sensitivity $S = .0108$ in./Volt		
Equivalent of Calibration - in. $D_c = V_a \cdot S = .5 \cdot .0108 = .0054$		
Equivalent of Calibration for PSD Plots $\left(\frac{D_c}{(TMG)(LG)} \right)^2 = \left[\frac{.0054}{(2)(1)} \right]^2 = .000729$ in. ² /cps		
Analyzer Attenuator Setting + 10 db	Log Converter Setting db	
Calibration Plotted at 3.77 x 10 ³ in. ² /cps		
Overall Deflection Level of Data RMS Defl. Level = $\frac{(D_c)(V_R)}{(TMG)(LG)(V_c)} =$ = _____ = psi		

2

CALC	1	REVISED	DATE	POWER SPECTRAL DENSITY ANALYSIS OF DISPLACEMENT PICKUP 1477 PRELIM THE BOEING COMPANY SEATTLE 24, WASHINGTON	Vol I
CHECK	YDS	10-23			DZ-30084
APR.					PAGE
APR					Fig 138

POWER SPECTRAL DENSITY - $(\text{in.})^2/\text{cps}$

1 2 3 4 5 6 7 8 9 1 2 3 4 5 6 7 8 9 1 2 3 4 5



100

200

FREQUENCY - CPS

300

400

500

1

ANALYSIS VARIABLES

Bandwidth

5 cycles from 50 to 550 cps
— cycles from — to — cps
— cycles from — to — cps

4 Sec.

Anal. Rate 1.25 cps/sec.

Loop Length 4 Sec.

DATA IDENTIFICATION

Test Title PANEL ATTACH. TYPE I PRELIM.		
EWA No. 5502-1	Panel or Specimen No. 1477	
Tape No. 19	Tape Channel 5	Displacement Pickup # 5
Elapsed Test Time		P/U RMS Level at Sonic Lab. $V_L =$ Volts

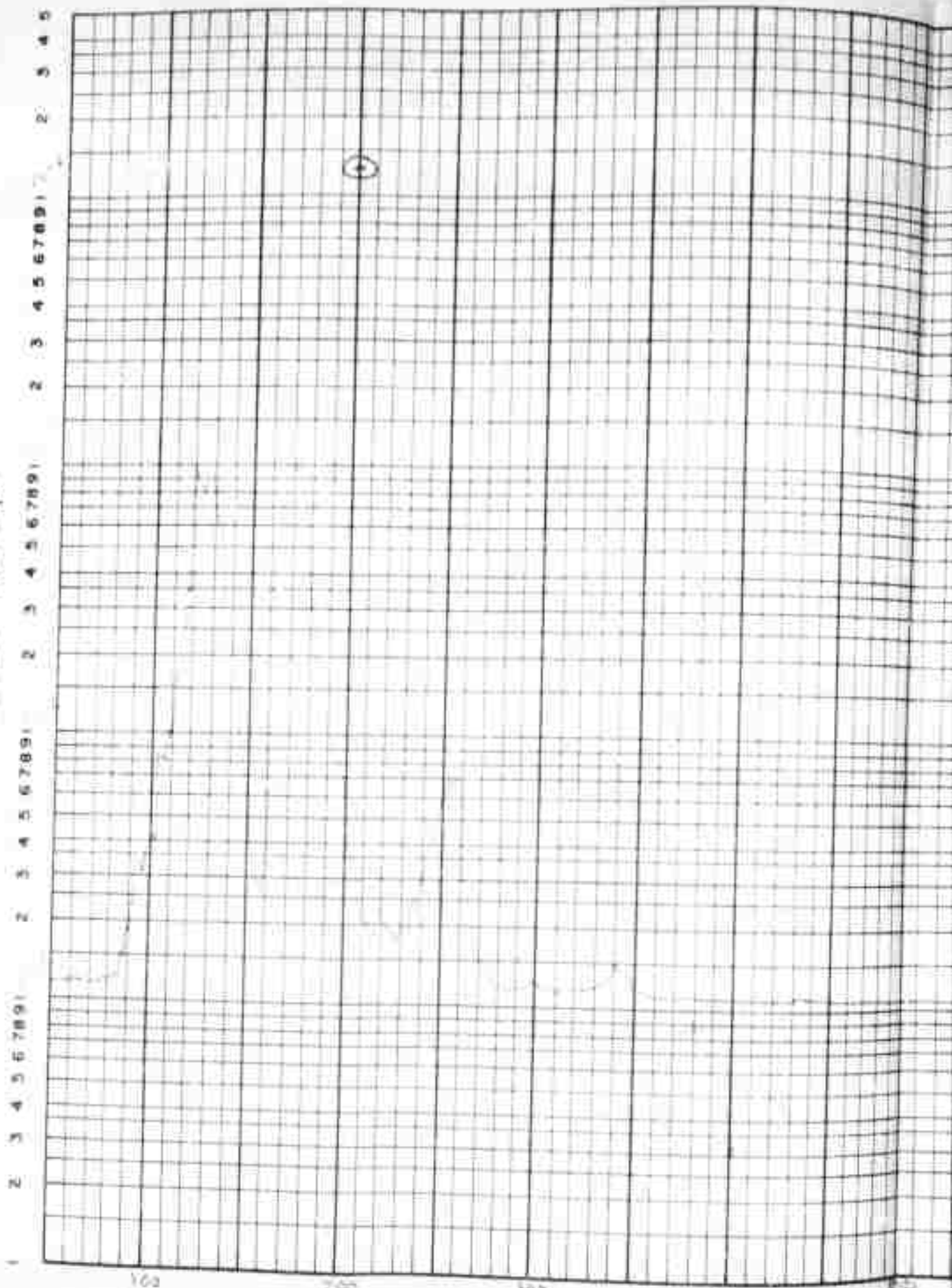
CALIBRATION

Tape No. 19	Tape Channel 1	Data Tape RMS Volt $V_R =$
Calibration Voltage $V_a = 5$ V_{rms} Into Line Amp.; $V_c = .5$ V_{rms} on Tape 20 cps		
Line Amplifier Settings For Calibration $G_c = .1$; for Data $G_d = .1$		
Lab. Gain $LG = 1$	Tape Monitor Gain $TMG = \frac{G_d}{G_c} = 1$	
Displacement Pickup Sensitivity $S = .0103$ in./Volt		
Equivalent of Calibration - in. $D_c = V_a \cdot S = (5) \cdot .0103 = .0515$		
Equivalent of Calibration for PSD Plots $\left(\frac{D_c}{(TMG)(LG)} \right)^2 = \left[\frac{.0515}{(1)(1)} \right]^2 = .00265$ in. ² /cps		
Analyzer Attenuator Setting db	Log Converter Setting db	
Calibration Plotted at In. ² /cps		
Overall Deflection Level of Data RMS Defl. Level = $\frac{(D_c)(V_R)}{(TMG)(LG)(V_c)} =$ = _____ = psi		

2

CALC	REVIS	DATE	POWER SPECTRAL DENSITY ANALYSIS OF DISPLACEMENT PICKUP 1477 P/U. 5. THE BOEING COMPANY SEATTLE 24, WASHINGTON	VOL I
CHECK RDS	10 L 3			L2-80084
APR.				PAGE
APR.				FIG 139

POWER SPECTRAL DENSITY - $(\text{in.})^2/\text{cps}$



FREQUENCY - CPS

ANALYSIS VARIABLES

Bandwidth

5 cycles from 50 to 550 cps
— cycles from — to — cps
— cycles from — to — cps

4 Sec.

Anal. Rate 1.25 cps/sec.

Loop Length 4 Sec.

DATA IDENTIFICATION

Test Title PANEL ATTACH TYPE I PRELIM		
EWA No. 5503-	Panel or Specimen No. 1477	
Tape No. 19	Tape Channel 6	Displacement Pickup 6
Elapsed Test Time		P/U RMS Level at Sonic Lab. $V_L =$ Volts

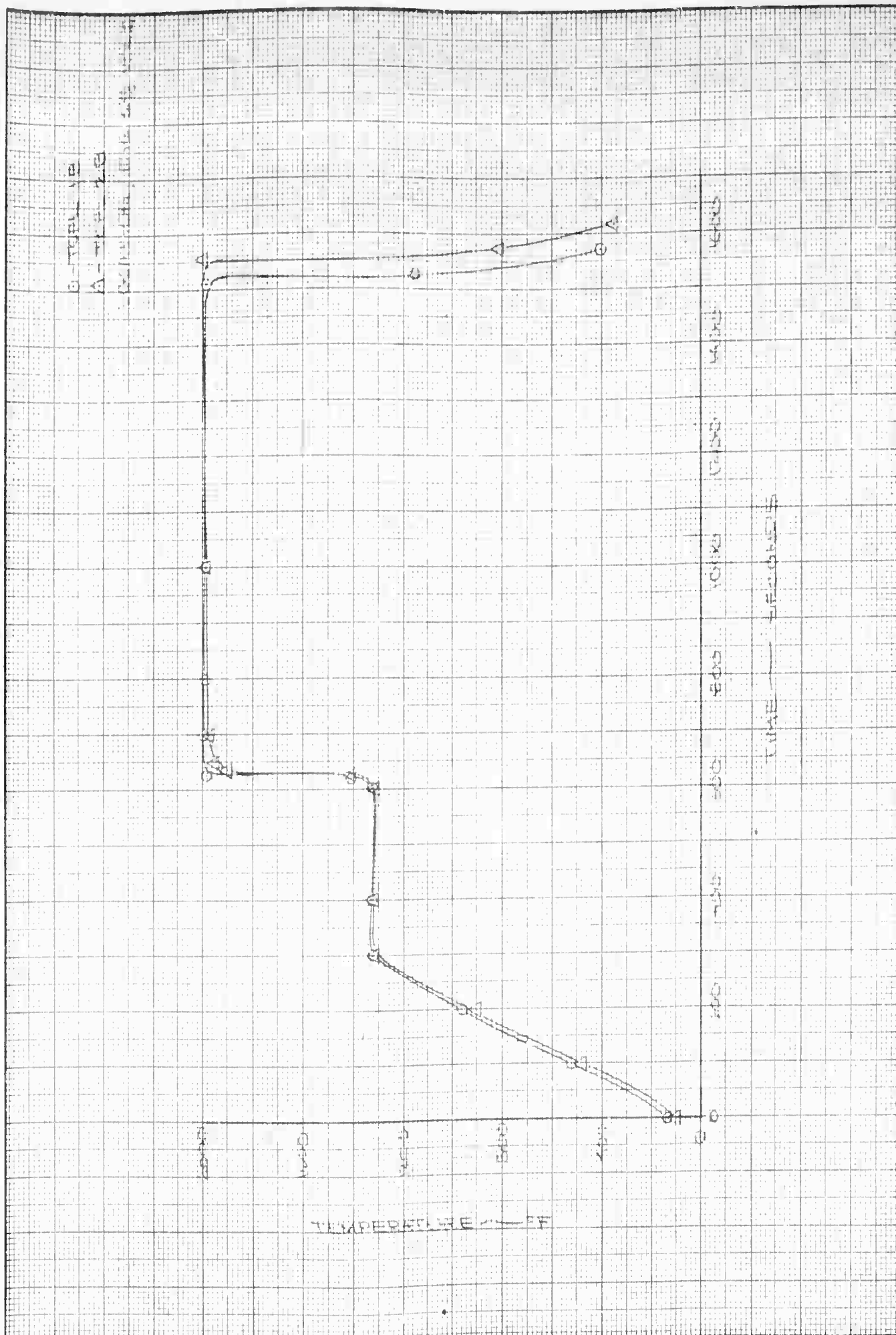
CALIBRATION

Tape No. 19	Tape Channel 1	Data Tape RMS Volt $V_R =$
Calibration Voltage $V_a = 5$ V_{rms} Into Line Amp.; $V_c = .5$ V_{rms} on Tape 200 cps		
Line Amplifier Settings For Calibration $G_c = .1$; for Data $G_d = .1$		
Lab. Gain LG = 1	Tape Monitor Gain $TMG = \frac{G_d}{G_c} = 1$	
Displacement Pickup Sensitivity $S = .010$ in./Volt		
Equivalent of Calibration - in. $D_c = V_a \cdot S = (.5) \cdot .010 = .005$		
Equivalent of Calibration for PSD Plots $\left(\frac{D_c}{(TMG)(LG)} \right)^2 = \frac{.005^2}{1 \cdot 1} = 2.5 \times 10^{-8}$ in. ² /cps		
Analyzer Attenuator Setting db	Log Converter Setting db	
Calibration Plotted at 1.25×10^{-7} in. ² /cps		
Overall Deflection Level of Data RMS Defl. Level = $\frac{(D_c)(V_R)}{(TMG)(LG)(V_c)} =$ = _____ = psi		

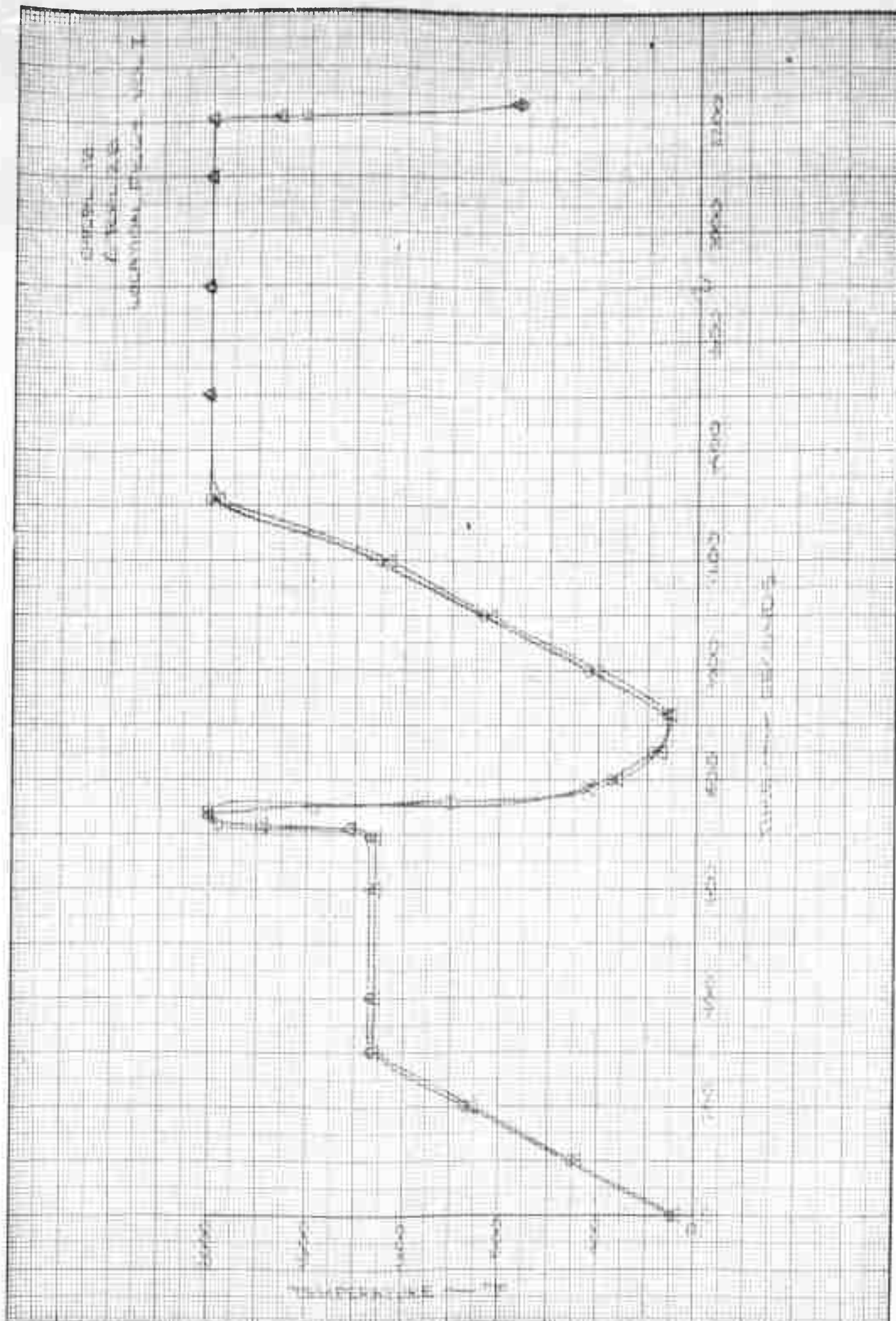
2

CALC	REF	REVISED	DATE	POWER SPECTRAL DENSITY ANALYSIS OF DISPLACEMENT PICKUP 1477 P/U 6 THE BOEING COMPANY SEATTLE 24, WASHINGTON	Vol I
CHECK	LDS	10-2-3			D2-80004
APR.					PAGE
APR.					FIG 140

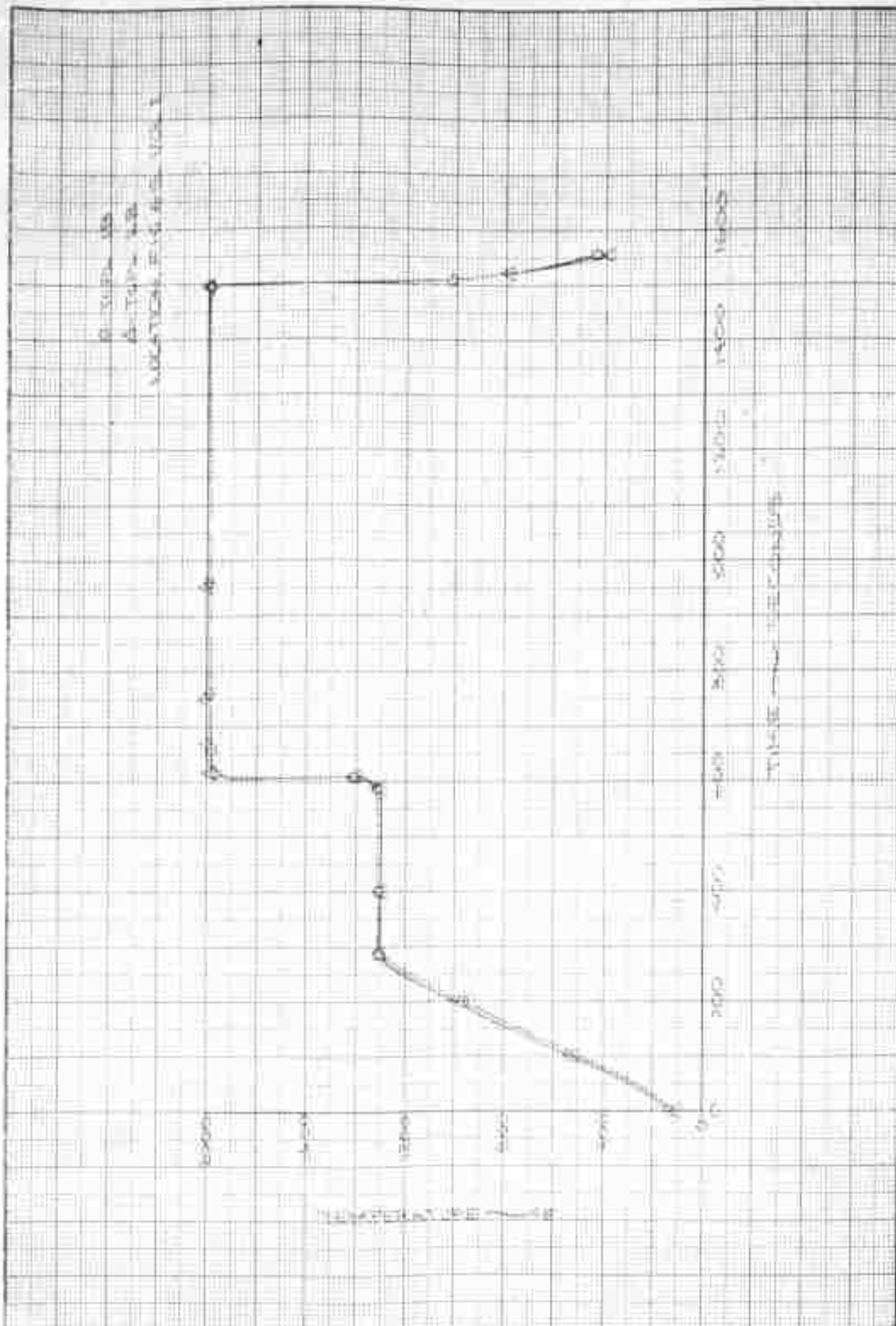
2-5353-4-38



CALC	by [signature]	1/2/51	REVISED	DATE	DRAWN BY [signature] 11/11/51 11/11/51 BOEING AIRPLANE COMPANY SEATTLE 24, WASHINGTON	D2-80084 PAGE FIG 141
CHECK	[signature]	1/2/51				
APR						
APR						



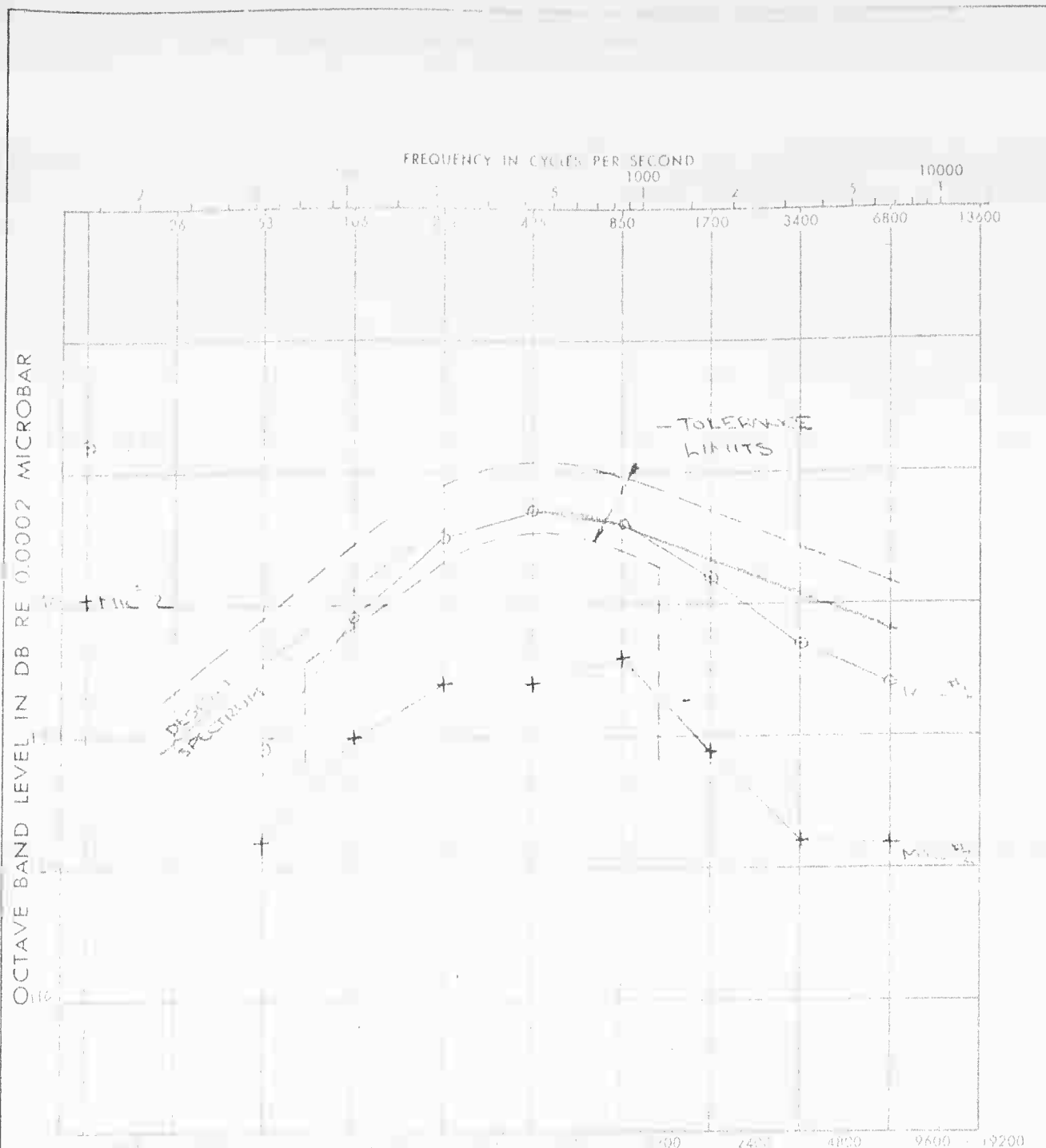
DATE	DESIGNED BY	REVISION	DATE	DRAWING PANEL ATTACHMENT NEW PANEL NO. 1 SEMI PANEL 1413	PAGE 12
CHECK	DATE				
APR					
BOEING AIRPLANE COMPANY SEATTLE 24, WASHINGTON				DZ-80084	



DATE	THURSDAY	APRIL	1951	REVISION	1	BY	W. H. B. / J. H. B.
CHECK	W. H. B.	J. H. B.					
APR	1951						
BY							

02-90084

BOEING AIRPLANE COMPANY



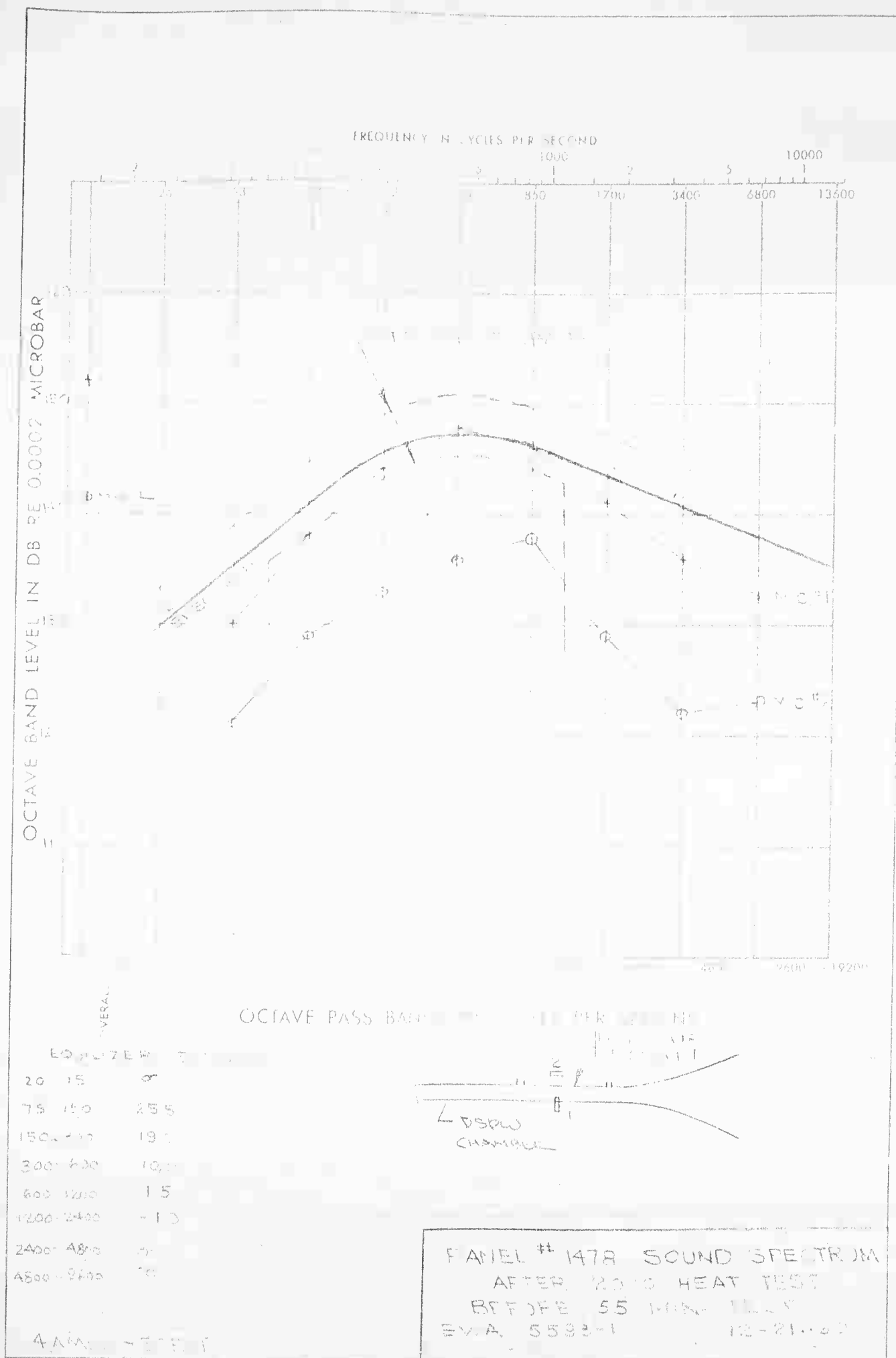
OVERALL

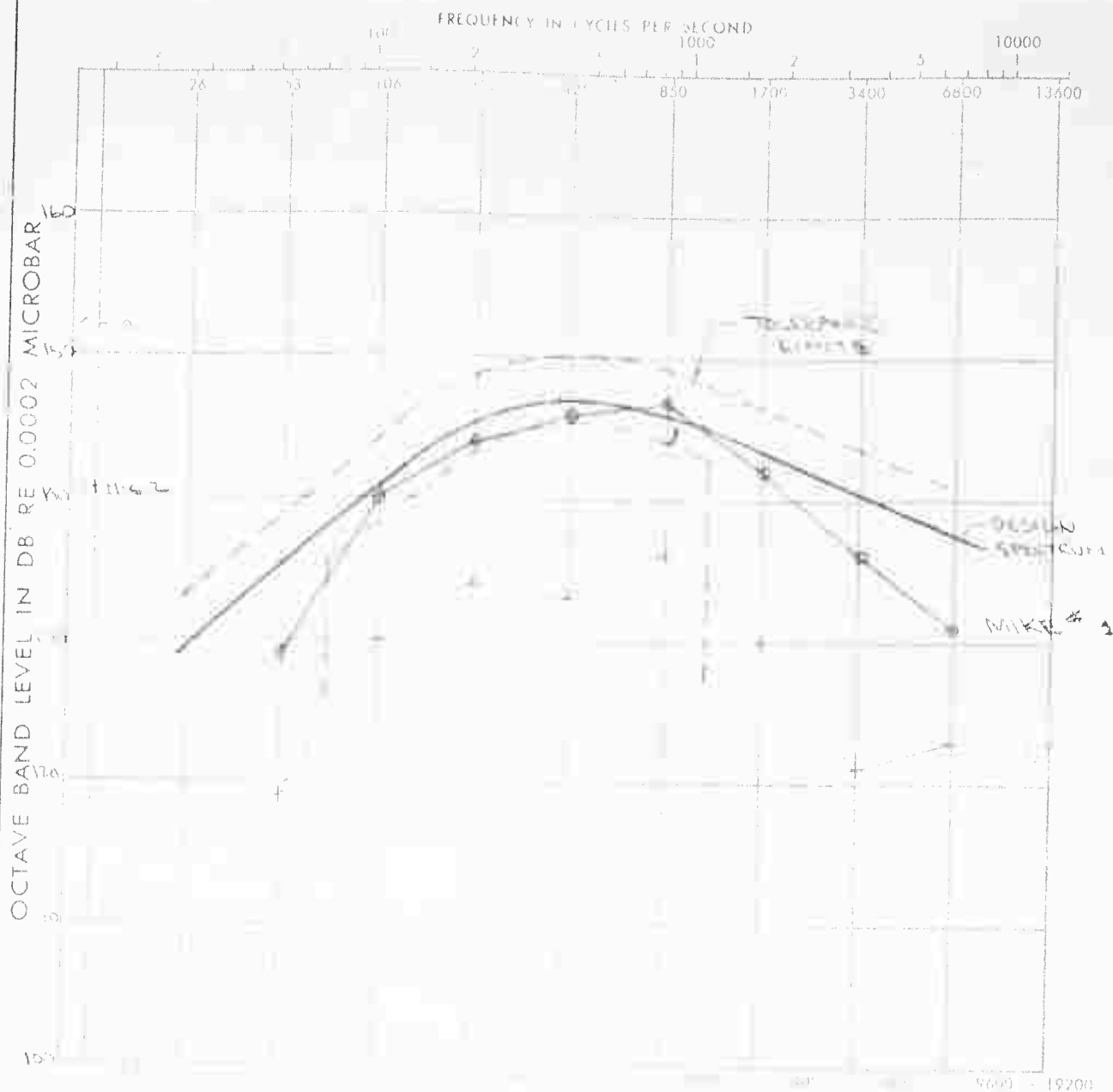
25	12.0
50	11.5
100	11.0
200	10.5
400	10.0
800	9.5
1600	9.0
3200	8.5
6400	8.0
12800	7.5
25600	7.0

OCTAVE PASS BANDS IN CYCLES PER SECOND



PANEL # 1477 SOUND SPECTRUM
 AFTER 3000° HEAT TEST
 BEFORE 55 MIN. TEST
 EWA 5593-1 12-22-60





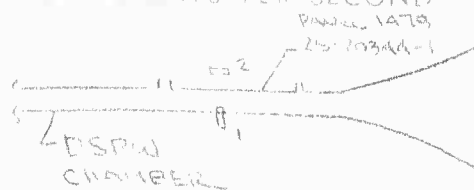
OVERALL

EQUATION 56

20-15	25.0
15-100	19.0
100-300	10.0
300-600	1.5
600-1200	-1
1200-2400	2
2400-4800	2
4800-9600	2
9600-19200	2

4.25 amps 50 psi

OCTAVE PASS BAND IN CYCLES PER SECOND



PANEL # 1479 SOUND SPECTRUM
AFTER 2000° HEAT TEST
BEFORE 50 MIN. TEST
FWA 5573-1

12-20-60

BOEING

NO D2-80084

PAGE FIG 146

PANEL 10

Total Test Time	Test Time	Panel No.	Panel No.	Panel No.	Panel No.	Panel No.
	15	VI		152		
0 5						NO NEW FAILURE
0 30	15	VI		152		" " "
0 40	20			152		SOME LOOSE FIREFLEX
1 00	25			152		NO NEW METAL FAILURE

TEST LOG

DSPW 190db

FR 147

149A

MAC 1017 R.S.

PANEL NUMBER 1475

10743

NEL FWA 1477

Tot. Test Time	Test Time	Freq.	Horn Ch. no. Press	Sound Level	P. no. Double A. Audio	
		Min.	chs	dB	Inches	
0 5	5	RANDOM	40	152	—	NO VISIBLE FAILURE
0 20	15	RANDOM	40	152	—	NO VISIBLE FAILURE
0 40	20	RANDOM	40	152	—	NO VISIBLE FAILURE
0 60	30	RANDOM	40	152	—	NO VISIBLE FAILURE
0 60.5	0.5	"	40	157	—	NO VISIBLE FAILURE
0 61.0	0.5	"	40	162	—	NO VISIBLE FAILURE

CAL CHIEF APR APR	A.B. 5/9/61	D.S. PANEL 1477 FWA 5-593 TEST LOG 10/11/61	DSPW 190db 10/11/61 FIG 150	VOL I 02-80084
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PANEL NUMBER 1478

Total Test Time		Test Time	Freq.	Horn Chamber Press	Sound Level	Panel Visible Amplitude
Hrs	Min	Min.	cps		db	Inches
0	00	5	Random	40	152	-
NO VISIBLE FAILURE						
0	25	20	Random	40	152	-
LOW LEVEL FRAX ON CORRUGATIONS						
0	45	20	Random	40	152	-
LOW LEVEL FRAX ON CORRUGATIONS						
0	60	15	Random	40	152	-
LOW LEVEL FRAX ON CORRUGATIONS						
0	60.5	0.5	Random	40	151	-
NO CHANGE						
0	61.0	0.5	Random	40	162	-
NO CHANGE						

DATE	DS-1 PANEL 1478	Item	VOL I
CHOLY	EWA 573 ~ TEST LOG		DZ-80084
APR			
APR			

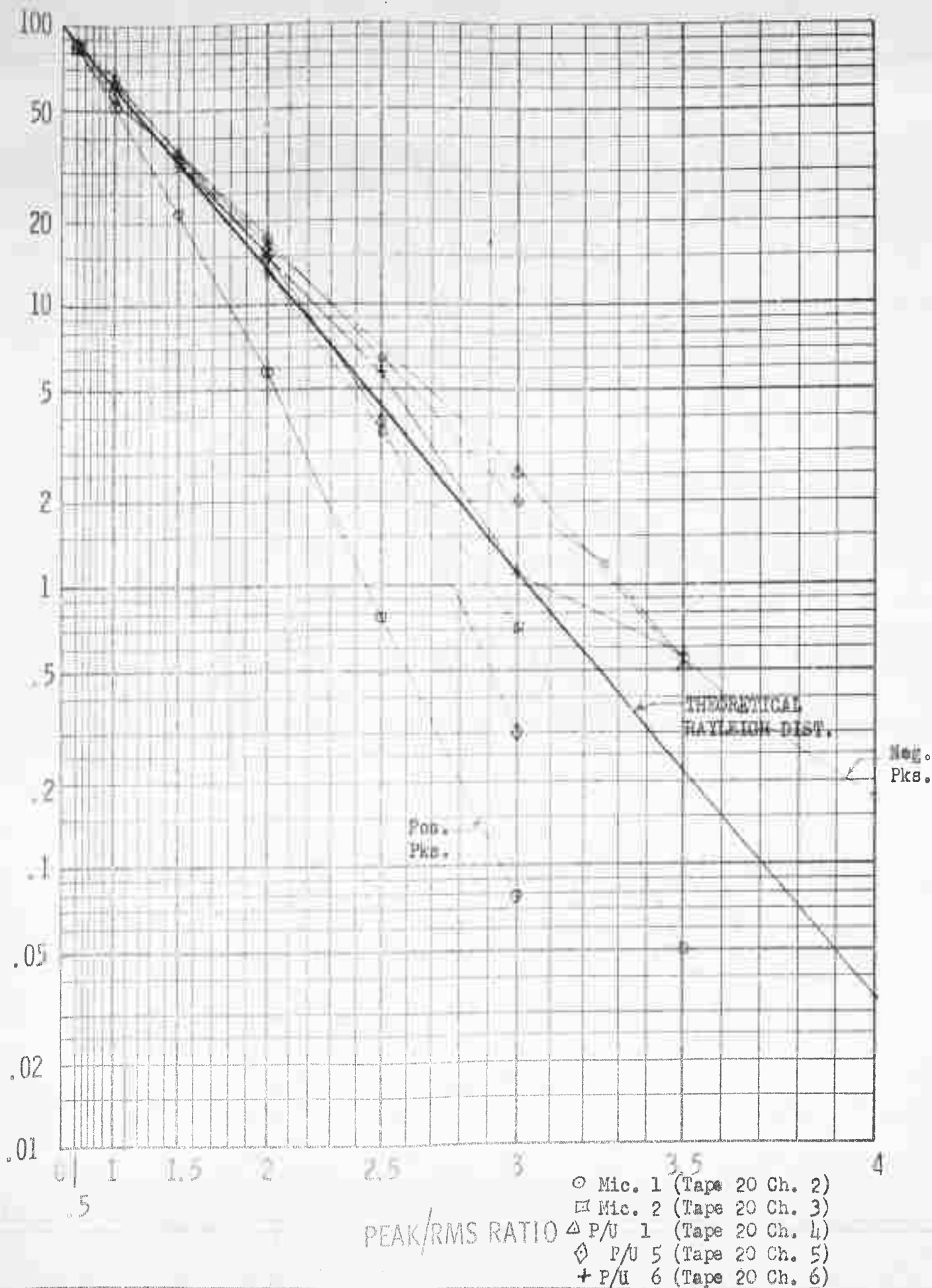
FIG 151

PANEL 1499

Total Test Time		Test Time	Freq.	Horn Chamber Press	Sound Level	Panel Double Amplitude	
hrs	Min	Min.	cps		db	Inches	
		5	RANDOM	—	152	—	NO VISIBLE FAILURE
0	10	5	RANDOM	40	152	—	LOOSE FIBER FRAY ON CORRUGATION
0	25	15	"	40	152	—	LOOSE FIBER FRAY ON CORRUGATION
0	45	20	"	40	152	—	LOOSE FIBER FRAY ON CORRUGATION
0	60	15	"	40	152	—	LOOSE FIBER FRAY ON CORRUGATION
0	60.5	0.5	RANDOM	40	157	—	LOOSE FIBER FRAY ON CORRUGATION
0	61.0	0.5	RANDOM	40	162	—	LOOSE FIBER FRAY ON CORRUGATION

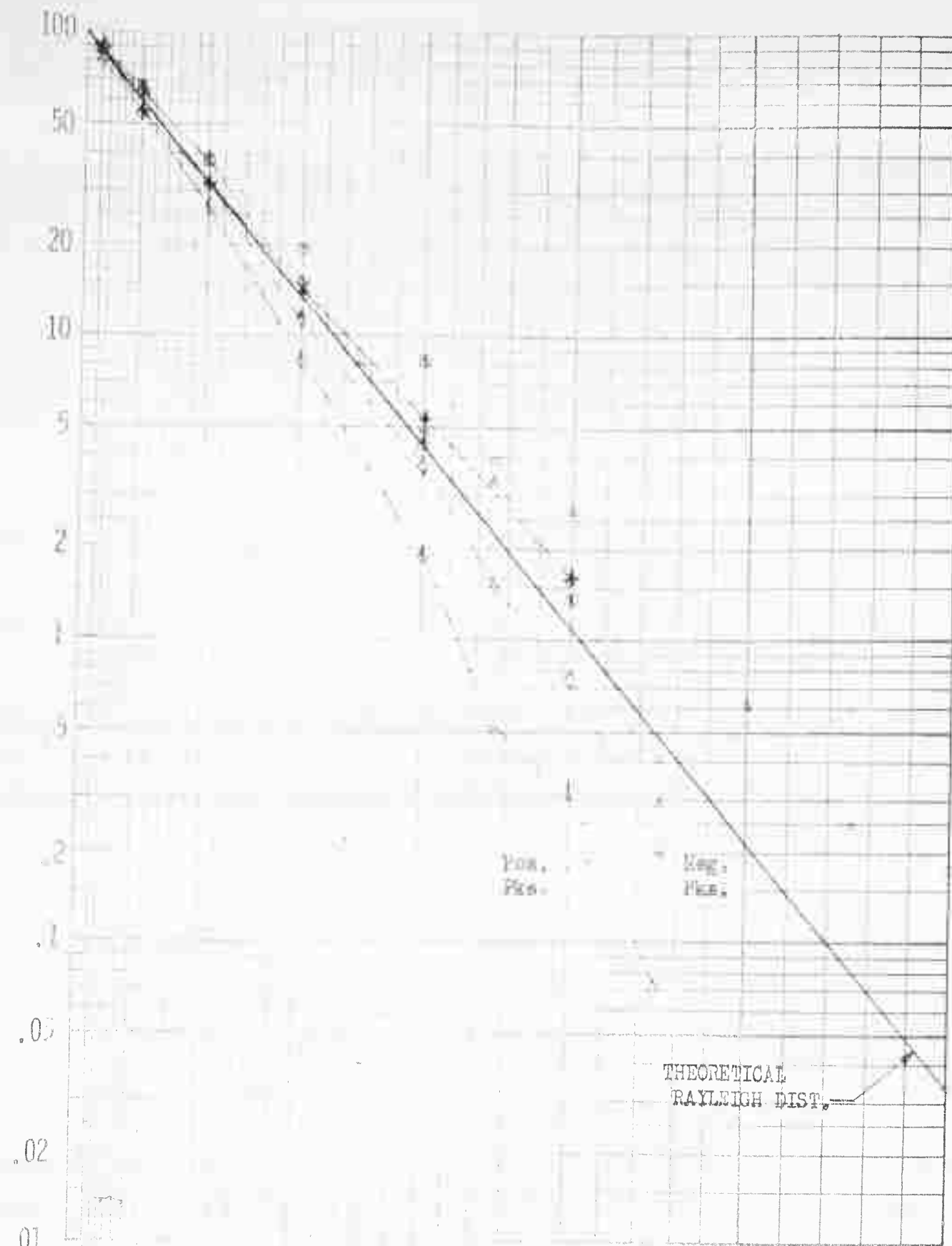
CAI	A.B.	5/10/61	PANEL 1499	Join	VOL I
CHICK			TEST LOG	DSPM	DE-80084
APR				19016	
APR				Cell	
				FIG 152	

CUMULATIVE PROBABILITY - %



CALC	7-7-1	REVISED	DATE	AMPLITUDE DISTRIBUTION Panel 1493 Phase A BOEING AIRPLANE COMPANY	Vol. 3. 3 D2-8-08-1 PAGE Fig 153
CHECK	7-7-1				
APPD					
APPD					

CUMULATIVE PROBABILITY - %



- ⊙ Mic. 1 (Tape 21A Ch. 6)
- ⊙ Mic. 2 (Tape 21A Ch. 2)
- + P/U 1 (Tape 21A Ch. 3)
- ⊙ P/U 5 (Tape 21A Ch. 4)
- ⊙ P/U 6 (Tape 21A Ch. 5)

CALC	KA
CHECK	
APPD	
APPD	

AMPLITUDE DISTRIBUTION

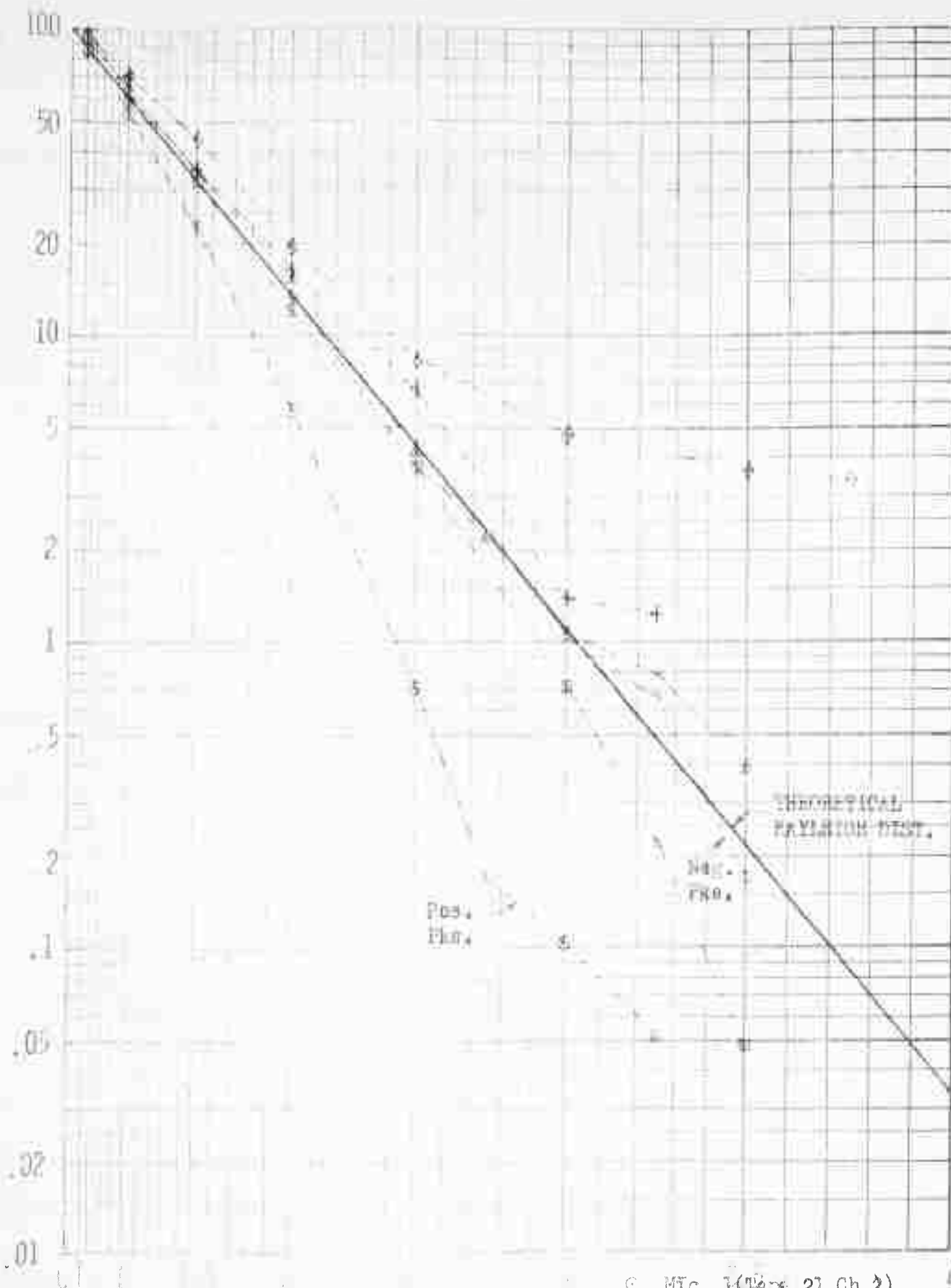
Panel 3494

Phase A

BOEING AIRPLANE COMPANY

PA 4 2A

CUMULATIVE PROBABILITY - %



- Mic. 1 (Tape 21 Ch. 2)
- Mic. 2 (Tape 21 Ch. 3)
- △ P/U 1 (Tape 21 Ch. 4)
- ◇ P/U 5 (Tape 21 Ch. 5)
- + P/U 6 (Tape 21 Ch. 6)

CALC	1
CHECK	
APPD	
APPD	

AMPLITUDE DISTRIBUTION

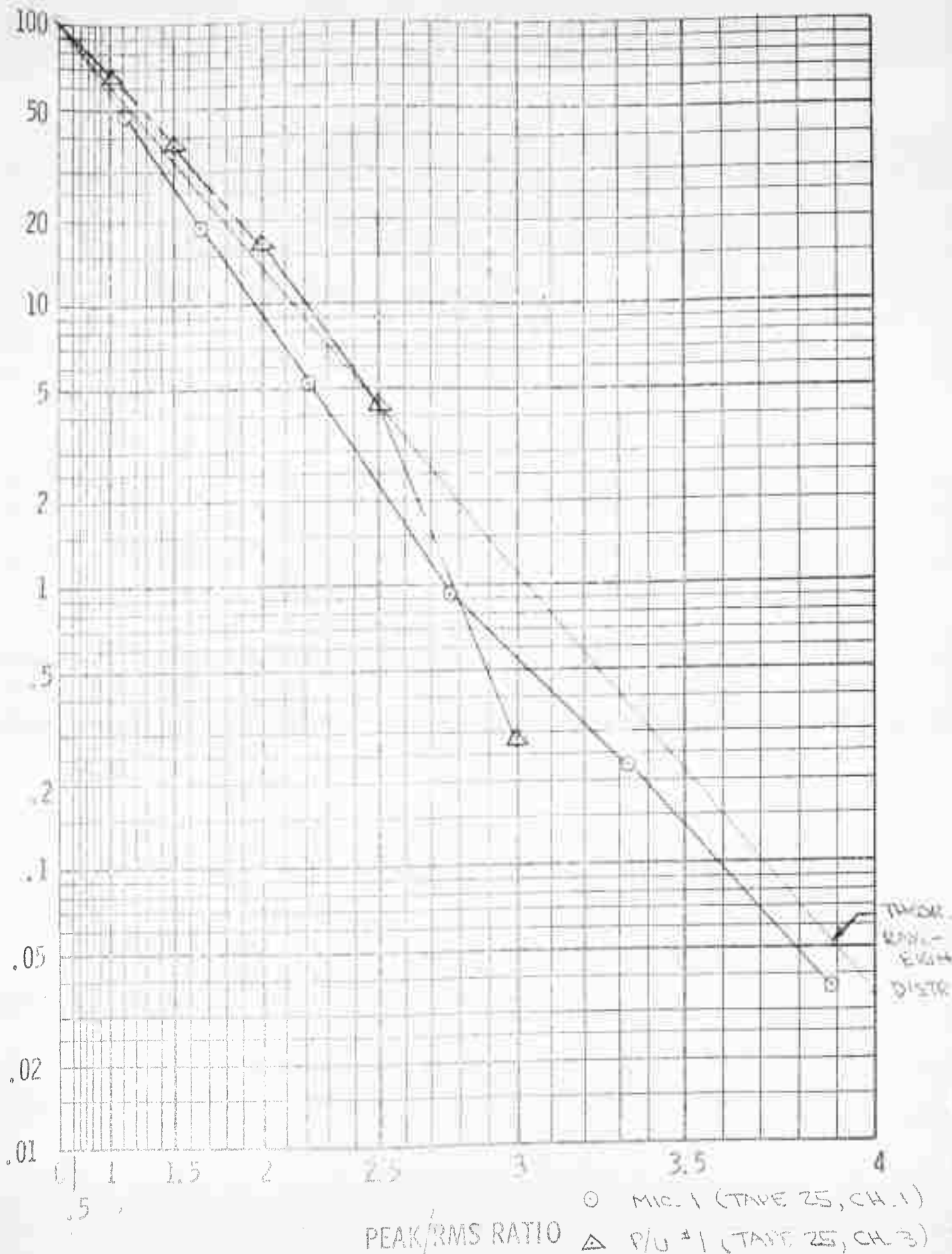
Panel 11/95

Phase A

BOEING AIRPLANE COMPANY

VOL. 1
PAGE 75
FIG. 15

CUMULATIVE PROBABILITY - %

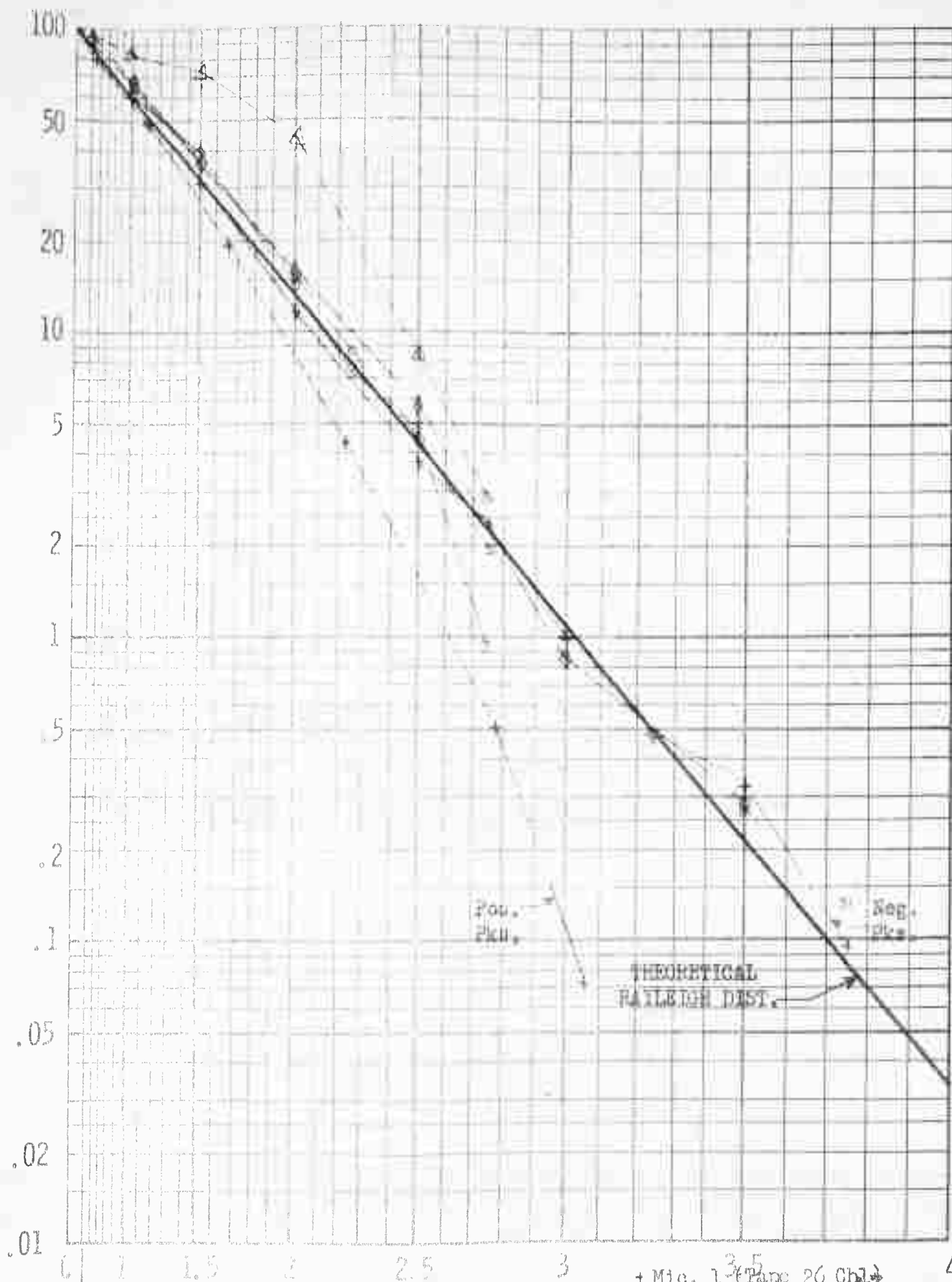


PEAK/RMS RATIO

○ MIC-1 (TAPE 25, CH. 1)
 △ P/U #1 (TAPE 25, CH. 3)

CALC	8/25/54	REVISED	DATE	AMPLITUDE DISTRIBUTION	Va. I
CHECK	8/25/54			PANEL 1495	PHASE B
APPD					D280081
APPD				BOEING AIRPLANE COMPANY	PAGE FIG 156

CUMULATIVE PROBABILITY - %

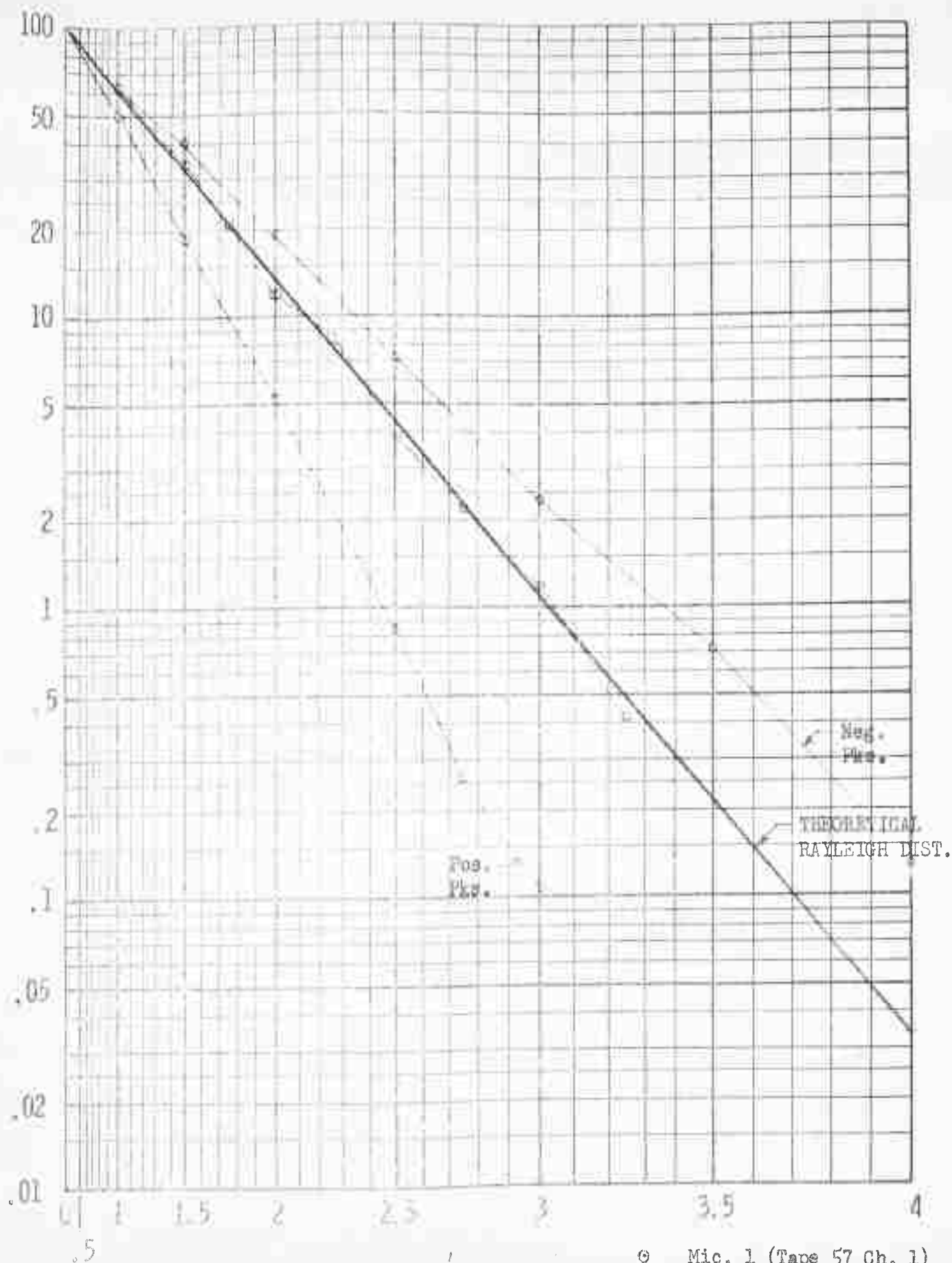


PEAK/RMS RATIO

- + Mic. 1 (Tape 26 Ch. 1)
- x Mic. 2 (Tape 26 Ch. 2)
- o P/U 1 (Tape 26 Ch. 3)
- Δ P/U 5 (Tape 26 Ch. 4)
- P/U 6 (Tape 26 Ch. 5)

CALC	REVISED	DATE	AMPLITUDE DISTRIBUTION	VOL. 3
CHECK			Panel 11/97	Phase A
APPD			BOEING AIRPLANE COMPANY	PAGE 157
APPD				

CUMULATIVE PROBABILITY - %



PEAK/RMS RATIO

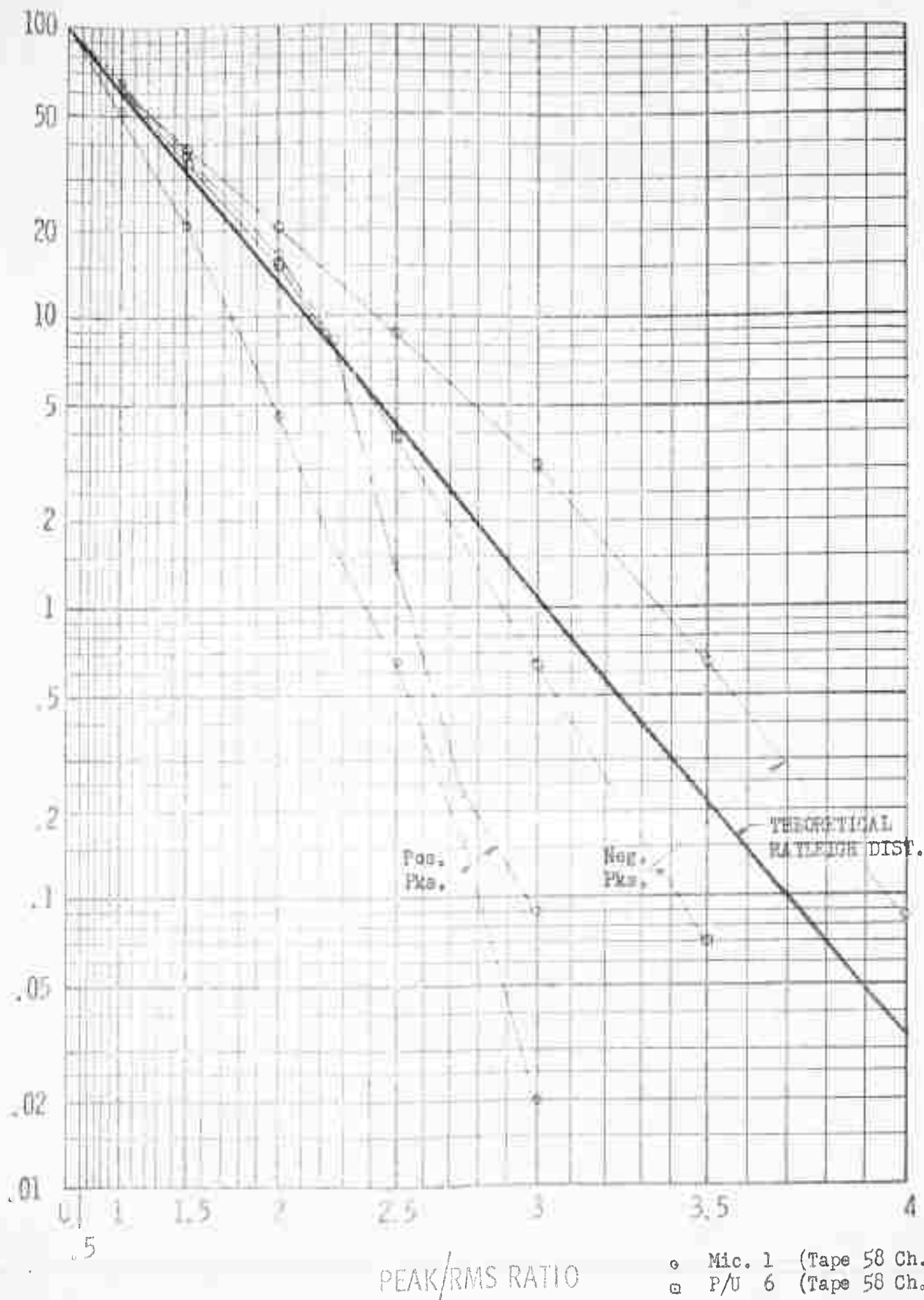
⊙ Mic. 1 (Tape 57 Ch. 1)
 □ P/U 6 (Tape 57 Ch. 5)

CALC		REVISED	DATE	AMPLITUDE DISTRIBUTION	VAL. 58
CHECK				Panel 1497	Phase C
APPD				BOEING AIRPLANE COMPANY	PAGE 158
APPD					

2-7000

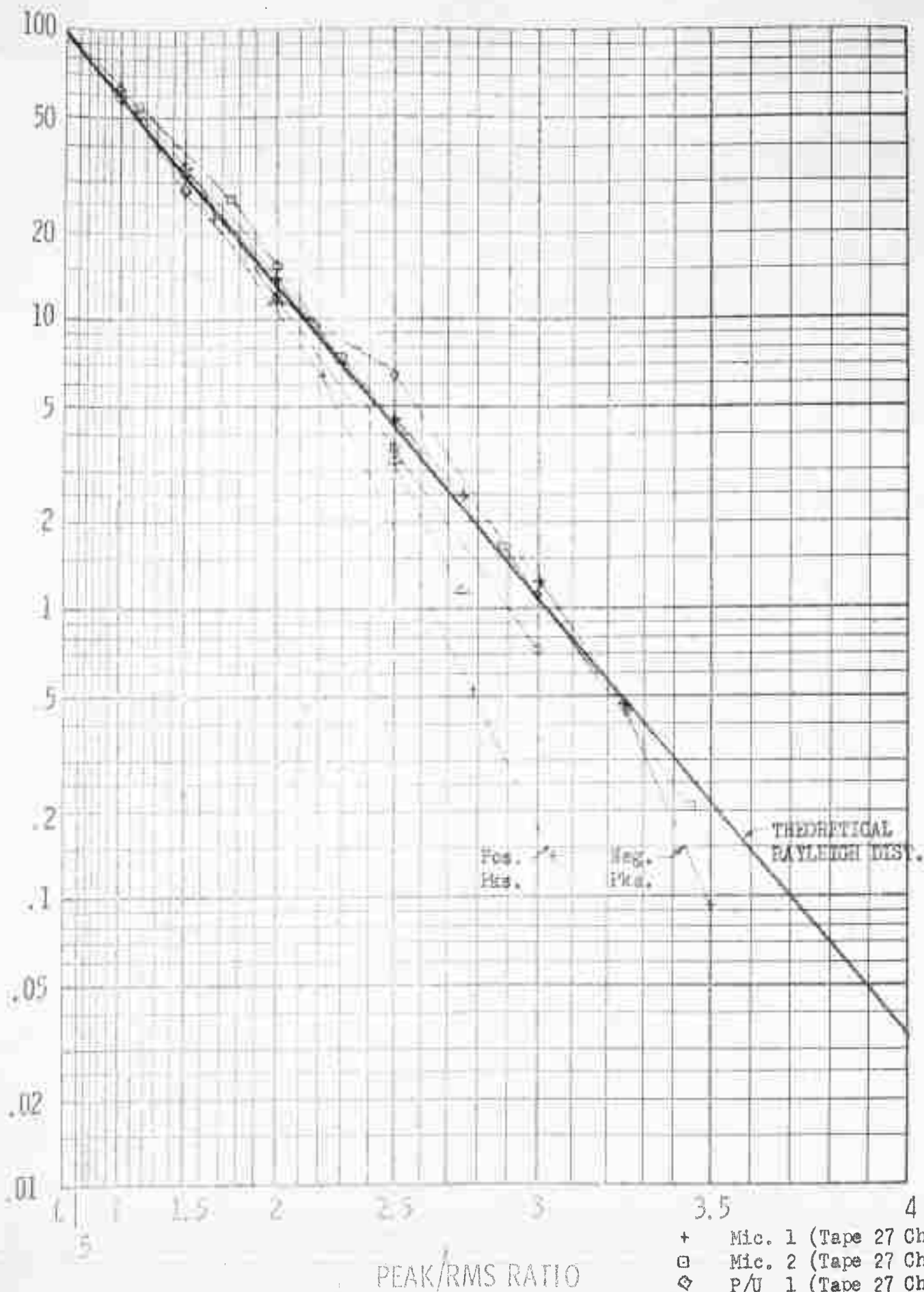
2-5353-7-1

CUMULATIVE PROBABILITY - %



CALC	DOA	REVIS	DATE	AMPLITUDE DISTRIBUTION Panel 1497 BOEING AIRPLANE COMPANY	Phase D PAGE 150
CHECK	RD				
APPD					
APPD					

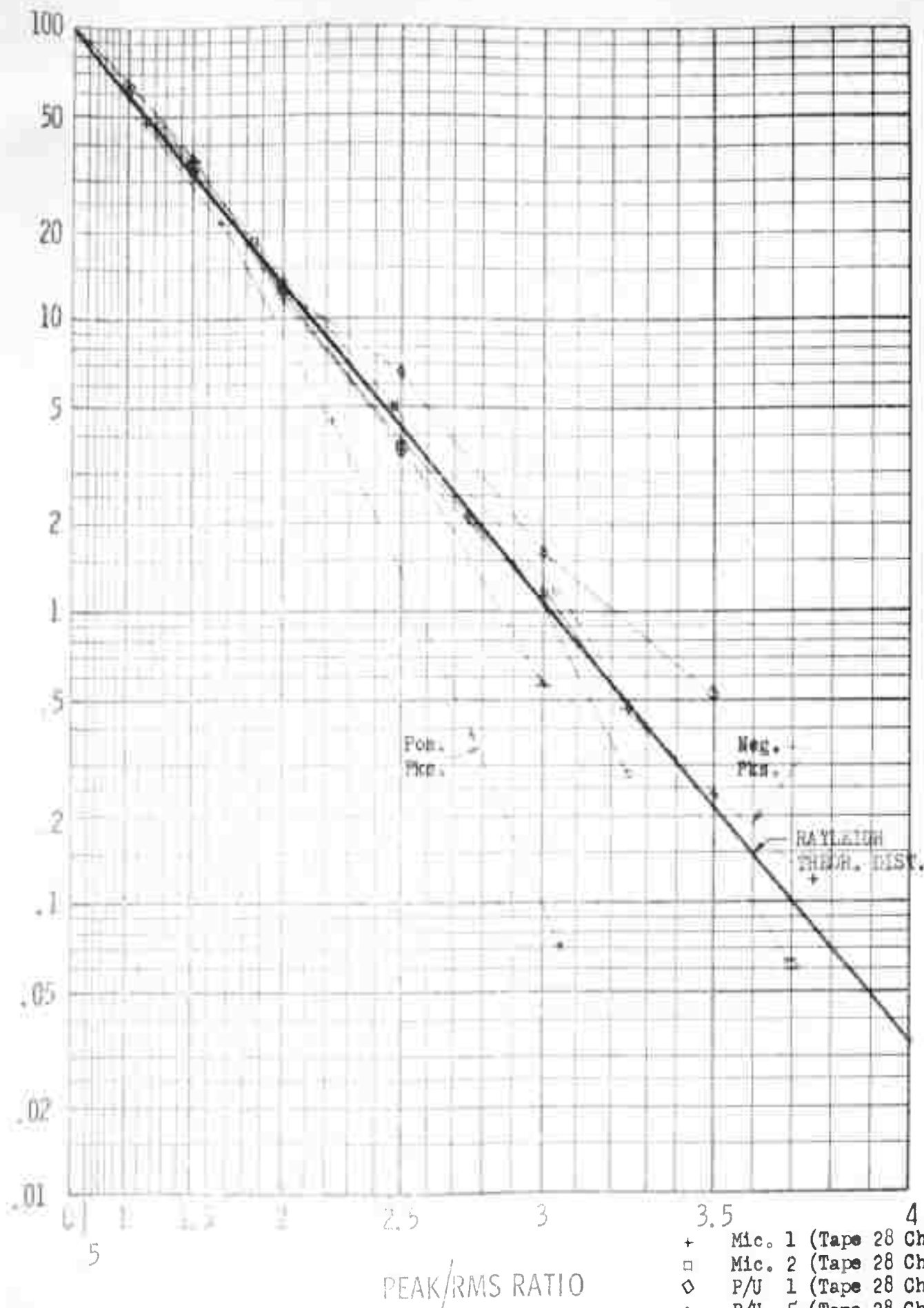
CUMULATIVE PROBABILITY - %



- + Mic. 1 (Tape 27 Ch. 1)
- Mic. 2 (Tape 27 Ch. 2)
- ◇ P/U 1 (Tape 27 Ch. 3)
- △ P/U 5 (Tape 27 Ch. 4)
- P/U 6 (Tape 27 Ch. 5)

CALC	JOA	7 MAY 68	REVISED	DATE	AMPLITUDE DISTRIBUTION		NO. 103
CHECK					Panel 1498	Phase A	DL 8 1051
APPD					BOEING AIRPLANE COMPANY		PAGE
APPD							FIG 100

CUMULATIVE PROBABILITY - %

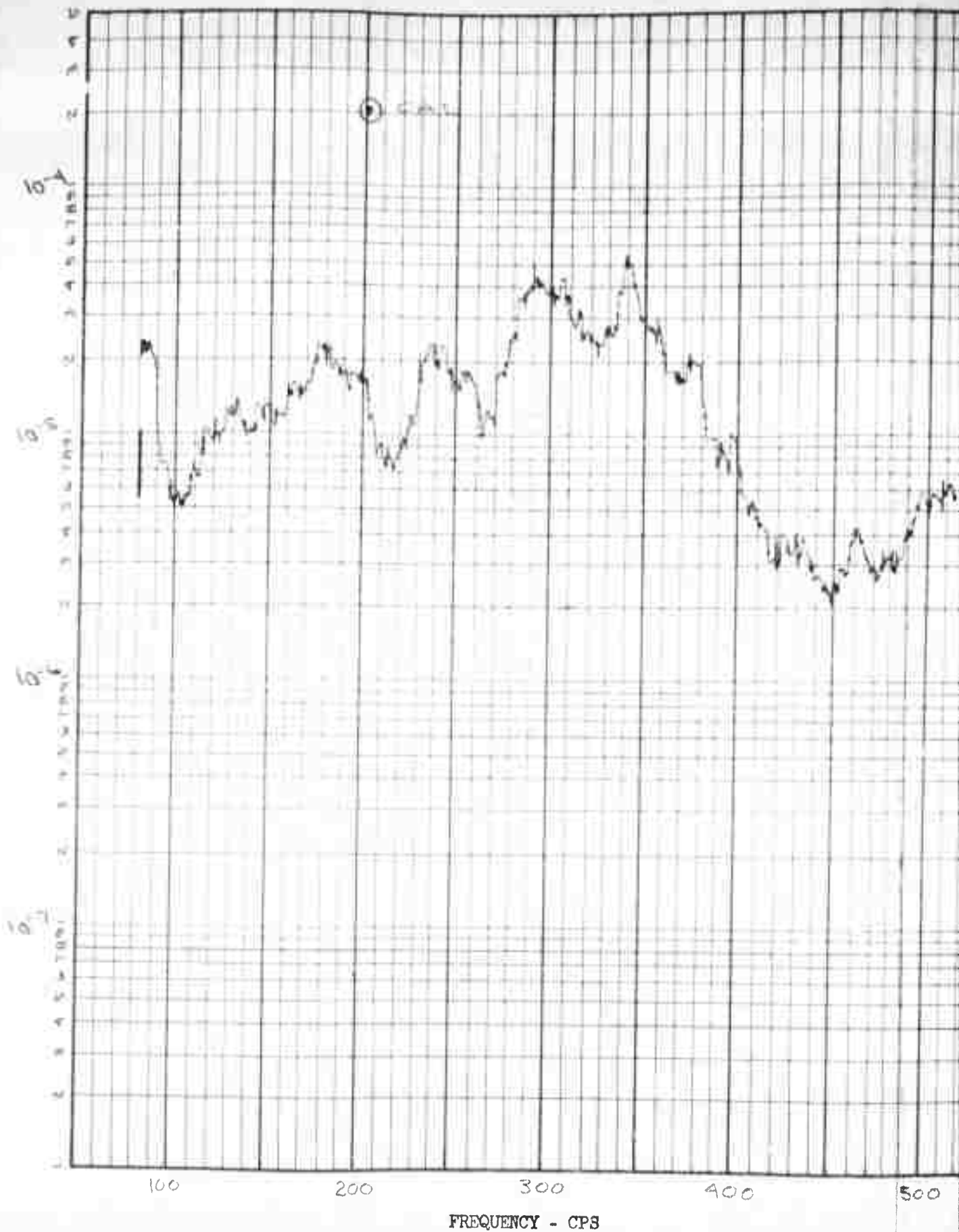


- + Mic. 1 (Tape 28 Ch. 1)
- Mic. 2 (Tape 28 Ch. 2)
- ◇ P/U 1 (Tape 28 Ch. 3)
- △ P/U 5 (Tape 28 Ch. 4)
- P/U 6 (Tape 28 Ch. 5)

DATE	3-28-54	TIME	11:00
NAME			
APP			
APP			

AMPLITUDE DISTRIBUTION		Vol. 1593
Panel 1499	Phase A	DZ 5-081
BOEING AIRPLANE COMPANY		PAGE 161

POWER SPECTRAL DENSITY - $(\text{psi})^2/\text{cps}$



ANALYSIS VARIABLES

Bandwidth

5 cycles from 80 to 500 cps
 cycles from to cps
 cycles from to cps

T_c 4 Sec.
 Anal. Rate 1.25 cps/Sec.
 Loop Length 4 Sec.

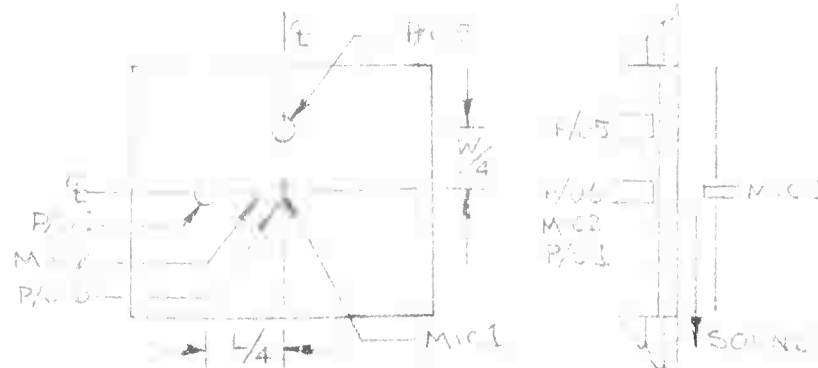
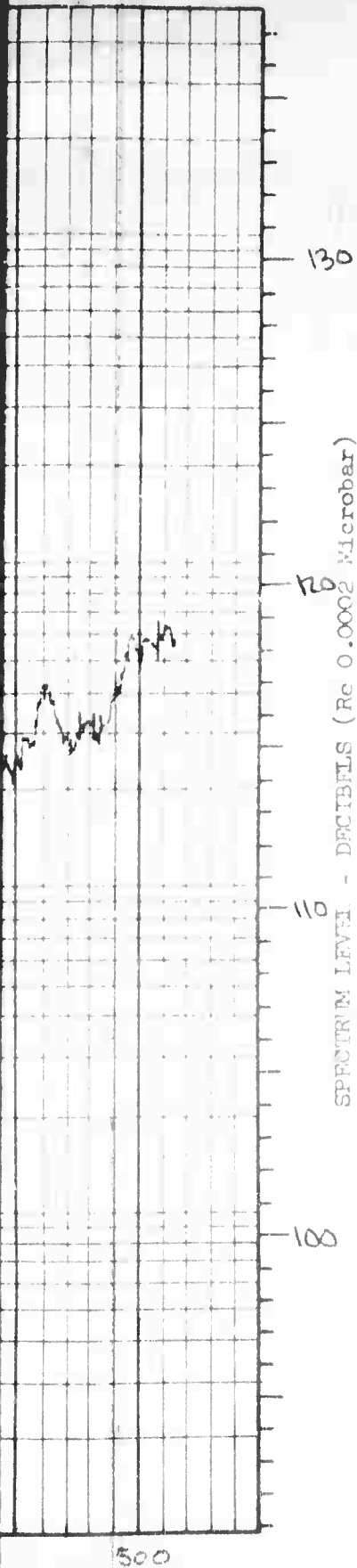
CALC	<i>MEM</i>
CHECK	<i>CBT</i>
APR	
APR	

DATA IDENTIFICATION

Test Title PANEL ATTACH TYPE I PRELIM.		
FWA No. 5-593	Panel or Specimen No. 1493	
Tape No. 20	Tape Channel 2	Mic. No. 1
Elapsed Test Time +5 MIN.		Mic. RMS Level at Sonic Lab. V_L = .415 Volts

CALIBRATION

Tape No. 20	Tape Channel 1	Data Tape RMS Volt V_R = .400
Calibration Voltage V_a = .5 V_{rms} into Line Amp.; V_c = .50 V_{rms} on Tape @200cps		
Line Amplifier Settings For Calibration G _c = .100 ; for Data G _d = .100		
Lab. Gain LG = 1.0	Tape Monitor Gain TMG = $\frac{G_d}{G_c} = 1.0$	
Microphone Sensitivity S = .290 psi/Volt or 1 Volt rms = 160 db SPL		
Equivalent of Calibration - psi P_c = V_a · S = .145		
Equivalent of Calibration for PSD Plots $\left(\frac{P_c}{(TMG)(LG)} \right)^2 = \left[\frac{.145}{(1.0)(1.0)} \right]^2 = 2.1 \times 10^{-2}$ psi²/cps		
Analyzer Attenuator Setting -20 db	Log Converter Setting 0 db	
Calibration Plotted at 2.1 (10⁻²) psi²/cps		
Overall Pressure Level Data RMS pressure level = $\frac{(P_c)(V_R)}{(TMG)(LG)(V_c)}$		Equiv. to 152.3 db SPL
= $\frac{(.145)(.400)}{(1.0)(1.0)(.5)} = .116$ psi		

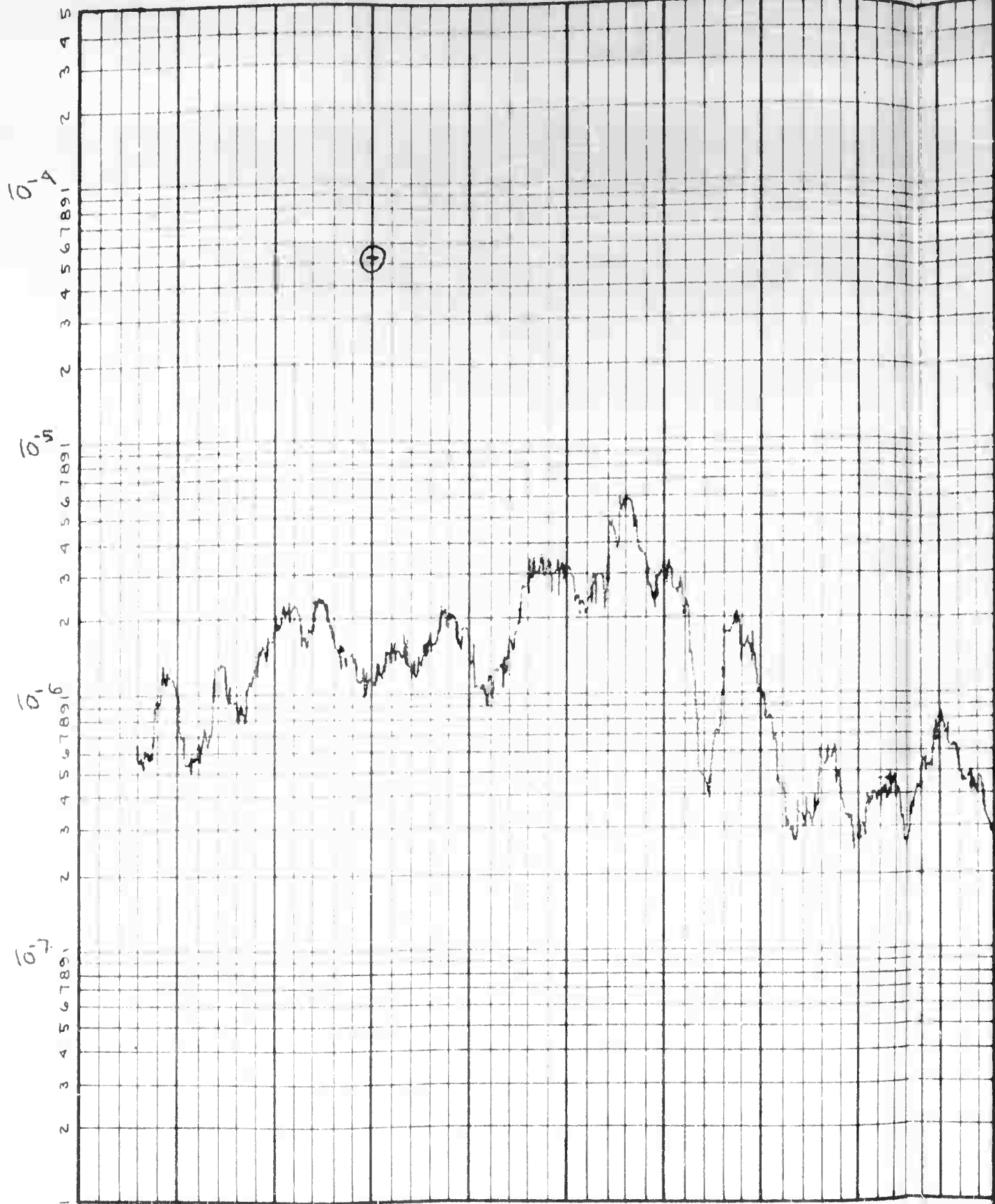


2

CALC	MEM	6/22/61	REVISED	DATE	POWER SPECTRAL DENSITY ANALYSIS OF MICROPHONE OUTPUT 5 MIN TEST MIC 1 PANEL 1493 PHASE A BOEING AIRPLANE COMPANY SEATTLE 24, WASHINGTON	VOL I
CHECK	1 BT	6/22/61				DEC 8 1961
APR						PAGE
APR						FIG 162

2-5353-7-8

POWER SPECTRAL DENSITY - (psi)²/cps



FREQUENCY - CPS

ANALYSIS VARIABLES

Bandwidth

5 cycles from 80 to 550 cps
 cycles from to cps
 cycles from to cps

T_c 4 Sec.
 Anal. Rate 1.25 cps/Sec.
 Loop Length 4 Sec.

CALC C.T.
 CHECK 50A
 APR.
 APR.

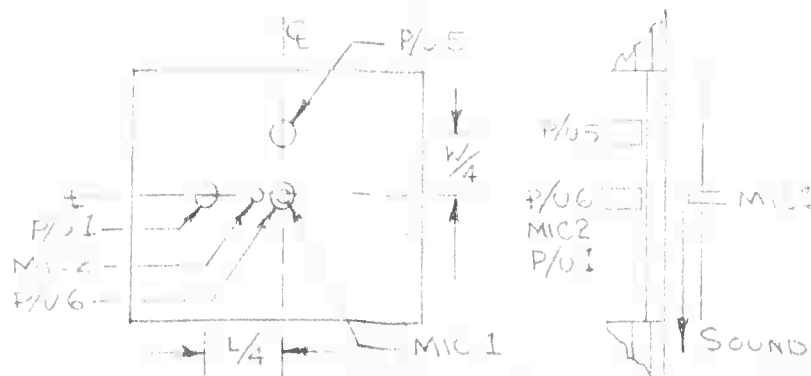
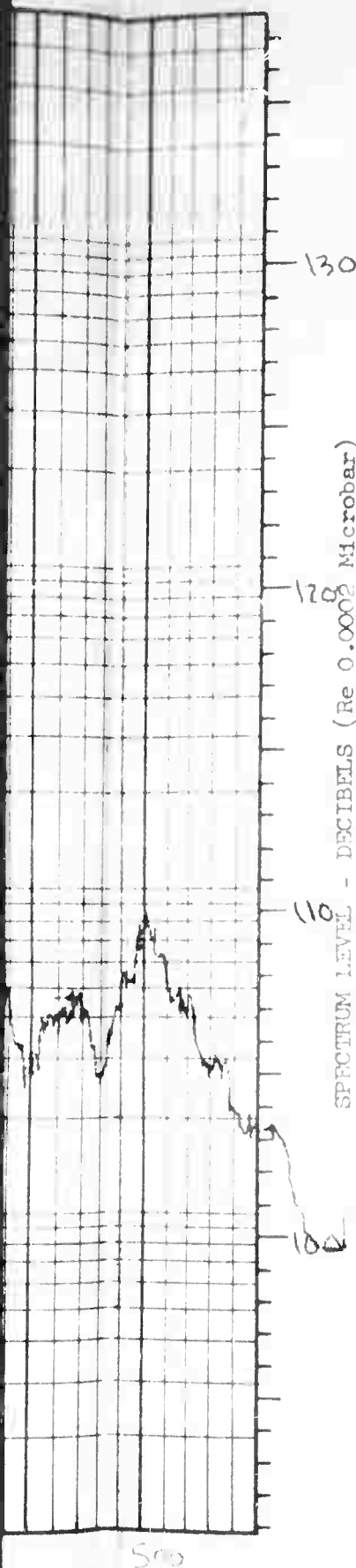
DATA IDENTIFICATION

Test Title PANEL ATTACH TYPE I PRELIM		
EWA No. 5503	Panel or Specimen No. 1493	
Tape No. 20	Tape Channel 3	Mic. No. 2
Elapsed Test Time + 5 MIN		Mic. RMS Level at Sonic Lab. V_L = .115 Volts

CALIBRATION

Tape No. 20	Tape Channel 1	Data Tape RMS Volt V_R = .212
Calibration Voltage V_a = .5 V_{rms} into Line Amp.; V_c = .50 V_{rms} on Tape @ 200cps		
Line Amplifier Settings For Calibration G _c = .100 ; for Data G _d = .200		
Lab. Gain LG = 10	Tape Monitor Gain TMG = $\frac{G_d}{G_c} = 2$	
Microphone Sensitivity S = .290 psi/Volt or 1 Volt rms = 160 db SPL		
Equivalent of Calibration - psi P_c = V_a · S = .145		
Equivalent of Calibration for PSD Plots $\left(\frac{P_c}{(TMG)(LG)}\right)^2 = \left[\frac{.145}{(2)(10)}\right]^2 = 5.25 (10^{-3})$ psi²/cps		
Analyzer Attenuator Setting -20 db	Log Converter Setting 0 db	
Calibration Plotted at 5.25 (10⁻³) psi ² /cps		
Overall Pressure Level Data RMS pressure level = $\frac{(P_c)(V_R)}{(TMG)(LG)(V_c)}$		Equiv. to 140.5db SPL
= $\frac{(.145)(.212)}{(2)(10)(.5)} = .0307$ psi		

SPECTRUM LEVEL - DECIBELS (Re 0.0002 Microbar)

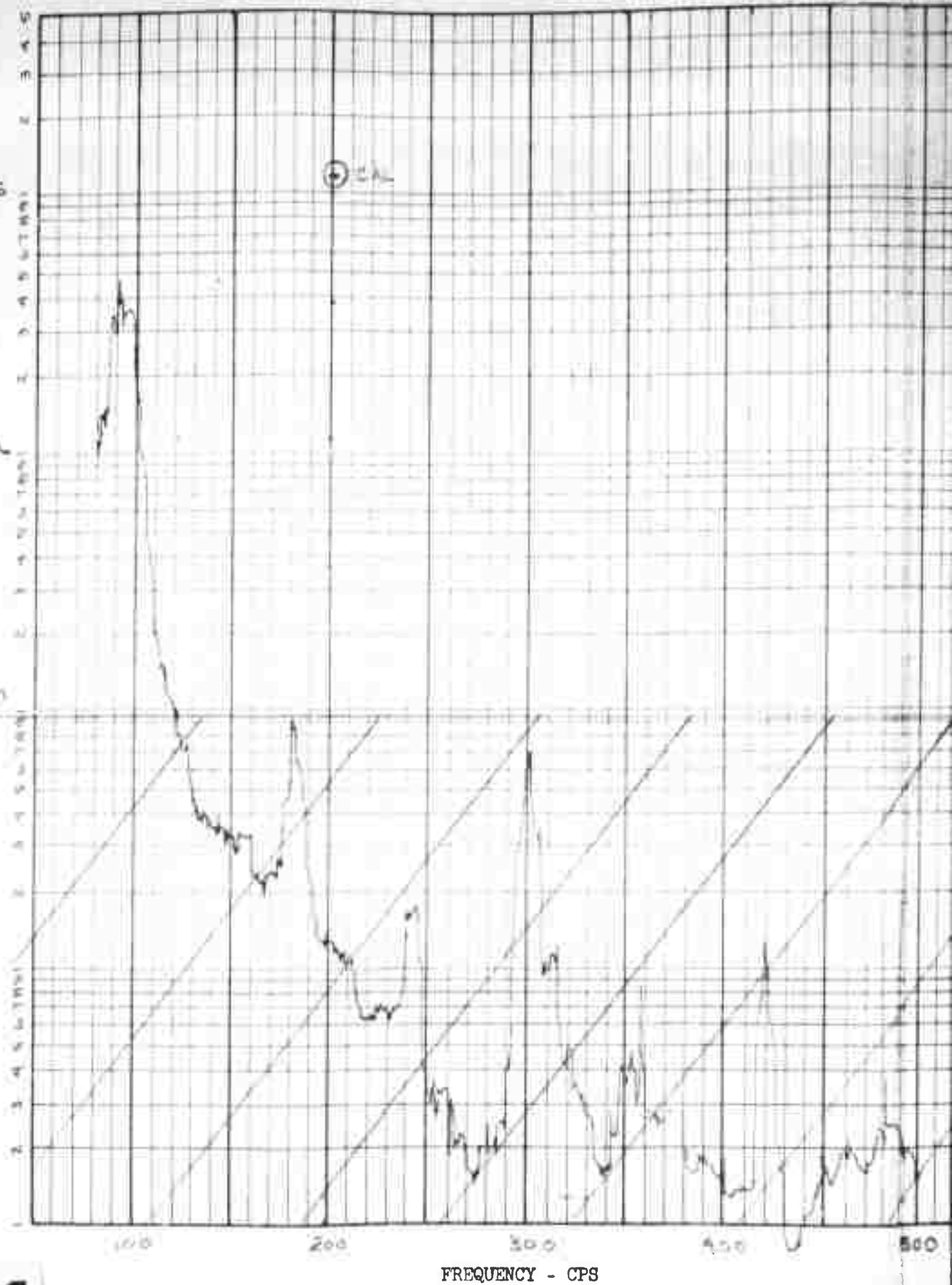


CALC.	C.T.	6/2/61	REVISED	DATE	POWER SPECTRAL DENSITY ANALYSIS OF MICROPHONE OUTPUT 5 MIN TEST MIC 2 PANEL 1493 PHASE A BOEING AIRPLANE COMPANY SEATTLE 24, WASHINGTON	VOL I
CHECK	SOA	4/23/61				DZ 27 47
APR.						PAGE
APR.						FIG 163

J-5353-7-3

2

POWER SPECTRAL DENSITY - (In.)²/cps



1

ANALYSIS VARIABLES

Bandwidth

5 cycles from 80 to 550 cps
 _____ cycles from _____ to _____ cps
 _____ cycles from _____ to _____ cps

T_c 4 Sec.

Anal. Rate 1.25 cps/sec.

Loop Length 4 Sec.

CALC	<u>10/1</u>
CHECK	<u>50A</u>
APR	
APR	

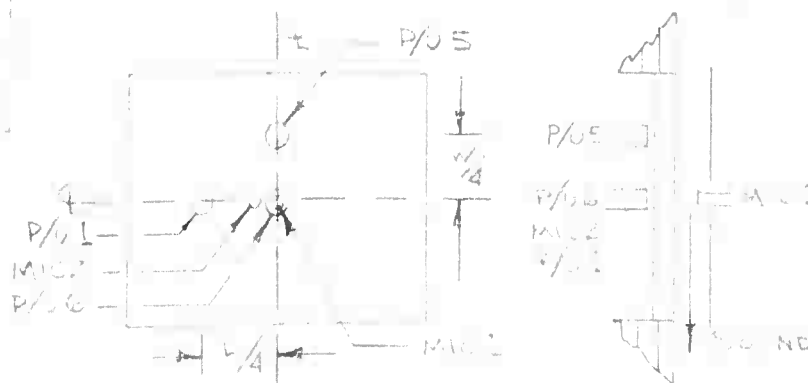
DATA IDENTIFICATION

Test Title PANEL ATTACH. TYPE I PRELIM.		
EWA No. C-593	Panel or Specimen No. 1493	
Tape No. 20	Tape Channel 4	Displacement Pickup # 1
Elapsed Test Time +5 MIN		P/U RMS Level at Sonic Lab. VL = .140 Volts

CALIBRATION

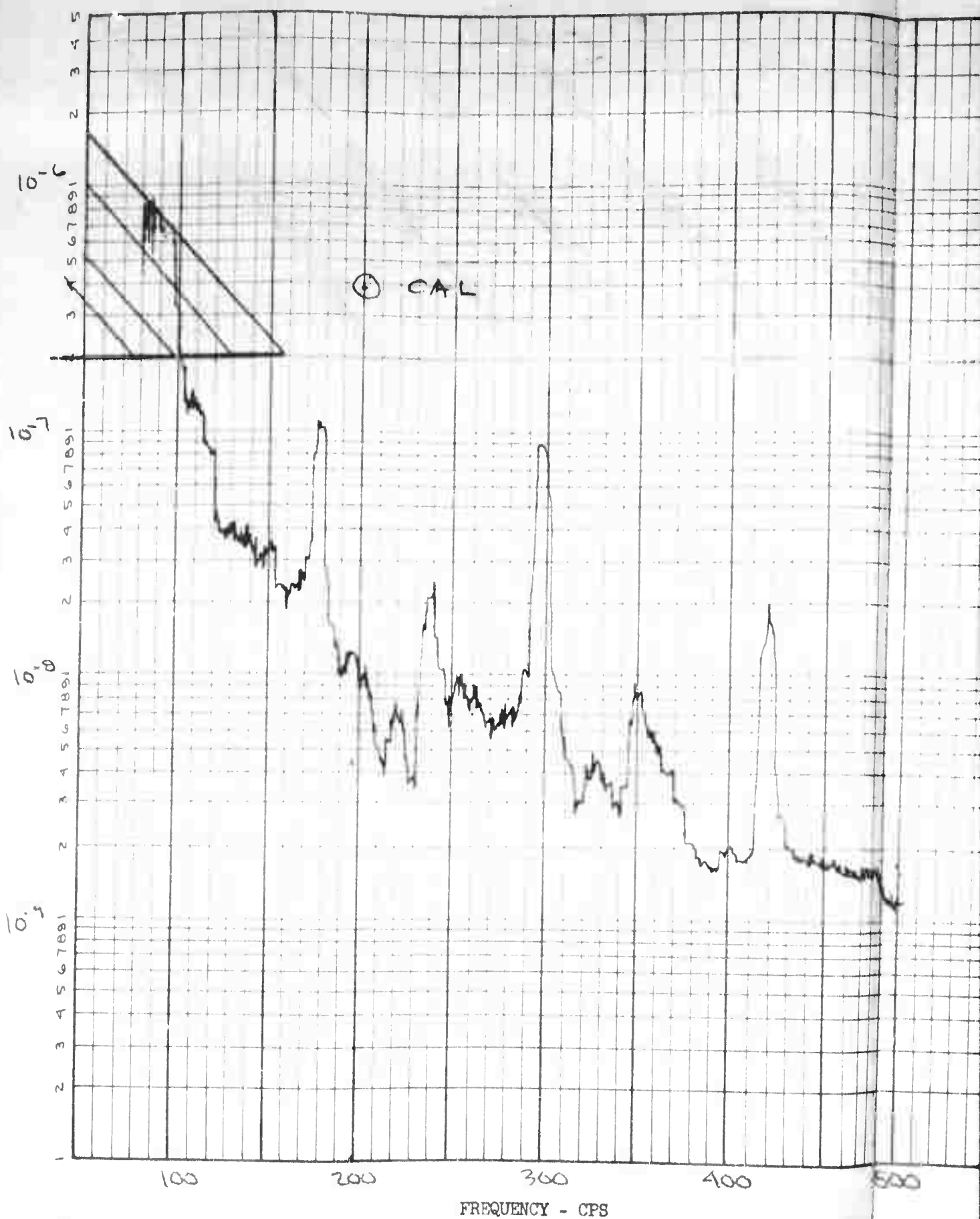
Tape No. 20	Tape Channel 1	Data Tape RMS Volt $V_R = .142$
Calibration Voltage $V_a = .5 V_{rms}$ into Line Amp.; $V_c = .50 V_{rms}$ on Tape @ 200 cps		
Line Amplifier Settings For Calibration $G_c = .100$; for Data $G_d = .100$		
Lab. Gain $LG = 1.0$	Tape Monitor Gain $TMG = \frac{G_d}{G_c} = 1.0$	
Displacement Pickup Sensitivity $S = .0707 \text{ in./Volt}$		
Equivalent of Calibration - in. $D_c = V_a \cdot S = .03535$		
Equivalent of Calibration for PSD Plots $\left(\frac{D_c}{(TMG)(LG)} \right)^2 = \left[\frac{.03535}{(1.0)(1.0)} \right]^2 = 1.225 \times 10^{-3} \text{ in.}^2/\text{cps}$		
Analyzer Attenuator Setting -20 db	Log Converter Setting 0 db	
Calibration Plotted at $1.225 \times 10^{-5} \text{ in.}^2/\text{cps}$		
Overall Deflection Level of Data $\text{RMS Defl. Level} = \frac{(D_c)(V_R)}{(TMG)(LG)(V_c)} = \frac{(.03535)(.142)}{(1.0)(1.0)(.5)} = .0100 \text{ in.}$		

FOR FREQUENCIES
ABOVE 150 CPS
USE PAGE 165



CALC	10/10	REVISED	DATE	POWER SPECTRAL DENSITY ANALYSIS OF DISPLACEMENT PICKUP SIMUL TEST P/U 1, PANEL 1493, PHASE A BOEING AIRPLANE COMPANY SEATTLE 24, WASHINGTON	VOL I 20 80001 PAGE FIG 164
CHECK	50A	4/2/61			
APP					
APP					

POWER SPECTRAL DENSITY - (In.)²/cps



ANALYSIS VARIABLES

Bandwidth

5 cycles from 80 to 550 cps
 _____ cycles from _____ to _____ cps
 _____ cycles from _____ to _____ cps

T_c 4 Sec.
 Anal. Rate 1.25 cps/sec.
 Loop Length 4 Sec.

CALC	MM	6
CHECK	30A	4
APR		
APR		

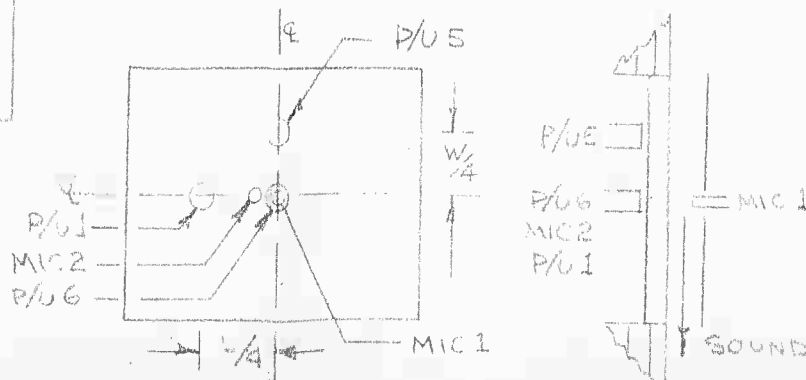
DATA IDENTIFICATION

Test Title PANEL ATTACH TYPE I PRELIM.		
EWA No. 5593	Panel or Specimen No. 1493	
Tape No. 20	Tape Channel 4	Displacement Pickup # 1
Elapsed Test Time +5 MIN		P/U RMS Level at Sonic Lab. V_L = .140 Volts

CALIBRATION

Tape No. 20	Tape Channel 1	Data Tape RMS Volt V_R = .142
Calibration Voltage V_a = .5 V_{rms} into Line Amp.; V_c = 50 V_{rms} on Tape @ 200cps		
Line Amplifier Settings For Calibration G_c = .100 ; for Data G_d = .100		
Lab. Gain LG = 1.0	Tape Monitor Gain TMG = $\frac{G_d}{G_c} = 1.0$	
Displacement Pickup Sensitivity S = .007 in./Volt		
Equivalent of Calibration - in. D_c = V_a · S = .03535		
Equivalent of Calibration for PSD Plots $\left(\frac{D_c}{(TMG)(LG)}\right)^2 = \left[\frac{.03535}{(1.0)(1.0)}\right]^2 = 1.225 \times 10^{-3}$ in.²/cps		
Analyzer Attenuator Setting -35 db	Log Converter Setting 0 db	
Calibration Plotted at 3.87 (10⁻⁷) in.²/cps		
Overall Deflection Level of Data RMS Defl. Level = $\frac{(D_c)(V_R)}{(TMG)(LG)(V_c)} = \frac{(.03535)(.142)}{(1)(1)(50)} = .0100$ in.		

FOR FREQUENCIES
BELOW 130 CPS
USE PAGE 164

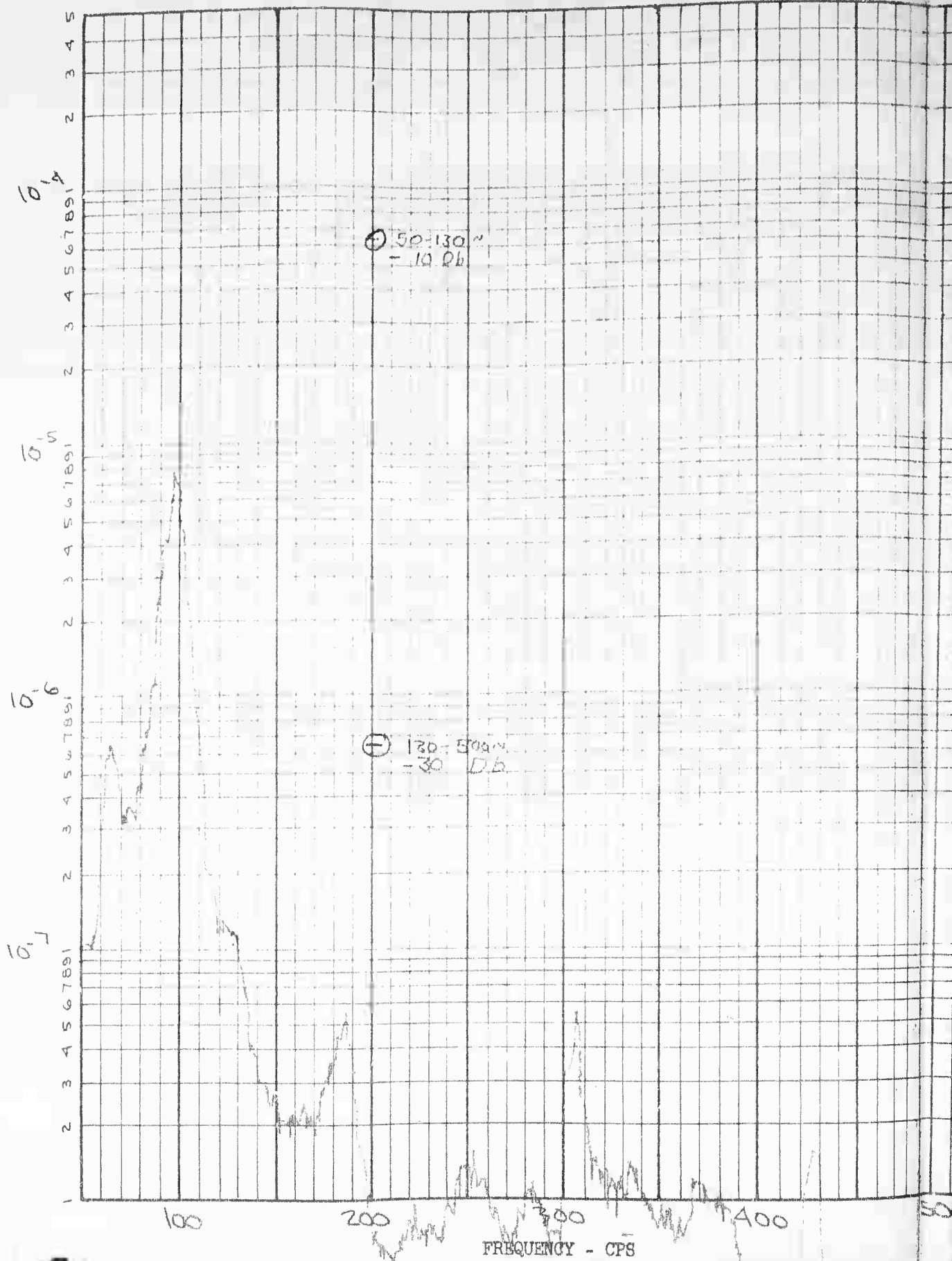


CALC	6-22-61	REVISED	DATE	POWER SPECTRAL DENSITY ANALYSIS OF DISPLACEMENT PICKUP 5 MIN TEST P/U 1 PANEL 1493 PHASE A BOEING AIRPLANE COMPANY SEATTLE 24, WASHINGTON	VOL I D2-50004 PAGE FIG 165
CHECK	4/23/61				
APR.					
APR.					

2-5353-7-9

2

POWER SPECTRAL DENSITY - (In.)²/cps



ANALYSIS VARIABLES

Bandwidth

5 cycles from 50 to 500 cps
 _____ cycles from _____ to _____ cps
 _____ cycles from _____ to _____ cps

T_c 4 Sec.

Anal. Rate 1.25 cps/sec.

Loop Length 4 Sec.

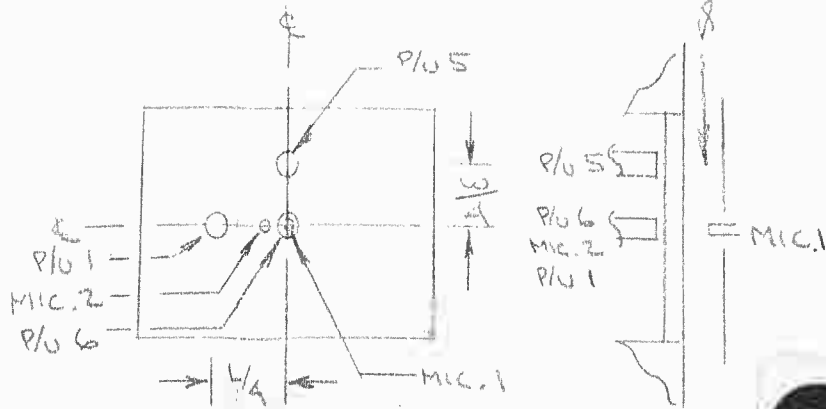
CALC	
CHECK	50
APR.	
APR.	

DATA IDENTIFICATION

Test Title PANEL ATTACH TYPE I - PRELIM		
EWA No. 5-593	Panel or Specimen No. 1493	
Tape No. 20	Tape Channel 5	Displacement Pickup # 5
Elapsed Test Time +5 MIN		P/U RMS Level at Sonic Lab. V_L = .090 Volts

CALIBRATION

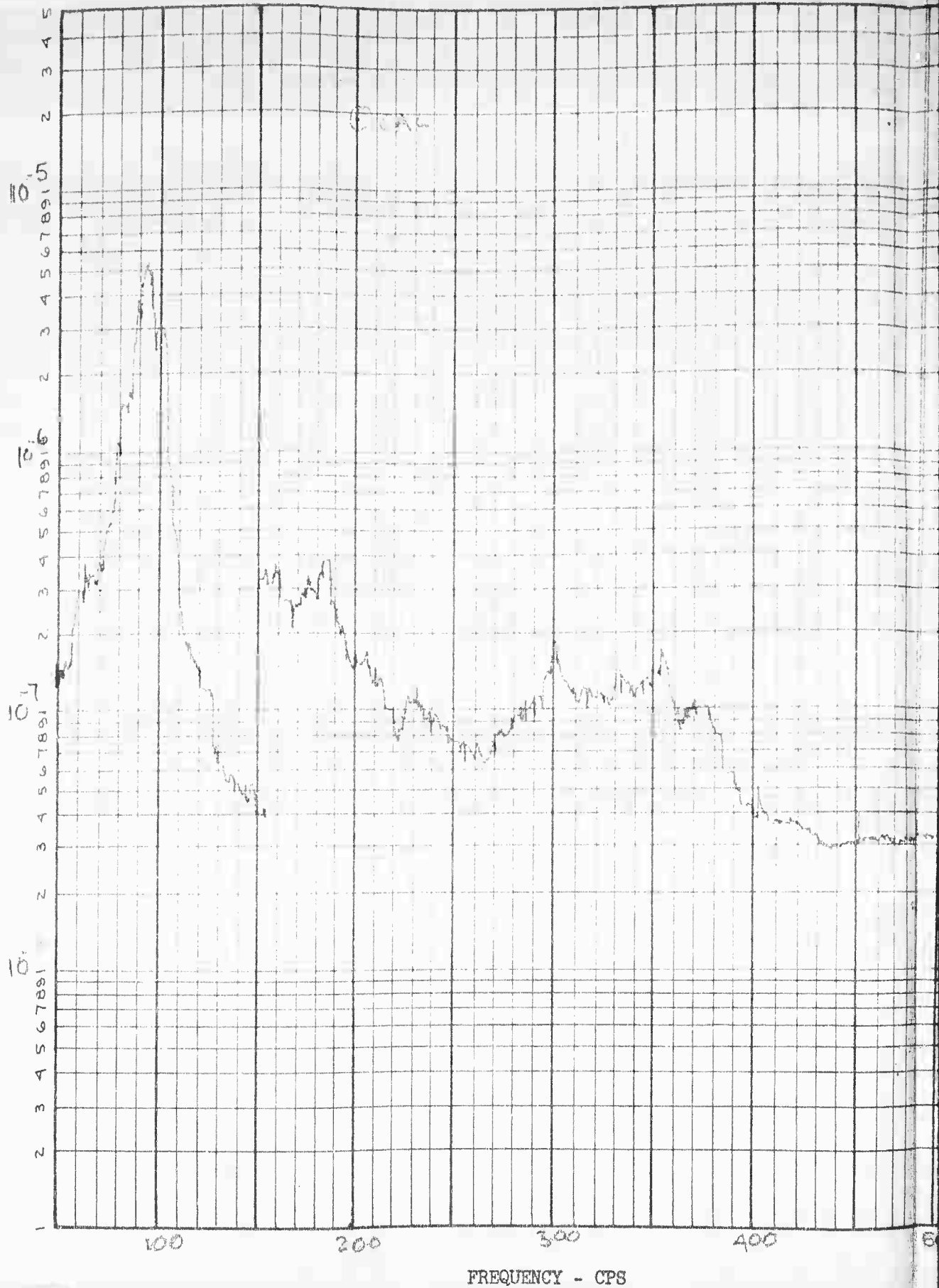
Tape No. 20	Tape Channel 5	Data Tape RMS Volt V_R = .215
Calibration Voltage V_a = .5 V_{rms} into Line Amp.; V_c = .5 V_{rms} on Tape @ 200 cps		
Line Amplifier Settings For Calibration G_c = .100 ; for Data G_d = .200		
Lab. Gain LG = 1.0	Tape Monitor Gain TMG = $\frac{G_d}{G_c} = 2$	
Displacement Pickup Sensitivity S = .100 in./Volt		
Equivalent of Calibration - in. D_c = V_a · S = .050		
Equivalent of Calibration for PSD Plots $\left(\frac{D_c}{(TMG)(LG)}\right)^2 = \left(\frac{.050}{(2)(1)}\right)^2 = 6.25 \times 10^{-4}$ in.²/cps		
Analyzer Attenuator Setting 50-300 ~ -10 130-300 ~ -30		Log Converter Setting db
Calibration Plotted at 6.25 (10⁻⁴) in.²/cps		
Overall Deflection Level of Data RMS Defl. Level = $\frac{(D_c)(V_R)}{(TMG)(LG)(V_c)} = \frac{(.050)(.215)}{(2)(1)(.5)} = .0107$ in.		



CALC	6/16/61	REVISED	DATE	POWER SPECTRAL DENSITY ANALYSIS OF DISPLACEMENT PICKUP 5 MIN TEST P/U #5 PANEL 1493 PHASE A BOEING AIRPLANE COMPANY SEATTLE 24, WASHINGTON	VOL I
CHECK	SDA				DZ-8008A
APR.					PAGE
APR.					FIA 166

2-5353-7-9

POWER SPECTRAL DENSITY - (in.)²/cps



FREQUENCY - CPS

ANALYSIS VARIABLES

Bandwidth

5 cycles from 50 to 550 cps
 _____ cycles from _____ to _____ cps
 _____ cycles from _____ to _____ cps

T_c 4 Sec.

Anal. Rate 1.25 cps/sec.

Loop Length 4 Sec.

CALC

CHECK

APR.

APR.

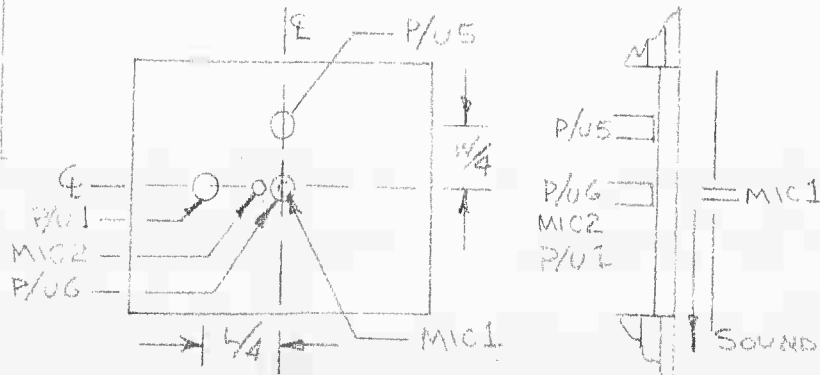
DATA IDENTIFICATION

Test Title PANEL ATTACH TYPE I PHASE		
EWA No. E 1000	Panel or Specimen No. 1493	
Tape No. 30	Tape Channel 6	Displacement Pickup # 6
Elapsed Test Time 4:5 MIN		P/U RMS Level at Sonic Lab. VL = .120 Volts

CALIBRATION

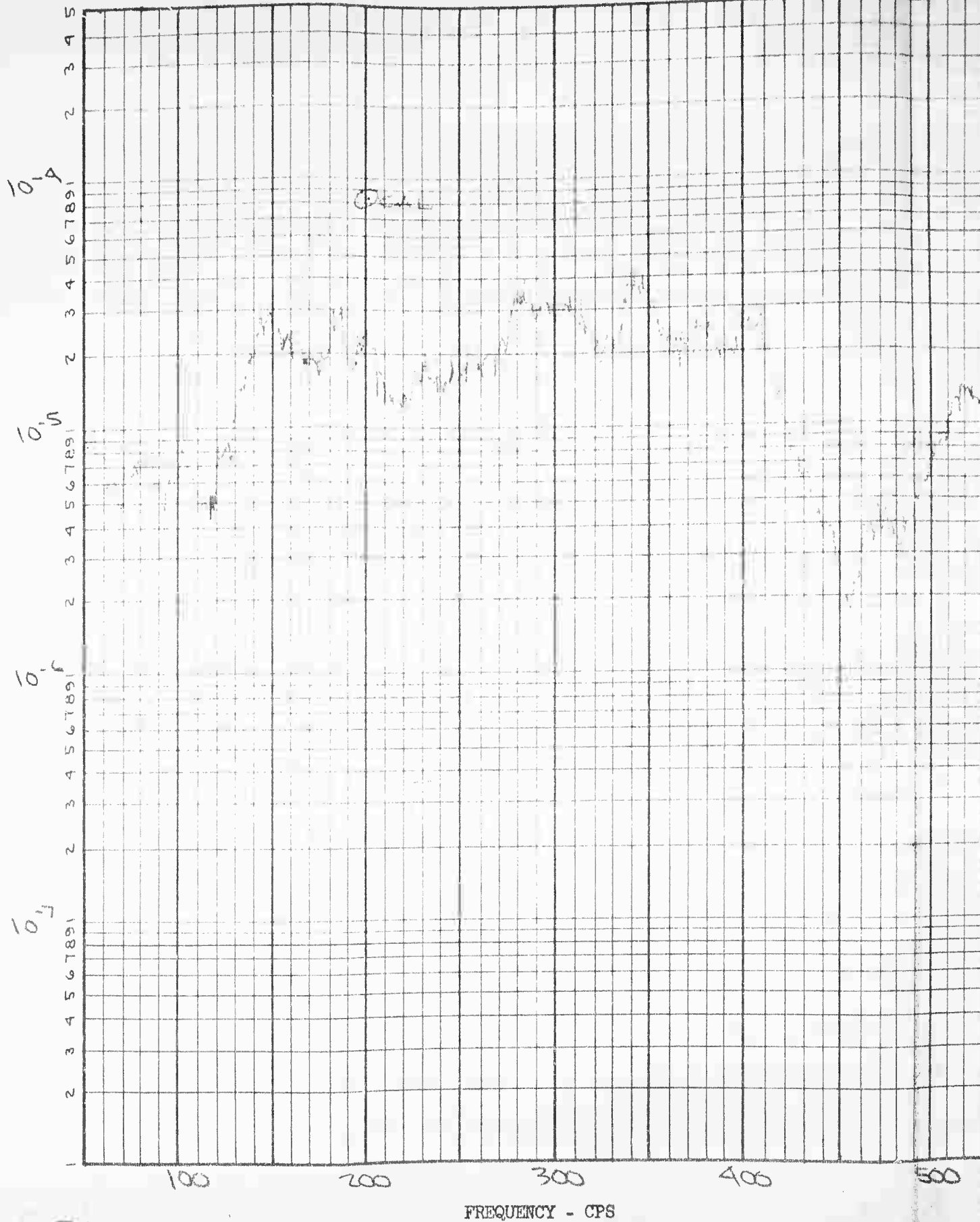
Tape No. 30	Tape Channel 1	Data Tape RMS Volt VR = .100
Calibration Voltage VA = .5 Vrms into Line Amp.; VC = .5 Vrms on Tape @ 200cps		
Line Amplifier Settings For Calibration GC = .1 ; for Data GD = .1		
Lab. Gain LG = .1	Tape Monitor Gain TMG = $\frac{GD}{GC} = 1.0$	
Displacement Pickup Sensitivity S = .0816 in./Volt		
Equivalent of Calibration - in. DC = VA * S = .0432		
Equivalent of Calibration for PSD Plots $\left(\frac{DC}{(TMG)(LG)}\right)^2 = \left(\frac{.0432}{(1)(1)}\right)^2 = 1.92 \times 10^{-3} \text{ in.}^2/\text{cps}$		
Analyzer Attenuator Setting -20 db -30	Log Converter Setting db	
Calibration Plotted at 1.92×10^{-5} $1.92 \times 10^{-6} \text{ in.}^2/\text{cps}$		
Overall Deflection Level of Data RMS Defl. Level = $\frac{(DC)(VR)}{(TMG)(LG)(VC)} = \frac{(.0432)(.100)}{(1)(1)(.5)} = .009 \text{ in.}$		

TO 150 CPS USE
LEFT SCALE,
150 500 CPS USE
RIGHT SCALE



CALC	C.T.	6/23/61	REVISED	DATE	POWER SPECTRAL DENSITY ANALYSIS OF DISPLACEMENT PICKUP	Vol I
CHECK	JOA	6/23/61			P/U #6 PANEL 1493 PHASE A	D2-B0084
APR.					5 MIN TEST	
APR.					BOEING AIRPLANE COMPANY	PAGE
					SEATTLE 24, WASHINGTON	FIG 167

POWER SPECTRAL DENSITY - (psi)²/cps



1

ANALYSIS VARIABLES

Bandwidth

5 cycles from 50 to 500 cps
 _____ cycles from _____ to _____ cps
 _____ cycles from _____ to _____ cps

T_c 4 Sec.
 Anal. Rate 1.25 cps/Sec.
 Loop Length 4 Sec.

CALC	C.T.
CHECK	SOP
APR.	
APR	JTC

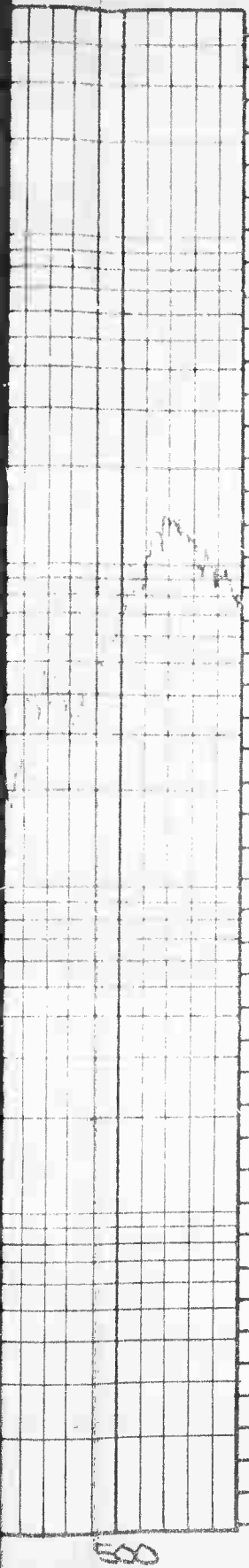
DATA IDENTIFICATION

Test Title FAMM - A - 1000 - TYPE I MECHAN		
EWA No. E 100	Panel or Specimen No. 40	
Tape No. 23	Tape Channel 1	Mic. No. 1
Elapsed Test Time 1:55:11.1		Mic. RMS Level at Sonic Lab. V _L = — Volts

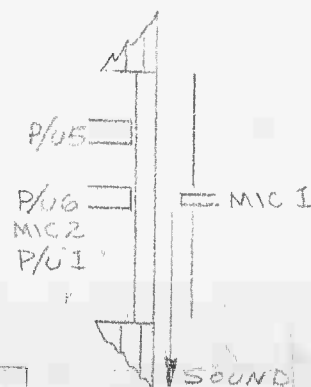
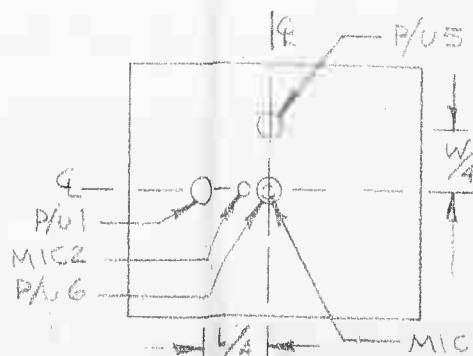
CALIBRATION

Tape No. 23	Tape Channel 7	Data Tape RMS Volt V _R = .192
Calibration Voltage V _a = V _{rms} into Line Amp.; V _c = V _{rms} on Tape @ 200cps		
Line Amplifier Settings For Calibration G _c = .200; for Data G _d = .100		
Lab. Gain LG = 1.0	Tape Monitor Gain TMG = $\frac{G_d}{G_c}$ = .50	
Microphone Sensitivity S = .290 psi/Volt or 1 Volt rms = 160 db SPL		
Equivalent of Calibration - psi P _c = V _a · S = .145		
Equivalent of Calibration for PSD Plots $\left(\frac{P_c}{(TMG)(LG)}\right)^2 = \left[\frac{.145}{(.5)(1.0)}\right]^2 = 8.41 \times 10^{-2} \text{ psi}^2/\text{cps}$		
Analyzer Attenuator Setting 30 db	Log Converter Setting db	
Calibration Plotted at 8.41 × 10 ⁻² psi ² /cps		
Overall Pressure Level Data (P _c)(V _R) RMS pressure level = $\frac{(P_c)(V_R)}{(TMG)(LG)(V_c)}$ = $\frac{(.145)(.192)}{(.5)(1)(.5)} = .112 \text{ psi}$		Equiv. to 151.8 db SPL

SPECTRUM LEVEL - DECIBELS (Re 0.0002 Microbar)

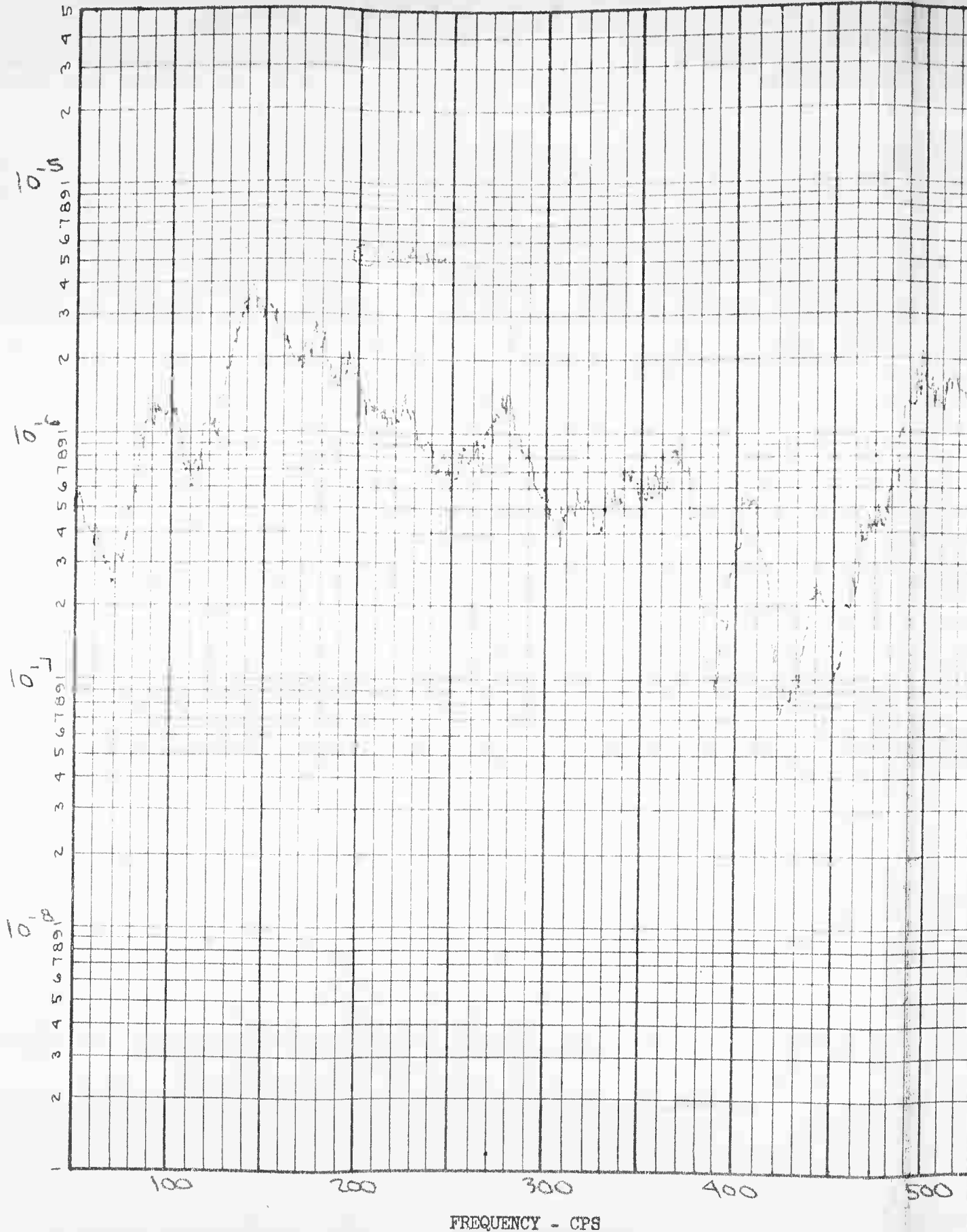


2



CALC	CT	4/22/61	REVISED	DATE	POWER SPECTRAL DENSITY ANALYSIS	VOL I
CHECK	30A	4/22/61			OF MICROPHONE OUTPUT	D280064
APR					MIC. 1 PANEL 1493 PHASE	
APR					BOEING AIRPLANE COMPANY	PAGE
	D.C.	6/22/61			SEATTLE 24, WASHINGTON	FIG 168

POWER SPECTRAL DENSITY - (psi)²/cps



1

ANALYSIS VARIABLES

Bandwidth

5 cycles from 50 to 500 cps
 _____ cycles from _____ to _____ cps
 _____ cycles from _____ to _____ cps

T_c 4 Sec.
 Anal. Rate 1.25 cps/Sec.
 Loop Length 4 Sec.

CALC	C.T.
CHECK	SOA
APR.	
APR.	

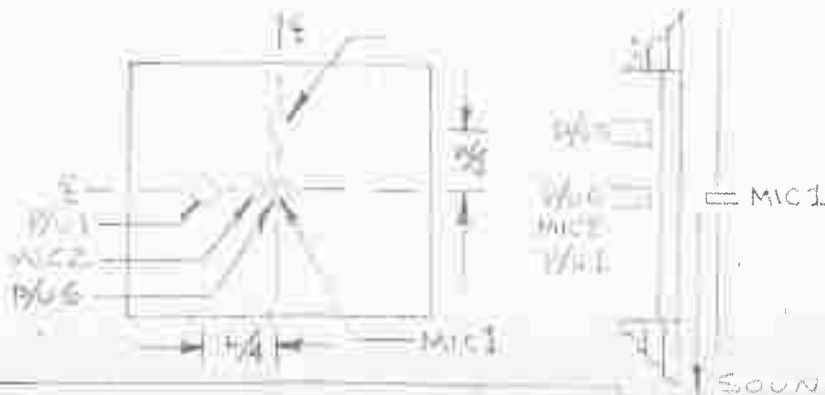
DATA IDENTIFICATION

Test Title PANEL AIRCRAFT TYPE I 1493		
EWA No.	Panel or Specimen No. 1493	
Tape No. 23	Tape Channel 2	Mic. No. 2
Elapsed Test Time 1:58:10		Mic. RMS Level at Sonic Lab. V _L = — Volts

CALIBRATION

Tape No.	Tape Channel 1	Data Tape RMS Volt V _R = .204
Calibration Voltage V _a = — V _{rms} into Line Amp.; V _c = .5 V _{rms} on Tape @ 200cps		
Line Amplifier Settings For Calibration G _c = .200 ; for Data G _d = .400		
Lab. Gain LG = 1.0	Tape Monitor Gain TMG = $\frac{G_d}{G_c}$ = 2.0	
Microphone Sensitivity S = — psi/Volt or 1 Volt rms = 160 db SPL		
Equivalent of Calibration - psi P _c = V _a · S = —		
Equivalent of Calibration for PSD Plots $\left(\frac{P_c}{(TMG)(LG)} \right)^2 = — — — — —$ psi ² /cps		
Analyzer Attenuator Setting — db	Log Converter Setting — db	
Calibration Plotted at — — — — — psi ² /cps		
Overall Pressure Level Data RMS pressure level = $\frac{(P_c)(V_R)}{(TMG)(LG)(V_c)}$ = $\frac{(145)(.204)}{(2.0)(1.0)} = .0296$ psi		Equiv. to 140 db SPL

SPECTRUM LEVEL - DECIBELS (Re 0.0002 Microbar)



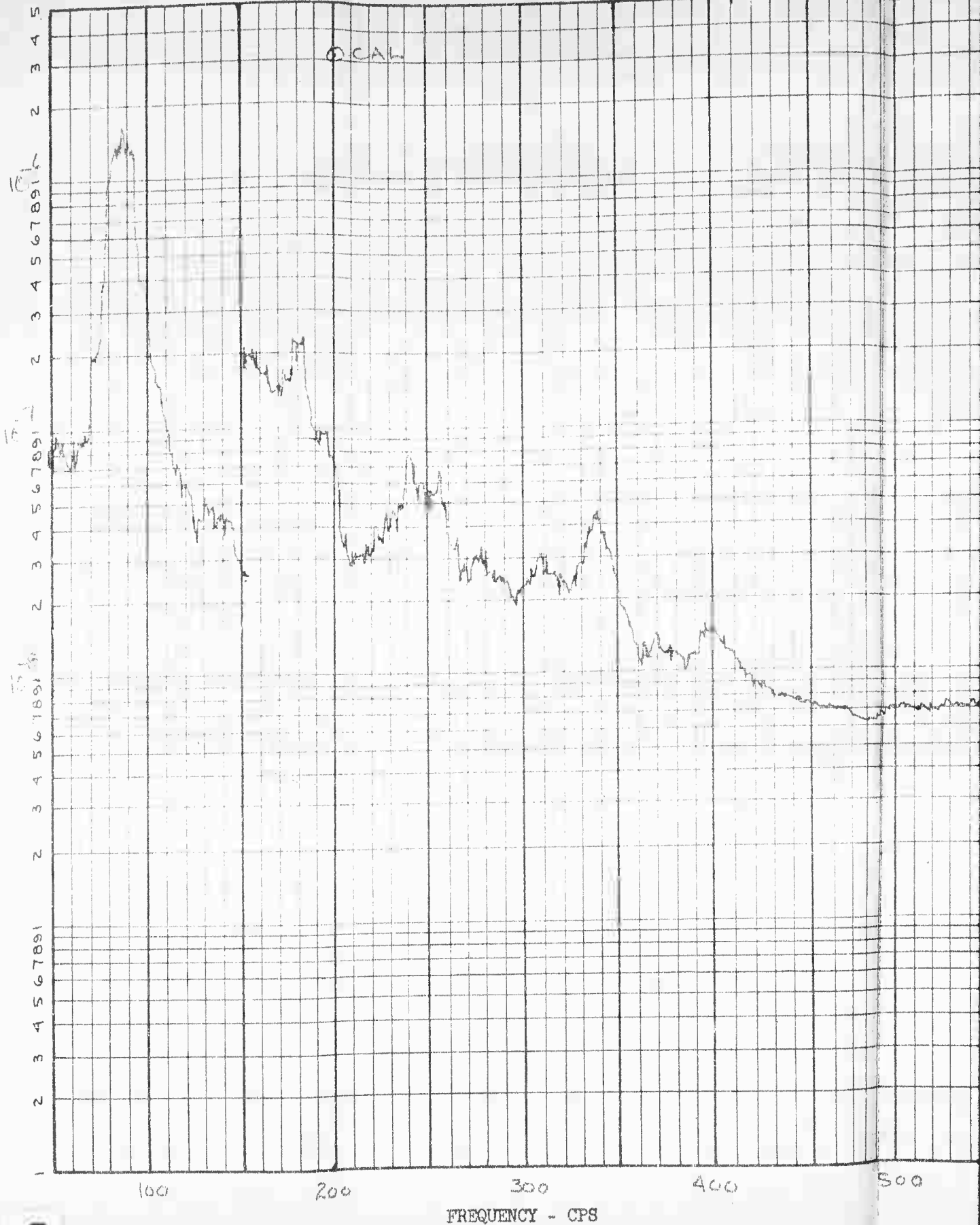
CALC	C.T.	6/2/61	REVISED	DATE
CHECK	SOA	6/20/61		
APR.				
APR.				

POWER SPECTRAL DENSITY ANALYSIS OF MICROPHONE OUTPUT		Va I
MIC. #2 PANEL 1493 PHASE B		02-80084
BOEING AIRPLANE COMPANY		PAGE
SEATTLE 24, WASHINGTON		FIG. 169

2-5353-7-8

2

POWER SPECTRAL DENSITY - (In.)²/cps



1

ANALYSIS VARIABLES

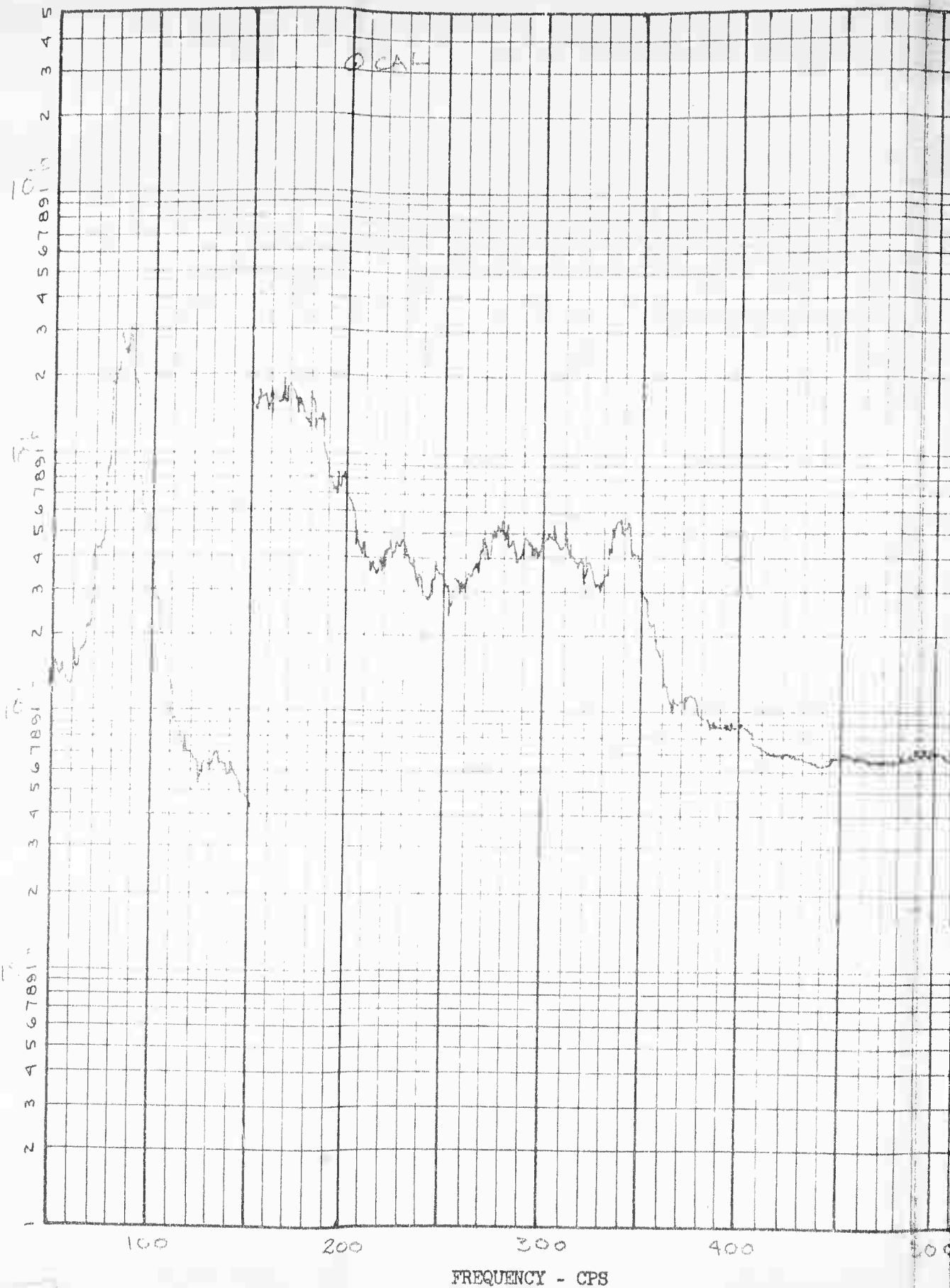
Bandwidth

5 cycles from 50 to 500 cps
 — cycles from — to — cps
 — cycles from — to — cps

T_c 4 Sec.
 Anal. Rate 1.25 cps/sec.
 Loop Length 4 Sec.

CALC	C.T.
CHECK	30A
APR.	
APR	

POWER SPECTRAL DENSITY - (In.)²/cps



1

ANALYSIS VARIABLES

Bandwidth

5 cycles from 50 to 550 cps
 _____ cycles from _____ to _____ cps
 _____ cycles from _____ to _____ cps

T_c 4 Sec.

Anal. Rate 1.25 cps/sec.

Loop Length 4 Sec.

CALC	CB
CHECK	SC
APR	
APR	A

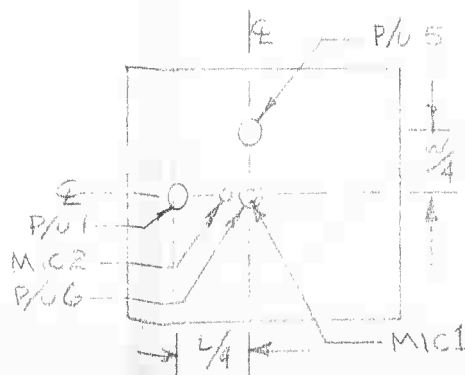
DATA IDENTIFICATION

Test Title PANEL ATTACH TYPE I PRELIM.		
EWA No. 5-573	Panel or Specimen No. 1493	
Tape No. 23	Tape Channel 4	Displacement Pickup # 5
Elapsed Test Time +58		P/U RMS Level at Sonic Lab. VL = .210 Volts

CALIBRATION

Tape No. 23	Tape Channel 7	Data Tape RMS Volt VR = .200
Calibration Voltage Va = .5 Vrms into Line Amp.; Vc = .50 Vrms on Tape @ 200 cps		
Line Amplifier Settings For Calibration Gc = .200 ; for Data Gd = .200		
Lab. Gain LG = 1.0	Tape Monitor Gain TMG = $\frac{G_d}{G_c} = 1.0$	
Displacement Pickup Sensitivity S = .0354 in./Volt		
Equivalent of Calibration - in. Dc = Va · S = .0177		
Equivalent of Calibration for PSD Plots $\left(\frac{D_c}{(TMG)(LG)} \right)^2 = \left[\frac{.0177}{(1)(1)} \right]^2 = 3.13(10^{-4}) \text{ in.}^2/\text{cps}$		
Analyzer Attenuator Setting -10 dB	Log Converter Setting dB	
Calibration Plotted at 3.13 × 10 ⁻⁵ 3.13 × 10 ⁻¹	in. ² /cps	
Overall Deflection Level of Data $\text{RMS Defl. Level} = \frac{(D_c)(V_R)}{(TMG)(LG)(V_C)} = \frac{(.0177)(.200)}{(1)(1)(.50)} = .0071 \text{ in.}$		

TO 150 CPS USE
LEFT SCALE
150-500 CPS USE
RIGHT SCALE



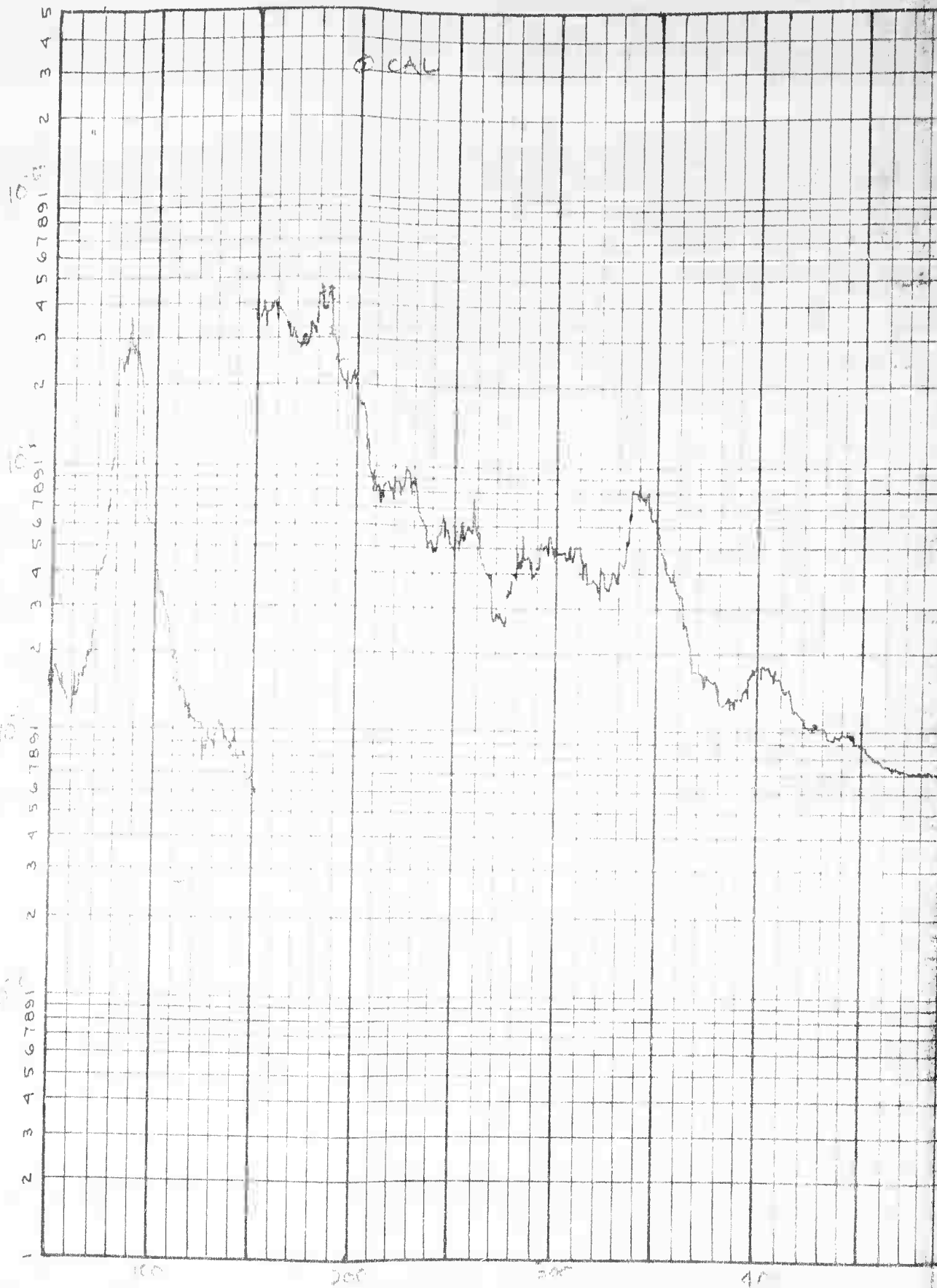
P/U 5
P/U 6
MIC 2
P/U 1
MIC 1
SOUND

CALC	SET	6/23/61	REVISED	DATE	POWER SPECTRAL DENSITY ANALYSIS OF DISPLACEMENT PICKUP 55 MIN TEST	VOL I
CHECK	SOA	6/24/61			P/U 5 PANEL 1493 PHASE B	0290000
APP					BOEING AIRPLANE COMPANY	PAGE
APP		6/24/61			SEATTLE 24, WASHINGTON	FIG 171

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2

POWER SPECTRAL DENSITY - $(\text{In.})^2/\text{cps}$



FREQUENCY - CPS

ANALYSIS VARIABLES

Bandwidth

5 cycles from 50 to 550 cps
 _____ cycles from _____ to _____ cps
 _____ cycles from _____ to _____ cps

T_c 4 Sec.

Anal. Rate 125 cps/sec.

Loop Length 4 Sec.

CALC
 CHECK
 APR
 APR

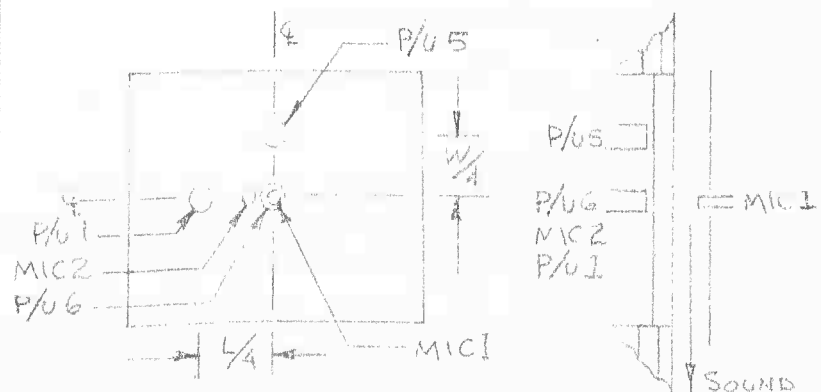
DATA IDENTIFICATION

Test Title PANEL ATTACH TYPE I FEELIM		
EWA No. E-552	Panel or Specimen No. 1493	
Tape No. 22	Tape Channel 5	Displacement Pickup # 6
Elapsed Test Time 4:58		P/U RMS Level at Sonic Lab. VL = .230 Volts

CALIBRATION

Tape No. 22	Tape Channel 7	Data Tape RMS Volt $V_R = .215$
Calibration Voltage $V_A = .5 V_{rms}$ into Line Amp.; $V_C = .5 V_{rms}$ on Tape @ 100 cps		
Line Amplifier Settings For Calibration $G_C = .200$; for Data $G_d = .200$		
Lab. Gain LG = 1.0	Tape Monitor Gain $TMG = \frac{G_d}{G_C} = 1.0$	
Displacement Pickup Sensitivity $S = .004 \text{ in./Volt}$		
Equivalent of Calibration - in. $D_C = V_A \cdot S = .002 \text{ in.}$		
Equivalent of Calibration for PSD Plots $\left(\frac{D_C}{(TMG)(LG)} \right)^2 = \left[\frac{.002}{(1.0)(1.0)} \right]^2 = .0004 \text{ in.}^2/\text{cps}$		
Analyzer Attenuator Setting 10 db	Log Converter Setting db	
Calibration Plotted at 100 cps in. ² /cps		
Overall Deflection Level of Data $RMS \text{ Defl. Level} = \frac{(D_C)(V_R)}{(TMG)(LG)(V_C)} = \frac{(.002)(.215)}{(1.0)(1.0)(.5)} = .0086 \text{ in.}$		

TO 150 CPS USE
LEFT SCALE
150-550 CPS USE
RIGHT SCALE

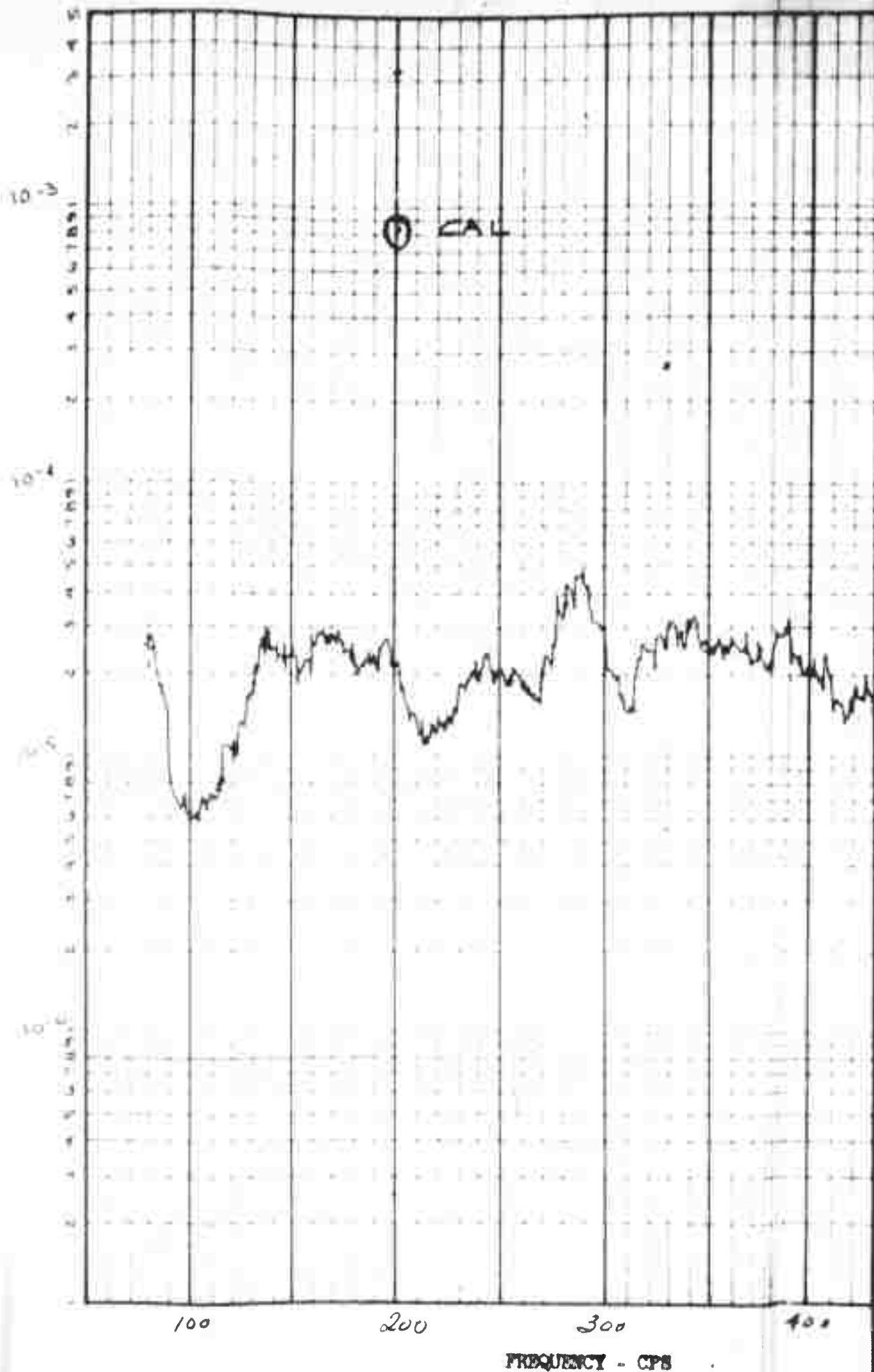


CALC JBT	6/23/6	REVISED	DATE	POWER SPECTRAL DENSITY ANALYSIS OF DISPLACEMENT PICKUP 55 MIN TEST	VOL I
CHECK JQA	6/24/6			P/U 6 PANEL 1493 TAPES 1	DZ80084
APR				BOEING AIRPLANE COMPANY	PAGE
APR	6/22/6			SEATTLE 24, WASHINGTON	FIG 172

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2

POWER SPECTRAL DENSITY - (psi)²/cps



ANALYSIS VARIABLES

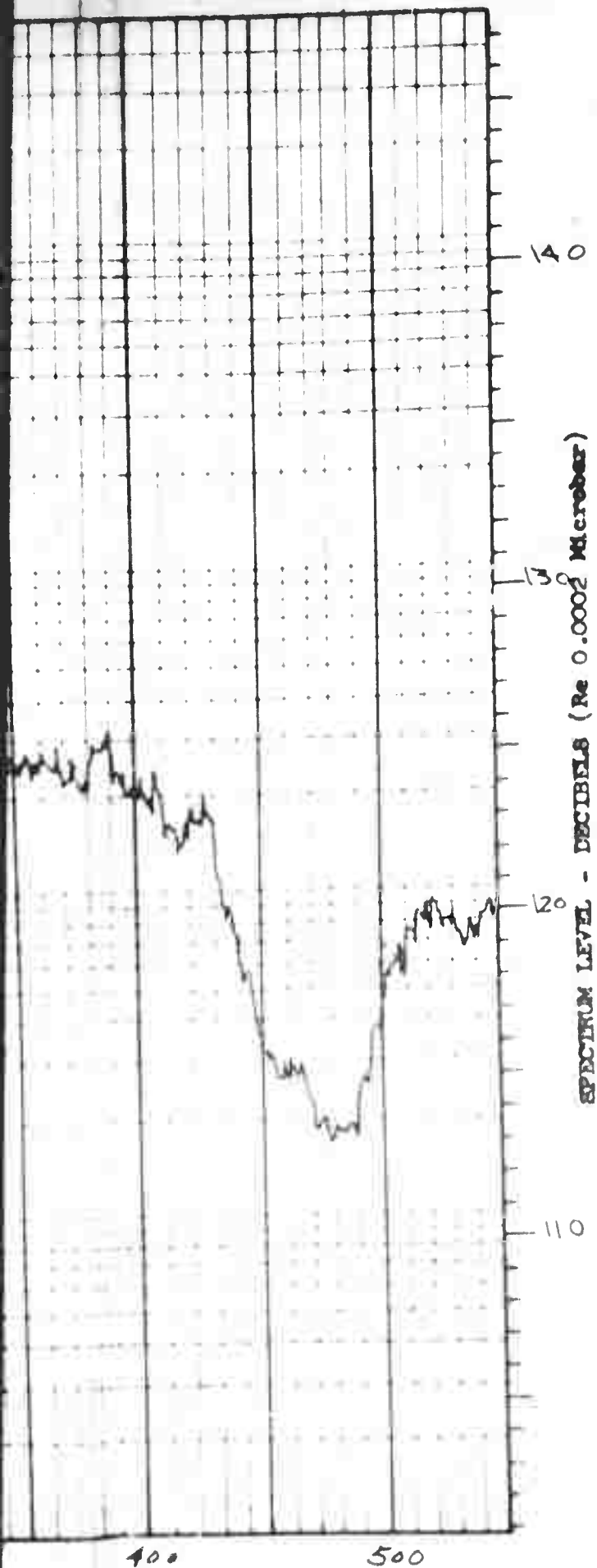
Bandwidth

5 cycles from 80 to 550 cps
 — cycles from — to — cps
 — cycles from — to — cps

4 Sec.

Anal. Rate 125 cps/Sec.

Loop Length 4 Sec.

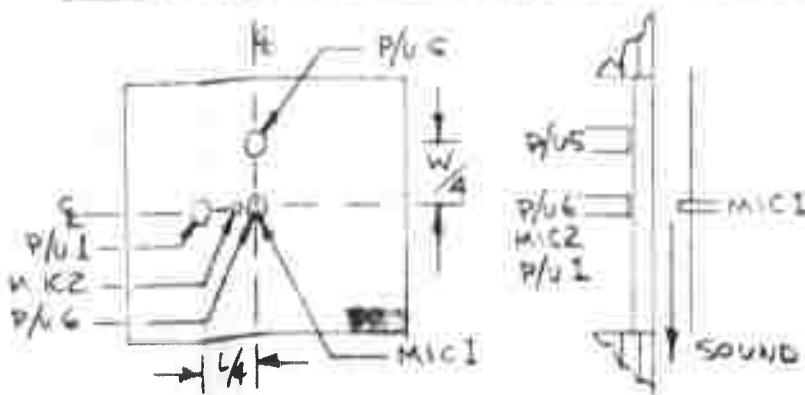


DATA IDENTIFICATION

Test Title PANEL ATTACH. TYPE I PRELIM.		
EWA No. 5-593		Panel or Specimen No. 1494
Type No. 21A	Type Channel 6	Mic. No. 1
Elapsed Test Time 15 MIN.		Mic. RMS Level at Sonic Lab. V_L = .398 Volts

CALIBRATION

Type No. 21A	Type Channel 7	Data Type RMS Volt V_R = .200
Calibration Voltage V_a = .5 V_{rms} into Line Amp.; V_c = .5 V_{rms} on Tape @ 200 cps		
Line Amplifier Settings For Calibration G_c = .200; for Data G_d = .100		
Lab. Gain LG = 1.0	Tape Monitor Gain TMD = $\frac{G_d}{G_c} = .5$	
Microphone Sensitivity 8 = .290 psi/Volt or 1 Volt rms = 160 db SPL		
Equivalent of Calibration - psi P_c = V_a · 8 = .145		
Equivalent of Calibration for PSD Plots $\left(\frac{P_c}{(TMD)(LG)}\right)^2 = \left[\frac{.145}{.5(1.0)}\right]^2 = 8.41 (10^{-2})$ psi²/cps		
Analyzer Attenuator Setting -20 db	Log Converter Setting 0 db	
Calibration Plotted at 8.41 (10⁻²) psi²/cps		
Overall Pressure Level Data RMS pressure level = $\frac{(P_c)(V_R)}{(TMD)(LG)(V_c)}$		Equiv. to 152.2 db SPL
$\frac{.145 (.200)}{(.5)(1) (.5)} = .116$ psi		



C.T. 6/29/21
RAL 6-204

POWER SPECTRAL DENSITY ANALYSIS
OF MICROPHONE OUTPUT

VOL I

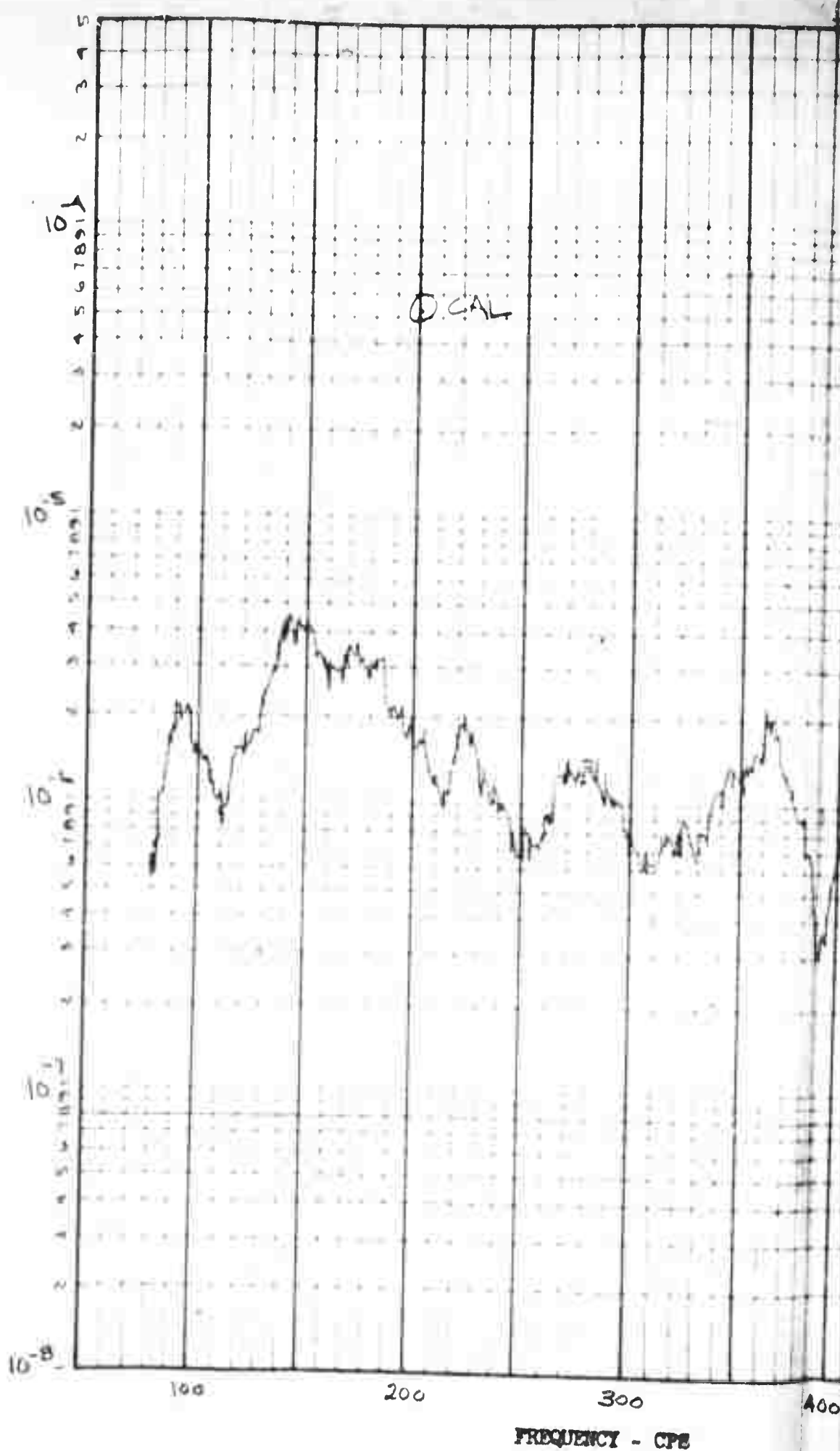
MIC¹ PANEL 1494 PHASE 'A'
BOEING AIRPLANE COMPANY
SEATTLE 24 WASHINGTON

DZ-50094

PAGE
FIG 173

125 cps/Sec.
4 Sec.

POWER SPECTRAL DENSITY - (psf)²/cps

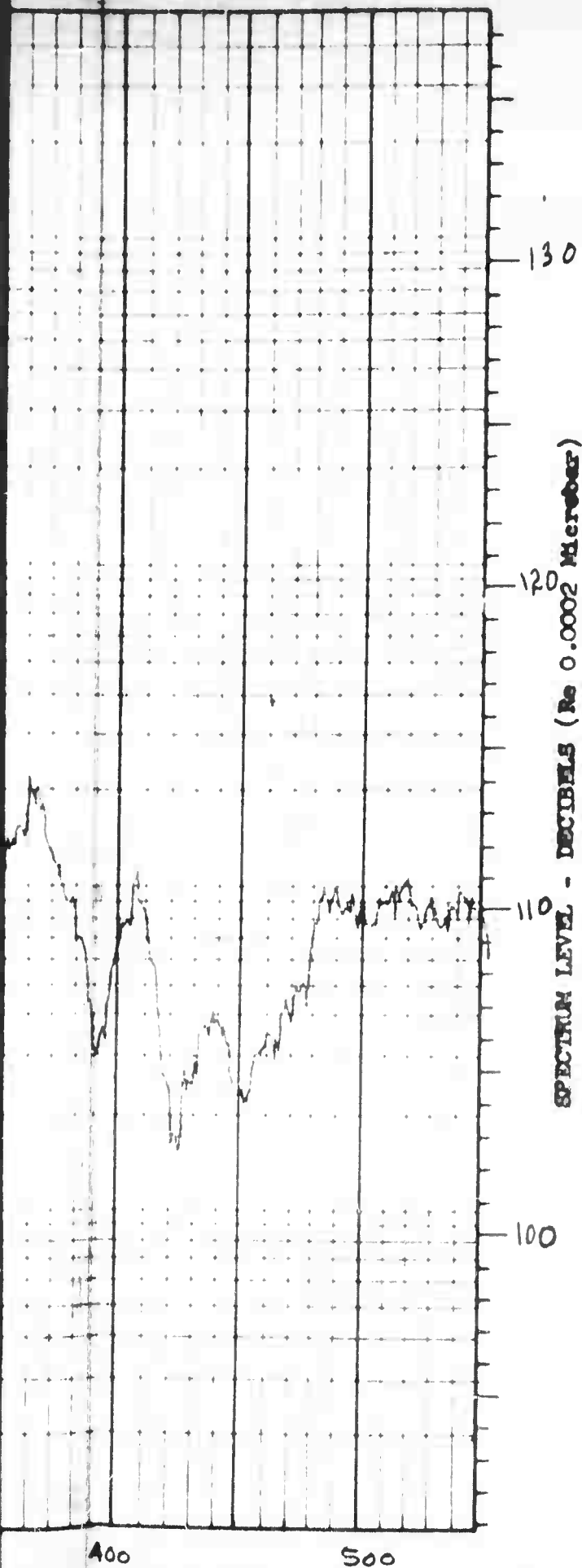


ANALYSIS VARIABLES

Bandwidth

5 cycles from 80 to 550 cps
 ___ cycles from ___ to ___ cps
 ___ cycles from ___ to ___ cps

4 Sec.
 Anal. Rate 1.25 cps/Sec.
 Loop Length 4 Sec.

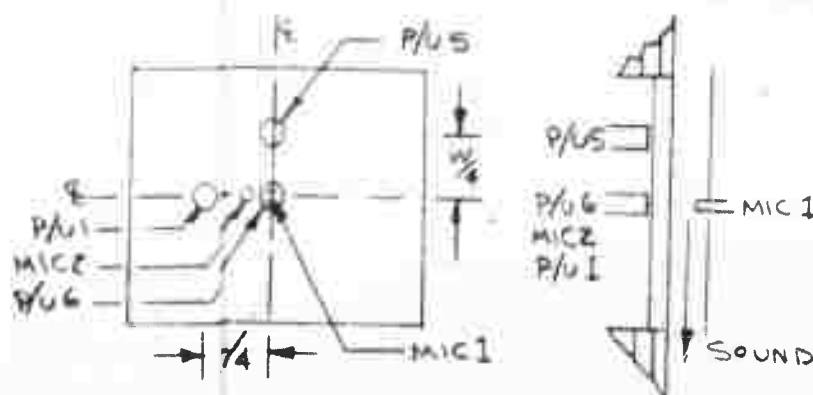


DATA IDENTIFICATION

Test Title PANEL ATTACH. TYPE I PRELIM.		
FWA No. 5-593	Panel or Specimen No. 1494	
Tape No. 2/A	Tape Channel 2	Mic. No. 2
Elapsed Test Time + 5 MIN.		Mic. RMS Level at Sonic Lab. V_L = .112 Volts

CALIBRATION

Tape No. 2/A	Tape Channel 7	Data Tape RMS Volt V_R = .225
Calibration Voltage V_a = .5 V_{rms} into Line Amp.; V_c = .5 V_{rms} on Tape @ 200 cps		
Line Amplifier Settings For Calibration G_c = .200; for Data G_d = .400		
Lab. Gain LG = 1.0	Tape Monitor Gain TMG = $\frac{G_d}{G_c} = 2.0$	
Microphone Sensitivity S = .290 psi/Volt or 1 Volt rms = 160 db SPL		
Equivalent of Calibration - psi P_c = V_a · S = .145		
Equivalent of Calibration for PSD Plots $\left(\frac{P_c}{(TMG)(LG)} \right)^2 = \left[\frac{.145}{(2.0)(1.0)} \right]^2 = 5.26 (10^{-3})$ psi²/cps		
Analyzer Attenuator Setting - 20 db	Log Converter Setting 0 db	
Calibration Plotted at 5.26 (10⁻⁵) psi ² /cps		
Overall Pressure Level Data RMS pressure level = $\frac{(P_c)(V_R)}{(TMG)(LG)(V_c)}$		Equiv. to 141.1 db SPL
= $\frac{(.145)(.225)}{(2)(1.0)(.5)} = .0326$ psi		



APR C.T. 6/26/61
 CHECK RAL 6-201
 APR
 APR LK 6/26/61

POWER SPECTRAL DENSITY ANALYSIS OF MICROPHONE OUTPUT

MIC #2 PANEL 1494 PHASE A
 BOEING AIRPLANE COMPANY
 SEATTLE 28 WASHINGTON

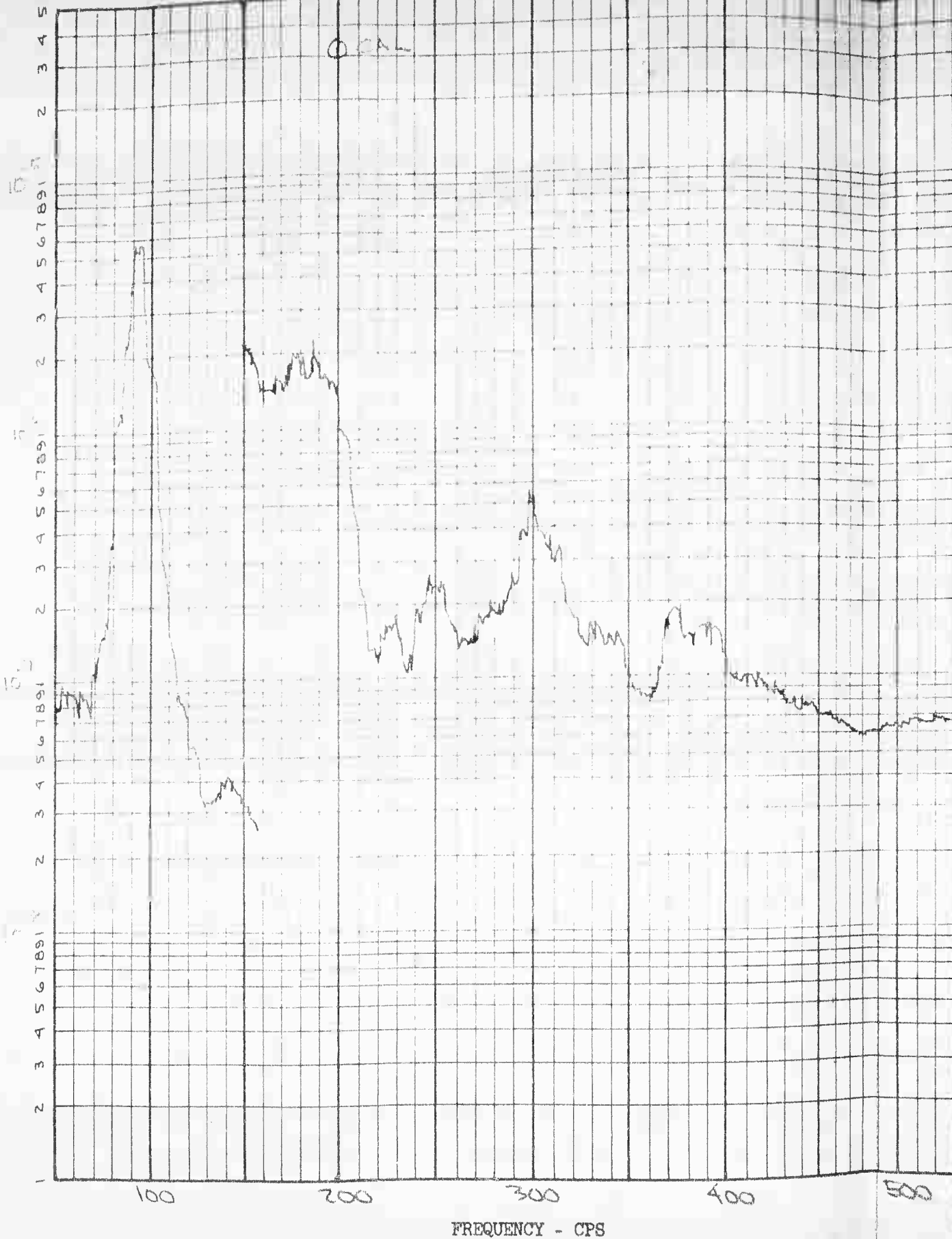
VOL I

DR-80084

PAGE
 FIG 174

0.25 cps/Sec.
 4 Sec.

POWER SPECTRAL DENSITY - (In.)²/cps



ANALYSIS VARIABLES

Bandwidth

5 cycles from 50 to 500 cps
 — cycles from — to — cps
 — cycles from — to — cps

T_c 4 Sec.

Anal. Rate 1.25 cps/sec.

Loop Length 4 Sec.

CALC	CBT
CHECK	SGA
APR.	
APR.	

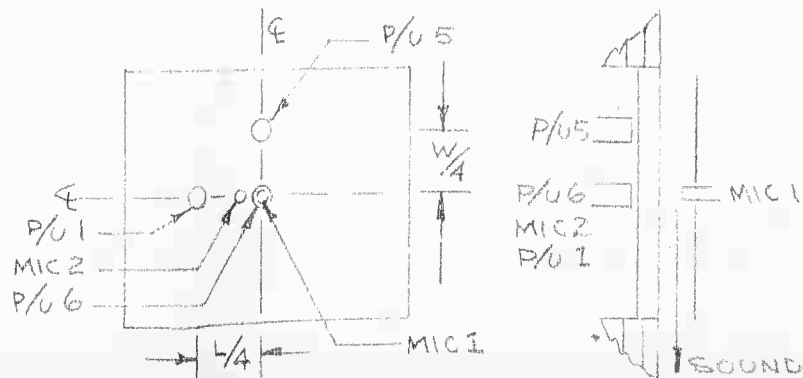
DATA IDENTIFICATION

Test Title PANEL ATTACH. TYPE I PRELIM.		
EWA No. 5-593	Panel or Specimen No. 1494	
Tape No. 21A	Tape Channel 3	Displacement Pickup # 1
Elapsed Test Time +5 MIN		P/U RMS Level at Sonic Lab. V_L = .250 Volts

CALIBRATION

Tape No. 21A	Tape Channel 7	Data Tape RMS Volt V_R = .245
Calibration Voltage V_a = .5 V_{rms} into Line Amp.; V_c = V_{rms} on Tape @ 200 cps		
Line Amplifier Settings For Calibration G _c = .200; for Data G _d = .200		
Lab. Gain LG = 1.0	Tape Monitor Gain TMG = G_d / G_c = 1.0	
Displacement Pickup Sensitivity S = .0354 in./Volt		
Equivalent of Calibration - in. D_c = V_a · S = .0177		
Equivalent of Calibration for PSD Plots $\left(\frac{D_c}{(TMG)(LG)} \right)^2 = \left(\frac{.0177}{(1.0)(1.0)} \right)^2 = 3.13 \times 10^{-4} \text{ in.}^2/\text{cps}$		
Analyzer Attenuator Setting db	Log Converter Setting db	
Calibration Plotted at 3.13 × 10⁻⁵ 3.13 × 10⁻⁷	in.²/cps	
Overall Deflection Level of Data RMS Defl. Level = $\frac{(D_c)(V_R)}{(TMG)(LG)(V_c)} = \frac{(.0177)(.245)}{(1.0)(1.0)(.5)} = .0087 \text{ in.}$		

TO 150 CPS USE
LEFT SCALE
150-530 CPS USE
RIGHT SCALE

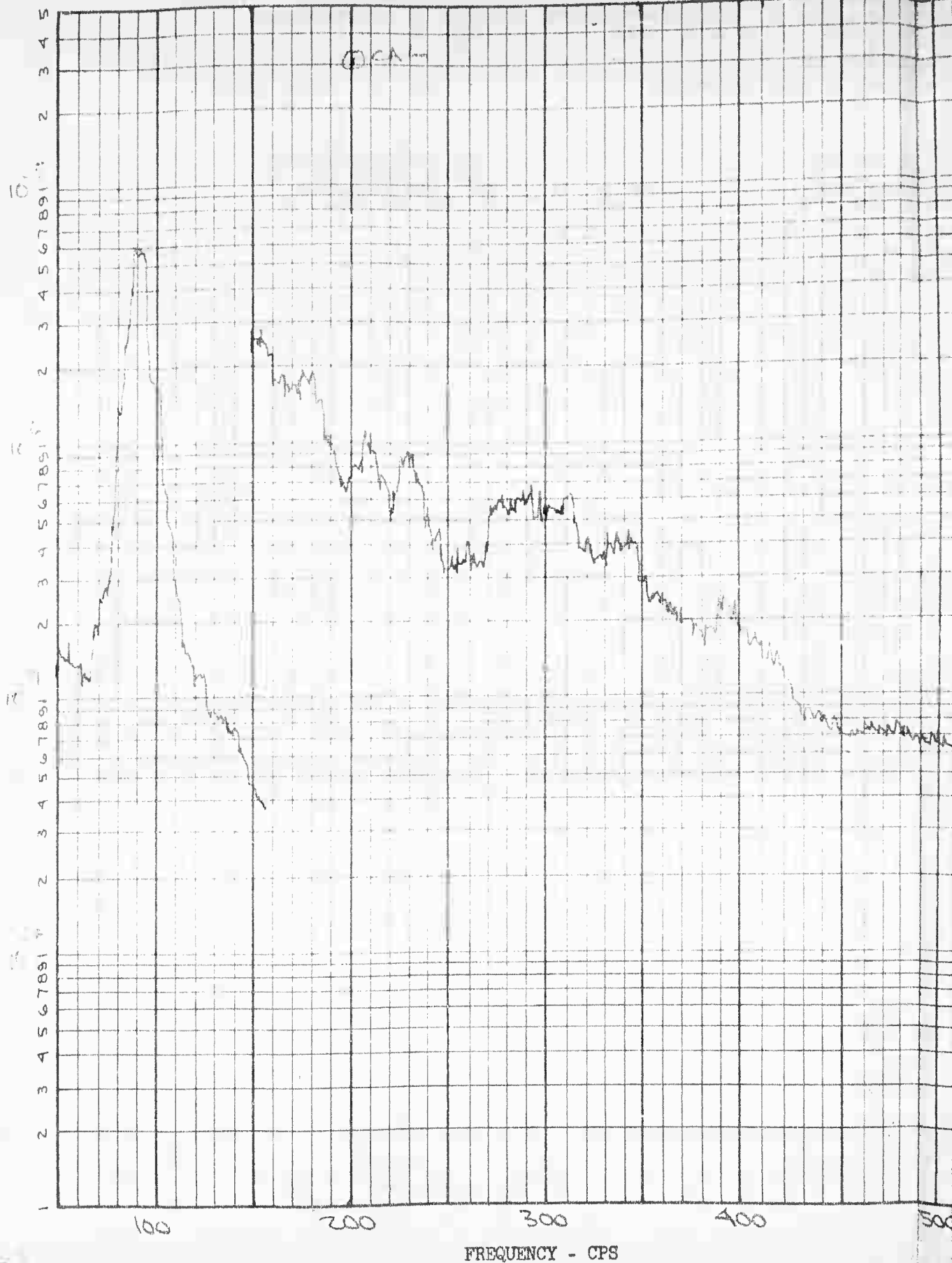


CALC	CBT	6/23/61	REVISED	DATE	POWER SPECTRAL DENSITY ANALYSIS	VOL I
CHECK	SA	4/24/61			OF DISPLACEMENT PICKUP	
APR.					P/U #1 PANEL 1494 PHASE A	DZ-80084
APR.					BOEING AIRPLANE COMPANY	PAGE
					SEATTLE 24, WASHINGTON	FIG 175

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2

POWER SPECTRAL DENSITY - (In.)²/cps



ANALYSIS VARIABLES

Bandwidth

5 cycles from 50 to 500 cps
 — cycles from — to — cps
 — cycles from — to — cps

T_c 4 Sec.

Anal. Rate 1.25 cps/sec.

Loop Length 4 Sec.

CALC	C.B.
CHECK	30
APR.	
APR	

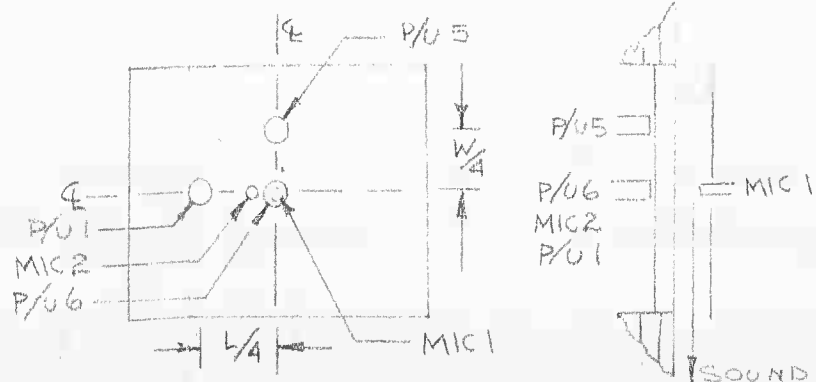
DATA IDENTIFICATION

Test Title PANEL ATTACH. TYPE I PRELIM		
EWA No. 5-593	Panel or Specimen No. 149A	
Tape No. 21A	Tape Channel A	Displacement Pickup # 5
Elapsed Test Time +5 MIN	P/U RMS Level at Sonic Lab. V_L = 260 Volts	

CALIBRATION

Tape No. 21A	Tape Channel 7	Data Tape RMS Volt V_R = .42
Calibration Voltage V_a = .5 V_{rms} into Line Amp.; V_c = .5 V_{rms} on Tape @ 200cps		
Line Amplifier Settings For Calibration G_c = 200; for Data G_d = 200		
Lab. Gain LG = 1.0	Tape Monitor Gain TMG = $\frac{G_d}{G_c} = 1.0$	
Displacement Pickup Sensitivity S = 0.35 in./Volt		
Equivalent of Calibration - in. D_c = V_a · S = .0177		
Equivalent of Calibration for PSD Plots $\left(\frac{D_c}{(TMG)(LG)}\right)^2 = \left(\frac{(0.0177)}{(1.0)(1.0)}\right)^2 = 3.13 \times 10^{-4}$ in.²/cps		
Analyzer Attenuator Setting 10 db	Log Converter Setting 0 db	
Calibration Plotted at 303 in.²/cps		
Overall Deflection Level of Data RMS Defl. Level = $\frac{(D_c)(V_R)}{(TMG)(LG)(V_c)} = \frac{(0.0177)(.42)}{(1.0)(1.0)(.5)} = .0074$ in.		

TO 150 CPS USE
LEFT SCALE
150-550 CPS USE
RIGHT SCALE

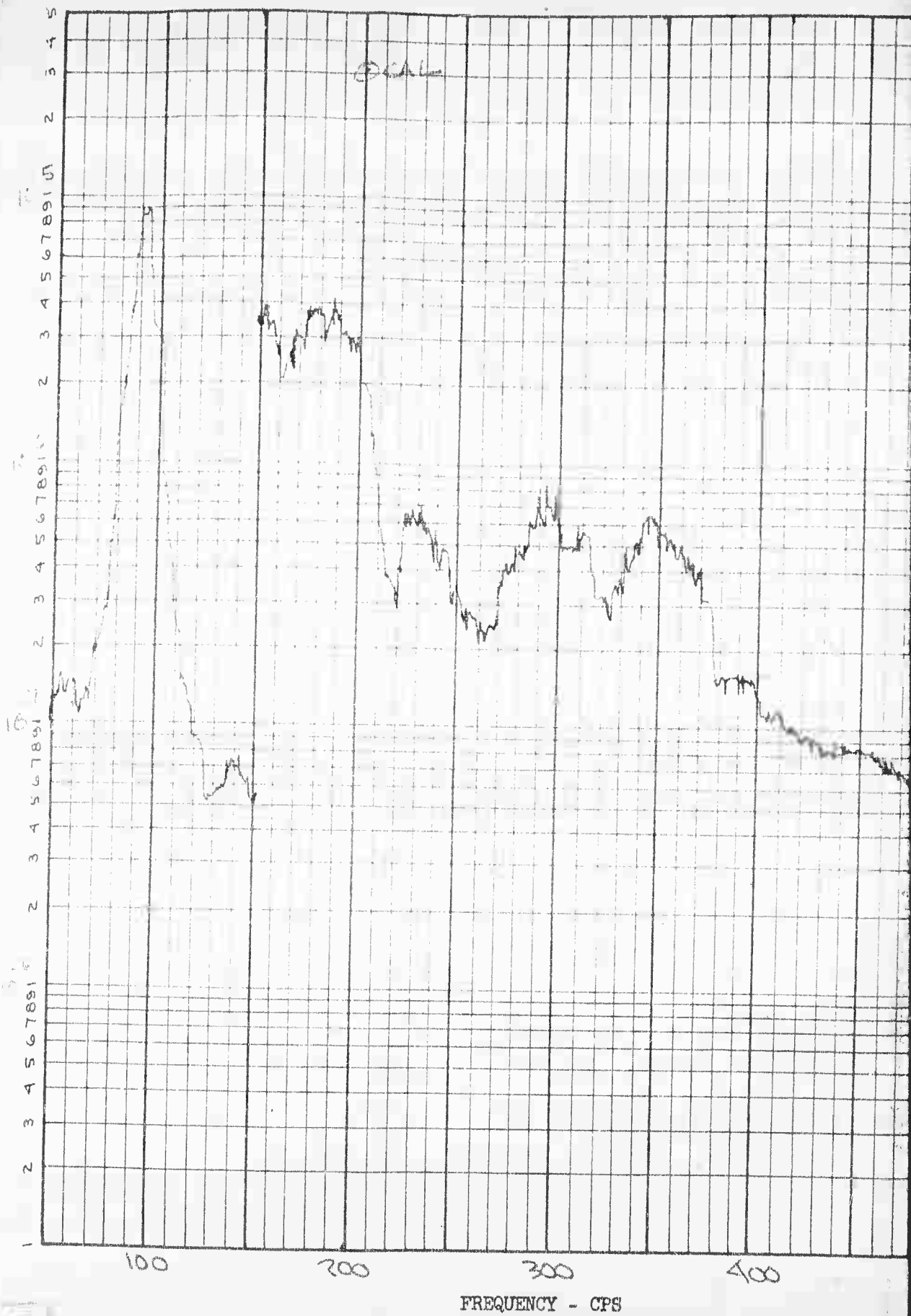


CALC	CRT	6/23/61	REVISED	DATE	POWER SPECTRAL DENSITY ANALYSIS OF DISPLACEMENT PICKUP 5 MIN TEST P/U #5 PANEL 149A PHASE A BOEING AIRPLANE COMPANY SEATTLE 24, WASHINGTON	VOL I 02-51000 PAGE FIG 176
CHECK	SOA	6/24/61				
APR.						
APR						

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2

POWER SPECTRAL DENSITY - (In.)²/cps



1

ANALYSIS VARIABLES

Bandwidth

5 cycles from 50 to 550 cps
 _____ cycles from _____ to _____ cps
 _____ cycles from _____ to _____ cps

T_c 4 Sec.
 Anal. Rate 1.25 cps/sec.
 Loop Length 4 Sec.

CALC
 CHECK
 APR.
 APR.

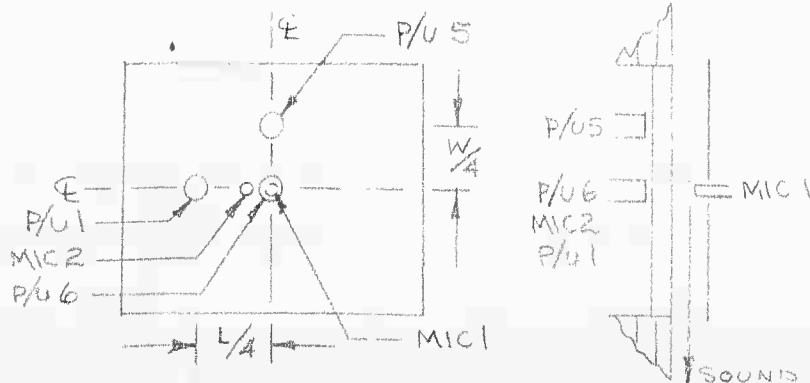
DATA IDENTIFICATION

Test Title PANEL ATTACH. TYPE I PRELIM		
EWA No. 5-593	Panel or Specimen No. 1494	
Tape No. 21A	Tape Channel 5	Displacement Pickup # 6
Elapsed Test Time +5 MIN	P/U RMS Level at Sonic Lab. V_L = .290 Volts	

CALIBRATION

Tape No. 21A	Tape Channel 7	Data Tape RMS Volt V_R = .15
Calibration Voltage V_a = .5 V_{rms} into Line Amp.; V_c = .5 V_{rms} on Tape @200cps		
Line Amplifier Settings For Calibration G_c = .200 ; for Data G_d = .200		
Lab. Gain LG = 1.0	Tape Monitor Gain TMG = $\frac{G_d}{G_c} = 1.0$	
Displacement Pickup Sensitivity S = .0354 in./Volt		
Equivalent of Calibration - in. D_c = V_a · S = .0177		
Equivalent of Calibration for PSD Plots $\left(\frac{D_c}{(TM)(LG)}\right)^2 = \left(\frac{.0177}{(1.0)(1.0)}\right)^2 = 3.13 \times 10^{-4}$ in.²/cps		
Analyzer Attenuator Setting 4 db	Log Converter Setting db	
Calibration Plotted at 3.13 in.²/cps		
Overall Deflection Level of Data RMS Defl. Level = $\frac{(D_c)(V_R)}{(TM)(LG)(V_c)} = \frac{.0177(.15)}{(1.0)(1.0)(.5)} = .0115$ in.		

TO 150 CPS USE
LEFT SCALE
150-550 CPS USE
RIGHT SCALE

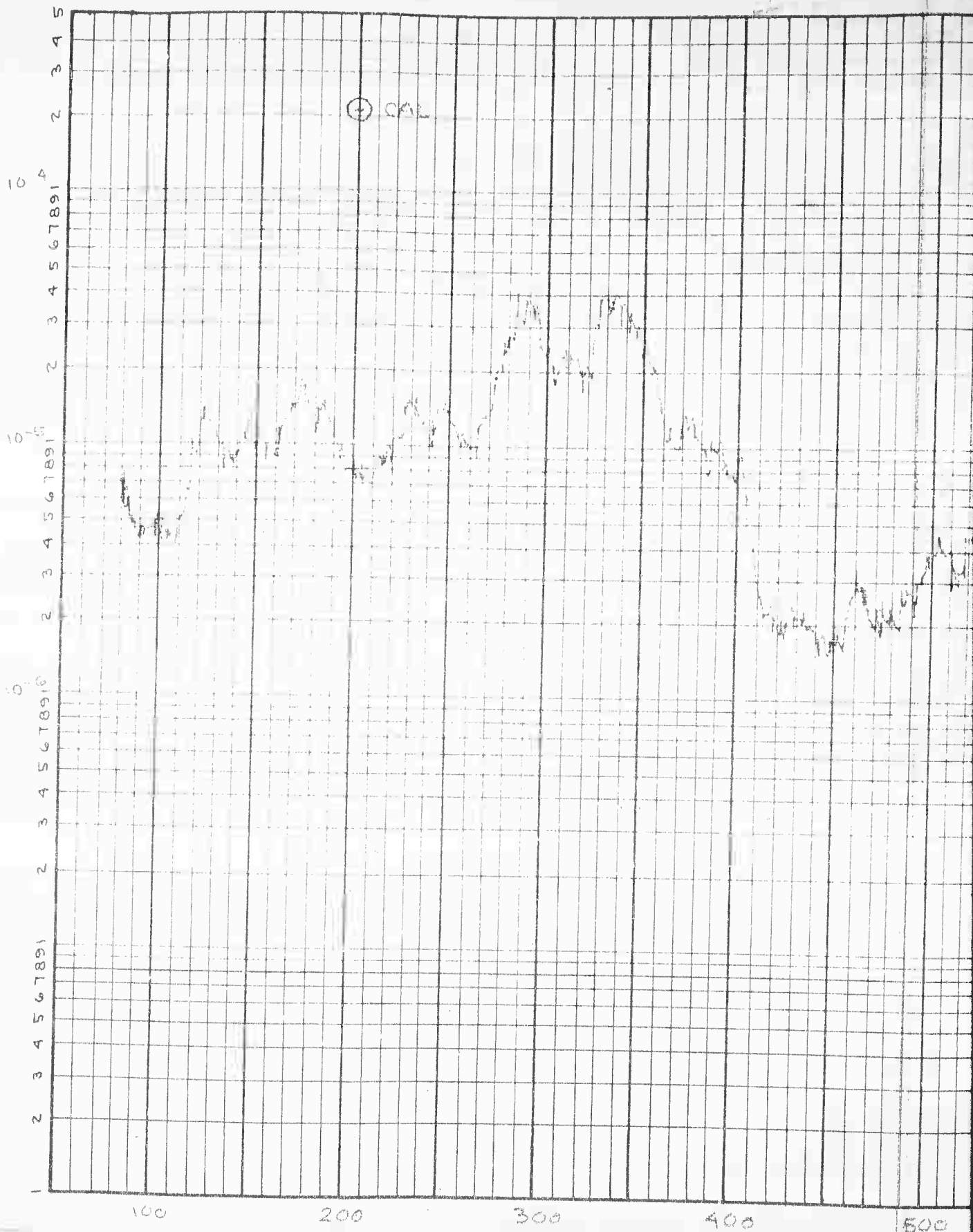


CALC	CBT	4/22/61	REVISED	DATE	POWER SPECTRAL DENSITY ANALYSIS OF DISPLACEMENT PICKUP 5 MIN TEST P/U #6 PANEL 1494 PHASE A BOEING AIRPLANE COMPANY SEATTLE 24, WASHINGTON	Vol. I
CHECK	JOA	4/24/61				DZ-80084
APR.						PAGE
APR.	DR	4/24/61				FIG 177

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2

POWER SPECTRAL DENSITY - (psi)²/cps



FREQUENCY - CPS

ANALYSIS VARIABLES

Bandwidth

5 cycles from 50 to 550 cps
 _____ cycles from _____ to _____ cps
 _____ cycles from _____ to _____ cps

4 Sec.
 Anal. Rate 1.25 cps/Sec.
 Loop Length 4 Sec.

CALC	<u>10/11</u>
CHECK	<u>30A</u>
APR.	
APR.	

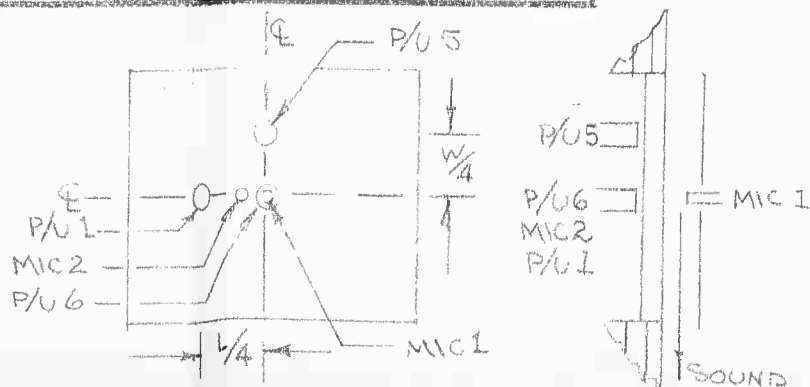
DATA IDENTIFICATION

Test Title PANEL ATTACH TYPE I PRELIM.		
EWA No. 5-592	Panel or Specimen No. 1495	
Tape No. 21	Tape Channel 2	Mic. No. 1
Elapsed Test Time 45		Mic. RMS Level at Sonic Lab. $V_L = .420$ Volts

CALIBRATION

Tape No. 21	Tape Channel 1	Data Tape RMS Volt $V_R = .355$
Calibration Voltage $V_a = .5 V_{rms}$ into Line Amp.; $V_c = .47 V_{rms}$ on Tape @ 20 cps		
Line Amplifier Settings For Calibration $G_c = .100$; for Data $G_d = .100$		
Lab. Gain $LG = 1.0$	Tape Monitor Gain $TMG = \frac{G_d}{G_c} = 1.0$	
Microphone Sensitivity $S = .270$ psi/Volt or 1 Volt rms = 160 db SPL		
Equivalent of Calibration - psi $P_c = V_a \cdot S = .145$		
Equivalent of Calibration for PSD Plots $\left(\frac{P_c}{(TMG)(LG)} \right)^2 = \left[\frac{.145}{(1.0)(1.0)} \right]^2 \cdot 2.1 (10^{-2})$ psi ² /cps		
Analyzer Attenuator Setting -20 db	Log Converter Setting 0 db	
Calibration Plotted at $2.1 / 10^{-4}$ psi ² /cps		
Overall Pressure Level Data $(P_c)(V_R)$		Equiv. to 151.6 db SPL
RMS pressure level = $\frac{(TMG)(LG)(V_c)}{(1.0)(1.0)(.47)} = \frac{.145 (.355)}{(1.0)(1.0)(.47)} = 1025$ psi		

SPECTRUM LEVEL - DECIBELS (Re 0.0002 Microbar)

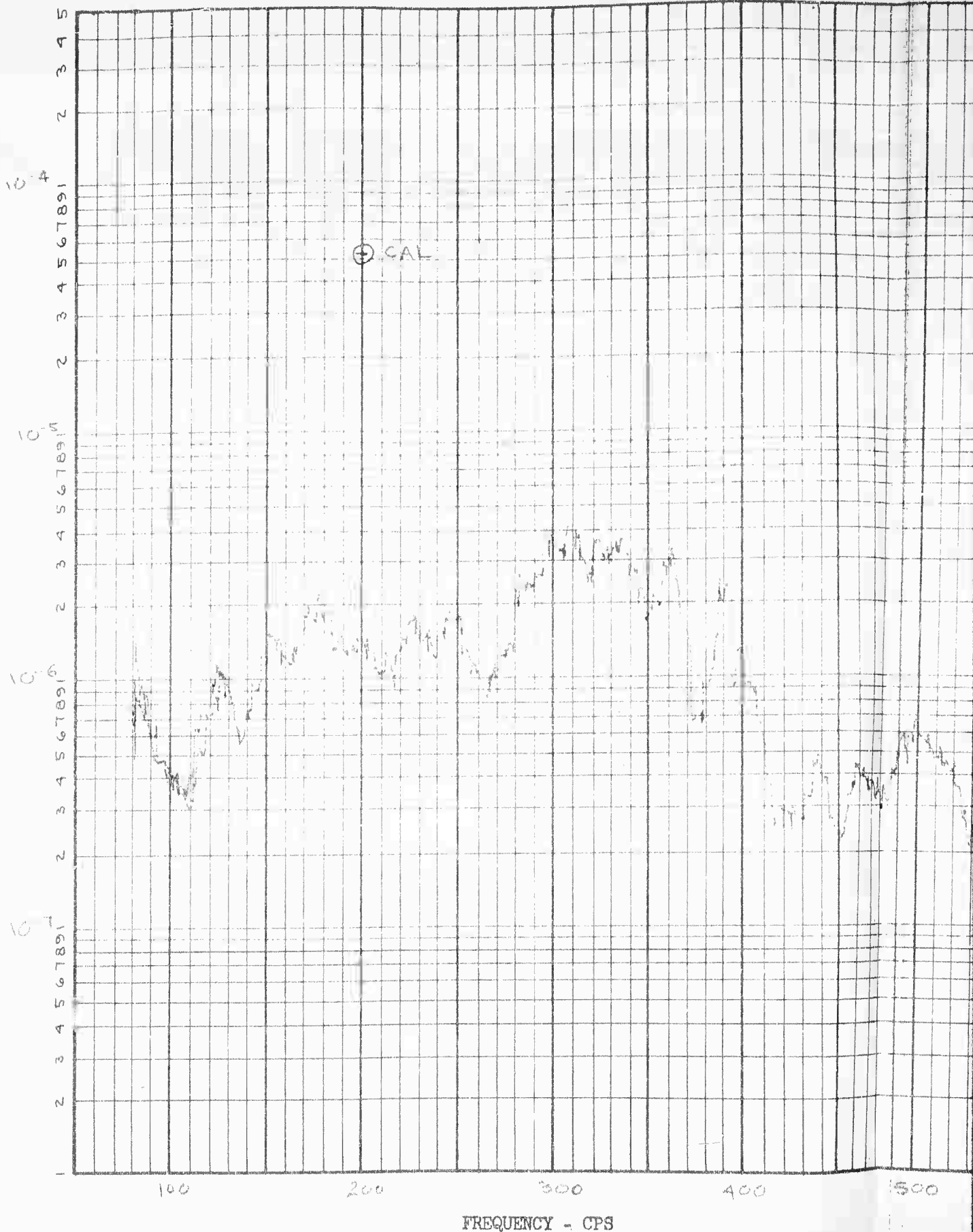


CALC	REVISED	DATE	POWER SPECTRAL DENSITY ANALYSIS OF MICROPHONE OUTPUT 5 MIN TEST. MIC 1 PANEL 1495 PHASE A BOEING AIRPLANE COMPANY SEATTLE 24, WASHINGTON	Vox I
CHECK				DZ-80084
APR.				PAGE
APR.				FIG 178

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2

POWER SPECTRAL DENSITY - (psi)²/cps



ANALYSIS VARIABLES

Bandwidth

5 cycles from 80 to 550 cps
 _____ cycles from _____ to _____ cps
 _____ cycles from _____ to _____ cps

T_c 4 Sec.
 Anal. Rate 1.25 cps/Sec.
 Loop Length 4 Sec.

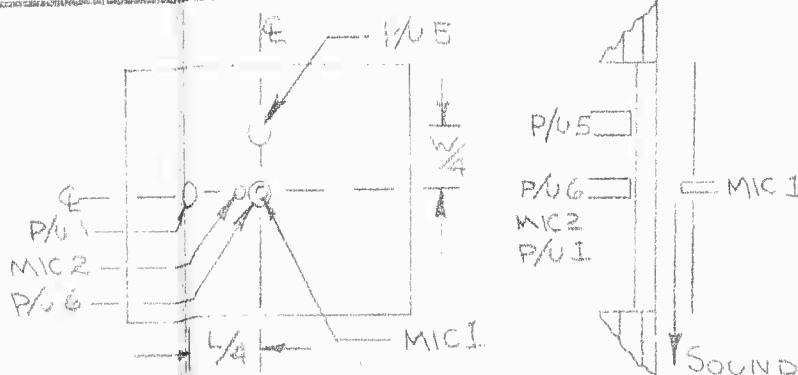
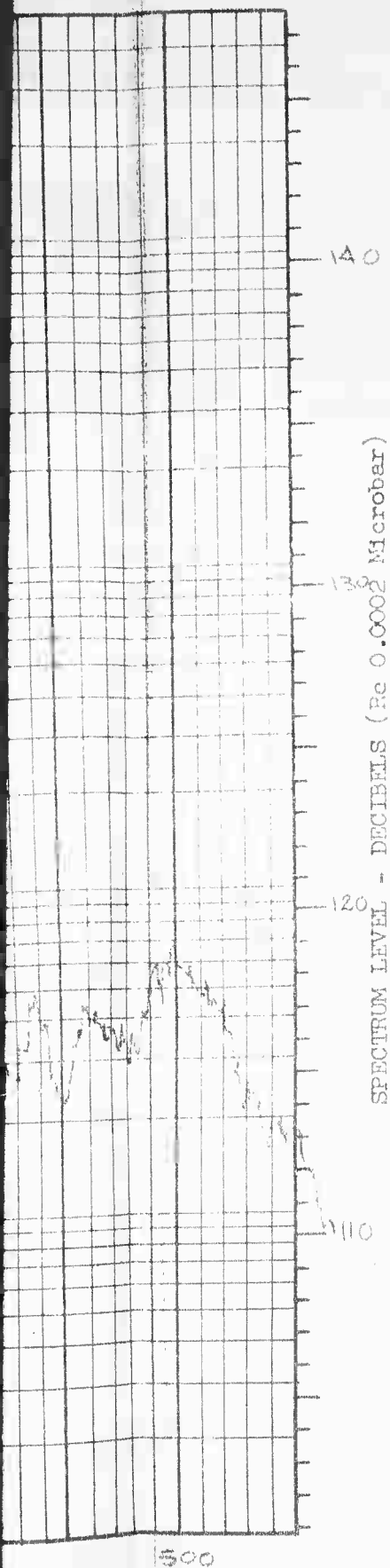
CALC	<u>mm</u>
CHECK	<u>30A</u>
APR.	
APR.	

DATA IDENTIFICATION

Test Title PANEL ATTACH TYPE I PRELIM		
EWA No. 5-593	Panel or Specimen No. 1495	
Tape No. 21	Tape Channel 3	Mic. No. 2
Elapsed Test Time +5		Mic. RMS Level at Sonic Lab. V_L = .116 Volts

CALIBRATION

Tape No. 21	Tape Channel 1	Data Tape RMS Volt V_R = .200
Calibration Voltage V_a = .5 V_{rms} into Line Amp.; V_c = .17 V_{rms} on Tape @ 200cps		
Line Amplifier Settings For Calibration G _c = .100 ; for Data G _d = .200		
Lab. Gain LG = 1.0	Tape Monitor Gain TMG = $\frac{G_d}{G_c} = 2.0$	
Microphone Sensitivity S = .290 psi/Volt or 1 Volt rms = 160 db SPL		
Equivalent of Calibration - psi P_c = V_a · S = .145		
Equivalent of Calibration for PSD Plots $\left(\frac{P_c}{(TMG)(LG)}\right)^2 = \left[\frac{.145}{(2)(1)}\right]^2 = 5.25 (10^{-3}) \text{ psi}^2/\text{cps}$		
Analyzer Attenuator Setting -20 db	Log Converter Setting 0 db	
Calibration Plotted at 5.2 (10⁻⁵) psi²/cps		
Overall Pressure Level Data (P_c)(V_R)		Equiv. to 140.5 db SPL
RMS pressure level = $\frac{(P_c)(V_R)}{(TMG)(LG)(V_c)}$ = $\frac{(.145)(.200)}{(2)(1)(.17)} = .0708 \text{ psi}$		

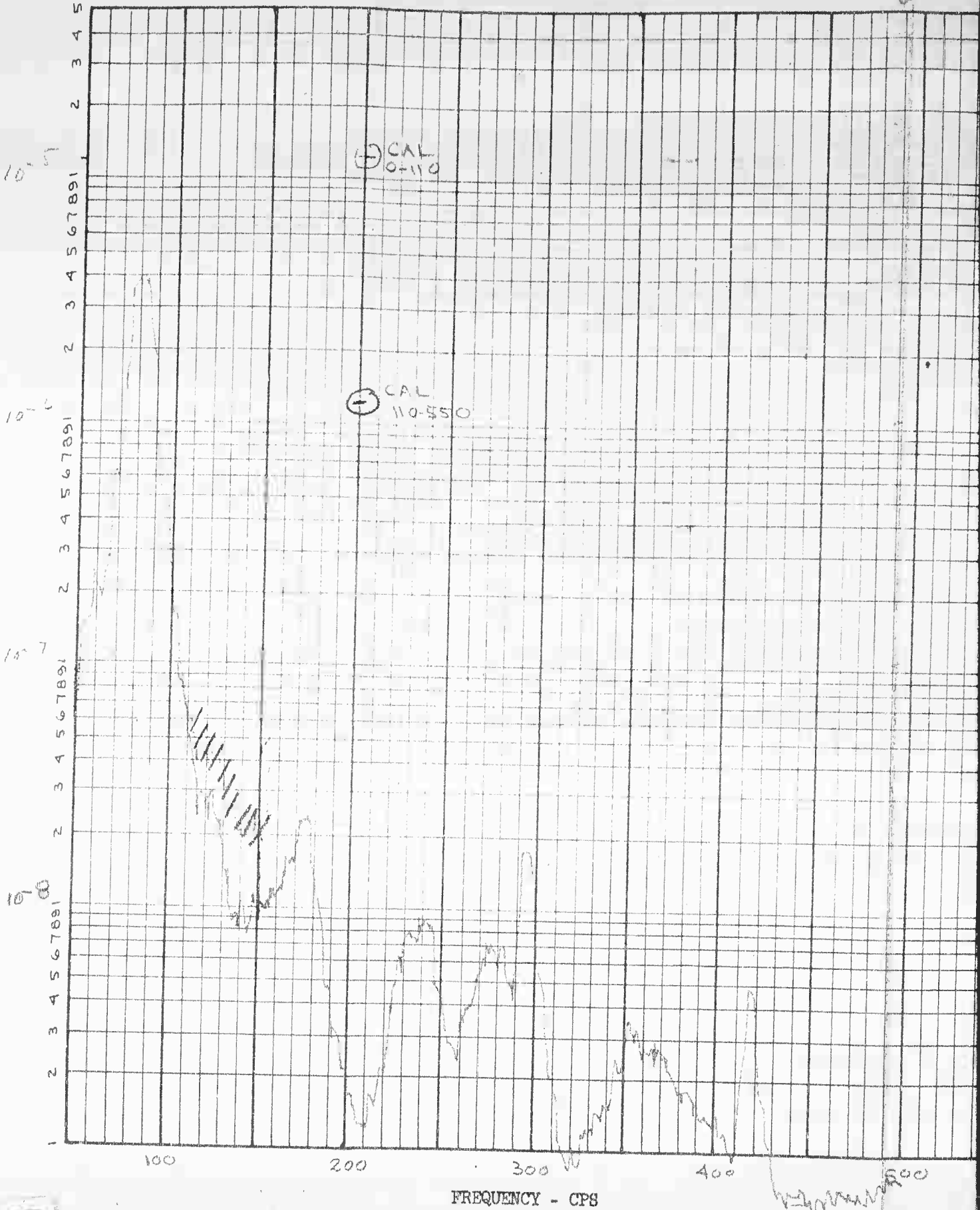


CALC MM	REVISED	DATE	POWER SPECTRAL DENSITY ANALYSIS OF MICROPHONE OUTPUT MIC 2 PANEL 1495L PHASE A BOEING AIRPLANE COMPANY SEATTLE 24, WASHINGTON	VOL I D2-81184 PAGE Fk 173
CHECK 308				
APR				
APR				

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2

POWER SPECTRAL DENSITY - $(\text{In.})^2/\text{cps}$



ANALYSIS VARIABLES

Bandwidth

5 cycles from 50 to 500 cps
 _____ cycles from _____ to _____ cps
 _____ cycles from _____ to _____ cps

T_c 4 Sec.
 Anal. Rate 1.25 cps/sec.
 Loop Length 4 Sec.

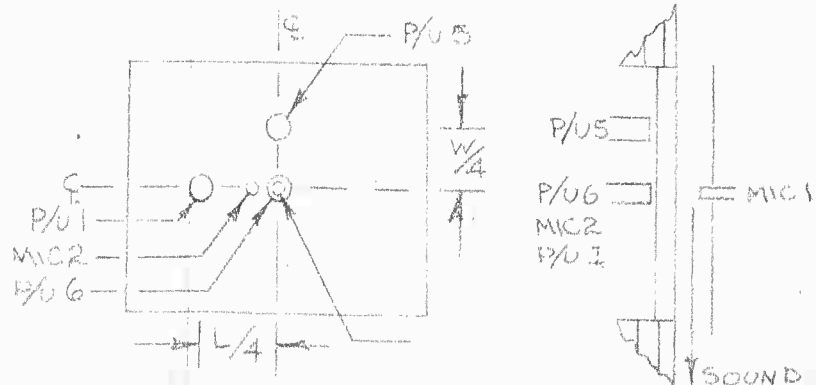
CALC	<u>MEM</u>
CHECK	<u>JOA</u>
APR.	
APR.	

DATA IDENTIFICATION

Test Title PANEL ATTACH TYPE I PRELIM.		
EWA No. 5-593	Panel or Specimen No. 1495	
Tape No. 21	Tape Channel 4	Displacement Pickup # 1
Elapsed Test Time +5 MIN		P/U RMS Level at Sonic Lab. VL = .130 Volts

CALIBRATION

Tape No. 21	Tape Channel 1	Data Tape RMS Volt VR = .115
Calibration Voltage Va = .5 Vrms into Line Amp.; Vc = .47 Vrms on Tape @ 200cps		
Line Amplifier Settings For Calibration Gc = .100; for Data Gd = .100		
Lab. Gain LG = 1.0	Tape Monitor Gain TMG = $\frac{G_d}{G_c} = 1.0$	
Displacement Pickup Sensitivity S = .0707 in./Volt		
Equivalent of Calibration - in. Dc = Va · S = .0354		
Equivalent of Calibration for PSD Plots $\left(\frac{D_c}{(TMG)(LG)} \right)^2 = \left[\frac{.0354}{(1)(1)} \right]^2 = 1.255 (10^{-3}) \text{ in.}^2/\text{cps}$		
Analyzer Attenuator Setting -20 db		Log Converter Setting 0 db
Calibration Plotted at 1.255 (10 ⁻³) 0-110 1.255 (10 ⁻⁶) 10-54 in. ² /cps		
Overall Deflection Level of Data $\text{RMS Defl. Level} = \frac{(D_c)(V_R)}{(TMG)(LG)(V_c)} = \frac{(.0354)(.115)}{(1)(1)(.47)} = .0087 \text{ in.}$		

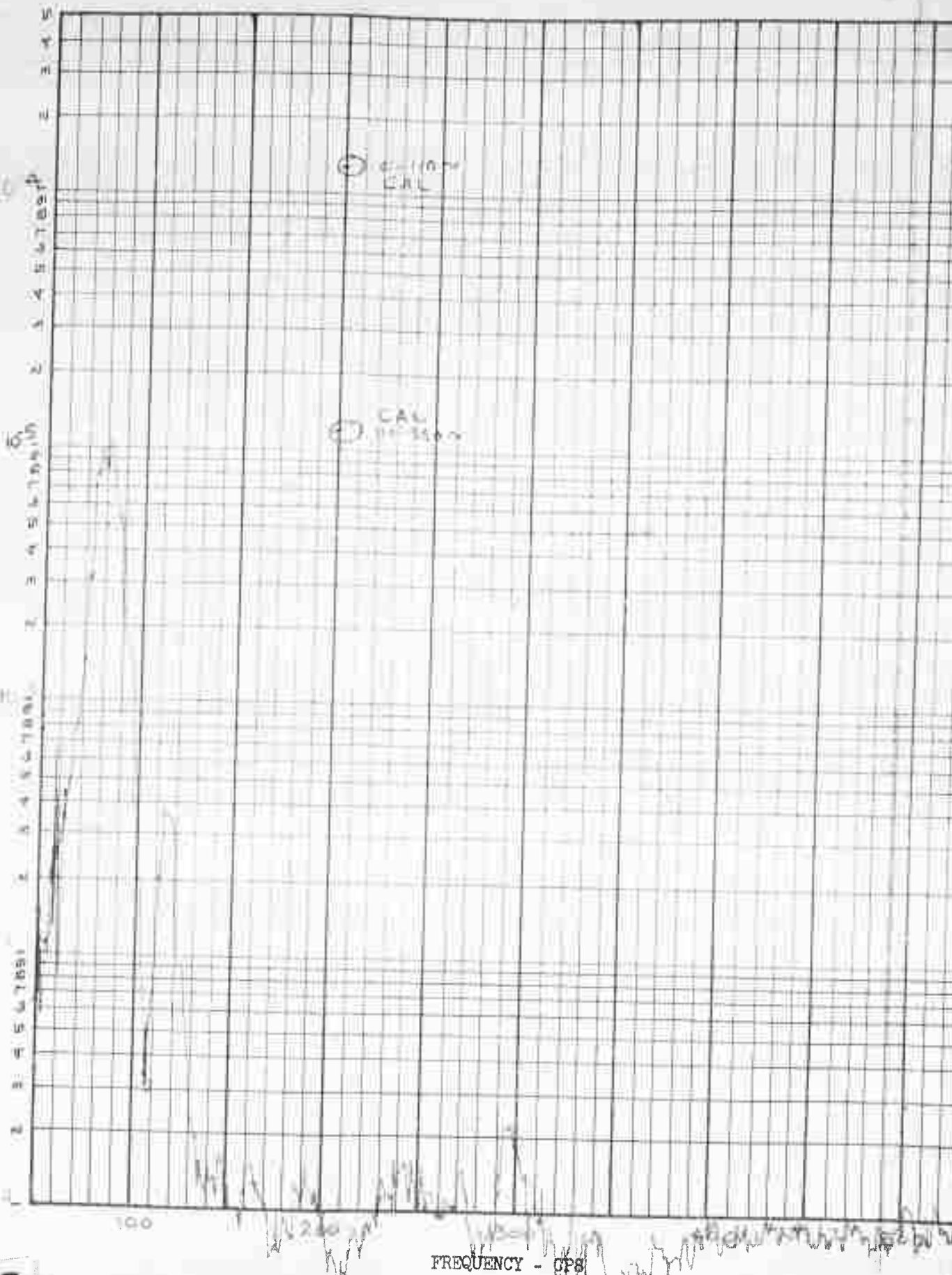


CALC	PREP	REVISED	DATE	POWER SPECTRAL DENSITY ANALYSIS OF DISPLACEMENT PICKUP	VOL I
CHECK	SOA			5 MIN TEST	02 90084
APR.				P/U 1 PANEL 1495 PHASE A	PAGE
APR.				BOEING AIRPLANE COMPANY	FIG 180
				SEATTLE 24, WASHINGTON	

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2

POWER SPECTRAL DENSITY - $(\text{In.})^2/\text{cps}$



FREQUENCY - CPS

ANALYSIS VARIABLES

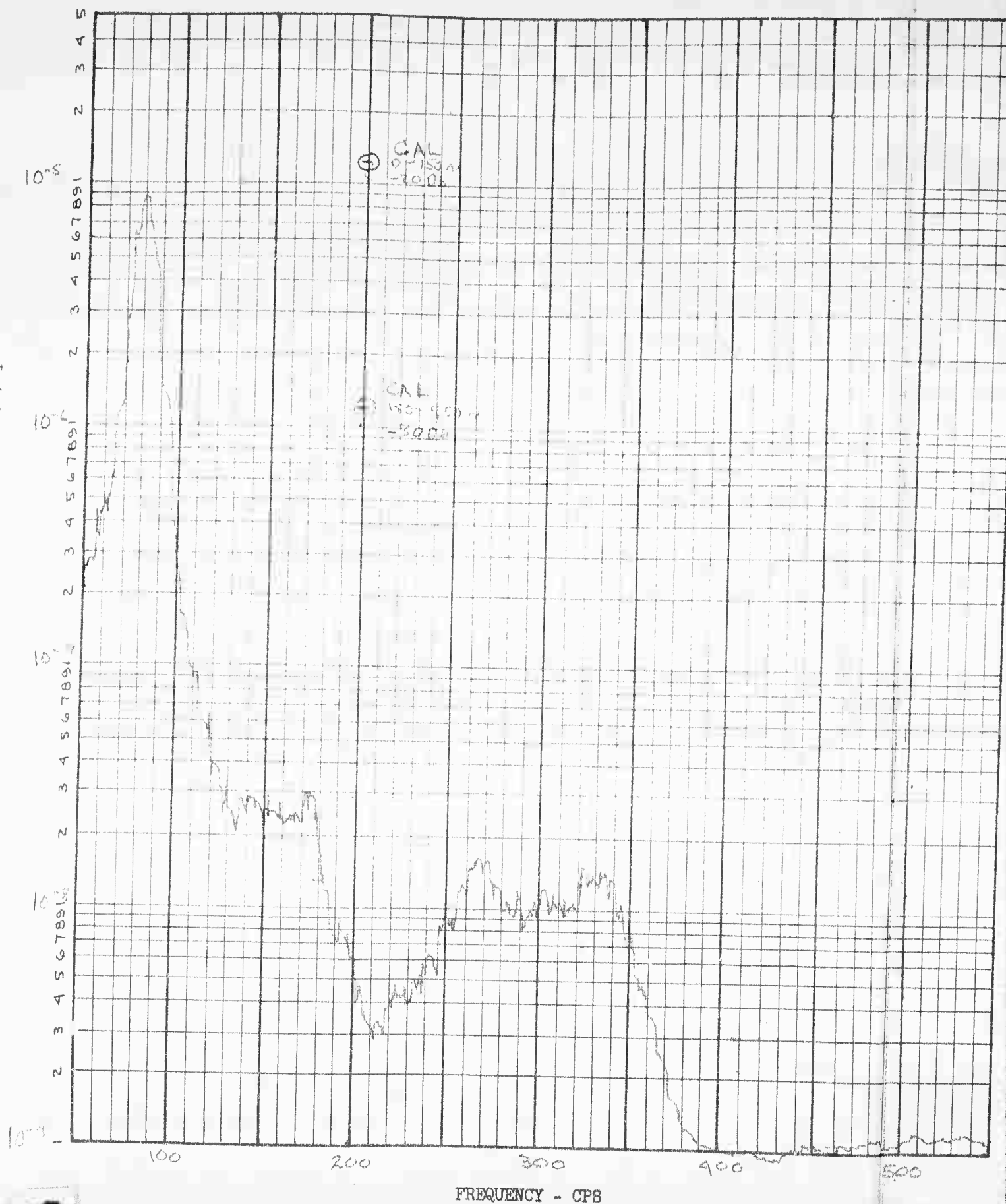
Bandwidth

5 cycles from 50 to 500 cps
 _____ cycles from _____ to _____ cps
 _____ cycles from _____ to _____ cps

T_c 4 Sec.
 Anal. Rate 1.25 cps/sec.
 Loop Length 4 Sec.

CALC	MECH
CHECK	SOA
APR.	
APR.	

POWER SPECTRAL DENSITY - $(\text{in.})^2/\text{cps}$



ANALYSIS VARIABLES

Bandwidth

5 cycles from 50 to 500 cps
 _____ cycles from _____ to _____ cps
 _____ cycles from _____ to _____ cps

T_c 4 Sec.

Anal. Rate 1.25 cps/sec.

Loop Length 4 Sec.

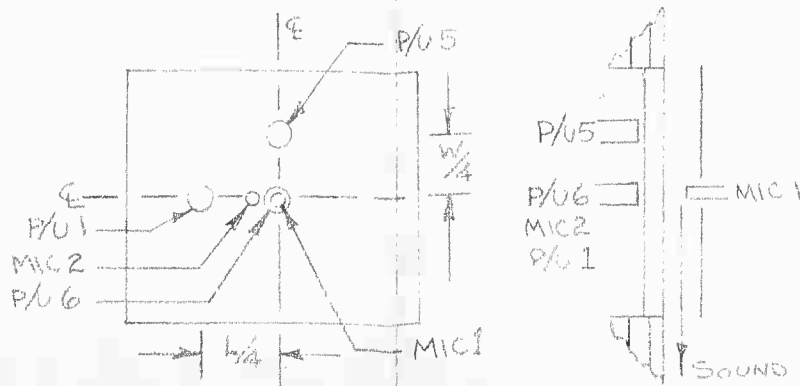
CALC	MCM	6/2
CHECK	SDA	4/20
APR.		
APR.		

DATA IDENTIFICATION

Test Title PANEL ATTACH TYPE I PRELIM.		
EWA No. 5-593	Panel or Specimen No. 1495	
Tape No. 21	Tape Channel 6	Displacement Pickup # 6
Elapsed Test Time +5		P/U RMS Level at Sonic Lab. VL = .180 Volts

CALIBRATION

Tape No. 21	Tape Channel 1	Data Tape RMS Volt VR = .155
Calibration Voltage Va = .5 Vrms into Line Amp.; Vc = .470 Vrms on Tape @ 200 cps		
Line Amplifier Settings For Calibration Gc = .100 ; for Data Gd = .100		
Lab. Gain LG = 1.0	Tape Monitor Gain TMG = $\frac{G_d}{G_c} = 1.0$	
Displacement Pickup Sensitivity S = .0707 in./Volt		
Equivalent of Calibration - in. Dc = Va * S = .0354		
Equivalent of Calibration for PSD Plots $\left(\frac{D_c}{(TMG)(LG)} \right)^2 = \left[\frac{.0354}{(1.0)(1.0)} \right]^2 = 1.255 (10^{-3}) \text{ in.}^2/\text{cps}$		
Analyzer Attenuator Setting -20 0-150 db -30 150-250 db		Log Converter Setting 0 db
Calibration Plotted at 1.255 (10 ⁻³) 0-150 1.255 (10 ⁻³) 150-250 in. ² /cps		
Overall Deflection Level of Data $\text{RMS Defl. Level} = \frac{(D_c)(V_R)}{(TMG)(LG)(V_c)} = \frac{.0354(.155)}{(1.0)(1.0)(.47)} = .0117 \text{ in.}$		

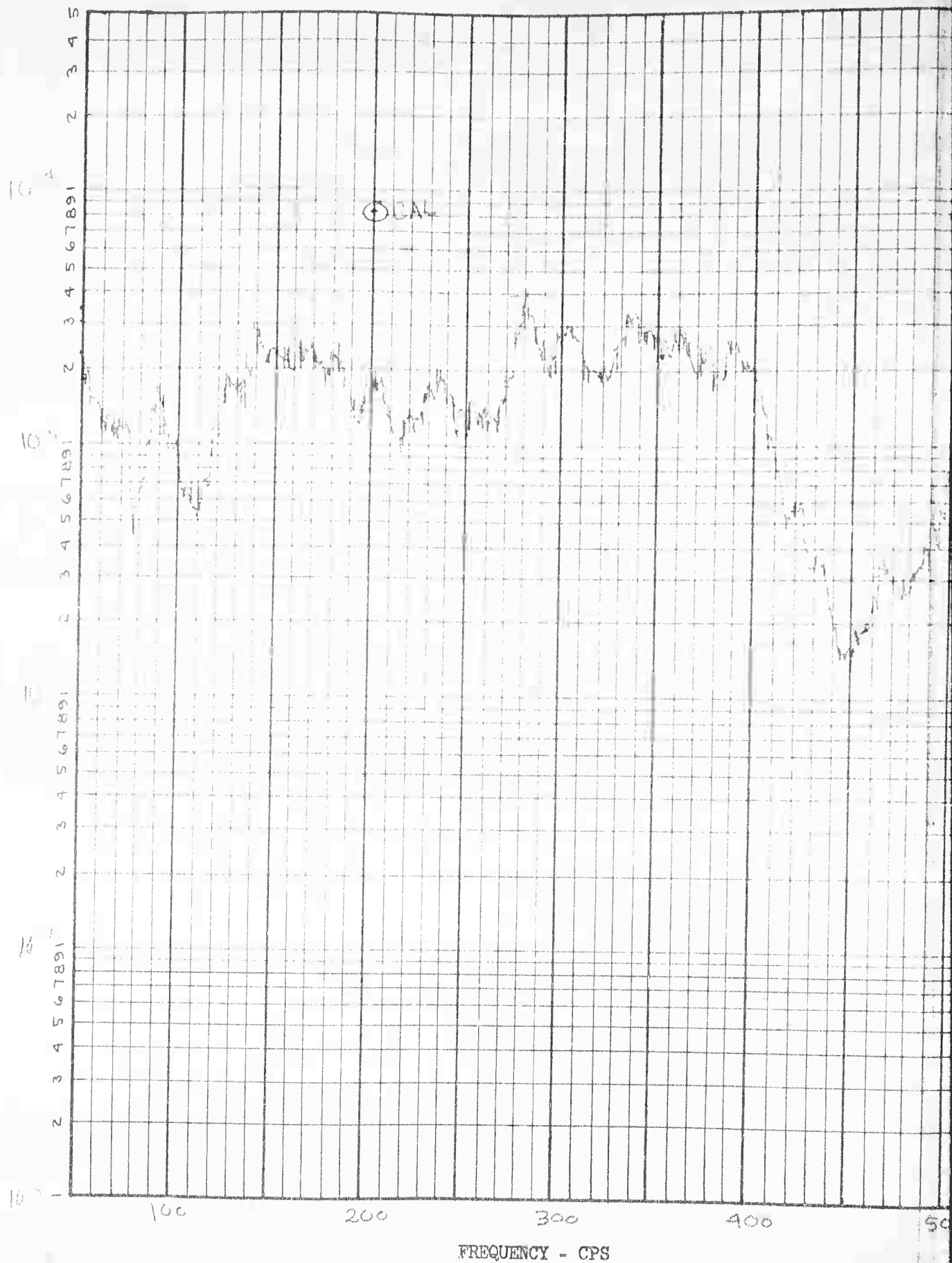


CALC	WCM	6/23	REVISED	DATE	POWER SPECTRAL DENSITY ANALYSIS OF DISPLACEMENT PICKUP 5 MIN TEST P/U 6 PANEL 1495 PHASE A BOEING AIRPLANE COMPANY SEATTLE 24, WASHINGTON	Vol I
CHECK	30A	6/24/66				DZ-80084
APR.						PAGE
APR.						FIG 182

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2

POWER SPECTRAL DENSITY - (psi)²/cps



ANALYSIS VARIABLES

Bandwidth

5 cycles from 50 to 500 cps
 _____ cycles from _____ to _____ cps
 _____ cycles from _____ to _____ cps

T_c 4 Sec.

Anal. Rate 1.25 cps/Sec.

Loop Length 4 Sec.

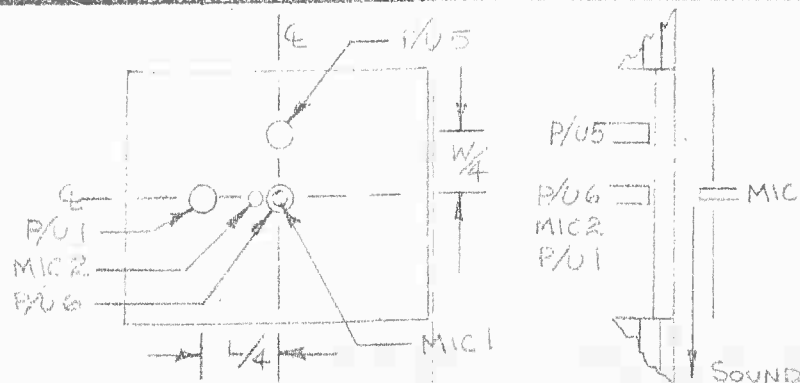
CALC	me
CHECK	30
APR.	
APR.	

DATA IDENTIFICATION

Test Title PANEL ATTACH TYPE I PRELIM.		
EWA No. 5-593	Panel or Specimen No. 1495	
Tape No. 25	Tape Channel 1	Mic. No. 1
Elapsed Test Time +55		Mic. RMS Level at Sonic Lab. VL = .192 Volts

CALIBRATION

Tape No. 25	Tape Channel 1	Data Tape RMS Volt VR = .187
Calibration Voltage Va = .5 Vrms into Line Amp.; Vc = .5 Vrms on Tape @ 200 cps		
Line Amplifier Settings For Calibration Ga = .50; for Data Ga = .250		
Lab. Gain LG = 1.0	Tape Monitor Gain TMG = $\frac{Ga}{Gc} = 1.50$	
Microphone Sensitivity S = .290 psi/Volt or 1 Volt rms = 100 db SPL		
Equivalent of Calibration - psi Pc = Va * S = .145		
Equivalent of Calibration for PSD Plots $\left(\frac{Pc}{(TMG)(LG)}\right)^2 = \left[\frac{.145}{(1.5)(1.0)}\right]^2 = 8.41 (10^{-2})$ psi ² /cps		
Analyzer Attenuator Setting -3.0 db	Log Converter Setting 0 db	
Calibration Plotted at 8.41 (10 ⁻⁵) psi ² /cps		
Overall Pressure Level Data (Pc)(VR) RMS pressure level = $\frac{(Pc)(VR)}{(TMG)(LG)(Vc)}$ = $\frac{.145(.187)}{(1.5)(1.0)(.5)} = .1085$ psi		Equiv. to 51.5 db SPL

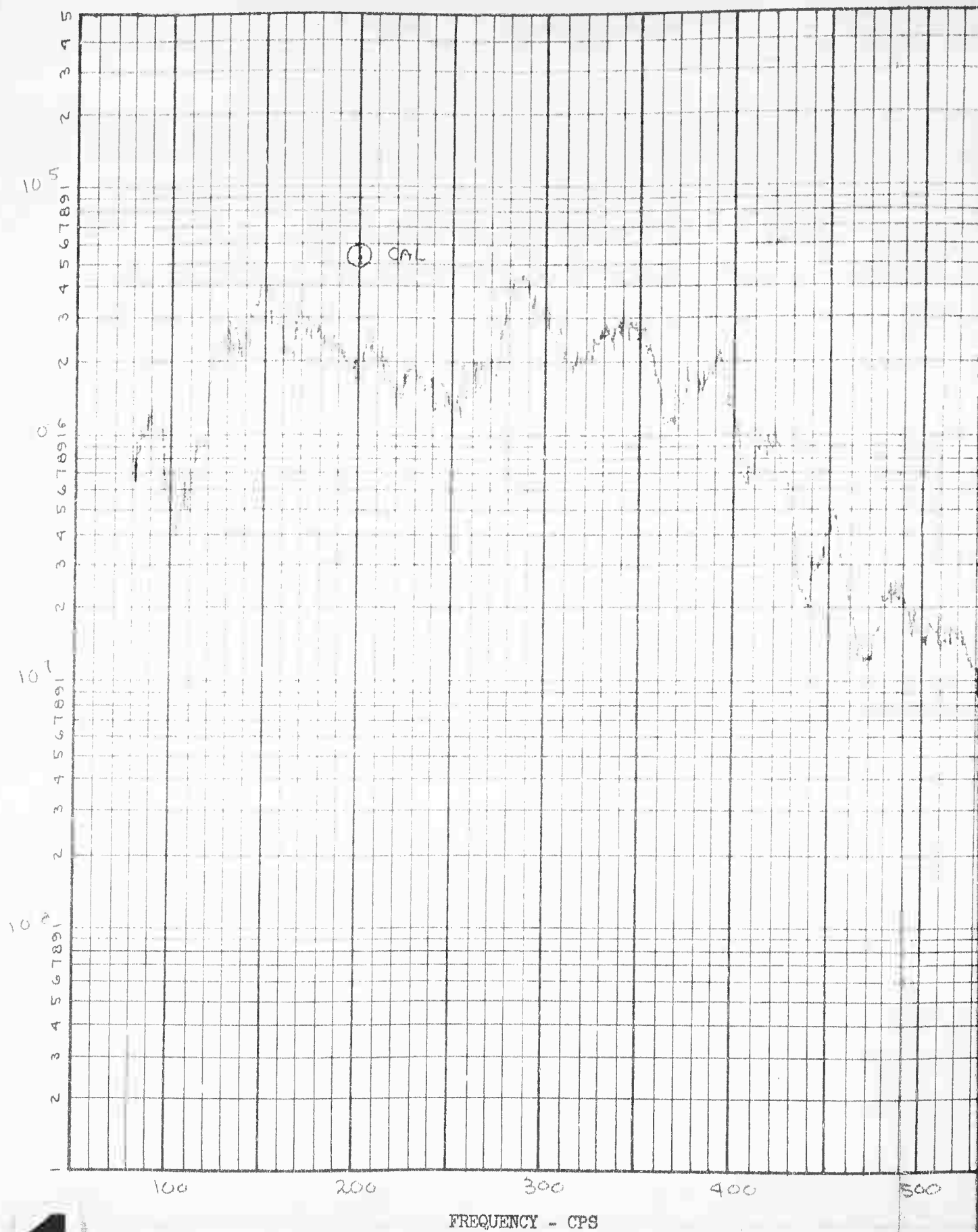


CALC	MEM	6-23	REVISED	DATE	POWER SPECTRAL DENSITY ANALYSIS OF MICROPHONE OUTPUT 55 MIN TEST MIC I PANEL 1495 PHASE B BOEING AIRPLANE COMPANY SEATTLE 24, WASHINGTON	VOL I
CHECK	SDA	4/4/61				D2-80084
APR.						PAGE
APR.						FIG 183

2-5353-7-8

2

POWER SPECTRAL DENSITY - (psi)²/cps



ANALYSIS VARIABLES

Bandwidth

5 cycles from 80 to 550 cps
 _____ cycles from _____ to _____ cps
 _____ cycles from _____ to _____ cps

4 Sec.
 Anal. Rate 1.25 cps/Sec.
 Loop Length 4 Sec.

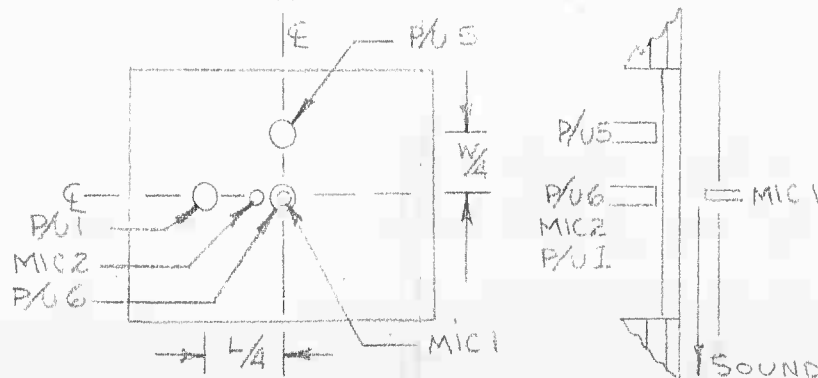
CALC	EGGERS
CHECK	SOA
APR.	
APR.	

DATA IDENTIFICATION

Test Title PANEL ATTACH TYPE I PRELIM.		
EWA No. 5-593	Panel or Specimen No. 1495	
Tape No. 25	Tape Channel 2	Mic. No. 2
Elapsed Test Time 155		Mic. RMS Level at Sonic Lab. $V_L = \text{---} \text{ Volts}$

CALIBRATION

Tape No. 25	Tape Channel 7	Data Tape RMS Volt $V_R = .228$
Calibration Voltage $V_a = .5 V_{rms}$ into Line Amp.; $V_c = .5 V_{rms}$ on Tape @ 200 cps		
Line Amplifier Settings For Calibration $G_c = .500$; for Data $G_d = 1.000$		
Lab. Gain $LG = 1.0$	Tape Monitor Gain $TMG = \frac{G_d}{G_c} = 2.0$	
Microphone Sensitivity $S = .296 \text{ psi/Volt}$ or $1 \text{ Volt rms} = 160 \text{ db SPL}$		
Equivalent of Calibration - psi $P_c = V_a \cdot S = .145$		
Equivalent of Calibration for PSD Plots $\left(\frac{P_c}{(1.0)(1.0)} \right)^2 = \left[\frac{.145}{(2.0)(1.0)} \right]^2 = 5.25 (10^{-3}) \text{ psi}^2/\text{cps}$		
Analyzer Attenuator Setting -30 db	Log Converter Setting 0 db	
Calibration Plotted at 5.25×10^{-6} psi²/cps		
Overall Pressure Level Data $\frac{(P_c)(V_R)}{(TMG)(LG)(V_c)}$ RMS pressure level = $\frac{.145 (.228)}{(2)(1)(.5)} = .0331 \text{ psi}$		Equiv. to 141.2 db SPL

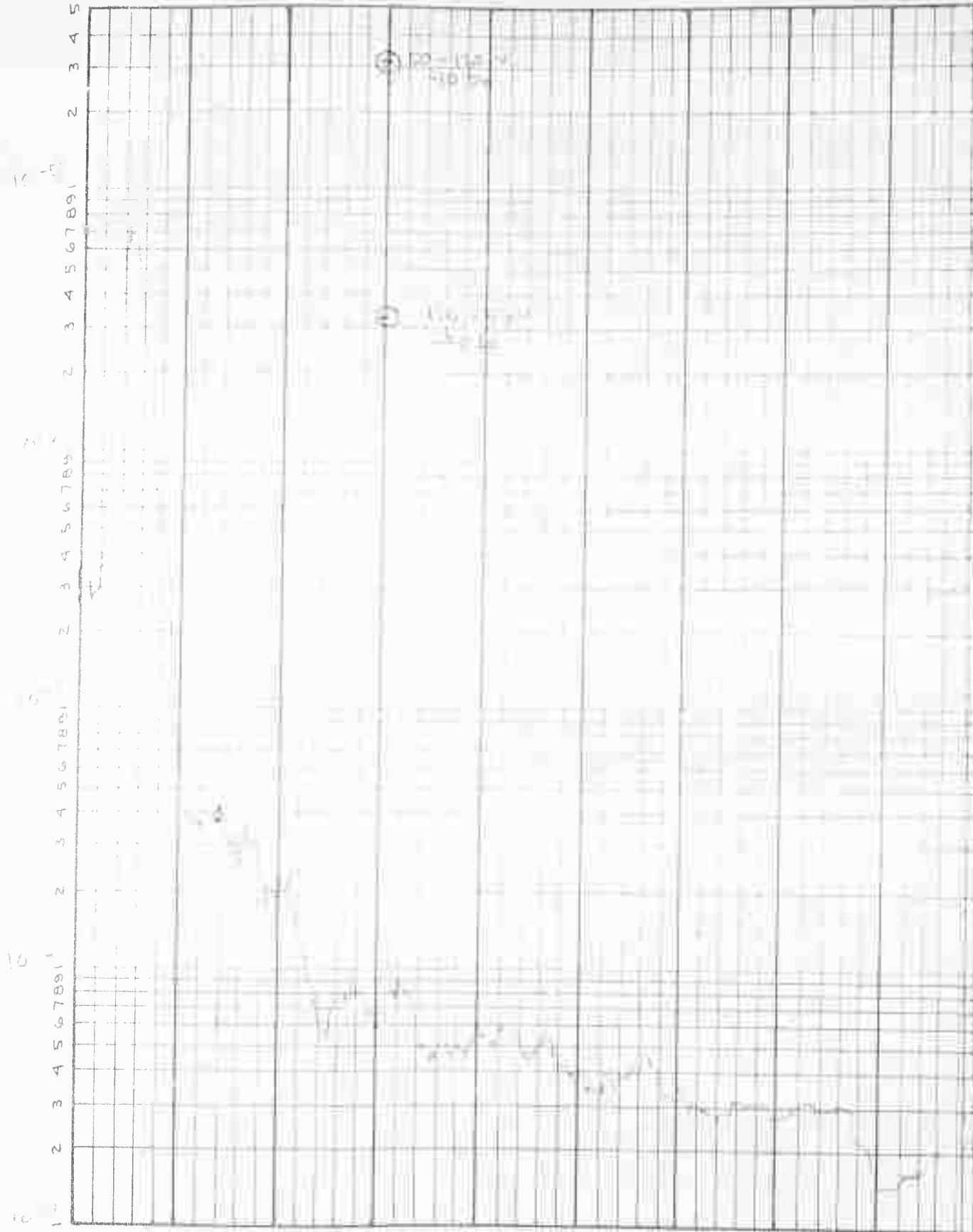


CALC	EGGERS	6-20-64	REVISED	DATE	POWER SPECTRAL DENSITY ANALYSIS OF MICROPHONE OUTPUT 55 MIN TEST MIC 2 PANEL 1495 PHASE B BOEING AIRPLANE COMPANY SEATTLE 24, WASHINGTON	Vol I
CHECK	SOA	4/26/64				DX-80084
APR.						PAGE
APR.						Fig 184

2-5353-7-8

2

POWER SPECTRAL DENSITY - (In.)²/cps



FREQUENCY - CPS

ANALYSIS VARIABLES

Bandwidth

5 cycles from 50 to 500 cps
 _____ cycles from _____ to _____ cps
 _____ cycles from _____ to _____ cps

T_c 4 Sec.
 Anal. Rate 1.25 cps/sec.
 Loop Length 4 Sec.

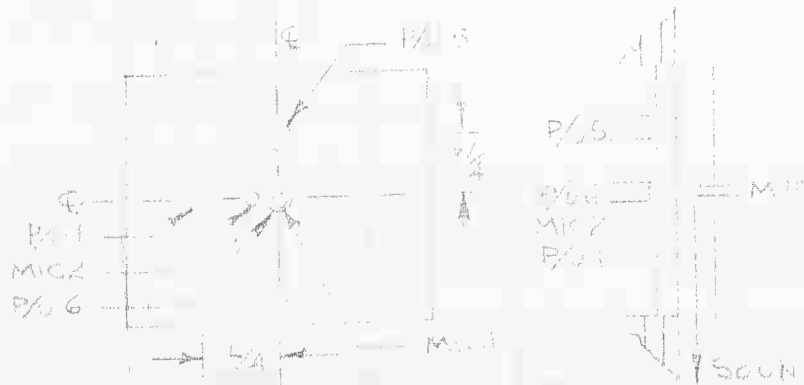
CALC
CHECK
APR.
APR

DATA IDENTIFICATION

Test Title PANEL ATTACH TYPE I PIPES		
EWA No. 5-572		Panel or Specimen No. 1475
Tape No. 25	Tape Channel 3	Displacement Pickup # 1
Elapsed Test Time +35		P/U RMS Level at Sonic Lab. VL = 12.70 Volts

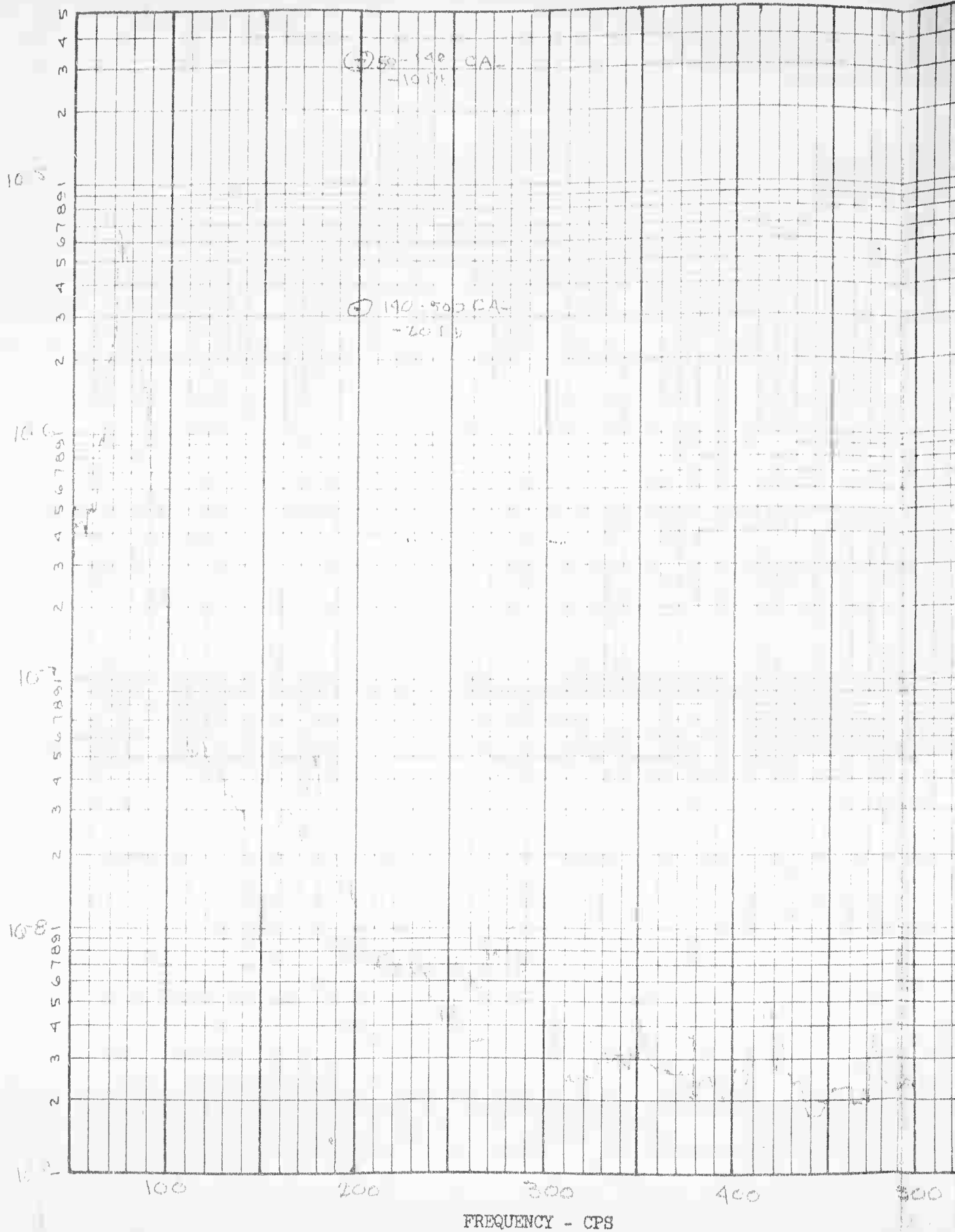
CALIBRATION

Tape No. 25	Tape Channel 7	Data Tape RMS Volt VR = 1.785
Calibration Voltage Va = .5 Vrms into Line Amp.; Vc = .5 Vrms on Tape @ 200 cps		
Line Amplifier Settings For Calibration Gc = .500; for Data Gd = .500		
Lab. Gain LG = 1.0	Tape Monitor Gain TMG = Gd = 1.0 Vc	
Displacement Pickup Sensitivity S = .004 in./Volt		
Equivalent of Calibration - in. Dc = Va * S = .002 in.		
Equivalent of Calibration for PSD Plots $\left(\frac{D_c}{(TMG)(LG)} \right)^2 = \left(\frac{.002}{(1.0)(1.0)} \right)^2 = .0004 \text{ in.}^2/\text{cps}$		
Analyzer Attenuator Setting -10 db		Log Converter Setting 0 db
Calibration Plotted at 200 cps		
Overall Deflection Level of Data $\text{RMS Defl. Level} = \frac{(D_c)(V_R)}{(TMG)(LG)(V_c)} = \frac{(.002)(1.785)}{(1.0)(1.0)(.5)} = .00714 \text{ in.}$		



CALC	6/24/61	REVISED	DATE	POWER SPECTRAL DENSITY ANALYSIS OF DISPLACEMENT PICKUP	VOL I
CHECK	SOA			53 MOUNT	12304
APR				P/U 1 PANEL 1475 PHASE B	PAGE
APR				BOEING AIRPLANE COMPANY SEATTLE 24, WASHINGTON	FIG 185

POWER SPECTRAL DENSITY - (In.)²/cps



ANALYSIS VARIABLES

Bandwidth

5 cycles from 50 to 500 cps
 _____ cycles from _____ to _____ cps
 _____ cycles from _____ to _____ cps

T_c 4 Sec.
 Anal. Rate 125 cps/sec.
 Loop Length 4 Sec.

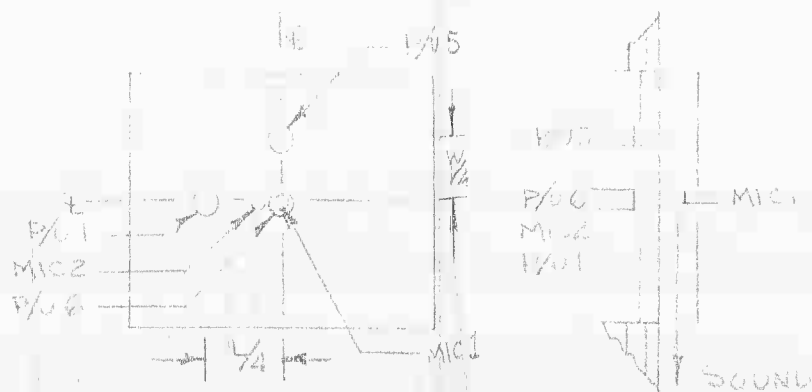
CALC. 11/14
 CHECK 30A
 APR.
 APR.

DATA IDENTIFICATION

Test Title PANEL ATTACH TYPE I PRELIM		
EWA No. 5-505		Panel or Specimen No. 1495
Tape No. 25	Tape Channel 4	Displacement Pickup # 5
Elapsed Test Time +55		P/U RMS Level at Sonic Lab. V_L = .300 Volts

CALIBRATION

Tape No. 25	Tape Channel 7	Data Tape RMS Volt V_R = .285
Calibration Voltage V_a = .5 V_{rms} into Line Amp.; V_c = .5 V_{rms} on Tape @ 200cps		
Line Amplifier Settings For Calibration G_c = .500 ; for Data G_d = .500		
Lab. Gain LG = 1.0	Tape Monitor Gain TMG = $\frac{G_d}{G_c} = 1.0$	
Displacement Pickup Sensitivity S = .004 in./Volt		
Equivalent of Calibration - in. D_c = V_a · S = .0177		
Equivalent of Calibration for PSD Plots $\left(\frac{D_c}{(TMG)(LG)}\right)^2 = \frac{.0177^2}{(1.0)(1.0)} = 3.12 (10^{-4})$ in.²/cps		
Analyzer Attenuator Setting -10 50 140 db	Log Converter Setting db	
Calibration Plotted at 10 140 in. ² /cps		
Overall Deflection Level of Data RMS Defl. Level = $\frac{(D_c)(V_R)}{(TMG)(LG)(V_c)} = \frac{.0177(.285)}{(1.0)(1.0)(.5)} = .0101$ in.		



CALC	MEM	REVISED	DATE	POWER SPECTRAL DENSITY ANALYSIS OF DISPLACEMENT PICKUP P/O 5 PANEL 1495 PHASE B BOEING AIRPLANE COMPANY SEATTLE 24, WASHINGTON	VOL I PAGE 186
CHECK	30A	6/4/61			
APR					
APR					

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2

POWER SPECTRAL DENSITY - (In.)²/cps



FREQUENCY - CPS

1

ANALYSIS VARIABLES

Bandwidth

5 cycles from 50 to 500 cps
cycles from to cps
cycles from to cps

T_c 4 Sec.
Anal. Rate 125 cps/sec.
Loop Length 4 Sec.

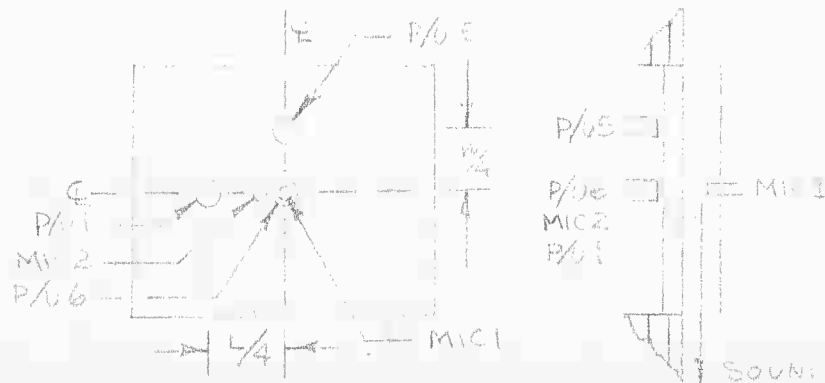
CALC	
CHECK	500
APR.	
APR.	

DATA IDENTIFICATION

Test Title PANEL ATTACH TYPE I PRELIM.		
EWA No. 5-593	Panel or Specimen No. 1495	
Tape No. 25	Tape Channel 5	Displacement Pickup # 6
Elapsed Test Time +55		P/U RMS Level at Sonic Lab. VL = .370 Volts

CALIBRATION

Tape No. 25	Tape Channel 7	Data Tape RMS Volt VR = .210
Calibration Voltage VA = .5 Vrms into Line Amp.; VC = .5 Vrms on Tape @ 200 cps		
Line Amplifier Settings For Calibration GC = .500; for Data GD = .250		
Lab. Gain LG = 1.0	Tape Monitor Gain TMG = $\frac{GD}{GC} = .500$	
Displacement Pickup Sensitivity S = .0254 in./Volt		
Equivalent of Calibration - in. DC = VA * S = .0127		
Equivalent of Calibration for PSD Plots $\left(\frac{DC}{(TMG)(LG)}\right)^2 = \frac{(0.0127)^2}{(.5)(1)} = 1.25(10^{-7}) \text{ in.}^2/\text{cps}$		
Analyzer Attenuator Setting 10 db	Log Converter Setting 0 db	
Calibration Plotted at $1.25 \times 10^{-7} (150-550)$ $1.25 \times 10^{-5} (150-550) \text{ in.}^2/\text{cps}$		
Overall Deflection Level of Data RMS Defl. Level = $\frac{(DC)(VR)}{(TMG)(LG)(VC)} = \frac{(0.0127)(.210)}{(.5)(1)(.5)} = .0145 \text{ in.}$		

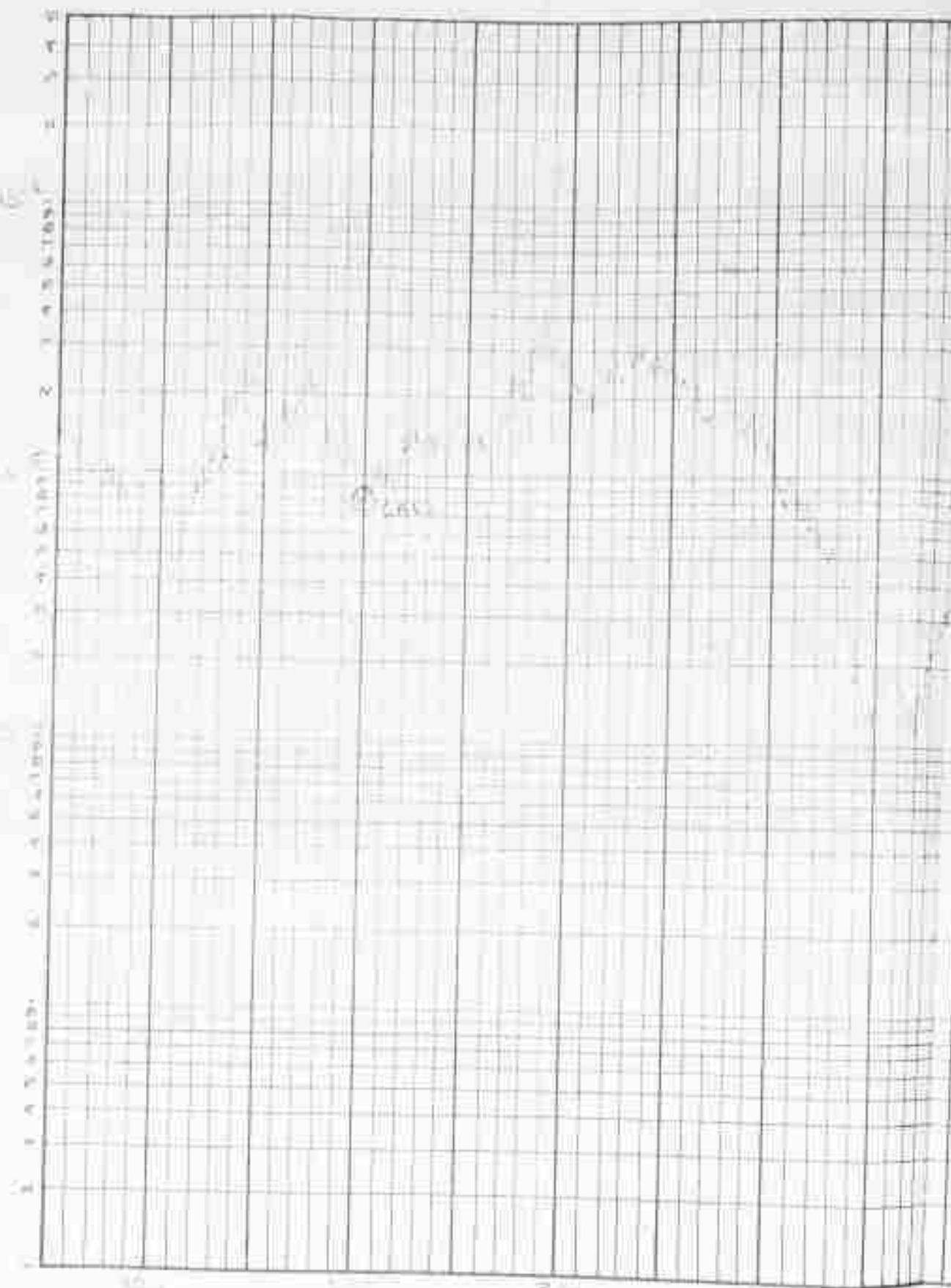


CALC	6-53	REVISED	DATE	POWER SPECTRAL DENSITY ANALYSIS	VOL I
CHECK	3/24			OF DISPLACEMENT PICKUP	
APR.				35 MIL TEST	DZ-100-61
APR				P/U 6, PANEL 1495, PHASE B	PAGE
				BOEING AIRPLANE COMPANY	FIG. 187
				SEATTLE 24, WASHINGTON	

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2

POWER SPECTRAL DENSITY - (psi)²/cps



FREQUENCY - CPS

ANALYSIS VARIABLES

Bandwidth

5 cycles from 50 to 300 cps
 _____ cycles from _____ to _____ cps
 _____ cycles from _____ to _____ cps

T_c 4 Sec.
 Anal. Rate 1.25 cps/Sec.
 Loop Length 4 Sec.

CALC	
CHECK	
APR	
APR	

1

DATA IDENTIFICATION

Test Title D. PANEL ATTACHMENT - TYPE I		
FWA No. 1497	Panel or Specimen No. 1497	
Tape No. 26	Tape Channel 1	Mic. No. 1
Elapsed Test Time 5 MIN		Mic. RMS Level at Sonic Lab. $V_L = .200$ Volts

CALIBRATION

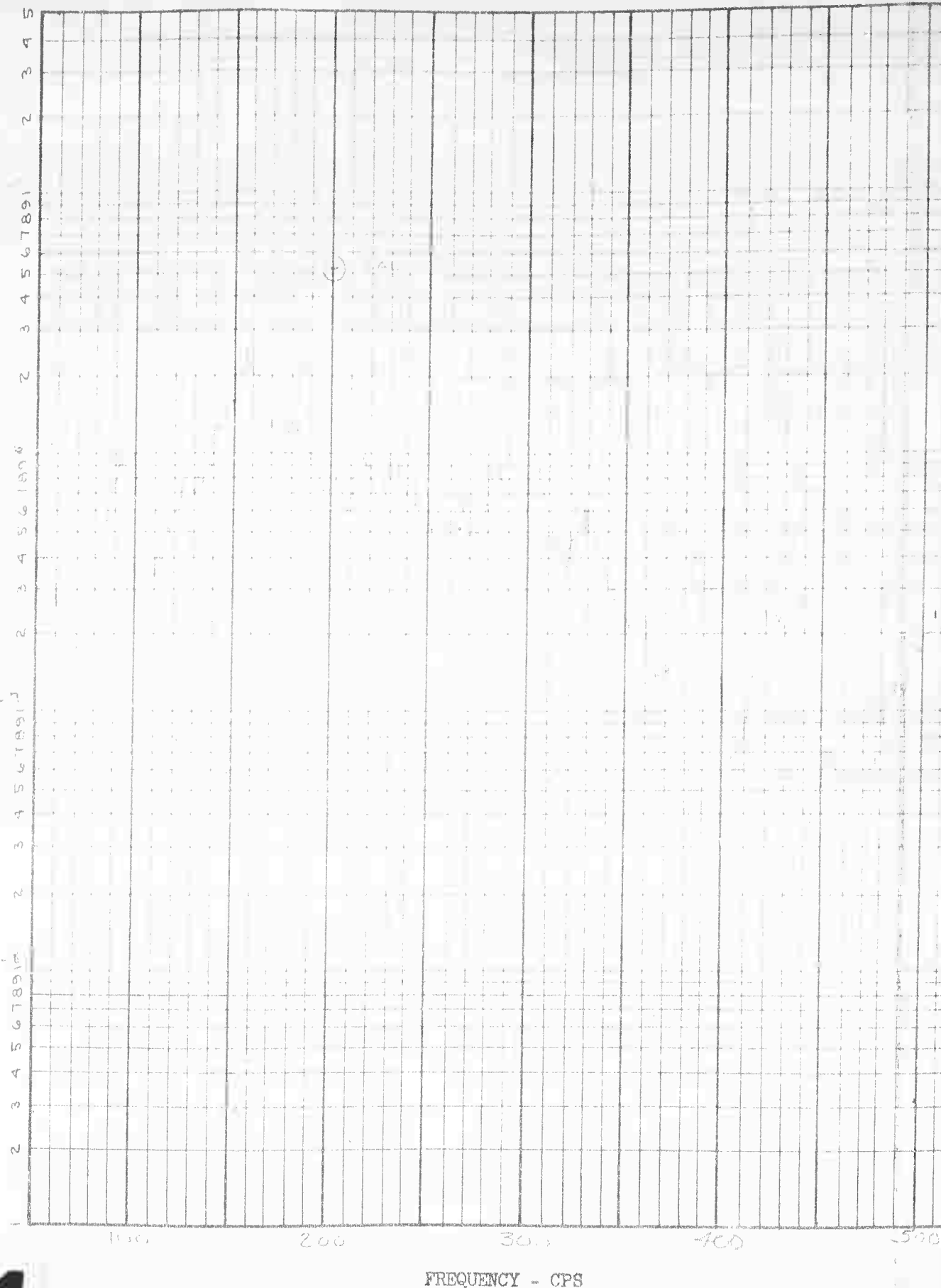
Tape No. 26	Tape Channel 7	Data Tape RMS Volt $V_R = .178$
Calibration Voltage $V_R = .50 V_{RMS}$ into Line Amp.; $V_C = .40 V_{RMS}$ on Tape 6 cps		
Line Amplifier Settings For Calibration $G_C = .5$; for Data $G_d = .5$		
Lab. Gain $LG = 1.0$	Tape Monitor Gain $TMG = \frac{G_d}{G_C} = .5$	
Microphone Sensitivity $S = .270$ psi/Volt or 1 Volt rms / 270 db SPL		
Equivalent of Calibration - psi $P_C = V_R \cdot S = 0.135$		
Equivalent of Calibration for ISD Plots $\left(\frac{P_C}{(TMG)(LG)} \right)^2 = .0045$ psi ² /cps		
Analyzer Attenuator Setting db	Log Converter Setting db	
Calibration Plotted at psi ² /cps		
Overall Pressure Level Data $(P_C)(V_R)$		Equiv. to 1 db SPL
RMS pressure level = $\frac{(P_C)(V_R)}{(TMG)(LG)(V_C)}$ $= \frac{0.135 \cdot 0.178}{0.5 \cdot 1.0 \cdot 0.40} = .596$ psi		

SPECTRUM LEVEL - DECIBELS (Re 0.0002 Microbar)

CALC	REVISED	DATE	POWER SPECTRAL DENSITY ANALYSIS	Vol I
CHECK			OF MICROPHONE OUTPUT	
APR			MIC 1 PANEL 1497 PHA. EA	
APR			BOEING AIRPLANE COMPANY	PAGE
			SEATTLE 24, WASHINGTON	FIG 198

2-5353-7-8

POWER SPECTRAL DENSITY - (psi)²/cps



FREQUENCY - CPS

ANALYSIS VARIABLES

Bandwidth

5 cycles from 50 to 50 cps
 _____ cycles from _____ to _____ cps
 _____ cycles from _____ to _____ cps

T_c 4 Sec.
 Anal. Rate 1.25 cps/Sec.
 Loop Length 4 Sec.

CALC	
CHECK	
APR	
APR	

DATA IDENTIFICATION

Test Title D.S. PANEL ATVA HML - TYPE 1		
EWA No. 5-5-4	Panel or Specimen No. 1-1-1	
Tape No. 26	Tape Channel 2	Mic. No. 2
Elapsed Test Time 5 MIN.		Mic. RMS Level at Sonic Lab. VL = 1.2 Volts

CALIBRATION

Tape No. 26	Tape Channel 2	Data Tape RMS Volt VR = 1.2
Calibration Voltage Va = 1.0 Vrms into Line Amp.: Vc = 490 Vrms on Tape 2 cps		
Line Amplifier Settings For Calibration Gc = 1.0; for Data Gd = 1.0		
Lab. Gain LG = 1.0	Tape Monitor Gain MG = 1.0	
Microphone Sensitivity S = 200 psi/volt or 1 Volt rms = 100 dB SPL		
Equivalent of Calibration - psi Fc = Va * S = 200		
Equivalent of Calibration for PSD plots $\left(\frac{F_c}{(TW)(LG)} \right) = \dots$		
Amplifier Attenuator Setting ab	Log Converter Setting cb	
Calibration Flashed at 5 Hz (10)		
Overall Pressure Level Data $\frac{(F_c)(V_R)}{(TW)(LG)(V_a)}$		equiv. to 100 dB SPL
RMS pressure level = $\frac{(F_c)(V_R)}{(TW)(LG)(V_a)} = \dots$ psi		

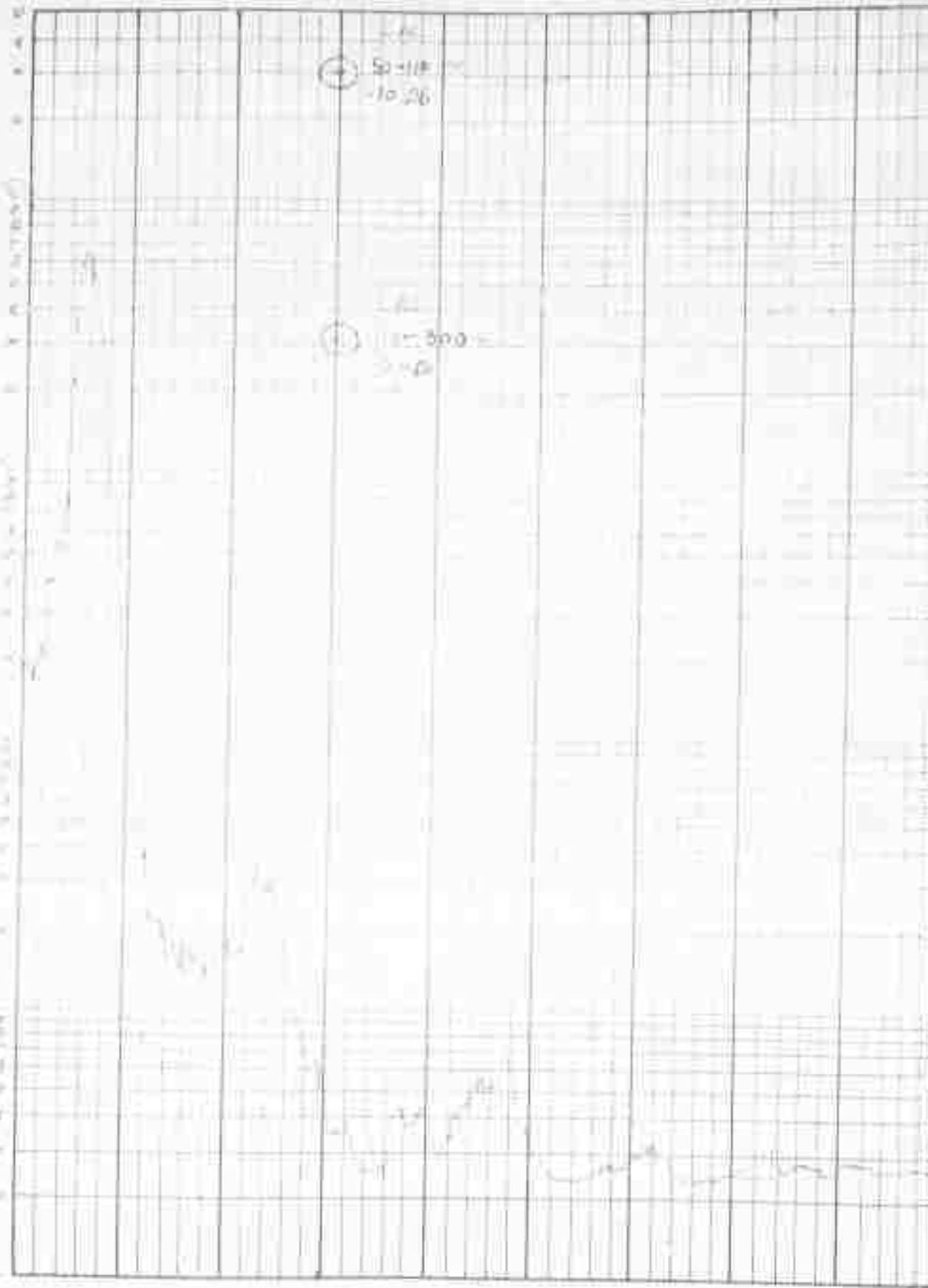
SPECTRUM LEVEL - DECIBELS (Re 0.000 Microbar)

2

CALC	REVISED	DATE	POWER SPECTRAL DENSITY ANALYSIS	VOL I
CHECK			OF MICROPHONE OUTPUT	
APR			MIC #2 PHASE A	
APR			BOEING AIRPLANE COMPANY	PAGE 183
			SEATTLE 24, WASHINGTON	

4-5353-7-8

POWER SPECTRAL DENSITY - (In.)²/cps



FREQUENCY - CPS

1

ANALYSIS VARIABLES

Bandwidth

5 cycles from 50 to 500 cps
 _____ cycles from _____ to _____ cps
 _____ cycles from _____ to _____ cps

T_c 4 Sec.

Anal. Rate 1.25 cps/sec.

Loop Length 4 Sec.

CALC
 CHECK
 APR.
 APR.

DATA IDENTIFICATION

Test Title D.S. PANEL ATTACH - TYPE I		
EWA No.	Panel or Specimen No. 1937	
Tape No. 26	Tape Channel	Displacement Pickup
Elapsed Test Time 5 MIN	P/U RMS Level at Sonic Lab. VL = 2.2 Volts	

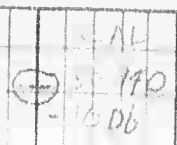
CALIBRATION

Tape No.	Tape Channel	Data Tape RMS Volt VR = 2.65
Calibration Voltage Va = Vrms into Line Amp. V. = 2.95 rms on spec		
Line Amplifier Settings For Calibration: 1.5 1.5 1.5		
Lab. Gain 10 = 10	Tape Monitor Gain: 10 = 10	
Displacement Pickup Sensitivity S = 0.05 in./Volt		
Equivalent of Calibration in Fe = Va / S = 58 in.		
Equivalent of Calibration for RMS Flats $\left(\frac{2}{(10)(15)} \right)^2 \cdot \left[\frac{0.175}{(1.0)} \right]^2$		
Log Converter Setting 0 db		
RMS Deflection Level of Data $\text{RMS Defl. Level} = \frac{(Fe)(VR)}{(10G)(LG)(Vc)} = 1.1 \text{ in}$		

2

CALC	MEM	6-3	REVISED	DATE	POWER SPECTRAL DENSITY ANALYSIS OF DISPLACEMENT PICKUP	Vol I
CHEK	10.1	6/3/60			500 cps	DEPT 44
APR					7/0 #1 PANEL TEST PHASE A	PAGE
APR					BOEING AIRPLANE COMPANY	FIG 190
SEATTLE 24, WASHINGTON						

1



Bandwidth

T_c 4 Sec.

Anal. Rate 1.25 cps/sec.
Loop Length 1 Sec.

CALC *ACN*

CHECK 2B7

APR.

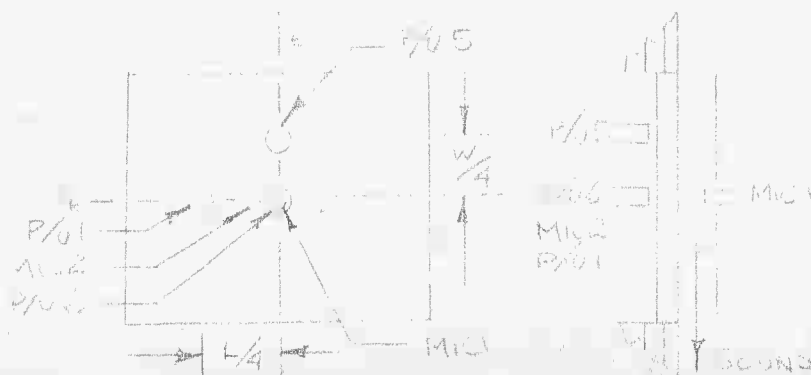
APP

DATA IDENTIFICATION

Test Title D.S. PANEL ATTACHMENT - TYPE 1		
EWA No. 5 573	Panel or Specimen No. 1417	
Tape No. 26	Tape Channel 4	Displacement Pickup 5
Elapsed Test Time 5 MIN.		P/U RMS Level at Sonic Lab. VL = .350 Volts

CALIBRATION

Tape No. 26	Tape Channel 7	Data Tape RMS Volt VR = .340
Calibration Voltage Va = .5 Vrms into Line Amp.; Vc = .470 rms on Tape @ 500 cps		
Line Amplifier Settings For Calibration Gc = .500; for Data Gd = .5		
Lab. Gain LG = 1.0	Tape Monitor Gain TMG = $\frac{G_d}{G_c} = 1.0$	
Displacement Pickup Sensitivity S = .035 in./Volt		
Equivalent of Calibration - in. Dc = Va * S = 0.0175		
Equivalent of Calibration for PSD Plots $\left(\frac{D_c}{(TMG)(LG)}\right)^2 = 2.04 \times 10^{-4}$ in. ² /cps		
Analyzer Attenuator Setting 10 db	Log Converter Setting 0 db	
Calibration Plotted at 500 cps		
Overall Deflection Level of Data RMS Defl. Level = $\frac{(D_c)(V_R)}{(TMG)(LG)(V_c)} = 0.0004$ in.		

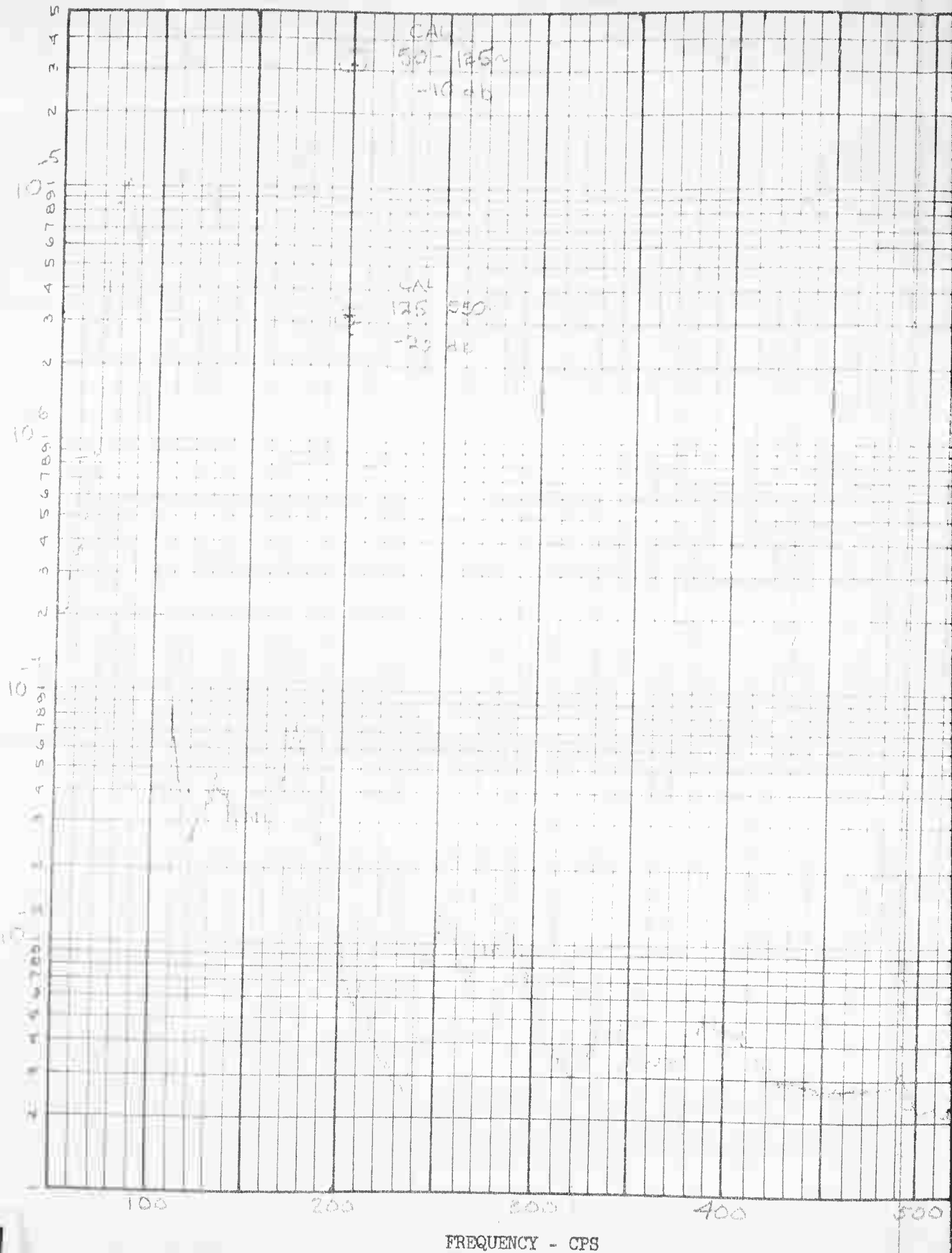


CALC 1/25/61	REVISED	DATE	POWER SPECTRAL DENSITY ANALYSIS OF DISPLACEMENT PICKUP	VOLT
CHECK DET.			P/U #5 PANEL 1417 PHASE "A"	0.35004
APR.			BOEING AIRPLANE COMPANY	PAGE
APR.			SEATTLE 24, WASHINGTON	FIG 191

2-5353-7-9

2

POWER SPECTRAL DENSITY - (In.)²/cpe



1

ANALYSIS VARIABLES

Bandwidth

5 cycles from 50 to 500 cps
 _____ cycles from _____ to _____ cps
 _____ cycles from _____ to _____ cps

T_c 4 Sec.
 Anal. Rate 1.25 cps/sec.
 Loop Length 4 Sec.

CALC	C BT
CHECK	
APR.	
APR.	

DATA IDENTIFICATION

Test Title L.S. PANEL ATTACHMENT - TYPE I		
EWA No. 5-573	Panel or Specimen No. 1297	
Tape No. 26	Tape Channel 5	Displacement Pickup # 6
Elapsed Test Time 5 MIN.		P/U RMS Level at Sonic Lab. VL = .370 Volts

CALIBRATION

Tape No. 26	Tape Channel 7	Data Tape RMS Volt VR = .370
Calibration Voltage Va = .50 Vrms into Line Amp.; Vc = 1 Vrms on Tape @ 20 cps		
Line Amplifier Settings For Calibration Gc = 1.000; for Data Gd = 1.000		
Lab. Gain LG = 1.0	Tape Monitor Gain TMG = $\frac{Gd}{Vc}$ = 1.0	
Displacement Pickup Sensitivity S = .035 in./Volt		
Equivalent of Calibration - in. Dc = Va * S = .0175		
Equivalent of Calibration for PSD Plots $\left(\frac{Dc}{(TMG)(LG)}\right)^2 = 3.06 \times 10^{-4}$ in. ² /cps		
Analyzer Attenuator Setting 10 dB	Log Converter Setting dB	
Calibration limited at 3.00 in. ² /cps		
Overall Deflection Level of Data RMS Defl. Level = $\frac{(Dc)(VR)}{(TMG)(LG)(Vc)}$ = 1.0 in.		

CALC	BT	W/2/6	REVISED	DATE	POWER SPECTRAL DENSITY ANALYSIS OF DISPLACEMENT PICKUP	1297
CHECK					P/U #6 PANEL 1297 PHASE A	1297
APR					BOEING AIRPLANE COMPANY	PAGE
APR					SEATTLE 24, WASHINGTON	FIG 1-2

POWER SPECTRAL DENSITY - (psi)²/cps

1

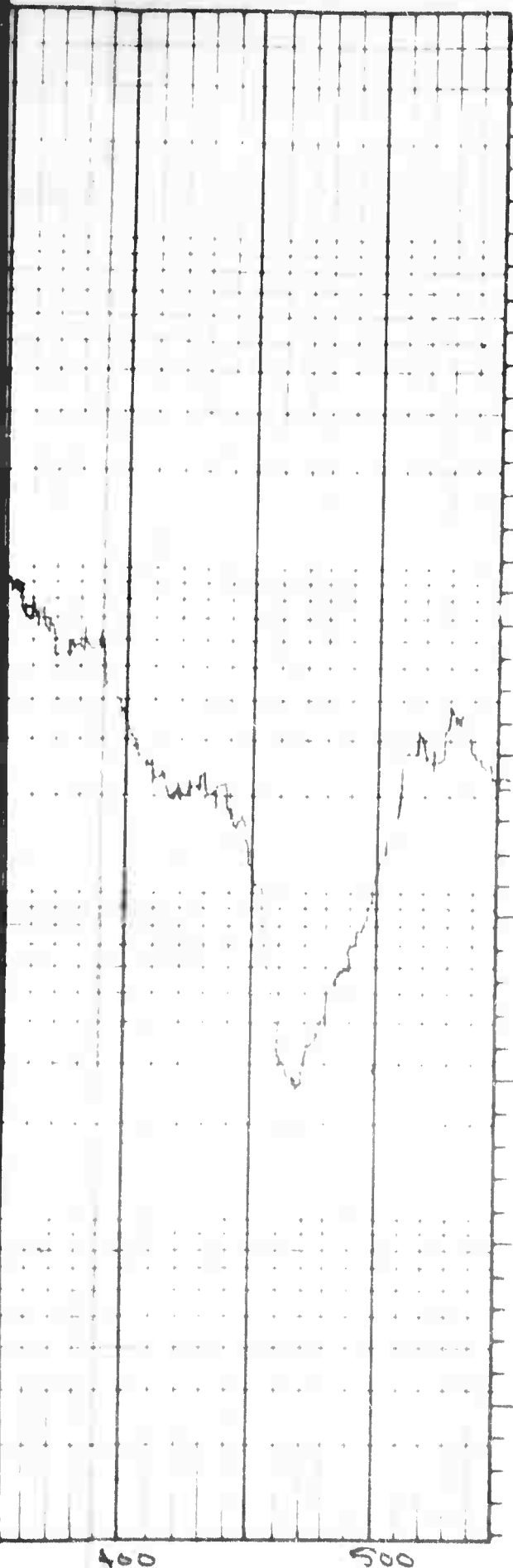


ANALYSIS VARIABLES

Bandwidth

5 cycles from 50 to 500 cps
 cycles from to cps
 cycles from to cps

15 Sec.
 Anal. Rate 333 cps/Sec.
 Loop Length 15 Sec.



SPECTRUM LEVEL - DECIBELS (Re 0.0002 Microbar)

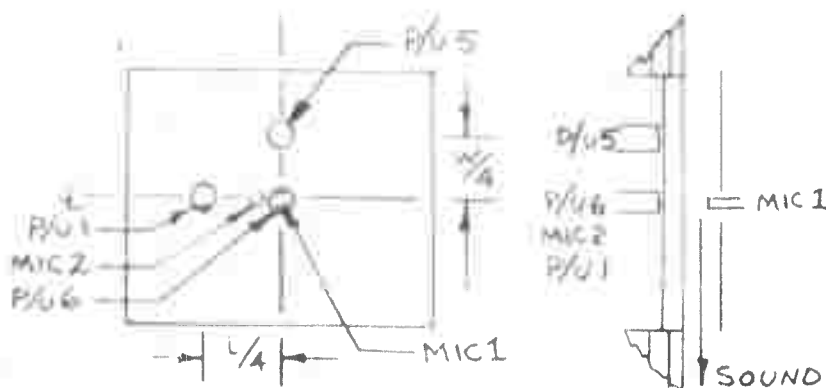
DATA IDENTIFICATION

Test Title D S. PANEL ATTACHMENT TYPE 1		
EWA No. 5-593	Panel or Specimen No. 1497	
Tape No. 57	Tape Channel 1	Mic. No. 1
Elapsed Test Time 60 MIN		Mic. RMS Level at Sonic Lab. V_L = .700 Volts

CALIBRATION

Tape No. 57	Tape Channel 6	Data Tape RMS Volt V_R = .134
Calibration Voltage V_a = .50V_{rms} into Line Amp.; V_c = .50V_{rms} on Tape @ 200cps		
Line Amplifier Settings For Calibration G_c = 500; for Data G_d = 100		
Lab. Gain LG = 1	Tape Monitor Gain TMG = $\frac{G_d}{G_c} = .2$	
Microphone Sensitivity S = 290 psi/Volt or 1 Volt rms = 160 db SPL		
Equivalent of Calibration - psi P_c = V_R · S = .145		
Equivalent of Calibration for PSD Plots $\left(\frac{P_c}{(TMG)(LG)}\right)^2 = \left[\frac{.145}{(.2)(1)}\right]^2 = .525$ psi²/cps		
Analyzer Attenuator Setting - 30 db	Log Converter Setting db	
Calibration Plotted at 5.25×10^{-4}		psi ² /cps
Overall Pressure Level Data RMS pressure level = $\frac{(P_c)(V_R)}{(TMG)(LG)(V_c)}$		Equiv. to 156.8 db SPL
		= $\frac{(145)(.134)}{(.2)(1)(.50)} = .1945$ psi

2



POWER SPECTRAL DENSITY ANALYSIS OF MICROPHONE OUTPUT

PANEL 1497 PHASE C
BOEING AIRPLANE COMPANY
TAMPA, FLORIDA

FIG 193

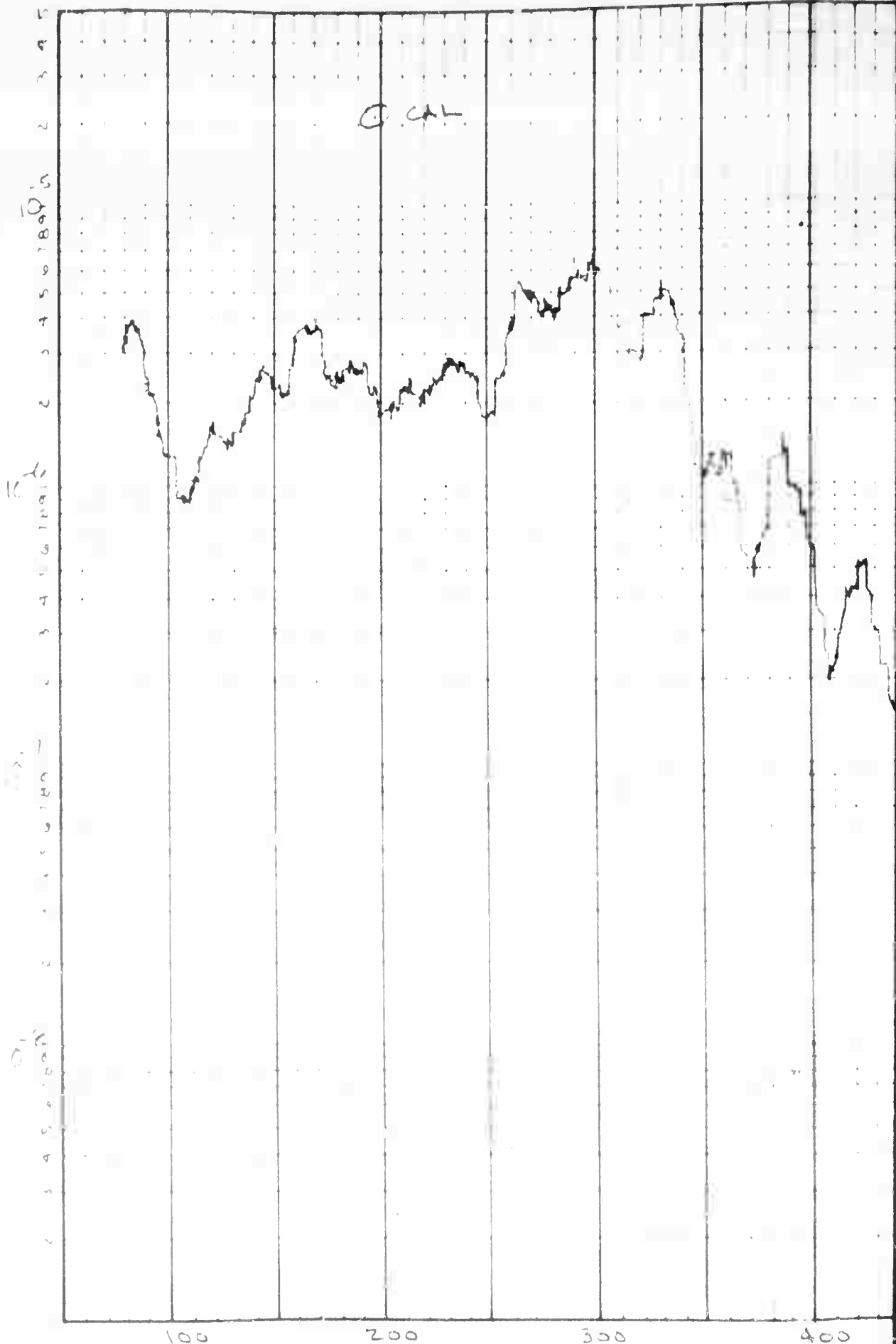
33 cps/sec.
15 sec.

APP

6/21/61

14976 200 WAS 11AC 1656HZ

POWER SPECTRAL DENSITY - $(\text{psi})^2/\text{cpe}$



FREQUENCY - CPS

ANALYSIS VARIABLES

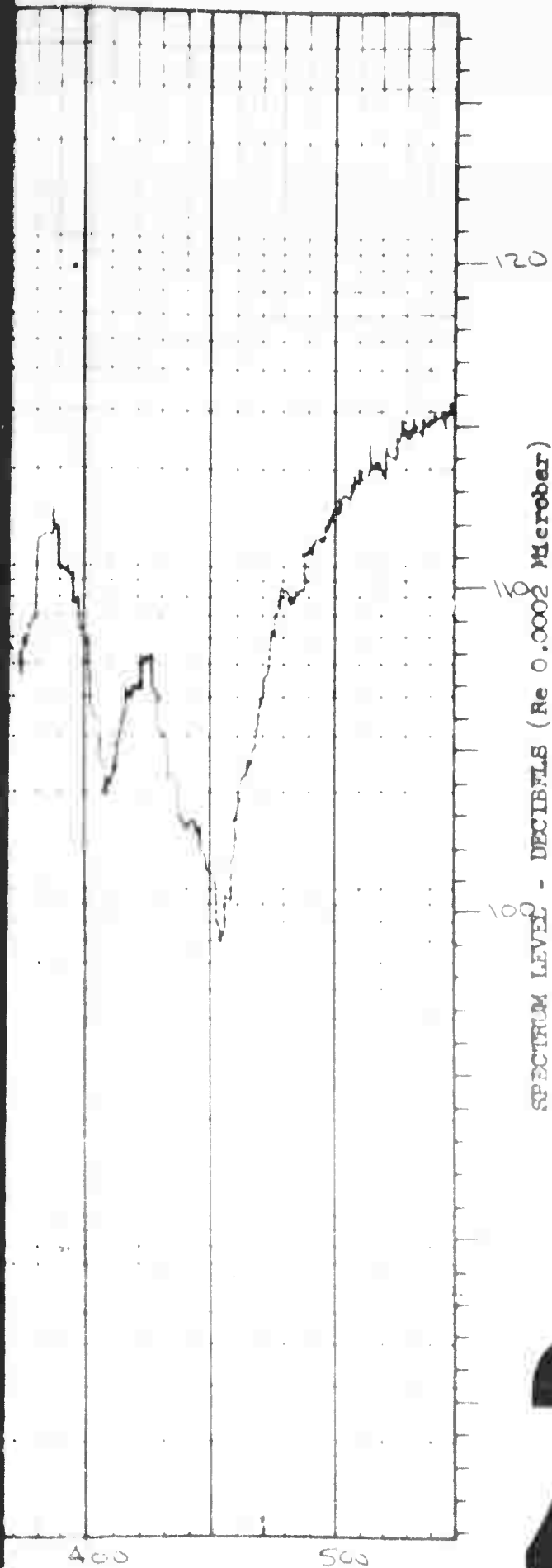
Bandwidth

5 cycles from 50 to 500 cps
 — cycles from — to — cps
 — cycles from — to — cps

T_c 15 Sec.

Anal. Rate 33.3 cps/Sec.

Loop Length 15 Sec.



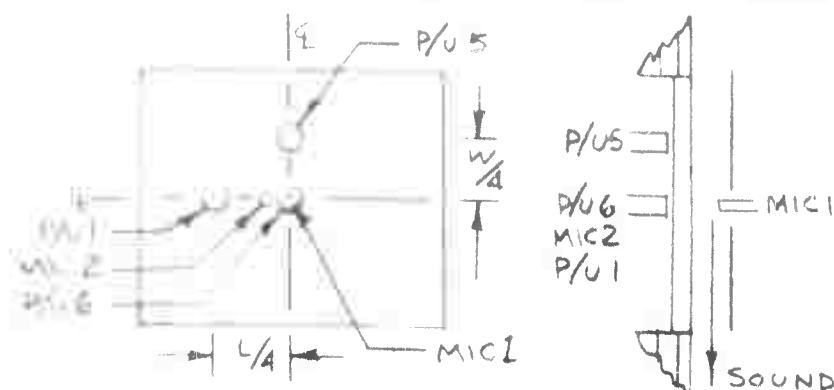
DATA IDENTIFICATION

Test Title D.S. PANEL ATTACHMENT - TYPE 1		
EWA No. 5-593	Panel or Specimen No. 1497	
Tape No. 57	Tape Channel 2	Mic. No. 2
Elapsed Test Time +60 MIN.		Mic. RMS Level at Sonic Lab. $V_L = .145$ Volts

CALIBRATION

Tape No. 57	Tape Channel 6	Data Tape RMS Volt $V_R = .147$
Calibration Voltage $V_a = .50V_{rms}$ into Line Amp.; $V_c = .50V_{rms}$ on Tape @ 200 cps		
Line Amplifier Settings For Calibration $G_c = 500$; for Data $G_d = 500$		
Lab. Gain $LG = 1$	Tape Monitor Gain $TMG = \frac{G_d}{G_c} = 1$	
Microphone Sensitivity $S = .290$ psi/Volt or 1 Volt rms = 160 db SPL		
Equivalent of Calibration - psi $P_c = V_a \cdot S = .145$		
Equivalent of Calibration for PSD Plots $\left(\frac{P_c}{(TMG)(LG)} \right)^2 = \left[\frac{.145}{(1)(1)} \right]^2 = .021 \quad \text{psi}^2/\text{cps}$		
Analyzer Attenuator Setting - 20 db	Log Converter Setting db	
Calibration Plotted at $2.1 \times 10^{-5} \quad \text{psi}^2/\text{cps}$		
Overall Pressure Level Data $\text{RMS pressure level} = \frac{(P_c)(V_R)}{(TMG)(LG)(V_c)}$ $= \frac{(.145)(.147)}{(1)(1)(.50)} = .0427 \quad \text{psi}$		equiv. to 143.4 db SPL

2



POWER SPECTRAL DENSITY ANALYSIS OF MICROPHONE OUTPUT

PANEL 1497 THASEC
GENERAL AIRPLANE COMPANY
CANTON, MASSACHUSETTS

VOL 2

FIG 194

PAGE

FIG 194

cps/Sec.
Dec.

1/1/61

1/1/61

POWER SPECTRAL DENSITY - (In.)²/cps



FREQUENCY - CPS

ANALYSIS VARIABLES

Bandwidth

5 cycles from 100 to 500 cps
 _____ cycles from _____ to _____ cps
 _____ cycles from _____ to _____ cps

T_c 15 Sec.

Anal. Rate .333 cps/sec.

Loop Length 15 Sec.

CALC ARM

CHECK CBT

APR.

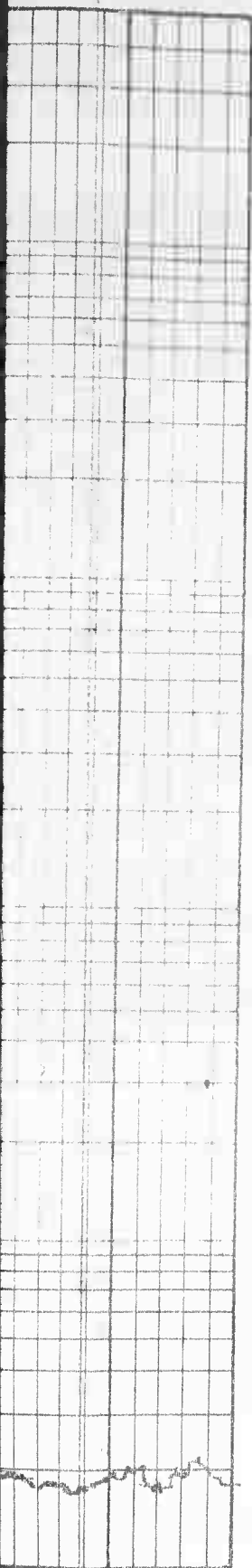
APR

DATA IDENTIFICATION

Test Title D.E. PANEL ATTACHMENT - TYPE I		
EWA No. 5-593	Panel or Specimen No. 1A 37	
Tape No. 57	Tape Channel 3	Displacement Pickup 1
Elapsed Test Time 60 MIN.		P/U RMS Level at Sonic Lab. VL = .265 Volts

CALIBRATION

Tape No. 57	Tape Channel 6	Data Tape RMS Volt VR = 165
Calibration Voltage Va = .50Vrms into Line Amp.; Vc = .50Vrms on Tape @ 200 cps		
Line Amplifier Settings For Calibration Gc = 500 ; for Data Gd = 250		
Lab. Gain LG = 1	Tape Monitor Gain TMC = $\frac{G_d}{G_c} = .5$	
Displacement Pickup Sensitivity S = .0354 in./Volt		
Equivalent of Calibration - in. Dc = Va * S = .0177		
Equivalent of Calibration for PSD Plots $\left(\frac{D_c}{(TMC)(LG)} \right)^2 = \frac{.0177^2}{(250)(1)} = 1.25 \times 10^{-7} \text{ in.}^2/\text{cps}$		
Analyzer Attenuator Setting -20 db		Log Converter Setting 0 db
Calibration Plotted at 1.25 (10 ⁻⁷) in. ² /cps		
Overall Deflection Level of Data $\text{RMS Defl. Level} = \frac{(D_c)(V_R)}{(TMC)(LG)(V_C)} = \frac{(.0177)(165)}{(250)(1)(.5)} = .232 \text{ in.}$		

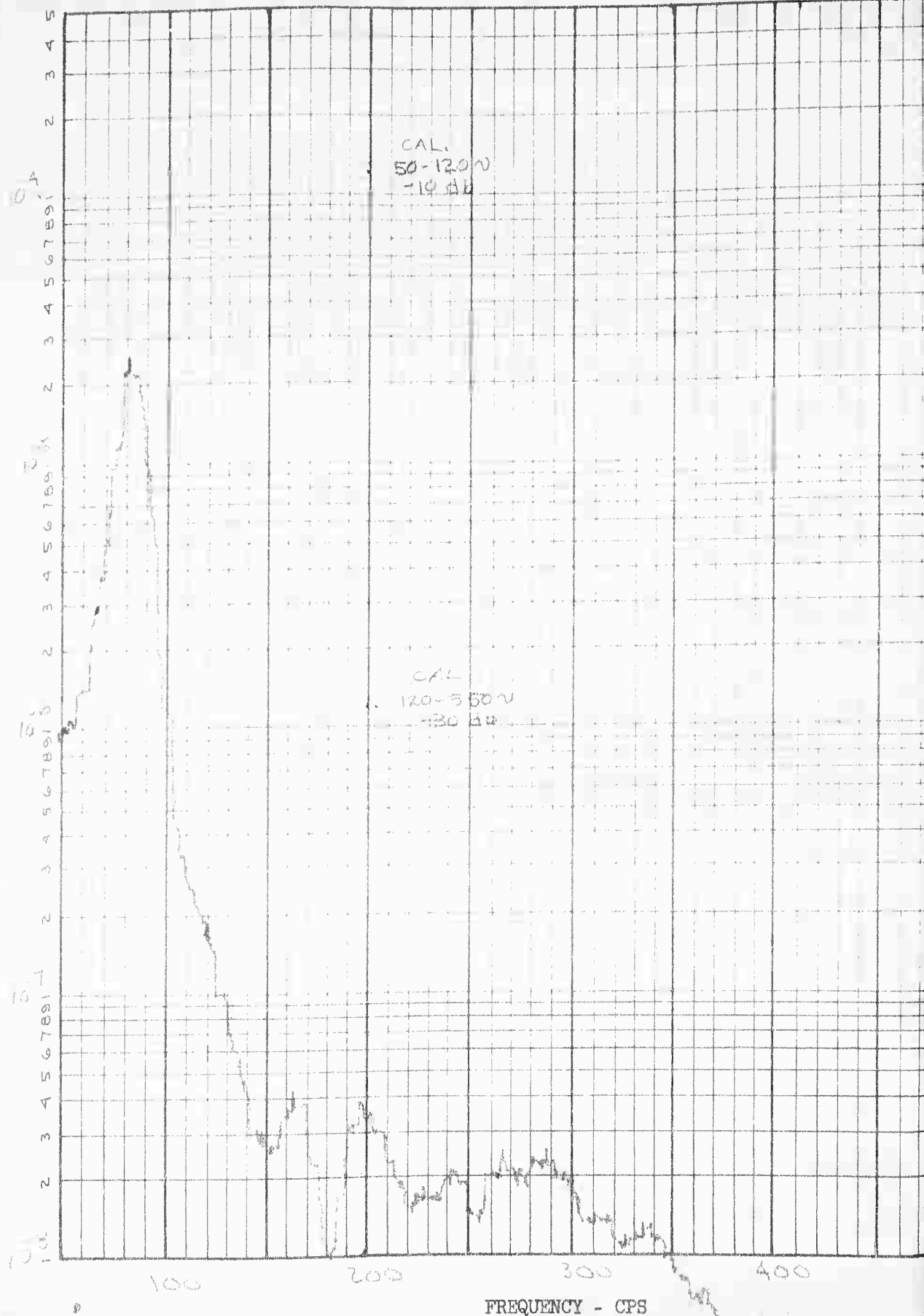


CALC	1/1/11	REVISED	DATE	POWER SPECTRAL DENSITY ANALYSIS	1/1/11
CHECK	CRT			OF DISPLACEMENT PICKUP	
APR.				3.5 MIN TEST 157.5 db	
APR				P/U #1 PANEL 1A37 FMS/C	
				BOEING AIRPLANE COMPANY	PAGE
				SEATTLE 24, WASHINGTON	Fig 195

2-5353-7-9

2

POWER SPECTRAL DENSITY - (In.)²/cps



ANALYSIS VARIABLES

Bandwidth

5 cycles from 50 to 500 cps
 _____ cycles from _____ to _____ cps
 _____ cycles from _____ to _____ cps

T_c 15 Sec.

Anal. Rate .333 cps/sec.

Loop Length 15 Sec.

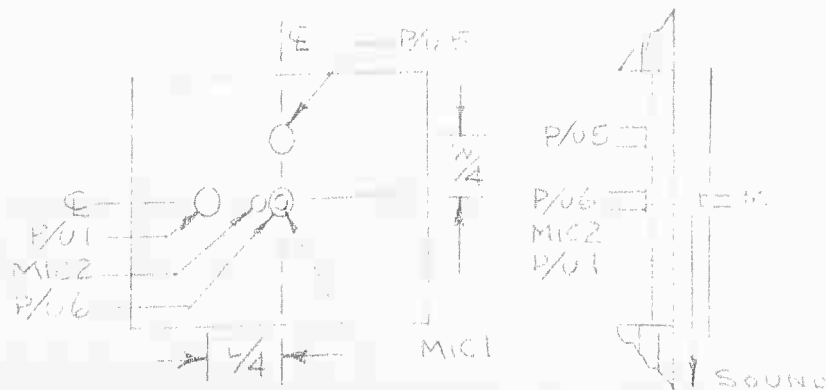
CAL
 CHE
 APR
 APR

DATA IDENTIFICATION

Test Title D.S. PANEL ATTACHMENT - TYPE 1		
EWA No. 5-593		Panel or Specimen No. 1497
Tape No. 57	Tape Channel 4	Displacement Pickup # 5
Elapsed Test Time 60 MIN.		P/U RMS Level at Sonic Lab. VL = .560 Volts

CALIBRATION

Tape No. 57	Tape Channel 6	Data Tape RMS Volt VR = .790
Calibration Voltage Va = .50Vrms into Line Amp.; Vc = .5 Vrms on Tape @ 200cps		
Line Amplifier Settings For Calibration Gc = 5.00; for Data Gd = 2.50		
Lab. Gain LG = 1	Tape Monitor Gain TMG = $\frac{G_d}{G_c} = .5$	
Displacement Pickup Sensitivity S = .0154 in./Volt		
Equivalent of Calibration - in. Dc = Va * S = .0177		
Equivalent of Calibration for PSD Plots $\left(\frac{D_c}{(TMG)(LG)} \right)^2 = \left(\frac{.0177}{(.5)(1)} \right)^2 = 1.25 \times 10^{-4} \text{ in.}^2/\text{cps}$		
Analyzer Attenuator Setting db	Log Converter Setting db	
Calibration Plotted at $1.25 \times 10^{-4} \text{ in.}^2/\text{cps}$		
Overall Deflection Level of Data RMS Defl. Level = $\frac{(D_c)(V_R)}{(TMG)(LG)(V_c)} = \frac{(.0177)(.790)}{(.5)(1)(.5)} = .056 \text{ in.}$		

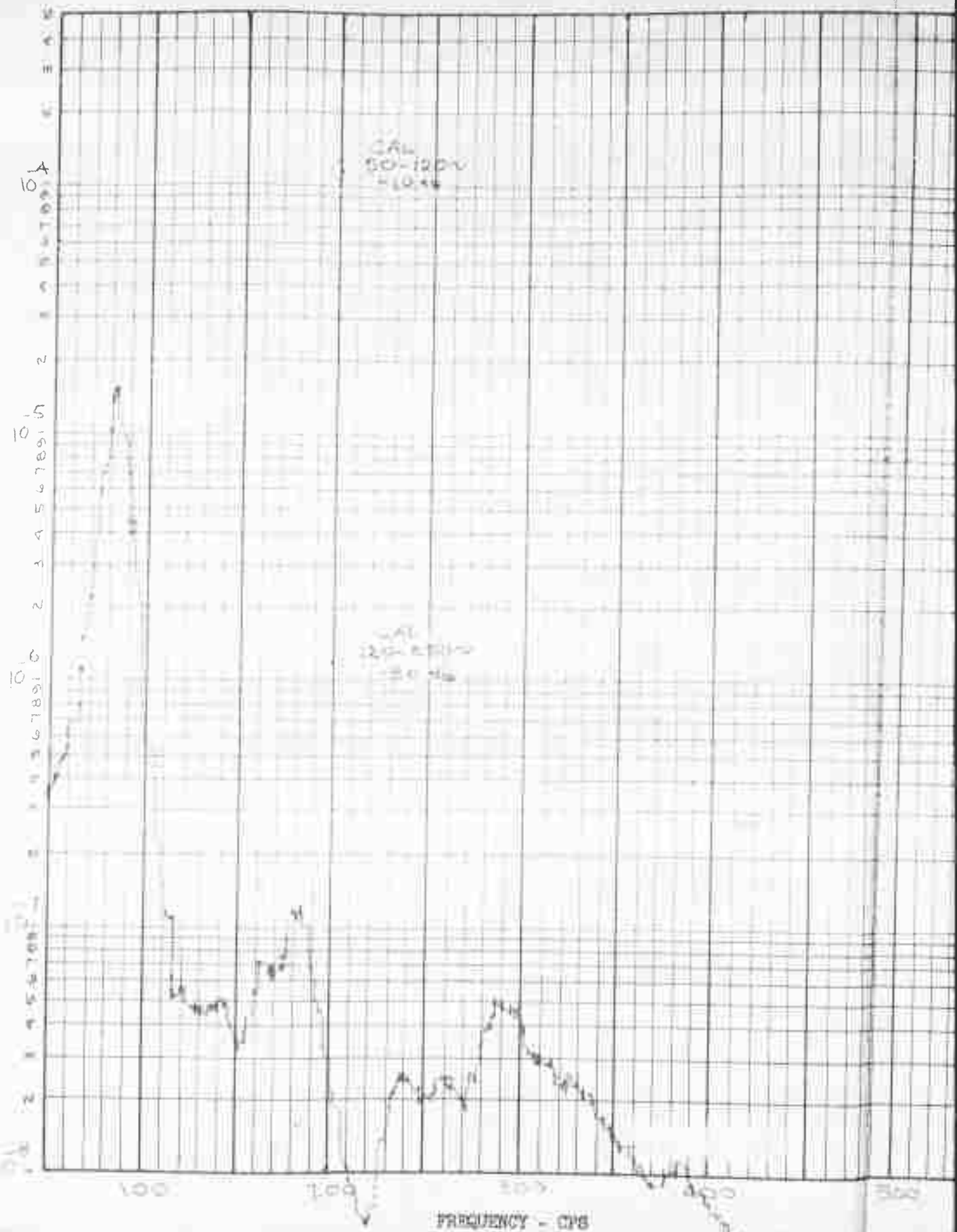


CALC	CRT	6/29/61	REVISED	DATE	POWER SPECTRAL DENSITY ANALYSIS OF DISPLACEMENT PICKUP 0.5 MIN TEST 157.5db	VOL I
CHECK						
APR					P/U 5 PANEL 1497 P. 1497	PAGE
APR					BOEING AIRPLANE COMPANY SEATTLE 24, WASHINGTON	FIG 136

2-5353-7-9

2

POWER SPECTRAL DENSITY - (In.)²/cps



1

ANALYSIS VARIABLES

Bandwidth

5 cycles from 50 to 500 cps
 _____ cycles from _____ to _____ cps
 _____ cycles from _____ to _____ cps

1.15 Sec.
 Anal. Rate .333 cps/sec.
 Loop Length 15 Sec.

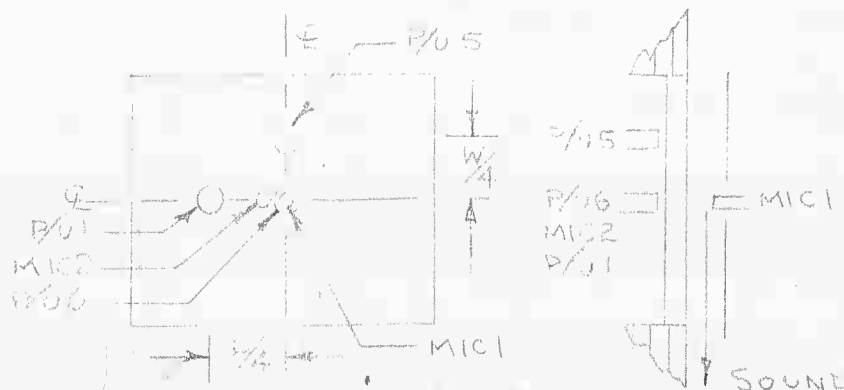
CALC
 CHECK
 AFE

DATA IDENTIFICATION

Test Title D.S. PANEL ATTACHMENT - TYPE I		
EWA No. 5-593	Panel or Specimen No. 1497	
Tape No. 57	Tape Channel 5	Displacement Pickup # 6
Elapsed Test Time 60 MIN.	P/U RMS Level at Sonic Lab. VL = 480 Volts	

CALIBRATION

Tape No. 57	Tape Channel 6	Data Tape RMS Volt VR = .230
Calibration Voltage VA = 50Vrms into Line Amp.; VC = 50Vrms on Tape @ 200 cps		
Line Amplifier Settings For Calibration GC = 500 ; for Data GD = 250		
Lab. Gain LG = 1	Tape Monitor Gain TMC = $\frac{GD}{GC} = .5$	
Displacement Pickup Sensitivity S = .034 in./Volt		
Equivalent of Calibration - in. DC = VA · S = .0177		
Equivalent of Calibration for PSD Plots $\left(\frac{DC}{(TMC)(LG)}\right)^2 = \frac{(.0177)^2}{(.5)(1)} = 1.25 \times 10^{-3} \text{ in.}^2/\text{cps}$		
Analyzer Attenuator Setting 50-120 120-500	Log Converter Setting -10 -30 db db	
Calibration Plotted at $1.25 \times 10^{-3} \text{ in.}^2/\text{cps}$		
Overall Deflection Level of Data RMS Defl. Level = $\frac{(DC)(VR)}{(TMC)(LG)(VC)} = \frac{(.0177)(.23)}{(.5)(1)(.5)} = .0163 \text{ in.}$		

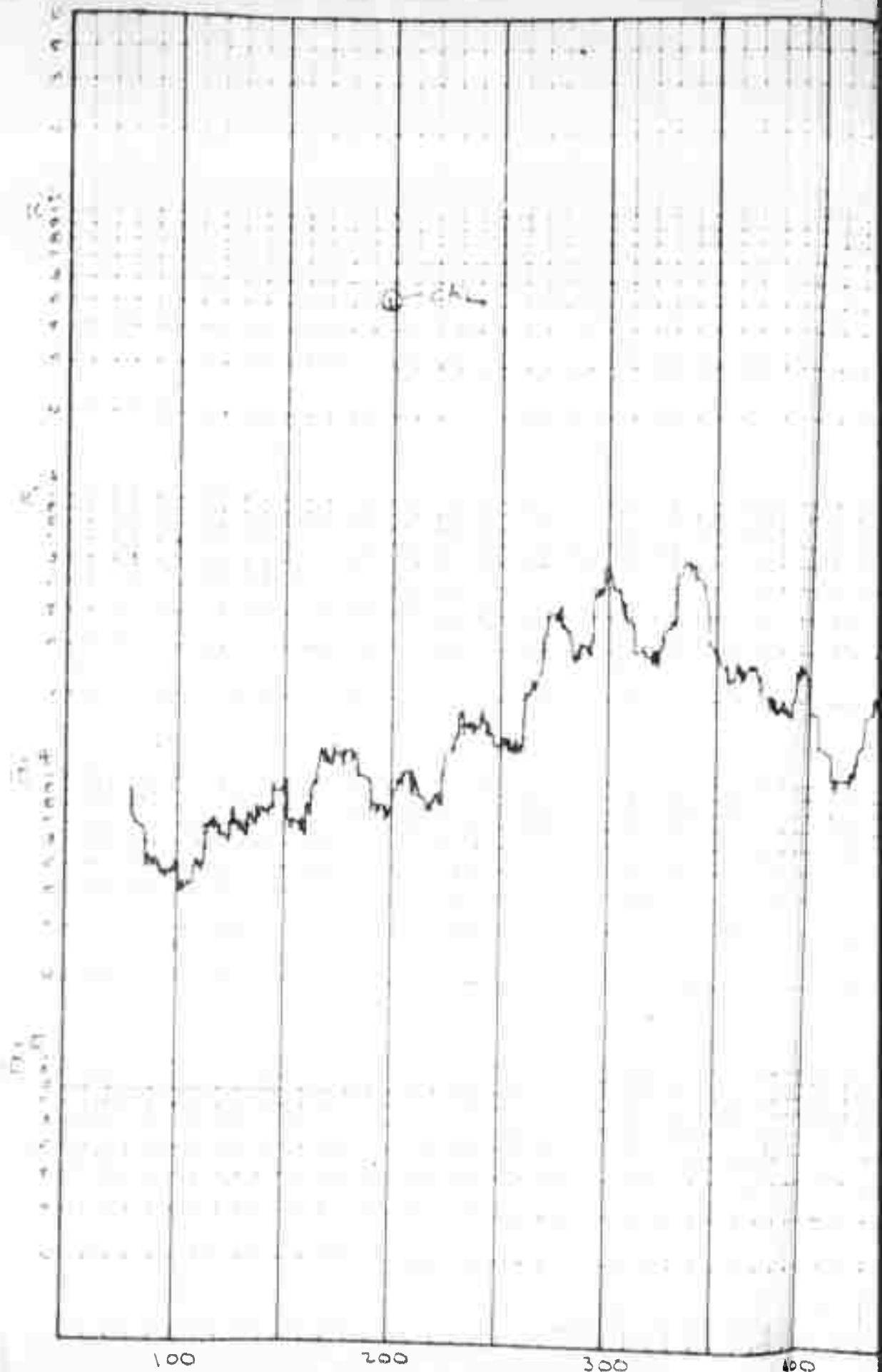


CALC	CBT	4/28/61	REVISED	DATE	POWER SPECTRAL DENSITY ANALYSIS OF DISPLACEMENT PICKUP 0.5 MIN TEST 157.5db	VOL I
CHECK					P/U #6 PANEL 1497 PHASE 15	DZ-8-084
APR.					BOEING AIRPLANE COMPANY SEATTLE 24, WASHINGTON	PAGE FIG 1A7

2-5353-7-9

2

POWER SPECTRAL DENSITY - $(\text{psi})^2/\text{cps}$



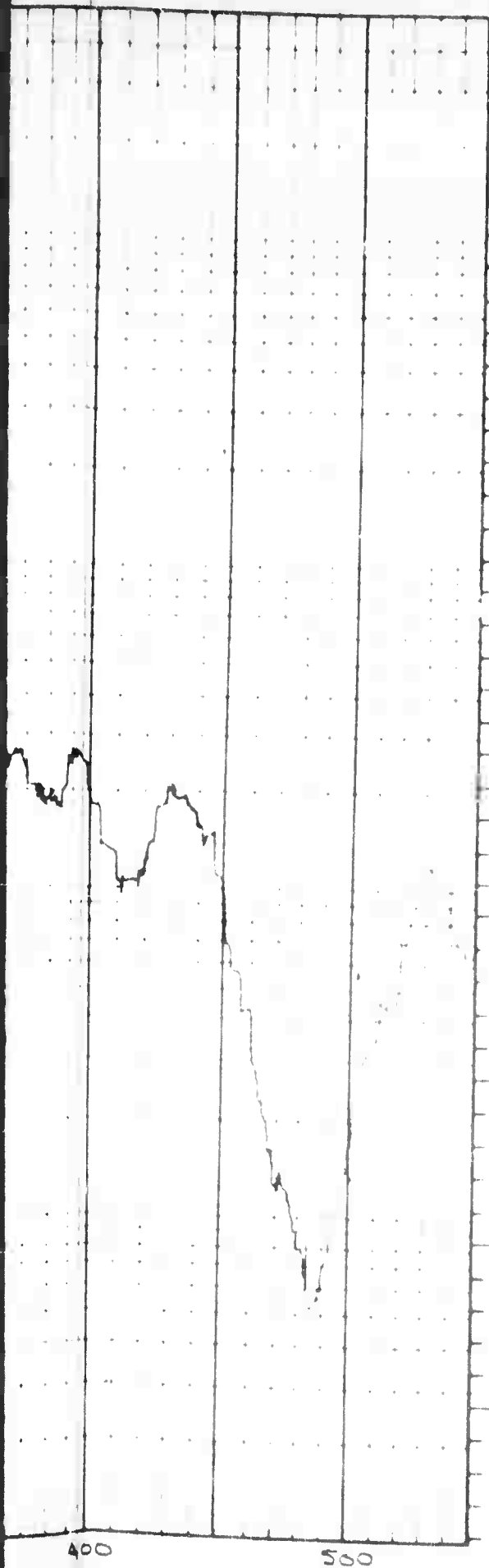
FREQUENCY - CPS

ANALYSIS VARIABLES

Bandwidth

5 cycles from 50 to 500 cps
 _____ cycles from _____ to _____ cps
 _____ cycles from _____ to _____ cps

T_c 15 Sec.
 Anal. Rate 333 cps/Sec.
 Loop Length 15 Sec.



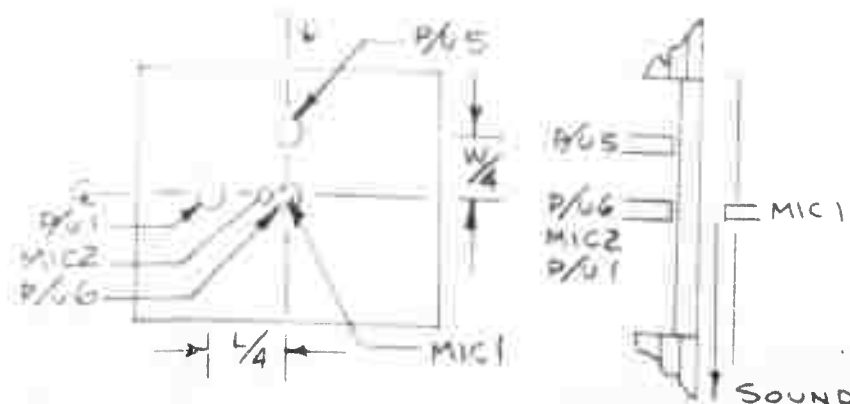
SPECTRUM LEVEL - DECIBELS (Re 0.0002 Microbar)

DATA IDENTIFICATION

Test Title D.S. PANEL ATTACHMENT - TYPE I		
EWA No. 5.593	Panel or Specimen No. 1497	
Tape No. 58	Tape Channel 1	Mic. No. 1
Elapsed Test Time 60.5 MIN.	Mic. RMS Level at Sonic Lab. V_L = 1.27 Volts	

CALIBRATION

Tape No. 58	Tape Channel 6	Data Tape RMS Volt V_R = .230
Calibration Voltage V_a = .50V_{rms} into Line Amp.; V_c = .50V_{rms} on Tape @ 200cps		
Line Amplifier Settings For Calibration G_c = 500 ; for Data G_d = 100		
Lab. Gain LG = 1	Tape Monitor Gain TMG = $\frac{G_d}{G_c} = .2$	
Microphone Sensitivity S = .290 psi/Volt or 1 Volt rms = 160 db SPL		
Equivalent of Calibration - psi P_c = V_a · S = .145		
Equivalent of Calibration for PSD Plots $\left(\frac{P_c}{(TMG)(LG)} \right)^2 = \left[\frac{.145}{(.2)(1)} \right]^2 = .525$ psi²/cps		
Analyzer Attenuator Setting db	Log Converter Setting db	
Calibration Plotted at -20 -10	psi²/cps	
Overall Pressure Level Data RMS pressure level = $\frac{(P_c)(V_R)}{(TMG)(LG)(V_c)}$		Equiv. to 161.3 db SPL
= $\frac{(.145)(.230)}{(.2)(1)(.50)} = .334$ psi		



POWER SPECTRAL DENSITY ANALYSIS OF MICROPHONE OUTPUT

PANEL 1497 PHASE D
BOEING AIRPLANE COMPANY
SEATTLE, WASHINGTON

DZ 80084

PAGE

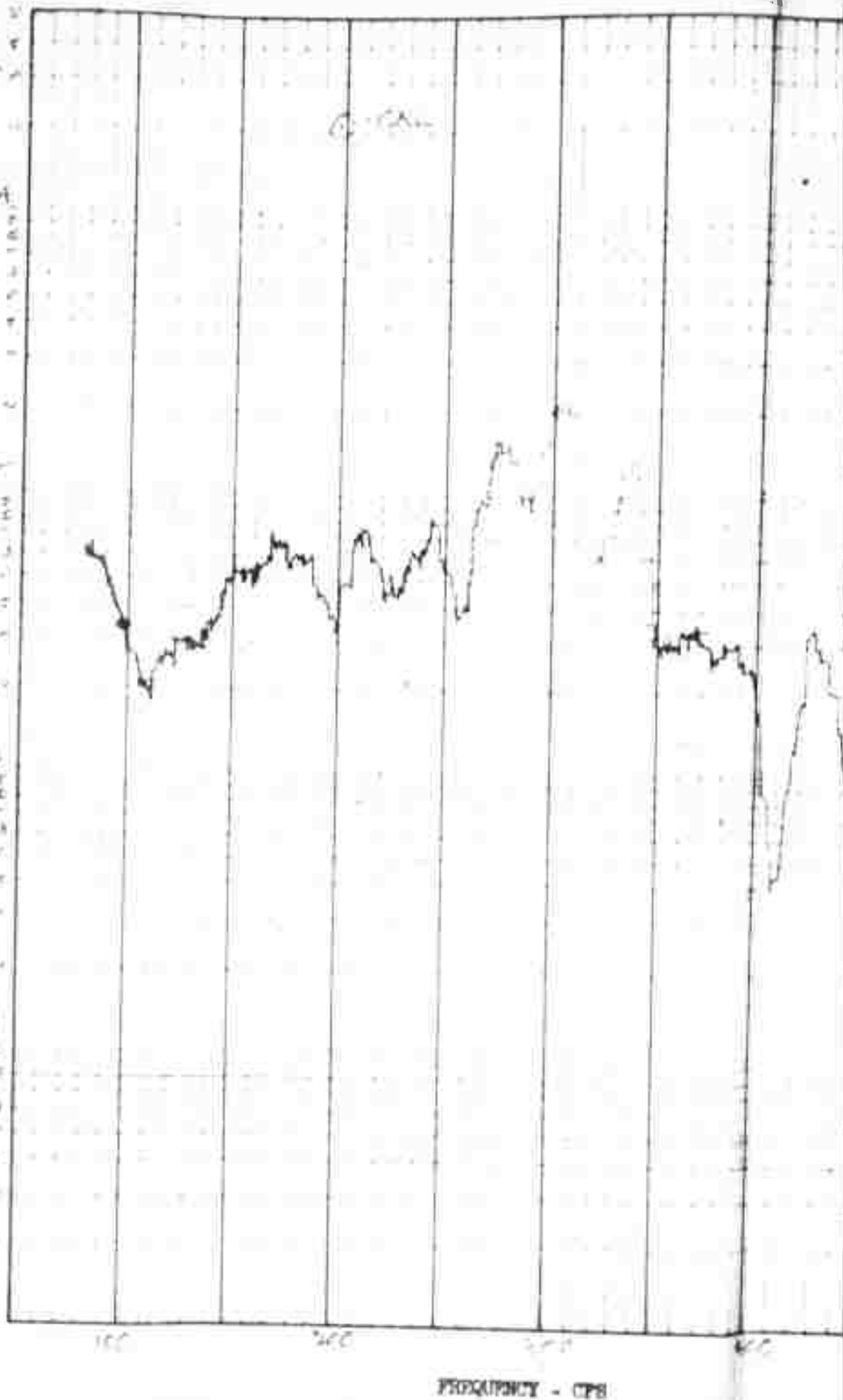
FIG 198

3 cps/Bec.
Bec.

3- 6/24/61
4/25/61

2- 6/2/61

POWER SPECTRAL DENSITY - $(\text{psi})^2/\text{cps}$



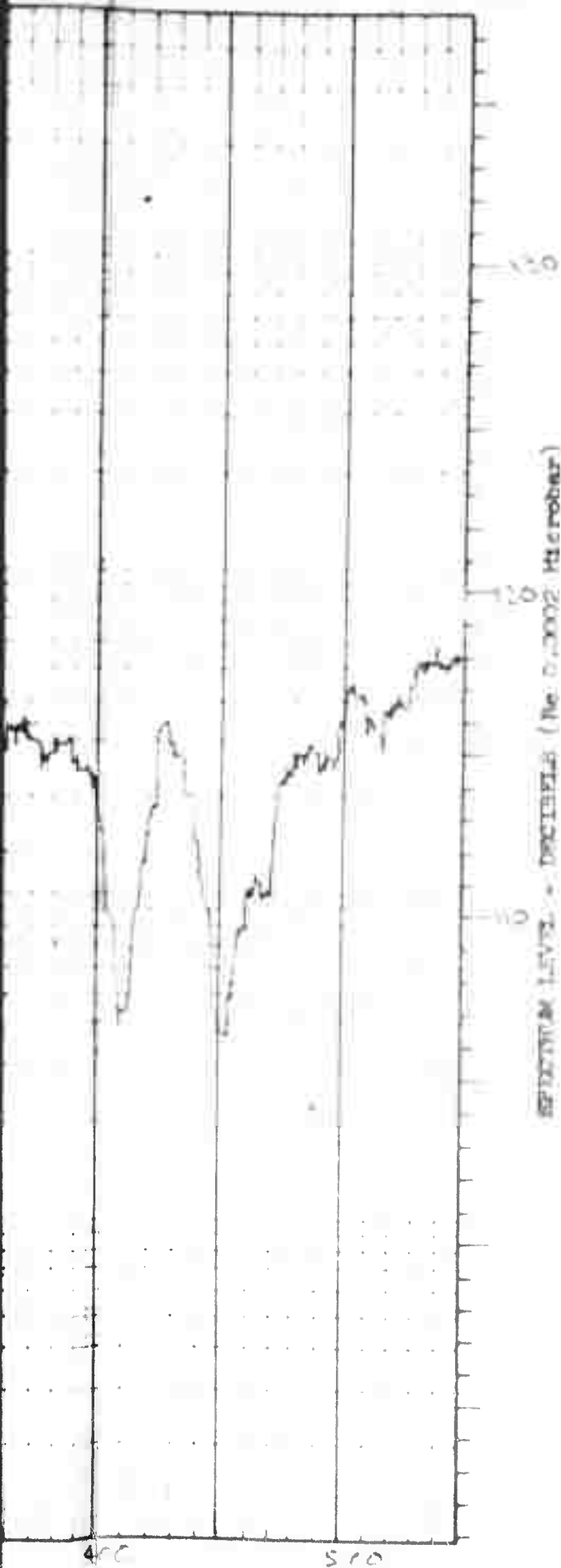
1

ANALYSIS VARIABLES

Bandwidth

5 cycles from 50 to 500 cps
 cycles from to cps
 cycles from to cps

T_c 15 Sec.
 Anal. Rate 133 cps/Sec.
 Loop Length 15 Sec.

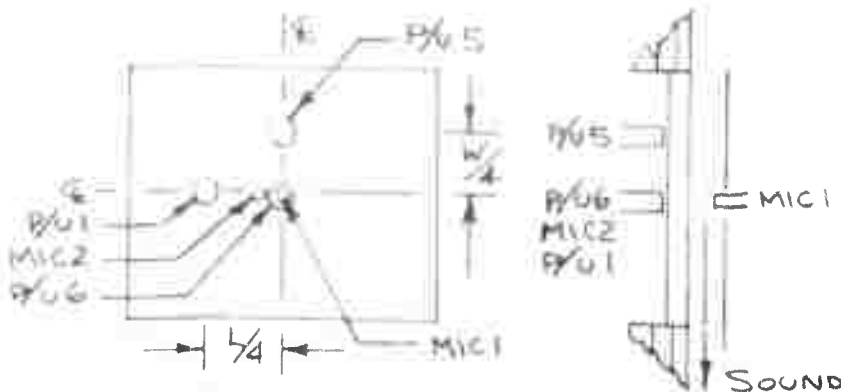


DATA IDENTIFICATION

Test Title D.C. PANEL ATTACHMENT - TYPE I		
EWA No. E-293	Panel or Specimen No. 1497	
Type No. 58	Type Channel 2	Mic. No. 2
Elapsed Test Time 60.5 MIN		Mic. RMS Level at Sonic Lab. VL = 1225 Volts

CALIBRATION

Type No. 58	Type Channel 6	Data Type RMS Volt VR = .215
Calibration Voltage $V_a = .50V_{rms}$ into Line Amp.; $V_c = .50V_{rms}$ on Tape @ 200cps		
Line Amplifier Settings For Calibration $G_c = 100$; for Data $G_d = 500$		
Lab. Gain LG = 1	Tape Monitor Gain $TMG = \frac{G_d}{G_c} = 1$	
Microphone Sensitivity $S = .240 \text{ psi/Volt}$ or 1 Volt rms = 160 db SPL		
Equivalent of Calibration - psi $P_c = V_a \cdot S = (.50)(.240) = .120$		
Equivalent of Calibration for PSD Plots $\left(\frac{P_c}{(TMG)(LG)} \right)^2 = (.120)^2 = .0144 \text{ psi}^2/\text{cps}$		
Analyzer Attenuator Setting 20 db	Log Converter Setting 0 db	
Calibration Plotted at $2.1 \times 10^{-4} \text{ psi}^2/\text{cps}$		
Overall Pressure Level Data RMS pressure level = $\frac{P_c(VR)}{(TMG)(LG)(V_c)}$ $= \frac{(.120)(.215)}{(1)(1)(.50)} = .0624 \text{ psi}$		Equiv. to 146 db SPL



POWER SPECTRAL DENSITY ANALYSIS OF MICROPHONE OUTPUT

PANEL 1497 PHASE D.
BOEING AIRPLANE COMPANY
SEATTLE 28 WASHINGTON

DZ8008A

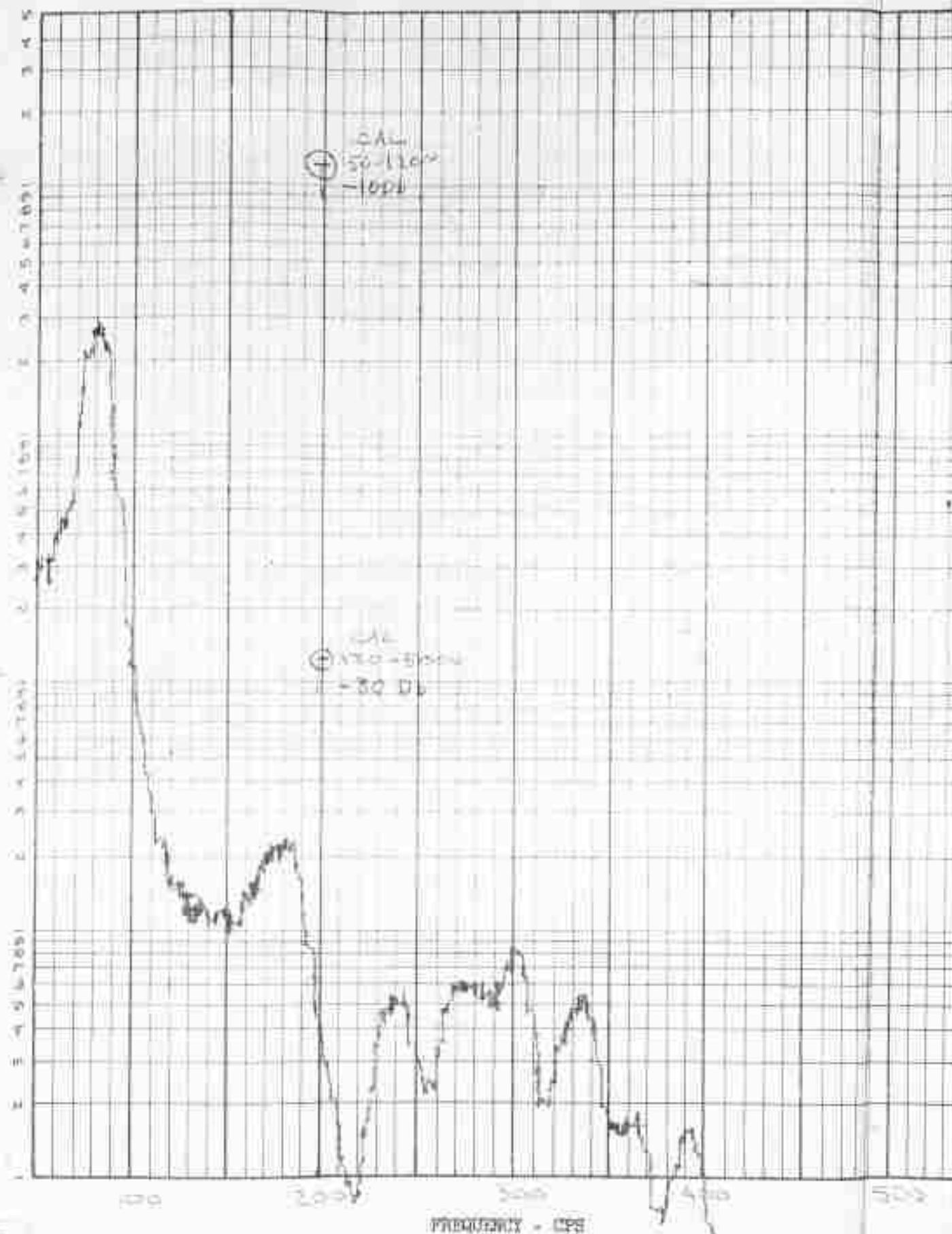
PAGE
FIG 199

CBT 6/24/61
6/24/61

6/21/61

cps/Dec.
Sec.

FORM (SPIN)AL. REBILITY - (Y₀)²/CPS



1

ANALYSIS VARIABLES

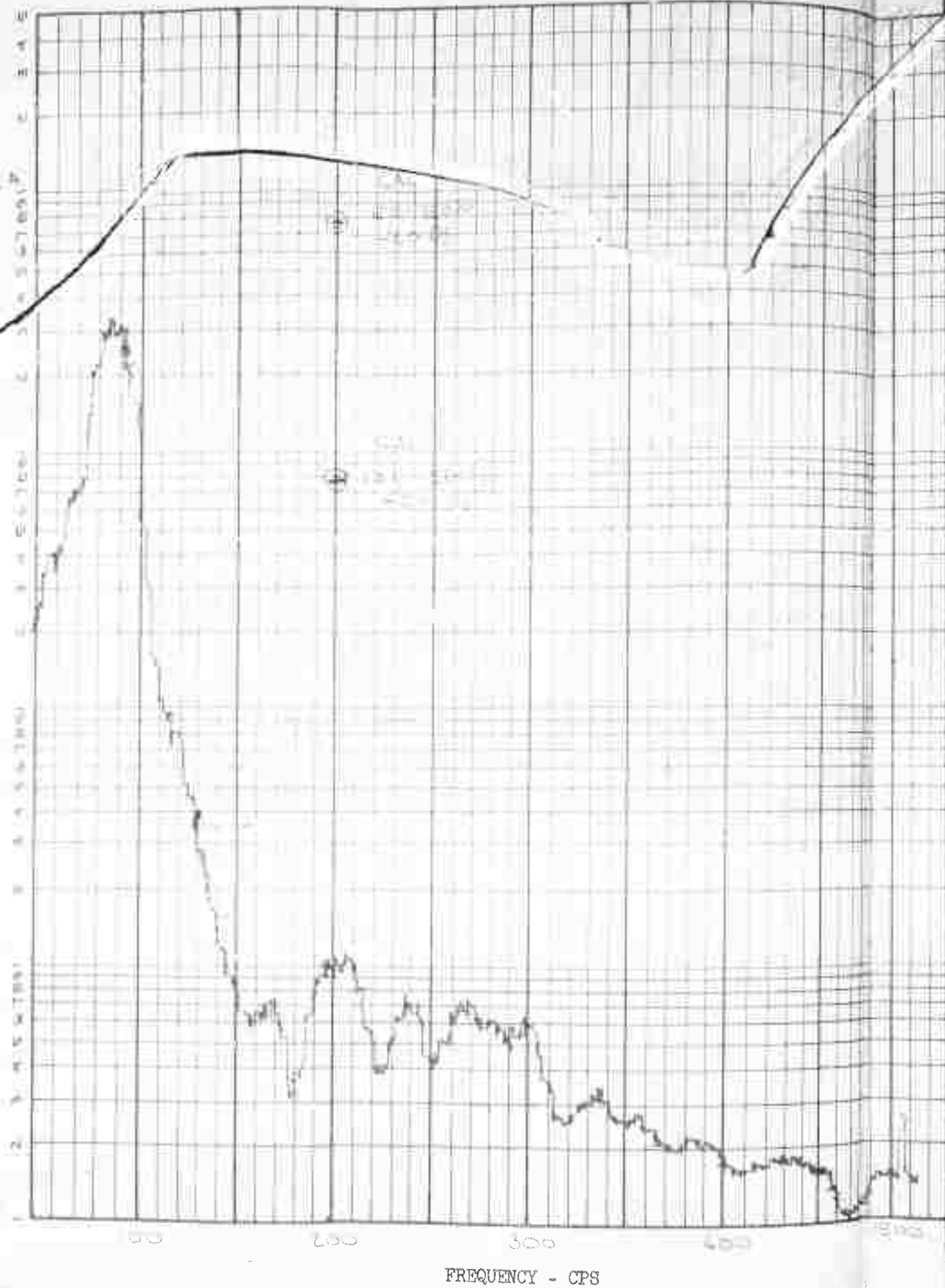
Bandwidth

cycles from 50 to 1200 cps
 cycles from 120 to 5000 cps
 cycles from to cps

Time 1.0 Sec.
 Anal. Rate 100 cps/sec.
 Loop Length 5 Sec.

CALC
 CHECK
 ATT
 ATT

POWER SPECTRAL DENSITY - (16.3)²/cps



1

ANALYSIS VARIABLES

Bandwidth

5 cycles from 50 to 500 cps
 _____ cycles from _____ to _____ cps
 _____ cycles from _____ to _____ cps

15 Sec.

Anal. Rate 333 cps/sec.

Loop Length 15 Sec.

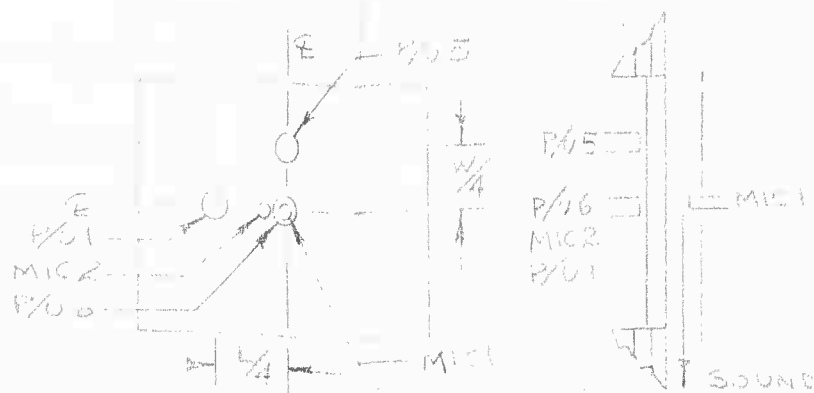
CALC	<u>1000</u>
CHECK	<u>UBT</u>
APR	
APR	

DATA IDENTIFICATION

Test Title O.S. PANEL ATTACHMENT - TYPE I		
EWA No. 5-593	Panel or Specimen No. 1497	
Tape No. 58	Tape Channel 4	Displacement Pickup # 5
Elapsed Test Time 60.5 MIN		P/U RMS Level at Sonic Lab. V _L = — Volts

CALIBRATION

Tape No. 58	Tape Channel 6	Data Tape RMS Volt V _R = 16
Calibration Voltage V _a = .5 V _{rms} into Line Amp.; V _c = .5 V _{rms} on Tape @ 100 cps		
Line Amplifier Settings For Calibration G _c = 500; for Data G _d = 100		
Lab. Gain LG = 1	Tape Monitor Gain TMG = $\frac{G_d}{G_c} = .2$	
Displacement Pickup Sensitivity S = .0335 in./Volt		
Equivalent of Calibration - in. D _c = V _a * S = .0167		
Equivalent of Calibration for PSD Plots $\left(\frac{D_c}{(TMG)(LG)} \right)^2 = \left(\frac{.0167}{(.2)(1)} \right)^2 = 7.0 \times 10^{-3} \text{ in.}^2/\text{cps}$		
Analyzer Attenuator Setting -20db to 50-130db	Log Converter Setting db	
Calibration Plotted at 7.22 (10 ⁻⁵) 50-130db 7.22 (10 ⁻⁵) 130-150db in. ² /cps		
Overall Deflection Level of Data $\text{RMS Defl. Level} = \frac{(D_c)(V_R)}{(TMG)(LG)(V_c)} = \frac{(.0167)(16)}{(.2)(1)(.5)} = .265 \text{ in.}$		

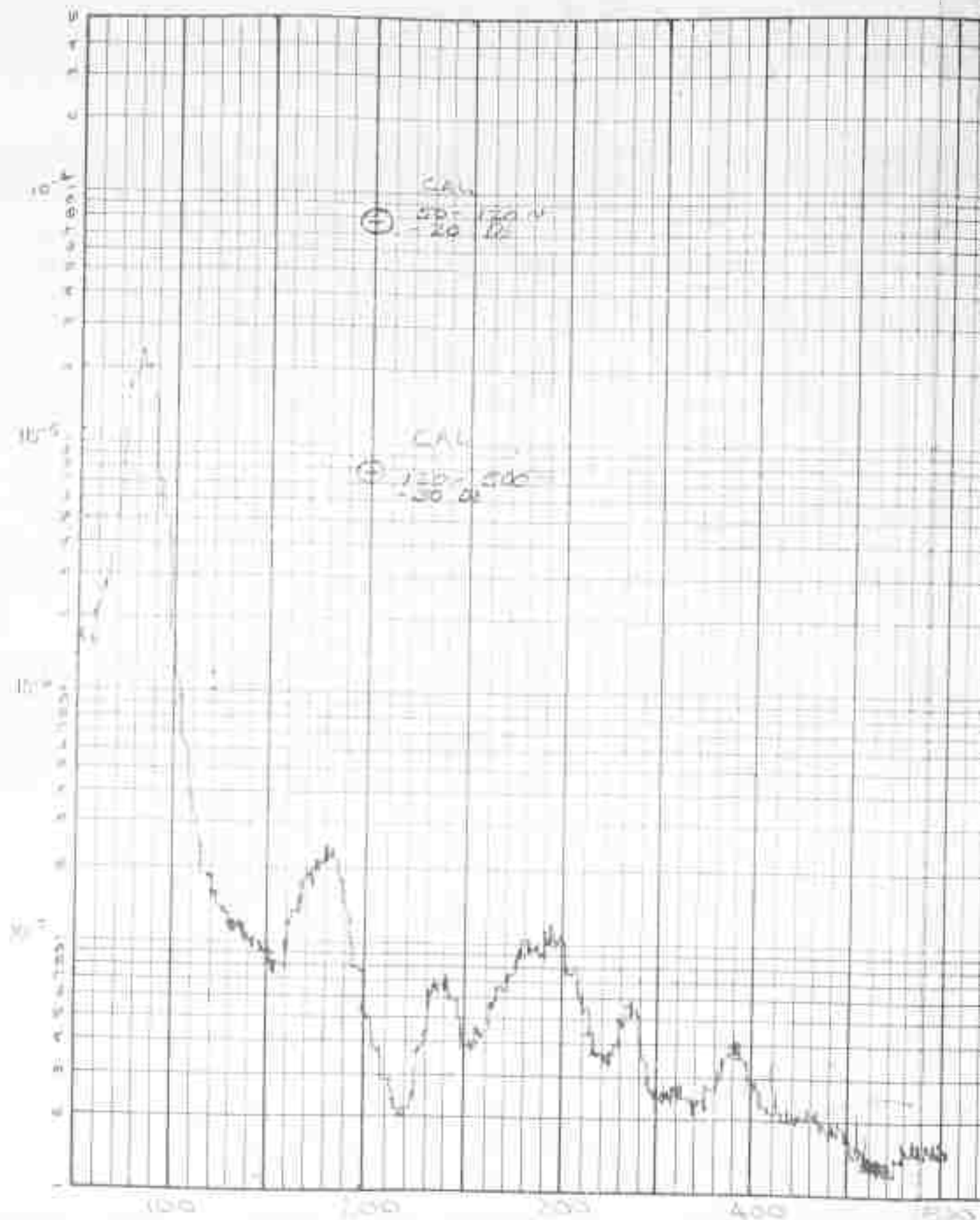


CALC	6/26	REVISED	DATE	POWER SPECTRAL DENSITY ANALYSIS OF DISPLACEMENT PICKUP 0.5 MIN TEST 162.5db P/U #5 PANEL 1497 PHASE 'D' BOEING AIRPLANE COMPANY SEATTLE 28, WASHINGTON	VOL I
CHECK	2BT	6/27/61			0280084
APR					PAGE
APR					FIG 201

2-5353-7-9

2

POWER SPECTRAL DENSITY - (In.)²/cps



FREQUENCY - CPS

ANALYSIS VARIABLES

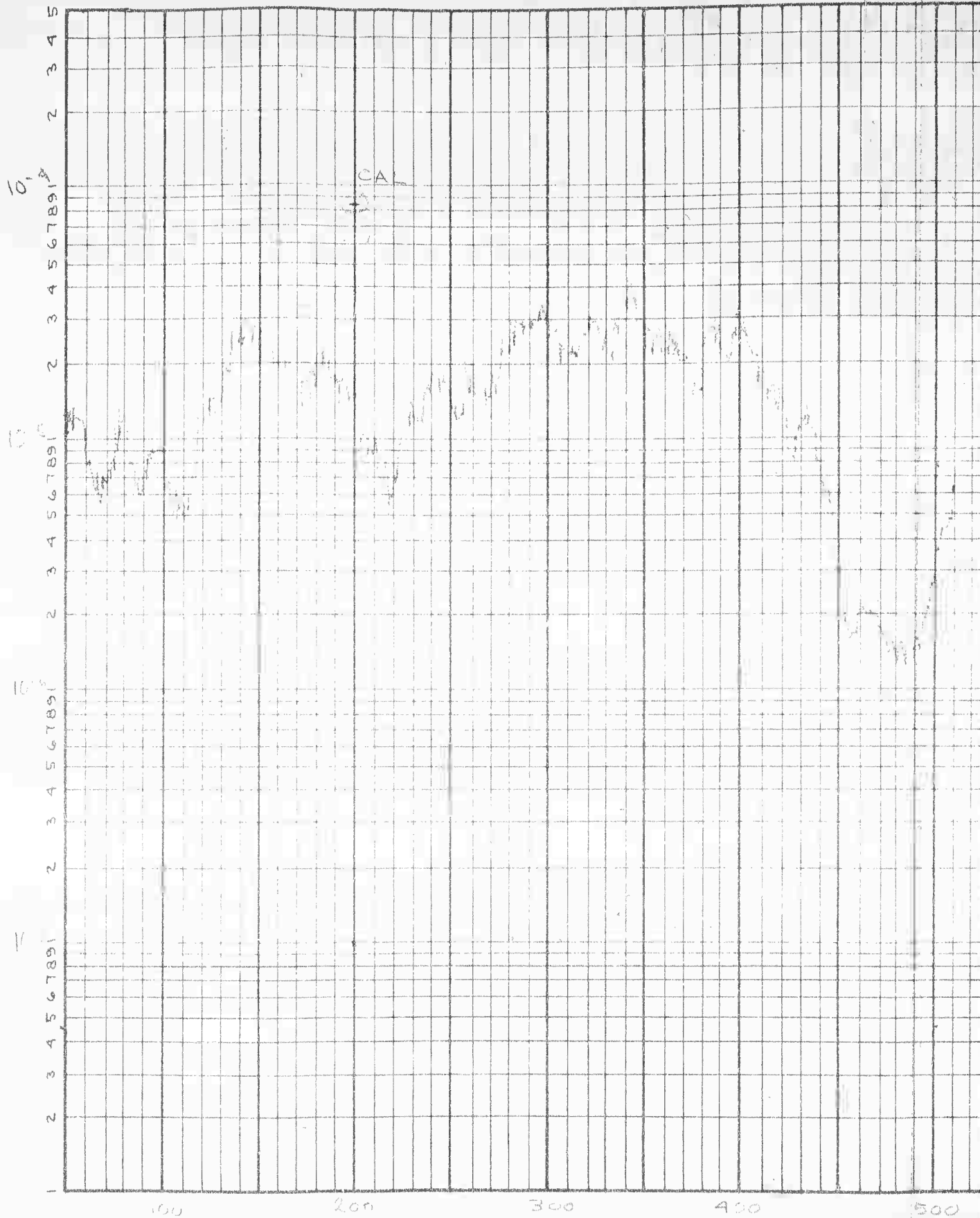
Bandwidth

5 cycles from 50 to 500 cps
 _____ cycles from _____ to _____ cps
 _____ cycles from _____ to _____ cps

T_c 15 Sec.
 Anal. Rate .333 cps/sec.
 Loop Length 15 Sec.

CALC	<u>120</u>
CHECK	<u>CBT</u>
APR.	
APR	

POWER SPECTRAL DENSITY - (psi)²/cps



FREQUENCY - CPS

ANALYSIS VARIABLES

Bandwidth

5 cycles from 50 to 500 cps
 — cycles from — to — cps
 — cycles from — to — cps

T_c 4 Sec.
 Anal. Rate 1.25 cps/Sec.
 Loop Length 4 Sec.

CALC 10/2/71
 CHECK 30A
 APR.
 APR.

DATA IDENTIFICATION

Test Title PANEL ATTACH, TYPE I PRELIM		
EWA No. 5-543	Panel or Specimen No. 1498	
Tape No. 27	Tape Channel 1	Mic. No. 1
Elapsed Test Time +5		Mic. RMS Level at Sonic Lab. VL = .410 Volts

CALIBRATION

Tape No. 27	Tape Channel 6	Data Tape RMS Volt VR = .196
Calibration Voltage Va = 5 Vrms into Line Amp.; Vc = .52 Vrms on Tape @ 200 cps		
Line Amplifier Settings For Calibration Gc = .500; for Data Ga = .250		
Lab. Gain LG = 1.0	Tape Monitor Gain TMG = $\frac{G_d}{G_c} = .5$	
Microphone Sensitivity S = .200 psi/Volt or 1 Volt rms = 50 db SPL		
Equivalent of Calibration - psi Pc = Va · S = .145		
Equivalent of Calibration for PSD Plots $\left(\frac{P_c}{(TMG)(LG)}\right)^2 = \frac{.145^2}{(.5)(1)} = 8.91 \times 10^{-3}$ psi ² /cps		
Analyzer Attenuator Setting -30 db	Log Converter Setting 0 db	
Calibration Plotted at 101 (10 ³) psi ² /cps		
Overall Pressure Level Data RMS pressure level = $\frac{(P_c)(V_R)}{(TMG)(LG)(V_c)}$ $= \frac{(.145)(.196)}{(.5)(1)(.52)} = .110$ psi		Equiv. to 51.6 db SPL

SPECTRUM LEVEL - DECIBELS (Re 0.0002 Microbar)

130

120

110

100

500

M.E.

P.O.

P/15-1

P/16-1

M/2

1701

M/1

Y SOUND

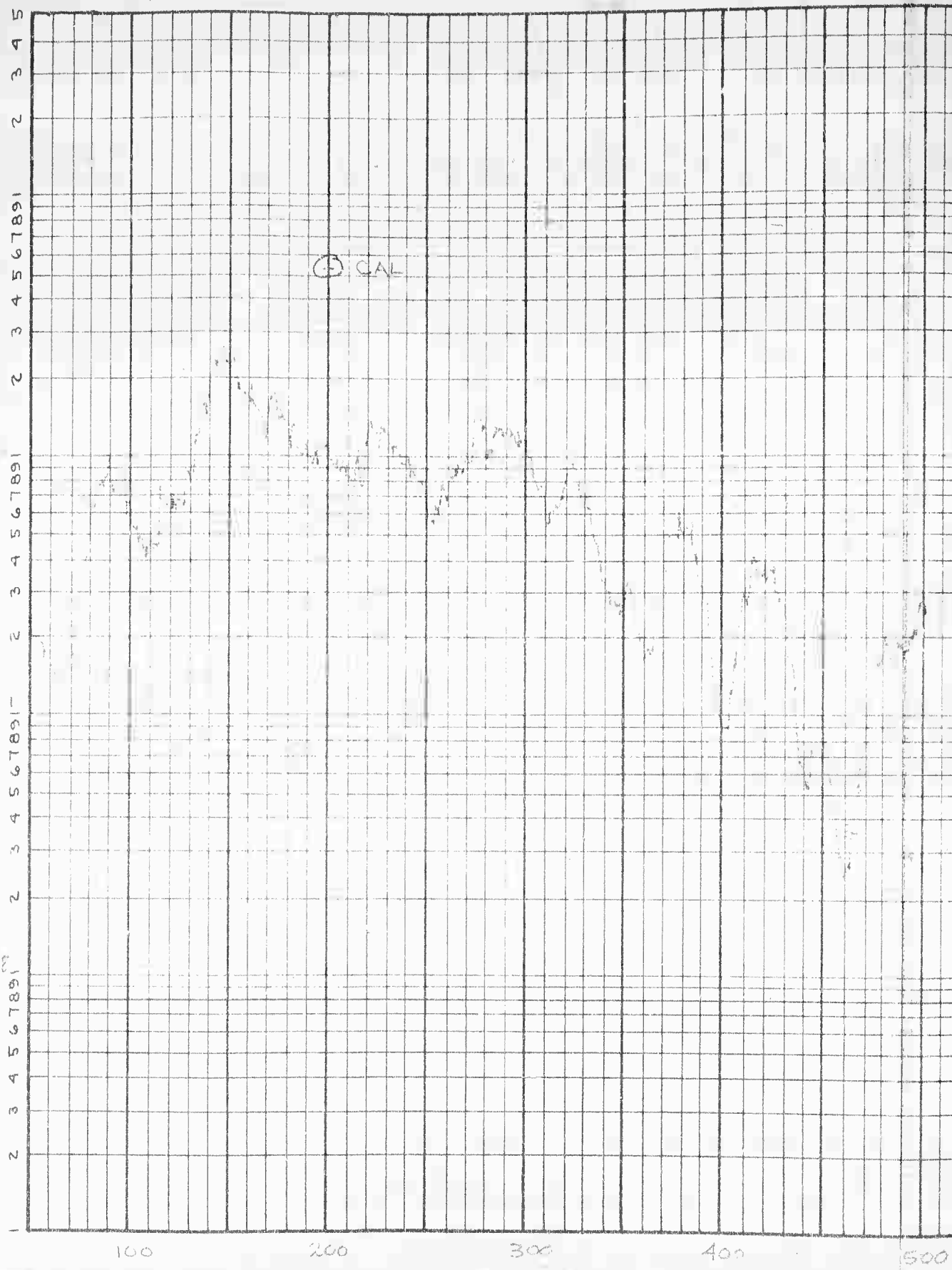
2

CALC	REVISD	DATE	POWER SPECTRAL DENSITY ANALYSIS OF MICROPHONE OUTPUT 5 MIN TEST MIC I PANEL 1498 PHASE A BOEING AIRPLANE COMPANY SEATTLE 24, WASHINGTON	VOL I
CHECK				D25X84
APR				PAGE
APR				FIG 203

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1

16



ANALYSIS VARIABLES

Bandwidth

cycles from 50 to 500 cps
cycles from to cps
cycles from to cps

Tc 4 Sec.
Anal. Rate 1.25 cps/Sec.
Loop Length 4 Sec.

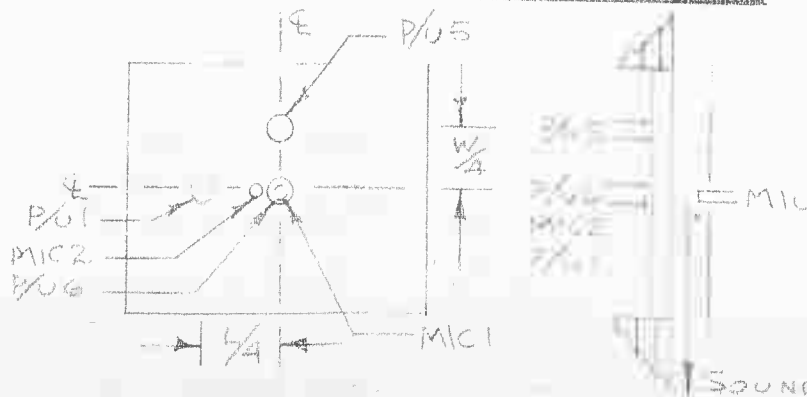
CALC
CHECK
APR.
APR.

DATA IDENTIFICATION

Test Title PANEL ATTACH TYPE I PRELIM.		
EWA No. S-593	Panel or Specimen No. 1498	
Tape No. 27	Tape Channel 2	Mic. No. 2
Elapsed Test Time 15		Mic. RMS Level at Sonic Lab. V _L = 5070 Volts

CALIBRATION

Tape No. 27	Tape Channel 6	Data Tape RMS Volt V _R = .150
Calibration Voltage V _a = .5 V _{rms} into Line Amp.; V _c = .5 V _{rms} on Tape @ 200cps		
Line Amplifier Settings For Calibration G _c = .500 ; for Data G _d = 1.000		
Lab. Gain LG = 1.0	Tape Monitor Gain TMG = $\frac{G_d}{G_c} = 2.0$	
Microphone Sensitivity S = .230 psi/Volt or 1 Volt rms = 160 db SPL		
Equivalent of Calibration - psi P _c = V _a · S = .145		
Equivalent of Calibration for PSD Plots $\left(\frac{P_c}{(TMG)(LG)} \right)^2 = \frac{.145^2}{(2)(1)} = 5.25(10^{-3})$ psi ² /cps		
Analyzer Attenuator Setting -20 db	Log Converter Setting 0 db	
Calibration Plotted at 5.25 (10 ⁻³) psi ² /cps		
Overall Pressure Level Data (P _c)(V _R) RMS pressure level = $\frac{(P_c)(V_R)}{(TMG)(LG)(V_c)}$ $= \frac{(.145)(.150)}{(2)(1)(.52)} = .025$ psi		Equiv. to 139 db SPL



SPECTRUM LEVEL - DECIBELS (Re 0.0002 Microbar)

120

110

100

90

500

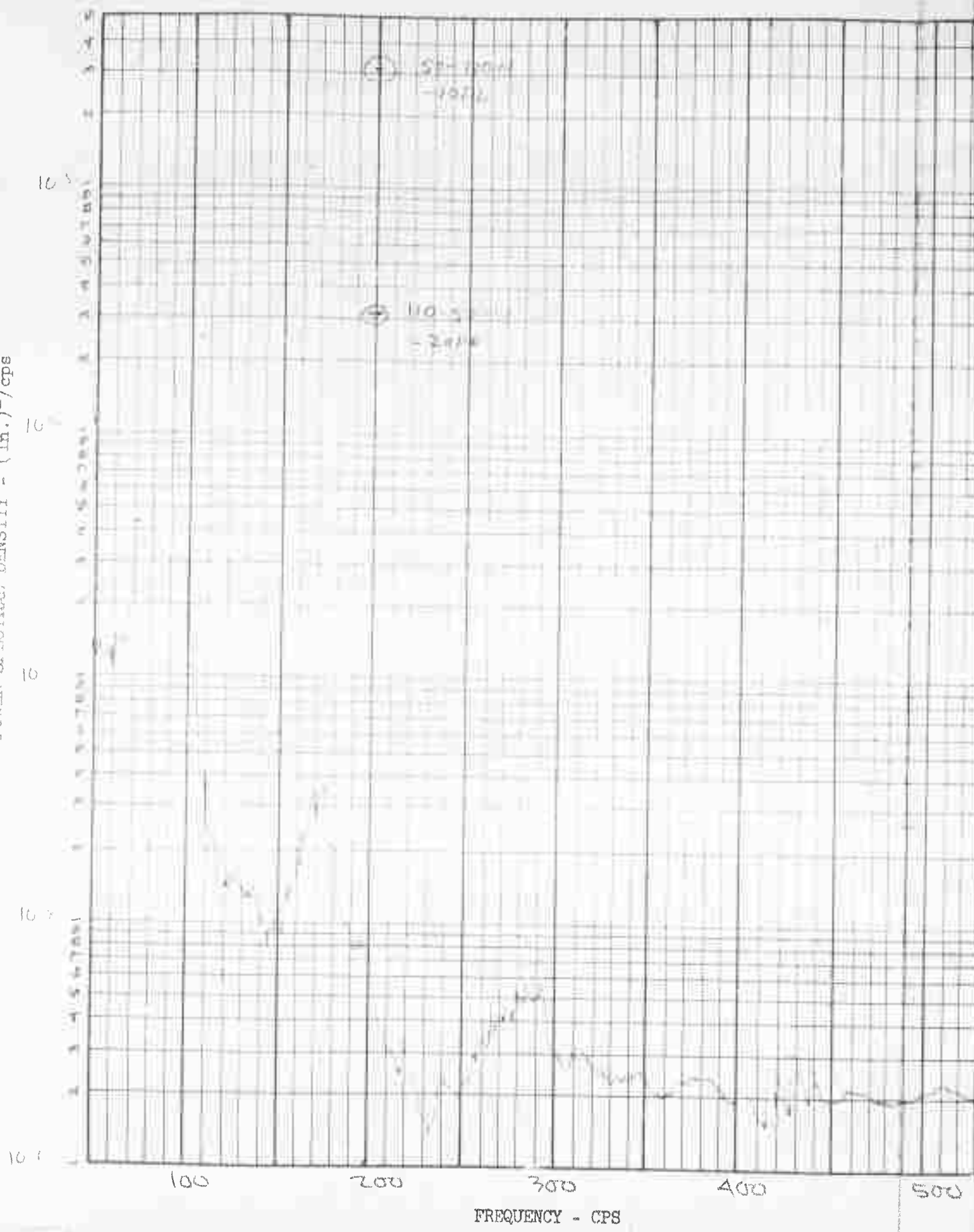
SOUND

2

CALC	30A	4/2/61	REVISED	DATE	POWER SPECTRAL DENSITY ANALYSIS OF MICROPHONE OUTPUT 5 MIN TEST MIC 2 - PANEL 1498 - PHASE A BOEING AIRPLANE COMPANY SEATTLE 24, WASHINGTON	VOL I PAGE 304
CHECK						
APR						
APR						

2-5353-7-8

POWER SPECTRAL DENSITY - (In.)²/cps



1

ANALYSIS VARIABLES

Bandwidth

5 cycles from 50 to 500 cps
cycles from to cps
cycles from to cps

T_c 4 Sec.
Anal. Rate 1.25 cps/sec.
Loop Length 4 Sec.

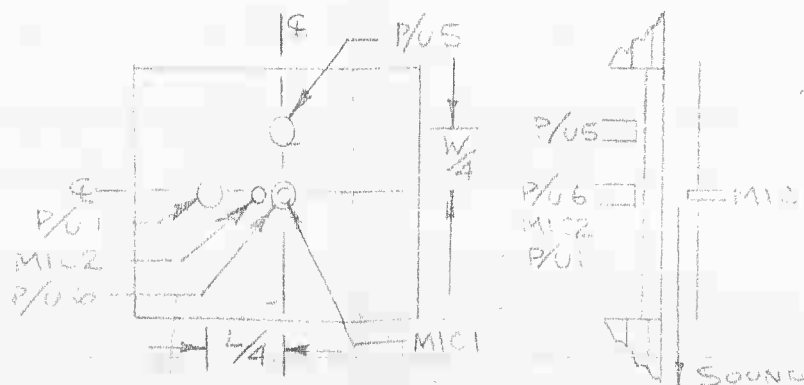
CALC	
CHECK	<u>30A</u>
APR.	
APR	

DATA IDENTIFICATION

Test Title PANEL ATTACH TYPE I PRELIM		
EWA No. 5593		Panel or Specimen No. 1A98
Tape No. 27	Tape Channel 3	Displacement Pickup # 1
Elapsed Test Time +5 MIN.		P/U RMS Level at Sonic Lab. V_L = .250 Volts

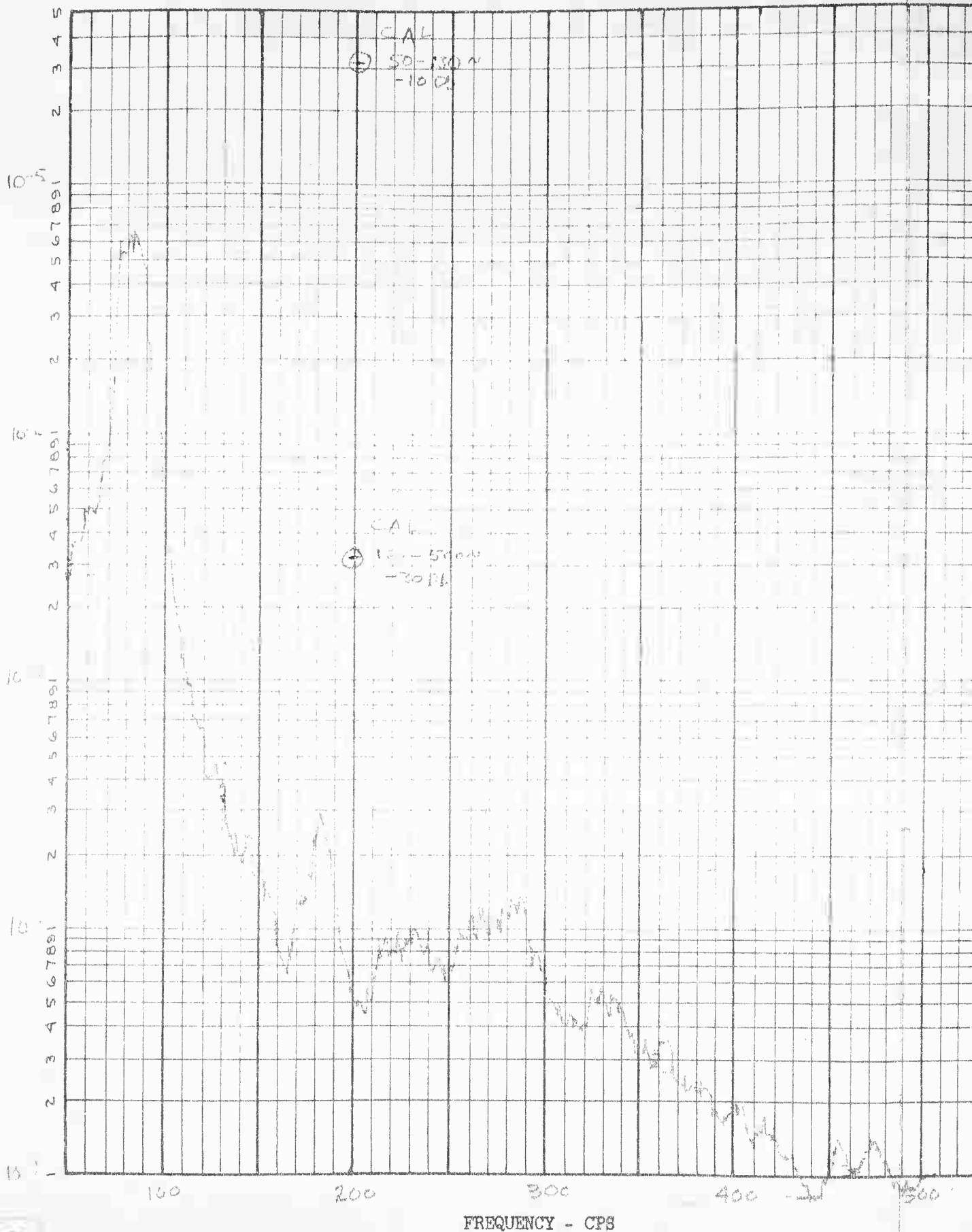
CALIBRATION

Tape No. 27	Tape Channel 6	Data Tape RMS Volt V_R = .245
Calibration Voltage V_a = 5 V_{rms} into Line Amp.; V_c = .52 V_{rms} on Tape @ 200 cps		
Line Amplifier Settings For Calibration G_c = .500 ; for Data G_d = .500		
Lab. Gain LG = 1.0	Tape Monitor Gain TMG = $\frac{G_d}{G_c} = 1.0$	
Displacement Pickup Sensitivity S = .0354 in./Volt		
Equivalent of Calibration - in. D_c = V_a · S = .0177		
Equivalent of Calibration for PSD Plots $\left(\frac{D_c}{(TMG)(LG)}\right)^2 = \left[\frac{.0177}{(1)(1)}\right]^2 = 3.13 \times 10^{-4}$ in.²/cps		
Analyzer Attenuator Setting -10 50-110V db	Log Converter Setting 0 db	
Calibration Plotted at 3.13 x 10⁻⁵ 50-110V in.²/cps		
Overall Deflection Level of Data RMS Defl. Level = $\frac{(D_c)(V_R)}{(TMG)(LG)(V_c)} = \frac{(.0177)(.245)}{(1)(1)(.52)} = .0083$ in.		



CALC	REVISD	DATE	POWER SPECTRAL DENSITY ANALYSIS	VOL. I
CHECK			OF DISPLACEMENT PICKUP	
APR			5 MIN TEST	
APR			P/U 1 PANEL 1A98 PHASE A	DE 8-100
			BOEING AIRPLANE COMPANY	PAGE
			SEATTLE 24, WASHINGTON	FIG 205

POWER SPECTRAL DENSITY - (In.)²/cps



ANALYSIS VARIABLES

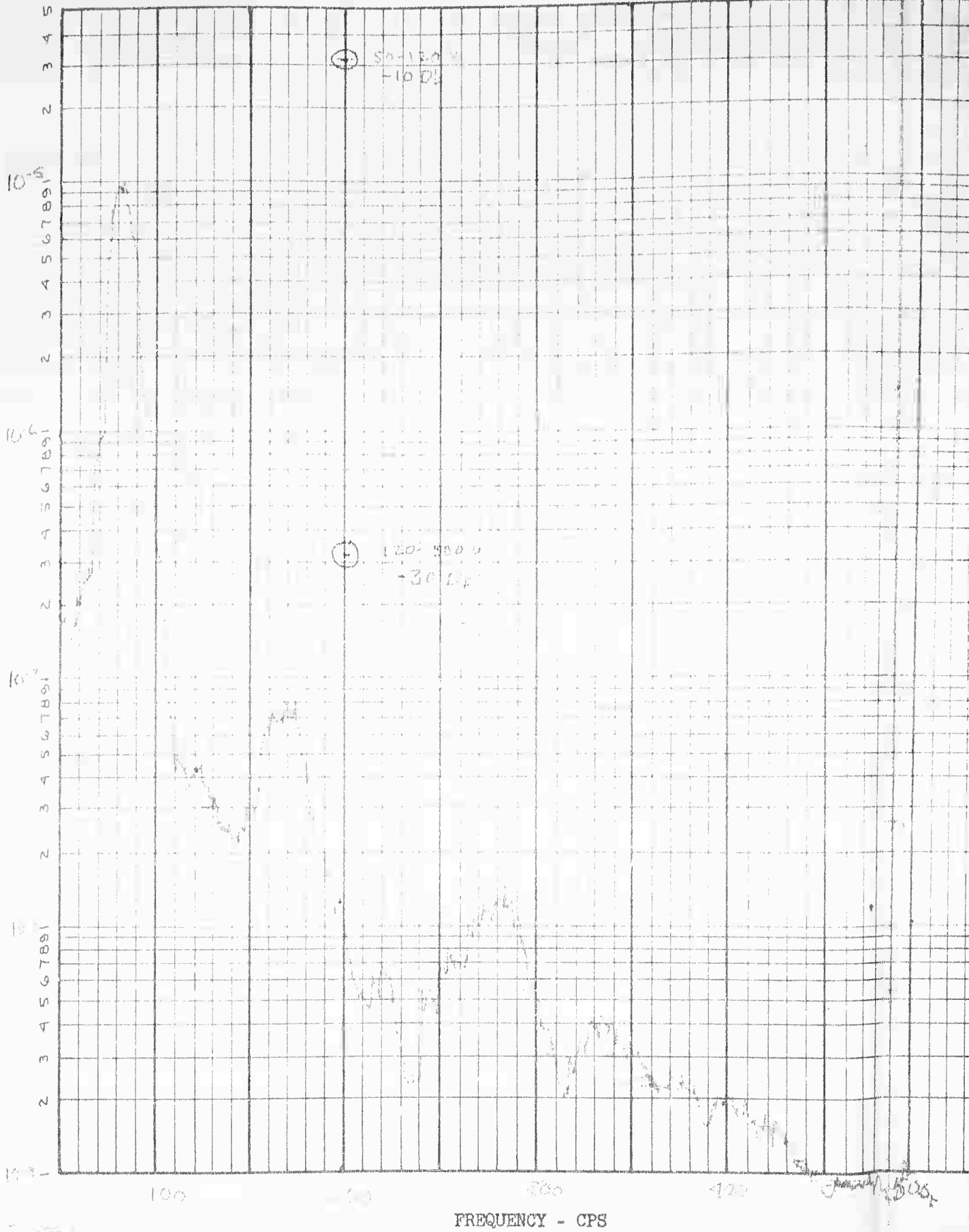
Bandwidth

5 cycles from 50 to 500 cps
 _____ cycles from _____ to _____ cps
 _____ cycles from _____ to _____ cps

T_c 4 Sec.
 Anal. Rate 125 cps/sec.
 Loop Length 4 Sec.

CALC	<u>MEM</u>
CHECK	<u>SOA</u>
APR.	
APR.	

POWER SPECTRAL DENSITY - (In.)²/cps



1

ANALYSIS VARIABLES

Bandwidth

5 cycles from 50 to 500 cps
 cycles from to cps
 cycles from to cps

T_c 4 Sec.
 Anal. Rate 1.25 cps/sec.
 Loop Length 4 Sec.

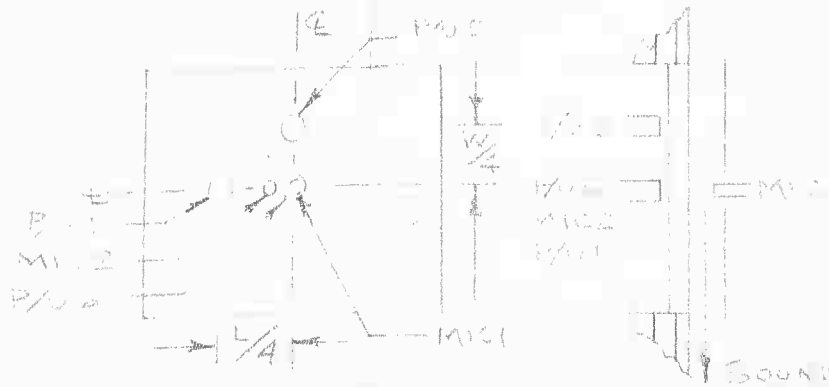
CALC MEM
 CHECK SDA
 APR
 APR

DATA IDENTIFICATION

Test Title PANEL ATTACH TYPE I PRELIM		
EWA No. 500	Panel or Specimen No. 1499	
Tape No. 27	Tape Channel 5	Displacement Pickup # 6
Elapsed Test Time +5		P/U RMS Level at Sonic Lab. V_L = .360 Volts

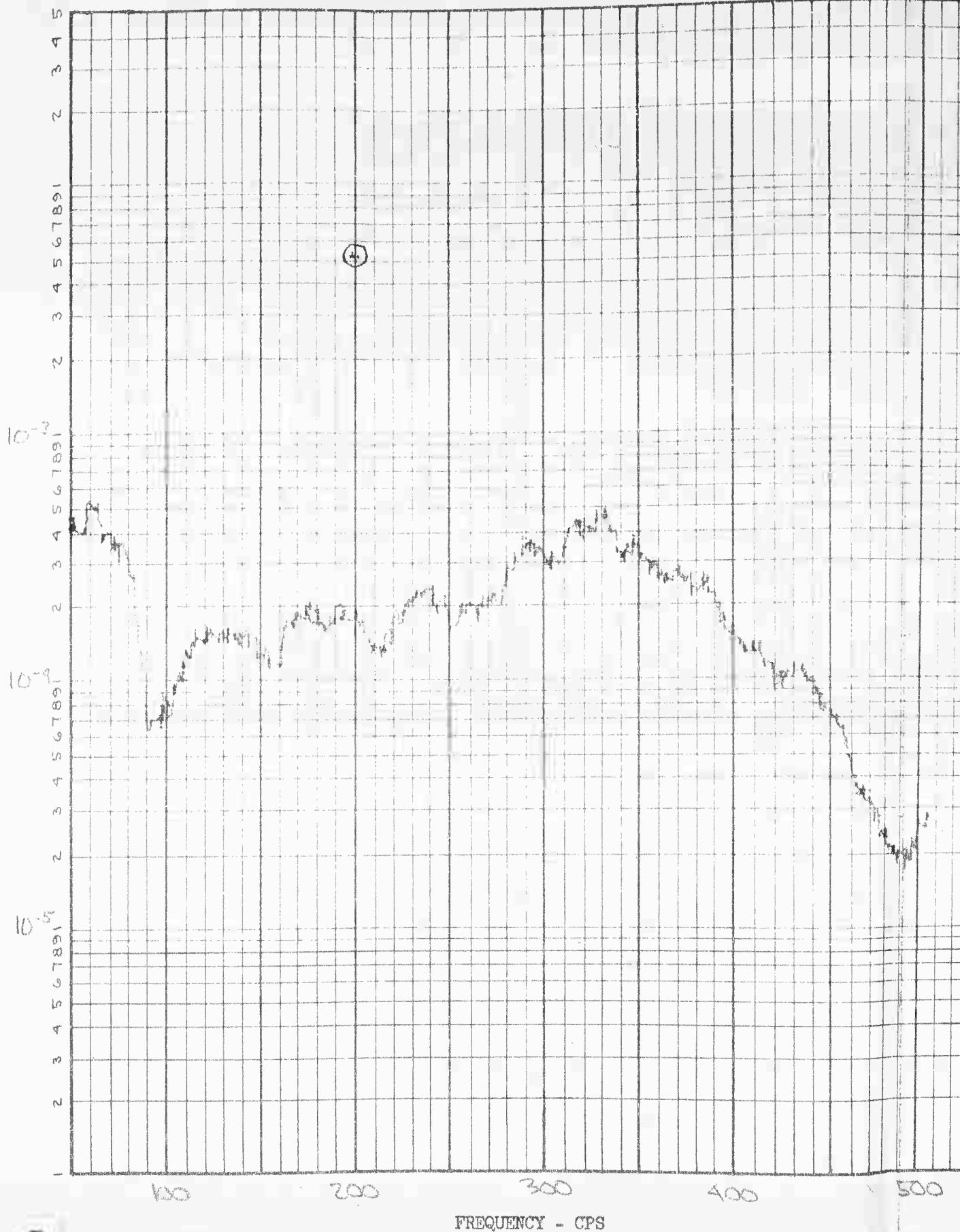
CALIBRATION

Tape No. 27	Tape Channel 6	Data Tape RMS Volt V_R = .355
Calibration Voltage V_a = .5 V_{rms} into Line Amp.; V_c = .52 V_{rms} on Tape @ 200 cps		
Line Amplifier Settings For Calibration G_c = .500 ; for Data G_d = .500		
Lab. Gain LG = 1.0	Tape Monitor Gain TMG = $\frac{G_d}{G_c} = 1.0$	
Displacement Pickup Sensitivity S = .0054 in./Volt		
Equivalent of Calibration - in. D_c = V_a · S = .0027		
Equivalent of Calibration for PSD Plots $\left(\frac{D_c}{(TMG)(LG)}\right)^2 = \left[\frac{.0027}{(1)(1)}\right]^2 = 3.13(10^{-6})$ in.²/cps		
Analyzer Attenuator Setting -10 db	Log Converter Setting 0 db	
Calibration Plotted at 3.13(10⁻⁶) in.²/cps		
Overall Deflection Level of Data RMS Defl. Level = $\frac{(D_c)(V_R)}{(TMG)(LG)(V_c)} = \frac{(.0027)(.355)}{(1)(1)(.52)} = .0012$ in.		



CALC	MEM	6-26	REVISED	DATE	POWER SPECTRAL DENSITY ANALYSIS OF DISPLACEMENT PICKUP 5 MIN TEST P/U 6 PANEL 1499 PHASE A BOEING AIRPLANE COMPANY SEATTLE 24, WASHINGTON	VOL I
CHECK	DOA	6/20/61				02-80084
APR						PAGE
APR						FIG 207

POWER SPECTRAL DENSITY - (psi)²/cps



ANALYSIS VARIABLES

Bandwidth

5 cycles from 50 to 500 cps
 — cycles from — to — cps
 — cycles from — to — cps

T_c 15 Sec.
 Anal. Rate 33 cps/Sec.
 Loop Length 15 Sec.

CALC 309
 CHECK
 APR
 APR

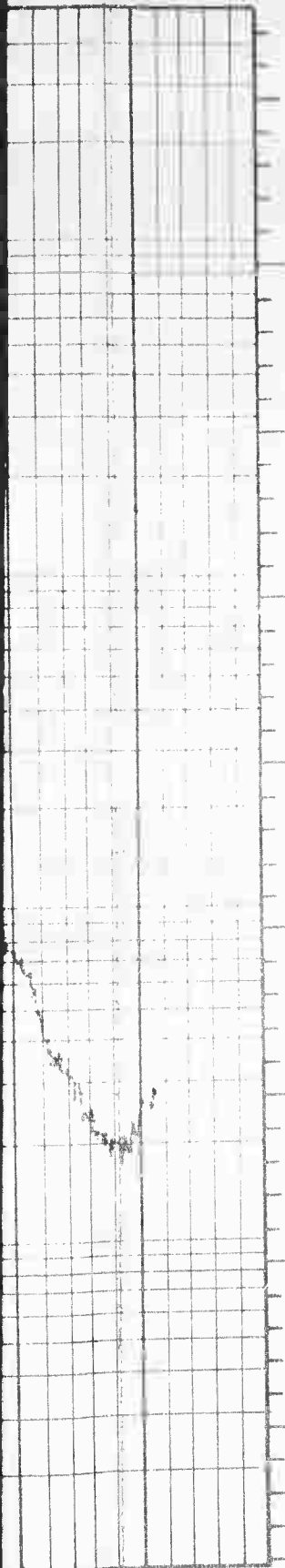
DATA IDENTIFICATION

Test Title PANEL ATTACH TYPE I ~ PRELIM.		
EWA No. 5-593	Panel or Specimen No. 1498	
Tape No. 61	Tape Channel 1	Mic. No. 1
Elapsed Test Time + 605 MIN.		Mic. RMS Level at Sonic Lab. VL = 1.25 Volts

CALIBRATION

Tape No. 61	Tape Channel 6	Data Tape RMS Volt VR = .225
Calibration Voltage VA = .5 VRMS into Line Amp.; VC = .48 VRMS on Tape @ 200 cps		
Line Amplifier Settings For Calibration GC = .500; for Data GD = .100		
Lab. Gain LG = 10	Tape Monitor Gain TMG = $\frac{GD}{GC} = .2$	
Microphone Sensitivity S = .290 psi/Volt or 1 Volt rms = 160 db SPL		
Equivalent of Calibration - psi TC = VA · S = .145		
Equivalent of Calibration for PSD Plots $\left(\frac{PC}{(TMG)(LG)}\right)^2 = \left(\frac{.145}{(.2)(10)}\right)^2 = 5.2 \times 10^{-1}$ psi ² /cps		
Analyzer Attenuator Setting -20 db	Log Converter Setting 0 db	
Calibration Plotted at 5.2 (10 ⁻¹) psi ² /cps		
Overall Pressure Level Data (PC)(VR) RMS pressure level = $\frac{(TMG)(LG)(VC)}{(2)(.1)(.48)} = .340$ psi		Equiv. to 161.5 db SPL

SPECTRUM LEVEL - DECIBELS (Rc 0.0002 Microbar)



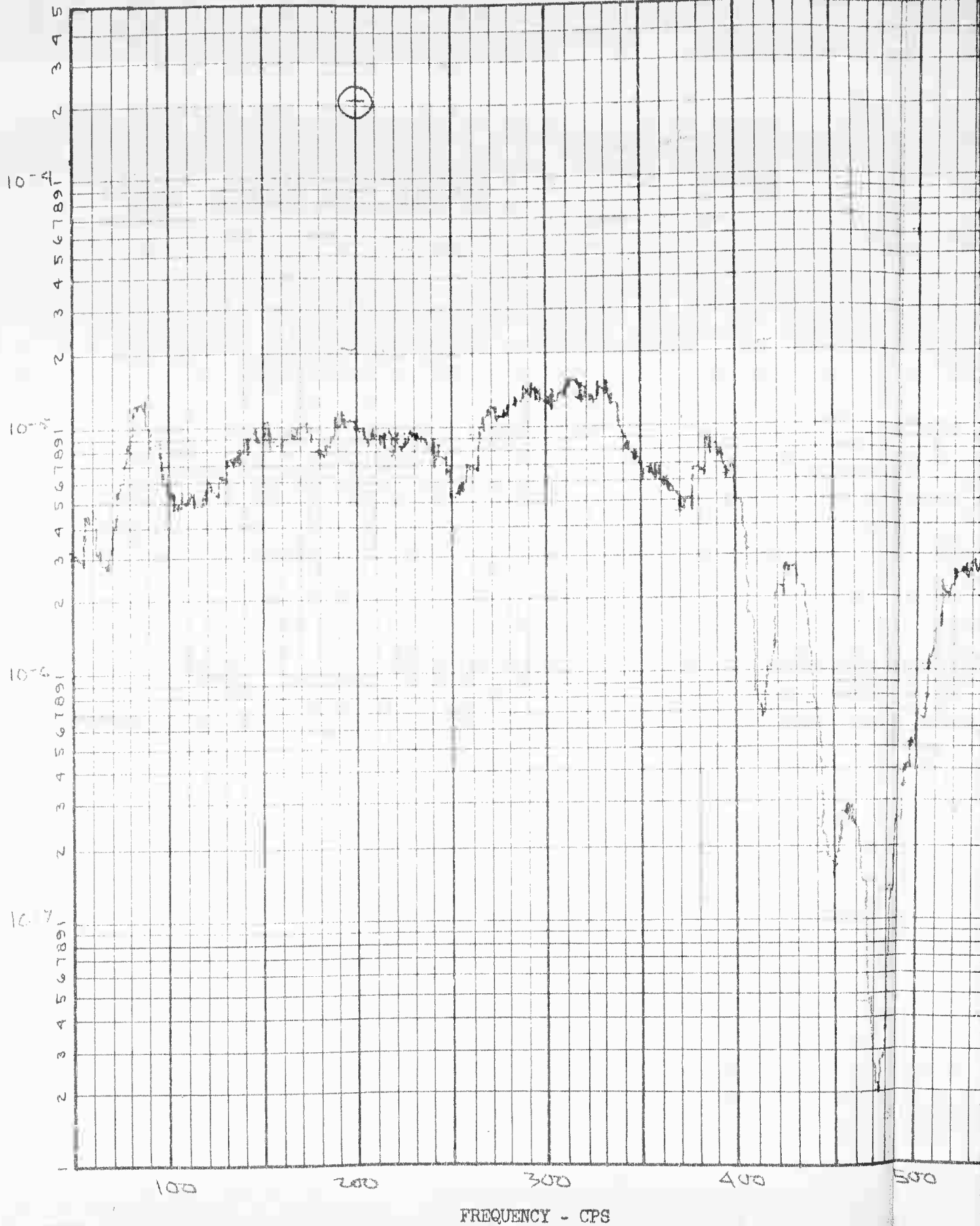
500

CALC	50A	4/27/61	REVISED	DATE	POWER SPECTRAL DENSITY ANALYSIS	VOL I
CHECK					OF MICROPHONE OUTPUT	
APR.					MIC #1	D23004
APR.					PANEL 1498 PHASE D	PAGE
					BOEING AIRPLANE COMPANY	FIG 208
					SEATTLE 24, WASHINGTON	

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2

POWER SPECTRAL DENSITY - (psi)²/cps



ANALYSIS VARIABLES

Bandwidth

5 cycles from 50 to 500 cps
 cycles from to cps
 cycles from to cps

T_c 15 Sec.
 Anal. Rate .33 cps/Sec.
 Loop Length 15 Sec.

CALC 30A
 CHECK
 APR.
 APR.

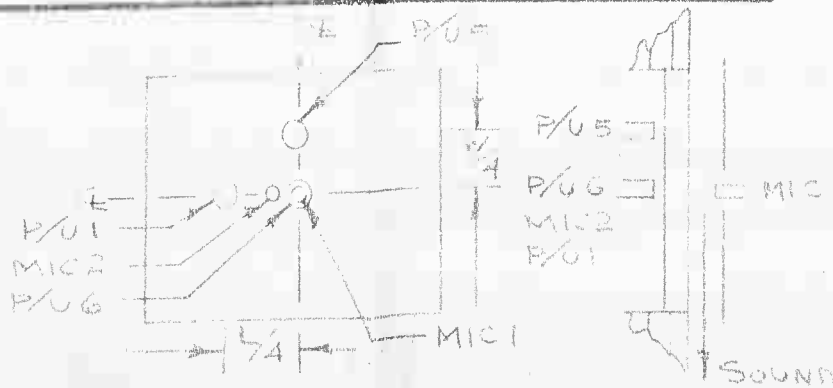
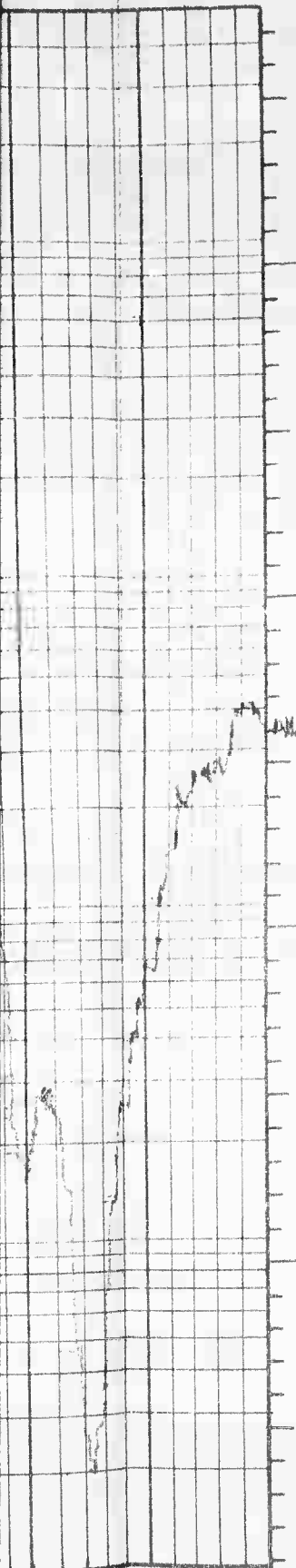
DATA IDENTIFICATION

Test Title PAUEL ATTACH TYPE I - PRELIM		
EWA No. 5-593	Panel or Specimen No. 1498	
Tape No. 61	Tape Channel 2	Mic. No. 2
Elapsed Test Time + 60.5 MIN.		Mic. RMS Level at Sonic Lab. V_L = .250 Volts

CALIBRATION

Tape No. 61	Tape Channel 6	Data Tape RMS Volt V_R = .230
Calibration Voltage V_a = .5 V_{rms} into Line Amp.; V_c = .48 V_{rms} on Tape @ 200cps		
Line Amplifier Settings For Calibration G_c = .500 ; for Data G_d = .500		
Lab. Gain LG = 1.0	Tape Monitor Gain TMG = $\frac{G_d}{G_c} = 1.0$	
Microphone Sensitivity S = 290 psi/Volt or 1 Volt rms = 160 db SPL		
Equivalent of Calibration - psi P_c = V_a · S = .145		
Equivalent of Calibration for PSD Plots $\left(\frac{P_c}{(TMG)(LG)}\right)^2 = \left(\frac{.145}{(1)(1)}\right)^2 = 2.1 \times 10^{-2} \text{ psi}^2/\text{cps}$		
Analyzer Attenuator Setting -20 db	Log Converter Setting 0 db	
Calibration Plotted at 2.1 (10⁻⁹)		psi²/cps
Overall Pressure Level Data (P_c)(V_R)		Equiv. to 147.6 db SPL
RMS pressure level = $\frac{(P_c)(V_R)}{(TMG)(LG)(V_c)}$ = $\frac{(.145)(.230)}{(1.0)(1)(.48)} = .070$		psi

SPECTRUM LEVEL - DECIBELS (REF 0.0002 Microbar)

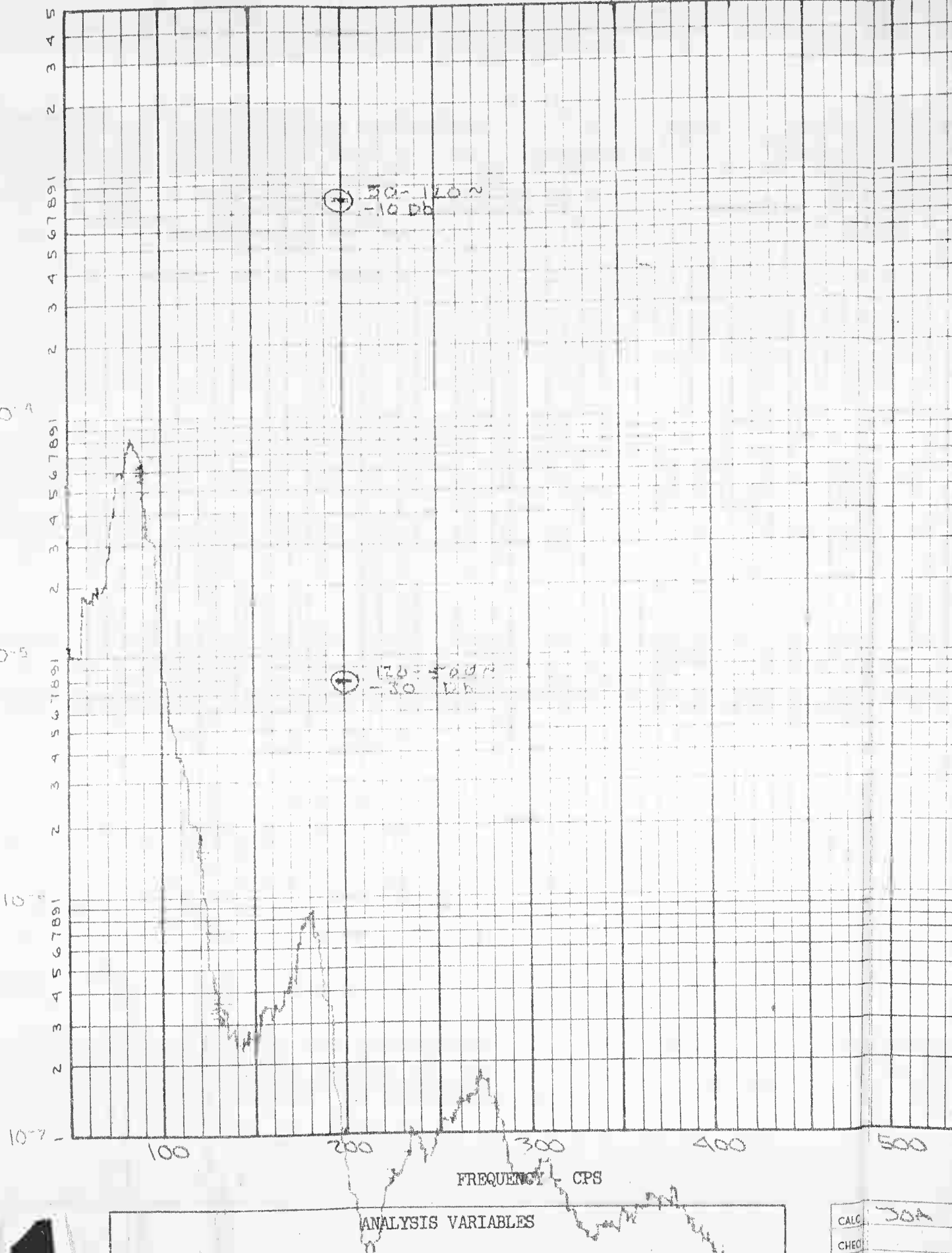


CALC	30A	4/2/61	REVISED	DATE	POWER SPECTRAL DENSITY ANALYSIS	VOL I
CHECK					OF MICROPHONE OUTPUT	
APR.					0.5 MIN TEST 162.5 db	
APR.					MIC #2 PAUEL 1498 PHASE D	D280084
					BOEING AIRPLANE COMPANY	PAGE
					SEATTLE 24, WASHINGTON	FIG 200

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2

POWER SPECTRAL DENSITY - $(\text{in.})^2/\text{cps}$



ANALYSIS VARIABLES

Bandwidth

5 cycles from 50 to 500 cps
 _____ cycles from _____ to _____ cps
 _____ cycles from _____ to _____ cps

T_c 15 Sec.

Anal. Rate 33 cps/sec.

Loop Length 15 Sec.

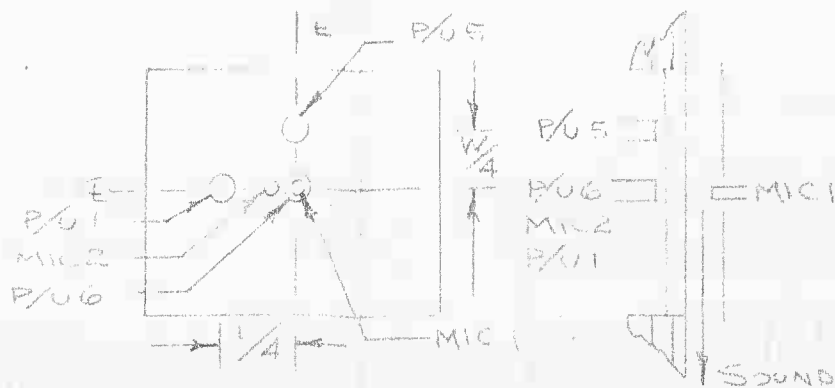
CALC 30A
 CHECK
 APR
 APR

DATA IDENTIFICATION

Test Title PANEL ATTACH. TYPE I - PRELIM.		
EWA No. 5-593	Panel or Specimen No. 1498	
Tape No. 61	Tape Channel 3	Displacement Pickup 1
Elapsed Test Time + 60.5 MIN		P/U RMS Level at Sonic Lab. VL = .870 Volts

CALIBRATION

Tape No. 61	Tape Channel 6	Data Tape RMS Volt VR = .170
Calibration Voltage VA = .5 VRMS into Line Amp.; VC = .48 VRMS on Tape @ 200 cps		
Line Amplifier Settings For Calibration GC = 500; for Data GD = 100		
Lab. Gain LG = \	Tape Monitor Gain TMC = $\frac{GD}{GC} = .2$	
Displacement Pickup Sensitivity S = .0354 in./Volt		
Equivalent of Calibration - in. DC = VA * S = .0177		
Equivalent of Calibration for PSD Plots $\left(\frac{DC}{(TMC)(LG)}\right)^2 = \left(\frac{.0177}{(.2)(1)}\right)^2 = 7.8 \times 10^{-3} \text{ in.}^2/\text{cps}$		
Analyzer Attenuator Setting -10 -30		Log Converter Setting 50-120 dB 120-300 dB 0 dB
Calibration Plotted at 7.8 (10^-3) in.²/cps		
Overall Deflection Level of Data RMS Defl. Level = $\frac{(DC)(VR)}{(TMC)(LG)(VC)} = \frac{(.0177)(.170)}{(.2)(1)(.48)} = .0314 \text{ in.}$		

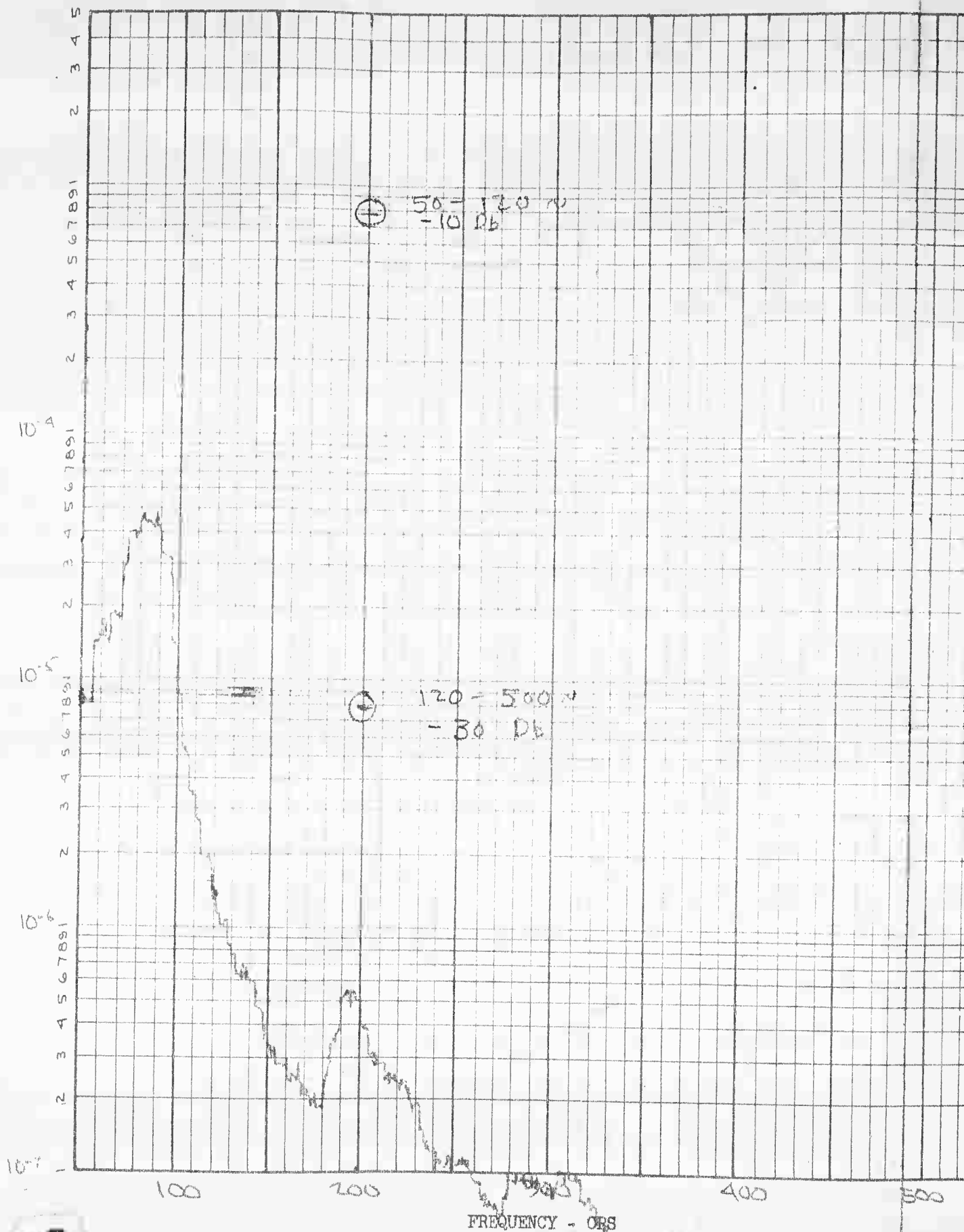


CALC	30A	6/27/61	REVISED	DATE	POWER SPECTRAL DENSITY ANALYSIS OF DISPLACEMENT PICKUP	VOL I
CHECK					0.5 MIN TEST 162.5 dB	
APR.	P/U #1 - PANEL 1493 PHASE D					12-20084
APR.	BOEING AIRPLANE COMPANY					PAGE
	SEATTLE 24, WASHINGTON					FIG 2-0

2-5353-7-9

2

POWER SPECTRAL DENSITY - (In.)²/cps



1

ANALYSIS VARIABLES

Bandwidth

5 cycles from 50 to 500 cps
 _____ cycles from _____ to _____ cps
 _____ cycles from _____ to _____ cps

T_c 15 Sec.
 Anal. Rate 33 cps/sec.
 Loop Length 15 Sec.

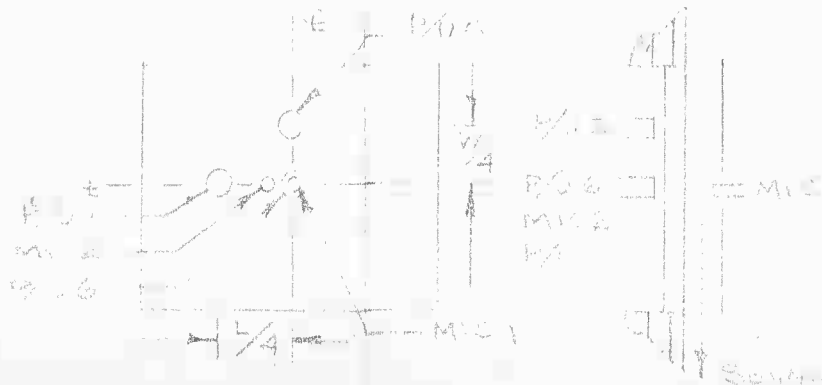
CALC	30A
CHECK	
APR.	

DATA IDENTIFICATION

Test Title PAWEL ATTACH TYPE I ~ PRELIM.		
EWA No. 5-593	Panel or Specimen No. 1498	
Tape No. 61	Tape Channel A	Displacement Pickup 5
Elapsed Test Time +60.5 MIN		P/U RMS Level at Sonic Lab. V _L = Volts

CALIBRATION

Tape No. 61	Tape Channel 6	Data Tape RMS Volt V _R = .210
Calibration Voltage V _A = .5 V _{rms} into Line Amp.; V _C = .485 V _{rms} on Tape @ 200 cps		
Line Amplifier Settings For Calibration G _C = 500; for Data G _d = 100		
Lab. Gain LG = 10	Tape Monitor Gain TMG = $\frac{G_d}{G_C} = 2$	
Displacement Pickup Sensitivity S = .0354 in./Volt		
Equivalent of Calibration - in. D _C = V _A * S = .0777		
Equivalent of Calibration for PSD Plots $\left(\frac{D_C}{(TMG)(LG)}\right)^2 = \left(\frac{.0777}{(2)(10)}\right)^2 = 7.8 \times 10^{-3}$ in. ² /cps		
Analyzer Attenuator Setting -10 db		Log Converter Setting 0 db
Calibration Plotted at in. ² /cps		
Overall Deflection Level of Data RMS Defl. Level = $\frac{(D_C)(V_R)}{(TMG)(LG)(V_C)} = \frac{(.0777)(.210)}{(2)(10)(.485)} = .0383$ in.		

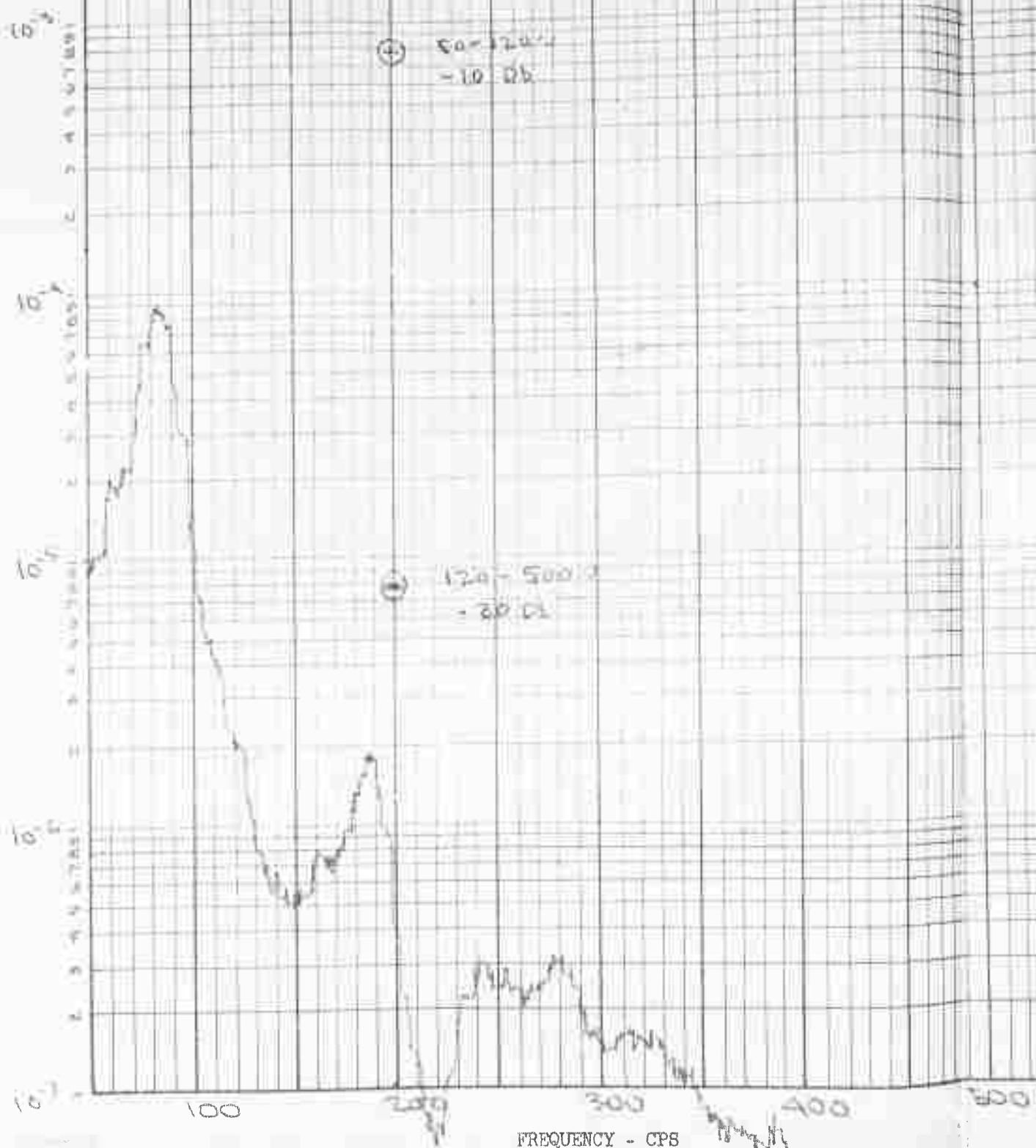


CALC	50A	4/27/61	REVISED	DATE	POWER SPECTRAL DENSITY ANALYSIS OF DISPLACEMENT PICKUP	VOL I
CHECK					P/U #5 PANEL 1498 PHASE "D"	DE 80061
APR.					BOEING AIRPLANE COMPANY	PAGE
					SEATTLE 24, WASHINGTON	Fig 211

2-5353-7-9

2

POWER SPECTRAL DENSITY - $(\text{In.})^2/\text{cps}$



1

ANALYSIS VARIABLES

Bandwidth

5 cycles from 50 to 500 cps
 _____ cycles from _____ to _____ cps
 _____ cycles from _____ to _____ cps

T_c 15 Sec.

Anal. Rate 33 cps/sec.

Loop Length 15 Sec.

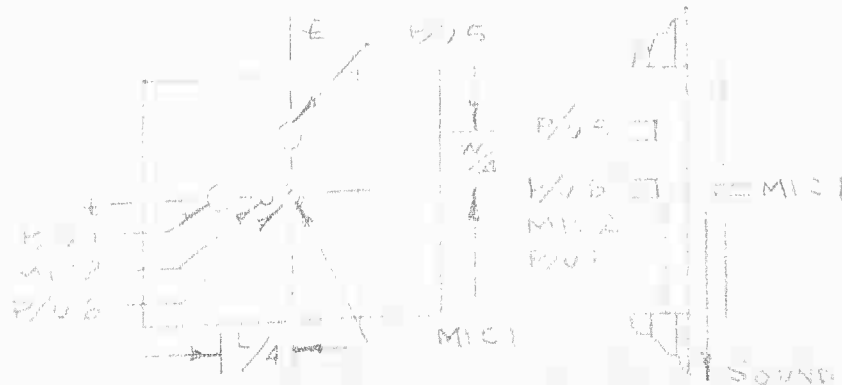
CALC
 CHECK
 APR. 50A

DATA IDENTIFICATION

Test Title PANEL ATTACH. TYPE I ~ PRELIM.		
EWA No. 5-593	Panel or Specimen No. 1498	
Tape No. 61	Tape Channel 5	Displacement Pickup # 6
Elapsed Test Time +60.5 MIN.	P/U RMS Level at Sonic Lab. VL = 1.40 Volts	

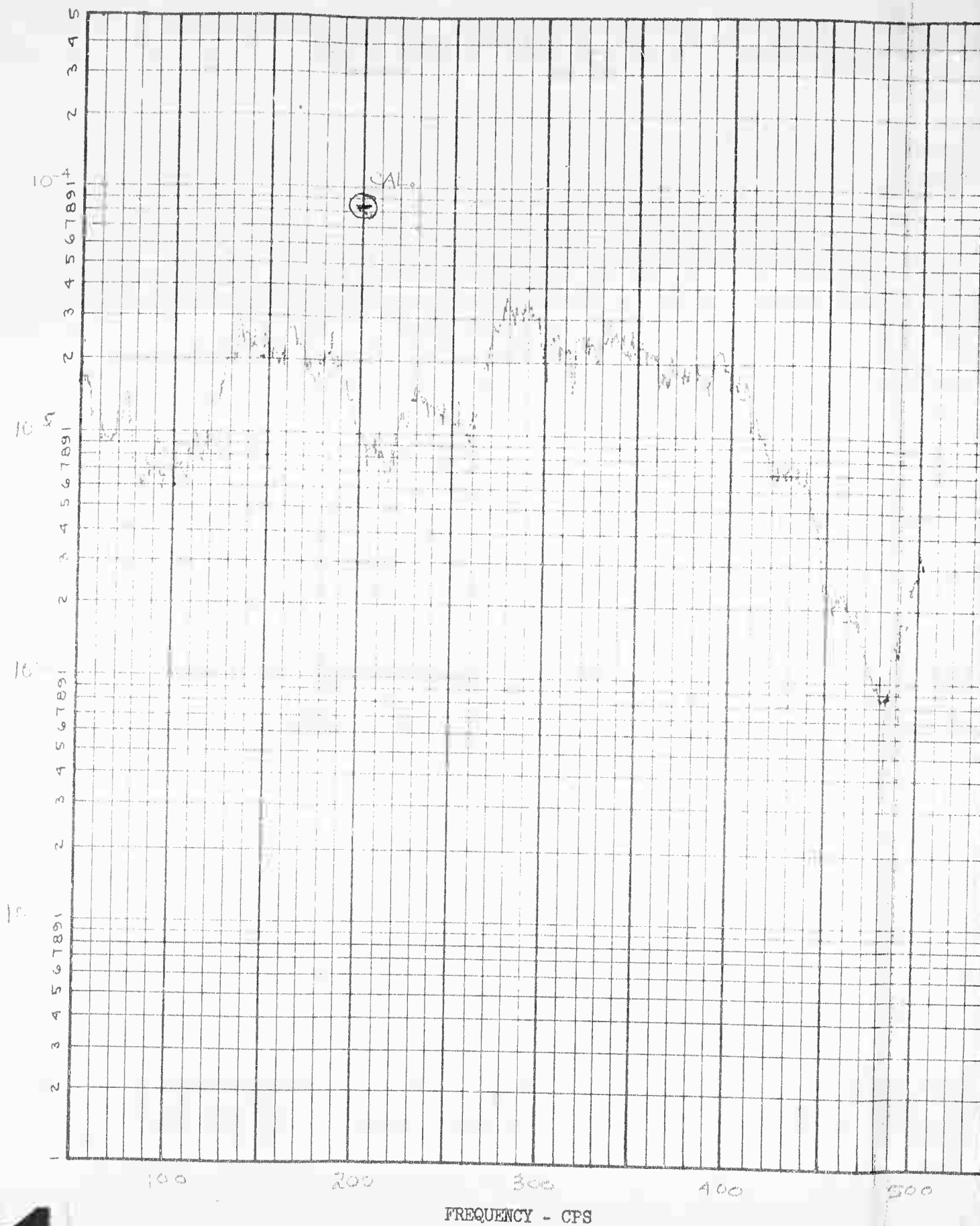
CALIBRATION

Tape No. 61	Tape Channel 6	Data Tape RMS Volt VR = .250
Calibration Voltage VA = .5 VRMS into Line Amp.; VC = .485 VRMS on Tape @ 20 cps		
Line Amplifier Settings For Calibration GC = .500; for Data GD = .100		
Lab. Gain LG = 1.0	Tape Monitor Gain TMC = $\frac{GD}{GC} = .2$	
Displacement Pickup Sensitivity S = .035 in./Volt		
Equivalent of Calibration - in. DC = VA * S = .0177		
Equivalent of Calibration for PSD Plots $\left(\frac{DC}{(TMC)(LG)}\right)^2 = \left(\frac{.0177}{(.2)(1)}\right)^2 = 7.8 \times 10^{-3} \text{ in.}^2/\text{cps}$		
Analyzer Attenuator Setting -10 db -30 db	Log Converter Setting 50-120 db 10-30 db	
Calibration Plotted at 7.8 (10^-3) in.^2/cps		
Overall Deflection Level of Data RMS Defl. Level = $\frac{(DC)(VR)}{(TMC)(LG)(VC)} = \frac{(.0177)(.250)}{(.2)(1)(.485)} = .0455 \text{ in.}$		



CALC	50A	4/2/6	REVISED	DATE	POWER SPECTRAL DENSITY ANALYSIS OF DISPLACEMENT PICKUP	VOLT
CHECK					0.5 MIN. TEST 162.5 db	
APR.					P/U #6 PANEL 1498 PHASE "D"	D2-B-173
					BOEING AIRPLANE COMPANY	PAGE
					SEATTLE 24, WASHINGTON	FIG 212

POWER SPECTRAL DENSITY - (psi)²/cps



ANALYSIS VARIABLES

Bandwidth

5 cycles from 50 to 500 cps
 _____ cycles from _____ to _____ cps
 _____ cycles from _____ to _____ cps

T_c 4 Sec.
 Anal. Rate 1.25 cps/Sec.
 Loop Length 4 Sec.

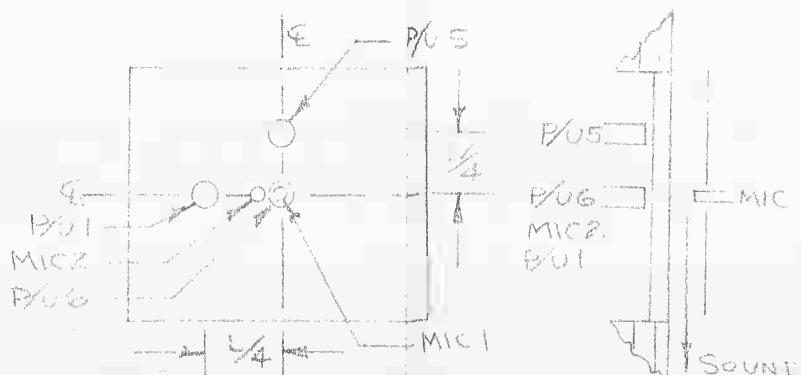
CALC. 1/11
 CHECK CBT
 APR.
 APR.

DATA IDENTIFICATION

Test Title <u>PANEL ATTACH TYPE I PRELIM</u>		
EWA No. <u>5-575</u>		Panel or Specimen No. <u>1499</u>
Tape No. <u>28</u>	Tape Channel <u>1</u>	Mic. No. <u>1</u>
Elapsed Test Time <u>45</u>		Mic. RMS Level at Sonic Lab. $V_L = \text{---} \text{ Volts}$

CALIBRATION

Tape No. <u>28</u>	Tape Channel <u>6</u>	Data Tape RMS Volt $V_R = .192$
Calibration Voltage $V_a = .5 V_{rms}$ into Line Amp.; $V_c = .5 V_{rms}$ on Tape @ 700 cps		
Line Amplifier Settings For Calibration $G_c = .500$; for Data $G_d = .250$		
Lab. Gain $LG = 1.0$	Tape Monitor Gain $TMG = \frac{G_d}{G_c} = .50$	
Microphone Sensitivity $S = .270 \text{ psi/Volt}$ or $1 \text{ Volt rms} = 130 \text{ db SPL}$		
Equivalent of Calibration - psi $P_c = V_a \cdot S = .145$		
Equivalent of Calibration for PSD Plots $\left(\frac{P_c}{(TMG)(LG)} \right)^2 = \left(\frac{.145}{(.5)(1.0)} \right)^2 = 8.41 (10^{-5}) \text{ psi}^2/\text{cps}$		
Analyzer Attenuator Setting <u>-30</u> db	Log Converter Setting <u>0</u> db	
Calibration Plotted at <u>$8.41 (10^{-5})$</u> psi^2/cps		
Overall Pressure Level Data $(P_c)(V_R)$ RMS pressure level = $\frac{(P_c)(V_R)}{(TMG)(LG)(V_c)}$ $= \frac{(.145)(.192)}{(.5)(1.0)(.5)} = 0.113 \text{ psi}$		Equiv. to <u>111.5</u> db SPL

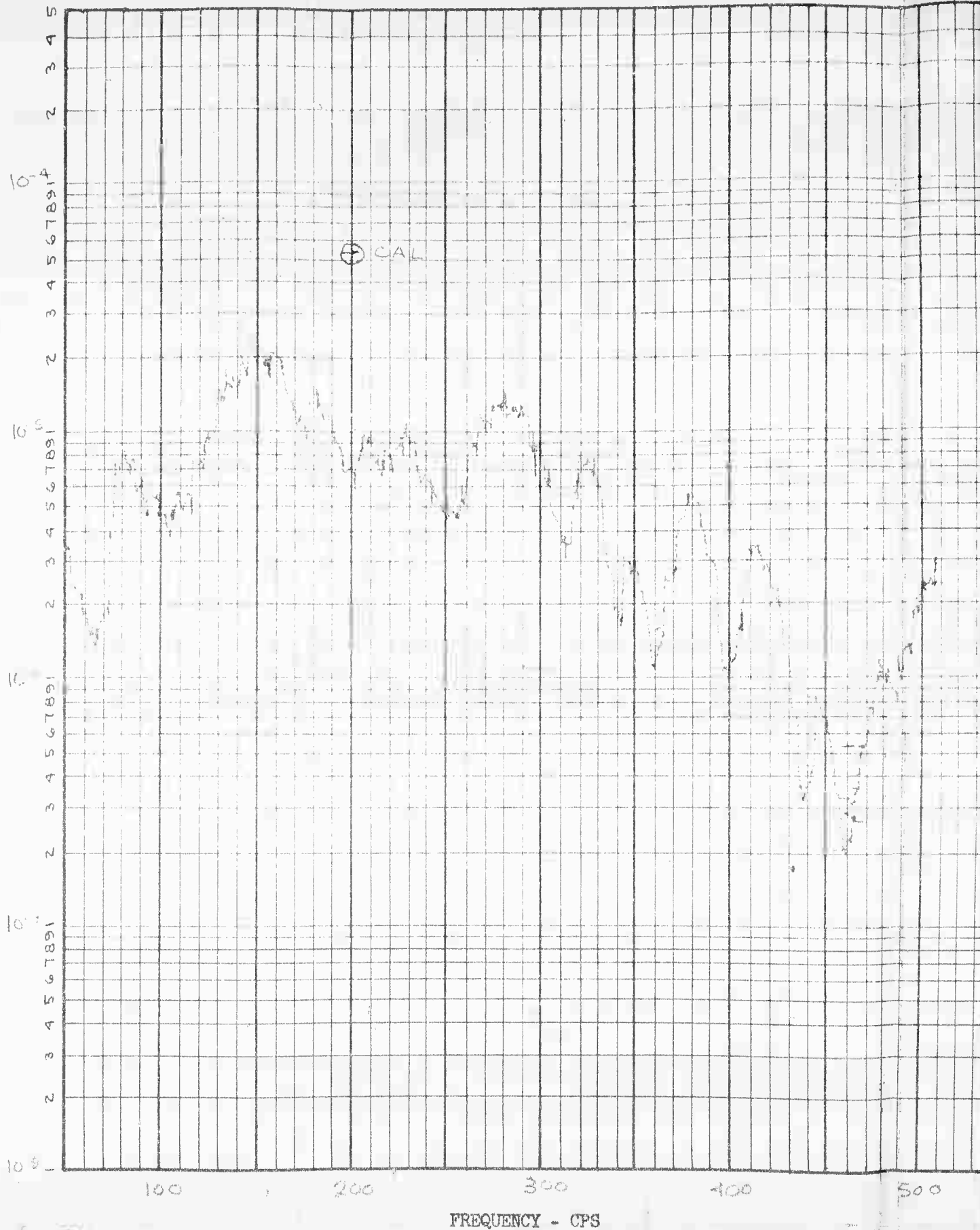


CALC.	6/1/61	REVISED	DATE	POWER SPECTRAL DENSITY ANALYSIS OF MICROPHONE OUTPUT SMITH TEST MIC1 PANEL 1499 PHASE A BOEING AIRPLANE COMPANY SEATTLE 24, WASHINGTON
CHECK	CBT	4/3/61		
APR				
APR				

2-5353-7-8

2

POWER SPECTRAL DENSITY - (psi)²/cps



ANALYSIS VARIABLES

Bandwidth

5 cycles from 50 to 500 cps
 _____ cycles from _____ to _____ cps
 _____ cycles from _____ to _____ cps

T_c 4 Sec.
 Anal. Rate 125 cps/Sec.
 Loop Length 4 Sec.

CALC 125
 CHECK CST
 APR.
 APR.

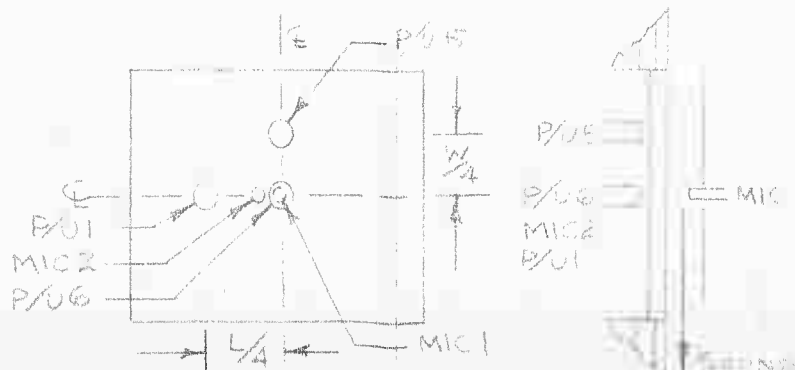
DATA IDENTIFICATION

Test Title <u>PANEL ATTACH TYPE I PRELIM</u>		
EWA No. <u>5-523</u>		Panel or Specimen No. <u>1499</u>
Tape No. <u>28</u>	Tape Channel <u>2</u>	Mic. No. <u>2</u>
Elapsed Test Time <u>45</u>		Mic. RMS Level at Sonic Lab. VL = <u> </u> Volts

CALIBRATION

Tape No. <u>28</u>	Tape Channel <u>2</u>	Data Tape RMS Volt VR = <u>.164</u>
Calibration Voltage Va = .5 V _{rms} into Line Amp.; Vc = .5 V _{rms} on Tape @ 700 cps		
Line Amplifier Settings For Calibration Gc = .500; for Data Gd = 1.000		
Lab. Gain LG = <u>1.0</u>	Tape Monitor Gain TMG = $\frac{G_d}{G_c} = 2.0$	
Microphone Sensitivity S = .290 psi/Volt or 1 Volt rms = 160 db SPL		
Equivalent of Calibration - psi Pc = Va · S = <u>.145</u>		
Equivalent of Calibration for PSD Plots $\left(\frac{P_c}{(TMG)(LG)} \right)^2 = \frac{.145^2}{(2)(1)} = 5.25(10^{-3}) \text{ psi}^2/\text{cps}$		
Analyzer Attenuator Setting <u>-30</u> db	Log Converter Setting <u> </u> db	
Calibration Plotted at <u>5.25(10⁻⁵)</u> psi ² /cps		
Overall Pressure Level Data RMS pressure level = $\frac{(P_c)(V_R)}{(TMG)(LG)(V_c)}$ $= \frac{.145(.164)}{(2)(1)(.510)} = 0.0233 \text{ psi}$		Equiv. to 138.0 db SPL

SPECTRUM LEVEL - DECIBELS (Re 0.0002 Microbar)



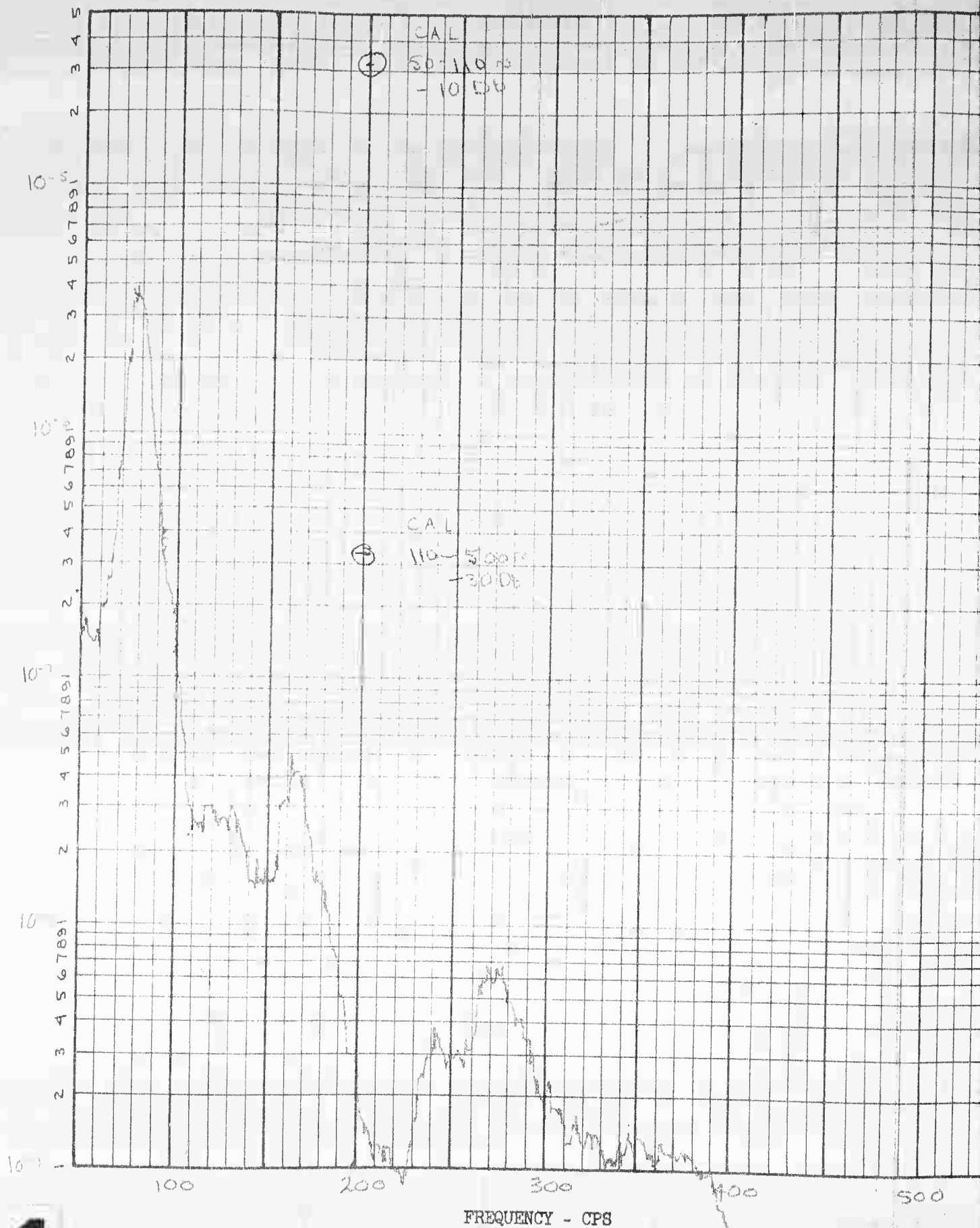
CALC	1/27/77	6-26	REVISED	DATE
CHECK	CET	6/30/81		
APR.				
APR.				

POWER SPECTRAL DENSITY ANALYSIS
OF MICROPHONE OUTPUT
5 MIN TEST
MIC 2 PANEL 1499 PHASE A
BOEING AIRPLANE COMPANY
SEATTLE 24, WASHINGTON

2-5253-7-8

2

POWER SPECTRAL DENSITY - (In.)²/cps



FREQUENCY - CPS

ANALYSIS VARIABLES

Bandwidth

5 cycles from 50 to 500 cps
 ___ cycles from ___ to ___ cps
 ___ cycles from ___ to ___ cps

T_c 4 Sec.
 Anal. Rate 125 cps/sec.
 Loop Length 4 Sec.

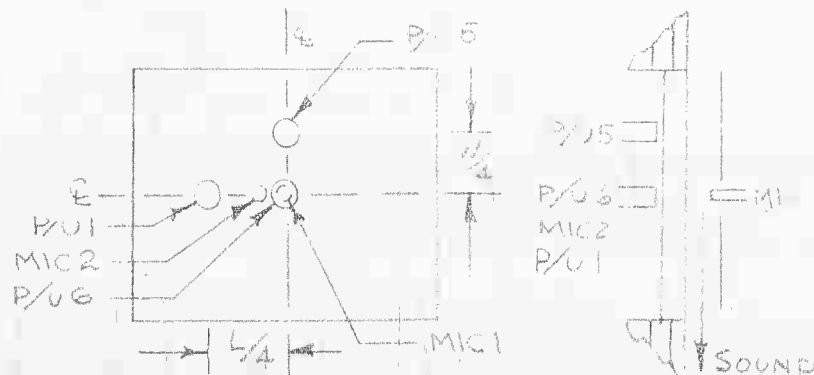
CALC MEM
 CHECK GBT
 APR.
 APR.

DATA IDENTIFICATION

Test Title PANEL ATTACH TYPE I PRELIM.		
FWA No. 5-593	Panel or Specimen No. 1499	
Tape No. 28	Tape Channel 3	Displacement Pickup # 1
Elapsed Test Time +5		P/U RMS Level at Sonic Lab. VL = .210 Volts

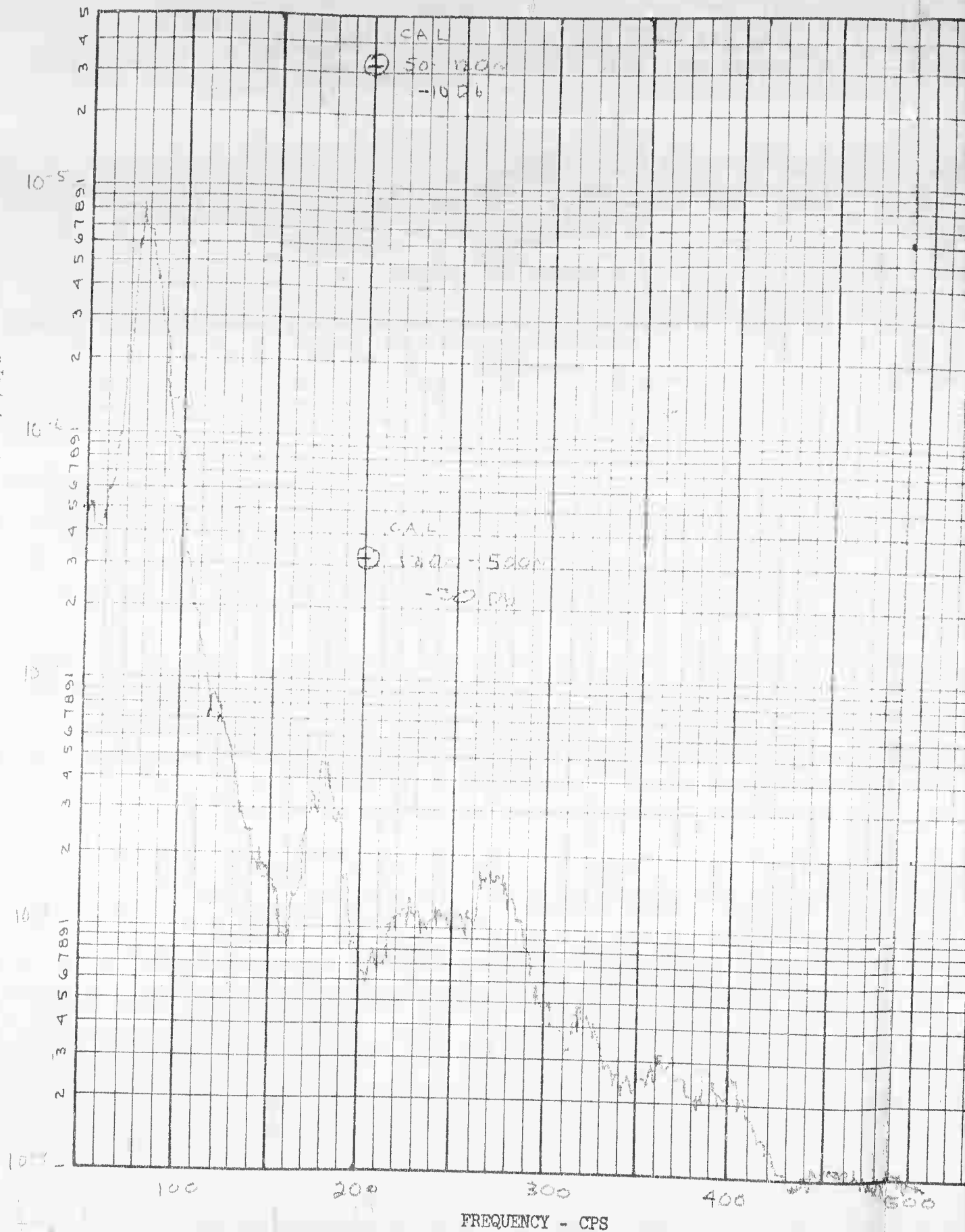
CALIBRATION

Tape No. 28	Tape Channel 6	Data Tape RMS Volt V_R = .230
Calibration Voltage V_a = .5 V_{rms} into Line Amp.; V_c = .510 V_{rms} on Tape @ 200 cps		
Line Amplifier Settings For Calibration G_c = .500; for Data G_d = .500		
Lab. Gain LG = 1.0	Tape Monitor Gain TMG = $\frac{G_d}{G_c} = 1.0$	
Displacement Pickup Sensitivity S = .0334 in./Volt		
Equivalent of Calibration - in. D_c = V_a · S = .0177		
Equivalent of Calibration for PSD Plots $\left(\frac{D_c}{(TMG)(LG)}\right)^2 = \left[\frac{.0177}{(1.0)(1.0)}\right]^2 = 3.13 (10^{-4})$ in.²/cps		
Analyzer Attenuator Setting -10db 50-1100 db	Log Converter Setting 0 db	
Calibration Plotted at 3.13 (10⁻⁴) 50-1100 in.²/cps		
Overall Deflection Level of Data RMS Defl. Level = $\frac{(D_c)(V_R)}{(TMG)(LG)(V_c)} = \frac{(.0177)(.23)}{(1.0)(1.0)(.51)} = .00824$ in.		



QALC	6/30/61	REVISED	DATE	POWER SPECTRAL DENSITY ANALYSIS OF DISPLACEMENT PICKUP 5 MIN TEST	VOL I
CHECK	QBT			P/U1 PANEL 1499 PHASE A	DE-8008A
APR.				BOEING AIRPLANE COMPANY	PAGE
APR.				SEATTLE 24, WASHINGTON	FIG 215

POWER SPECTRAL DENSITY - (In.)²/cps



ANALYSIS VARIABLES

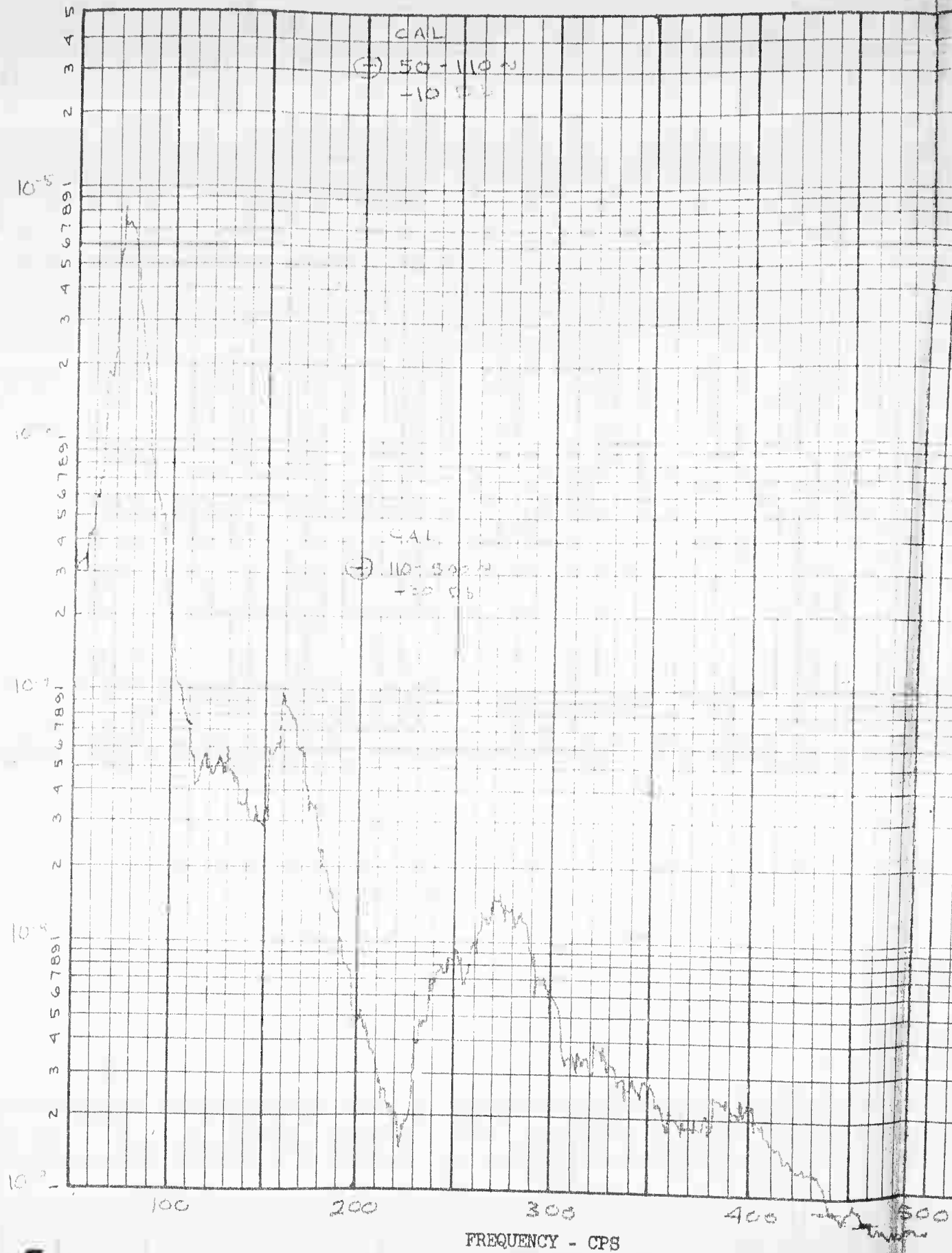
Bandwidth

5 cycles from 50 to 500 cps
 _____ cycles from _____ to _____ cps
 _____ cycles from _____ to _____ cps

T_c 4 Sec.
 Anal. Rate 125 cps/sec.
 Loop Length 4 Sec.

CALC 1000
 CHECK CBT
 APR.
 APR.

POWER SPECTRAL DENSITY - (in.)²/cps



ANALYSIS VARIABLES

Bandwidth

5 cycles from 50 to 500 cps
 _____ cycles from _____ to _____ cps
 _____ cycles from _____ to _____ cps

T_c 4 Sec.

Anal. Rate 1.25 cps/sec.

Loop Length 4 Sec.

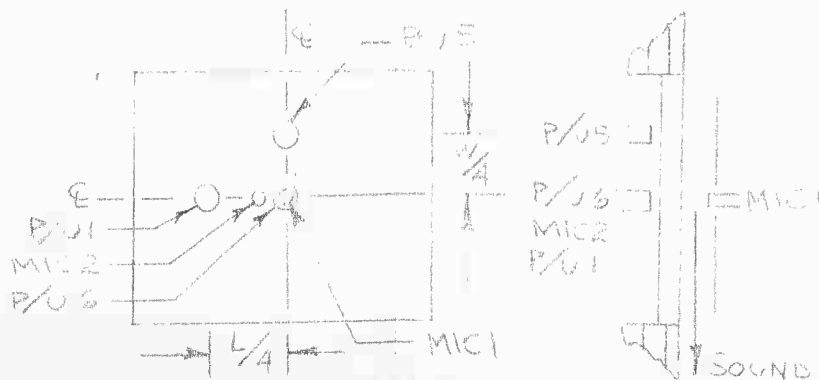
CALC
CHECK
APR
APR

DATA IDENTIFICATION

Test Title <i>PANEL ATTACH TYPE I PRELIM</i>		
EWA No. <i>5-593</i>	Panel or Specimen No. <i>1499</i>	
Tape No. <i>28</i>	Tape Channel <i>5</i>	Displacement Pickup <i>6</i>
Elapsed Test Time <i>45</i>		P/U RMS Level at Sonic Lab. <i>V_L = .310 Volts</i>

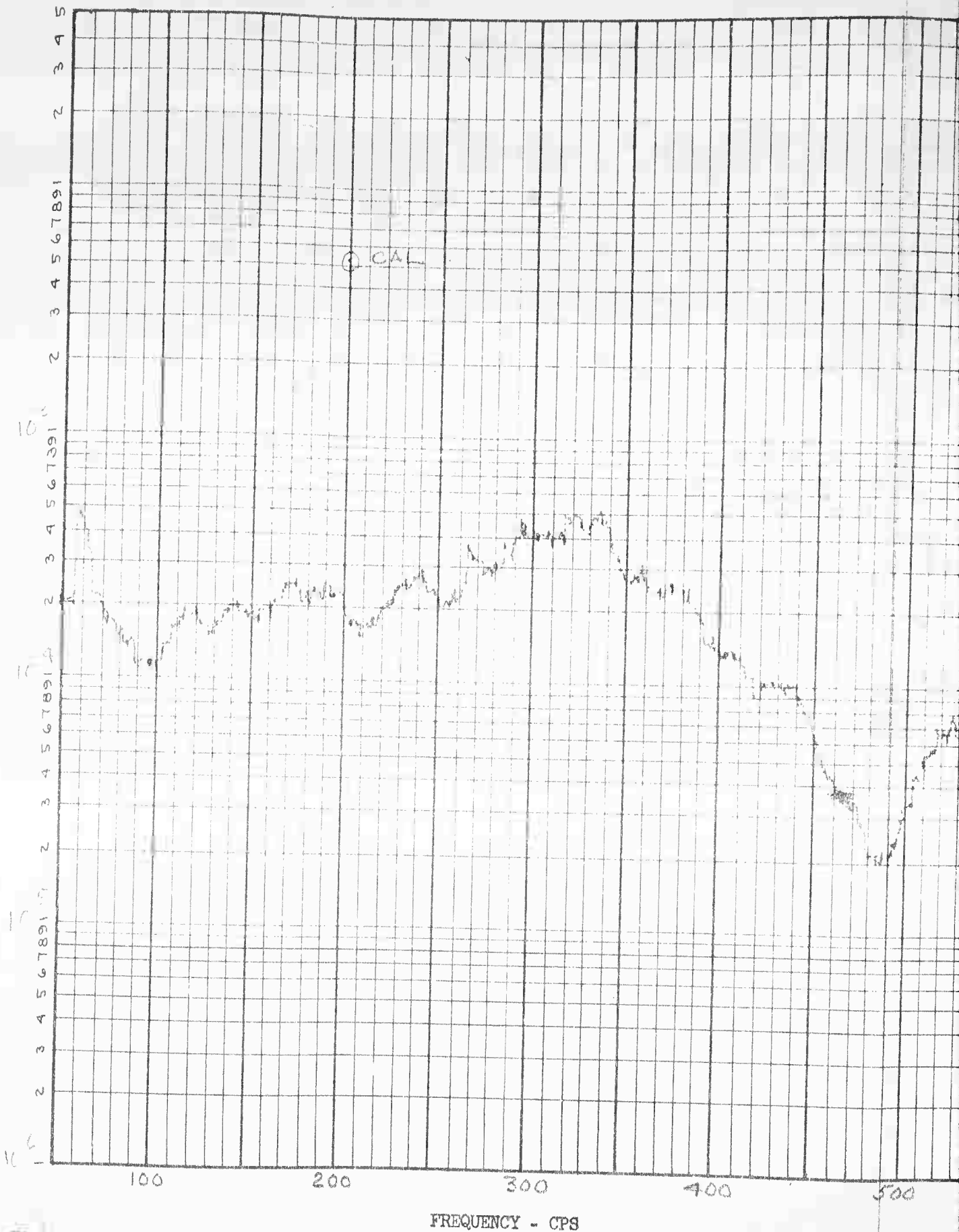
CALIBRATION

Tape No. <i>28</i>	Tape Channel <i>6</i>	Data Tape RMS Volt <i>V_R = .315</i>
Calibration Voltage <i>V_a = .5 V_{rms} into Line Amp.; V_c = .5 V_{rms} on Tape @ 200 cps</i>		
Line Amplifier Settings <i>For Calibration G_c = .500 ; For Data G_d = .500</i>		
Lab. Gain <i>LG = 1.0</i>	Tape Monitor Gain <i>TMG = $\frac{G_d}{G_c} = 1.0$</i>	
Displacement Pickup Sensitivity <i>S = .0384 in./Volt</i>		
Equivalent of Calibration - in. <i>D_c = V_a · S = .0171</i>		
Equivalent of Calibration for PSD Plots $\left(\frac{D_c}{(TMG)(LG)} \right)^2 = \left[\frac{.0171}{(1)(1)} \right]^2 = 3.13 (10^{-4}) \text{ in.}^2/\text{cps}$		
Analyzer Attenuator Setting <i>-10 db</i>		Log Converter Setting <i>0 db</i>
Calibration Plotted at <i>3.13 (10^{-4}) in.}^2/\text{cps}</i>		
Overall Deflection Level of Data $\text{RMS Defl. Level} = \frac{(D_c)(V_R)}{(TMG)(LG)(V_c)} = \frac{(.0171)(.315)}{(1)(1)(.500)} = .0115 \text{ in.}$		



CALC	<i>MEM</i>	<i>6-26</i>	REVISED	DATE	POWER SPECTRAL DENSITY ANALYSIS OF DISPLACEMENT PICKUP <i>SHOOT TEST</i> <i>P/U6 PANEL 1499 PHASE A</i> BOEING AIRPLANE COMPANY SEATTLE 24, WASHINGTON	VOL I
CHECK	<i>CBT</i>	<i>6/26</i>				DZ-80084
APR						PAGE
APR						FIG 217

POWER SPECTRAL DENSITY - $(\text{psi})^2/\text{cps}$



ANALYSIS VARIABLES

Bandwidth

5 cycles from 50 to 500 cps
 _____ cycles from _____ to _____ cps
 _____ cycles from _____ to _____ cps

T_c 15 Sec.
 Anal. Rate 333 cps/Sec.
 Loop Length 15 Sec.

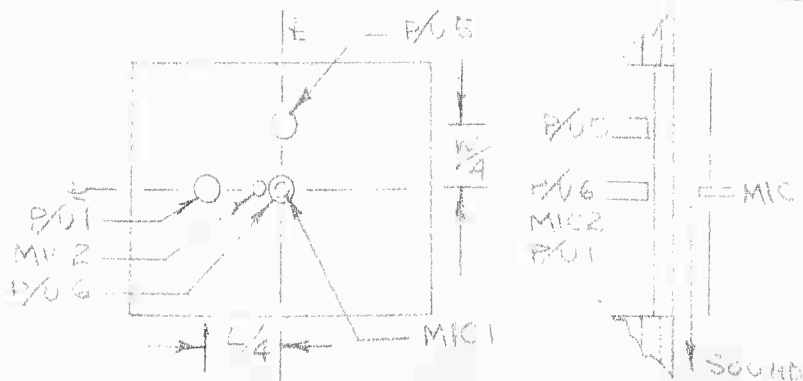
CALC	CBI
CHECK	
APR.	
APR.	

DATA IDENTIFICATION

Test Title PANEL ATTACHMENT - TYPE I		
EWA No. 5-593,	Panel or Specimen No. 1499	
Tape No. 64	Tape Channel 1	Mic. No. 1
Elapsed Test Time 60.5 MIN		Mic. RMS Level at Sonic Lab. V_L = 1.27 Volts

CALIBRATION

Tape No. 64	Tape Channel 6	Data Tape RMS Volt V_R = 1.27
Calibration Voltage V_a = .50 V_{rms} into Line Amp.; V_c = V_{rms} on Tape @ 200 cps		
Line Amplifier Settings For Calibration G _c = .500 ; for Data G _d = .100		
Lab. Gain LG = 1.0	Tape Monitor Gain TMG = G_d/G_c = .20	
Microphone Sensitivity S = .240 psi/Volt or 1 Volt rms = 160 db SPL		
Equivalent of Calibration - psi P_c = V_a · S = 0.145		
Equivalent of Calibration for PSD Plots $\left(\frac{P_c}{(TMG)(LG)} \right)^2 = 5.25 \times 10^{-5} \text{ psi}^2/\text{cps}$		
Analyzer Attenuator Setting 20 db	Log Converter Setting db	
Calibration Plotted at 5.25 × 10⁻⁵ psi²/cps		
Overall Pressure Level Data (P_c)(V_R)		Equiv. to 161.3 db SPL
RMS pressure level = $\frac{(TMG)(LG)(V_c)}{(P_c)(V_R)} = \frac{(0.2)(1)(1.27)}{(0.145)(1.27)} = 0.314 \text{ psi}$		

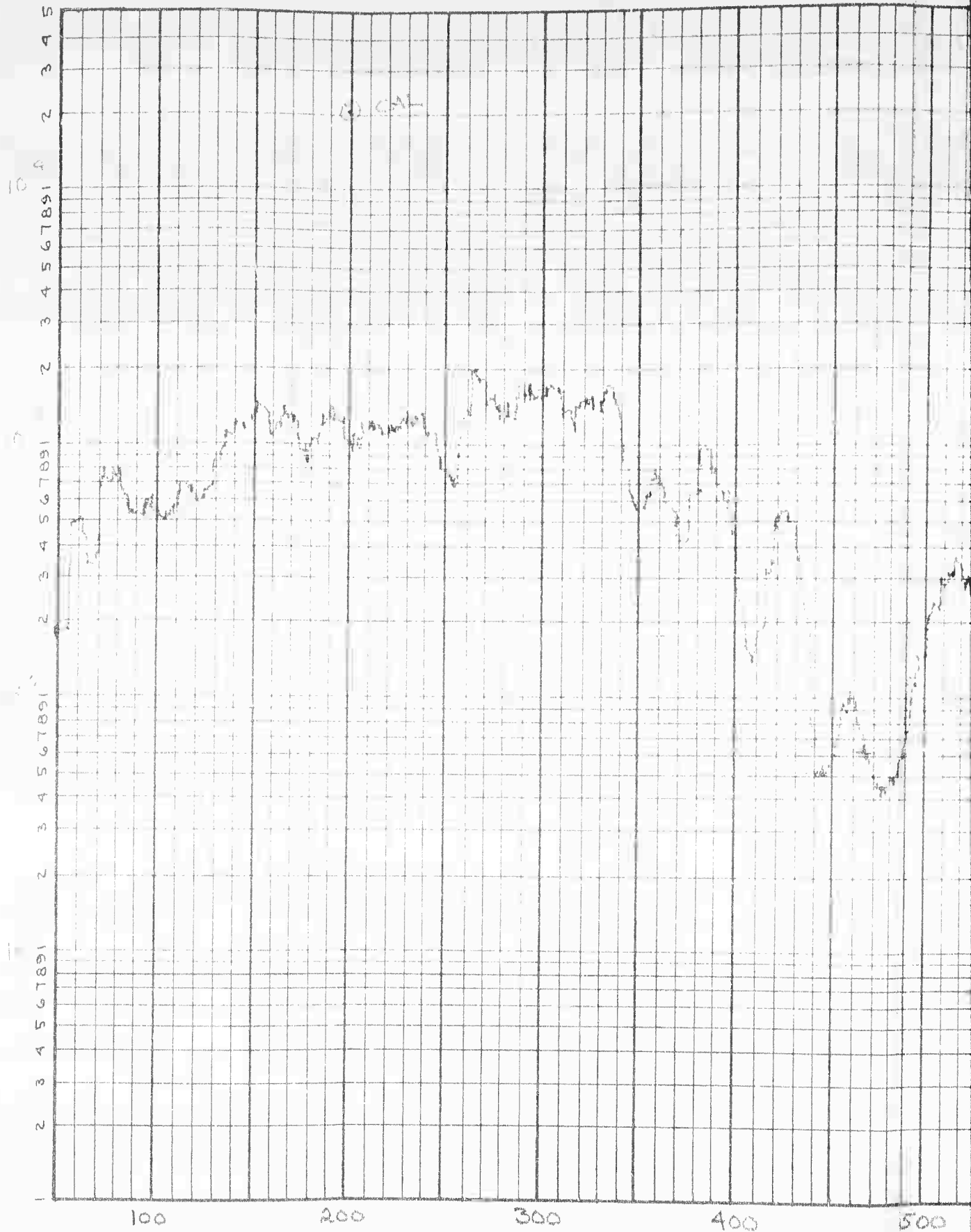


CALC	CBI	4/2/61	REVISED	DATE	POWER SPECTRAL DENSITY ANALYSIS	VOL. I
CHECK					OF MICROPHONE OUTPUT	
APR.					MIC. #1 PANEL 1499 PHASE "D"	D2-80X64
APR.					BOEING AIRPLANE COMPANY	PAGE
					SEATTLE 24, WASHINGTON	FIG 218

2-5353-7-8

2

POWER SPECTRAL DENSITY - $(\text{psi})^2/\text{cps}$



FREQUENCY - CPS

ANALYSIS VARIABLES

Bandwidth

5 cycles from 50 to 500 cps
 cycles from to cps
 cycles from to cps

T_c 15 Sec.
 Anal. Rate .333 cps/Sec.
 Loop Length 15 Sec.

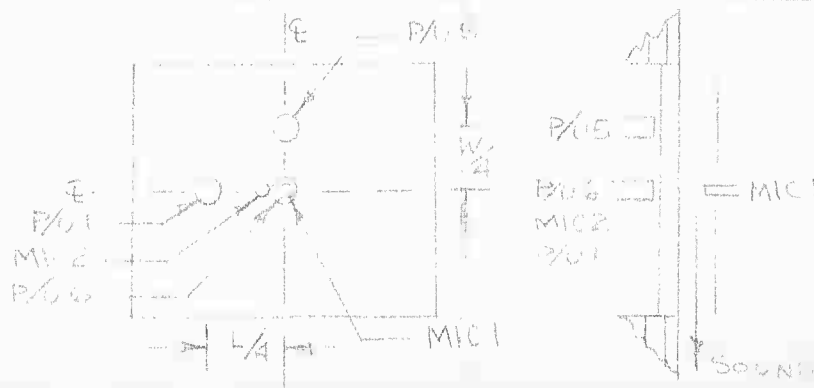
CALC.	2.51
CHECK	
APR.	
APR.	176

DATA IDENTIFICATION

Test Title PANEL ATTACHMENT - TYPE I		
EWA No. 5-593	Panel or Specimen No. 1499	
Tape No. 64	Tape Channel 2	Mic. No. 2
Elapsed Test Time 60.5 MIN.		Mic. RMS Level at Sonic Lab. V_L = .250 Volts

CALIBRATION

Tape No. 64	Tape Channel 6	Data Tape RMS Volt V_R = .252
Calibration Voltage V_a = .50 V_{rms} into Line Amp.; V_c = .5 V_{rms} on Tape @ 200 cps		
Line Amplifier Settings For Calibration G_c = .500 ; for Data G_d = .500		
Lab. Gain LG = 1.0	Tape Monitor Gain TMG = $\frac{G_d}{G_c} = 1.0$	
Microphone Sensitivity S = .290 psi/Volt or 1 Volt rms = 160 db SPL		
Equivalent of Calibration - psi P_c = V_a · S = 0.145		
Equivalent of Calibration for PSD Plots $\left(\frac{P_c}{(TMG)(LG)}\right)^2 = \left[\frac{.145}{(1.0)(1.0)}\right]^2 = 2.1 \times 10^{-2} \text{ psi}^2/\text{cps}$		
Analyzer Attenuator Setting -20 db	Log Converter Setting db	
Calibration Plotted at $2.1 \times 10^{-4} \text{ psi}^2/\text{cps}$		
Overall Pressure Level Data RMS pressure level = $\frac{(P_c)(V_R)}{(TMG)(LG)(V_c)}$ $= \frac{(0.145)(.252)}{(1)(1)(.500)} = 0.074 \text{ psi}$		Equiv. to 98 db SPL



CALC	CEI	6/20/61	REVISED	DATE	POWER SPECTRAL DENSITY ANALYSIS OF MICROPHONE OUTPUT 0.5 MIN TEST	Vol. I
CHECK					MIC #2 PANEL 1499 PHASE "D"	D2-80084
APR.					BOEING AIRPLANE COMPANY	PAGE
APR.		6/27/61			SEATTLE 24, WASHINGTON	FIG 219

2-5253-7-3

POWER SPECTRAL DENSITY - (In.)²/cps



ANALYSIS VARIABLES

Bandwidth

5 cycles from 50 to 500 cps
 _____ cycles from _____ to _____ cps
 _____ cycles from _____ to _____ cps

T_c 15 Sec.
 Anal. Rate .333 cps/sec.
 Loop Length 15 Sec.

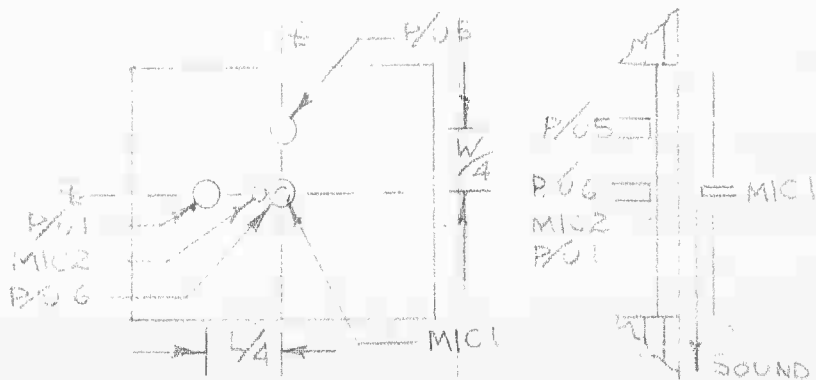
CALC	CB
CHECK	
APR.	
APR	SA

DATA IDENTIFICATION

Test Title PANEL ATTACHMENT TYPE II		
EWA No. 5-573		Panel or Specimen No. 1499
Tape No. 64	Tape Channel 3	Displacement Pickup 1
Elapsed Test Time 60.5 MIN.		P/U RMS Level at Sonic Lab. VL = 1.05 Volts

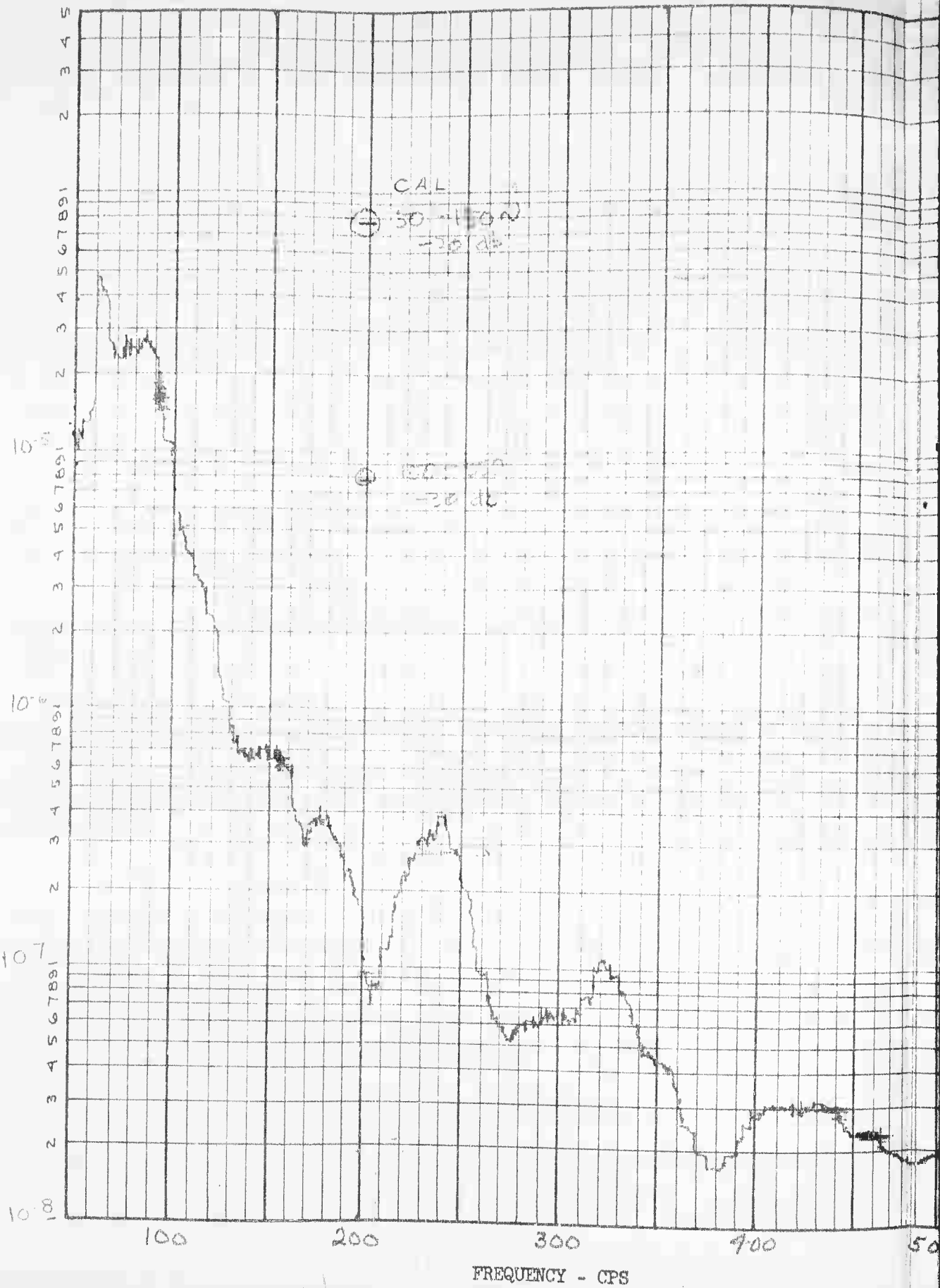
CALIBRATION

Tape No. 64	Tape Channel 6	Data Tape RMS Volt VR = .175
Calibration Voltage: VA = .50 Vrms into Line Amp.; VC = .48 Vrms on Tape @ 200 cps		
Line Amplifier Settings For Calibration GC = .500; for Data GD = .100		
Lab. Gain LG = 1.0	Tape Monitor Gain TMG = $\frac{GD}{GC} = .2$	
Displacement Pickup Sensitivity S = .035 in./Volt		
Equivalent of Calibration - in. DC = VA * S = .0175		
Equivalent of Calibration for PSD Plots $\left(\frac{DC}{(TMG)(LG)}\right)^2 = \left[\frac{.0175}{(.2)(1)}\right]^2 = 7.65 \times 10^{-3} \text{ in.}^2/\text{cps}$		
Analyzer Attenuator Setting 20	Log Converter Setting 0 db	
Calibration Plotted at 7.65 (10^-3) in.²/cps		
Overall Deflection Level of Data RMS Defl. Level = $\frac{(DC)(VR)}{(TMG)(LG)(VC)} = \frac{(.0175)(.175)}{(.2)(1)(.48)} = .0319 \text{ in.}$		



CALC	CBT	6/30/61	REVISED	DATE	POWER SPECTRAL DENSITY ANALYSIS OF DISPLACEMENT PICKUP 1625db 0.5 MIN TEST P/U #1 PANEL 1499 PHASE D	VOL I
CHECK					BOEING AIRPLANE COMPANY	D2-80004
APR.					SEATTLE 24, WASHINGTON	PAGE
APR.						FIG 220

POWER SPECTRAL DENSITY - $(\text{In.})^2/\text{cps}$



ANALYSIS VARIABLES

Bandwidth

5 cycles from 50 to 500 cps
 _____ cycles from _____ to _____ cps
 _____ cycles from _____ to _____ cps

T. 15 Sec.

Anal. Rate .333 cps/sec.

Loop Length 15 Sec.

CALC

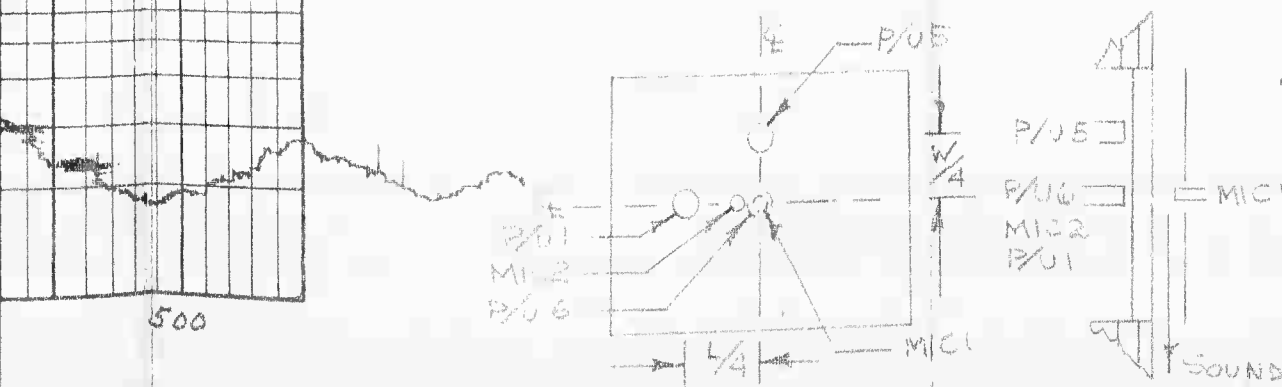
CHECK

APR.

APR.

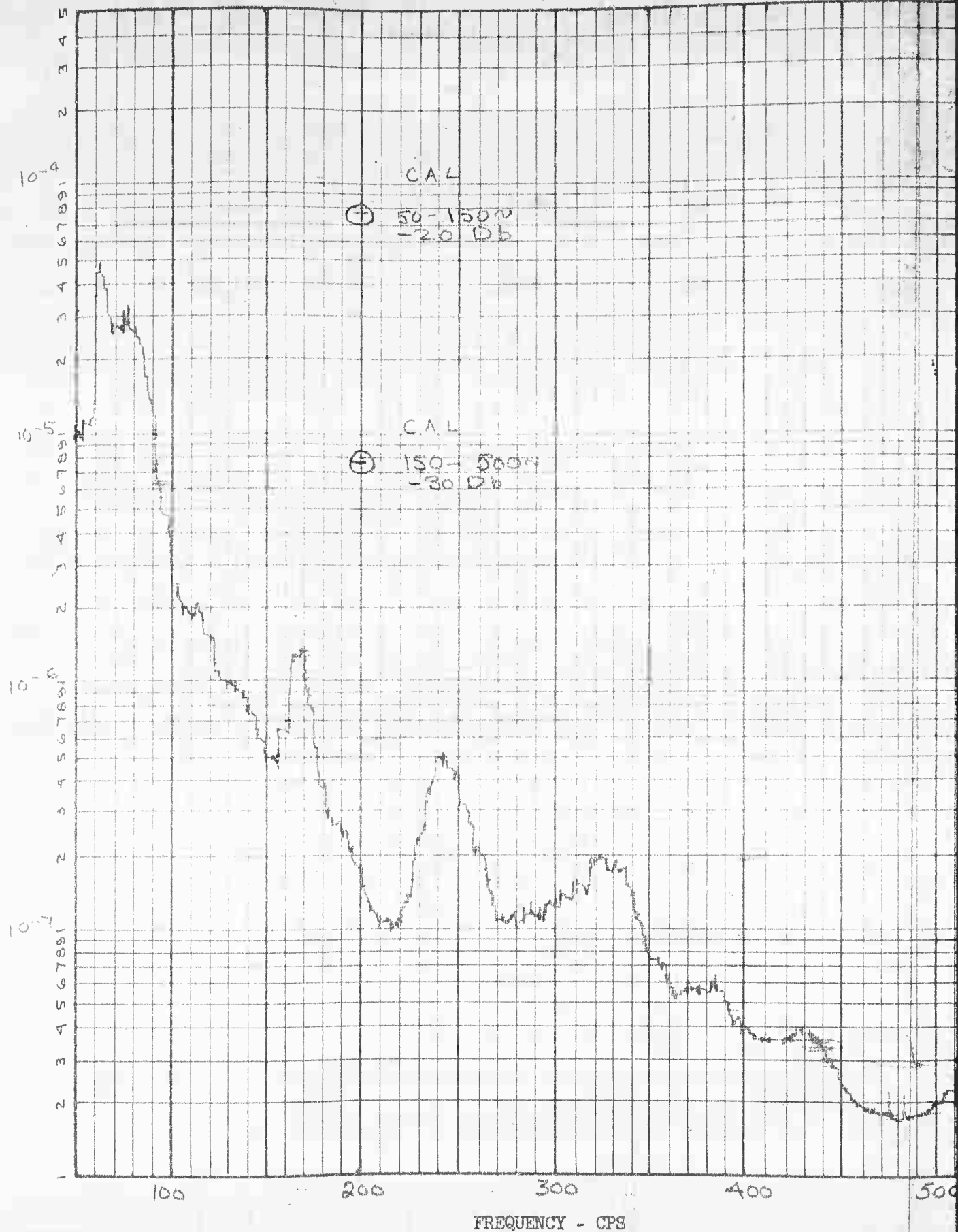
Test Title			DATA IDENTIFICATION		
PANEL ATTACHMENT - TYPE I					
EWA No. 5-593			Panel or Specimen No. 1499		
Tape No. 64		Tape Channel 4		Displacement Pickup 5	
Elapsed Test Time 60.5 MIN			P/U RMS Level at Sonic Lab. VL = 1.00 Volts		

Tape No. 64	Tape Channel 6	Data Tape RMS Volt $V_R = .190$
Calibration Voltage $V_a = .50 V_{rms}$ into Line Amp.; $V_c = .48 V_{rms}$ on Tape @ 200 cps		
Line Amplifier Settings For Calibration $G_c = .500$; for Data $G_d = .100$		
Lab. Gain $LG = 1.0$	Tape Monitor Gain $TMG = \frac{G_d}{G_c} = .2$	
Displacement Pickup Sensitivity $S = .035 \text{ in./Volt}$		
Equivalent of Calibration - in. $D_c = V_a \cdot S = 0.0175$		
Equivalent of Calibration for PSD Plots $\left(\frac{D_c}{(TMG)(LG)} \right)^2 = 7.65 \times 10^{-3} \text{ in.}^2/\text{cps}$		
Analyzer Attenuator Setting -20 50-450n -3000/20-250n	Log Converter Setting 0 db	
Calibration Plotted at $7.65 (10^{-3}) \text{ in.}^2/\text{cps}$		
Overall Deflection Level of Data $\text{RMS Defl. Level} = \frac{(D_c)(V_R)}{(TMG)(LG)(V_c)} = \frac{(0.0175)(.190)}{(.2)(1)(.48)} = .0345 \text{ in.}$		



CALC	CBT	6/30/61	REVISED	DATE	POWER SPECTRAL DENSITY ANALYSIS OF DISPLACEMENT PICKUP 162.5db 3.5 INCH TEST	VOL I
CHECK					P/U # 5 PANEL 499 PHASE "D"	D2 8016
APR.					BOEING AIRPLANE COMPANY	PAGE
APR.	SA	6/28/61			SEATTLE 24, WASHINGTON	F16 221

POWER SPECTRAL DENSITY - (In.)²/cps



ANALYSIS VARIABLES

Bandwidth

5 cycles from 50 to 500 cps
 _____ cycles from _____ to _____ cps
 _____ cycles from _____ to _____ cps

15 Sec.

Anal. Rate .333 cps/sec.

Loop Length 15 Sec.

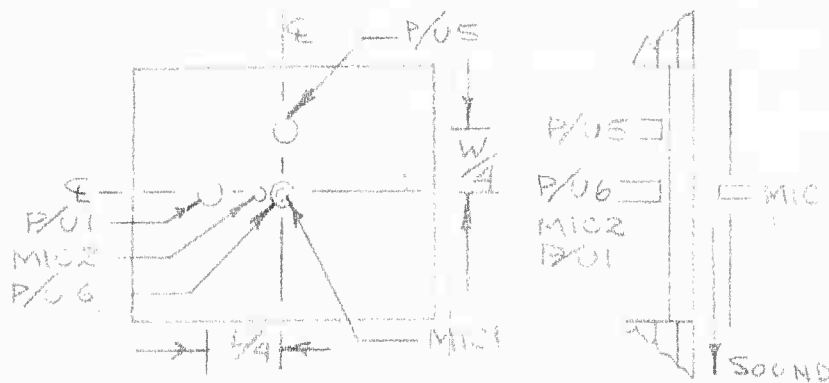
CALC	C
CHECK	
APR.	
APR	

DATA IDENTIFICATION

Test Title PANEL ATTACHMENT - TYPE I		
EWA No. 5-593		Panel or Specimen No. 1499
Tape No. 64	Tape Channel 5	Displacement Pickup # 6
Elapsed Test Time 60.5 MIN.		P/U RMS Level at Sonic Lab. VL = .900 Volts

CALIBRATION

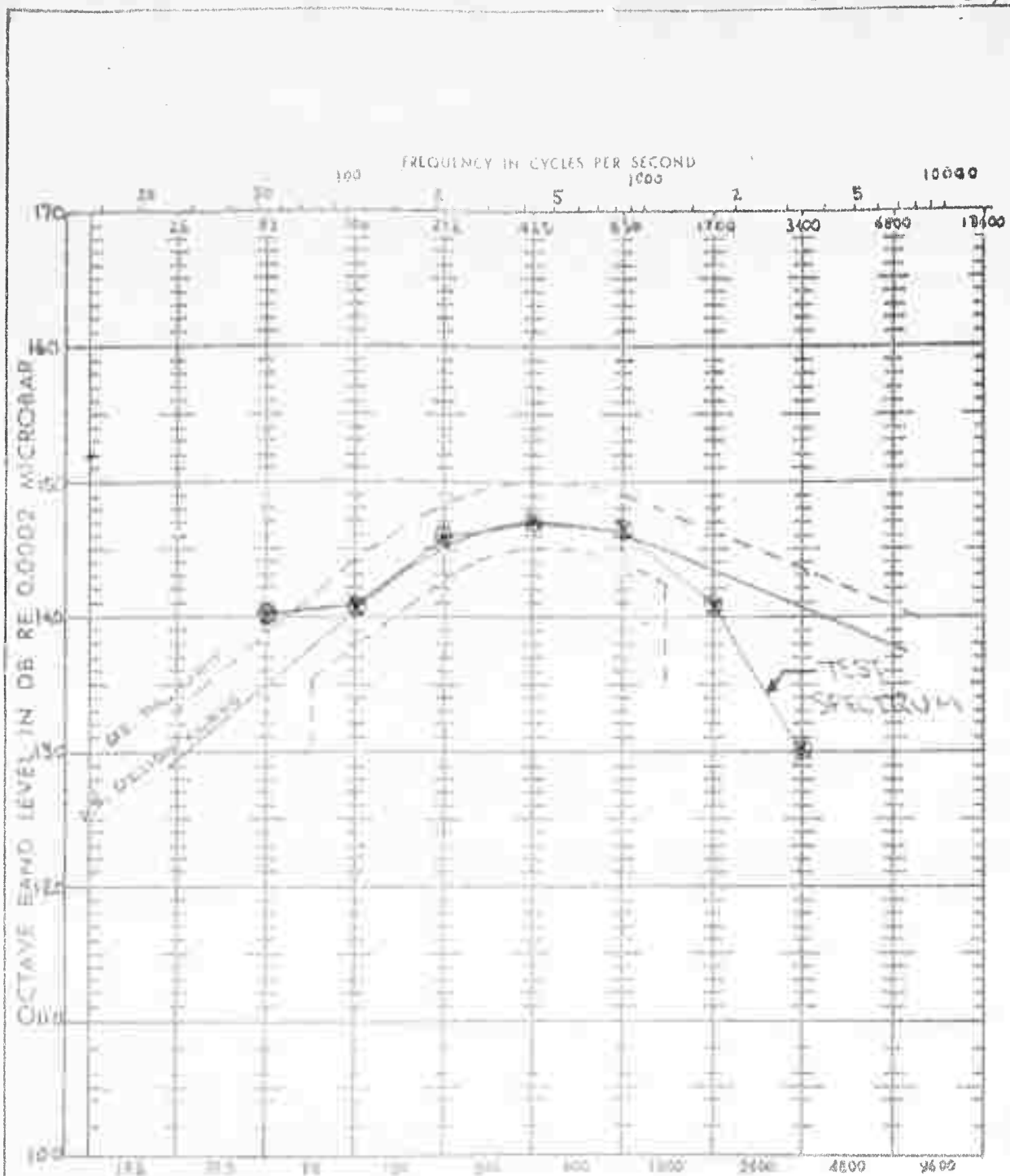
Tape No. 64	Tape Channel 6	Data Tape RMS Volt V_R = .180
Calibration Voltage V_a = .50 V_{rms} into Line Amp.; V_c = .90 V_{rms} on Tape @ 200 cps		
Line Amplifier Settings For Calibration G_c = .500 ; for Data G_d = .100		
Lab. Gain LG = 1.0	Tape Monitor Gain TMG = $\frac{G_d}{G_c} = .20$	
Displacement Pickup Sensitivity S = .035 in./Volt		
Equivalent of Calibration - in. D_c = V_a · S = .0175"		
Equivalent of Calibration for PSD Plots $\left(\frac{D_c}{(TMG)(LG)}\right)^2 = 7.65 \times 10^{-3}$ in.²/cps		
Analyzer Attenuator Setting -20 db		Log Converter Setting 0 db
Calibration Plotted at 1.0 (1.0) in. ² /cps		
Overall Deflection Level of Data RMS Defl. Level = $\frac{(D_c)(V_R)}{(TMG)(LG)(V_c)} = \frac{(0.0175)(.180)}{(.2)(1.0)(.90)} = .0328$ in.		



CALC	CBT	6/30/60	REVISED	DATE	POWER SPECTRAL DENSITY ANALYSIS OF DISPLACEMENT PICKUP 167.2 dB	VOL I
CHECK					P/U #6 0.5 MIN TEST PHASE "D"	D2-80064
APR.					BOEING AIRPLANE COMPANY	PAGE
APR.	SA	6/30/60			SEATTLE 24, WASHINGTON	FIG 222

2-5353-7-9

2



150

OCTAVE PASS BANDS IN CYCLES PER SECOND

EQUILIZER SETTINGS

20 - 75	20.5
75 - 150	24.0
150 - 300	17.0
300 - 600	7.0
600 - 1200	3
1200 - 2400	-1.0
2400 - 4800	0
4800 - 9600	0

3 AMPS 28 PSI

PANEL 1493

EWA 5-593

MIKE "1"

CALC

DATE VOL I

BOEING

NO. DZ-80084

SONIC LAB.

PAGE

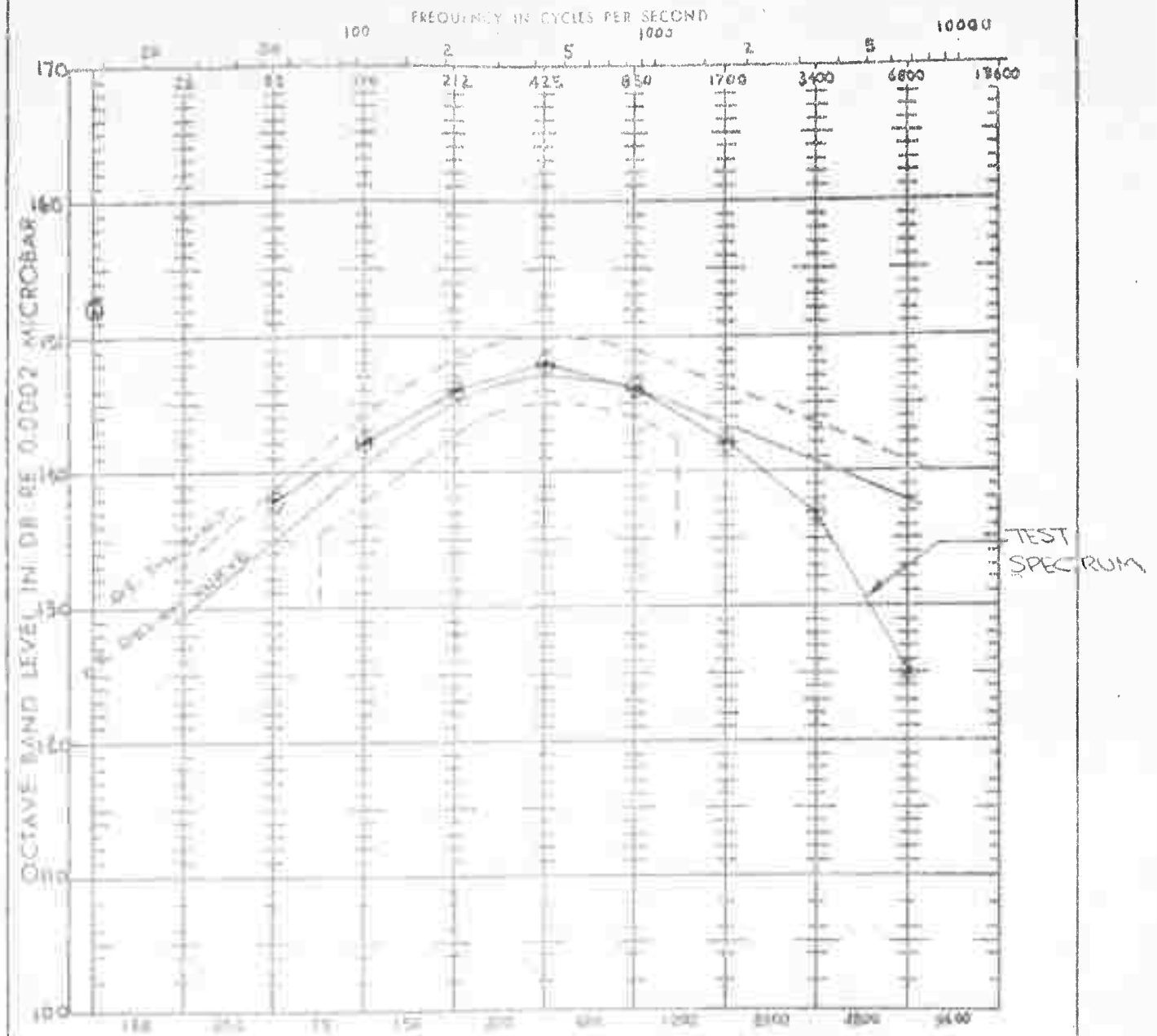
Fid 223



EQUILIZER SETTINGS	
20 - 75	20.5
75 - 150	24.0
150 - 300	17.0
300 - 600	7.0
600 - 1200	3.0
1200 - 2400	-1.0
2400 - 4800	∞
4800 - 9600	∞
3.2 AMPS 35 PSI	

PANEL 1494
MIC. 1 (INSIDE HORN)

CALC. A.B. DATE 5/4/61 Vol. I
 BEING NO 02-80084
 SONIC LAB. PAGE FIG 224



OVERALL

OCTAVE PASS BANDS IN CYCLES PER SECOND

MICROBAR

PASSEL 1495

EQUILIZER SETTINGS	
20 - 75	0.5
75 - 150	3.0
150 - 300	7.0
300 - 600	7.0
600 - 1200	7.0
1200 - 2400	7.0
2400 - 4800	00
4800 - 9600	00

3.2 AMPS 25 PSI

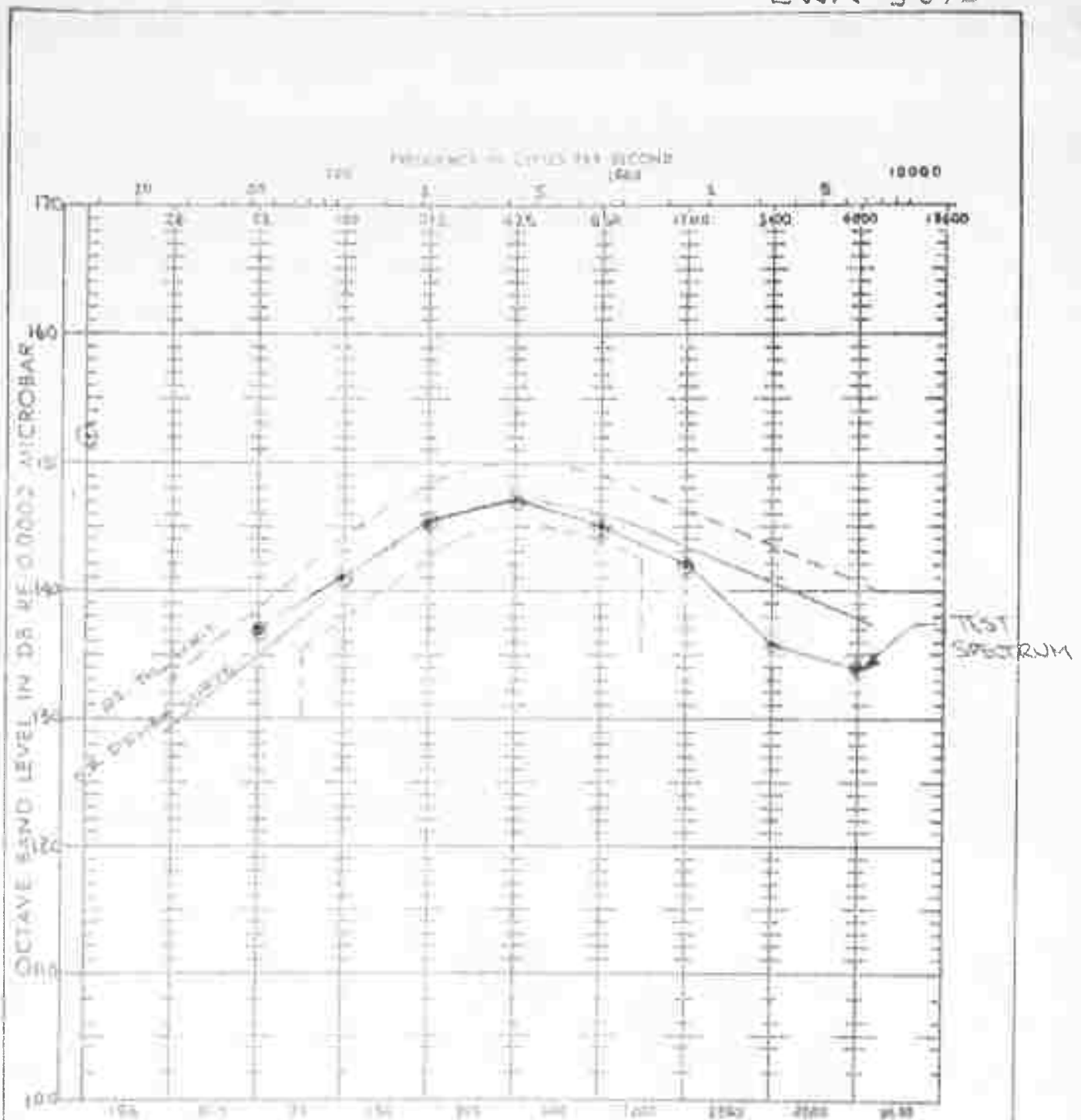
CALC. A.B. DATE 5/8/61 VOLT

BOEING

NO 02-80084

SONIC LAB.

PAGE FIG 225



OCTAVE PASS BANDS IN CYCLES PER SECOND

EQUILIZER SETTINGS

20 - 75	20.5
75 - 150	21.0
150 - 300	17.0
300 - 600	7.0
600 - 1200	-1.0
1200 - 2400	-1.0
2400 - 4800	00
4800 - 9600	00

3.0 AMPS 35 PSI

MIC. #1

PANEL 1417

CALC A.B.

DATE 5/9/61

VOLT.

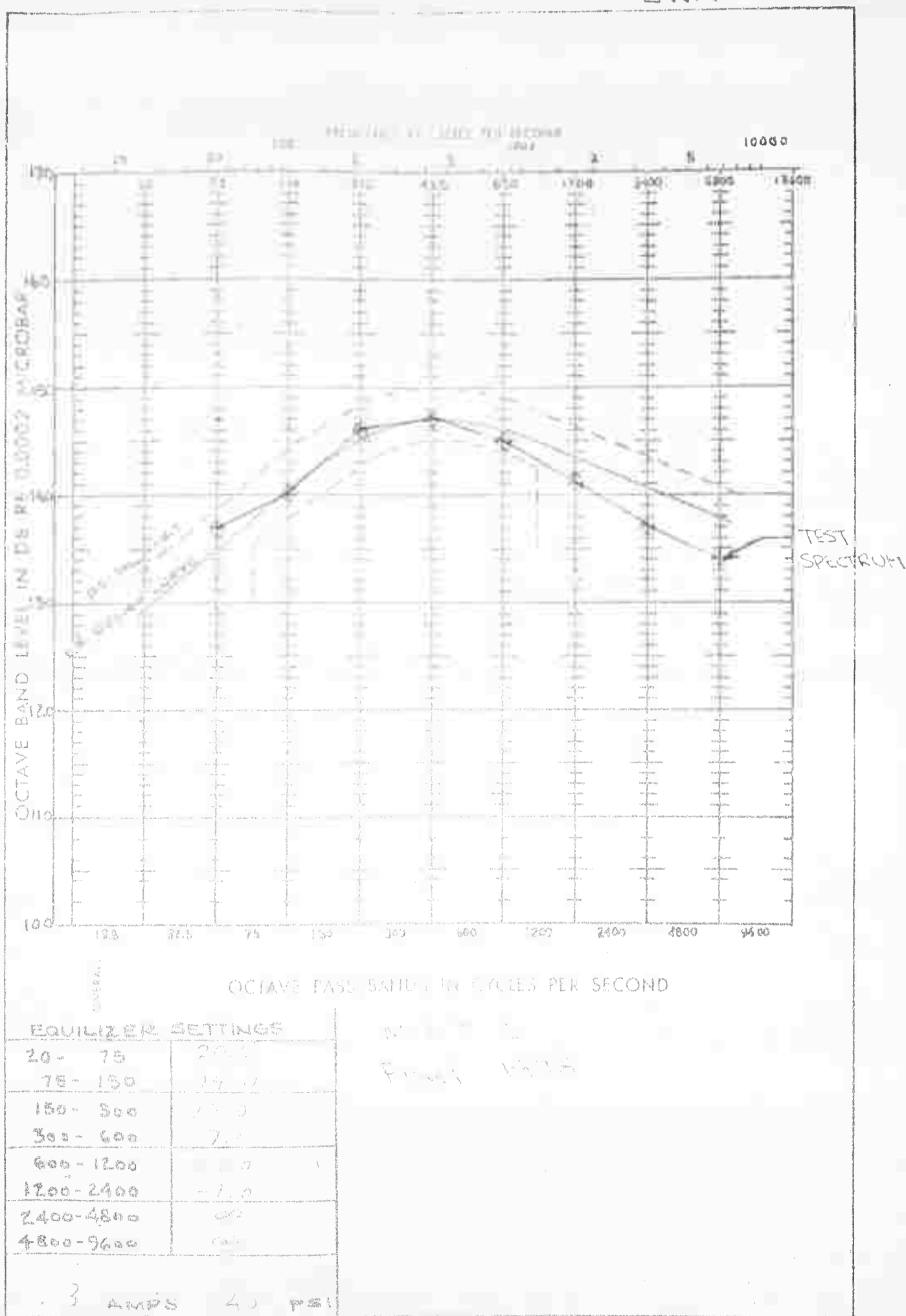
BRIEFING

NO DZ-80084

SONIC LAB.

PAGE

FIG 226



CALL 40 33

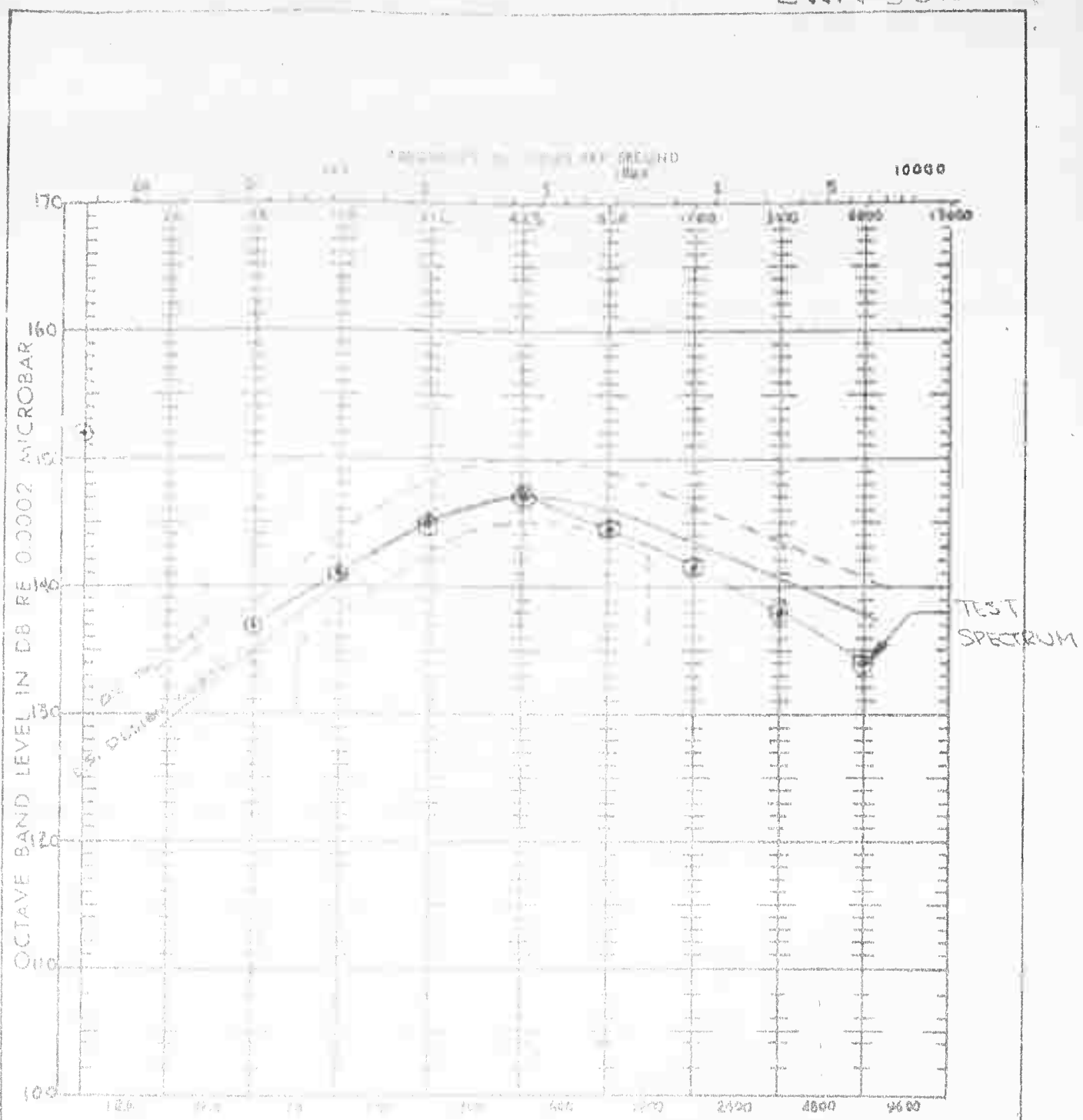
DATE 5-1-61 VOLT

BLUEING

NO. DZ-80084

SONIC LAB.

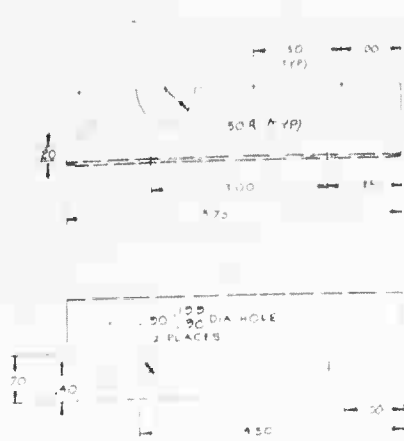
PAGE FIG 227



EQUILIZER SETTINGS	
20 - 75	5.0
75 - 150	2.0
150 - 300	7.0
300 - 600	7.0
600 - 1200	-1.0
1200 - 2400	1.0
2400 - 4800	0.0
4800 - 9600	0.0

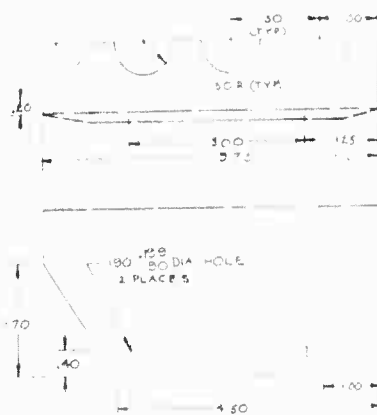
3.2 AMPS 35 PSI

MA 111
PR 1111

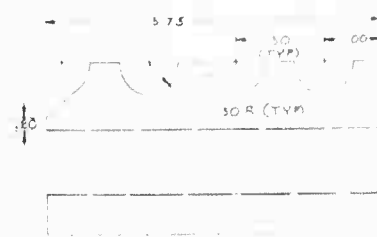


5, -6 OPP (.020 GA)

BAG 830BH JORN
HAS 670 C3W
PLATES
TEST ATTACHMENT



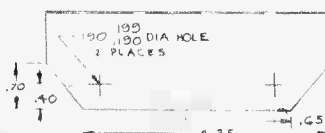
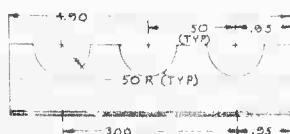
-9, -10 OPP (.020 GA)



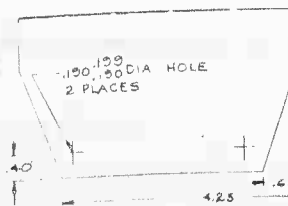
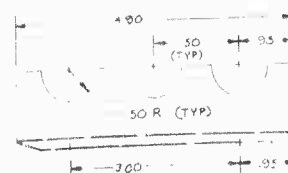
-11, -12 OPP (.020 GA)



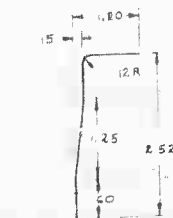
-13 (.020 GA)



-7 (.020 GA)



-8 (.020 GA)



-25 (CUT INTO STRIPS TO
INSTALL BETWEEN CLIPS)

-25 (FIBER)

1

SYM

SYM

SEW BOTH 23 SCREEN SECTIONS
TOGETHER AFTER INSTALLING
SEPARATELY OVER - 4 - 151 - 6
CLIPS SEW ON - 24 SCREEN STRIPS
AS SHOWN JUL 002 WORK

SYM

SYM

1-24
K 2-4-5

-23

23 05

DETAIL AG

DETAIL 46
 ASSY OF 231-24 TO 25-20367-1-2
 HALF SIZE

RECEIVED IN TYPICAL CASE

w25 (2)A H03 E

-16 (0206A)

10 6200

 $(2 \quad R \quad r \vee p)^2$

-15 (2020 GA)

$$\frac{1}{2} \text{YM}$$
$$\frac{1}{2} \text{YM}$$

12 5 5 7 8

$$= .4 (.020 \text{ GA})$$

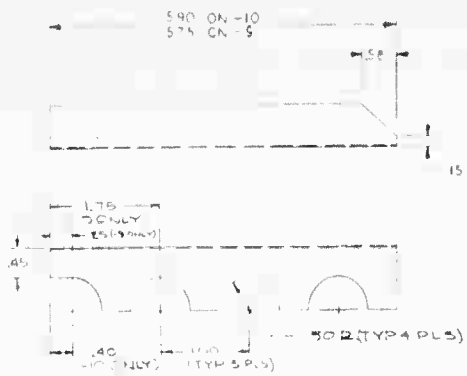
NOTE: ALL PARTS
FABRICATED FROM
RENE' 41 EXCEPT
AS NOTED.

3

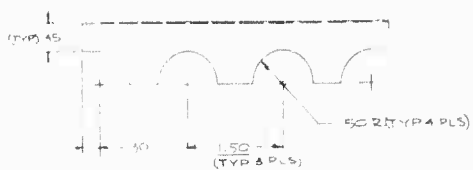
SEE SHEET 1 FOR LIST OF MATERIAL AND NOTES

[illegible]

1 NAME: NG	2 ORIGIN: DYNASOAR	3 DYNASOAR AIRFRAME	4 <i>DLN-1</i>
5 FVVA 5-593	6 ORIGIN: DYNASOAR	7 WING & CONTROL SURFACE	



-9&-10 (.020 GA.)
(-10 SHOWN)



-8 (.020 GA.)

BAC B30BH-3 (BA
M3679C3W
(12 PLACES)
(TEST FIXTURE
ATTACHMENT)

.09 R

STEEL STAMP
ASSY NO P/B
BAC NOT BEFORE
INSTALLATION OF



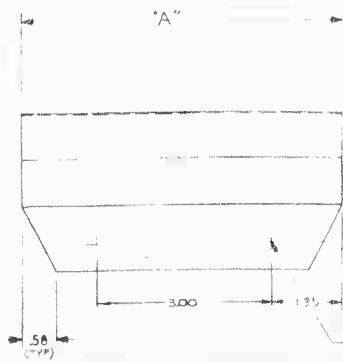
2
SEE ZN B3
FOR DETAIL

OPR (TYP)
25 (TYP BOTH SIDES)

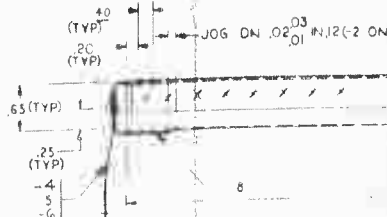
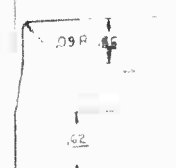
25
(TYP 4 PLACES)

.45 (TYP BOTH ENDS)

50 (TYP BOTH
ENDS)
25 (TYP 4 PLACES)



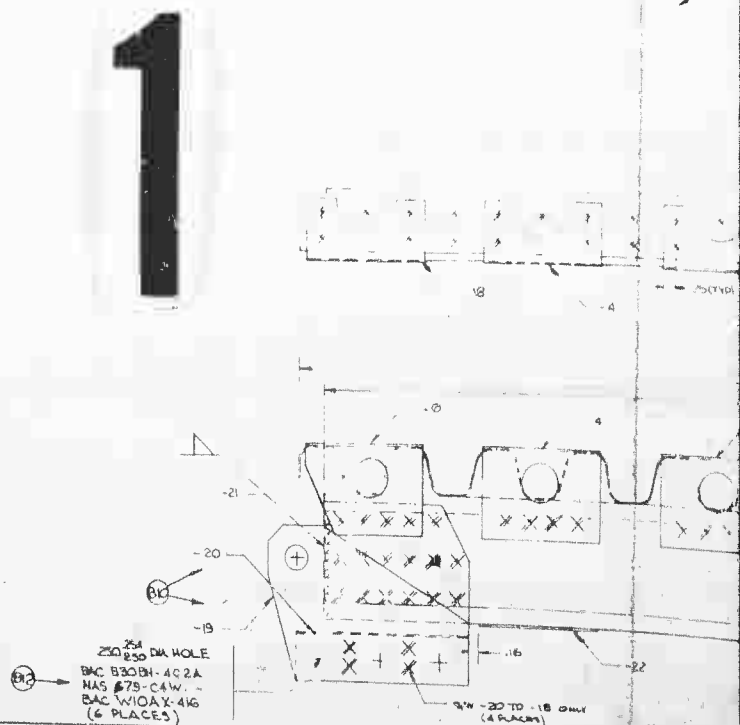
1.00 DIA HOLE
LOCATE TO MATCH
MOUNTING FIXTURE



-4, -5 & -6 OPP; -7, -11 & -12 OPP (.020 GA. TYP.)

PART NUMBER	A"	B"	C"
-4	5.70	2.53	1.13
-5 & -6 OPP	5.45	2.53	1.13
-7	5.70	1.68	1.03
-11 & -12 OPP	5.45	1.68	1.03

1



SYM

11 (A3)

C5_{EN}

AB

SHOULD BE KNOWN
FOR LENGTH OF

53

B7

TIME & EXCEPT AS NOTED

2

1/2" SECTION LINE

PARAMETER 3
MINIMUM FULL
LENGTH OF 7

FIELD 1
FIELD 2
FIELD 3
FIELD 4
FIELD 5
FIELD 6
FIELD 7
FIELD 8
FIELD 9
FIELD 10
FIELD 11
FIELD 12
FIELD 13
FIELD 14
FIELD 15
FIELD 16
FIELD 17
FIELD 18
FIELD 19
FIELD 20
FIELD 21
FIELD 22
FIELD 23
FIELD 24
FIELD 25
FIELD 26
FIELD 27
FIELD 28
FIELD 29
FIELD 30
FIELD 31
FIELD 32
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FIELD 78
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FIELD 80
FIELD 81
FIELD 82
FIELD 83
FIELD 84
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FIELD 86
FIELD 87
FIELD 88
FIELD 89
FIELD 90
FIELD 91
FIELD 92
FIELD 93
FIELD 94
FIELD 95
FIELD 96
FIELD 97
FIELD 98
FIELD 99
FIELD 100

0.05 DIA HOLE

0.05 DIA HOLE

0.020 GA

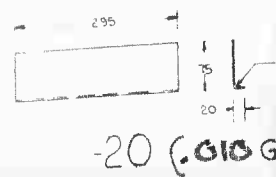
SW (TYP 5 PLACES)

PANEL ASSY 25-20374-1
(-12, -13, -14 & -15 NOT SHOWN, SEE A5-2A3-3 FOR THESE PARTS)

5

4

6



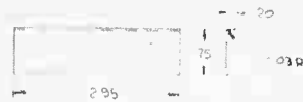
NOTE: A
F
R

-17 SHOWN (030
-18 OPP

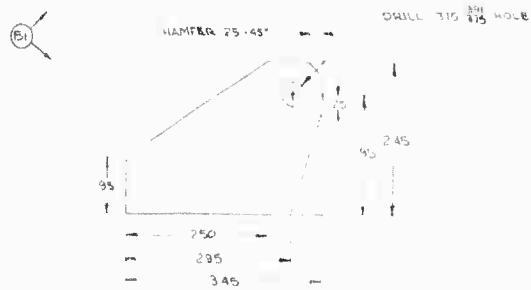
-20 (GIG G

-21 (030 GA)

-19 (060 GA.)

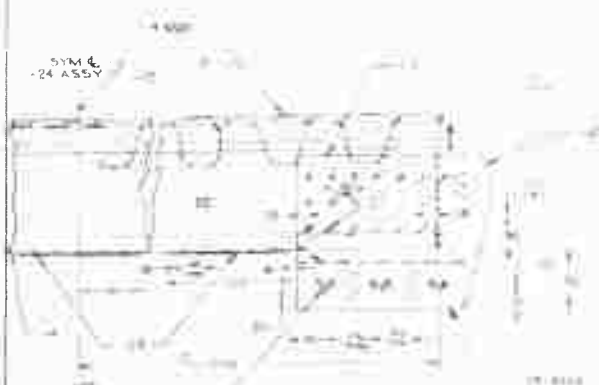


25 (.010 GA.)



20 (.060 GA.)

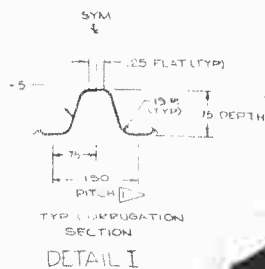
SYM 4
-24 ASSY



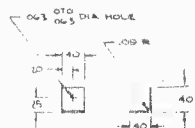
200 250 DIA HOLE
BAC B20BH-AC2A
NAD 679-CAW
BAC WIOAX-416
(6 PLACES)

A1

B2

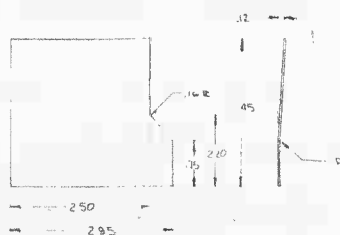


TYP CORRUGATION
SECTION
DETAIL I



-26 (.020 GA.)

B1



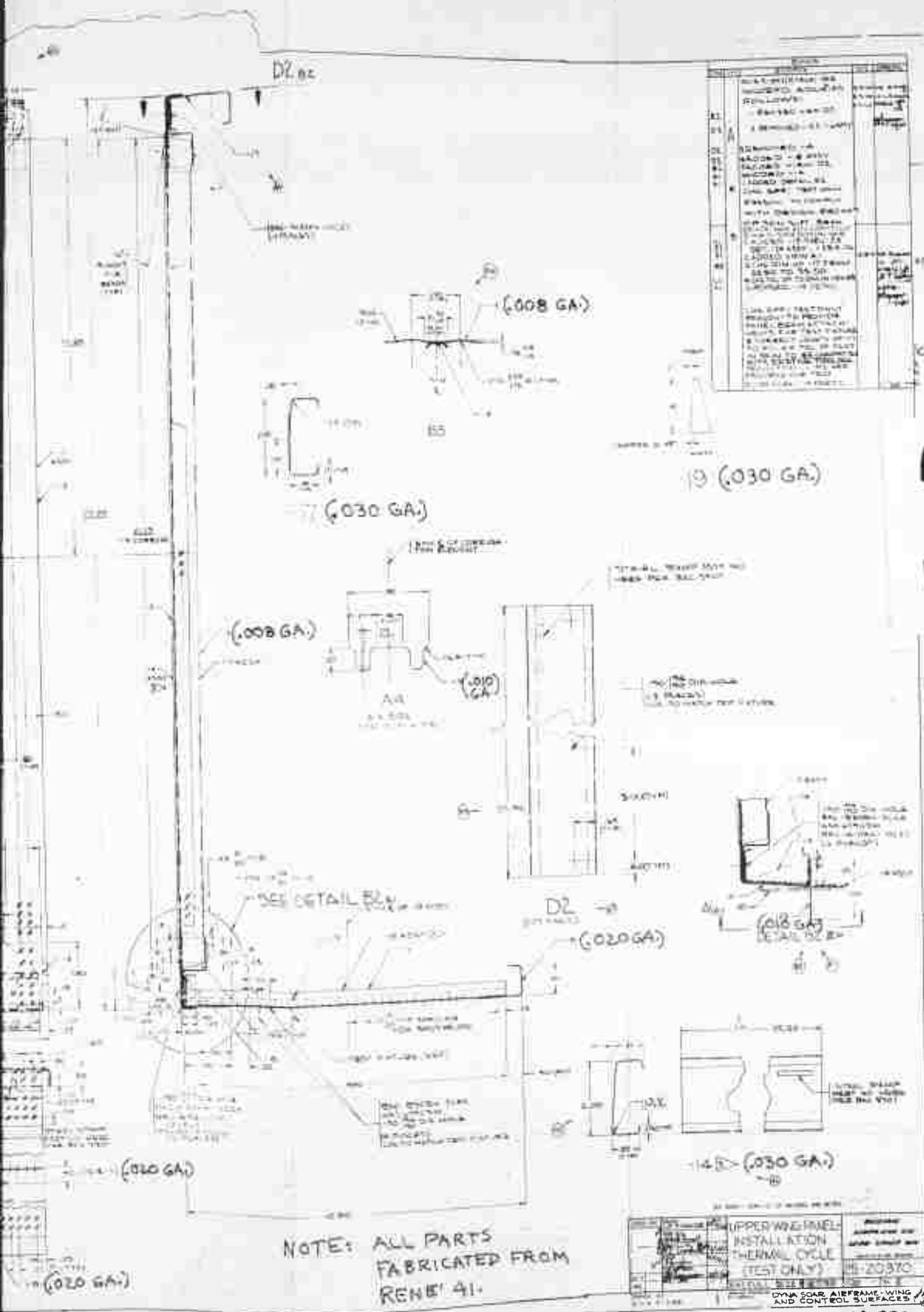
-21 SHOWN (.030 GA.)
-22 OPP

1

4A
(TYP)

B3





3

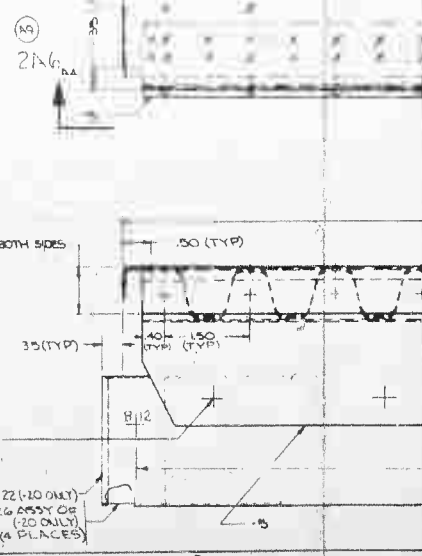
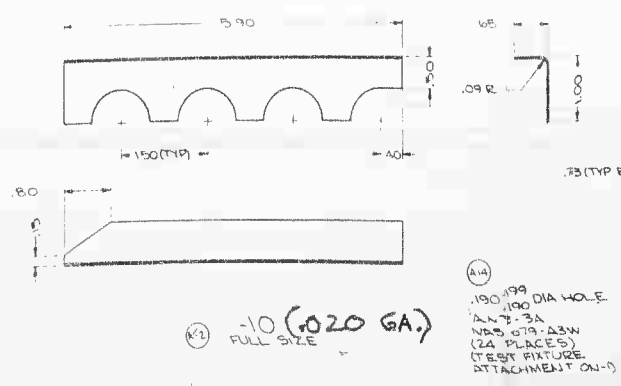
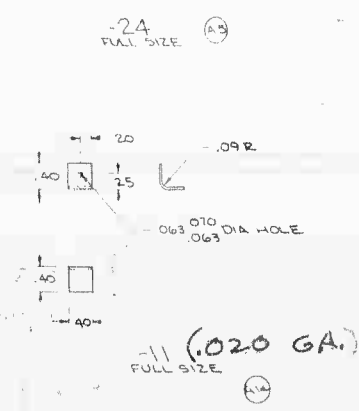
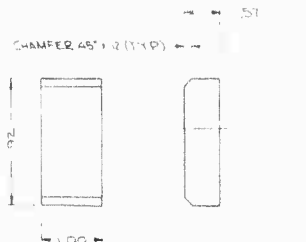
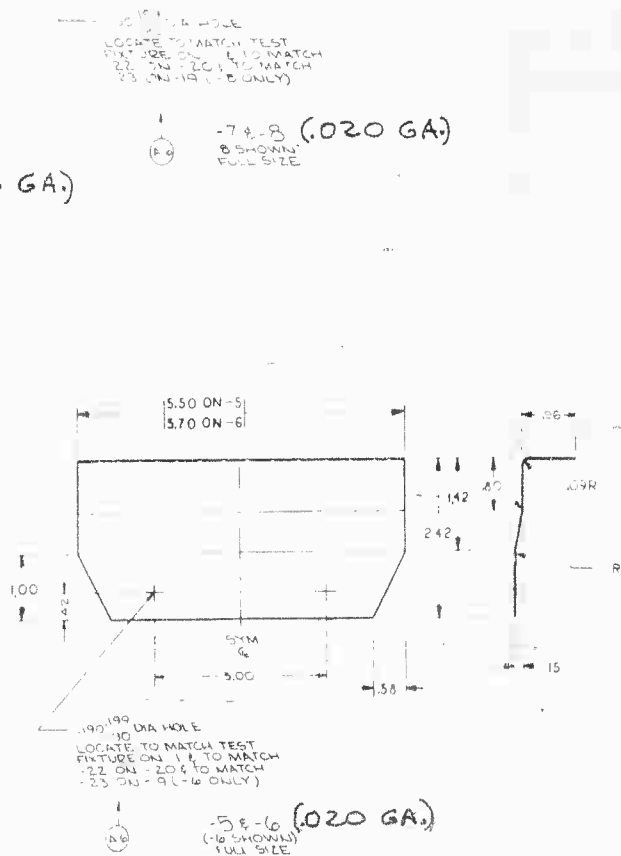
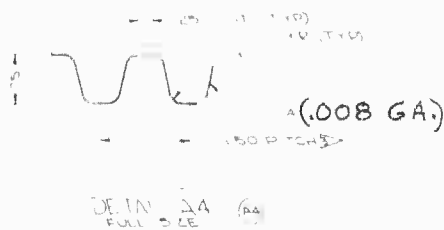
FIG. 232

C

2

A

1



2

WELD (TYP)
1.50
FOR CORRUGATION PITCH 1/2 INCHES
SPOT WELDS (TYP)

ASSEMBLY OF 25 7-352-14
FULL SIZE
(24 BENT OR NOT SHOWN)

UNCLASSIFIED

UNCLASSIFIED